# MC9S12E128 <br> MC9S12E64 <br> MC9S12E32 

Data Sheet

HCS12<br>Microcontrollers

# MC9S12E128 Data Sheet 

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## Chapter 1

MC9S12E128 Device Overview (MC9S12E128DGV1)

### 1.1 Introduction

The MC9S12E128 is a 112/80/64 pin low cost general purpose MCU comprised of standard on-chip peripherals including a 16 -bit central processing unit (HCS12 CPU), up to 128 K bytes of Flash EEPROM, up to 8 K bytes of RAM, three asynchronous serial communications interface modules (SCI), a serial peripheral interface (SPI), an Inter-IC Bus (IIC), three 4-channel 16-bit timer modules (TIM), a 6-channel 15-bit Pulse Modulator with Fault protection module (PMF), a 6-channel 8-bit Pulse Width Modulator (PWM), a 16-channel 10-bit analog-to-digital converter (ADC), and two 1-channel 8-bit digital-to-analog converters (DAC). The MC9S12E128 has full 16-bit data paths throughout. The inclusion of a PLL circuit allows power consumption and performance to be adjusted to suit operational requirements. In addition to the I/O ports available on each module, 16 dedicated I/O port bits are available with Wake-Up capability from STOP or WAIT mode. Furthermore, an on chip bandgap based voltage regulator (VREG) generates the internal digital supply voltage of 2.5 V (VDD) from a 3.135 V to 5.5 V external supply range.

### 1.1.1 Features

- 16-bit HCS12 CORE
- HCS12 CPU
- i. Upward compatible with M 68 HC 11 instruction set
- ii. Interrupt stacking and programmer's model identical to M68HC11
- iii. Instruction queue
- iv. Enhanced indexed addressing
- Module Mapping Control (MMC)
- Interrupt control (INT)
- Background Debug Module (BDM)
- Debugger (DBG12) including breakpoints and change-of-flow trace buffer
- Multiplexed External Bus Interface (MEBI)
- Wake-Up interrupt inputs
- Up to 16 port bits available for wake up interrupt function with digital filtering
- Memory Options
- $32 \mathrm{~K}, 64 \mathrm{~K}$ or 128 K Byte Flash EEPROM
- $2 \mathrm{~K}, 4 \mathrm{~K}$ or 8 K Byte RAM
- Two 1-channel Digital-to-Analog Converters (DAC)
- 8-bit resolution
- Analog-to-Digital Converter (ADC)
- 16-channel module with 10-bit resolution
- External conversion trigger capability
- Three 4-channel Timers (TIM)
- Programmable input capture or output compare channels
- Simple PWM mode
- Counter modulo reset
- External event counting
- Gated time accumulation
- 6 PWM channels (PWM)
- Programmable period and duty cycle
- 8-bit 6-channel or 16-bit 3-channel
- Separate control for each pulse width and duty cycle
- Center-aligned or left-aligned outputs
- Programmable clock select logic with a wide range of frequencies
- Fast emergency shutdown input
- 6-channel Pulse width Modulator with Fault protection (PMF)
- Three independent 15-bit counters with synchronous mode
- Complementary channel operation
- Edge and center aligned PWM signals
- Programmable dead time insertion
- Integral reload rates from 1 to 16
- Four fault protection shut down input pins
- Three current sense input pins
- Serial interfaces
- Three asynchronous serial communication interfaces (SCI)
- Synchronous serial peripheral interface (SPI)
- Inter-IC Bus (IIC)
- Clock and Reset Generator (CRG)
- Windowed COP watchdog
- Real Time interrupt
- Clock Monitor
- Pierce or low current Colpitts oscillator
- Phase-locked loop clock frequency multiplier
- Self Clock mode in absence of external clock
- Low power 0.5 to 16 Mhz crystal oscillator reference clock
- Operating frequency
- 50 MHz equivalent to 25 MHz Bus Speed
- Internal 2.5 V Regulator
- Input voltage range from 3.135 V to 5.5 V
- Low power mode capability
- Includes low voltage reset (LVR) circuitry
- Includes low voltage interrupt (LVI) circuitry
- 112-Pin LQFP or 80-Pin QFP or 64-Pin QFN package
- Up to $90 \mathrm{I} / \mathrm{O}$ lines with 5 V input and drive capability (112 pin package)
- Up to two dedicated 5 V input only lines (IRQ and XIRQ)
- Sixteen 3.3V/5V A/D converter inputs
- Development Support.
- Single-wire background debug ${ }^{\mathrm{TM}}$ mode
- On-chip hardware breakpoints
- Enhanced debug features


### 1.1.2 Modes of Operation

User modes (Expanded modes are only available in the 112-pin package version)

- Normal modes
- Normal Single-Chip Mode
- Normal Expanded Wide Mode
- Normal Expanded Narrow Mode
- Emulation Expanded Wide Mode
- Emulation Expanded Narrow Mode
- Special Operating Modes
- Special Single-Chip Mode with active Background Debug Mode
- Special Test Mode (Freescale use only)
- Special Peripheral Mode (Freescale use only)
- Low power modes
- Stop Mode
- Pseudo Stop Mode
- Wait Mode

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)

### 1.1.3 Block Diagram



Figure 1-1. MC9S12E128 Block Diagram

### 1.2 Device Memory Map

Table 1-1 shows the device register map of the MC9S12E128 after reset. Figure 1-2, Figure 1-3 and Figure 1-4 illustrate the device memory map with Flash and RAM.

Table 1-1. Device Register Map Overview

| Address | Module | Size |
| :---: | :---: | :---: |
| 0x0000-0x0017 | CORE (Ports A, B, E, Modes, Inits, Test) | 24 |
| $0 \times 0018$ | Reserved | 1 |
| 0x0019 | Voltage Regulator (VREG) | 1 |
| 0x001A-0x001B | Device ID register (PARTID) | 2 |
| 0x001C-0x001F | CORE (MEMSIZ, IRQ, HPRIO) | 4 |
| 0x0020-0x002F | CORE (DBG) | 16 |
| 0x0030-0x0033 | CORE (PPAGE, Port K) | 4 |
| 0x0034-0x003F | Clock and Reset Generator (PLL, RTI, COP) | 12 |
| 0x0040-0x006F | Standard Timer 16-bit 4 channels (TIM0) | 48 |
| 0x0070-0x007F | Reserved | 16 |
| 0x0080-0x00AF | Analog to Digital Converter 10-bit 16 channels (ATD) | 48 |
| 0x00B0-0x00C7 | Reserved | 24 |
| 0x00C8-0x00CF | Serial Communications Interface 0 (SCIO) | 8 |
| 0x00D0-0x00D7 | Serial Communications Interface 1 (SCI1) | 8 |
| 0x00D8-0x00DF | Serial Peripheral Interface (SPI) | 8 |
| 0x00E0-0x00E7 | Inter IC Bus | 8 |
| 0x00E8-0x00EF | Serial Communications Interface 2 (SCl2) | 8 |
| 0x00F0-0x00F3 | Digital to Analog Converter 8-bit 1-channel (DAC0) | 4 |
| 0x00F4-0x00F7 | Digital to Analog Converter 8-bit 1-channel (DAC1) | 4 |
| 0x00F8-0x00FF | Reserved | 8 |
| 0x0100-0x010F | Flash Control Register | 16 |
| 0x0110-0x013F | Reserved | 48 |
| 0x0140-0x016F | Standard Timer 16-bit 4 channels (TIM1) | 48 |
| 0x0170-0x017F | Reserved | 16 |
| 0x0180-0x01AF | Standard Timer 16-bit 4 channels (TIM2) | 48 |
| 0x01B0-0x01DF | Reserved | 48 |
| 0x01E0-0x01FF | Pulse Width Modulator 8-bit 6 channels (PWM) | 32 |
| 0x0200-0x023F | Pulse Width Modulator with Fault 15-bit 6 channels (PMF) | 64 |
| 0x0240-0x027F | Port Integration Module (PIM) | 64 |
| 0x0280-0x03FF | Reserved | 384 |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)


The figure shows a useful map, which is not the map out of reset. After reset the map is:
\$0000-\$03FF: Register Space
\$0000-\$1FFF: 8K RAM (only 7K RAM visible \$0400-\$1FFF)
Figure 1-2. MC9S12E128 User Configurable Memory Map


The figure shows a useful map, which is not the map out of reset. After reset the map is:
\$0000-\$03FF: Register Space
\$0000-\$0FFF: 4K RAM (only 3K RAM visible \$0400-\$0FFF)
Figure 1-3. MC9S12E64 User Configurable Memory Map

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)


The figure shows a useful map, which is not the map out of reset. After reset the map is:
\$0000-\$03FF: Register Space
\$0000-\$07FF: 2K RAM (only 1K RAM visible \$0400-\$07FF)
Figure 1-4. MC9S12E32 User Configurable Memory Map

### 1.2.1 Detailed Register Map

0x0000 - 0x000F MEBI Map 1 of 3 (HCS12 Multiplexed External Bus Interface)


Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0010 - 0x0014 MMC Map 1 of 4 (HCS12 Module Mapping Control)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0010$ | INITRM | R | RAM15 | RAM14 | RAM13 | RAM12 | RAM11 | 0 | 0 | RAMHAL |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0011$ | INITRG | R | 0 | REG14 | REG13 | REG12 | REG11 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0012$ | INITEE | R | EE15 | EE14 | EE13 | EE12 | EE11 | 0 | 0 | EEON |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0013$ | MISC | R | 0 | 0 | 0 | 0 | EXSTR1 | EXSTR0 | ROMHM | ROMON |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0014$ | MTST0 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0015-0x0016 INT Map 1 of 2 (HCS12 Interrupt)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0015$ | ITCR | R | 0 | 0 | 0 | WRINT | ADR3 | ADR2 | ADR1 | ADR0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0016$ | ITEST | $R$ $W$ | INTE | INTC | INTA | INT8 | INT6 | INT4 | INT2 | INT0 |

0x0017-0x0017MMC Map 2 of 4 (HCS12 Module Mapping Control)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0017 | MTST1 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0018-0x0018 Miscellaneous Peripherals (Device User Guide)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0018$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0019-0x0019 |  | VREG3V3 (Voltage Regulator) |  |  |  |  |  |  |  |  |
| Address | Name | Bit 7 |  | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| $0 \times 0019$ | VREGCTRL | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | 0 | 0 | 0 | 0 | 0 | LVDS | LVIE | LVIF |
|  |  |  |  |  |  |  |  |  |  |  |

0x001A - 0x001B Miscellaneous Peripherals (Device User Guide)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x001A | PARTIDH | R | ID15 | ID14 | ID13 | ID12 | ID11 | ID10 | ID9 | ID8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x001B | PARTIDL | R | ID7 | ID6 | ID5 | ID4 | ID3 | ID2 | ID1 | ID0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x001C - 0x001D MMC Map 3 of 4 (HCS12 Module Mapping Control, Device User Guide)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x001C | MEMSIZO | R | reg_sw0 | 0 | eep_sw1 | eep_sw0 | 0 | ram_sw2 | ram_sw1 | ram_sw0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x001D | MEMSIZ1 | R | rom_sw1 | rom_sw0 | 0 | 0 | 0 | 0 | pag_sw1 | pag_sw0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x001E - 0x001E MEBI Map 2 of 3 (HCS12 Multiplexed External Bus Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x001E | INTCR | R | IRQE | IRQEN | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

## 0x001F - 0x001F INT Map 2 of 2 (HCS12 Interrupt)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x001F | HPRIO | R | PSEL7 | PSEL6 | PSEL5 | PSEL4 | PSEL3 | PSEL2 | PSEL1 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0020-0x002F DBG (Including BKP) Map 1 of 1 (HCS12 Debug)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0020 | DBGC1 | $R$ $W$ | DBGEN | ARM | TRGSEL | BEGIN | DBGBRK | 0 | CAPMOD |  |
| 0x0021 | DBGSC | R | AF | BF | CF | 0 | TRG |  |  |  |
| 0x0022 | DBGTBH | R | Bit 15 | Bit 14 | Bit 13 | Bit 12 | Bit 11 | Bit 10 | Bit 9 | Bit 8 |
|  | - | W |  |  |  |  |  |  |  |  |
| 0x0023 | DBGTBL | R | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
|  | - | W |  |  |  |  |  |  |  |  |
|  | DBGCNT | R | TBF | 0 | CNT |  |  |  |  |  |
|  | - | W |  |  |  |  |  |  |  |  |
| 0x0025 | DBGCCX | R $W$ | PAGSEL |  | EXTCMP |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0020 - 0x002F DBG (Including BKP) Map 1 of 1 (HCS12 Debug) (continued)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0026$ | DBGCCH | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| $0 \times 0027$ | DBGCCL | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| $0 \times 0028$ | DBGC2 <br> BKPCTO | R W | BKABEN | FULL | BDM | TAGAB | BKCEN | TAGC | RWCEN | RWC |
| 0x0029 | DBGC3 <br> BKPCT1 | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | BKAMBH | BKAMBL | BKBMBH | BKBMBL | RWAEN | RWA | RWBEN | RWB |
| 0x002A | DBGCAX BKPOX | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | PAGSEL |  | EXTCMP |  |  |  |  |  |
| 0x002B | DBGCAH BKPOH | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x002C | DBGCAL BKPOL | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x002D | $\begin{gathered} \text { DBGCBX } \\ \text { BKP1X } \end{gathered}$ | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | PAGSEL |  | EXTCMP |  |  |  |  |  |
| 0x002E | DBGCBH BKP1H | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x002F | DBGCBL BKP1L | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |

0x0030 - 0x0031 MMC Map 4 of 4 (HCS12 Module Mapping Control)

| Address | Name |  | it | Bit | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0030 | PPAGE | R | 0 | 0 | PIX5 | PIX4 | PIX3 | PIX2 | PIX1 | PIX0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0031$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0032 - 0x0033 MEBI Map 3 of 3 (HCS12 Multiplexed External Bus Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0032 | PORTK | $R$ $W$ | ECS | XCS | XAB19 | XAB18 | XAB17 | XAB16 | XAB15 | XAB14 |
| $0 \times 0033$ | DDRK | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |

0x0034-0x003F CRG (Clock and Reset Generator)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0034 | SYNR | R | 0 | 0 | SYN5 | SYN4 | SYN3 | SYN2 | SYN1 | SYN0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0035 | REFDV | R | 0 | 0 | 0 | 0 | REFDV3 | REFDV2 | REFDV1 | REFDV0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0036 | CTFLG <br> TEST ONLY | $R$$W$ | TOUT7 | TOUT6 | TOUT5 | TOUT4 | TOUT3 | TOUT2 | TOUT1 | TOUT0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0037$ | CRGFLG | R | RTIF | PROF | 0 | LOCKIF | LOCK | TRACK | SCMIF | SCM |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0038$ | CRGINT | R | RTIE | 0 | 0 | LOCKIE | 0 | 0 | SCMIE | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0039$ | CLKSEL | $R$ $W$ | PLLSEL | PSTP | SYSWAI | ROAWAI | PLLWAI | CWAI | RTIWAI | COPWAI |
| 0x003A | PLLCTL | R | CME | PLLON | AUTO | ACQ | 0 | PRE | PCE | SCME |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x003B | RTICTL | R | 0 | RTR6 | RTR5 | RTR4 | RTR3 | RTR2 | RTR1 | RTR0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x003C | COPCTL | R | WCOP | RSBCK | 0 | 0 | 0 | CR2 | CR1 | CRO |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x003D | FORBYP TEST ONLY | R | RTIBYP | COPBYP | 0 | PLLBYP | 0 | 0 | FCM | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x003E | CTCTL <br> TEST ONLY | R | TCTL7 | TCTL6 | TCTL5 | TCTL4 | TCLT3 | TCTL2 | TCTL1 | TCTL0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x003F |  | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  | ARMCOP | W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |

0x0040-0x006F TIM0 (Timer 16 Bit 4 Channels) (Sheet 1 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0040 | TIOS | R | IOS7 | IOS6 | IOS5 | IOS4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0041 | CFORC | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W | FOC7 | FOC6 | FOC5 | FOC4 |  |  |  |  |
| 0x0042 | OC7M | R | OC7M7 | OC7M6 | OC7M5 | OC7M4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0043 | OC7D | R | OC7D7 | OC7D6 | OC7D5 | OC7D4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0044 | TCNT (hi) | R | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0045 | TCNT (lo) | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W |  |  |  |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0040-0x006F TIM0 (Timer 16 Bit 4 Channels) (Sheet 2 of 4)

| $\begin{array}{llllllllllll}\text { Adress } & \text { Name } & \text { Bit } 7 & \text { Bit } 6 & \text { Bit } 5 & \text { Bit } 4 & \text { Bit } 3 & \text { Bit } 2 & \text { Bit } 1 & \text { Bit } 0\end{array}$ |  |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0046$ | TSCR1 |  | TEN | TSWAI | TSFRZ | TFFCA | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0047$ | TTOV |  | TOV7 | TOV6 | TOV5 | TOV4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0048 | TCTL1 | $R$ $W$ | OM7 | OL7 | OM6 | OL6 | OM5 | OL5 | OM4 | OL4 |
| 0x0049 | Reserved | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x004A | TCTL3 | $R$ $W$ | EDG7B | EDG7A | EDG6B | EDG6A | EDG5B | EDG5A | EDG4B | EDG4A |
| 0x004B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x004C | TIE |  | C71 | C6I | C5I | C4I | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x004D | TSCR2 |  | TOI | 0 | 0 | 0 | TCRE | PR2 | PR1 | PR0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x004E | TFLG1 | R | C7F | C6F | C5F | C4F | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x004F | TFLG2 | R | TOF | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0050 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0051$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0052$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0053$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0054 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0055$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0056$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0057$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0058$ | TC4 (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |

## 0x0040-0x006F TIM0 (Timer 16 Bit 4 Channels) (Sheet 3 of 4)



Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0040-0x006F TIM0 (Timer 16 Bit 4 Channels) (Sheet 4 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x006C | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x006D | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x006E | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x006F | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0070-0x007F Reserved

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0070- | Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x007F |  |  |  |  |  |  |  |  |  |  |

$0 \times 0080$ - 0x00AF ATD (Analog to Digital Converter 10 Bit 16 Channel) (Sheet 1 of 3)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0080 | ATDCTLO | R | 0 | 0 | 0 | 0 | WRAP3 ${ }^{1}$ | WRAP2 ${ }^{1}$ | WRAP1 ${ }^{1}$ | WRAP0 ${ }^{1}$ |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0081 | ATDCTL1 | R | ETRIGSEL ${ }^{2}$ | 0 | 0 | 0 | ETRIGCH3 ${ }^{2}$ | ETRIGCH2 ${ }^{2}$ | ETRIGCH1 ${ }^{2}$ | ETRIGCH0 ${ }^{2}$ |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0082 | ATDCTL2 | R | ADPU | AFFC | AWAI | ETRIGLE | ETRIGP | ETRIG | ASCIE | ASCIF |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0083 | ATDCTL3 | R | 0 | S8C | S4C | S2C | S1C | FIFO | FRZ1 | FRZ0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0084 | ATDCTL4 | R | SRES8 | SMP1 | SMP0 | PRS4 | PRS3 | PRS2 | PRS1 | PRS0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0085 | ATDCTL5 | R | DJM | DSGN | SCAN | MULT | 0 | CC | CB | CA |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0086 | ATDSTATO | R | SCF | 0 | ETORF | FIFOR | 0 | CC2 | CC1 | CC0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0087 | Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0088 | ATDTEST0 | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0089 | ATDTEST1 | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | SC |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x008A | ATDSTAT0 | R | CCF15 | CCF14 | CCF13 | CCF12 | CCF11 | CCF10 | CCF9 | CCF8 |
|  |  | W |  |  |  |  |  |  |  |  |

MC9S12E128 Data Sheet, Rev. 1.07
$0 \times 0080$ - 0x00AF ATD (Analog to Digital Converter 10 Bit 16 Channel) (Sheet 2 of 3)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x008B | ATDSTAT1 | $R$$W$ | CCF7 | CCF6 | CCF5 | CCF4 | CCF3 | CCF2 | CCF1 | CCFO |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x008C | ATDDIEN0 | $R$ $W$ | IEN15 | IEN14 | IEN13 | IEN12 | IEN11 | IEN10 | IEN9 | IEN8 |
| 0x008D | ATDDIEN1 | $R$ $W$ | IEN7 | IEN6 | IEN5 | IEN4 | IEN3 | IEN2 | IEN1 | IENO |
| 0x008E | PORTAD0 | R | PTAD15 | PTAD14 | PTAD13 | PTAD12 | PTAD11 | PTAD10 | PTAD9 | PTAD8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x008F | PORTAD1 | R | PTAD7 | PTAD6 | PTAD5 | PTAD4 | PTAD3 | PTAD2 | PTAD1 | PTAD0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0090$ | ATDDROH | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0091 | ATDDROL | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0092 | ATDDR1H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0093$ | ATDDR1L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0094$ | ATDDR2H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0095$ | ATDDR2L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0096$ | ATDDR3H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0097$ | ATDDR3L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0098 | ATDDR4H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0099 | ATDDR4L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x009A | ATDDR5H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x009B | ATDDR5L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x009C | ATDDR6H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x009D | ATDDR6L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0080-0x00AF ATD (Analog to Digital Converter 10 Bit 16 Channel) (Sheet 3 of 3)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x009E | ATDDR7H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x009F | ATDDR7L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A0 | ATDDR8H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A1 | ATDDR8L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A2 | ATDDR9H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A3 | ATDDR9L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A4 | ATDDR10H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A5 | ATDDR10L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A6 | ATDDR11H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A7 | ATDDR11L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A8 | ATDDR12H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00A9 | ATDDR12L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00AA | ATDDR13H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 00 \mathrm{AB}$ | ATDDR13L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00AC | ATDDR14H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00AD | ATDDR14L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00AE | ATDDR15H | R | Bit15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit8 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00AF | ATDDR15L | R | Bit7 | Bit6 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

1 WRAP0-3 bits are available in version V04 of ATD10B16C
2 ETRIGSEL and ETRIGCH0-3 bits are available in version V04 of ATD10B16C

## 0x00B0 - 0x00C7 Reserved

| Address | Name | Bit 7 |  | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{gathered} 0 \times 00 \mathrm{BO}- \\ 0 \times 00 \mathrm{C} 7 \end{gathered}$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

## 0x00C8 - 0x00CF SCIO (Asynchronous Serial Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00C8 | SCIBDH | $R$ $W$ | IREN | TNP1 | TNP0 | SBR12 | SBR11 | SBR10 | SBR9 | SBR8 |
| 0x00C9 | SCIBDL | $R$ $W$ | SBR7 | SBR6 | SBR5 | SBR4 | SBR3 | SBR2 | SBR1 | SBR0 |
| 0x00CA | SCICR1 | $R$ $W$ | LOOPS | SCISWAI | RSRC | M | WAKE | ILT | PE | PT |
| 0x00CB | SCICR2 | $R$ $W$ | TIE | TCIE | RIE | ILIE | TE | RE | RWU | SBK |
| x00CC | SCISR | R | TDRE | TC | RDRF | IDLE | OR | NF | FE | PF |
| 0x00CC | SCISR | W |  |  |  |  |  |  |  |  |
| 0x00CD | SCISR2 | R | 0 | 0 | 0 | TXPOL ${ }^{1}$ | RXPOL ${ }^{1}$ | BRK13 | TXDIR | RAF |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00CE | SCIDRH | R | R8 | T8 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00CF | SCIDRL | R | R7 | R6 | R5 | R4 | R3 | R2 | R1 | R0 |
|  |  | W | T7 | T6 | T5 | T4 | T3 | T2 | T1 | T0 |

1 TXPOL and RXPOL bits are available in version V04 of SCI

0x00D0 - 0x00D7 SCl1 (Asynchronous Serial Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00D0 | SCIBDH | R W | IREN | TNP1 | TNP0 | SBR12 | SBR11 | SBR10 | SBR9 | SBR8 |
| 0x00D1 | SCIBDL | $R$ $W$ | SBR7 | SBR6 | SBR5 | SBR4 | SBR3 | SBR2 | SBR1 | SBR0 |
| 0x00D2 | SCICR1 | R W | LOOPS | SCISWAI | RSRC | M | WAKE | ILT | PE | PT |
| 0x00D3 | SCICR2 | R W | TIE | TCIE | RIE | ILIE | TE | RE | RWU | SBK |
| 0x00D |  | R | TDRE | TC | RDRF | IDLE | OR | NF | FE | PF |
| , |  | W |  |  |  |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)

## 0x00D0 - 0x00D7 SCl1 (Asynchronous Serial Interface) (continued)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00D5 | SCISR2 | R | 0 | 0 | 0 | TXPOL ${ }^{1}$ | RXPOL ${ }^{1}$ | BRK13 | TXDIR | RAF |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00D6 | SCIDRH | R | R8 | T8 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00D7 | SCIDRL | R | R7 | R6 | R5 | R4 | R3 | R2 | R1 | R0 |
|  |  | W | T7 | T6 | T5 | T4 | T3 | T2 | T1 | T0 |

1 TXPOL and RXPOL are available in version V04 of SCl

0x00D8 - 0x00DF SPI (Serial Peripheral Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00D8 | SPICR1 | $R$ $W$ | SPIE | SPE | SPTIE | MSTR | CPOL | CPHA | SSOE | LSBFE |
| 0x00D9 | SPICR2 | R | 0 | 0 | 0 | MODFEN | BIDIROE | 0 | SPISWAI | SPC0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00DA | SPIBR | R$W$ | 0 | SPPR2 | SPPR1 | SPPR0 | 0 | SPR2 | SPR1 | SPR0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00DB | SPISR | $R$$W$ | SPIF | 0 | SPTEF | MODF | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00DC | Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00DD | SPIDR | $R$ $W$ | Bit7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit0 |
| 0x00DE | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00DF | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x00E0 - 0x00E7 IIC (Inter-IC Bus)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00E0 | IBAD | R | ADR7 | ADR6 | ADR5 | ADR4 | ADR3 | ADR2 | ADR1 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00E1 | IBFD | $R$ $W$ | IBC7 | IBC6 | IBC5 | IBC4 | IBC3 | IBC2 | IBC1 | IBCO |
| 0x00E2 | IBCR | R | IBEN | IBIE | MS/SL | $T x / \overline{R x}$ | TXAK | 0 | 0 | IBSWAI |
|  |  | W |  |  |  |  |  | RSTA |  |  |
| 0x00E3 | IBSR | R | TCF | IAAS | IBB | IBAL | 0 | SRW | IBIF | RXAK |
|  |  | W |  |  |  |  |  |  |  |  |

## 0x00E0 - 0x00E7 IIC (Inter-IC Bus) (continued)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00E4 | IBDR | $R$ $W$ | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
| 0x00E5 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00E6 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00E7 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x00E8 - 0x00EF SCI2 (Asynchronous Serial Interface)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00E8 | SCIBDH | $R$ $W$ | IREN | TNP1 | TNP0 | SBR12 | SBR11 | SBR10 | SBR9 | SBR8 |
| 0x00E9 | SCIBDL | $R$ $W$ | SBR7 | SBR6 | SBR5 | SBR4 | SBR3 | SBR2 | SBR1 | SBR0 |
| 0x00EA | SCICR1 | R W | LOOPS | SCISWAI | RSRC | M | WAKE | ILT | PE | PT |
| 0x00EB | SCICR2 | $R$ $W$ | TIE | TCIE | RIE | ILIE | TE | RE | RWU | SBK |
| 0x00EC | SCIS | R | TDRE | TC | RDRF | IDLE | OR | NF | FE | PF |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00ED | SCISR2 | R | 0 | 0 | 0 | TXPOL ${ }^{1}$ | RXPOL ${ }^{1}$ | BRK13 | TXDIR | RAF |
| 0x00EE | SCIDRH | RW | R8 | T8 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00EF | SCIDRL | R | R7 | R6 | R5 | R4 | R3 | R2 | R1 | R0 |
|  |  | W | T7 | T6 | T5 | T4 | T3 | T2 | T1 | T0 |

1 TXPOL and RXPOL are available in version V04 of SCI

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x00F0 - 0x00F3 DAC0 (Digital-to-Analog Converter)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00F0 | DACCO |  | DACE | DACTE | 0 | 0 | DJM | DSGN | DACWAI | DACOE |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00F1 | DACC1 | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00F2 | DACD | $R$ $W$ | BIT7 | BIT6 | BIT5 | BIT4 | BIT3 | BIT2 | BIT1 | BITO |
| 0x00F3 | DACD | $R$ $W$ | BIT7 | BIT6 | BIT5 | BIT4 | BIT3 | BIT2 | BIT1 | BITO |

0x00F4 - 0x00F7 DAC1 (Digital-to-Analog Converter)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x00F4 | DACCO | R | DACE | DACTE | 0 | 0 | DJM | DSGN | DACWAI | DACOE |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x00F5 | DACC1 | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x00F6 | DACD | $R$ $W$ | BIT7 | BIT6 | BIT5 | BIT4 | BIT3 | BIT2 | BIT1 | BITO |
| 0x00F7 | DACD | $R$ $W$ | BIT7 | BIT6 | BIT5 | BIT4 | BIT3 | BIT2 | BIT1 | BITO |

## 0x00F8 - 0x00FF Reserved

| Address | Name |  | it 7 | Bit | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{aligned} & 0 \times 00 \mathrm{~F} 8- \\ & 0 \times 00 \mathrm{FF} \end{aligned}$ | Reserved | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |

0x0100-0x010F Flash Control Register

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0100 | FCLKDIV | R | FDIVLD | PRDIV8 | FDIV5 | FDIV4 | FDIV3 | FDIV2 | FDIV1 | FDIV0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0101$ | FSEC | R | KEYEN1 | NV6 | NV5 | NV4 | NV3 | NV2 | SEC1 | SEC0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0102$ | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0103$ | FCNFG | R | CBEIE | CCIE | KEYACC | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0104 | FPROT | $R$ $W$ | FPOPEN | NV6 | FPHDIS | FPHS1 | FPHSO | FPLDIS | FPLS1 | FPLS0 |

## 0x0100-0x010F Flash Control Register (continued)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0105 | FSTAT | R | CBEIF | CCIF | PVIOL | ACCERR | 0 | BLANK | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0106$ | FCMD | R | 0 | CMDB6 | CMDB5 | 0 | 0 | CMDB2 | 0 | CMDB0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0107$ | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0108 | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0109 | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010A | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010B | Reserved for Factory Test | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010C | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010D | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010E | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x010F | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

## $0 \times 0110$ - 0x013F Reserved

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{gathered} 0 \times 0110- \\ 0 \times 013 F \end{gathered}$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

$0 \times 0140$ - 0x016F TIM1 (Timer 16 Bit 4 Channels) (Sheet 1 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0140$ | TIOS | R | 1057 | IOS6 | IOS5 | IOS4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0141$ | CFORC | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W | FOC7 | FOC6 | FOC5 | FOC4 |  |  |  |  |
| $0 \times 0142$ | OC7M | R | OC7M7 | OC7M6 | OC7M5 | OC7M4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0143 | OC7D | R | OC7D7 | OC7D6 | OC7D5 | OC7D4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

MC9S12E128 Data Sheet, Rev. 1.07

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
$0 \times 0140$ - 0x016F TIM1 (Timer 16 Bit 4 Channels) (Sheet 2 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0144 | TCNT (hi) | R | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0145$ | TCNT (lo) | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0146$ | TSCR1 | R | TEN | TSWAI | TSFRZ | TFFCA | 0 | 0 | 0 | 0 |
|  |  | W | TEN | TSWAI | TSFRZ | TFFCA |  |  |  |  |
| $0 \times 0147$ | TTOV | R | TOV7 | TOV6 | TOV5 | TOV4 | 0 | 0 | 0 | 0 |
|  |  | W | TOV7 | TOV6 | TOV5 | TOV4 |  |  |  |  |
| 0x0148 | TCTL1 | R W | OM7 | OL7 | OM6 | OL6 | OM5 | OL5 | OM4 | OL4 |
| 0x0149 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x014A | TCTL3 | R W | EDG7B | EDG7A | EDG6B | EDG6A | EDG5B | EDG5A | EDG4B | EDG4A |
| 0x014B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x014C | TIE | R | C71 | C61 | C5I | C4I | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x014D | TSCR2 | R | TOI | 0 | 0 | 0 | TCRE | PR2 | PR1 | PR0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x014E | TFLG1 | R | C7F | C6F | C5F | C4F | 0 | 0 | 0 | 0 |
|  |  | W | C7F | C6F | C5F | C4F |  |  |  |  |
| 0x014F | TFLG2 | R | TOF | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W | TOF |  |  |  |  |  |  |  |
| 0x0150 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0151 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0152$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0153$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0154$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0155 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0156 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

## 0x0140-0x016F TIM1 (Timer 16 Bit 4 Channels) (Sheet 3 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0157$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0158 | TC4 (hi) | R W | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0159 | TC4 (lo) | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x015A | TC5 (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x015B | TC5 (lo) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x015C | TC6 (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x015D | TC6 (lo) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x015E | TC7 (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x015F | TC7 (1o) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| $0 \times 0160$ | PA | $R$ $W$ | 0 | PAEN | PAMOD | PEDGE | CLK1 | CLKO | PAOVI | PAI |
| $0 \times 0161$ | PAFLG | R | 0 | 0 | 0 | 0 | 0 | 0 | PAOVF | PAIF |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0162 | PACNT (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0163 | PACNT (lo) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x0164 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0165$ | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0166$ | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0167$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0168$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0169 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)

## 0x0140-0x016F TIM1 (Timer 16 Bit 4 Channels) (Sheet 4 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x016A | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x016B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x016C | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x016D | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x016E | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x016F | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

## $0 \times 0170$ - 0x017F Reserved

| Address | Name |  | it 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{gathered} 0 \times 0110- \\ 0 \times 013 F \end{gathered}$ | Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |

$0 \times 0180$ - 0x01AF TIM2 (Timer 16 Bit 4 Channels) (Sheet 1 of 3)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0180$ | TIOS | R | IOS7 | IOS6 | IOS5 | IOS4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0181 | CFORC | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W | FOC7 | FOC6 | FOC5 | FOC4 |  |  |  |  |
| $0 \times 0182$ | OC7M | R | OC7M7 | OC7M6 | OC7M5 | OC7M4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0183$ | OC7D | R | OC7D7 | OC7D6 | OC7D5 | OC7D4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0184$ | TCNT (hi) | R | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0185$ | TCNT (lo) | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0186 | TSCR1 | R | TEN | TSWAI | TSFRZ | TFFCA | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0187$ | TTOV | R | TOV7 | TOV6 | TOV5 | TOV4 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0188$ | TCTL1 | $\begin{gathered} R \\ W \end{gathered}$ | OM7 | OL7 | OM6 | OL6 | OM5 | OL5 | OM4 | OL4 |


| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0189 | Reserved | $R$W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x018A | TCTL3 | R | EDG7B | EDG7A | EDG6B | EDG6A | EDG5B | EDG5A | EDG4B | EDG4A |
| 0x018B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x018C | TIE | $\begin{gathered} \mathrm{R} \\ \mathrm{w} \end{gathered}$ | C71 | C6I | C5I | C4I | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x018D | TSCR2 | R | TOI | 0 | 0 | 0 | TCRE | PR2 | PR1 | PR0 |
| 0x018E | TFLG1 | RW | C7F | C6F | C5F | C4F | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x018F | TFLG2 | $\mathrm{R}$ | TOF | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x0190 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0191 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0192 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0193$ | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0194 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0195 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0196 | Reserved | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0197 | Reserved | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0198 | TC4 (hi) | $\begin{gathered} \mathrm{R} \\ \hline \end{gathered}$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0199 | TC4 (10) | $\begin{gathered} \mathrm{R} \\ \mathrm{w} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x015A | TC5 (hi) | R W | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x019B | TC5 (10) | $\begin{gathered} \mathrm{R} \\ \mathrm{w} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x019C | TC6 (hi) |  | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
$0 \times 0180$ - 0x01AF TIM2 (Timer 16 Bit 4 Channels) (Sheet 3 of 3)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x019D | TC6 (10) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x019E | TC7 (hi) | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x019F | TC7 (o) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01A0 | PACTL | $R$ $W$ | 0 | PAEN | PAMOD | PEDGE | CLK1 | CLK0 | PAOVI | PAI |
| 0x01A1 | PAFLG | R | 0 | 0 | 0 | 0 | 0 | 0 | PAOVF | PAIF |
| Ox01A1 | PAFLG | W |  |  |  |  |  |  | PAOVF |  |
| 0x01A2 | PACNT (hi) | R W | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x01A3 | PACNT (lo) | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| x01A4 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 退A4 | Reserved | W |  |  |  |  |  |  |  |  |
| 0x01A5 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01A6 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01A7 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01A9 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01AA | Reserve | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01AB | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| A |  | W |  |  |  |  |  |  |  |  |
| 0x01AC | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01AD | er | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x01AE | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
|  |  | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 1AF | Reserved | W |  |  |  |  |  |  |  |  |

## 0x01B0 - 0x01DF Reserved

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{gathered} 0 \times 01 \mathrm{B0}- \\ 0 \times 01 \mathrm{DF} \end{gathered}$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x01E0 - 0x01FF PWM (Pulse Width Modulator)

| Address Name Bit 7 Bit 6 Bit 5 Bit 4 Bit 3 Bit 2 Bit 1 Bit 0 |  |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x01E0 | PWME | 0 | 0 | PWME5 | PWME4 | PWME3 | PWME2 | PWME1 | PWME0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E1 | PWMPOL | 0 | 0 | PPOL5 | PPOL4 | PPOL3 | PPOL2 | PPOL1 | PPOL0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E2 | PWMCLK | 0 | 0 | PCLK5 | PCLK4 | PCLK3 | PCLK2 | PCLK1 | PCLK0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E3 | PWMPRCLK | 0 | PCKB2 | PCKB1 | PCKB0 | 0 | PCKA2 | PCKA1 | PCKA0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E4 | PWMCAE | 0 | 0 | CAE5 | CAE4 | CAE3 | CAE2 | CAE1 | CAE0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E5 | PWMCTL | 0 | CON45 | CON23 | CON01 | PSWAI | PFRZ | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E6 | PWMTST Test Only | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E7 | PWMPRSC | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01E8 | PWMSCLA | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01E9 | PWMSCLB | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01EA | PWMSCNTA | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01EB | PWMSCNTB | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| 0x01EC | PWMCNT0 | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x01ED | PWMCNT1 | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x01EE | PWMCNT2 | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x01EF | PWMCNT3 | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x01E0 - 0x01FF PWM (Pulse Width Modulator) (continued)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x01F0 | PWMCNT4 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x01F1 | PWMCNT5 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x01F2 | PWMPER0 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F3 | PWMPER1 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F4 | PWMPER2 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F5 | PWMPER3 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F6 | PWMPER4 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F7 | PWMPER5 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F8 | PWMDTY0 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01F9 | PWMDTY1 | R $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01FA | PWMDTY2 | R $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| $0 \times 01 \mathrm{FB}$ | PWMDTY3 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01FC | PWMDTY4 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01FD | PWMDTY5 | R $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x01FE | PWMSDN | R |  |  | 0 |  | 0 | PWM5IN |  |  |
|  |  | W | PWMF | PWME | PWMRSTRT | , |  |  | PWMSINL | PWIJENA |
| 0x01FF | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0200-0x023F PMF (Pulse width Modulator with Fault protection) (Sheet 1 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0200 | PMFCFG0 | $R$ $W$ | WP | MTG | EDGEC | EDGEB | EDGEA | INDEPC | INDEPB | INDEPA |
| 0x0201 | PMFCFG1 | $R$ $W$ | ENHA | 0 | BOTNEGC | TOPNEGC | BOTNEGB | TOPNEGB | BOTNEGA | TOPNEGA |
| 0x0202 | PMFCFG2 | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | 0 | 0 | MSK5 | MSK4 | MSK3 | MSK2 | MSK1 | MSK0 |
| 0x0203 | PMFCFG3 | $\begin{gathered} R \\ \mathrm{~W} \end{gathered}$ | PMFWAI | PMFFRZ | 0 | VLMODE |  | SWAPC | SWAPB | SWAPA |
| 0x0204 | PMFFCTL | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | FMODE3 | FIE3 | FMODE2 | FIE2 | FMODE1 | FIE1 | FMODE0 | FIEO |
| 0x0205 | PMFFPIN | R | 0 | FPINE3 | 0 | FPINE2 | 0 | FPINE1 | 0 | FPINE0 |
|  |  |  |  |  |  |  |  |  |  |  |
| $0 \times 0206$ | PMFFSTA | $R$$W$ | 0 | FFLAG3 | 0 | FFLAG2 | 0 | FFLAG1 | 0 | FL |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0207 | PMFQSMP | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | QSMP3 |  | QSMP2 |  | QSMP1 |  | QSMP0 |  |
| 0x0208 | PMFDMPA | W | DMP13 | DMP12 | DMP11 | DMP10 | DMP03 | DMP02 | DMP01 | DMP00 |
| 0x0209 | PMFDMPB | $\begin{gathered} \mathrm{R} \\ \mathrm{w} \end{gathered}$ | DMP33 | DMP32 | DMP31 | DMP30 | DMP23 | DMP22 | DMP21 | DMP20 |
| 0x020A | PMFDMPC | $\begin{gathered} \mathrm{R} \\ \mathrm{w} \end{gathered}$ | DMP53 | DMP52 | DMP51 | DMP50 | DMP43 | DMP42 | DMP41 | DMP40 |
| 0x020B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 0x020C | PMFOUTC | R | 0 | 0 | OUTCTL5 | OUTCTL4 | OUTCTL3 | OUTCTL2 | OUTCTL1 | OUTCTLO |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x020D | PMFOUTB | R | 0 | 0 | OUT5 | OUT4 | OUT3 | OUT2 | OUT1 | OUT0 |
| 0x020E | PMFDTMS | $R$$W$ | 0 | 0 | DT5 | DT4 | DT3 | DT2 | DT1 | DT0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x020F | PMFCCTL | RW | 0 | 0 | ISENS |  | 0 | IPOLC | IPOLB | IPOLA |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0210 | PMFVALO | $\begin{gathered} R \\ \mathrm{~W} \end{gathered}$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0211 | PMFVALO | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x0212 | PMFVAL1 |  | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)

## 0x0200-0x023F PMF (Pulse width Modulator with Fault protection) (Sheet 2 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $0 \times 0213$ | PMFVAL1 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| $0 \times 0214$ | PMFVAL2 | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0215 | PMFVAL2 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x0216 | PMFVAL3 | $R$ $W$ | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0217 | PMFVAL3 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x0218 | PMFVAL4 | R W | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0219 | PMFVAL4 | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x021A | PMFVAL5 | R W | Bit 15 | 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x021B | PMFVAL5 | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x02 | R | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x021D | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x021E | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x021F | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0220 | PMFENCA | R | PWMENA | 0 | 0 | 0 | 0 | 0 | LDOKA | PWMRIEA |
|  |  | W | PWMENA |  |  |  |  |  | LDOKA | PWMRIEA |
| $0 \times 0221$ | PMFFQCA | W |  |  |  |  | HALFA |  |  | PWMRFA |
| $0 \times 0222$ | PMFCNTA | R W | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| $0 \times 0223$ | PMFCNTA | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| 0x0224 | PMFMODA | R W | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| 0x0225 | PMFMODA |  | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |

## 0x0200-0x023F PMF (Pulse width Modulator with Fault protection) (Sheet 3 of 4)

Address

## Name

$0 \times 0226$ PMFDTMA $0 \times 0227$ $0 \times 0228$
0x0229
PMFDTMA

PMFENCB
$0 \times 022 A$
PMFFQCB PMFCNTB 0x022B PMFCNTB 0x022C PMFMODB 0x022D PMFMODB 0x022E PMFDTMB 0x022F PMFDTMB $0 \times 0230$ PMFENCC $0 \times 0231$ PMFFQCC

| R | 0 | 0 | 0 | 0 | Bit 11 | 10 | 9 | Bit 8 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W |  |  |  |  |  |  |  |  |
| R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| $R$$W$ | PWMENB | 0 | 0 | 0 | 0 | 0 | LDOKB | PWMRIEB |
|  |  |  |  |  |  | 0 |  |  |
| R | LDFQB |  |  |  | HALFB | PRSCB |  | PWMRFB |
| R | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| R | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W |  |  |  |  |  |  |  |  |
| R | 0 | 0 | 0 | 0 | Bit 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W |  |  |  |  |  |  |  |  |
| R | PWMENC | 0 | 0 | 0 | 0 | 0 | LDOKC | PWMRIEC |
| W |  |  |  |  |  |  |  |  |
| R | LDFQC |  |  |  | HALFC | PRSCC |  | PWMRFC |
| W |  |  |  |  | HALFC |  |  |  |  |
| R | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W | Bit | 6 |  |  |  |  |  |  |
| R | 0 | Bit 14 | 13 | 12 | 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W |  |  |  |  |  |  |  |  |
| R | 0 | 0 | 0 | 0 | Bit 11 | 10 | 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W |  |  |  |  |  |  |  |  |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0200-0x023F PMF (Pulse width Modulator with Fault protection) (Sheet 4 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0239 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x023A | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x023B | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x023C | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x023D | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x023E | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 023 F$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

0x0240-0x027F PIM (Port Interface Module) (Sheet 1 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0240 | PTT | $R$ $W$ | PTT7 | PTT6 | PTT5 | PTT4 | PTT3 | PTT2 | PTT1 | PTT0 |
| $0 \times 0241$ | PTIT | RW | PTIT7 | PTIT6 | PTIT5 | PTIT4 | PTIT3 | PTIT2 | PTIT1 | PTIT0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0242 | DDRT | R W | DDRT7 | DDRT7 | DDRT5 | DDRT4 | DDRT3 | DDRT2 | DDRT1 | DDRT0 |
| $0 \times 0243$ | RDRT | R W | RDRT7 | RDRT6 | RDRT5 | RDRT4 | RDRT3 | RDRT2 | RDRT1 | RDRT0 |
| 0x0244 | PERT | R W | PERT7 | PERT6 | PERT5 | PERT4 | PERT3 | PERT2 | PERT1 | PERT0 |
| $0 \times 0245$ | PPST | R W | PPST7 | PPST6 | PPST5 | PPST4 | PPST3 | PPST2 | PPST1 | PPST0 |
| 0x0246 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0247 | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0248 | PTS | R W | PTS7 | PTS6 | PTS5 | PTS4 | PTS3 | PTS2 | PTS1 | PTS0 |
| 0x0249 | PTIS | R | PTIS7 | PTIS6 | PTIS5 | PTIS4 | PTIS3 | PTIS2 | PTIS1 | PTIS0 |
|  |  | W |  |  |  |  |  |  |  |  |

## 0x0240-0x027F PIM (Port Interface Module) (Sheet 2 of 4)



Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)
0x0240-0x027F PIM (Port Interface Module) (Sheet 3 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x025D | PPSP |  | 0 | 0 | PPSP5 | PPSP4 | PPSP3 | PPSP2 | PPSP1 | PPSP0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x025E | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x025F | Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0260 | PTQ | R | 0 | PTQ6 | PTQ5 | PTQ4 | PTQ3 | PTQ2 | PTQ1 | PTQ0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0261 | PTIQ | RW | 0 | PTIQ6 | PTIQ5 | PTIQ4 | PTIQ3 | PTIQ2 | PTIQ1 | PTIQ0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0262 | DDRQ | R | 0 | DDRQ6 | DDRQ5 | DDRQ4 | DDRQ3 | DDRQ2 | DDRQ1 | DDRQ0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0263 | RDRQ | R | 0 | RDRQ6 | RDRQ5 | RDRQ4 | RDRQ3 | RDRQ2 | RDRQ1 | RDRQ0 |
| 0x0264 | PERQ | R | 0 | PERQ6 | PERQ5 | PERQ4 | PERQ3 | PERQ2 | PERQ1 | PERQ0 |
|  |  | W |  |  |  |  |  |  |  |  |
| 0x0265 | PPSQ | R | 0 | PPSQ6 | PPSQ5 | PPSQ4 | PPSQ3 | PPSQ2 | PPSQ1 | PPSQ0 |
| 0x0266 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0267 | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x0268 | PTU | R | PTU7 | PTU6 | PTU5 | PTU4 | PTU3 | PTU2 | PTU1 | PTU0 |
| 0x0269 | PTIU | $R$$W$ | PTIU7 | PTIU6 | PTIU5 | PTIU4 | PTIU3 | PTIU2 | PTIU1 | PTIU0 |
|  |  |  |  |  |  |  |  |  |  |  |
| 0x026A | DDRU | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | DDRU7 | DDRU6 | DDRU5 | DDRU4 | DDRU3 | DDRU2 | DDRU1 | DDRU0 |
| 0x026B | RDRU | R | RDRU7 | RDRU6 | RDRU5 | RDRU4 | RDRU3 | RDRU2 | RDRU1 | RDRU0 |
| 0x026C | PERU | W | PERU7 | PERU6 | PERU5 | PERU4 | PERU3 | PERU2 | PERU1 | PERU0 |
| 0x026D | PPSU | W | PPSU7 | PPSU6 | PPSU5 | PPSU4 | PPSU3 | PPSU2 | PPSU1 | PPSU0 |
| 0x026E | MODRR |  | 0 | 0 | 0 | 0 | MODRR3 | MODRR2 | MODRR1 | MODRR0 |
| 0x026F | Reserved | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |  |

## 0x0240-0x027F PIM (Port Interface Module) (Sheet 4 of 4)

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0x0270 | PTAD(H) | $R$ $W$ | PTAD15 | PTAD14 | PTAD13 | PTAD12 | PTAD11 | PTAD10 | PTAD9 | PTAD8 |
| 0x0271 | PTAD(L) | $R$ $W$ | PTAD7 | PTAD6 | PTAD5 | PTAD4 | PTAD3 | PTAD2 | PTAD1 | PTAD0 |
| 0x0272 |  | R | PTIAD15 | PTIAD14 | PTIAD13 | PTIAD12 | PTIAD11 | PTIAD10 | PTIAD9 | PTIAD8 |
| $0 \times 0272$ |  | W |  |  |  |  |  |  |  |  |
| 0x0273 |  | R | PTIAD7 | PTIAD6 | PTIAD5 | PTIAD4 | PTIAD3 | PTIAD2 | PTIAD1 | PTIAD0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $0 \times 0274$ | DDRAD(H) | $R$ $W$ | DDRAD15 | DDRAD14 | DDRAD13 | DDRAD12 | DDRAD11 | DDRAD10 | DDRAD9 | DDRAD8 |
| $0 \times 0275$ | DDRAD(L) | $R$ $W$ | DDRAD7 | DDRAD6 | DDRAD5 | DDRAD4 | DDRAD3 | DDRAD2 | DDRAD1 | DDRAD0 |
| $0 \times 0276$ | RDRAD(H) | $R$ $W$ | RDRAD15 | RDRAD14 | RDRAD13 | RDRAD12 | RDRAD11 | RDRAD10 | RDRAD9 | RDRAD8 |
| $0 \times 0277$ | RDRAD(L) | $R$ $W$ | RDRAD7 | RDRAD6 | RDRAD5 | RDRAD4 | RDRAD3 | RDRAD2 | RDRAD1 | RDRAD0 |
| $0 \times 0278$ | PERAD(H) | $R$ $W$ | PERAD15 | PERAD14 | PERAD13 | PERAD12 | PERAD11 | PERAD10 | PERAD9 | PERAD8 |
| $0 \times 0279$ | PERAD(L) | $R$ $W$ | PERAD7 | PERAD6 | PERAD5 | PERAD4 | PERAD3 | PERAD2 | PERAD1 | PERAD0 |
| 0x027A | PPSAD(H) | $R$ $W$ | PPSAD15 | PPSAD14 | PPSAD13 | PPSAD12 | PPSAD11 | PPSAD10 | PPSAD9 | PPSAD8 |
| 0x027B | PPSAD(L) | $R$ $W$ | PPSAD7 | PPSAD6 | PPSAD5 | PPSAD4 | PPSAD3 | PPSAD2 | PPSAD1 | PPSAD0 |
| 0x027C | $\operatorname{PIEAD}(\mathrm{H})$ | $R$ $W$ | PIEAD15 | PIEAD14 | PIEAD13 | PIEAD12 | PIEAD11 | PIEAD10 | PIEAD9 | PIEAD8 |
| 0x027D | PIEAD(L) | $R$ $W$ | PIEAD7 | PIEAD6 | PIEAD5 | PIEAD4 | PIEAD3 | PIEAD2 | PIEAD1 | PIEAD0 |
| 0x027E | PIFAD(H) | $R$ $W$ | PIFAD15 | PIFAD14 | PIFAD13 | PIFAD12 | PIFAD11 | PIFAD10 | PIFAD9 | PIFAD8 |
| 0x027F | PIFAD(L) | R W | PIFAD7 | PIFAD6 | PIFAD5 | PIFAD4 | PIFAD3 | PIFAD2 | PIFAD1 | PIFAD0 |

0x0280-0x03FF Reserved Space

| Address | Name |  | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{gathered} 0 \times 0280- \\ 0 \times 2 F F \end{gathered}$ | Reserved | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |
| $\begin{aligned} & 0 \times 0300- \\ & 0 \times 03 F F \end{aligned}$ | Unimplemented | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  | W |  |  |  |  |  |  |  |  |

MC9S12E128 Data Sheet, Rev. 1.07

Chapter 1 MC9S12E128 Device Overview (MC9S12E128DGV1)

### 1.2.2 Part ID Assignments

The part ID is located in two 8-bit registers PARTIDH and PARTIDL (addresses 0x001A and 0x001B after reset. The read-only value is a unique part ID for each revision of the chip. Table 1-2 shows the assigned part ID numbers.

Table 1-2. Assigned Part ID Numbers

| Device | Mask Set Number | Part ID ${ }^{\mathbf{1}}$ |
| :---: | :---: | :---: |
| MC9S12E128 | $2 L 15 P$ | $0 \times 5102$ |

1 The coding is as follows:
Bit 15-12: Major family identifier
Bit 11-8: Minor family identifier
Bit 7-4: Major mask set revision number including FAB transfers
Bit 3-0: Minor - non full - mask set revision

The device memory sizes are located in two 8-bit registers MEMSIZ0 and MEMSIZ1 (addresses 0x001C and $0 x 001 \mathrm{D}$ after reset). Table $1-3$ shows the read-only values of these registers. Refer to HCS12 Module Mapping Control (MMC) block description chapter for further details.

Table 1-3. Memory Size Registers

| Device | Register name | Value |
| :---: | :---: | :---: |
| MC9S12E128 | MEMSIZ0 | $0 \times 03$ |
| MC9S12E128 | MEMSIZ1 | $0 \times 80$ |

### 1.3 Signal Description

### 1.3.1 Device Pinout



Signals shown in Bold are not available on the 80-pin package
Figure 1-5. Pin Assignments for 112-LQFP


Signals shown in Bold are not available on the 64-pin package
Figure 1-6. Pin Assignments for 80-QFP


Figure 1-7. Pin Assignments for 64-QFN

### 1.3.2 Signal Properties Summary

Table 1-4. Signal Properties

| Pin Name Function 1 | Pin Name Function 2 | Pin Name Function 3 | Power Domain | Internal Pull Resistor |  | Description |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | CTRL | Reset State |  |
| EXTAL | - | - | VDDPLL | NA | NA | Oscillator pins |
| XTAL | - | - | VDDPLL | NA | NA |  |
| XFC | - | - | VDDPLL | NA | NA | PLL loop filter pin |
| RESET | - | - | VDDX | None | None | External reset pin |
| BKGD | MODC | TAGHI | VDDX | Up | Up | Background debug, mode pin, tag signal high |
| TEST | VPP | - | NA | NA | NA | Test pin only |
| $\begin{array}{\|c\|} \hline \text { PAD[15,13, } \\ 12,8,6,4,2,0] \end{array}$ | $\begin{gathered} \text { AN }[15,13, \\ 12,8,6,4,2,0] \end{gathered}$ | $\begin{gathered} \hline \text { KWAD[15,13, } \\ 12,8,6,4,2,0] \end{gathered}$ | VDDX | PERAD/ PPSAD | Disabled | Port AD I/O Pins, ATD inputs, keypad Wake-up |
| $\begin{array}{\|c} \hline \text { PAD[14,11, } \\ 10,9,7,5,3,1] \end{array}$ | $\begin{gathered} \text { AN }[14,11, \\ 10,9,7,5,3,1] \end{gathered}$ | $\begin{aligned} & \hline \text { KWAD[14,11, } \\ & 10,9,7,5,3,1] \end{aligned}$ | VDDX | PERAD/ PPSAD | Disabled | Port AD I/O Pins, ATD inputs, keypad Wake-up |
| PA[7:0] | $\begin{gathered} \hline \text { ADDR[15:8]/ } \\ \text { DATA[15:8] } \end{gathered}$ | - | VDDX | PUCR | Disabled | Port A I/O pin, multiplexed address/data |
| PB[7:0] | $\begin{aligned} & \text { ADDR[7:0]/ } \\ & \text { DATA[7:0] } \end{aligned}$ | - | VDDX | PUCR | Disabled | Port B I/O pin, multiplexed address/data |
| PE7 | NOACC | XCLKS | VDDX | Input | Input | Port E I/O pin, access, clock select |
| PE6 | IPIPE1 | MODB | VDDX | While RESET is low: Down |  | Port E I/O pin, pipe status, mode selection |
| PE5 | IPIPE0 | MODA | VDDX | While RESET is low: Down |  | Port E I/O pin, pipe status, mode selection |
| PE4 | ECLK | - | VDDX | PUCR | Mode Dep ${ }^{1}$ | Port E I/O pin, bus clock output |
| PE3 | $\overline{\text { LSTRB }}$ | TAGLO | VDDX | PUCR | Mode Dep ${ }^{1}$ | Port E I/O pin, low strobe, tag signal low |
| PE2 | R/W | - | VDDX | PUCR | Mode Dep ${ }^{1}$ | Port E I/O pin, R/W in expanded modes |
| PE1 | IRQ | - | VDDX | PUCR | Up | Port E input, external interrupt pin |
| PE0 | XIRQ | - | VDDX | PUCR | Up | Port E input, non-maskable interrupt pin |
| PK[7] | ECS | ROMCTL | VDDX | PUCR | Up | Port K I/O Pin, Emulation Chip Select |
| PK[6] | XCS | - | VDDX | PUCR | Up | Port K I/O Pin, External Chip Select |
| PK[5:0] | XADDR[19:14] | - | VDDX | PUCR | Up | Port K I/O Pins, Extended Addresses |
| PM7 | SCL | - | VDDX | PERM/ PPSM | Up | Port M I/O Pin, IIC SCL signal |
| PM6 | SDA | - | VDDX | PERM/ PPSM | Up | Port M I/O Pin, IIC SDA signal |
| PM5 | TXD2 | - | VDDX | PERM/ PPSM | Up | Port M I/O Pin, SCI2 transmit signal |
| PM4 | RXD2 | - | VDDX | PERM/ PPSM | Up | Port M I/O Pin, SCI2 receive signal |
| PM3 | - | - | VDDX | PERM/ PPSM | Disabled | Port M I/O Pin |
| PM1 | DAO1 | - | VDDX | PERM/ PPSM | Disabled | Port M I/O Pin, DAC1 output |

Table 1-4. Signal Properties

| Pin Name Function 1 | Pin Name Function 2 | Pin Name Function 3 | Power Domain | Internal Pull Resistor |  | Description |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | CTRL | Reset State |  |
| PM0 | DAO0 | - | VDDX | $\begin{aligned} & \hline \text { PERM/ } \\ & \text { PPSM } \end{aligned}$ | Disabled | Port M I/O Pin, DAC0 output |
| PP[5:0] | PW0[5:0] | - | VDDX | PERP/ PPSP | Disabled | Port P I/O Pins, PWM output |
| PQ[6:4] | $\overline{\text { IS [6:4] }}$ | - | VDDX | $\begin{aligned} & \hline \text { PERQ/ } \\ & \text { PPSQ } \end{aligned}$ | Disabled | Port Q I/O Pins, $\overline{\text { IS }}[6: 4]$ input |
| PQ[3:0] | FAULT[3:0] | - | VDDX | $\begin{aligned} & \hline \text { PERQ/ } \\ & \text { PPSQ } \end{aligned}$ | Disabled | Port Q I/O Pins, Fault[3:0] input |
| PS7 | SS | - | VDDX | $\begin{aligned} & \text { PERS/ } \\ & \text { PPSS } \end{aligned}$ | Up | Port S I/O Pin, SPI SS signal |
| PS6 | SCK | - | VDDX | $\begin{aligned} & \text { PERS/ } \\ & \text { PPSS } \end{aligned}$ | Up | Port S I/O Pin, SPI SCK signal |
| PS5 | MOSI | - | VDDX | PERS/ PPSS | Up | Port S I/O Pin, SPI MOSI signal |
| PS4 | MISO | - | VDDX | PERS/ PPSS | Up | Port S I/O Pin, SPI MISO signal |
| PS3 | TXD1 | - | VDDX | $\begin{aligned} & \text { PERS/ } \\ & \text { PPSS } \end{aligned}$ | Up | Port S I/O Pin, SCI1 transmit signal |
| PS2 | RXD1 | - | VDDX | PERS/ PPSS | Up | Port S I/O Pin, SCI1 receive signal |
| PS1 | TXD0 | - | VDDX | PERS/ PPSS | Up | Port S I/O Pin, SCIO transmit signal |
| PS0 | RXD0 | - | VDDX | PERS/ PPSS | Up | Port S I/O Pin, SCIO receive signal |
| PT[7:4] | IOC1[7:4] | - | VDDX | PERT/ PPST | Disabled | Port T I/O Pins, timer (TIM1) |
| PT[3:0] | IOC0[7:4] | - | VDDX | PERT/ PPST | Disabled | Port T I/O Pins, timer (TIM0) |
| PU[7:6] | - | - | VDDX | $\begin{aligned} & \text { PERU/ } \\ & \text { PPSU } \end{aligned}$ | Disabled | Port U I/O Pins |
| PU[5:4] | PW1[5:4] | - | VDDX | $\begin{aligned} & \text { PERU/ } \\ & \text { PPSU } \end{aligned}$ | Disabled | Port U I/O Pins, PWM outputs |
| PU[3:0] | IOC2[7:4] | PW1[3:0] | VDDX | $\begin{aligned} & \text { PERU/ } \\ & \text { PPSU } \end{aligned}$ | Disabled | Port U I/O Pins, timer (TIM2), PWM outputs |

1 The Port E output buffer enable signal control at reset is determined by the PEAR register and is mode dependent. For example, in special test mode RDWE = LSTRE $=1$ which enables the PE[3:2] output buffers and disables the pull-ups. Refer to the S12 MEBI block description chapter for PEAR register details.

## NOTE

Signals shown in bold are not available in the 112-pin package.
Signals shown in italic are not available in the 80-pin package.
If the port pins are not bonded out in the chosen package the user should initialize the registers to be inputs with enabled pull resistance to avoid excess current consumption. This applies to the following pins:
(80QFP): Port A[7:0], Port B[7:0], Port E[6,5,3,2], Port K[7:0], Port U[7:4]
(64QFN): Port U[3:0], Port Q[6:4], Port M[3], Port AD[14,11, 10,9,7,5,3,1]

### 1.4 Detailed Signal Descriptions

### 1.4.1 EXTAL, XTAL — Oscillator Pins

EXTAL and XTAL are the external clock and crystal driver pins. On reset all the device clocks are derived from the EXTAL input frequency. XTAL is the crystal output.

### 1.4.2 RESET - External Reset Pin

RESET is an active low bidirectional control signal that acts as an input to initialize the MCU to a known start-up state. It also acts as an open-drain output to indicate that an internal failure has been detected in either the clock monitor or COP watchdog circuit. External circuitry connected to the RESET pin should not include a large capacitance that would interfere with the ability of this signal to rise to a valid logic one within 32 ECLK cycles after the low drive is released. Upon detection of any reset, an internal circuit drives the RESET pin low and a clocked reset sequence controls when the MCU can begin normal processing.

### 1.4.3 TEST - Test Pin

The TEST pin is reserved for test and must be tied to VSS in all applications.

### 1.4.4 XFC — PLL Loop Filter Pin

Dedicated pin used to create the PLL loop filter. See the CRG block description chapter for more detailed information.

### 1.4.5 BKGD / TAGHI / MODC - Background Debug, Tag High \& Mode Pin

The BKGD / TAGHI / MODC pin is used as a pseudo-open-drain pin for the background debug communication. It is used as a MCU operating mode select pin during reset. The state of this pin is latched to the MODC bit at the rising edge of RESET. In MCU expanded modes of operation, when instruction tagging is on, an input low on this pin during the falling edge of E-clock tags the high half of the instruction word being read into the instruction queue. This pin always has an internal pull up.

### 1.4.6 PA[7:0] / ADDR[15:8] / DATA[15:8] — Port A I/O Pins

PA[7:0] are general purpose input or output pins. In MCU expanded modes of operation, these pins are used for the multiplexed external address and data bus. PA[7:0] pins are not available in the 80 pin package version.

### 1.4.7 PB[7:0] / ADDR[7:0] / DATA[7:0] — Port B I/O Pins

$\mathrm{PB}[7: 0]$ are general purpose input or output pins. In MCU expanded modes of operation, these pins are used for the multiplexed external address and data bus. $\mathrm{PB}[7: 0]$ pins are not available in the 80 pin package version.

### 1.4.8 PE7 / NOACC / XCLKS — Port E I/O Pin 7

PE7 is a general purpose input or output pin. During MCU expanded modes of operation, the NOACC signal, when enabled, is used to indicate that the current bus cycle is an unused or "free cycle". This signal will assert when the CPU is not using the bus. The XCLKS is an input signal which controls whether a crystal in combination with the internal Colpitts (low power) oscillator is used or whether Pierce oscillator/external clock circuitry is used. The state of this pin is latched at the rising edge of $\overline{\text { RESET }}$. If the input is a logic low the EXTAL pin is configured for an external clock drive or a Pierce Oscillator. If the input is a logic high a Colpitts oscillator circuit is configured on EXTAL and XTAL. Since this pin is an input with a pull-up device during reset, if the pin is left floating, the default configuration is a Colpitts oscillator circuit on EXTAL and XTAL.


1. Due to the nature of a translated ground Colpitts oscillator a DC voltage bias is applied to the crystal. Please contact the crystal manufacturer for crystal DC

Figure 1-8. Colpitts Oscillator Connections (PE7 = 1)


1. Rs can be zero (shorted) when use with higher frequency crystals. Refer to manufacturer's data.
Figure 1-9. Pierce Oscillator Connections (PE7 = 0)

### 1.4.9 PE6 / MODB / IPIPE1 - Port E I/O Pin 6

PE6 is a general purpose input or output pin. It is used as a MCU operating mode select pin during reset. The state of this pin is latched to the MODB bit at the rising edge of RESET. This pin is shared with the instruction queue tracking signal IPIPE1. This pin is an input with a pull-down device which is only active when RESET is low. PE6 is not available in the 80 pin package version.

### 1.4.10 PE5 / MODA / IPIPE0 - Port E I/O Pin 5

PE5 is a general purpose input or output pin. It is used as a MCU operating mode select pin during reset. The state of this pin is latched to the MODA bit at the rising edge of RESET. This pin is shared with the instruction queue tracking signal IPIPE0. This pin is an input with a pull-down device which is only active when RESET is low. PE5 is not available in the 80-pin package version.

### 1.4.11 PE4 / ECLK— Port E I/O Pin 4 / E-Clock Output

PE4 is a general purpose input or output pin. In Normal Single Chip mode PE4 is configured with an active pull-up while in reset and immediately out of reset. The pullup can be turned off by clearing PUPEE in the PUCR register. In all modes except Normal Single Chip Mode, the PE4 pin is initially configured as the output connection for the internal bus clock (ECLK). ECLK is used as a timing reference and to demultiplex the address and data in expanded modes. The ECLK frequency is equal to $1 / 2$ the crystal frequency out of reset. The ECLK output function depends upon the settings of the NECLK bit in the PEAR register, the IVIS bit in the MODE register and the ESTR bit in the EBICTL register. All clocks, including the ECLK, are halted when the MCU is in STOP mode. It is possible to configure the MCU to interface to slow external memory. ECLK can be stretched for such accesses. The PE4 pin is initially configured as ECLK output with stretch in all expanded modes. Reference the MISC register (EXSTR[1:0] bits) for more information. In normal expanded narrow mode, the ECLK is available for use in external select decode logic or as a constant speed clock for use in the external application system.

### 1.4.12 PE3 / $\overline{\text { LSTRB } / ~ T A G L O ~}-$ Port E I/O Pin 3 / Low-Byte Strobe (LSTRB)

PE3 can be used as a general-purpose I/O in all modes and is an input with an active pull-up out of reset. The pullup can be turned off by clearing PUPEE in the PUCR register. PE3 can also be configured as a Low-Byte Strobe ( $\overline{\mathrm{LSTRB}})$. The $\overline{\text { LSTRB signal is used in write operations, so external low byte writes will }}$ not be possible until this function is enabled. LSTRB can be enabled by setting the LSTRE bit in the PEAR register. In Expanded Wide and Emulation Narrow modes, and when BDM tagging is enabled, the LSTRB function is multiplexed with the $\overline{\text { TAGLO }}$ function. When enabled a logic zero on the $\overline{\text { TAGLO }}$ pin at the falling edge of ECLK will tag the low byte of an instruction word being read into the instruction queue. PE3 is not available in the 80 pin package version.

### 1.4.13 PE2 / R/ $\bar{W}$ — Port E I/O Pin 2 / Read/Write

PE2 can be used as a general-purpose I/O in all modes and is configured an input with an active pull-up out of reset. The pullup can be turned off by clearing PUPEE in the PUCR register. If the read/write function is required it should be enabled by setting the RDWE bit in the PEAR register. External writes will not be possible until the read/write function is enabled. The PE2 pin is not available in the 80 pin package version.

### 1.4.14 PE1 / $\overline{\mathrm{IRQ}}$ — Port E input Pin 1 / Maskable Interrupt Pin

PE1 is always an input and can always be read. The PE1 pin is also the $\overline{\mathrm{IRQ}}$ input used for requesting an asynchronous interrupt to the MCU. During reset, the I bit in the condition code register (CCR) is set and any $\overline{\mathrm{IRQ}}$ interrupt is masked until software enables it by clearing the I bit. The $\overline{\mathrm{IRQ}}$ is software
programmable to either falling edge-sensitive triggering or level-sensitive triggering based on the setting of the IRQE bit in the IRQCR register. The $\overline{\text { IRQ }}$ is always enabled and configured to level-sensitive triggering out of reset. It can be disabled by clearing IRQEN bit in the IRQCR register. There is an active pull-up on this pin while in reset and immediately out of reset. The pullup can be turned off by clearing PUPEE in the PUCR register.

### 1.4.15 PEO / XIRQ — Port E input Pin 0 / Non Maskable Interrupt Pin

PE0 is always an input and can always be read. The PE0 pin is also the $\overline{\text { XIRQ }}$ input for requesting a nonmaskable asynchronous interrupt to the MCU. During reset, the X bit in the condition code register (CCR) is set and any $\overline{\text { XIRQ }}$ interrupt is masked until MCU software enables it by clearing the X bit. Because the XIRQ input is level sensitive triggered, it can be connected to a multiple-source wired-OR network. There is an active pull-up on this pin while in reset and immediately out of reset. The pullup can be turned off by clearing PUPEE in the PUCR register.

### 1.4.16 PK7 / ECS / ROMCTL — Port K I/O Pin 7

PK7 is a general purpose input or output pin. During MCU expanded modes of operation, when the EMK bit in the MODE register is set to 1 , this pin is used as the emulation chip select output ( $\overline{\mathrm{ECS}}$ ). In expanded modes the PK7 pin can be used to determine the reset state of the ROMON bit in the MISC register. At the rising edge of RESET, the state of the PK7 pin is latched to the ROMON bit. There is an active pull-up on this pin while in reset and immediately out of reset. The pullup can be turned off by clearing PUPKE in the PUCR register. Refer to the HCS12 MEBI block description chapter for further details. PK7 is not available in the 80 pin package version.

### 1.4.17 PK6 / $\overline{\text { XCS }}$ — Port K I/O Pin 6

PK6 is a general purpose input or output pin. During MCU expanded modes of operation, when the EMK bit in the MODE register is set to 1 , this pin is used as an external chip select signal for most external accesses that are not selected by ECS. There is an active pull-up on this pin while in reset and immediately out of reset. The pullup can be turned off by clearing PUPKE in the PUCR register. Refer to the HCS12 MEBI block description chapter for further details. PK6 is not available in the 80 pin package version.

### 1.4.18 PK[5:0] / XADDR[19:14] — Port K I/O Pins [5:0]

PK[5:0] are general purpose input or output pins. In MCU expanded modes of operation, when the EMK bit in the MODE register is set to $1, \mathrm{PK}[5: 0]$ provide the expanded address XADDR[19:14] for the external bus. There are active pull-ups on PK [5:0] pins while in reset and immediately out of reset. The pullup can be turned off by clearing PUPKE in the PUCR register. Refer to the HCS12 MEBI block description chapter for further details. $\mathrm{PK}[5: 0]$ are not available in the 80 pin package version.

### 1.4.19 PAD[15:0] / AN[15:0] / KWAD[15:0] — Port AD I/O Pins [15:0]

$\operatorname{PAD}[15: 0]$ are the analog inputs for the analog to digital converter (ADC). They can also be configured as general purpose digital input or output pin. When enabled as digital inputs or outputs, the PAD[15:0] can
also be configured as Keypad Wake-up pins (KWU) and generate interrupts causing the MCU to exit STOP or WAIT mode. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the ATD_10B16C block description chapter for information about pin configurations.

### 1.4.20 PM7 / SCL — Port M I/O Pin 7

PM7 is a general purpose input or output pin. When the IIC module is enabled it becomes the serial clock line (SCL) for the IIC module (IIC). While in reset and immediately out of reset the PM7 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the IIC block description chapter for information about pin configurations.

### 1.4.21 PM6 / SDA — Port M I/O Pin 6

PM6 is a general purpose input or output pin. When the IIC module is enabled it becomes the Serial Data Line (SDL) for the IIC module (IIC). While in reset and immediately out of reset the PM6 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the IIC block description chapter for information about pin configurations.

### 1.4.22 PM5 / TXD2 — Port M I/O Pin 5

PM5 is a general purpose input or output. When the Serial Communications Interface 2 (SCI2) transmitter is enabled the PM5 pin is configured as the transmit pin TXD2 of SCI2. While in reset and immediately out of reset the PM5 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.23 PM4 / RXD2 — Port M I/O Pin 4

PM4 is a general purpose input or output. When the Serial Communications Interface 2 (SCI2) receiver is enabled the PM4 pin is configured as the receive pin RXD2 of SCI2. While in reset and immediately out of reset the PM4 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.24 PM3 — Port M I/O Pin 3

PM3 is a general purpose input or output pin. While in reset and immediately out of reset the PM3 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter for information about pin configurations.

### 1.4.25 PM1 / DAO1 — Port M I/O Pin 1

PM1 is a general purpose input or output pin. When the Digital to Analog module 1 (DAC1) is enabled the PM1 pin is configured as the analog output DA01 of DAC1. While in reset and immediately out of reset the PM1 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM)

PIM_9E128 block description chapter and the DAC_8B1C block description chapter for information about pin configurations.

### 1.4.26 PMO / DAO2 — Port M I/O Pin 0

PM0 is a general purpose input or output pin. When the Digital to Analog module 2 (DAC2) is enabled the PM0 pin is configured as the analog output DA02 of DAC2. While in reset and immediately out of reset the PM0 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the DAC_8B1C block description chapter for information about pin configurations.

### 1.4.27 PP[5:0] / PW0[5:0] — Port P I/O Pins [5:0]

$\mathrm{PP}[5: 0]$ are general purpose input or output pins. When the Pulse width Modulator with Fault protection (PMF) is enabled the $\operatorname{PP}[5: 0]$ output pins, as a whole or as pairs, can be configured as $\mathrm{PW} 0[5: 0]$ outputs. While in reset and immediately out of reset the $\mathrm{PP}[5: 0]$ pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the PMF_15B6C block description chapter for information about pin configurations.

### 1.4.28 PQ[6:4] / IS[2:0] — Port Q I/O Pins [6:4]

$\operatorname{PQ}[6: 4]$ are general purpose input or output pins. When enabled in the Pulse width Modulator with Fault protection module (PMF), the PQ[6:4] pins become the current status input pins, $\overline{\mathrm{IS}}[2: 0]$, for top/bottom pulse width correction. While in reset and immediately out of reset PP[5:0] pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the PMF_15B6C block description chapter for information about pin configurations.

### 1.4.29 PQ[3:0] / FAULT[3:0] — Port Q I/O Pins [3:0]

$\operatorname{PQ}[3: 0]$ are general purpose input or output pins. When enabled in the Pulse width Modulator with Fault protection module (PMF), the PQ[3:0] pins become the Fault protection inputs pins, FAULT[3:0], of the PMF. While in reset and immediately out of reset the $\mathrm{PQ}[3: 0]$ pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the PMF_15B6C block description chapter for information about pin configurations.

### 1.4.30 PS7 / $\overline{\mathrm{SS}}$ — Port S I/O Pin 7

PS7 is a general purpose input or output. When the Serial Peripheral Interface (SPI) is enabled PS7 becomes the slave select pin $\overline{\text { SS. While in reset and immediately out of reset the PS7 pin is configured as }}$ a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SPI block description chapter for information about pin configurations.

### 1.4.31 PS6 / SCK — Port S I/O Pin 6

PS6 is a general purpose input or output pin. When the Serial Peripheral Interface (SPI) is enabled PS6 becomes the serial clock pin, SCK. While in reset and immediately out of reset the PS6 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SPI block description chapter for information about pin configurations.

### 1.4.32 PS5 / MOSI — Port S I/O Pin 5

PS5 is a general purpose input or output pin. When the Serial Peripheral Interface (SPI) is enabled PS5 is the master output (during master mode) or slave input (during slave mode) pin. While in reset and immediately out of reset the PS5 pin is configured as a high impedance input pin Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SPI block description chapter for information about pin configurations.

### 1.4.33 PS4 / MISO — Port S I/O Pin 4

PS4 is a general purpose input or output pin. When the Serial Peripheral Interface (SPI) is enabled PS4 is the master input (during master mode) or slave output (during slave mode) pin. While in reset and immediately out of reset the PS4 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SPI block description chapter for information about pin configurations.

### 1.4.34 PS3 / TXD1 — Port S I/O Pin 3

PS3 is a general purpose input or output. When the Serial Communications Interface 1 (SCI1) transmitter is enabled the PS3 pin is configured as the transmit pin, TXD1, of SCI1. While in reset and immediately out of reset the PS3 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.35 PS2 / RXD1 — Port S I/O Pin 2

PS2 is a general purpose input or output. When the Serial Communications Interface 1 (SCI1) receiver is enabled the PS2 pin is configured as the receive pin RXD1 of SCI1. While in reset and immediately out of reset the PS2 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.36 PS1 / TXD0 — Port S I/O Pin 1

PS1 is a general purpose input or output. When the Serial Communications Interface 0 (SCI0) transmitter is enabled the PS1 pin is configured as the transmit pin, TXD0, of SCI0. While in reset and immediately out of reset the PS1 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.37 PSO / RXDO — Port S I/O Pin 0

PS0 is a general purpose input or output. When the Serial Communications Interface 0 (SCI0) receiver is enabled the PS0 pin is configured as the receive pin RXD0 of SCI0. While in reset and immediately out of reset the PS0 pin is configured as a high impedance input pin. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the SCI block description chapter for information about pin configurations.

### 1.4.38 PT[7:4] / IOC1[7:4]— Port T I/O Pins [7:4]

$\mathrm{PT}[7: 4]$ are general purpose input or output pins. When the Timer system 1 (TIM1) is enabled they can also be configured as the TIM1 input capture or output compare pins IOC1[7-4]. While in reset and immediately out of reset the PT[7:4] pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the TIM_16B4C block description chapter for information about pin configurations.

### 1.4.39 PT[3:0] / IOC0[7:4]— Port T I/O Pins [3:0]

PT[3:0] are general purpose input or output pins. When the Timer system 0 (TIM0) is enabled they can also be configured as the TIM0 input capture or output compare pins IOC0[7-4]. While in reset and immediately out of reset the PT[3:0] pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the TIM_16B4C block description chapter for information about pin configurations.

### 1.4.40 PU[7:6] — Port U I/O Pins [7:6]

$\operatorname{PU}[7: 6]$ are general purpose input or output pins. While in reset and immediately out of reset the PU[7:6] pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 for information about pin configurations. PU[7:6] are not available in the 80 pin package version.

### 1.4.41 PU[5:4] / PW1[5:4] — Port U I/O Pins [5:4]

$\mathrm{PU}[5: 4]$ are general purpose input or output pins. When the Pulse Width Modulator (PWM) is enabled the $\operatorname{PU}[5: 4]$ output pins, individually or as a pair, can be configured as PW1[5:4] outputs. While in reset and immediately out of reset the PU[5:4] pins are configured as a high impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter and the PWM_8B6C block description chapter for information about pin configurations. $\mathrm{PU}[5: 4]$ are not available in the 80 pin package version.

### 1.4.42 PU[3:0] / IOC2[7:4]/PW1[3:0] — Port U I/O Pins [3:0]

$\mathrm{PU}[3: 0]$ are general purpose input or output pins. When the Timer system 2 (TIM2) is enabled they can also be configured as the TIM2 input capture or output compare pins IOC2[7-4]. When the Pulse Width Modulator (PWM) is enabled the PU[3:0] output pins, individually or as a pair, can be configured as PW1[3:0] outputs. The MODRR register in the Port Integration Module determines if the TIM2 or PWM function is selected. While in reset and immediately out of reset the $\mathrm{PU}[3: 0]$ pins are configured as a high
impedance input pins. Consult the Port Integration Module (PIM) PIM_9E128 block description chapter, TIM_16B4C block description chapter, and the PWM_8B6C block description chapter for information about pin configurations.

### 1.4.43 VDDX,VSSX — Power \& Ground Pins for I/O Drivers

External power and ground for I/O drivers. Bypass requirements depend on how heavily the MCU pins are loaded.

### 1.4.44 VDDR, VSSR — Power Supply Pins for I/O Drivers \& for Internal Voltage Regulator

External power and ground for I/O drivers and input to the internal voltage regulator. Bypass requirements depend on how heavily the MCU pins are loaded.

### 1.4.45 VDD1, VDD2, VSS1, VSS2 — Power Supply Pins for Internal Logic

Power is supplied to the MCU through VDD and VSS. This 2.5 V supply is derived from the internal voltage regulator. There is no static load on those pins allowed. The internal voltage regulator is turned off, if VDDR is tied to ground.

### 1.4.46 VDDA, VSSA — Power Supply Pins for ATD and VREG

VDDA, VSSA are the power supply and ground input pins for the voltage regulator and the analog to digital converter.

### 1.4.47 VRH, VRL — ATD Reference Voltage Input Pins

VRH and VRL are the reference voltage input pins for the analog to digital converter.

### 1.4.48 VDDPLL, VSSPLL — Power Supply Pins for PLL

Provides operating voltage and ground for the Oscillator and the Phased-Locked Loop. This allows the supply voltage to the Oscillator and PLL to be bypassed independently. This 2.5 V voltage is generated by the internal voltage regulator.

Table 1-5. MC9S12E128 Power and Ground Connection Summary

| Mnemonic | Nominal Voltage | Description |
| :---: | :---: | :---: |
| VDD1, VDD2 | 2.5 V | Internal power and ground generated by internal regulator. These also allow an external source to supply the core VDD/VSS voltages and bypass the internal voltage regulator. |
| VSS1, VSS2 | 0 V |  |
| VDDR | $3.3 / 5.0 \mathrm{~V}$ | External power and ground, supply to internal voltage regulator. To disable voltage regulator attach $\mathrm{V}_{\mathrm{DDR}}$ to $\mathrm{V}_{\mathrm{SSR}}$. |
| VSSR | 0 V |  |
| VDDX | 3.3/5.0 V | External power and ground, supply to pin drivers. |
| VSSX | 0 V |  |
| VDDA | 3.3/5.0 V | Operating voltage and ground for the analog-to-digital converter, the reference for the internal voltage regulator and the digital-to-analog converters, allows the supply voltage to the $A / D$ to be bypassed independently. |
| VSSA | 0 V |  |
| VRH | 3.3/5.0 V | Reference voltage high for the ATD converter, and DAC. |
| VRL | 0 V | Reference voltage low for the ATD converter. |
| VDDPLL | 2.5 V | Provides operating voltage and ground for the Phased-Locked Loop. This allows the supply voltage to the PLL to be bypassed independently. Internal power and ground generated by internal regulator. |
| VSSPLL | 0 V |  |

## NOTE

All VSS pins must be connected together in the application. Because fast signal transitions place high, short-duration current demands on the power supply, use bypass capacitors with high-frequency characteristics and place them as close to the MCU as possible. Bypass requirements depend on MCU pin load.

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### 1.5 System Clock Description

The Clock and Reset Generator provides the internal clock signals for the core and all peripheral modules. Figure 1-10 shows the clock connections from the CRG to all modules. Consult the CRG block description chapter for details on clock generation.


Figure 1-10. Clock Connections

Table 1-6. Clock Selection Based on PE7

| PE7 $=\overline{\text { XCLKS }}$ | Description |
| :---: | :--- |
| 1 | Colpitts Oscillator selected |
| 0 | Pierce Oscillator/external clock selected |

### 1.6 Modes of Operation

### 1.6.1 Overview

Eight possible modes determine the operating configuration of the MC9S12E128. Each mode has an associated default memory map and external bus configuration controlled by a further pin.

Three low power modes exist for the device.

### 1.6.2 Chip Configuration Summary

The operating mode out of reset is determined by the states of the MODC, MODB, and MODA pins during reset. The MODC, MODB, and MODA bits in the MODE register show the current operating mode and provide limited mode switching during operation. The states of the MODC, MODB, and MODA pins are latched into these bits on the rising edge of the reset signal. The ROMCTL signal allows the setting of the ROMON bit in the MISC register thus controlling whether the internal Flash is visible in the memory map. ROMON $=1$ mean the Flash is visible in the memory map. The state of the ROMCTL pin is latched into the ROMON bit in the MISC register on the rising edge of the reset signal.

Table 1-7. Mode Selection

| BKGD $=$ <br> MODC | PE6 = <br> MODB | PE5 = <br> MODA | PK7 = <br> ROMCTL | ROMON <br> Bit | Mode Description |
| :---: | :---: | :---: | :---: | :---: | :--- |
| 0 | 0 | 0 | X | 1 | Special Single Chip, BDM allowed and ACTIVE. BDM is <br> allowed in all other modes but a serial command is <br> required to make BDM active. |
| 0 | 0 | 1 | 0 | 1 | Emulation Expanded Narrow, BDM allowed |
|  |  |  | 1 | 0 |  |
| 0 | 1 | 0 | X | 0 | Special Test (Expanded Wide), BDM allowed |
| 0 | 1 | 1 | 0 | 1 | Emulation Expanded Wide, BDM allowed |
|  |  | 0 | 1 | 0 |  |
| 1 | 0 | 1 | 0 | 0 | Normal Expanded Narrow, BDM allowed |
| 1 | 1 | 0 | 1 | 1 |  |
| 1 | 1 |  | 1 | 0 | 1 |

For further explanation on the modes refer to the HCS12 MEBI block description chapter.
Table 1-8. Clock Selection Based on PE7

| PE7 $=\overline{\text { XCLKS }}$ | Description |
| :---: | :--- |
| 1 | Colpitts Oscillator selected |
| 0 | Pierce Oscillator/external clock selected |

### 1.7 Security

The device will make available a security feature preventing the unauthorized read and write of the memory contents. This feature allows:

- Protection of the contents of FLASH,
- Operation in single-chip mode,
- Operation from external memory with internal FLASH disabled.

The user must be reminded that part of the security must lie with the user's code. An extreme example would be user's code that dumps the contents of the internal program. This code would defeat the purpose of security. At the same time the user may also wish to put a back door in the user's program. An example of this is the user downloads a key through the SCI which allows access to a programming routine that updates parameters.

### 1.7.1 Securing the Microcontroller

Once the user has programmed the FLASH, the part can be secured by programming the security bits located in the FLASH module. These non-volatile bits will keep the part secured through resetting the part and through powering down the part.

The security byte resides in a portion of the Flash array.
Check the Flash block description chapter for more details on the security configuration.

### 1.7.2 Operation of the Secured Microcontroller

### 1.7.2.1 Normal Single Chip Mode

This will be the most common usage of the secured part. Everything will appear the same as if the part was not secured with the exception of BDM operation. The BDM operation will be blocked.

### 1.7.2.2 Executing from External Memory

The user may wish to execute from external space with a secured microcontroller. This is accomplished by resetting directly into expanded mode. The internal FLASH will be disabled. BDM operations will be blocked.

### 1.7.3 Unsecuring the Microcontroller

In order to unsecure the microcontroller, the internal FLASH must be erased. This can be done through an external program in expanded mode.

Once the user has erased the FLASH, the part can be reset into special single chip mode. This invokes a program that verifies the erasure of the internal FLASH. Once this program completes, the user can erase and program the FLASH security bits to the unsecured state. This is generally done through the BDM, but the user could also change to expanded mode (by writing the mode bits through the BDM) and jumping to
an external program (again through BDM commands). Note that if the part goes through a reset before the security bits are reprogrammed to the unsecure state, the part will be secured again.

### 1.8 Low Power Modes

The microcontroller features three main low power modes. Consult the respective block description chapter for information on the module behavior in Stop, Pseudo Stop, and Wait Mode. An important source of information about the clock system is the Clock and Reset Generator (CRG) block description chapter.

### 1.8.1 Stop

Executing the CPU STOP instruction stops all clocks and the oscillator thus putting the chip in fully static mode. Wake up from this mode can be done via reset or external interrupts.

### 1.8.2 Pseudo Stop

This mode is entered by executing the CPU STOP instruction. In this mode the oscillator is still running and the Real Time Interrupt (RTI) or Watchdog (COP) sub module can stay active. Other peripherals are turned off. This mode consumes more current than the full STOP mode, but the wake up time from this mode is significantly shorter.

### 1.8.3 Wait

This mode is entered by executing the CPU WAI instruction. In this mode the CPU will not execute instructions. The internal CPU signals (address and data bus) will be fully static. All peripherals stay active. For further power consumption the peripherals can individually turn off their local clocks.

### 1.8.4 Run

Although this is not a low power mode, unused peripheral modules should not be enabled in order to save power.

### 1.9 Resets and Interrupts

Consult the Exception Processing section of the CPU12 Reference Manual for information on resets and interrupts. System resets can be generated through external control of the RESET pin, through the clock and reset generator module CRG or through the low voltage reset (LVR) generator of the voltage regulator module. Refer to the CRG and VREG block description chapters for detailed information on reset generation.

### 1.9.1 Vectors

Table 1-9 lists interrupt sources and vectors in default order of priority.

Table 1-9. Interrupt Vector Locations

| Vector Address | Interrupt Source | CCR <br> Mask | Local Enable | HPRIO Value to Elevate |
| :---: | :---: | :---: | :---: | :---: |
| 0xFFFEE, 0xFFFF | External Reset, Power On Reset or Low Voltage Reset (see CRG Flags Register to determine reset source) | None | None | - |
| 0xFFFFC, 0xFFFD | Clock Monitor fail reset | None | COPCTL (CME, FCME) | - |
| 0xFFFA, 0xFFFB | COP failure reset | None | COP rate select | - |
| 0xFFF8, 0xFFF9 | Unimplemented instruction trap | None | None | - |
| 0xFFF6, 0xFFF7 | SWI | None | None | - |
| 0xFFF4, 0xFFF5 | XIRQ | X-Bit | None | - |
| 0xFFF2, 0xFFF3 | IRQ | I-Bit | INTCR (IRQEN) | 0xF2 |
| 0xFFF0, 0xFFF1 | Real Time Interrupt | I-Bit | CRGINT (RTIE) | 0xF0 |
| 0xFFE8 to 0xFFEF | Reserved |  |  |  |
| 0xFFE6, 0xFFE7 | Standard Timer 0 channel 4 | I-Bit | TIE (C4I) | 0xE6 |
| 0xFFEE4, 0xFFE5 | Standard Timer 0 channel 5 | I-Bit | TIE (C5I) | 0xE4 |
| 0xFFE2, 0xFFE3 | Standard Timer 0 channel 6 | I-Bit | TIE (C6I) | 0xE2 |
| 0xFFEE0, 0xFFE1 | Standard Timer 0 channel 7 | I-Bit | TIE (C7I) | 0xE0 |
| 0xFFDE, 0xFFDF | Standard Timer overflow | I-Bit | TSCR2 (TOI) | 0xDE |
| 0xFFDC, 0xFFDD | Pulse accumulator overflow | I-Bit | PACTL(PAOVI) | 0xDC |
| 0xFFDA, 0xFFDB | Pulse accumulator input edge | I-Bit | PACTL (PAI) | 0xDA |
| 0xFFD8, 0xFFD9 | SPI | I-Bit | SPICR1 (SPIE, SPTIE) | 0xD8 |
| 0xFFD6, 0xFFD7 | SCIO | I-Bit | SCICR2 (TIE, TCIE, RIE, ILIE) | 0xD6 |
| 0xFFD4, 0xFFD5 | SCI1 | I-Bit | SCICR2 (TIE, TCIE, RIE, ILIE) | 0xD4 |
| 0xFFD2, 0xFFD3 | SCI2 | I-Bit | SCICR2 (TIE, TCIE, RIE, ILIE) | 0xD2 |
| 0xFFD0, 0xFFD1 | ATD | I-Bit | ATDCTL2 (ASCIE) | 0xD0 |
| 0xFFCE, 0xFFCF | Port AD (KWU) | I-Bit | PTADIF (PTADIE) | 0xCE |
| 0xFFC88 to 0xFFCD | Reserved |  |  |  |
| 0xFFC6, 0xFFC7 | CRG PLL lock | I-Bit | PLLCR (LOCKIE) | 0xC6 |
| 0xFFC4, 0xFFC5 | CRG Self Clock Mode | I-Bit | PLLCR (SCMIE) | 0xC4 |
| 0xFFC2, 0xFFC3 | Reserved |  |  |  |
| 0xFFC0, 0xFFC1 | IIC Bus | I-Bit | IBCR (IBIE) | 0xC0 |
| 0xFFBA to 0xFFBF | Reserved |  |  |  |
| 0xFFB8, 0xFFB9 | FLASH | I-Bit | FCNFG (CCIE, CBEIE) | 0xB8 |
| 0xFFB6, 0xFFB7 | Standard Timer 1 channel 4 | I-Bit | TIE (C4I) | 0xB6 |
| 0xFFB4, 0xFFB5 | Standard Timer 1 channel 5 | I-Bit | TIE (C5I) | 0xB4 |
| 0xFFB2, 0xFFB3 | Standard Timer 1 channel 6 | I-Bit | TIE (C6I) | 0xB2 |
| 0xFFB0, 0xFFB1 | Standard Timer 1 channel 7 | I-Bit | TIE (C7I) | 0xB0 |
| 0xFFAE, 0xFFAF | Standard Timer 1 overflow | I-Bit | TSCR2 (TOI) | 0xAE |

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Table 1-9. Interrupt Vector Locations (continued)

| Vector Address | Interrupt Source | $\begin{aligned} & \text { CCR } \\ & \text { Mask } \end{aligned}$ | Local Enable | HPRIO Value to Elevate |
| :---: | :---: | :---: | :---: | :---: |
| 0xFFAC, 0xFFAD | Standard Timer 1 Pulse accumulator overflow | I-Bit | PACTL (PAOVI) | 0xAC |
| 0xFFAA, 0xFFAB | Standard Timer 1 Pulse accumulator input edge | I-Bit | PACTL (PAI) | 0xAA |
| 0xFFA8, 0xFFA9 | Reserved |  |  |  |
| 0xFFA6, 0xFFA7 | Standard Timer 2 channel 4 | I-Bit | TIE (C4I) | 0xA6 |
| 0xFFA4, 0xFFA5 | Standard Timer 2 channel 5 | I-Bit | TIE (C5I) | 0xA4 |
| 0xFFA2, 0xFFA3 | Standard Timer 2 channel 6 | I-Bit | TIE (C6I) | 0xA2 |
| 0xFFA0, 0xFFA1 | Standard Timer 2 channel 7 | I-Bit | TIE (C7I) | 0xA0 |
| 0xFF9E, 0xFF9F | Standard Timer overflow | I-Bit | TSCR2 (TOI) | 0x9E |
| 0xFF96, 0xFF9D | Standard Timer 2 Pulse accumulator overflow | I-Bit | PACTL (PAOVI) | 0x9C |
| 0xFF9A, 0xFF9B | Standard Timer 2 Pulse accumulator input edge | I-Bit | PACTL (PAI) | $0 \times 9 \mathrm{~A}$ |
| 0xFF98, 0xFF99 | PMF Generator A Reload | I-Bit | PMFENCA (PWMRIEA) | 0x98 |
| 0xFF96, 0xFF97 | PMF Generator B Reload | I-Bit | PMFENCB (PWMRIEB) | 0x96 |
| 0xFF94, 0xFF95 | PMF Generator C Reload | I-Bit | PMFENCC (PWMRIEC) | 0x94 |
| 0xFF92, 0xFF93 | PMF Fault 0 | I-Bit | PMFFCTL (FIE0) | 0x92 |
| 0xFF90, 0xFF91 | PMF Fault 1 | I-Bit | PMFFCTL (FIE1) | 0x90 |
| 0xFF8E, 0xFF8F | PMF Fault 2 | I-Bit | PMFFCTL (FIE2) | 0x8E |
| 0xFF8C, 0xFF8D | PMF Fault 3 | I-Bit | PMFFCTL (FIE3) | 0x8C |
| 0xFF8A, 0xFF8B | VREG LVI | I-Bit | CTRL0 (LVIE) | 0x8A |
| 0xFF88, 0xFF89 | PWM Emergency Shutdown | I-Bit | PWMSDN(PWMIE) | 0x88 |
| 0xFF80 to 0xFF87 | Reserved |  |  |  |

### 1.9.2 Resets

Resets are a subset of the interrupts featured in Table 1-9. The different sources capable of generating a system reset are summarized in Table 1-10.

### 1.9.2.1 Reset Summary Table

Table 1-10. Reset Summary

| Reset | Priority | Source | Vector |
| :---: | :---: | :---: | :---: |
| Power-on Reset | 1 | CRG Module | $0 \times$ FFFF, 0xFFFF |
| External Reset | 1 | RESET pin | $0 x F F F E, 0 x F F F F$ |
| Low Voltage Reset | 1 | VREG Module | $0 x F F F E, 0 x F F F F$ |
| Clock Monitor Reset | 2 | CRG Module | 0xFFFC, 0xFFFD |
| COP Watchdog Reset | 3 | CRG Module | 0xFFFA, 0xFFFB |

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### 1.9.2.2 Effects of Reset

When a reset occurs, MCU registers and control bits are changed to known start-up states. Refer to the respective module block description chapters for register reset states. Refer to the HCS12 MEBI block description chapter for mode dependent pin configuration of port A, B and E out of reset.

Refer to the PIM block description chapter for reset configurations of all peripheral module ports.
Refer to Table 1-1 for locations of the memories depending on the operating mode after reset.
The RAM array is not automatically initialized out of reset.

### 1.10 Recommended Printed Circuit Board Layout

The Printed Circuit Board (PCB) must be carefully laid out to ensure proper operation of the voltage regulator as well as the MCU itself. The following rules must be observed:

- Every supply pair must be decoupled by a ceramic capacitor connected as near as possible to the corresponding pins (C1-C6).
- Central point of the ground star should be the VSSR pin.
- Use low ohmic low inductance connections between VSS1, VSS2 and VSSR.
- VSSPLL must be directly connected to VSSR.
- Keep traces of VSSPLL, EXTAL and XTAL as short as possible and occupied board area for C7, $\mathrm{C} 8, \mathrm{C} 11$ and Q1 as small as possible.
- Do not place other signals or supplies underneath area occupied by C7, C8, C10 and Q1 and the connection area to the MCU.
- Central power input should be fed in at the VDDA/VSSA pins.

Table 1-11. Recommended Decoupling Capacitor Choice

| Component | Purpose | Type | Value |
| :---: | :---: | :---: | :---: |
| C1 | VDD1 filter cap | Ceramic X7R | 100-220nF |
| C2 | VDD2 filter cap (80 QFP only) | Ceramic X7R | 100-220nF |
| C3 | VDDA filter cap | Ceramic X7R | 100nF |
| C4 | VDDR filter cap | X7R/tantalum | >=100nF |
| C5 | VDDPLL filter cap | Ceramic X7R | 100nF |
| C6 | VDDX filter cap | X7R/tantalum | >=100nF |
| C7 | OSC load cap | See PLL specification chapter |  |
| C8 | OSC load cap |  |  |
| C9 | PLL loop filter cap |  |  |
| C10 | PLL loop filter cap |  |  |
| C11 | DC cutoff cap |  |  |
| R1 | PLL loop filter res |  |  |
| Q1 | Quartz |  |  |

NOTE: Oscillator in Colpitts mode.


Figure 1-11. Recommended PCB Layout (112-LQFP)

NOTE: Oscillator in Colpitts mode.


Figure 1-12. Recommended PCB Layout (80-QFP)

NOTE: Oscillator in Colpitts mode.


Figure 1-13. Recommended PCB Layout (64-QFN)

## Chapter 2

128 Kbyte Flash Module (FTS128K1V1)

### 2.1 Introduction

The FTS128K1 module implements a 128 Kbyte Flash (nonvolatile) memory. The Flash memory contains one array of 128 Kbytes organized as 1024 rows of 128 bytes with an erase sector size of eight rows (1024 bytes). The Flash array may be read as either bytes, aligned words, or misaligned words. Read access time is one bus cycle for byte and aligned word, and two bus cycles for misaligned words.
The Flash array is ideal for program and data storage for single-supply applications allowing for field reprogramming without requiring external voltage sources for program or erase. Program and erase functions are controlled by a command driven interface. The Flash module supports both mass erase and sector erase. An erased bit reads 1 and a programmed bit reads 0 . The high voltage required to program and erase is generated internally. It is not possible to read from a Flash array while it is being erased or programmed.

## CAUTION

A Flash word must be in the erased state before being programmed.
Cumulative programming of bits within a Flash word is not allowed.

### 2.1.1 Glossary

Command Write Sequence - A three-step MCU instruction sequence to program, erase, or erase verify the Flash array memory.

### 2.1.2 Features

- 128 Kbytes of Flash memory comprised of one 128 Kbyte array divided into 128 sectors of 1024 bytes
- Automated program and erase algorithm
- Interrupts on Flash command completion and command buffer empty
- Fast sector erase and word program operation
- 2-stage command pipeline for faster multi-word program times
- Flexible protection scheme to prevent accidental program or erase
- Single power supply for Flash program and erase operations
- Security feature to prevent unauthorized access to the Flash array memory


### 2.1.3 Modes of Operation

See Section 2.4.2, "Operating Modes" for a description of the Flash module operating modes. For program and erase operations, refer to Section 2.4.1, "Flash Command Operations".

### 2.1.4 Block Diagram

Figure 2-1 shows a block diagram of the FTS128K1 module.


Figure 2-1. FTS128K1 Block Diagram

### 2.2 External Signal Description

The FTS128K1 module contains no signals that connect off-chip.

### 2.3 Memory Map and Registers

This section describes the FTS128K1 memory map and registers.

### 2.3.1 Module Memory Map

The FTS128K1 memory map is shown in Figure 2-2. The HCS12 architecture places the Flash array addresses between $0 \times 4000$ and $0 \times F F F F$, which corresponds to three 16 Kbyte pages. The content of the HCS12 Core PPAGE register is used to map the logical middle page ranging from address $0 \times 8000$ to $0 x B F F F$ to any physical 16 K byte page in the Flash array memory. ${ }^{1}$ The FPROT register (see Section 2.3.2.5) can be set to globally protect the entire Flash array. Three separate areas, one starting from the Flash array starting address (called lower) towards higher addresses, one growing downward from the Flash array end address (called higher), and the remaining addresses, can be activated for protection. The Flash array addresses covered by these protectable regions are shown in Figure 2-2. The higher address area is mainly targeted to hold the boot loader code since it covers the vector space. The lower address area can be used for EEPROM emulation in an MCU without an EEPROM module since it can be left unprotected while the remaining addresses are protected from program or erase. Default protection settings as well as security information that allows the MCU to restrict access to the Flash module are stored in the Flash configuration field described in Table 2-1.

Table 2-1. Flash Configuration Field

| Flash Address | Size <br> (bytes) | Description |
| :---: | :---: | :--- |
| 0xFF00-0xFF07 | 8 | Backdoor Key to unlock security |
| 0xFF08-0xFF0C | 5 | Reserved |
| 0xFF0D | 1 | Flash Protection byte <br> Refer to Section 2.3.2.5, "Flash Protection Register (FPROT)" |
| 0xFF0E | 1 | Reserved |
| 0xFF0F | 1 | Flash Security/Options byte <br> Refer to Section 2.3.2.2, "Flash Security Register (FSEC)" |

[^0]
## Chapter 2128 Kbyte Flash Module (FTS128K1V1)



Note: $0 \times 38-0 \times 3$ F correspond to the PPAGE register content
Figure 2-2. Flash Memory Map

Table 2-2. Flash Array Memory Map Summary

| MCU Address Range | PPAGE | Protectable Low Range | Protectable High Range | Array Relative Address ${ }^{1}$ |
| :---: | :---: | :---: | :---: | :---: |
| 0x0000-0x3FFF ${ }^{2}$ | Unpaged (0x3D) | N.A. | N.A. | 0x14000-0x17FFF |
| 0x4000-0x7FFF | Unpaged (0x3E) | $\begin{aligned} & 0 \times 4000-0 \times 43 F F \\ & 0 \times 4000-0 \times 47 \mathrm{FF} \\ & 0 \times 4000-0 \times 4 \mathrm{FFF} \\ & 0 \times 4000-0 \times 5 \mathrm{FFF} \end{aligned}$ | N.A. | 0x18000-0x1BFFF |
| 0x8000-0xBFFF | $0 \times 38$ | N.A. | N.A. | 0x00000-0x03FFF |
|  | $0 \times 39$ | N.A. | N.A. | 0x04000-0x07FFF |
|  | 0x3A | N.A. | N.A. | 0x08000-0x0BFFF |
|  | 0x3B | N.A. | N.A. | 0x0C000-0x0FFFF |
|  | 0x3C | N.A. | N.A. | 0x10000-0x13FFF |
|  | 0x3D | N.A. | N.A. | 0x14000-0x17FFF |
|  | 0x3E | $\begin{aligned} & \hline 0 \times 8000-0 \times 83 F F \\ & 0 \times 8000-0 \times 87 F F \\ & 0 \times 8000-0 \times 8 F F F \\ & 0 \times 8000-0 \times 9 F F F \end{aligned}$ | N.A. | 0x18000-0x1BFFF |
|  | 0x3F | N.A. | $\begin{aligned} & 0 \times B 800-0 x B F F F \\ & 0 \times B 000-0 x B F F F \\ & 0 \times A 000-0 x B F F F \\ & 0 \times 8000-0 x B F F F \end{aligned}$ | 0x1C000-0x1FFFF |
| 0xC000-0xFFFF | Unpaged (0x3F) | N.A. | $\begin{aligned} & 0 x F 800-0 x F F F F \\ & 0 x F 000-0 x F F F F \\ & 0 x E 000-0 x F F F F \\ & 0 x C 000-0 x F F F F \end{aligned}$ | 0x1C000-0x1FFFF |

1 Inside Flash block.
2 If allowed by MCU.

Chapter 2128 Kbyte Flash Module (FTS128K1V1)

### 2.3.2 Register Descriptions

The Flash module contains a set of 16 control and status registers located between module base $+0 \times 0000$ and $0 \times 000 \mathrm{~F}$. A summary of the Flash module registers is given in Figure 2-3. Detailed descriptions of each register bit are provided.

| Register Name | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{array}{cc} 0 \times 0000 & \mathrm{R} \\ \text { FCLKDIV } & \mathrm{W} \end{array}$ | FDIVLD | PRDIV8 | FDIV5 | FDIV4 | FDIV3 | FDIV2 | FDIV1 | FDIV0 |
| 0x0001 R | KEYEN1 | KEYEN0 | NV5 | NV4 | NV3 | NV2 | SEC1 | SEC0 |
| FSEC W |  |  |  |  |  |  |  |  |
| 0x0002 R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED1 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |
| 0x0003 R | CBEIE | CCIE | KEYACC | 0 | 0 | 0 | 0 | 0 |
| FCNFG W | CBEIE | COIE | KEYACO |  |  |  |  |  |
| $0 \times 0004$ $R$ <br> FPROT $W$ | FPOPEN | NV6 | FPHDIS | FPHS1 | FPHS0 | FPLDIS | FPLS1 | FPLS0 |
| 0x0005 R | CBEIF | CCIF | VI | ACCERR | 0 | BLANK | FAIL | DONE |
| FSTAT W |  |  | PVIOL | ACCERR |  |  | AIL |  |
| 0x0006 R | 0 | CMDB6 | CMDB5 | 0 | 0 | CMDB2 | 0 |  |
| FCMD W |  | CMDB6 | , |  |  | MDB2 |  | CMDB0 |
| 0x0007 R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED2 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |
| $\begin{array}{cc} 0 \times 0008 & \mathrm{R} \\ \text { FADDRHI }^{1} & \mathrm{~W} \end{array}$ | FABHI |  |  |  |  |  |  |  |
| $\begin{array}{cc} 0 \times 0009 & R \\ \text { FADDRLO }^{1} & \mathrm{~W} \end{array}$ | FABLO |  |  |  |  |  |  |  |
| $\begin{array}{cc} 0 \times 000 A & \mathrm{R} \\ \text { FDATAHI }^{1} & \mathrm{~W} \end{array}$ | FDHI |  |  |  |  |  |  |  |
| $\begin{array}{cc} 0 \times 000 B & R \\ \text { FDATALO }^{1} & \mathrm{~W} \end{array}$ | FDLO |  |  |  |  |  |  |  |
| 0x000C R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED3 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |
| 0x000D R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED4 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |
| 0x000E R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED5 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |
| 0x000F R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| RESERVED6 ${ }^{1} \mathrm{~W}$ |  |  |  |  |  |  |  |  |

Figure 2-3. Flash Register Summary
1 Intended for factory test purposes only.

### 2.3.2.1 Flash Clock Divider Register (FCLKDIV)

The FCLKDIV register is used to control timed events in program and erase algorithms.
Module Base $+0 \times 0000$


Figure 2-4. Flash Clock Divider Register (FCLKDIV)
All bits in the FCLKDIV register are readable, bits 6-0 are write once and bit 7 is not writable.
Table 2-3. FCLKDIV Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| FDIVLD | Clock Divider Loaded <br> 0 <br> 1 <br> 1 <br> FCLKDIV register has not been written |
| 6 | Enable Prescalar by 8 <br> 0 <br> PRDIV8 <br> 1 |
| The oscillator clock is directly fed into the Flash clock divider clock is divided by 8 before feeding into the Flash clock divider |  |

### 2.3.2.2 Flash Security Register (FSEC)

The FSEC register holds all bits associated with the security of the MCU and Flash module.
Module Base + 0x0001


Figure 2-5. Flash Security Register (FSEC)
All bits in the FSEC register are readable but not writable.
The FSEC register is loaded from the Flash configuration field at 0 xFF 0 F during the reset sequence, indicated by F in Figure 2-5.

Table 2-4. FSEC Field Descriptions

| Field | Description |
| :---: | :--- |
| $7-6$ <br> KEYEN $[1: 0]$ | Backdoor Key Security Enable Bits - The KEYEN[1:0] bits define the enabling of the backdoor key access <br> to the Flash module as shown in Table 2-5. |
| $5-2$ <br> $N V[5: 2]$ | Nonvolatile Flag Bits - The NV[5:2] bits are available to the user as nonvolatile flags. |
| $1-0$ <br> SEC[1:0] | Flash Security Bits - The SEC[1:0] bits define the security state of the MCU as shown in Table 2-6. If the Flash <br> module is unsecured using backdoor key access, the SEC[1:0] bits are forced to 1:0. |

Table 2-5. Flash KEYEN States

| KEYEN[1:0] | Status of Backdoor Key Access |
| :---: | :---: |
| 00 | DISABLED |
| $01^{1}$ | DISABLED |
| 10 | ENABLED |
| 11 | DISABLED |

1 Preferred KEYEN state to disable Backdoor Key Access.

Table 2-6. Flash Security States

| SEC[1:0] | Status of Security |
| :---: | :---: |
| 00 | Secured |
| $01^{1}$ | Secured |
| 10 | Unsecured |
| 11 | Secured |

The security function in the Flash module is described in Section 2.4.3, "Flash Module Security".

### 2.3.2.3 RESERVED1

This register is reserved for factory testing and is not accessible to the user.
Module Base $+0 \times 0002$

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 2-6. RESERVED1
All bits read 0 and are not writable.

### 2.3.2.4 Flash Configuration Register (FCNFG)

The FCNFG register enables the Flash interrupts and gates the security backdoor key writes.
Module Base + 0x0003

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | CBEIE | CCIE | KEYACC | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 2-7. Flash Configuration Register (FCNFG)
CBEIE, CCIE, and KEYACC are readable and writable while remaining bits read 0 and are not writable. KEYACC is only writable if the KEYEN bit in the FSEC register is set to the enabled state (see Section 2.3.2.2).

Table 2-7. FCNFG Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| CBEIE | Command Buffer Empty Interrupt Enable - The CBEIE bit enables the interrupts in case of an empty <br> command buffer in the Flash module. <br> 0 <br> Command Buffer Empty interrupts disabled <br> 1 |
| 6 | An interrupt will be requested whenever the CBEIF flag is set (see Section 2.3.2.6) |

### 2.3.2.5 Flash Protection Register (FPROT)

The FPROT register defines which Flash sectors are protected against program or erase.


Figure 2-8. Flash Protection Register (FPROT)

The FPROT register is readable in normal and special modes. FPOPEN can only be written from a 1 to a 0 . FPLS[1:0] can be written anytime until FPLDIS is cleared. FPHS[1:0] can be written anytime until

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FPHDIS is cleared. The FPROT register is loaded from Flash address 0xFF0D during the reset sequence, indicated by F in Figure 2-8.

To change the Flash protection that will be loaded on reset, the upper sector of the Flash array must be unprotected, then the Flash protection byte located at Flash address 0xFF0D must be written to.
A protected Flash sector is disabled by FPHDIS and FPLDIS while the size of the protected sector is defined by FPHS[1:0] and FPLS[1:0] in the FPROT register.

Trying to alter any of the protected areas will result in a protect violation error and the PVIOL flag will be set in the FSTAT register (see Section 2.3.2.6). A mass erase of the whole Flash array is only possible when protection is fully disabled by setting the FPOPEN, FPLDIS, and FPHDIS bits. An attempt to mass erase a Flash array while protection is enabled will set the PVIOL flag in the FSTAT register.

Table 2-8. FPROT Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { FPOPEN } \end{gathered}$ | Protection Function for Program or Erase - It is possible using the FPOPEN bit to either select address ranges to be protected using FPHDIS, FPLDIS, FPHS[1:0] and FPLS[1:0] or to select the same ranges to be unprotected. When FPOPEN is set, FPxDIS enables the ranges to be protected, whereby clearing FPxDIS enables protection for the range specified by the corresponding FPxS[1:0] bits. When FPOPEN is cleared, FPxDIS defines unprotected ranges as specified by the corresponding FPxS[1:0] bits. In this case, setting FPxDIS enables protection. Thus the effective polarity of the FPxDIS bits is swapped by the FPOPEN bit as shown in Table 2-9. This function allows the main part of the Flash array to be protected while a small range can remain unprotected for EEPROM emulation. <br> 0 The FPHDIS and FPLDIS bits define Flash address ranges to be unprotected <br> 1 The FPHDIS and FPLDIS bits define Flash address ranges to be protected |
| $\begin{gathered} 6 \\ \text { NV6 } \end{gathered}$ | Nonvolatile Flag Bit - The NV6 bit should remain in the erased state for future enhancements. |
| $\begin{gathered} 5 \\ \text { FPHDIS } \end{gathered}$ | Flash Protection Higher Address Range Disable - The FPHDIS bit determines whether there is a protected/unprotected area in the higher space of the Flash address map. <br> 0 Protection/unprotection enabled <br> 1 Protection/unprotection disabled |
| $\begin{gathered} 4-3 \\ \operatorname{FPHS}[1: 0] \end{gathered}$ | Flash Protection Higher Address Size - The FPHS[1:0] bits determine the size of the protected/unprotected sector as shown in Table 2-10. The FPHS[1:0] bits can only be written to while the FPHDIS bit is set. |
| $\stackrel{2}{\text { FPLDIS }}$ | Flash Protection Lower Address Range Disable - The FPLDIS bit determines whether there is a protected/unprotected sector in the lower space of the Flash address map. <br> 0 Protection/unprotection enabled <br> 1 Protection/unprotection disabled |
| $\begin{gathered} 1-0 \\ \text { FPLS[1:0] } \end{gathered}$ | Flash Protection Lower Address Size - The FPLS[1:0] bits determine the size of the protected/unprotected sector as shown in Table 2-11. The FPLS[1:0] bits can only be written to while the FPLDIS bit is set. |

Table 2-9. Flash Protection Function

| FPOPEN | FPHDIS | FPHS[1] | FPHS[0] | FPLDIS | FPLS[1] | FPLS[0] | Function $^{\mathbf{1}}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :--- |
| 1 | 1 | x | x | 1 | x | x | No protection |
| 1 | 1 | x | x | 0 | x | x | Protect low range |
| 1 | 0 | x | x | 1 | x | x | Protect high range |
| 1 | 0 | x | x | 0 | x | x | Protect high and low ranges |
| 0 | 1 | x | x | 1 | x | x | Full Flash array protected |
| 0 | 0 | x | x | 1 | x | x | Unprotected high range |
| 0 | 1 | x | x | 0 | x | x | Unprotected low range |
| 0 | 0 | x | x | 0 | x | x | Unprotected high and low ranges |

${ }^{1}$ For range sizes refer to Table 2-10 and Table 2-11 or .

Table 2-10. Flash Protection Higher Address Range

| FPHS[1:0] | Address Range | Range Size |
| :---: | :---: | :---: |
| 00 | $0 x F 800-0 x F F F F$ | 2 Kbytes |
| 01 | $0 x F 000-0 x F F F F$ | 4 Kbytes |
| 10 | $0 x E 000-0 x F F F F$ | 8 Kbytes |
| 11 | $0 x C 000-0 x F F F F$ | 16 Kbytes |

Table 2-11. Flash Protection Lower Address Range

| FPLS[1:0] | Address Range | Range Size |
| :---: | :---: | :---: |
| 00 | $0 \times 4000-0 \times 43 F F$ | 1 Kbyte |
| 01 | $0 \times 4000-0 \times 47 \mathrm{FF}$ | 2 Kbytes |
| 10 | $0 \times 4000-0 \times 4 \mathrm{FFF}$ | 4 Kbytes |
| 11 | $0 \times 4000-0 \times 5 \mathrm{FFF}$ | 8 Kbytes |

Figure 2-9 illustrates all possible protection scenarios. Although the protection scheme is loaded from the Flash array after reset, it is allowed to change in normal modes. This protection scheme can be used by applications requiring re-programming in single chip mode while providing as much protection as possible if no re-programming is required.

FPHDIS = 1
FPHDIS $=0$

$$
\text { FPHDIS = } 0
$$

FPLDIS $=0$
FPLDIS = 1
FPLDIS $=0$

Protected Flash

Figure 2-9. Flash Protection Scenarios

### 2.3.2.5.1 Flash Protection Restrictions

The general guideline is that protection can only be added, not removed. All valid transitions between Flash protection scenarios are specified in Table 2-12. Any attempt to write an invalid scenario to the FPROT register will be ignored and the FPROT register will remain unchanged. The contents of the FPROT register reflect the active protection scenario.

Table 2-12. Flash Protection Scenario Transitions

| From <br> Protection <br> Scenario | To Protection Scenario $^{\mathbf{1}}$ |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\mathbf{0}$ | $\mathbf{1}$ | $\mathbf{2}$ | $\mathbf{3}$ | $\mathbf{4}$ | $\mathbf{5}$ | $\mathbf{6}$ | $\mathbf{7}$ |  |
| 0 | X | X | X | X |  |  |  |  |  |
| 1 |  | X |  | X |  |  |  |  |  |
| 2 |  |  | X | X |  |  |  |  |  |
| 3 |  |  |  | X |  |  |  |  |  |
| 4 |  |  |  | X | X |  |  |  |  |
| 5 |  |  | X | X | X | X |  |  |  |

Table 2-12. Flash Protection Scenario Transitions

| From <br> Protection <br> Scenario | To Protection Scenario $^{\text {1 }}$ |  |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\mathbf{0}$ | $\mathbf{1}$ | $\mathbf{2}$ | $\mathbf{3}$ | $\mathbf{4}$ | $\mathbf{5}$ | $\mathbf{6}$ | $\mathbf{7}$ |  |
| 6 |  | X |  | X | X |  | X |  |  |
| 7 | X | X | X | X | X | X | X | X |  |

1 Allowed transitions marked with X .

### 2.3.2.6 Flash Status Register (FSTAT)

The FSTAT register defines the status of the Flash command controller and the results of command execution.


Figure 2-10. Flash Status Register (FSTAT)
In normal modes, bits CBEIF, PVIOL, and ACCERR are readable and writable, bits CCIF and BLANK are readable and not writable, remaining bits, including FAIL and DONE, read 0 and are not writable. In special modes, FAIL is readable and writable while DONE is readable but not writable. FAIL must be clear in special modes when starting a command write sequence.

Table 2-13. FSTAT Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { CBEIF } \end{gathered}$ | Command Buffer Empty Interrupt Flag - The CBEIF flag indicates that the address, data and command buffers are empty so that a new command write sequence can be started. The CBEIF flag is cleared by writing a 1 to CBEIF. Writing a 0 to the CBEIF flag has no effect on CBEIF. Writing a 0 to CBEIF after writing an aligned word to the Flash address space but before CBEIF is cleared will abort a command write sequence and cause the ACCERR flag in the FSTAT register to be set. Writing a 0 to CBEIF outside of a command write sequence will not set the ACCERR flag. The CBEIF flag is used together with the CBEIE bit in the FCNFG register to generate an interrupt request (see Figure 2-26). <br> 0 Buffers are full <br> 1 Buffers are ready to accept a new command |
| $\begin{gathered} 6 \\ \mathrm{CCIF} \end{gathered}$ | Command Complete Interrupt Flag - The CCIF flag indicates that there are no more commands pending. The CCIF flag is cleared when CBEIF is clear and sets automatically upon completion of all active and pending commands. The CCIF flag does not set when an active commands completes and a pending command is fetched from the command buffer. Writing to the CCIF flag has no effect. The CCIF flag is used together with the CCIE bit in the FCNFG register to generate an interrupt request (see Figure 2-26). <br> 0 Command in progress <br> 1 All commands are completed |

Table 2-13. FSTAT Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 5 \\ \text { PVIOL } \end{gathered}$ | Protection Violation - The PVIOL flag indicates an attempt was made to program or erase an address in a protected Flash array memory area. The PVIOL flag is cleared by writing a 1 to PVIOL. Writing a 0 to the PVIOL flag has no effect on PVIOL. While PVIOL is set, it is not possible to launch another command. <br> 0 No protection violation detected <br> 1 Protection violation has occurred |
| $4$ <br> ACCERR | Access Error - The ACCERR flag indicates an illegal access to the Flash array caused by either a violation of the command write sequence, issuing an illegal command (illegal combination of the CMDBx bits in the FCMD register) or the execution of a CPU STOP instruction while a command is executing (CCIF=0). The ACCERR flag is cleared by writing a 1 to ACCERR. Writing a 0 to the ACCERR flag has no effect on ACCERR. While ACCERR is set, it is not possible to launch another command. <br> 0 No access error detected <br> 1 Access error has occurred |
| $\begin{gathered} 2 \\ \text { BLANK } \end{gathered}$ | Flash Array Has Been Verified as Erased - The BLANK flag indicates that an erase verify command has checked the Flash array and found it to be erased. The BLANK flag is cleared by hardware when CBEIF is cleared as part of a new valid command write sequence. Writing to the BLANK flag has no effect on BLANK. <br> 0 If an erase verify command has been requested, and the CCIF flag is set, then a 0 in BLANK indicates the array is not erased <br> 1 Flash array verifies as erased |
| $\begin{gathered} 1 \\ \text { FAIL } \end{gathered}$ | Flag Indicating a Failed Flash Operation - In special modes, the FAIL flag will set if the erase verify operation fails (Flash array verified as not erased). Writing a 0 to the FAIL flag has no effect on FAIL. The FAIL flag is cleared by writing a 1 to FAIL. While FAIL is set, it is not possible to launch another command. <br> 0 Flash operation completed without error <br> 1 Flash operation failed |
| $\begin{gathered} 0 \\ \text { DONE } \end{gathered}$ | Flag Indicating a Failed Operation is not Active - In special modes, the DONE flag will clear if a program, erase, or erase verify operation is active. <br> 0 Flash operation is active <br> 1 Flash operation is not active |

### 2.3.2.7 Flash Command Register (FCMD)

The FCMD register defines the Flash commands.

> Module Base + 0x0006


Figure 2-11. Flash Command Register (FCMD)
Bits CMDB6, CMDB5, CMDB2, and CMDB0 are readable and writable during a command write sequence while bits $7,4,3$, and 1 read 0 and are not writable.

Table 2-14. FCMD Field Descriptions

| Field | Description |
| :---: | :--- |
| $6,5,2,0$ | Valid Flash commands are shown in Table 2-15. An attempt to execute any command other than those listed in |
| CMDB[6:5] | Table 2-15 will set the ACCERR bit in the FSTAT register (see Section 2.3.2.6). |
| CMDB[2] |  |
| CMDB[0] |  |

Table 2-15. Valid Flash Command List

| CMDB | NVM Command |
| :---: | :--- |
| $0 \times 05$ | Erase verify |
| $0 \times 20$ | Word program |
| $0 \times 40$ | Sector erase |
| $0 \times 41$ | Mass erase |

### 2.3.2.8 RESERVED2

This register is reserved for factory testing and is not accessible to the user.
Module Base $+0 \times 0007$

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 2-12. RESERVED2
All bits read 0 and are not writable.

### 2.3.2.9 Flash Address Register (FADDR)

FADDRHI and FADDRLO are the Flash address registers.


Figure 2-13. Flash Address High Register (FADDRHI)

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Module Base + 0x0009


Figure 2-14. Flash Address Low Register (FADDRLO)
In normal modes, all FABHI and FABLO bits read 0 and are not writable. In special modes, the FABHI and FABLO bits are readable and writable. For sector erase, the MCU address bits [9:0] are ignored. For mass erase, any address within the Flash array is valid to start the command.

### 2.3.2.10 Flash Data Register (FDATA)

FDATAHI and FDATALO are the Flash data registers.


Figure 2-15. Flash Data High Register (FDATAHI)


Figure 2-16. Flash Data Low Register (FDATALO)
In normal modes, all FDATAHI and FDATALO bits read 0 and are not writable. In special modes, all FDATAHI and FDATALO bits are readable and writable when writing to an address within the Flash address range.

### 2.3.2.11 RESERVED3

This register is reserved for factory testing and is not accessible to the user.

Module Base $+0 \times 000 \mathrm{C}$

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 2-17. RESERVED3
All bits read 0 and are not writable.

### 2.3.2.12 RESERVED4

This register is reserved for factory testing and is not accessible to the user.

```
Module Base + 0x000D
```

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 2-18. RESERVED4
All bits read 0 and are not writable.

### 2.3.2.13 RESERVED5

This register is reserved for factory testing and is not accessible to the user.
Module Base + 0x000E


Figure 2-19. RESERVED5
All bits read 0 and are not writable.

### 2.3.2.14 RESERVED6

This register is reserved for factory testing and is not accessible to the user.

```
Module Base + 0x000F
```



Figure 2-20. RESERVED6
All bits read 0 and are not writable.

### 2.4 Functional Description

### 2.4.1 Flash Command Operations

Write operations are used for the program, erase, and erase verify algorithms described in this section. The program and erase algorithms are controlled by a state machine whose timebase FCLK is derived from the oscillator clock via a programmable divider. The FCMD register as well as the associated FADDR and FDATA registers operate as a buffer and a register (2-stage FIFO) so that a new command along with the necessary data and address can be stored to the buffer while the previous command is still in progress. This pipelined operation allows a time optimization when programming more than one word on a specific row, as the high voltage generation can be kept active in between two programming commands. The pipelined operation also allows a simplification of command launching. Buffer empty as well as command completion are signalled by flags in the FSTAT register with corresponding interrupts generated, if enabled.

The next sections describe:

- How to write the FCLKDIV register
- Command write sequence used to program, erase or erase verify the Flash array
- Valid Flash commands
- Errors resulting from illegal Flash operations


### 2.4.1.1 Writing the FCLKDIV Register

Prior to issuing any Flash command after a reset, it is first necessary to write the FCLKDIV register to divide the oscillator clock down to within the $150-\mathrm{kHz}$ to $200-\mathrm{kHz}$ range. Since the program and erase timings are also a function of the bus clock, the FCLKDIV determination must take this information into account.

If we define:

- FCLK as the clock of the Flash timing control block
- Tbus as the period of the bus clock
- $\operatorname{INT}(\mathrm{x})$ as taking the integer part of $\mathrm{x}($ e.g., $\operatorname{INT}(4.323)=4)$,
then FCLKDIV register bits PRDIV8 and FDIV[5:0] are to be set as described in Figure 2-21.
For example, if the oscillator clock frequency is 950 kHz and the bus clock is 10 MHz , FCLKDIV bits FDIV[5:0] should be set to 4 (000100) and bit PRDIV8 set to 0 . The resulting FCLK is then 190 kHz . As a result, the Flash algorithm timings are increased over optimum target by:

$$
(200-190) / 200 \times 100=5 \%
$$

Command execution time will increase proportionally with the period of FCLK.

## CAUTION

Because of the impact of clock synchronization on the accuracy of the functional timings, programming or erasing the Flash array cannot be performed if the bus clock runs at less than 1 MHz . Programming or erasing the Flash array with an input clock $<150 \mathrm{kHz}$ should be avoided. Setting FCLKDIV to a value such that FCLK $<150 \mathrm{kHz}$ can destroy the Flash array due to overstress. Setting FCLKDIV to a value such that (1/FCLK + Tbus) $<5 \mu \mathrm{~s}$ can result in incomplete programming or erasure of the Flash array cells.

If the FCLKDIV register is written, the bit FDIVLD is set automatically. If the FDIVLD bit is 0 , the FCLKDIV register has not been written since the last reset. If the FCLKDIV register has not been written to, the Flash command loaded during a command write sequence will not execute and the ACCERR flag in the FSTAT register will set.

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Figure 2-21. PRDIV8 and FDIV Bits Determination Procedure

### 2.4.1.2 Command Write Sequence

The Flash command controller is used to supervise the command write sequence to execute program, erase, and erase verify algorithms.
Before starting a command write sequence, the ACCERR and PVIOL flags in the FSTAT register must be clear and the CBEIF flag should be tested to determine the state of the address, data, and command buffers. If the CBEIF flag is set, indicating the buffers are empty, a new command write sequence can be started. If the CBEIF flag is clear, indicating the buffers are not available, a new command write sequence will overwrite the contents of the address, data, and command buffers.

A command write sequence consists of three steps which must be strictly adhered to with writes to the Flash module not permitted between the steps. However, Flash register and array reads are allowed during a command write sequence. The basic command write sequence is as follows:

1. Write to a valid address in the Flash array memory.
2. Write a valid command to the FCMD register.
3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the command.

The address written in step 1 will be stored in the FADDR registers and the data will be stored in the FDATA registers. When the CBEIF flag is cleared in step 3, the CCIF flag is cleared by the Flash command controller indicating that the command was successfully launched. For all command write sequences, the CBEIF flag will set after the CCIF flag is cleared indicating that the address, data, and command buffers are ready for a new command write sequence to begin. A buffered command will wait for the active operation to be completed before being launched. Once a command is launched, the completion of the command operation is indicated by the setting of the CCIF flag in the FSTAT register. The CCIF flag will set upon completion of all active and buffered commands.

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### 2.4.1.3 Valid Flash Commands

Table 2-16 summarizes the valid Flash commands along with the effects of the commands on the Flash array.

Table 2-16. Valid Flash Commands

| FCMD | Meaning | Function on Flash Array |
| :---: | :---: | :--- |
| $0 \times 05$ | Erase <br> Verify | Verify all bytes in the Flash array are erased. <br> If the Flash array is erased, the BLANK bit will set in the FSTAT register upon command completion. |
| $0 \times 20$ | Program | Program a word (2 bytes) in the Flash array. |
| $0 \times 40$ | Sector <br> Erase | Erase all 1024 bytes in a sector of the Flash array. |
| $0 \times 41$ | Mass <br> Erase | Erase all bytes in the Flash array. <br> A mass erase of the full Flash array is only possible when FPLDIS, FPHDIS, and FPOPEN bits in <br> the FPROT register are set prior to launching the command. |

## CAUTION

A Flash word must be in the erased state before being programmed. Cumulative programming of bits within a Flash word is not allowed.

### 2.4.1.3.1 Erase Verify Command

The erase verify operation will verify that a Flash array is erased.
An example flow to execute the erase verify operation is shown in Figure 2-22. The erase verify command write sequence is as follows:

1. Write to a Flash array address to start the command write sequence for the erase verify command. The address and data written will be ignored.
2. Write the erase verify command, $0 x 05$, to the FCMD register.
3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the erase verify command.

After launching the erase verify command, the CCIF flag in the FSTAT register will set after the operation has completed unless a new command write sequence has been buffered. Upon completion of the erase verify operation, the BLANK flag in the FSTAT register will be set if all addresses in the Flash array are verified to be erased. If any address in the Flash array is not erased, the erase verify operation will terminate and the BLANK flag in the FSTAT register will remain clear.

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Figure 2-22. Example Erase Verify Command Flow

### 2.4.1.3.2 Program Command

The program operation will program a previously erased word in the Flash array using an embedded algorithm.

An example flow to execute the program operation is shown in Figure 2-23. The program command write sequence is as follows:

1. Write to a Flash array address to start the command write sequence for the program command. The data written will be programmed to the Flash array address written.
2. Write the program command, $0 \times 20$, to the FCMD register.
3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the program command.

If a word to be programmed is in a protected area of the Flash array, the PVIOL flag in the FSTAT register will set and the program command will not launch. Once the program command has successfully launched, the CCIF flag in the FSTAT register will set after the program operation has completed unless a new command write sequence has been buffered. By executing a new program command write sequence on sequential words after the CBEIF flag in the FSTAT register has been set, up to $55 \%$ faster programming time per word can be effectively achieved than by waiting for the CCIF flag to set after each program operation.

## Chapter 2128 Kbyte Flash Module (FTS128K1V1)



Figure 2-23. Example Program Command Flow

### 2.4.1.3.3 Sector Erase Command

The sector erase operation will erase all addresses in a 1024 byte sector of the Flash array using an embedded algorithm.

An example flow to execute the sector erase operation is shown in Figure 2-24. The sector erase command write sequence is as follows:

1. Write to a Flash array address to start the command write sequence for the sector erase command. The Flash address written determines the sector to be erased while MCU address bits [9:0] and the data written are ignored.
2. Write the sector erase command, $0 \times 40$, to the FCMD register.
3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the sector erase command.

If a Flash sector to be erased is in a protected area of the Flash array, the PVIOL flag in the FSTAT register will set and the sector erase command will not launch. Once the sector erase command has successfully launched, the CCIF flag in the FSTAT register will set after the sector erase operation has completed unless a new command write sequence has been buffered.

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Figure 2-24. Example Sector Erase Command Flow

### 2.4.1.3.4 Mass Erase Command

The mass erase operation will erase all addresses in a Flash array using an embedded algorithm.
An example flow to execute the mass erase operation is shown in Figure 2-25. The mass erase command write sequence is as follows:

1. Write to a Flash array address to start the command write sequence for the mass erase command. The address and data written will be ignored.
2. Write the mass erase command, $0 \times 41$, to the FCMD register.
3. Clear the CBEIF flag in the FSTAT register by writing a 1 to CBEIF to launch the mass erase command.

If a Flash array to be erased contains any protected area, the PVIOL flag in the FSTAT register will set and the mass erase command will not launch. Once the mass erase command has successfully launched, the CCIF flag in the FSTAT register will set after the mass erase operation has completed unless a new command write sequence has been buffered.

## Chapter 2128 Kbyte Flash Module (FTS128K1V1)



Figure 2-25. Example Mass Erase Command Flow

### 2.4.1.4 Illegal Flash Operations

### 2.4.1.4.1 Access Error

The ACCERR flag in the FSTAT register will be set during the command write sequence if any of the following illegal Flash operations are performed causing the command write sequence to immediately abort:

1. Writing to the Flash address space before initializing the FCLKDIV register
2. Writing a misaligned word or a byte to the valid Flash address space
3. Writing to the Flash address space while CBEIF is not set
4. Writing a second word to the Flash address space before executing a program or erase command on the previously written word
5. Writing to any Flash register other than FCMD after writing a word to the Flash address space
6. Writing a second command to the FCMD register before executing the previously written command
7. Writing an invalid command to the FCMD register
8. Writing to any Flash register other than FSTAT (to clear CBEIF) after writing to the FCMD register
9. The part enters stop mode and a program or erase command is in progress. The command is aborted and any pending command is killed
10. When security is enabled, a command other than mass erase originating from a non-secure memory or from the background debug mode is written to the FCMD register
11. A 0 is written to the CBEIF bit in the FSTAT register to abort a command write sequence.

The ACCERR flag will not be set if any Flash register is read during the command write sequence. If the Flash array is read during execution of an algorithm ( $\mathrm{CCIF}=0$ ), the Flash module will return invalid data and the ACCERR flag will not be set. If an ACCERR flag is set in the FSTAT register, the Flash command controller is locked. It is not possible to launch another command until the ACCERR flag is cleared.

### 2.4.1.4.2 Protection Violation

The PVIOL flag in the FSTAT register will be set during the command write sequence after the word write to the Flash address space if any of the following illegal Flash operations are performed, causing the command write sequence to immediately abort:

1. Writing a Flash address to program in a protected area of the Flash array (see Section 2.3.2.5).
2. Writing a Flash address to erase in a protected area of the Flash array.
3. Writing the mass erase command to the FCMD register while any protection is enabled.

If the PVIOL flag is set, the Flash command controller is locked. It is not possible to launch another command until the PVIOL flag is cleared.

### 2.4.2 Operating Modes

### 2.4.2.1 Wait Mode

If the MCU enters wait mode while a Flash command is active $(\mathrm{CCIF}=0)$, that command and any buffered command will be completed.

The Flash module can recover the MCU from wait mode if the interrupts are enabled (see Section 2.4.5).

### 2.4.2.2 Stop Mode

If the MCU enters stop mode while a Flash command is active (CCIF $=0$ ), that command will be aborted and the data being programmed or erased is lost. The high voltage circuitry to the Flash array will be switched off when entering stop mode. CCIF and ACCERR flags will be set. Upon exit from stop mode, the CBEIF flag will be set and any buffered command will not be executed. The ACCERR flag must be cleared before returning to normal operation.

## NOTE

As active Flash commands are immediately aborted when the MCU enters stop mode, it is strongly recommended that the user does not use the STOP instruction during program and erase execution.

### 2.4.2.3 Background Debug Mode

In background debug mode (BDM), the FPROT register is writable. If the MCU is unsecured, then all Flash commands listed in Table 2-16 can be executed. If the MCU is secured and is in special single chip mode, the only possible command to execute is mass erase.

### 2.4.3 Flash Module Security

The Flash module provides the necessary security information to the MCU. After each reset, the Flash module determines the security state of the MCU as defined in Section 2.3.2.2, "Flash Security Register (FSEC)".

The contents of the Flash security/options byte at address 0xFF0F in the Flash configuration field must be changed directly by programming address 0 xFF 0 F when the device is unsecured and the higher address sector is unprotected. If the Flash security/options byte is left in the secure state, any reset will cause the MCU to return to the secure operating mode.

### 2.4.3.1 Unsecuring the MCU using Backdoor Key Access

The MCU may only be unsecured by using the backdoor key access feature which requires knowledge of the contents of the backdoor key (four 16-bit words programmed at addresses $0 \times \mathrm{xFF} 00-0 \times \mathrm{xFF} 07$ ). If KEYEN[1:0] = 1:0 and the KEYACC bit is set, a write to a backdoor key address in the Flash array triggers a comparison between the written data and the backdoor key data stored in the Flash array. If all four words of data are written to the correct addresses in the correct order and the data matches the backdoor key stored in the Flash array, the MCU will be unsecured. The data must be written to the backdoor key
addresses sequentially staring with $0 \mathrm{xFF} 00-0 \mathrm{xFF} 01$ and ending with $0 \mathrm{xFF} 06-0 \mathrm{xFF} 07$. The values 0 x 0000 and $0 x F F F F$ are not permitted as keys. When the KEYACC bit is set, reads of the Flash array will return invalid data.

The user code stored in the Flash array must have a method of receiving the backdoor key from an external stimulus. This external stimulus would typically be through one of the on-chip serial ports.

If KEYEN[1:0] = 1:0 in the FSEC register, the MCU can be unsecured by the backdoor key access sequence described below:

1. Set the KEYACC bit in the FCNFG register
2. Write the correct four 16 -bit words to Flash addresses $0 x F F 00-0 x F F 07$ sequentially starting with 0xFF00
3. Clear the KEYACC bit in the FCNFG register
4. If all four 16-bit words match the backdoor key stored in Flash addresses $0 \times \mathrm{xFF} 00-0 \mathrm{xFF} 07$, the MCU is unsecured and bits SEC[1:0] in the FSEC register are forced to the unsecure state of 1:0

The backdoor key access sequence is monitored by the internal security state machine. An illegal operation during the backdoor key access sequence will cause the security state machine to lock, leaving the MCU in the secured state. A reset of the MCU will cause the security state machine to exit the lock state and allow a new backdoor key access sequence to be attempted. The following illegal operations will lock the security state machine:

1. If any of the four 16-bit words does not match the backdoor key programmed in the Flash array
2. If the four 16 -bit words are written in the wrong sequence
3. If more than four 16 -bit words are written
4. If any of the four 16 -bit words written are $0 \times 0000$ or $0 x F F F F$
5. If the KEYACC bit does not remain set while the four 16-bit words are written

After the backdoor key access sequence has been correctly matched, the MCU will be unsecured. The Flash security byte can be programmed to the unsecure state, if desired.

In the unsecure state, the user has full control of the contents of the four word backdoor key by programming bytes $0 \times \mathrm{xFF} 00-0 \mathrm{xFF} 07$ of the Flash configuration field.

The security as defined in the Flash security/options byte at address $0 x F F 0 F$ is not changed by using the backdoor key access sequence to unsecure. The backdoor key stored in addresses $0 x \mathrm{xF} 00-0 \mathrm{xFF} 07$ is unaffected by the backdoor key access sequence. After the next reset sequence, the security state of the Flash module is determined by the Flash security/options byte at address 0xFF0F. The backdoor key access sequence has no effect on the program and erase protection defined in the FPROT register.

It is not possible to unsecure the MCU in special single chip mode by executing the backdoor key access sequence in background debug mode.

### 2.4.4 Flash Reset Sequence

On each reset, the Flash module executes a reset sequence to hold CPU activity while loading the following registers from the Flash array memory according to Table 2-1:

- FPROT — Flash Protection Register (see Section 2.3.2.5)
- FSEC - Flash Security Register (see Section 2.3.2.2)


### 2.4.4.1 Reset While Flash Command Active

If a reset occurs while any Flash command is in progress, that command will be immediately aborted. The state of the word being programmed or the sector/array being erased is not guaranteed.

### 2.4.5 Interrupts

The Flash module can generate an interrupt when all Flash commands have completed execution or the Flash address, data, and command buffers are empty.

Table 2-17. Flash Interrupt Sources

| Interrupt Source | Interrupt Flag | Local Enable | Global (CCR) Mask |
| :--- | :---: | :---: | :---: |
| Flash Address, Data, and Command <br> Buffers are empty | CBEIF <br> (FSTAT register) | CBEIE | I Bit |
| All Flash commands have completed <br> execution | CCIF <br> (FSTAT register) | CCIE | I Bit |

NOTE
Vector addresses and their relative interrupt priority are determined at the MCU level.

### 2.4.5.1 Description of Interrupt Operation

Figure 2-26 shows the logic used for generating interrupts.
The Flash module uses the CBEIF and CCIF flags in combination with the enable bits CBIE and CCIE to discriminate for the generation of interrupts.


Figure 2-26. Flash Interrupt Implementation
For a detailed description of these register bits, refer to Section 2.3.2.4, "Flash Configuration Register (FCNFG)" and Section 2.3.2.6, "Flash Status Register (FSTAT)".

## Chapter 3 Port Integration Module (PIM9E128V1)

### 3.1 Introduction

The port integration module establishes the interface between the peripheral modules and the I/O pins for for ports AD, M, P, Q, S, T and U.

This section covers:

- Port A, B, E, and K and the BKGD pin
- Port AD associated with ATD module (channels 15 through 0) and keyboard wake-up interrupts
- Port M connected to 2 DAC, 1 IIC and 1 SCI (SCI2) modules
- Port P and port Q connected to PMF module
- Port S connected to 2 SCI (SCI0 and SCI1) and 1 SPI modules
- Port T connected to 2 TIM (TIM0 and TIM1) modules
- Port U connected to 1 TIM (TIM2) and 1 PWM modules

Each I/O pin can be configured by several registers: input/output selection, drive strength reduction, enable and select of pull resistors, wired-or mode selection, interrupt enable, and/or status flags.

## NOTE

Refer to the MEBI block description chapter for details on p orts A, B, E and K , and the BKGD pin.

### 3.1.1 Features

A standard port has the following minimum features:

- Input/output selection
- 5-V output drive with two selectable drive strength (or slew rates)
- 5-V digital and analog input
- Input with selectable pull-up or pull-down device

Optional features:

- Open drain for wired-OR connections
- Interrupt input with glitch filtering

Chapter 3 Port Integration Module (PIM9E128V1)

### 3.1.2 Block Diagram

Figure 3-1 is a block diagram of the PIM9E128V1.


Figure 3-1. PIM9E128V1 Block Diagram

### 3.2 External Signal Description

This section lists and describes the signals that connect off chip.
Table 3-1 shows all the pins and their functions that are controlled by the PIM9E128V1. The order in which the pin functions are listed represents the functions priority (top - highest priority, bottom - lowest priority).

Table 3-1. Detailed Signal Descriptions (Sheet 1 of 6)

| Port | Pin Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| - | BKGD | MODC | Refer to the MEBI block description chapter | Refer to the MEBI block description chapter |
|  |  | BKGD | Refer to the BDM block description chapter |  |
|  |  | TAGHI | Refer to the MEBI block description chapter |  |
| Port A | PA7 | ADDR15/DATA15 | Refer to the MEBI block description chapter | Refer to the MEBI block description chapter |
|  |  | GPIO | General-purpose I/O |  |
|  | PA6 | ADDR14/DATA14 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA5 | ADDR13/DATA13 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA4 | ADDR12/DATA12 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA3 | ADDR11/DATA11 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA2 | ADDR10/DATA10 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA1 | ADDR9/DATA9 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PA0 | ADDR8/DATA8 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
| Port B | PB7 | ADDR7/DATA7 | Refer to the MEBI block description chapter | Refer to the MEBI block description chapter |
|  |  | GPIO | General-purpose I/O |  |
|  | PB6 | ADDR6/DATA6 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB5 | ADDR5/DATA5 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB4 | ADDR4/DATA4 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB3 | ADDR3/DATA3 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB2 | ADDR2/DATA2 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB1 | ADDR1/DATA1 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PB0 | ADDR0/DATA0 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |

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Table 3-1. Detailed Signal Descriptions (Sheet 2 of 6)

| Port | Pin <br> Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Port E | PE7 | XCLKS | Refer to OSC block description chapter | Refer to the MEBI block description chapter |
|  |  | NOACC | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE6 | IPIPE1/MODB | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE5 | IPIPE0/MODA | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE4 | ECLK | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE3 | $\overline{\text { LSTRB/TAGLO }}$ | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE2 | R/W | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE1 | $\overline{\mathrm{IRQ}}$ | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PE0 | $\overline{\text { XIRQ }}$ | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
| Port K | PK7 | ECS/ROMONE | Refer to the MEBI block description chapter | Refer to the MEBI block description chapter |
|  |  | GPIO | General-purpose I/O |  |
|  | PK6 | $\overline{\text { XCS }}$ | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK5 | XADDR19 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK4 | XADDR18 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK3 | XADDR17 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK2 | XADDR16 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK1 | XADDR15 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PK0 | XADDR14 | Refer to the MEBI block description chapter |  |
|  |  | GPIO | General-purpose I/O |  |

Table 3-1. Detailed Signal Descriptions (Sheet 3 of 6)

| Port | Pin Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Port AD | PAD15 | AN15 | Analog-to-digital converter input channel 15 | GPIO |
|  |  | KWAD15 | Keyboard wake-up interrupt 15 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD14 | AN14 | Analog-to-digital converter input channel 14 |  |
|  |  | KWAD14 | Keyboard wake-up interrupt 14 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD13 | AN13 | Analog-to-digital converter input channel 13 |  |
|  |  | KWAD13 | Keyboard wake-up interrupt 13 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD12 | AN12 | Analog-to-digital converter input channel 12 |  |
|  |  | KWAD12 | Keyboard wake-up interrupt 12 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD11 | AN11 | Analog-to-digital converter input channel 11 |  |
|  |  | KWAD11 | Keyboard wake-up interrupt 11 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD10 | AN10 | Analog-to-digital converter input channel 10 |  |
|  |  | KWAD10 | Keyboard wake-up interrupt 10 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD9 | AN9 | Analog-to-digital converter input channel 9 |  |
|  |  | KWAD9 | Keyboard wake-up interrupt 9 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD8 | AN8 | Analog-to-digital converter input channel 8 |  |
|  |  | KWAD8 | Keyboard wake-up interrupt 8 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD7 | AN7 | Analog-to-digital converter input channel 7 |  |
|  |  | KWAD7 | Keyboard wake-up interrupt 7 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD6 | AN6 | Analog-to-digital converter input channel 6 |  |
|  |  | KWAD6 | Keyboard wake-up interrupt 6 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD5 | AN5 | Analog-to-digital converter input channel 5 |  |
|  |  | KWAD5 | Keyboard wake-up interrupt 5 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD4 | AN4 | Analog-to-digital converter input channel 4 |  |
|  |  | KWAD4 | Keyboard wake-up interrupt 4 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD3 | AN3 | Analog-to-digital converter input channel 3 |  |
|  |  | KWAD3 | Keyboard wake-up interrupt 3 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD2 | AN2 | Analog-to-digital converter input channel 2 |  |
|  |  | KWAD2 | Keyboard wake-up interrupt 2 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PAD1 | AN1 | Analog-to-digital converter input channel 1 |  |
|  |  | KWAD1 | Keyboard wake-up interrupt 1 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PADO | ANO | Analog-to-digital converter input channel 0 |  |
|  |  | KWAD0 | Keyboard wake-up interrupt 0 |  |
|  |  | GPIO | General-purpose I/O |  |

Table 3-1. Detailed Signal Descriptions (Sheet 4 of 6 )

| Port | Pin Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Port M | PM7 | SCL | Inter-integrated circuit serial clock line | GPIO |
|  |  | GPIO | General-purpose I/O |  |
|  | PM6 | SDA | Inter-integrated circuit serial data line |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PM5 | TXD2 | Serial communication interface 2 transmit pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PM4 | RXD2 | Serial communication interface 2 receive pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PM3 | GPIO | General-purpose I/O |  |
|  | PM1 | DAO1 | Digital to analog convertor 1 output |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PM0 | DAO0 | Digital to analog convertor 0 output |  |
|  |  | GPIO | General-purpose I/O |  |
| Port P | PP5 | PWM5 | Pulse-width modulator 0 channel 5 | GPIO |
|  |  | GPIO | General-purpose I/O |  |
|  | PP4 | PWM4 | Pulse-width modulator 0 channel 4 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PP3 | PWM3 | Pulse-width modulator 0 channel 3 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PP2 | PWM2 | Pulse-width modulator 0 channel 2 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PP1 | PWM1 | Pulse-width modulator 0 channel 1 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PP0 | PWM0 | Pulse-width modulator 0 channel 0 |  |
|  |  | GPIO | General-purpose I/O |  |
| Port Q | PQ6 | IS2 | PMF current status pin 2 | GPIO |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ5 | IS1 | PMF current status pin 1 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ4 | IS0 | PMF current status pin 0 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ3 | FAULT3 | PMF fault pin3 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ2 | FAULT2 | PMF fault pin 2 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ1 | FAULT11 | PMF fault pin 1 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PQ0 | FAULT0 | PMF fault pin 0 |  |
|  |  | GPIO | General-purpose I/O |  |

Table 3-1. Detailed Signal Descriptions (Sheet 5 of 6)

| Port | Pin Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Port S | PS7 | SS | Serial peripheral interface slave select input/output in master mode, input in slave mode | GPIO |
|  |  | GPIO | General-purpose I/O |  |
|  | PS6 | SCK | Serial peripheral interface serial clock pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS5 | MOSI | Serial peripheral interface master out/slave in pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS4 | MISO | Serial peripheral interface master in/slave out pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS3 | TXD0 | Serial communication interface 1 transmit pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS2 | RXD0 | Serial communication interface 1 receive pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS1 | TXD0 | Serial communication interface 0 transmit pin |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PS0 | RXD0 | Serial communication interface 0 receive pin |  |
|  |  | GPIO | General-purpose I/O |  |
| Port T | PT7 | $10 C 7$ | Timer 1 channel 7 | GPIO |
|  |  | GPIO | General-purpose I/O |  |
|  | PT6 | IOC6 | Timer 1 channel 6 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT5 | IOC5 | Timer 1 channel 5 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT4 | IOC4 | Timer 1 channel 4 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT3 | IOC3 | Timer 0 channel 7 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT2 | IOC2 | Timer 0 channel 6 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT1 | IOC1 | Timer 0 channel 5 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PT0 | IOC0 | Timer 0 channel 4 |  |
|  |  | GPIO | General-purpose I/O |  |

## Chapter 3 Port Integration Module (PIM9E128V1)

Table 3-1. Detailed Signal Descriptions (Sheet 6 of 6)

| Port | Pin Name | Pin Function | Description | Pin Function after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Port U | PU7 | GPIO | General-purpose I/O | GPIO |
|  | PU6 | GPIO | General-purpose I/O |  |
|  | PU5 | PW15 | Pulse-width modulator 1 channel 5 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PU4 | PW14 | Pulse-width modulator 1 channel 4 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PU3 | IOC3 | Timer 2 channel 7 |  |
|  |  | PW13 | Pulse-width modulator 1 channel 3 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PU2 | IOC2 | Timer 2 channel 6 |  |
|  |  | PW12 | Pulse-width modulator 1 channel 2 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PU1 | IOC1 | Timer 2 channel 5 |  |
|  |  | PW11 | Pulse-width modulator 1 channel 1 |  |
|  |  | GPIO | General-purpose I/O |  |
|  | PU0 | IOC0 | Timer 2 channel 4 |  |
|  |  | PW11 | Pulse-width modulator 1 channel 0 |  |
|  |  | GPIO | General-purpose I/O |  |

### 3.3 Memory Map and Register Definition

This section provides a detailed description of all registers. Table 3-2 is a standard memory map of port integration module.

Table 3-2. PIM9HZ256 Memory Map

| Address Offset | Use | Access |
| :---: | :---: | :---: |
| 0x0000 | Port T I/O Register (PTT) | R/W |
| $0 \times 0001$ | Port T Input Register (PTIT) | R |
| 0x0002 | Port T Data Direction Register (DDRT) | R/W |
| $0 \times 0003$ | Port T Reduced Drive Register (RDRT) | R/W |
| 0x0004 | Port T Pull Device Enable Register (PERT) | R/W |
| 0x0005 | Port T Polarity Select Register (PPST) | R/W |
| 0x0006-0x0007 | Reserved | - |
| $0 \times 0008$ | Port S I/O Register (PTS) | R/W |
| $0 \times 0009$ | Port S Input Register (PTIS) | R |
| 0x000A | Port S Data Direction Register (DDRS) | R/W |
| 0x000B | Port S Reduced Drive Register (RDRS) | R/W |
| 0x000C | Port S Pull Device Enable Register (PERS) | R/W |
| 0x000D | Port S Polarity Select Register (PPSS) | R/W |
| 0x000E | Port S Wired-OR Mode Register (WOMS) | R/W |
| 0x000F | Reserved | - |
| $0 \times 0010$ | Port M I/O Register (PTM) | R/W |
| $0 \times 0011$ | Port M Input Register (PTIM) | R |
| $0 \times 0012$ | Port M Data Direction Register (DDRM) | R/W |
| $0 \times 0013$ | Port M Reduced Drive Register (RDRM) | R/W |
| $0 \times 0014$ | Port M Pull Device Enable Register (PERM) | R/W |
| $0 \times 0015$ | Port M Polarity Select Register (PPSM) | R/W |
| $0 \times 0016$ | Port M Wired-OR Mode Register (WOMM) | R/W |
| $0 \times 0017$ | Reserved | - |
| $0 \times 0018$ | Port P I/O Register (PTP) | R/W |
| $0 \times 0019$ | Port P Input Register (PTIP) | R |
| 0x001A | Port P Data Direction Register (DDRP) | R/W |
| 0x001B | Port P Reduced Drive Register (RDRP) | R/W |
| 0x001C | Port P Pull Device Enable Register (PERP) | R/W |
| 0x001D | Port P Polarity Select Register (PPSP) | R/W |
| 0x001E-0x001F | Reserved | - |

Table 3-2. PIM9HZ256 Memory Map (continued)

| Address Offset | Use | Access |
| :---: | :---: | :---: |
| 0x0020 | Port Q I/O Register (PTQ) | R/W |
| $0 \times 0021$ | Port Q Input Register (PTIQ) | R |
| $0 \times 0022$ | Port Q Data Direction Register (DDRQ) | R/W |
| $0 \times 0023$ | Port Q Reduced Drive Register (RDRQ) | R/W |
| 0x0024 | Port Q Pull Device Enable Register (PERQ) | R/W |
| $0 \times 0025$ | Port Q Polarity Select Register (PPSQ) | R/W |
| 0x0026-0x0027 | Reserved | - |
| $0 \times 0028$ | Port U I/O Register (PTU) | R/W |
| $0 \times 0029$ | Port U Input Register (PTIU) | R |
| $0 \times 002 \mathrm{~A}$ | Port U Data Direction Register (DDRU) | R/W |
| $0 \times 002 \mathrm{~B}$ | Port U Reduced Drive Register (RDRU) | R/W |
| 0x002C | Port U Pull Device Enable Register (PERU) | R/W |
| 0x002D | Port U Polarity Select Register (PPSU) | R/W |
| 0x002E | Port U Module Routing Register (MODRR) | R/W |
| 0x002F | Reserved | - |
| $0 \times 0030$ | Port AD I/O Register (PTAD) | R/W |
| $0 \times 0031$ |  |  |
| 0x0032 | Port AD Input Register (PTIAD) | R |
| $0 \times 0033$ |  |  |
| $0 \times 0034$ | Port AD Data Direction Register (DDRAD) | R/W |
| $0 \times 0035$ |  |  |
| $0 \times 0036$ | Port AD Reduced Drive Register (RDRAD) | R/W |
| $0 \times 0037$ |  |  |
| 0x0038 | Port AD Pull Device Enable Register (PERAD) | R/W |
| 0x0039 |  |  |
| 0x003A | Port AD Polarity Select Register (PPSAD) | R/W |
| 0x003B |  |  |
| 0x003D | Port AD Interrupt Enable Register (PIEAD) | R/W |
| 0x003D |  |  |
| 0x003E | Port AD Interrupt Flag Register (PIFAD) | R/W |
| 0x003F |  |  |

### 3.3.1 Port AD

Port AD is associated with the analog-to-digital converter (ATD) and keyboard wake-up (KWU) interrupts. Each pin is assigned to these modules according to the following priority: ATD $>\mathrm{KWU}>$ general-purpose I/O.

For the pins of port AD to be used as inputs, the corresponding bits of the ATDDIEN0 and ATDDIEN1 registers in the ATD module must be set to 1 (digital input buffer is enabled). The ATDDIEN0 and ATDDIEN1 registers do not affect the port AD pins when they are configured as outputs.

Refer to the ATD block description chapter for information on the ATDDIEN0 and ATDDIEN1 registers.
During reset, port AD pins are configured as high-impedance analog inputs (digital input buffer is disabled).

### 3.3.1.1 Port AD I/O Register (PTAD)



Figure 3-2. Port AD I/O Register (PTAD)
Read: Anytime. Write: Anytime.
If the data direction bit of the associated I/O pin (DDRADx) is set to 1 (output), a write to the corresponding I/O Register bit sets the value to be driven to the Port AD pin. If the data direction bit of the associated I/O pin (DDRADx) is set to 0 (input), a write to the corresponding I/O Register bit takes place but has no effect on the Port AD pin.

If the associated data direction bit (DDRADx) is set to 1 (output), a read returns the value of the I/O register bit.

If the associated data direction bit (DDRADx) is set to 0 (input) and the associated ATDDIEN0(1) bit is set to 0 (digital input buffer is disabled), the associated I/O register bit (PTADx) reads " 1 ".

If the associated data direction bit (DDRADx) is set to 0 (input) and the associated ATDDIEN0(1) bit is set to 1 (digital input buffer is enabled), a read returns the value of the pin.

### 3.3.1.2 Port AD Input Register (PTIAD)



Figure 3-3. Port AD Input Register (PTIAD)
Read: Anytime. Write: Never; writes to these registers have no effect.
If the ATDDIEN0(1) bit of the associated I/O pin is set to 0 (digital input buffer is disabled), a read returns a 1. If the ATDDIEN0(1) bit of the associated I/O pin is set to 1 (digital input buffer is enabled), a read returns the status of the associated pin.

### 3.3.1.3 Port AD Data Direction Register (DDRAD)



Figure 3-4. Port AD Data Direction Register (DDRAD)
Read: Anytime. Write: Anytime.
This register configures port pins $\operatorname{PAD}$ [15:0] as either input or output.
If a data direction bit is 0 (pin configured as input), then a read value on PTADx depends on the associated ATDDIEN0(1) bit. If the associated ATDDIEN0(1) bit is set to 1 (digital input buffer is enabled), a read on PTADx returns the value on port AD pin. If the associated ATDDIEN0(1) bit is set to 0 (digital input buffer is disabled), a read on PTADx returns a 1.

Table 3-3. DDRAD Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| 15:0 | Data Direction Port AD <br> DDRAD[15:0] <br> 0 | Associated pin is configured as input. |
| 1 | Associated pin is configured as output. |  |

### 3.3.1.4 Port AD Reduced Drive Register (RDRAD)



Figure 3-5. Port AD Reduced Drive Register (RDRAD)
Read: Anytime. Write: Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-4. RDRAD Field Descriptions

| Field |  |
| :---: | :--- |
| $15: 0$ | Reduced Drive Port AD |
| RDRAD[15:0] | Rescription <br>  <br>  <br> 1 Full drive strength at output. |

### 3.3.1.5 Port AD Pull Device Enable Register (PERAD)



Figure 3-6. Port AD Pull Device Enable Register (PERAD)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input pins. If a pin is configured as output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-5. PERAD Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $15: 0$ | Pull Device Enable Port AD <br> PERAD[15:0 <br> 0 <br> 0 Pull-up or pull-down device is disabled. |  |
| 1 | Pull-up or pull-down device is enabled. |  |

### 3.3.1.6 Port AD Polarity Select Register (PPSAD)



Figure 3-7. Port AD Polarity Select Register (PPSAD)
Read: Anytime. Write: Anytime.
The Port AD Polarity Select Register serves a dual purpose by selecting the polarity of the active interrupt edge as well as selecting a pull-up or pull-down device if enabled (PERADx = 1). The Port AD Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input).

In pull-down mode (PPSADx = 1), a rising edge on a port AD pin sets the corresponding PIFADx bit. In pull-up mode ( $\mathrm{PPSADx}=0$ ), a falling edge on a port AD pin sets the corresponding PIFADx bit.

Table 3-6. PPSAD Field Descriptions

| Field | Description |
| :---: | :--- |
| 15:0 | Polarity Select Port AD <br> PPSAD[15:0] <br> 0 <br> A pulll-up device is connected to the associated port AD pin, and detects falling edge for interrupt generation. <br> A pull-down device is connected to the associated port AD pin, and detects rising edge for interrupt <br> generation. |

### 3.3.1.7 Port AD Interrupt Enable Register (PIEAD)



Figure 3-8. Port AD Interrupt Enable Register (PIEAD)
Read: Anytime. Write: Anytime.
This register disables or enables on a per pin basis the edge sensitive external interrupt associated with port AD.

Table 3-7. PIEAD Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| 15:0 | Interrupt Enable Port AD |  |
| PIEAD[15:0] | Interrupt is disabled (interrupt flag masked). <br>  <br> 1 |  |

### 3.3.1.8 Port AD Interrupt Flag Register (PIFAD)



Figure 3-9. Port AD Interrupt Flag Register (PIFAD)
Read: Anytime. Write: Anytime.
Each flag is set by an active edge on the associated input pin. The active edge could be rising or falling based on the state of the corresponding PPSADx bit. To clear each flag, write " 1 " to the corresponding PIFADx bit. Writing a " 0 " has no effect.

## NOTE

If the ATDDIEN0(1) bit of the associated pin is set to 0 (digital input buffer is disabled), active edges can not be detected.

Table 3-8. PIFAD Field Descriptions

| Field | Description |
| :---: | :--- |
| $15: 0$ | Interrupt Flags Port AD |
| PIFAD[15:0] | No active edge pending. Writing a "0" has no effect. <br> 1Active edge on the associated bit has occurred (an interrupt will occur if the associated enable bit is set). <br> Writing a "1" clears the associated flag. |

### 3.3.2 Port M

Port M is associated with the serial communication interface (SCI2), Inter-IC bus (IIC) and the digital to analog converter (DAC0 and DAC1) modules. Each pin is assigned to these modules according to the following priority: IIC/SCI2/DAC1/DAC0 > general-purpose I/O.

When the IIC bus is enabled, the PM[7:6] pins become SCL and SDA respectively. Refer to the IIC block description chapter for information on enabling and disabling the IIC bus.

When the SCI2 receiver and transmitter are enabled, the PM[5:4] become RXD2 and TXD2 respectively. Refer to the SCI block description chapter for information on enabling and disabling the SCI receiver and transmitter.

When the DAC1 and DAC0 outputs are enabled, the PM[1:0] become DAO1 and DAO0 respectively. Refer to the DAC block description chapter for information on enabling and disabling the DAC output.

During reset, $\mathrm{PM}[3]$ and $\mathrm{PM}[1: 0]$ pins are configured as high-impedance inputs and $\mathrm{PM}[7: 4]$ pins are configured as pull-up inputs.

### 3.3.2.1 Port M I/O Register (PTM)



Figure 3-10. Port M I/O Register (PTM)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRMx) is set to 1 (output), a read returns the value of the $\mathrm{I} / \mathrm{O}$ register bit. If the associated data direction bit (DDRMx) is set to 0 (input), a read returns the value of the pin.

### 3.3.2.2 Port M Input Register (PTIM)



Figure 3-11. Port M Input Register (PTIM)

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Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.2.3 Port M Data Direction Register (DDRM)



Figure 3-12. Port M Data Direction Register (DDRM)
Read: Anytime. Write: Anytime.
This register configures port pins PM[7:3] and PM[1:0] as either input or output.
If the IIC is enabled, the IIC controls the SCL and SDA I/O direction, and the corresponding DDRM[7:6] bits have no effect on their I/O direction. Refer to the IIC block description chapter for details.

If the SCI2 transmitter is enabled, the I/O direction of the transmit pin TXD2 is controlled by SCI2, and the DDRM5 bit has no effect. If the SCI2 receiver is enabled, the I/O direction of the receive pin RXD2 is controlled by SCI2, and the DDRM4 bit has no effect. Refer to the SCI block description chapter for further details.

If the DAC1 or DAC0 channel is enabled, the associated pin DAO1 or DAO0 is forced to be output, and the associated DDRM1 or DDRM0 bit has no effect.

The DDRM bits do not change to reflect the pin I/O direction when not being used as GPIO. The DDRM[7:3]; DDRM[1:0] bits revert to controlling the I/O direction of the pins when the associated IIC, SCI, or DAC1/0 function are disabled.

Table 3-9. DDRM Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 3,1: 0$ | Data Direction Port $\mathbf{M}$ |  |
| DDRM[7:3, | 0 Associated pin is configured as input. |  |
| $1: 0]$ | 1 Associated pin is configured as output. |  |

### 3.3.2.4 Port M Reduced Drive Register (RDRM)



Figure 3-13. Port M Reduced Drive Register (RDRM)
Read: Anytime. Write: Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-10. RDRM Field Descriptions

| Field |  |
| :---: | :--- |
| $7: 3,1: 0$ | Reduced Drive Port M |
| RDRM[7:3, | 0 Full drive strength at output |
| $1: 0]$ | 1 Associated pin drives at about $1 / 3$ of the full drive strength. |

### 3.3.2.5 Port M Pull Device Enable Register (PERM)



Figure 3-14. Port M Pull Device Enable Register (PERM)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input or wired-or output pins. If a pin is configured as push-pull output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-11. PERM Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 3,1: 0$ | Pull Device Enable Port M |  |
| PERM[7:3, | 0 Pull-up or pull-down device is disabled. |  |
| $1: 0]$ | 1 | Pull-up or pull-down device is enabled. |

### 3.3.2.6 Port M Polarity Select Register (PPSM)



Figure 3-15. Port M Polarity Select Register (PPSM)
Read: Anytime. Write: Anytime.
The Port M Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port M Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1 .

Table 3-12. PPSM Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 3,1: 0$ | Pull Select Port $\mathbf{M}$ |
| PPSM[7:3, | 0 A pull-up device is connected to the associated port M pin. |
| $1: 0]$ | 1 A pull-down device is connected to the associated port $M$ pin. |

### 3.3.2.7 Port M Wired-OR Mode Register (WOMM)



Figure 3-16. Port M Wired-OR Mode Register (WOMM)
Read: Anytime. Write: Anytime.
This register selects whether a port M output is configured as push-pull or wired-or. When a Wired-OR Mode Register bit is set to 1 , the corresponding output pin is driven active low only (open drain) and a high level is not driven. A Wired-OR Mode Register bit has no effect if the corresponding pin is configured as an input.

These bits apply also to the SCI2 outputs and allow a multipoint connection of several serial modules.
If the IIC is enabled, the associated pins are always set to wired-or mode, and the state of the WOMM[7:6] bits have no effect. The WOMM[7:6] bits will not change to reflect their wired-or mode configuration when the IIC is enabled.

Table 3-13. WOMM Field Descriptions

| Field |  |
| :---: | :--- |
| $7: 4$ | Wired-OR Mode Port M |
| WOMM[7:4] | Description <br>  <br>  <br>  <br> 1 <br> 1 Output buffers operate as push-pull outputs. |

### 3.3.3 Port $\mathbf{P}$

Port P is associated with the Pulse Width Modulator (PMF) modules. Each pin is assigned according to the following priority: $\mathrm{PMF}>$ general-purpose I/O.

When a PMF channel is enabled, the corresponding pin becomes a PWM output. Refer to the PMF block description chapter for information on enabling and disabling the PWM channels.

During reset, port P pins are configured as high-impedance inputs.

### 3.3.3.1 Port P I/O Register (PTP)



Figure 3-17. Port P I/O Register (PTP)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRPx) is set to 1 (output), a read returns the value of the $\mathrm{I} / \mathrm{O}$ register bit. If the associated data direction bit (DDRPx) is set to 0 (input), a read returns the value of the pin.

The PMF function takes precedence over the general-purpose I/O function if the associated PWM channel is enabled. The PWM channels 5-0 are outputs if the respective channels are enabled.

### 3.3.3.2 Port P Input Register (PTIP)



Figure 3-18. Port P Input Register (PTIP)
Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.3.3 Port P Data Direction Register (DDRP)



Figure 3-19. Port P Data Direction Register (DDRP)
Read: Anytime. Write: Anytime.
This register configures port pins $\operatorname{PP}$ [5:0] as either input or output.
If a PMF channel is enabled, the corresponding pin is forced to be an output and the associated Data Direction Register bit has no effect. If a PMF channel is disabled, the corresponding Data Direction Register bit reverts to control the I/O direction of the associated pin.

Table 3-14. DDRP Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $5: 0$ | Data Direction Port $\mathbf{P}$ |  |
| DDRP[5:0] | Associated pin is configured as input. <br> 1 |  |

### 3.3.3.4 Port P Reduced Drive Register (RDRP)



Figure 3-20. Port P Reduced Drive Register (RDRP)
Read:Anytime. Write:Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-15. RDRP Field Descriptions

| Field |  |
| :---: | :--- |
| $5: 0$ | Reduced Drive Port $\mathbf{P}$ |
| RDRP[5:0] | D Full drive strength at output. <br> 1 Associated pin drives at about $1 / 3$ of the full drive strength. |

### 3.3.3.5 Port P Pull Device Enable Register (PERP)



Figure 3-21. Port P Pull Device Enable Register (PERP)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input pins. If a pin is configured as output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-16. PERP Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $5: 0$ | Pull Device Enable Port P |  |
| PERP[5:0] | Pull-up or pull-down device is disabled. <br> 1 Pull-up or pull-down device is enabled. |  |

### 3.3.3.6 Port P Polarity Select Register (PPSP)



Figure 3-22. Port P Polarity Select Register (PPSP)
Read: Anytime. Write: Anytime.
The Port P Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port P Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1.

Table 3-17. PPSP Field Descriptions

| Field | Description |
| :---: | :--- |
| $5: 0$ | Polarity Select Port $\mathbf{P}$ |
| PPSP[5:0] | 0 pull-up device is connected to the associated port P pin. <br> 1 A pull-down device is connected to the associated port $P$ pin. |

### 3.3.4 Port Q

Port Q is associated with the Pulse Width Modulator (PMF) modules. Each pin is assigned according to the following priority: $\mathrm{PMF}>$ general-purpose I/O.

When a current status or fault function is enabled, the corresponding pin becomes an input. $\mathrm{PQ}[3: 0]$ are connected to FAULT[3:0] inputs and PQ[6:4] are connected to $\overline{\mathrm{IS}}[2: 0]$ inputs of the PMF module. Refer to the PMF block description chapter for information on enabling and disabling these PMF functions.

During reset, port Q pins are configured as high-impedance inputs.

### 3.3.4.1 Port Q I/O Register (PTQ)



Figure 3-23. Port Q I/O Register (PTQ)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRQx) is set to 1 (output), a read returns the value of the $\mathrm{I} / \mathrm{O}$ register bit. If the associated data direction bit (DDRQx) is set to 0 (input), a read returns the value of the pin.

### 3.3.4.2 Port Q Input Register (PTIQ)



Figure 3-24. Port Q Input Register (PTIQ)
Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.4.3 Port Q Data Direction Register (DDRQ)



Figure 3-25. Port Q Data Direction Register (DDRQ)
Read: Anytime. Write: Anytime.
This register configures port pins $\mathrm{PQ}[6: 0]$ as either input or output.
If a PMF function is enabled, the corresponding pin is forced to be an input and the associated Data Direction Register bit has no effect. If a PMF channel is disabled, the corresponding Data Direction Register bit reverts to control the I/O direction of the associated pin.

Table 3-18. DDRQ Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $6: 0$ | Data Direction Port Q |  |
| DDRQ[6:0] | 0 Associated pin is configured as input. <br> 1 |  |

### 3.3.4.4 Port Q Reduced Drive Register (RDRQ)



Figure 3-26. Port Q Reduced Drive Register (RDRQ)
Read:Anytime. Write:Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-19. RDRQ Field Descriptions

| Field |  |
| :---: | :--- |
| $6: 0$ | Reduced Drive Port Q |
| RDRQ[6:0] | D Full drive strength at output. <br> 1 Associated pin drives at about $1 / 3$ of the full drive strength. |

### 3.3.4.5 Port Q Pull Device Enable Register (PERQ)



Figure 3-27. Port Q Pull Device Enable Register (PERQ)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input pins. If a pin is configured as output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-20. PERP Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $6: 0$ | Pull Device Enable Port P |  |
| PERQ[6:0] | Pull-up or pull-down device is disabled. <br> 1 <br>  Pull-up or pull-down device is enabled. |  |

### 3.3.4.6 Port Q Polarity Select Register (PPSQ)



Figure 3-28. Port Q Polarity Select Register (PPSQ)
Read: Anytime. Write: Anytime.
The Port Q Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port Q Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1.

Table 3-21. PPSP Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 0$ | Polarity Select Port Q |
| PPSQ[6:0] | A pull-up device is connected to the associated port Q pin. <br> 1 A pull-down device is connected to the associated port Q pin. |

### 3.3.5 Port S

Port S is associated with the serial peripheral interface (SPI) and serial communication interfaces (SCI0 and SCI1). Each pin is assigned to these modules according to the following priority: SPI/SCI1/SCI0 > general-purpose I/O.

When the SPI is enabled, the PS[7:4] pins become $\overline{\text { SS }}, \mathrm{SCK}, \mathrm{MOSI}$, and MISO respectively. Refer to the SPI block description chapter for information on enabling and disabling the SPI.
When the SCI1 receiver and transmitter are enabled, the PS[3:2] pins become TXD1 and RXD1 respectively. When the SCI0 receiver and transmitter are enabled, the PS[1:0] pins become TXD0 and RXD0 respectively. Refer to the SCI block description chapter for information on enabling and disabling the SCI receiver and transmitter.

During reset, port S pins are configured as high-impedance inputs.

### 3.3.5.1 Port S I/O Register (PTS)



Figure 3-29. Port S I/O Register (PTS)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRSx) is set to 1 (output), a read returns the value of the I/O register bit. If the associated data direction bit (DDRSx) is set to 0 (input), a read returns the value of the pin.

### 3.3.5.2 Port S Input Register (PTIS)



Figure 3-30. Port S Input Register (PTIS)
Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.5.3 Port S Data Direction Register (DDRS)



Figure 3-31. Port S Data Direction Register (DDRS)
Read: Anytime. Write: Anytime.
This register configures port pins $\operatorname{PS}[7: 4]$ and $\operatorname{PS}[2: 0]$ as either input or output.
When the SPI is enabled, the PS[7:4] pins become the SPI bidirectional pins. The associated Data Direction Register bits have no effect.

When the SCI1 transmitter is enabled, the PS[3] pin becomes the TXD1 output pin and the associated Data Direction Register bit has no effect. When the SCI1 receiver is enabled, the PS[2] pin becomes the RXD1 input pin and the associated Data Direction Register bit has no effect.

When the SCI0 transmitter is enabled, the PS[1] pin becomes the TXD0 output pin and the associated Data Direction Register bit has no effect. When the SCI0 receiver is enabled, the PS[0] pin becomes the RXD0 input pin and the associated Data Direction Register bit has no effect.

If the SPI, SCI1 and SCI0 functions are disabled, the corresponding Data Direction Register bit reverts to control the I/O direction of the associated pin.

Table 3-22. DDRS Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Data Direction Port S |  |
| DDRS[7:0] | 0 Associated pin is configured as input. <br> 1 |  |

### 3.3.5.4 Port S Reduced Drive Register (RDRS)



Figure 3-32. Port S Reduced Drive Register (RDRS)
Read: Anytime. Write: Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-23. RDRS Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Reduced Drive Port S |
| RDRS[7:0] | 0 <br> 1 <br> 1 Full drive strength at output. |

### 3.3.5.5 Port S Pull Device Enable Register (PERS)



Figure 3-33. Port S Pull Device Enable Register (PERS)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input or wired-or (open drain) output pins. If a pin is configured as push-pull output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-24. PERS Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Pull Device Enable Port S |  |
| PERS[7:0] | Pull-up or pull-down device is disabled. <br> 1 |  |
|  | Pull-up or pull-down device is enabled. |  |

### 3.3.5.6 Port S Polarity Select Register (PPSS)



Figure 3-34. Port S Polarity Select Register (PPSS)
Read: Anytime. Write: Anytime.
The Port S Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port S Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1.

Table 3-25. PPSS Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Pull Select Port S |
| PPSS[7:0] | A pull-up device is connected to the associated port S pin. <br> 1 A pull-down device is connected to the associated port S pin. |

### 3.3.5.7 Port S Wired-OR Mode Register (WOMS)



Figure 3-35. Port S Wired-OR Mode Register (WOMS)
Read: Anytime. Write: Anytime.
This register selects whether a port S output is configured as push-pull or wired-or. When a Wired-OR Mode Register bit is set to 1 , the corresponding output pin is driven active low only (open drain) and a high level is not driven. A Wired-OR Mode Register bit has no effect if the corresponding pin is configured as an input.

Table 3-26. WOMS Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Wired-OR Mode Port S |
| WOMS[7:0] | O Output buffers operate as push-pull outputs. <br> 1 <br> OUtput buffers operate as open-drain outputs. |

### 3.3.6 Port T

Port T is associated with two 4-channel timers (TIM0 and TIM1). Each pin is assigned to these modules according to the following priority: TIM1/TIM0 $>$ general-purpose I/O.

If the timer TIM0 is enabled, the channels configured for output compare are available on port T pins PT[3:0]. If the timer TIM1 is enabled, the channels configured for output compare are available on port T pins PT[7:4].
Refer to the TIM block description chapter for information on enabling and disabling the TIM module.
During reset, port T pins are configured as high-impedance inputs.

### 3.3.6.1 Port T I/O Register (PTT)

| 7 |  | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W | PTT7 | PTT6 | PTT5 | PTT4 | PTT3 | PTT2 | PTT1 | PTTO |
| TIM: | OC17 | OC16 | OC15 | OC14 | OC07 | OC06 | OC05 | OCO4 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 3-36. Port T I/O Register (PTT)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRTx) is set to 1 (output), a read returns the value of the I/O register bit. If the associated data direction bit (DDRTx) is set to 0 (input), a read returns the value of the pin.

### 3.3.6.2 Port T Input Register (PTIT)



Figure 3-37. Port T Input Register (PTIT)
Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.6.3 Port T Data Direction Register (DDRT)



Figure 3-38. Port T Data Direction Register (DDRT)
Read: Anytime. Write: Anytime.
This register configures port pins $\mathrm{PT}[7: 0]$ as either input or output.
If the TIM0(1) module is enabled, each port pin configured for output compare is forced to be an output and the associated Data Direction Register bit has no effect. If the associated timer output compare is disabled, the corresponding DDRTx bit reverts to control the I/O direction of the associated pin.

If the TIM0(1) module is enabled, each port pin configured as an input capture has the corresponding DDRTx bit controlling the I/O direction of the associated pin.

Table 3-27. DDRT Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Data Direction Port T |  |
| DDRT[7:0] | Associated pin is configured as input. <br> 1 |  |

### 3.3.6.4 Port T Reduced Drive Register (RDRT)



Figure 3-39. Port T Reduced Drive Register (RDRT)
Read: Anytime. Write: Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-28. RDRT Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Reduced Drive Port T |
| RDRT[7:0] | $\begin{array}{l}0 \\ 0 \\ 1\end{array}$ Associated drive strength at output. |$]$| Asives at about $1 / 3$ of the full drive strength. |
| :--- |

### 3.3.6.5 Port T Pull Device Enable Register (PERT)



Figure 3-40. Port T Pull Device Enable Register (PERT)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input pins. If a pin is configured as output, the corresponding Pull Device Enable Register bit has no effect.

Table 3-29. PERT Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Pull Device Enable Port T |  |
| PERT[7:0] | Pull-up or pull-down device is disabled. |  |
| 1 | Pull-up or pull-down device is enabled. |  |

### 3.3.6.6 Port T Polarity Select Register (PPST)



Figure 3-41. Port T Polarity Select Register (PPST)
Read: Anytime. Write: Anytime.
The Port T Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port T Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1.

Table 3-30. PPST Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Pull Select Port T |
| PPST[7:0] | A pull-up device is connected to the associated port T pin. <br> 1 <br> A pull-down device is connected to the associated port T pin. |

### 3.3.7 Port U

Port U is associated with one 4-channel timer (TIM2) and the pulse width modulator (PWM) module. Each pin is assigned to these modules according to the following priority: TIM2/PWM > general-purpose I/O.
If the timer TIM2 is enabled, the channels configured for output compare are available on port $U$ pins PU[3:0]. Refer to the TIM block description chapter for information on enabling and disabling the TIM module.

When a PWM channel is enabled, the corresponding pin becomes a PWM output. Refer to the PWM block description chapter for information on enabling and disabling the PWM channels.

If both PWM and TIM2 are enabled simultaneously, the pin functionality is determined by the configuration of the MODRR bits

During reset, port U pins are configured as high-impedance inputs.

### 3.3.7.1 Port U I/O Register (PTU)

|  | 7 | 6 | 5 4 |  | 3 2 |  | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W | PTU7 | PTU6 | PTU5 | PTU4 | PTU3 | PTU2 | PTU1 | PTU0 |
| PWM: |  |  | PW15 | PW14 | PW13 | PW12 | PW11 | PW10 |
| TIM2: |  |  |  |  | OC27 | OC26 | OC25 | OC24 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 3-42. Port U I/O Register (PTU)
Read: Anytime. Write: Anytime.
If the associated data direction bit (DDRUx) is set to 1 (output), a read returns the value of the I/O register bit. If the associated data direction bit (DDRUx) is set to 0 (input), a read returns the value of the pin.

### 3.3.7.2 Port U Input Register (PTIU)



Figure 3-43. Port U Input Register (PTIU)
Read: Anytime. Write: Never, writes to this register have no effect.
This register always reads back the status of the associated pins.

### 3.3.7.3 Port U Data Direction Register (DDRU)



Figure 3-44. Port U Data Direction Register (DDRU)
Read: Anytime. Write: Anytime.
This register configures port pins PU[7:0] as either input or output.
If a pulse width modulator channel is enabled, the associated pin is forced to be an output and the associated Data Direction Register bit has no effect. If the associated pulse width modulator channel is disabled, the corresponding DDRUx bit reverts to control the I/O direction of the associated pin.

If the TIM2 module is enabled, each port pin configured for output compare is forced to be an output and the associated Data Direction Register bit has no effect. If the associated timer output compare is disabled, the corresponding DDRUx bit reverts to control the I/O direction of the associated pin.
If the TIM2 module is enabled, each port pin configured as an input capture has the corresponding DDRUx bit controlling the I/O direction of the associated pin.

When both a timer function and a PWM function are enabled on the same pin, the MODRR register determines which function has control of the pin

Table 3-31. DDRT Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Data Direction Port U |  |
| DDRU[7:0] | 0 Associated pin is configured as input. <br> 1 Associated pin is configured as output. |  |

### 3.3.7.4 Port U Reduced Drive Register (RDRU)



Figure 3-45. Port U Reduced Drive Register (RDRU)
Read: Anytime. Write: Anytime.
This register configures the drive strength of configured output pins as either full or reduced. If a pin is configured as input, the corresponding Reduced Drive Register bit has no effect.

Table 3-32. RDRT Field Descriptions

| Field |  |
| :---: | :--- |
| $7: 0$ | Reduced Drive Port U |
| RDRU[7:0] | O Full drive strength at output. <br> 1 <br> Associated pin drives at about $1 / 3$ of the full drive strength. |

### 3.3.7.5 Port U Pull Device Enable Register (PERU)



Figure 3-46. Port T Pull Device Enable Register (PERT)
Read: Anytime. Write: Anytime.
This register configures whether a pull-up or a pull-down device is activated on configured input pins. If a pin is configured as output, the corresponding Pull Device Enable Register bit has no effect.

## Table 3-33. PERT Field Descriptions

| Field |  | Description |
| :---: | :--- | :--- |
| $7: 0$ | Pull Device Enable Port U |  |
| PERU[7:0] | 0 Pull-up or pull-down device is disabled. <br> 1 <br> 1 Pull-up or pull-down device is enabled. |  |

### 3.3.7.6 Port U Polarity Select Register (PPSU)



Figure 3-47. Port U Polarity Select Register (PPSU)
Read: Anytime. Write: Anytime.
The Port U Polarity Select Register selects whether a pull-down or a pull-up device is connected to the pin. The Port U Polarity Select Register is effective only when the corresponding Data Direction Register bit is set to 0 (input) and the corresponding Pull Device Enable Register bit is set to 1.

Table 3-34. PPST Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Pull Select Port U |
| PPSU[7:0] | A pull-up device is connected to the associated port T pin. <br> 1 A pull-down device is connected to the associated port T pin. |

### 3.3.7.7 Port U Module Routing Register (MODRR)



Figure 3-48. Port U Module Routing Register (MODRR)
Read: Anytime. Write: Anytime.
This register selects the module connected to port U .
Table 3-35. MODRR Field Descriptions

| Field |  |
| :---: | :--- |
| 3:0 | Pull Select Port U |
| MODRR[3:0] | If enabled, TIM2 channel is connected to the associated port $U$ pin. <br> 1 <br> 1 <br> If enabled, PWM channel is connected to the associated port $U$ pin. |

### 3.4 Functional Description

Each pin associated with ports $\mathrm{AD}, \mathrm{M}, \mathrm{P}, \mathrm{Q}, \mathrm{S}, \mathrm{T}$ and U can act as general-purpose $\mathrm{I} / \mathrm{O}$. In addition the pin can act as an output from a peripheral module or an input to a peripheral module.

A set of configuration registers is common to all ports. All registers can be written at any time, however a specific configuration might not become active.

Example: Selecting a pull-up resistor. This resistor does not become active while the port is used as a push-pull output.

### 3.4.1 I/O Register

The I/O Register holds the value driven out to the pin if the port is used as a general-purpose I/O. Writing to the I/O Register only has an effect on the pin if the port is used as general-purpose output.

When reading the I/O Register, the value of each pin is returned if the corresponding Data Direction Register bit is set to 0 (pin configured as input). If the data direction register bits is set to 1 , the content of the I/O Register bit is returned. This is independent of any other configuration (Figure 3-49).

Due to internal synchronization circuits, it can take up to 2 bus cycles until the correct value is read on the I/O Register when changing the data direction register.

### 3.4.2 Input Register

The Input Register is a read-only register and generally returns the value of the pin (Figure 3-49). It can be used to detect overload or short circuit conditions.

Due to internal synchronization circuits, it can take up to 2 bus cycles until the correct value is read on the Input Register when changing the Data Direction Register.

### 3.4.3 Data Direction Register

The Data Direction Register defines whether the pin is used as an input or an output. A Data Direction Register bit set to 0 configures the pin as an input. A Data Direction Register bit set to 0 configures the pin as an output. If a peripheral module controls the pin the contents of the data direction register is ignored (Figure 3-49).


Figure 3-49. Illustration of I/O Pin Functionality
Figure 3-50 shows the state of digital inputs and outputs when an analog module drives the port. When the analog module is enabled all associated digital output ports are disabled and all associated digital input ports read " 1 ".


Figure 3-50. Digital Ports and Analog Module

### 3.4.4 Reduced Drive Register

If the port is used as an output the Reduced Drive Register allows the configuration of the drive strength.

### 3.4.5 Pull Device Enable Register

The Pull Device Enable Register turns on a pull-up or pull-down device. The pull device becomes active only if the pin is used as an input or as a wired-or output.

### 3.4.6 Polarity Select Register

The Polarity Select Register selects either a pull-up or pull-down device if enabled. The pull device becomes active only if the pin is used as an input or as a wired-or output.

### 3.4.7 Pin Configuration Summary

The following table summarizes the effect of various configuration in the Data Direction (DDR), Input/Output (I/O), reduced drive (RDR), Pull Enable (PE), Pull Select (PS) and Interrupt Enable (IE) register bits. The PS configuration bit is used for two purposes:

1. Configure the sensitive interrupt edge (rising or falling), if interrupt is enabled.
2. Select either a pull-up or pull-down device if PE is set to " 1 ".

Table 3-36. Pin Configuration Summary

| DDR | IO | RDR | PE | PS | $\mathbf{I E ~}^{\mathbf{1}}$ | Function $^{2}$ | Pull Device | Interrupt |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | X | X | 0 | X | 0 | Input | Disabled | Disabled |
| 0 | X | X | 1 | 0 | 0 | Input | Pull Up | Disabled |
| 0 | X | X | 1 | 1 | 0 | Input | Pull Down | Disabled |
| 0 | X | X | 0 | 0 | 1 | Input | Disabled | Falling Edge |
| 0 | X | X | 0 | 1 | 1 | Input | Disabled | Rising Edge |
| 0 | X | X | 1 | 0 | 1 | Input | Pull Up | Falling Edge |
| 0 | X | X | 1 | 1 | 1 | Input | Pull Down | Rising Edge |
| 1 | 0 | 0 | X | X | 0 | Output to 0, Full Drive | Disabled | Disabled |
| 1 | 1 | 0 | X | X | 0 | Output to 1, Full Drive | Disabled | Disabled |
| 1 | 0 | 1 | X | X | 0 | Output to 0, Reduced Drive | Disabled | Disabled |
| 1 | 1 | 1 | X | X | 0 | Output to 1, Reduced Drive | Disabled | Disabled |
| 1 | 0 | 0 | X | 0 | 1 | Output to 0, Full Drive | Disabled | Falling Edge |
| 1 | 1 | 0 | X | 1 | 1 | Output to 1, Full Drive | Disabled | Rising Edge |
| 1 | 0 | 1 | X | 0 | 1 | Output to 0, Reduced Drive | Disabled | Falling Edge |
| 1 | 1 | 1 | X | 1 | 1 | Output to 1, Reduced Drive | Disabled | Rising Edge |

${ }^{1}$ Applicable only on Port AD.
${ }^{2}$ Digital outputs are disabled and digital input logic is forced to " 1 " when an analog module associated with the port is enabled.

### 3.5 Resets

The reset values of all registers are given in the register description in Section 3.3, "Memory Map and Register Definition".

All ports start up as general-purpose inputs on reset.

### 3.5.1 Reset Initialization

All registers including the data registers get set/reset asynchronously. Table 3-37 summarizes the port properties after reset initialization.

Table 3-37. Port Reset State Summary

| Port | Reset States |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | Data Direction | Pull Mode | Red. Drive | Wired-OR Mode | Interrupt |
| A | Refer to section Bus Control and Input/Output | Pull Up | Refer to section Bus Control and Input/Output |  |  |
| B |  |  |  |  |  |
| E |  |  |  |  |  |
| K |  |  |  |  |  |
| BKGD pin |  |  |  |  |  |
| AD | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | N/A | Disabled |
| M[7:4] | Input | Pull Up | Disabled | Disabled | N/A |
| M[3,1:0] | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | Disabled | N/A |
| P | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | N/A | N/A |
| Q | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | N/A | N/A |
| S | Input | Pull Up | Disabled | Disabled | N/A |
| T | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | N/A | N/A |
| U | Input | $\mathrm{Hi}-\mathrm{z}$ | Disabled | N/A | N/A |

### 3.6 Interrupts

### 3.6.1 General

Port AD generates an edge sensitive interrupt if enabled. It offers sixteen I/O pins with edge triggered interrupt capability in wired-or fashion. The interrupt enable as well as the sensitivity to rising or falling edges can be individually configured on per pin basis. All eight bits/pins share the same interrupt vector. Interrupts can be used with the pins configured as inputs (with the corresponding ATDDIEN1 bit set to 1 ) or outputs.

An interrupt is generated when a bit in the port interrupt flag register and its corresponding port interrupt enable bit are both set. This external interrupt feature is capable to wake up the CPU when it is in stop or wait mode.

A digital filter on each pin prevents pulses (Figure 3-52) shorter than a specified time from generating an interrupt. The minimum time varies over process conditions, temperature and voltage (Figure 3-51 and Table 3-38).

Glitch, filtered out, no interrupt flag set


Figure 3-51. Interrupt Glitch Filter on Port AD (PPS = 0)

Table 3-38. Pulse Detection Criteria

| Pulse | Mode |  |  |  |
| :---: | :---: | :---: | :---: | :---: |
|  | $\overline{\text { STOP }}$ |  | STOP $^{1}$ |  |
|  |  | Unit |  | Unit |
| Ignored | $t_{\text {pulse }}<=3$ | Bus Clock | $t_{\text {pulse }}<=3.2$ | $\mu \mathrm{~s}$ |
| Uncertain | $3<\mathrm{t}_{\text {pulse }}<4$ | Bus Clock | $3.2<\mathrm{t}_{\text {pulse }}<10$ | $\mu \mathrm{~s}$ |
| Valid | $\mathrm{t}_{\text {pulse }}>=4$ | Bus Clock | $\mathrm{t}_{\text {pulse }}>=10$ | $\mu \mathrm{~s}$ |

${ }^{1}$ These values include the spread of the oscillator frequency over temperature, voltage and process.


Figure 3-52. Pulse Illustration
A valid edge on an input is detected if 4 consecutive samples of a passive level are followed by 4 consecutive samples of an active level directly or indirectly

The filters are continuously clocked by the bus clock in RUN and WAIT mode. In STOP mode the clock is generated by a single RC oscillator in the port integration module. To maximize current saving the RC oscillator runs only if the following condition is true on any pin:

Sample count $<=4$ and port interrupt enabled (PIE=1) and port interrupt flag not set (PIF=0).

### 3.6.2 Interrupt Sources

Table 3-39. Port Integration Module Interrupt Sources

| Interrupt <br> Source | Interrupt <br> Flag | Local <br> Enable | Global (CCR) <br> Mask |
| :---: | :---: | :---: | :---: |
| Port AD | PIFAD[15:0] | PIEAD[15:0] | I Bit |

NOTE
Vector addresses and their relative interrupt priority are determined at the MCU level.

### 3.6.3 Operation in Stop Mode

All clocks are stopped in STOP mode. The port integration module has asynchronous paths on port AD to generate wake-up interrupts from stop mode. For other sources of external interrupts refer to the respective block description chapters.

## Chapter 4 <br> Clocks and Reset Generator (CRGV4)

### 4.1 Introduction

This specification describes the function of the clocks and reset generator (CRGV4).

### 4.1.1 Features

The main features of this block are:

- Phase-locked loop (PLL) frequency multiplier
- Reference divider
- Automatic bandwidth control mode for low-jitter operation
- Automatic frequency lock detector
- CPU interrupt on entry or exit from locked condition
- Self-clock mode in absence of reference clock
- System clock generator
- Clock quality check
- Clock switch for either oscillator- or PLL-based system clocks
- User selectable disabling of clocks during wait mode for reduced power consumption
- Computer operating properly (COP) watchdog timer with time-out clear window
- System reset generation from the following possible sources:
- Power-on reset
- Low voltage reset

Refer to the device overview section for availability of this feature.

- COP reset
- Loss of clock reset
- External pin reset
- Real-time interrupt (RTI)


### 4.1.2 Modes of Operation

This subsection lists and briefly describes all operating modes supported by the CRG.

- Run mode

All functional parts of the CRG are running during normal run mode. If RTI or COP functionality is required the individual bits of the associated rate select registers (COPCTL, RTICTL) have to be set to a nonzero value.

- Wait mode

This mode allows to disable the system and core clocks depending on the configuration of the individual bits in the CLKSEL register.

- Stop mode

Depending on the setting of the PSTP bit, stop mode can be differentiated between full stop mode $(\operatorname{PSTP}=0)$ and pseudo-stop mode $(\operatorname{PSTP}=1)$.

- Full stop mode

The oscillator is disabled and thus all system and core clocks are stopped. The COP and the RTI remain frozen.

- Pseudo-stop mode

The oscillator continues to run and most of the system and core clocks are stopped. If the respective enable bits are set the COP and RTI will continue to run, else they remain frozen.

- Self-clock mode

Self-clock mode will be entered if the clock monitor enable bit (CME) and the self-clock mode enable bit (SCME) are both asserted and the clock monitor in the oscillator block detects a loss of clock. As soon as self-clock mode is entered the CRGV4 starts to perform a clock quality check. Self-clock mode remains active until the clock quality check indicates that the required quality of the incoming clock signal is met (frequency and amplitude). Self-clock mode should be used for safety purposes only. It provides reduced functionality to the MCU in case a loss of clock is causing severe system conditions.

### 4.1.3 Block Diagram

Figure 4-1 shows a block diagram of the CRGV4.


Figure 4-1. CRG Block Diagram

### 4.2 External Signal Description

This section lists and describes the signals that connect off chip.

### 4.2.1 $\quad V_{\text {DDPLL }}, V_{\text {SSPLL }}$ — PLL Operating Voltage, PLL Ground

These pins provides operating voltage ( $\mathrm{V}_{\text {DDPLL }}$ ) and ground $\left(\mathrm{V}_{\text {SSPLL }}\right)$ for the PLL circuitry. This allows the supply voltage to the PLL to be independently bypassed. Even if PLL usage is not required $V_{\text {DDPLL }}$ and $V_{\text {SSPLL }}$ must be connected properly.

### 4.2.2 XFC — PLL Loop Filter Pin

A passive external loop filter must be placed on the XFC pin. The filter is a second-order, low-pass filter to eliminate the VCO input ripple. The value of the external filter network and the reference frequency determines the speed of the corrections and the stability of the PLL. Refer to the device overview chapter for calculation of PLL loop filter (XFC) components. If PLL usage is not required the XFC pin must be tied to $\mathrm{V}_{\text {DDPLL }}$.


Figure 4-2. PLL Loop Filter Connections

### 4.2.3 RESET - Reset Pin

$\overline{\mathrm{RESET}}$ is an active low bidirectional reset pin. As an input it initializes the MCU asynchronously to a known start-up state. As an open-drain output it indicates that an system reset (internal to MCU) has been triggered.

### 4.3 Memory Map and Register Definition

This section provides a detailed description of all registers accessible in the CRGV4.

### 4.3.1 Module Memory Map

Table 4-1 gives an overview on all CRGV4 registers.
Table 4-1. CRGV4 Memory Map

| Address <br> Offset | Use | Access |
| :---: | :--- | :---: |
| $0 \times 0000$ | CRG Synthesizer Register (SYNR) | R/W |
| $0 \times 0001$ | CRG Reference Divider Register (REFDV) | R/W |
| $0 \times 0002$ | CRG Test Flags Register (CTFLG) | R/W |
| $0 \times 0003$ | CRG Flags Register (CRGFLG) | R/W |
| $0 \times 0004$ | CRG Interrupt Enable Register (CRGINT) | R/W |
| $0 \times 0005$ | CRG Clock Select Register (CLKSEL) | R/W |
| $0 \times 0006$ | CRG PLL Control Register (PLLCTL) | R/W |
| $0 \times 0007$ | CRG RTI Control Register (RTICTL) | R/W |
| $0 \times 0008$ | CRG COP Control Register (COPCTL) | R/W |
| $0 x 0009$ | CRG Force and Bypass Test Register (FORBYP) |  |
| 0x000A | CRG Test Control Register (CTCTL) | R/W |
| $0 \times 000 B$ | CRG COP Arm/Timer Reset (ARMCOP) | R/W |

1 CTFLG is intended for factory test purposes only.
2 FORBYP is intended for factory test purposes only.
3 CTCTL is intended for factory test purposes only.

## NOTE

Register address $=$ base address + address offset, where the base address is defined at the MCU level and the address offset is defined at the module level.

### 4.3.2 Register Descriptions

This section describes in address order all the CRGV4 registers and their individual bits.

| Register Name |  | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SYNR | R | 0 | 0 | SYN5 | SYN4 | SYN3 | SYN2 | SYN1 | SYNO |
|  | W |  |  |  |  |  |  |  |  |
| REFDV | R | 0 | 0 | 0 | 0 | REFDV3 | REFDV2 | REFDV1 | REFDV0 |
|  | W |  |  |  |  |  |  |  |  |
| CTFLG | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| CRGFLG | R | RTIF | PORF | LVRF | LOCKIF | LOCK | TRACK | SCMIF | SCM |
|  | W |  |  |  |  |  |  |  |  |
| CRGINT | R | RTIE | 0 | 0 | LOCKIE | 0 | 0 | SCMIE | 0 |
|  | W |  |  |  |  |  |  |  |  |
| CLKSEL | R | PLLSEL | PSTP | SYSWAI | ROAWAI | PLLWAI | CWAI | RTIWAI | COPWAI |
|  | W |  |  |  |  |  |  |  |  |
| PLLCTL | R | CME | PLLON | AUTO | ACQ | 0 | PRE | PCE | SCME |
|  | W |  |  |  |  |  |  |  |  |
| RTICTL | R | 0 | RTR6 | RTR5 | RTR4 | RTR3 | RTR2 | RTR1 | RTR0 |
|  | W |  |  |  |  |  |  |  |  |
| COPCTL | R | WCOP | RSBCK | 0 | 0 | 0 | CR2 | CR1 | CRO |
|  | W |  |  |  |  |  |  |  |  |
| FORBYP | RW | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
| CTCTL | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
|  |  |  | = Unimplemented or Reserved |  |  |  |  |  |  |

Figure 4-3. CRG Register Summary

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| Register <br> Name | Bit 7 |  | $\mathbf{6}$ | $\mathbf{5}$ | $\mathbf{4}$ | $\mathbf{3}$ | $\mathbf{2}$ | $\mathbf{1}$ | Bit $\mathbf{0}$ |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| ARMCOP | R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  | W Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |  |

Figure 4-3. CRG Register Summary (continued)

### 4.3.2.1 CRG Synthesizer Register (SYNR)

The SYNR register controls the multiplication factor of the PLL. If the PLL is on, the count in the loop divider (SYNR) register effectively multiplies up the PLL clock (PLLCLK) from the reference frequency by $2 \times(S Y N R+1)$. PLLCLK will not be below the minimum VCO frequency ( $\mathrm{f}_{\mathrm{SCM}}$ ).

$$
\text { PLLCLK }=2 x \text { OSCCLKx } \frac{(\mathrm{SYNR}+1)}{(\mathrm{REFDV}+1)}
$$

NOTE
If PLL is selected (PLLSEL=1), Bus Clock = PLLCLK / 2
Bus Clock must not exceed the maximum operating system frequency.


Figure 4-4. CRG Synthesizer Register (SYNR)
Read: anytime
Write: anytime except if PLLSEL $=1$

## NOTE

Write to this register initializes the lock detector bit and the track detector bit.

### 4.3.2.2 CRG Reference Divider Register (REFDV)

The REFDV register provides a finer granularity for the PLL multiplier steps. The count in the reference divider divides OSCCLK frequency by REFDV +1 .


Figure 4-5. CRG Reference Divider Register (REFDV)
Read: anytime
Write: anytime except when PLLSEL $=1$
NOTE
Write to this register initializes the lock detector bit and the track detector bit.

### 4.3.2.3 Reserved Register (CTFLG)

This register is reserved for factory testing of the CRGV4 module and is not available in normal modes.


Figure 4-6. CRG Reserved Register (CTFLG)
Read: always reads $0 \times 0000$ in normal modes
Write: unimplemented in normal modes
NOTE
Writing to this register when in special mode can alter the CRGV4 functionality.

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### 4.3.2.4 CRG Flags Register (CRGFLG)

This register provides CRG status bits and flags.


1. PORF is set to 1 when a power-on reset occurs. Unaffected by system reset.
2. LVRF is set to 1 when a low-voltage reset occurs. Unaffected by system reset.


Figure 4-7. CRG Flag Register (CRGFLG)
Read: anytime
Write: refer to each bit for individual write conditions
Table 4-2. CRGFLG Field Descriptions

| Field | Description |
| :---: | :---: |
| 7 RTIF | Real-Time Interrupt Flag - RTIF is set to 1 at the end of the RTI period. This flag can only be cleared by writing a 1 . Writing a 0 has no effect. If enabled (RTIE $=1$ ), RTIF causes an interrupt request. <br> 0 RTI time-out has not yet occurred. <br> 1 RTI time-out has occurred. |
| $\begin{gathered} 6 \\ \text { PORF } \end{gathered}$ | Power-on Reset Flag — PORF is set to 1 when a power-on reset occurs. This flag can only be cleared by writing a 1. Writing a 0 has no effect. <br> 0 Power-on reset has not occurred. <br> 1 Power-on reset has occurred. |
| $\begin{gathered} 5 \\ \text { LVRF } \end{gathered}$ | Low-Voltage Reset Flag - If low voltage reset feature is not available (see the device overview chapter), LVRF always reads 0 . LVRF is set to 1 when a low voltage reset occurs. This flag can only be cleared by writing a 1. Writing a 0 has no effect. <br> 0 Low voltage reset has not occurred. <br> 1 Low voltage reset has occurred. |
| $\begin{gathered} 4 \\ \text { LOCKIF } \end{gathered}$ | PLL Lock Interrupt Flag - LOCKIF is set to 1 when LOCK status bit changes. This flag can only be cleared by writing a 1 . Writing a 0 has no effect.If enabled (LOCKIE $=1$ ), LOCKIF causes an interrupt request. <br> 0 No change in LOCK bit. <br> 1 LOCK bit has changed. |
| $\begin{gathered} 3 \\ \text { LOCK } \end{gathered}$ | Lock Status Bit — LOCK reflects the current state of PLL lock condition. This bit is cleared in self-clock mode. <br> Writes have no effect. <br> 0 PLL VCO is not within the desired tolerance of the target frequency. <br> 1 PLL VCO is within the desired tolerance of the target frequency. |
| $\begin{gathered} 2 \\ \text { TRACK } \end{gathered}$ | Track Status Bit — TRACK reflects the current state of PLL track condition. This bit is cleared in self-clock mode. <br> Writes have no effect. <br> 0 Acquisition mode status. <br> 1 Tracking mode status. |

Table 4-2. CRGFLG Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 1 |  |
| SCMIF | Self-Clock Mode Interrupt Flag - SCMIF is set to 1 when SCM status bit changes. This flag can only be <br> cleared by writing a 1. Writing a 0 has no effect. If enabled (SCMIE=1), SCMIF causes an interrupt request. <br> 0 |
| 1 No change in SCM bit. |  |

### 4.3.2.5 CRG Interrupt Enable Register (CRGINT)

This register enables CRG interrupt requests.


Figure 4-8. CRG Interrupt Enable Register (CRGINT)
Read: anytime
Write: anytime
Table 4-3. CRGINT Field Descriptions

| Field | Description |
| :---: | :---: |
| $7$ <br> RTIE | Real-Time Interrupt Enable Bit <br> 0 Interrupt requests from RTI are disabled. <br> 1 Interrupt will be requested whenever RTIF is set. |
| 4 LOCKIE | Lock Interrupt Enable Bit <br> 0 LOCK interrupt requests are disabled. <br> 1 Interrupt will be requested whenever LOCKIF is set. |
| 1 SCMIE | Self-Clock Mode Interrupt Enable Bit <br> 0 SCM interrupt requests are disabled. <br> 1 Interrupt will be requested whenever SCMIF is set. |

Chapter 4 Clocks and Reset Generator (CRGV4)

### 4.3.2.6 CRG Clock Select Register (CLKSEL)

This register controls CRG clock selection. Refer to Figure 4-17 for details on the effect of each bit.


Figure 4-9. CRG Clock Select Register (CLKSEL)
Read: anytime
Write: refer to each bit for individual write conditions
Table 4-4. CLKSEL Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { PLLSEL } \end{gathered}$ | PLL Select Bit - Write anytime. Writing a 1 when LOCK $=0$ and AUTO $=1$, or TRACK $=0$ and AUTO $=0$ has no effect. This prevents the selection of an unstable PLLCLK as SYSCLK. PLLSEL bit is cleared when the MCU enters self-clock mode, stop mode or wait mode with PLLWAI bit set. <br> 0 System clocks are derived from OSCCLK (Bus Clock = OSCCLK / 2). <br> 1 System clocks are derived from PLLCLK (Bus Clock = PLLCLK / 2). |
| $\begin{gathered} 6 \\ \text { PSTP } \end{gathered}$ | Pseudo-Stop Bit — Write: anytime - This bit controls the functionality of the oscillator during stop mode. <br> 0 Oscillator is disabled in stop mode. <br> 1 Oscillator continues to run in stop mode (pseudo-stop). The oscillator amplitude is reduced. Refer to oscillator block description for availability of a reduced oscillator amplitude. <br> Note: Pseudo-stop allows for faster stop recovery and reduces the mechanical stress and aging of the resonator in case of frequent stop conditions at the expense of a slightly increased power consumption. <br> Note: Lower oscillator amplitude exhibits lower power consumption but could have adverse effects during any electro-magnetic susceptibility (EMS) tests. |
| $\begin{gathered} 5 \\ \text { SYSWAI } \end{gathered}$ | System Clocks Stop in Wait Mode Bit - Write: anytime 0 In wait mode, the system clocks continue to run. 1 In wait mode, the system clocks stop. Note: RTI and COP are not affected by SYSWAI bit. |
| 4 <br> ROAWAI | Reduced Oscillator Amplitude in Wait Mode Bit - Write: anytime - Refer to oscillator block description chapter for availability of a reduced oscillator amplitude. If no such feature exists in the oscillator block then setting this bit to 1 will not have any effect on power consumption. <br> 0 Normal oscillator amplitude in wait mode. <br> 1 Reduced oscillator amplitude in wait mode. <br> Note: Lower oscillator amplitude exhibits lower power consumption but could have adverse effects during any electro-magnetic susceptibility (EMS) tests. |
| $\begin{gathered} 3 \\ \text { PLLWAI } \end{gathered}$ | PLL Stops in Wait Mode Bit - Write: anytime - If PLLWAI is set, the CRGV4 will clear the PLLSEL bit before entering wait mode. The PLLON bit remains set during wait mode but the PLL is powered down. Upon exiting wait mode, the PLLSEL bit has to be set manually if PLL clock is required. <br> While the PLLWAI bit is set the AUTO bit is set to 1 in order to allow the PLL to automatically lock on the selected target frequency after exiting wait mode. <br> 0 PLL keeps running in wait mode. <br> 1 PLL stops in wait mode. |
| $\stackrel{2}{\text { CWAI }}$ | Core Stops in Wait Mode Bit - Write: anytime <br> 0 Core clock keeps running in wait mode. <br> 1 Core clock stops in wait mode. |

Table 4-4. CLKSEL Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 1 | RTI Stops in Wait Mode Bit — Write: anytime <br> 0 |
| RTIWAI keeps running in wait mode. |  |
| 1 | RTI stops and initializes the RTI dividers whenever the part goes into wait mode. |

### 4.3.2.7 CRG PLL Control Register (PLLCTL)

This register controls the PLL functionality.


Figure 4-10. CRG PLL Control Register (PLLCTL)
Read: anytime
Write: refer to each bit for individual write conditions
Table 4-5. PLLCTL Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \mathrm{CME} \end{gathered}$ | Clock Monitor Enable Bit - CME enables the clock monitor. Write anytime except when SCM = 1 . <br> 0 Clock monitor is disabled. <br> 1 Clock monitor is enabled. Slow or stopped clocks will cause a clock monitor reset sequence or self-clock mode. <br> Note: Operating with $\mathrm{CME}=0$ will not detect any loss of clock. In case of poor clock quality this could cause unpredictable operation of the MCU. <br> Note: In Stop Mode (PSTP = 0) the clock monitor is disabled independently of the CME bit setting and any loss of clock will not be detected. |
| $\begin{gathered} 6 \\ \text { PLLON } \end{gathered}$ | Phase Lock Loop On Bit - PLLON turns on the PLL circuitry. In self-clock mode, the PLL is turned on, but the PLLON bit reads the last latched value. Write anytime except when PLLSEL = 1 . <br> 0 PLL is turned off. <br> 1 PLL is turned on. If AUTO bit is set, the PLL will lock automatically. |
| $\begin{gathered} 5 \\ \text { AUTO } \end{gathered}$ | Automatic Bandwidth Control Bit - AUTO selects either the high bandwidth (acquisition) mode or the low bandwidth (tracking) mode depending on how close to the desired frequency the VCO is running. Write anytime except when PLLWAI=1, because PLLWAI sets the AUTO bit to 1 . <br> 0 Automatic mode control is disabled and the PLL is under software control, using ACQ bit. <br> 1 Automatic mode control is enabled and ACQ bit has no effect. |
| $\begin{gathered} 4 \\ A C Q \end{gathered}$ | Acquisition Bit - Write anytime. If $A U T O=1$ this bit has no effect. 0 Low bandwidth filter is selected. <br> 1 High bandwidth filter is selected. |

Table 4-5. PLLCTL Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 2 |  |
| PRE | RTI Enable during Pseudo-Stop Bit - PRE enables the RTI during pseudo-stop mode. Write anytime. <br> 0 <br> 1 <br> RTI stops running during pseudo-stop mode. <br> Note: If the PRE bit is cleared the RTI dividers will go static while pseudo-stop mode is active. The RTI dividers <br> will not initialize like in wait mode with RTIWAI bit set. |
| 1 |  |
| PCE | COP Enable during Pseudo-Stop Bit - PCE enables the COP during pseudo-stop mode. Write anytime. <br> 0 <br> 1 <br> COP stops running during pseudo-stop mode <br> Note: If the PCE bit is cleared the COP dividers will go static while pseudo-stop mode is active. The COP dividers <br> will not initialize like in wait mode with COPWAI bit set. |
| 0 | Self-Clock Mode Enable Bit — Normal modes: Write once -Special modes: Write anytime - SCME can not <br> Se cleared while operating in self-clock mode (SCM=1). <br> 0 <br> Setection of crystal clock failure causes clock monitor reset (see Section 4.5.1, "Clock Monitor Reset"). <br> 1 |
| Detection of crystal clock failure forces the MCU in self-clock mode (see Section 4.4.7.2, "Self-Clock Mode"). |  |

### 4.3.2.8 CRG RTI Control Register (RTICTL)

This register selects the timeout period for the real-time interrupt.


Figure 4-11. CRG RTI Control Register (RTICTL)
Read: anytime
Write: anytime

## NOTE

A write to this register initializes the RTI counter.
Table 4-6. RTICTL Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 4$ |  |
| RTR[6:4] |  | Real-Time Interrupt Prescale Rate Select Bits - These bits select the prescale rate for the RTI. See Table 4-7. $\quad$| $3: 0$ | Real-Time Interrupt Modulus Counter Select Bits - These bits select the modulus counter target value to <br> RTR[3:0 <br> provide additional granularity. Table 4-7 shows all possible divide values selectable by the RTICTL register. The <br> source clock for the RTI is OSCCLK. |
| :---: | :--- |

Table 4-7. RTI Frequency Divide Rates

| RTR[3:0] | RTR[6:4] = |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\begin{gathered} 000 \\ (\text { OFF) } \end{gathered}$ | $\begin{gathered} 001 \\ \left(2^{10}\right) \end{gathered}$ | $\begin{gathered} 010 \\ \left(2^{11}\right) \end{gathered}$ | $\begin{gathered} 011 \\ \left(2^{12}\right) \end{gathered}$ | $\begin{aligned} & 100 \\ & \left(2^{13}\right) \end{aligned}$ | $\begin{gathered} 101 \\ \left(2^{14}\right) \end{gathered}$ | $\begin{aligned} & 110 \\ & \left(2^{15}\right) \end{aligned}$ | $\begin{aligned} & 111 \\ & \left(2^{16}\right) \end{aligned}$ |
| 0000 ( $\div 1$ ) | OFF* | $2^{10}$ | $2^{11}$ | $2^{12}$ | $2^{13}$ | $2^{14}$ | $2^{15}$ | $2^{16}$ |
| 0001 ( $\div 2$ ) | OFF* | $2 \times 2{ }^{10}$ | $2 \times 2{ }^{11}$ | $2 \times 2{ }^{12}$ | $2 \times 2{ }^{13}$ | $2 \times 2{ }^{14}$ | $2 \times 2^{15}$ | $2 \times 2{ }^{16}$ |
| 0010 ( $\div 3$ ) | OFF* | $3 \times 2{ }^{10}$ | $3 \times 2{ }^{11}$ | $3 \times 2{ }^{12}$ | $3 \times 2{ }^{13}$ | $3 \times 2{ }^{14}$ | $3 \times 2{ }^{15}$ | $3 \times 2{ }^{16}$ |
| 0011 ( $\div 4)$ | OFF* | $4 \times 2{ }^{10}$ | $4 \times 2{ }^{11}$ | $4 \times 2{ }^{12}$ | $4 \times 2{ }^{13}$ | $4 \times 2{ }^{14}$ | $4 \times 2^{15}$ | $4 \times 2{ }^{16}$ |
| $0100(\div 5)$ | OFF* | $5 \times 2{ }^{10}$ | $5 \times 2{ }^{11}$ | $5 \times 2{ }^{12}$ | $5 \times 2{ }^{13}$ | $5 \times 2{ }^{14}$ | $5 \times 2^{15}$ | $5 \times 2{ }^{16}$ |
| 0101 ( $\div 6$ ) | OFF* | $6 \times 2^{10}$ | $6 \times 2{ }^{11}$ | $6 \times 2{ }^{12}$ | $6 \times 2^{13}$ | $6 \times 2^{14}$ | $6 \times 2^{15}$ | $6 \times 2{ }^{16}$ |
| 0110 ( $\div 7$ ) | OFF* | $7 \times 2^{10}$ | $7 \times 2{ }^{11}$ | $7 \times 2^{12}$ | $7 \times 2^{13}$ | $7 \times 2^{14}$ | $7 \times 2^{15}$ | $7 \times 2^{16}$ |
| 0111 ( $\div 8$ ) | OFF* | $8 \times 2^{10}$ | $8 \times 2{ }^{11}$ | $8 \times 2{ }^{12}$ | $8 \times 2^{13}$ | $8 \times 2^{14}$ | $8 \times 2^{15}$ | $8 \times 2^{16}$ |
| 1000 ( $\div 9$ ) | OFF* | $9 \times 2{ }^{10}$ | $9 \times 2{ }^{11}$ | $9 \times 2{ }^{12}$ | $9 \times 2{ }^{13}$ | $9 \times 2{ }^{14}$ | $9 \times 2{ }^{15}$ | $9 \times 2{ }^{16}$ |
| $1001(\div 10)$ | OFF* | $10 \times 2{ }^{10}$ | $10 \times 2{ }^{11}$ | $10 \times 2{ }^{12}$ | $10 \times 2^{13}$ | $10 \times 2{ }^{14}$ | $10 \times 2{ }^{15}$ | $10 \times 2{ }^{16}$ |
| 1010 ( $\div 11$ ) | OFF* | $11 \times 2{ }^{10}$ | $11 \times 2{ }^{11}$ | $11 \times 2{ }^{12}$ | $11 \times 2^{13}$ | $11 \times 2^{14}$ | $11 \times 2^{15}$ | $11 \times 2^{16}$ |
| $1011(\div 12)$ | OFF* | $12 \times 2{ }^{10}$ | $12 \times 2{ }^{11}$ | $12 \times 2{ }^{12}$ | $12 \times 2^{13}$ | $12 \times 2{ }^{14}$ | $12 \times 2{ }^{15}$ | $12 \times 2{ }^{16}$ |
| $1100(\div 13)$ | OFF* | $13 \times 2{ }^{10}$ | $13 \times 2{ }^{11}$ | $13 \times 2{ }^{12}$ | $13 \times 2{ }^{13}$ | $13 \times 2{ }^{14}$ | $13 \times 2{ }^{15}$ | $13 \times 2{ }^{16}$ |
| $1101(\div 14)$ | OFF* | $14 \times 2{ }^{10}$ | $14 \times 2{ }^{11}$ | $14 \times 2{ }^{12}$ | $14 \times 2{ }^{13}$ | $14 \times 2{ }^{14}$ | $14 \times 2{ }^{15}$ | $14 \times 2{ }^{16}$ |
| $1110(\div 15)$ | OFF* | $15 \times 2{ }^{10}$ | $15 \times 2{ }^{11}$ | $15 \times 2{ }^{12}$ | $15 \times 2{ }^{13}$ | $15 \times 2{ }^{14}$ | $15 \times 2{ }^{15}$ | $15 \times 2{ }^{16}$ |
| 1111 ( $\div 16$ ) | OFF* | $16 \times 2{ }^{10}$ | $16 \times 2{ }^{11}$ | $16 \times 2{ }^{12}$ | $16 \times 2^{13}$ | $16 \times 2^{14}$ | $16 \times 2^{15}$ | $16 \times 2^{16}$ |

* Denotes the default value out of reset.This value should be used to disable the RTI to ensure future backwards compatibility.


### 4.3.2.9 CRG COP Control Register (COPCTL)

This register controls the COP (computer operating properly) watchdog.


Figure 4-12. CRG COP Control Register (COPCTL)
Read: anytime
Write: WCOP, CR2, CR1, CR0: once in user mode, anytime in special mode
Write: RSBCK: once
Table 4-8. COPCTL Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 | Window COP Mode Bit — When set, a write to the ARMCOP register must occur in the last 25\% of the selected <br> period. A write during the first $75 \%$ of the selected period will reset the part. As long as all writes occur during <br> this window, 0x0055 can be written as often as desired. As soon as 0x00AA is written after the 0x0055, the <br> time-out logic restarts and the user must wait until the next window before writing to ARMCOP. Table 4-9 shows <br> the exact duration of this window for the seven available COP rates. <br> 0 Normal COP operation <br> 1 |
| 6 | COP and RTI Stop in Active BDM Mode Bit <br> 0 <br> COP Allows the COP and RTI to keep running in active BDM mode. <br> 1 <br> Stops the COP and RTI counters whenever the part is in active BDM mode. |
| RSBCK |  |
| CR[2:0] | COP Watchdog Timer Rate Select - These bits select the COP time-out rate (see Table 4-9). The COP <br> time-out period is OSCCLK period divided by CR[2:0] value. Writing a nonzero value to CR[2:0] enables the COP <br> counter and starts the time-out period. A COP counter time-out causes a system reset. This can be avoided by <br> periodically (before time-out) reinitializing the COP counter via the ARMCOP register. |

Table 4-9. COP Watchdog Rates ${ }^{1}$

| CR2 | CR1 | CR0 | OSCCLK <br> Cycles to Time Out |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | COP disabled |
| 0 | 0 | 1 | $2^{14}$ |
| 0 | 1 | 0 | $2^{16}$ |
| 0 | 1 | 1 | $2^{18}$ |
| 1 | 0 | 0 | $2^{20}$ |
| 1 | 0 | 1 | $2^{22}$ |
| 1 | 1 | 0 | $2^{23}$ |
| 1 | 1 | 1 | $2^{24}$ |

1 OSCCLK cycles are referenced from the previous COP time-out reset (writing 0x0055/0x00AA to the ARMCOP register)

### 4.3.2.10 Reserved Register (FORBYP)

## NOTE

This reserved register is designed for factory test purposes only, and is not intended for general user access. Writing to this register when in special modes can alter the CRG's functionality.


Figure 4-13. Reserved Register (FORBYP)
Read: always read $0 x 0000$ except in special modes
Write: only in special modes

### 4.3.2.11 Reserved Register (CTCTL)

## NOTE

This reserved register is designed for factory test purposes only, and is not intended for general user access. Writing to this register when in special test modes can alter the CRG's functionality.


Figure 4-14. Reserved Register (CTCTL)

Read: always read 0x0080 except in special modes
Write: only in special modes

### 4.3.2.12 CRG COP Timer Arm/Reset Register (ARMCOP)

This register is used to restart the COP time-out period.

| 7 |  | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 4-15. ARMCOP Register Diagram
Read: always reads $0 x 0000$
Write: anytime
When the COP is disabled $(\mathrm{CR}[2: 0]=$ " 000 ") writing to this register has no effect.
When the COP is enabled by setting CR[2:0] nonzero, the following applies:
Writing any value other than $0 \times 0055$ or 0x00AA causes a COP reset. To restart the COP time-out period you must write $0 x 0055$ followed by a write of $0 x 00 \mathrm{AA}$. Other instructions may be executed between these writes but the sequence ( $0 \times 0055,0 \times 00 \mathrm{AA}$ ) must be completed prior to COP end of time-out period to avoid a COP reset. Sequences of $0 x 0055$ writes or sequences of $0 x 00 \mathrm{AA}$ writes are allowed. When the WCOP bit is set, $0 x 0055$ and $0 x 00 \mathrm{AA}$ writes must be done in the last $25 \%$ of the selected time-out period; writing any value in the first $75 \%$ of the selected period will cause a COP reset.

### 4.4 Functional Description

This section gives detailed informations on the internal operation of the design.

### 4.4.1 Phase Locked Loop (PLL)

The PLL is used to run the MCU from a different time base than the incoming OSCCLK. For increased flexibility, OSCCLK can be divided in a range of 1 to 16 to generate the reference frequency. This offers a finer multiplication granularity. The PLL can multiply this reference clock by a multiple of $2,4,6, \ldots$ 126,128 based on the SYNR register.

$$
\text { PLLCLK }=2 \times \text { OSCCLK } \times \frac{[\text { SYNR }+1]}{[\operatorname{REFDV}+1]}
$$

## CAUTION

Although it is possible to set the two dividers to command a very high clock frequency, do not exceed the specified bus frequency limit for the MCU.
If $($ PLLSEL $=1)$, Bus Clock $=$ PLLCLK $/ 2$
The PLL is a frequency generator that operates in either acquisition mode or tracking mode, depending on the difference between the output frequency and the target frequency. The PLL can change between acquisition and tracking modes either automatically or manually.

The VCO has a minimum operating frequency, which corresponds to the self-clock mode frequency $f_{\text {SCM }}$.


Figure 4-16. PLL Functional Diagram

### 4.4.1.1 PLL Operation

The oscillator output clock signal (OSCCLK) is fed through the reference programmable divider and is divided in a range of 1 to 16 (REFDV+1) to output the reference clock. The VCO output clock, (PLLCLK) is fed back through the programmable loop divider and is divided in a range of 2 to 128 in increments of [2 x (SYNR +1)] to output the feedback clock. See Figure 4-16.

The phase detector then compares the feedback clock, with the reference clock. Correction pulses are generated based on the phase difference between the two signals. The loop filter then slightly alters the DC voltage on the external filter capacitor connected to XFC pin, based on the width and direction of the correction pulse. The filter can make fast or slow corrections depending on its mode, as described in the next subsection. The values of the external filter network and the reference frequency determine the speed of the corrections and the stability of the PLL.

### 4.4.1.2 Acquisition and Tracking Modes

The lock detector compares the frequencies of the feedback clock, and the reference clock. Therefore, the speed of the lock detector is directly proportional to the final reference frequency. The circuit determines the mode of the PLL and the lock condition based on this comparison.

The PLL filter can be manually or automatically configured into one of two possible operating modes:

- Acquisition mode

In acquisition mode, the filter can make large frequency corrections to the VCO. This mode is used at PLL start-up or when the PLL has suffered a severe noise hit and the VCO frequency is far off the desired frequency. When in acquisition mode, the TRACK status bit is cleared in the CRGFLG register.

- Tracking mode

In tracking mode, the filter makes only small corrections to the frequency of the VCO. PLL jitter is much lower in tracking mode, but the response to noise is also slower. The PLL enters tracking mode when the VCO frequency is nearly correct and the TRACK bit is set in the CRGFLG register.

The PLL can change the bandwidth or operational mode of the loop filter manually or automatically.
In automatic bandwidth control mode ( $\mathrm{AUTO}=1$ ), the lock detector automatically switches between acquisition and tracking modes. Automatic bandwidth control mode also is used to determine when the PLL clock (PLLCLK) is safe to use as the source for the system and core clocks. If PLL LOCK interrupt requests are enabled, the software can wait for an interrupt request and then check the LOCK bit. If CPU interrupts are disabled, software can poll the LOCK bit continuously (during PLL start-up, usually) or at periodic intervals. In either case, only when the LOCK bit is set, is the PLLCLK clock safe to use as the source for the system and core clocks. If the PLL is selected as the source for the system and core clocks and the LOCK bit is clear, the PLL has suffered a severe noise hit and the software must take appropriate action, depending on the application.

The following conditions apply when the PLL is in automatic bandwidth control mode (AUTO =1):

- The TRACK bit is a read-only indicator of the mode of the filter.
- The TRACK bit is set when the VCO frequency is within a certain tolerance, $\Delta_{\text {trk }}$, and is clear when the VCO frequency is out of a certain tolerance, $\Delta_{\text {unt }}$.
- The LOCK bit is a read-only indicator of the locked state of the PLL.
- The LOCK bit is set when the VCO frequency is within a certain tolerance, $\Delta_{\text {Lock }}$, and is cleared when the VCO frequency is out of a certain tolerance, $\Delta_{\mathrm{unl}}$ -
- CPU interrupts can occur if enabled (LOCKIE =1) when the lock condition changes, toggling the LOCK bit.

The PLL can also operate in manual mode (AUTO = 0 ). Manual mode is used by systems that do not require an indicator of the lock condition for proper operation. Such systems typically operate well below the maximum system frequency $\left(\mathrm{f}_{\text {sys }}\right)$ and require fast start-up. The following conditions apply when in manual mode:

- ACQ is a writable control bit that controls the mode of the filter. Before turning on the PLL in manual mode, the ACQ bit should be asserted to configure the filter in acquisition mode.
- After turning on the PLL by setting the PLLON bit software must wait a given time $\left(\mathrm{t}_{\text {acq }}\right)$ before entering tracking mode $(\mathrm{ACQ}=0)$.
- After entering tracking mode software must wait a given time ( $\mathrm{t}_{\mathrm{a}}$ ) before selecting the PLLCLK as the source for system and core clocks (PLLSEL $=1$ ).


### 4.4.2 System Clocks Generator



Figure 4-17. System Clocks Generator
The clock generator creates the clocks used in the MCU (see Figure 4-17). The gating condition placed on top of the individual clock gates indicates the dependencies of different modes (stop, wait) and the setting of the respective configuration bits.

The peripheral modules use the bus clock. Some peripheral modules also use the oscillator clock. The memory blocks use the bus clock. If the MCU enters self-clock mode (see Section 4.4.7.2, "Self-Clock Mode"), oscillator clock source is switched to PLLCLK running at its minimum frequency $\mathrm{f}_{\mathrm{SCM}}$. The bus clock is used to generate the clock visible at the ECLK pin. The core clock signal is the clock for the CPU. The core clock is twice the bus clock as shown in Figure 4-18. But note that a CPU cycle corresponds to one bus clock.

PLL clock mode is selected with PLLSEL bit in the CLKSEL register. When selected, the PLL output clock drives SYSCLK for the main system including the CPU and peripherals. The PLL cannot be turned off by clearing the PLLON bit, if the PLL clock is selected. When PLLSEL is changed, it takes a maximum
of 4 OSCCLK plus 4 PLLCLK cycles to make the transition. During the transition, all clocks freeze and CPU activity ceases.

```
CORE CLOCK:
```



Figure 4-18. Core Clock and Bus Clock Relationship

### 4.4.3 Clock Monitor (CM)

If no OSCCLK edges are detected within a certain time, the clock monitor within the oscillator block generates a clock monitor fail event. The CRGV4 then asserts self-clock mode or generates a system reset depending on the state of SCME bit. If the clock monitor is disabled or the presence of clocks is detected no failure is indicated by the oscillator block. The clock monitor function is enabled/disabled by the CME control bit.

### 4.4.4 Clock Quality Checker

The clock monitor performs a coarse check on the incoming clock signal. The clock quality checker provides a more accurate check in addition to the clock monitor.

A clock quality check is triggered by any of the following events:

- Power-on reset (POR)
- Low voltage reset (LVR)
- Wake-up from full stop mode (exit full stop)
- Clock monitor fail indication (CM fail)

A time window of 50000 VCO clock cycles ${ }^{1}$ is called check window.
A number greater equal than 4096 rising OSCCLK edges within a check window is called osc ok. Note that osc ok immediately terminates the current check window. See Figure 4-19 as an example.

[^1]

Figure 4-19. Check Window Example
The sequence for clock quality check is shown in Figure 4-20.


Figure 4-20. Sequence for Clock Quality Check

## NOTE

Remember that in parallel to additional actions caused by self-clock mode or clock monitor reset ${ }^{1}$ handling the clock quality checker continues to check the OSCCLK signal.

[^2]
## NOTE

The clock quality checker enables the PLL and the voltage regulator (VREG) anytime a clock check has to be performed. An ongoing clock quality check could also cause a running PLL ( $\mathrm{f}_{\mathrm{SCM}}$ ) and an active VREG during pseudo-stop mode or wait mode

### 4.4.5 Computer Operating Properly Watchdog (COP)



Figure 4-21. Clock Chain for COP
The COP (free running watchdog timer) enables the user to check that a program is running and sequencing properly. The COP is disabled out of reset. When the COP is being used, software is responsible for keeping the COP from timing out. If the COP times out it is an indication that the software is no longer being executed in the intended sequence; thus a system reset is initiated (see Section 4.5.2, "Computer Operating Properly Watchdog (COP) Reset)." The COP runs with a gated OSCCLK (see Section Figure 4-21., "Clock Chain for COP"). Three control bits in the COPCTL register allow selection of seven COP time-out periods.

When COP is enabled, the program must write 0x0055 and 0x00AA (in this order) to the ARMCOP register during the selected time-out period. As soon as this is done, the COP time-out period is restarted. If the program fails to do this and the COP times out, the part will reset. Also, if any value other than $0 x 0055$ or 0 x 00 AA is written, the part is immediately reset.

Windowed COP operation is enabled by setting WCOP in the COPCTL register. In this mode, writes to the ARMCOP register to clear the COP timer must occur in the last $25 \%$ of the selected time-out period. A premature write will immediately reset the part.

If PCE bit is set, the COP will continue to run in pseudo-stop mode.

### 4.4.6 Real-Time Interrupt (RTI)

The RTI can be used to generate a hardware interrupt at a fixed periodic rate. If enabled (by setting RTIE=1), this interrupt will occur at the rate selected by the RTICTL register. The RTI runs with a gated OSCCLK (see Section Figure 4-22., "Clock Chain for RTI"). At the end of the RTI time-out period the RTIF flag is set to 1 and a new RTI time-out period starts immediately.

A write to the RTICTL register restarts the RTI time-out period.
If the PRE bit is set, the RTI will continue to run in pseudo-stop mode.


Figure 4-22. Clock Chain for RTI

### 4.4.7 Modes of Operation

### 4.4.7.1 Normal Mode

The CRGV4 block behaves as described within this specification in all normal modes.

### 4.4.7.2 Self-Clock Mode

The VCO has a minimum operating frequency, $\mathrm{f}_{\mathrm{SCM}}$. If the external clock frequency is not available due to a failure or due to long crystal start-up time, the bus clock and the core clock are derived from the VCO
running at minimum operating frequency; this mode of operation is called self-clock mode. This requires $\mathrm{CME}=1$ and $\mathrm{SCME}=1$. If the MCU was clocked by the PLL clock prior to entering self-clock mode, the PLLSEL bit will be cleared. If the external clock signal has stabilized again, the CRG will automatically select OSCCLK to be the system clock and return to normal mode. See Section 4.4.4, "Clock Quality Checker" for more information on entering and leaving self-clock mode.

NOTE
In order to detect a potential clock loss, the CME bit should be always enabled ( $\mathrm{CME}=1$ ).

If CME bit is disabled and the MCU is configured to run on PLL clock (PLLCLK), a loss of external clock (OSCCLK) will not be detected and will cause the system clock to drift towards the VCO's minimum frequency $\mathrm{f}_{\mathrm{SCM}}$. As soon as the external clock is available again the system clock ramps up to its PLL target frequency. If the MCU is running on external clock any loss of clock will cause the system to go static.

### 4.4.8 Low-Power Operation in Run Mode

The RTI can be stopped by setting the associated rate select bits to 0 .
The COP can be stopped by setting the associated rate select bits to 0 .

### 4.4.9 Low-Power Operation in Wait Mode

The WAI instruction puts the MCU in a low power consumption stand-by mode depending on setting of the individual bits in the CLKSEL register. All individual wait mode configuration bits can be superposed. This provides enhanced granularity in reducing the level of power consumption during wait mode.
Table 4-10 lists the individual configuration bits and the parts of the MCU that are affected in wait mode.
Table 4-10. MCU Configuration During Wait Mode

|  | PLLWAI | CWAI | SYSWAI | RTIWAI | COPWAI | ROAWAI |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PLL | stopped | - | - | - | - | - |
| Core | - | stopped | stopped | - | - | - |
| System | - | - | stopped | - | - | - |
| RTI | - | - | - | stopped | - | - |
| COP | - | - | - | - | stopped | - |
| Oscillator | - | - | - | - | - | reduced $^{1}$ |

1 Refer to oscillator block description for availability of a reduced oscillator amplitude.
After executing the WAI instruction the core requests the CRG to switch MCU into wait mode. The CRG then checks whether the PLLWAI, CWAI and SYSWAI bits are asserted (see Figure 4-23). Depending on the configuration the CRG switches the system and core clocks to OSCCLK by clearing the PLLSEL bit, disables the PLL, disables the core clocks and finally disables the remaining system clocks. As soon as all clocks are switched off wait mode is active.


Figure 4-23. Wait Mode Entry/Exit Sequence

There are five different scenarios for the CRG to restart the MCU from wait mode:

- External reset
- Clock monitor reset
- COP reset
- Self-clock mode interrupt
- Real-time interrupt (RTI)

If the MCU gets an external reset during wait mode active, the CRG asynchronously restores all configuration bits in the register space to its default settings and starts the reset generator. After completing the reset sequence processing begins by fetching the normal reset vector. Wait mode is exited and the MCU is in run mode again.

If the clock monitor is enabled $(\mathrm{CME}=1)$ the MCU is able to leave wait mode when loss of oscillator/external clock is detected by a clock monitor fail. If the SCME bit is not asserted the CRG generates a clock monitor fail reset (CMRESET). The CRG's behavior for CMRESET is the same compared to external reset, but another reset vector is fetched after completion of the reset sequence. If the SCME bit is asserted the CRG generates a SCM interrupt if enabled (SCMIE=1). After generating the interrupt the CRG enters self-clock mode and starts the clock quality checker (see Section 4.4.4, "Clock Quality Checker'). Then the MCU continues with normal operation.If the SCM interrupt is blocked by SCMIE $=0$, the SCMIF flag will be asserted and clock quality checks will be performed but the MCU will not wake-up from wait mode.

If any other interrupt source (e.g. RTI) triggers exit from wait mode the MCU immediately continues with normal operation. If the PLL has been powered-down during wait mode the PLLSEL bit is cleared and the MCU runs on OSCCLK after leaving wait mode. The software must manually set the PLLSEL bit again, in order to switch system and core clocks to the PLLCLK.

If wait mode is entered from self-clock mode, the CRG will continue to check the clock quality until clock check is successful. The PLL and voltage regulator (VREG) will remain enabled.

Table 4-11 summarizes the outcome of a clock loss while in wait mode.

Table 4-11. Outcome of Clock Loss in Wait Mode

| CME | SCME | SCMIE | CRG Actions |
| :---: | :---: | :---: | :---: |
| 0 | X | X | Clock failure --> <br> No action, clock loss not detected. |
| 1 | 0 | X | Clock failure --> CRG performs Clock Monitor Reset immediately |
| 1 | 1 | 0 | Clock failure --> <br> Scenario 1: OSCCLK recovers prior to exiting Wait Mode. <br> - MCU remains in Wait Mode, <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> - Start Clock Quality Check, <br> - Set SCMIF interrupt flag. <br> Some time later OSCCLK recovers. <br> - CM no longer indicates a failure, <br> - 4096 OSCCLK cycles later Clock Quality Check indicates clock o.k., <br> - SCM deactivated, <br> - PLL disabled depending on PLLWAI, <br> - VREG remains enabled (never gets disabled in Wait Mode). <br> - MCU remains in Wait Mode. <br> Some time later either a wakeup interrupt occurs (no SCM interrupt) <br> - Exit Wait Mode using OSCCLK as system clock (SYSCLK), <br> - Continue normal operation. <br> or an External Reset is applied. <br> - Exit Wait Mode using OSCCLK as system clock, <br> - Start reset sequence. <br> Scenario 2: OSCCLK does not recover prior to exiting Wait Mode. <br> - MCU remains in Wait Mode, <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> - Start Clock Quality Check, <br> - Set SCMIF interrupt flag, <br> - Keep performing Clock Quality Checks (could continue infinitely) while in Wait Mode. <br> Some time later either a wakeup interrupt occurs (no SCM interrupt) <br> - Exit Wait Mode in SCM using PLL clock (fscm) as system clock, <br> - Continue to perform additional Clock Quality Checks until OSCCLK is o.k. again. <br> or an External RESET is applied. <br> - Exit Wait Mode in SCM using PLL clock (fscm) as system clock, <br> - Start reset sequence, <br> - Continue to perform additional Clock Quality Checks until OSCCLK is o.k.again. |

Table 4-11. Outcome of Clock Loss in Wait Mode (continued)

| CME | SCME | SCMIE | CRG Actions |
| :---: | :---: | :---: | :--- |
| 1 | 1 | 1 | Clock failure --> <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> - Start Clock Quality Check, <br> - SCMIF set. |
| SCMIF generates Self-Clock Mode wakeup interrupt. |  |  |  |
| - Exit Wait Mode in SCM using PLL clock (f SCM) as system clock, |  |  |  |
| - Continue to perform a additional Clock Quality Checks until OSCCLK |  |  |  |
| is o.k. again. |  |  |  |

### 4.4.10 Low-Power Operation in Stop Mode

All clocks are stopped in STOP mode, dependent of the setting of the PCE, PRE and PSTP bit. The oscillator is disabled in STOP mode unless the PSTP bit is set. All counters and dividers remain frozen but do not initialize. If the PRE or PCE bits are set, the RTI or COP continues to run in pseudo-stop mode. In addition to disabling system and core clocks the CRG requests other functional units of the MCU (e.g. voltage-regulator) to enter their individual power-saving modes (if available). This is the main difference between pseudo-stop mode and wait mode.

After executing the STOP instruction the core requests the CRG to switch the MCU into stop mode. If the PLLSEL bit remains set when entering stop mode, the CRG will switch the system and core clocks to OSCCLK by clearing the PLLSEL bit. Then the CRG disables the PLL, disables the core clock and finally disables the remaining system clocks. As soon as all clocks are switched off, stop mode is active.

If pseudo-stop mode $(\operatorname{PSTP}=1)$ is entered from self-clock mode the CRG will continue to check the clock quality until clock check is successful. The PLL and the voltage regulator (VREG) will remain enabled. If full stop mode $($ PSTP $=0)$ is entered from self-clock mode an ongoing clock quality check will be stopped. A complete timeout window check will be started when stop mode is exited again.

Wake-up from stop mode also depends on the setting of the PSTP bit.


Figure 4-24. Stop Mode Entry/Exit Sequence

### 4.4.10.1 Wake-Up from Pseudo-Stop (PSTP=1)

Wake-up from pseudo-stop is the same as wake-up from wait mode. There are also three different scenarios for the CRG to restart the MCU from pseudo-stop mode:

- External reset
- Clock monitor fail
- Wake-up interrupt

If the MCU gets an external reset during pseudo-stop mode active, the CRG asynchronously restores all configuration bits in the register space to its default settings and starts the reset generator. After completing the reset sequence processing begins by fetching the normal reset vector. Pseudo-stop mode is exited and the MCU is in run mode again.

If the clock monitor is enabled $(\mathrm{CME}=1)$ the MCU is able to leave pseudo-stop mode when loss of oscillator/external clock is detected by a clock monitor fail. If the SCME bit is not asserted the CRG generates a clock monitor fail reset (CMRESET). The CRG's behavior for CMRESET is the same compared to external reset, but another reset vector is fetched after completion of the reset sequence. If the SCME bit is asserted the CRG generates a SCM interrupt if enabled (SCMIE=1). After generating the interrupt the CRG enters self-clock mode and starts the clock quality checker (see Section 4.4.4, "Clock Quality Checker"). Then the MCU continues with normal operation. If the SCM interrupt is blocked by SCMIE $=0$, the SCMIF flag will be asserted but the CRG will not wake-up from pseudo-stop mode.

If any other interrupt source (e.g. RTI) triggers exit from pseudo-stop mode the MCU immediately continues with normal operation. Because the PLL has been powered-down during stop mode the PLLSEL bit is cleared and the MCU runs on OSCCLK after leaving stop mode. The software must set the PLLSEL bit again, in order to switch system and core clocks to the PLLCLK.

Table 4-12 summarizes the outcome of a clock loss while in pseudo-stop mode.

Table 4-12. Outcome of Clock Loss in Pseudo-Stop Mode

| CME | SCME | SCMIE | CRG Actions |
| :---: | :---: | :---: | :---: |
| 0 | X | X | Clock failure --> <br> No action, clock loss not detected. |
| 1 | 0 | X | Clock failure --> CRG performs Clock Monitor Reset immediately |
| 1 | 1 | 0 | Clock Monitor failure --> <br> Scenario 1: OSCCLK recovers prior to exiting Pseudo-Stop Mode. <br> - MCU remains in Pseudo-Stop Mode, <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> - Start Clock Quality Check, <br> - Set SCMIF interrupt flag. <br> Some time later OSCCLK recovers. <br> - CM no longer indicates a failure, <br> - 4096 OSCCLK cycles later Clock Quality Check indicates clock o.k., <br> - SCM deactivated, <br> - PLL disabled, <br> - VREG disabled. <br> - MCU remains in Pseudo-Stop Mode. <br> Some time later either a wakeup interrupt occurs (no SCM interrupt) <br> - Exit Pseudo-Stop Mode using OSCCLK as system clock (SYSCLK), <br> - Continue normal operation. <br> or an External Reset is applied. <br> - Exit Pseudo-Stop Mode using OSCCLK as system clock, <br> - Start reset sequence. <br> Scenario 2: OSCCLK does not recover prior to exiting Pseudo-Stop Mode. <br> - MCU remains in Pseudo-Stop Mode, <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> - Start Clock Quality Check, <br> - Set SCMIF interrupt flag, <br> - Keep performing Clock Quality Checks (could continue infinitely) while in Pseudo-Stop Mode. <br> Some time later either a wakeup interrupt occurs (no SCM interrupt) <br> - Exit Pseudo-Stop Mode in SCM using PLL clock (fscm) as system clock <br> - Continue to perform additional Clock Quality Checks until OSCCLK is o.k. again. <br> or an External RESET is applied. <br> - Exit Pseudo-Stop Mode in SCM using PLL clock (fsCM) as system clock <br> - Start reset sequence, <br> - Continue to perform additional Clock Quality Checks until OSCCLK is o.k.again. |

Table 4-12. Outcome of Clock Loss in Pseudo-Stop Mode (continued)

| CME | SCME | SCMIE | CRG Actions |
| :---: | :---: | :---: | :--- |
| 1 | 1 | 1 | Clock failure --> <br> - VREG enabled, <br> - PLL enabled, <br> - SCM activated, <br> -Start Clock Quality Check, <br> - SCMIF set. <br> SCMIF generates Self-Clock Mode wakeup interrupt. <br> - Exit Pseudo-Stop Mode in SCM using PLL clock (fscm) as system clock, <br> - Continue to perform a additional Clock Quality Checks until OSCCLK <br> is o.k. again. |

### 4.4.10.2 Wake-up from Full Stop (PSTP=0)

The MCU requires an external interrupt or an external reset in order to wake-up from stop mode.
If the MCU gets an external reset during full stop mode active, the CRG asynchronously restores all configuration bits in the register space to its default settings and will perform a maximum of 50 clock check_windows (see Section 4.4.4, "Clock Quality Checker"). After completing the clock quality check the CRG starts the reset generator. After completing the reset sequence processing begins by fetching the normal reset vector. Full stop mode is exited and the MCU is in run mode again.
If the MCU is woken-up by an interrupt, the CRG will also perform a maximum of 50 clock check_windows (see Section 4.4.4, "Clock Quality Checker"). If the clock quality check is successful, the CRG will release all system and core clocks and will continue with normal operation. If all clock checks within the timeout-window are failing, the CRG will switch to self-clock mode or generate a clock monitor reset (CMRESET) depending on the setting of the SCME bit.

Because the PLL has been powered-down during stop mode the PLLSEL bit is cleared and the MCU runs on OSCCLK after leaving stop mode. The software must manually set the PLLSEL bit again, in order to switch system and core clocks to the PLLCLK.

## NOTE

In full stop mode, the clock monitor is disabled and any loss of clock will not be detected.

### 4.5 Resets

This section describes how to reset the CRGV4 and how the CRGV4 itself controls the reset of the MCU. It explains all special reset requirements. Because the reset generator for the MCU is part of the CRG, this section also describes all automatic actions that occur during or as a result of individual reset conditions. The reset values of registers and signals are provided in Section 4.3, "Memory Map and Register

Definition." All reset sources are listed in Table 4-13. Refer to the device overview chapter for related vector addresses and priorities.

Table 4-13. Reset Summary

| Reset Source | Local Enable |
| :---: | :---: |
| Power-on Reset | None |
| Low Voltage Reset | None |
| External Reset | None |
| Clock Monitor Reset | PLLCTL (CME=1, SCME=0) |
| COP Watchdog Reset | COPCTL (CR[2:0] nonzero) |

The reset sequence is initiated by any of the following events:

- Low level is detected at the $\overline{\text { RESET }}$ pin (external reset).
- Power on is detected.
- Low voltage is detected.
- COP watchdog times out.
- Clock monitor failure is detected and self-clock mode was disabled $(S C M E=0)$.

Upon detection of any reset event, an internal circuit drives the $\overline{\text { RESET }}$ pin low for 128 SYSCLK cycles (see Figure 4-25). Because entry into reset is asynchronous it does not require a running SYSCLK.
However, the internal reset circuit of the CRGV4 cannot sequence out of current reset condition without a running SYSCLK. The number of 128 SYSCLK cycles might be increased by $\mathrm{n}=3$ to 6 additional SYSCLK cycles depending on the internal synchronization latency. After 128+n SYSCLK cycles the $\overline{\text { RESET }}$ pin is released. The reset generator of the CRGV4 waits for additional 64 SYSCLK cycles and then samples the RESET pin to determine the originating source. Table $4-14$ shows which vector will be fetched.

Table 4-14. Reset Vector Selection

| Sampled RESET Pin <br> (64 Cycles After <br> Release) | Clock Monitor <br> Reset Pending | COP Reset <br> Pending | Vector Fetch |
| :---: | :---: | :---: | :--- |
| 1 | 0 | 0 | POR / LVR / External Reset |
| 1 | 1 | X | Clock Monitor Reset |
| 1 | 0 | 1 | COP Reset |
| 0 | $X$ | X | POR / LVR / External Reset <br> with rise of RESET pin |

NOTE
External circuitry connected to the RESET pin should not include a large capacitance that would interfere with the ability of this signal to rise to a valid logic 1 within 64 SYSCLK cycles after the low drive is released.

The internal reset of the MCU remains asserted while the reset generator completes the 192 SYSCLK long reset sequence. The reset generator circuitry always makes sure the internal reset is deasserted synchronously after completion of the 192 SYSCLK cycles. In case the RESET pin is externally driven low for more than these 192 SYSCLK cycles (external reset), the internal reset remains asserted too.


Figure 4-25. RESET Timing

### 4.5.1 Clock Monitor Reset

The CRGV4 generates a clock monitor reset in case all of the following conditions are true:

- Clock monitor is enabled ( $\mathrm{CME}=1$ )
- Loss of clock is detected
- Self-clock mode is disabled (SCME=0)

The reset event asynchronously forces the configuration registers to their default settings (see Section 4.3, "Memory Map and Register Definition"). In detail the CME and the SCME are reset to logical ' 1 ' (which doesn't change the state of the CME bit, because it has already been set). As a consequence, the CRG immediately enters self-clock mode and starts its internal reset sequence. In parallel the clock quality check starts. As soon as clock quality check indicates a valid oscillator clock the CRG switches to OSCCLK and leaves self-clock mode. Because the clock quality checker is running in parallel to the reset generator, the CRG may leave self-clock mode while completing the internal reset sequence. When the reset sequence is finished the CRG checks the internally latched state of the clock monitor fail circuit. If a clock monitor fail is indicated processing begins by fetching the clock monitor reset vector.

### 4.5.2 Computer Operating Properly Watchdog (COP) Reset

When COP is enabled, the CRG expects sequential write of $0 x 0055$ and $0 x 00 \mathrm{AA}$ (in this order) to the ARMCOP register during the selected time-out period. As soon as this is done, the COP time-out period restarts. If the program fails to do this the CRG will generate a reset. Also, if any value other than 0x0055 or 0x00AA is written, the CRG immediately generates a reset. In case windowed COP operation is enabled
writes ( 0 x 0055 or 0 x 00 AA ) to the ARMCOP register must occur in the last $25 \%$ of the selected time-out period. A premature write the CRG will immediately generate a reset.

As soon as the reset sequence is completed the reset generator checks the reset condition. If no clock monitor failure is indicated and the latched state of the COP timeout is true, processing begins by fetching the COP vector.

### 4.5.3 Power-On Reset, Low Voltage Reset

The on-chip voltage regulator detects when $\mathrm{V}_{\mathrm{DD}}$ to the MCU has reached a certain level and asserts power-on reset or low voltage reset or both. As soon as a power-on reset or low voltage reset is triggered the CRG performs a quality check on the incoming clock signal. As soon as clock quality check indicates a valid oscillator clock signal the reset sequence starts using the oscillator clock. If after 50 check windows the clock quality check indicated a non-valid oscillator clock the reset sequence starts using self-clock mode.

Figure 4-26 and Figure 4-27 show the power-up sequence for cases when the RESET pin is tied to $\mathrm{V}_{\mathrm{DD}}$ and when the $\overline{\text { RESET }}$ pin is held low.




Figure 4-27. $\overline{\text { RESET Pin Held Low Externally }}$

### 4.6 Interrupts

The interrupts/reset vectors requested by the CRG are listed in Table 4-15. Refer to the device overview chapter for related vector addresses and priorities.

Table 4-15. CRG Interrupt Vectors

| Interrupt Source | CCR <br> Mask | Local Enable |
| :---: | :---: | :---: |
| Real-time interrupt | I bit | CRGINT (RTIE) |
| LOCK interrupt | I bit | CRGINT (LOCKIE) |
| SCM interrupt | I bit | CRGINT (SCMIE) |

### 4.6.1 Real-Time Interrupt

The CRGV4 generates a real-time interrupt when the selected interrupt time period elapses. RTI interrupts are locally disabled by setting the RTIE bit to 0 . The real-time interrupt flag (RTIF) is set to 1 when a timeout occurs, and is cleared to 0 by writing a 1 to the RTIF bit.

The RTI continues to run during pseudo-stop mode if the PRE bit is set to 1 . This feature can be used for periodic wakeup from pseudo-stop if the RTI interrupt is enabled.

### 4.6.2 PLL Lock Interrupt

The CRGV4 generates a PLL lock interrupt when the LOCK condition of the PLL has changed, either from a locked state to an unlocked state or vice versa. Lock interrupts are locally disabled by setting the LOCKIE bit to 0 . The PLL Lock interrupt flag (LOCKIF) is set to 1 when the LOCK condition has changed, and is cleared to 0 by writing a 1 to the LOCKIF bit.

### 4.6.3 Self-Clock Mode Interrupt

The CRGV4 generates a self-clock mode interrupt when the SCM condition of the system has changed, either entered or exited self-clock mode. SCM conditions can only change if the self-clock mode enable bit (SCME) is set to 1 . SCM conditions are caused by a failing clock quality check after power-on reset $(\mathrm{POR})$ or low voltage reset $(\mathrm{LVR})$ or recovery from full stop mode $(\mathrm{PSTP}=0)$ or clock monitor failure. For details on the clock quality check refer to Section 4.4.4, "Clock Quality Checker." If the clock monitor is enabled $(\mathrm{CME}=1)$ a loss of external clock will also cause a SCM condition $(\mathrm{SCME}=1)$.

SCM interrupts are locally disabled by setting the SCMIE bit to 0 . The SCM interrupt flag (SCMIF) is set to 1 when the SCM condition has changed, and is cleared to 0 by writing a 1 to the SCMIF bit.

## Chapter 5 Oscillator (OSCV2)

### 5.1 Introduction

The OSCV2 module provides two alternative oscillator concepts:

- A low noise and low power Colpitts oscillator with amplitude limitation control (ALC)
- A robust full swing Pierce oscillator with the possibility to feed in an external square wave


### 5.1.1 Features

The Colpitts OSCV2 option provides the following features:

- Amplitude limitation control (ALC) loop:
- Low power consumption and low current induced RF emission
- Sinusoidal waveform with low RF emission
- Low crystal stress (an external damping resistor is not required)
- Normal and low amplitude mode for further reduction of power and emission
- An external biasing resistor is not required

The Pierce OSC option provides the following features:

- Wider high frequency operation range
- No DC voltage applied across the crystal
- Full rail-to-rail ( 2.5 V nominal) swing oscillation with low EM susceptibility
- Fast start up

Common features:

- Clock monitor (CM)
- Operation from the $\mathrm{V}_{\text {DDPLL }} 2.5 \mathrm{~V}$ (nominal) supply rail


### 5.1.2 Modes of Operation

Two modes of operation exist:

- Amplitude limitation controlled Colpitts oscillator mode suitable for power and emission critical applications
- Full swing Pierce oscillator mode that can also be used to feed in an externally generated square wave suitable for high frequency operation and harsh environments


### 5.2 External Signal Description

This section lists and describes the signals that connect off chip.

### 5.2.1 $\quad V_{\text {DDPLL }}$ and $V_{\text {SSPLL }}$ — PLL Operating Voltage, PLL Ground

These pins provide the operating voltage $\left(\mathrm{V}_{\mathrm{DDPLL}}\right)$ and ground $\left(\mathrm{V}_{\text {SSPLL }}\right)$ for the OSCV2 circuitry. This allows the supply voltage to the OSCV2 to be independently bypassed.

### 5.2.2 EXTAL and XTAL — Clock/Crystal Source Pins

These pins provide the interface for either a crystal or a CMOS compatible clock to control the internal clock generator circuitry. EXTAL is the external clock input or the input to the crystal oscillator amplifier. XTAL is the output of the crystal oscillator amplifier. All the MCU internal system clocks are derived from the EXTAL input frequency. In full stop mode $(\mathrm{PSTP}=0)$ the EXTAL pin is pulled down by an internal resistor of typical $200 \mathrm{k} \Omega$.

## NOTE

Freescale Semiconductor recommends an evaluation of the application board and chosen resonator or crystal by the resonator or crystal supplier.

The Crystal circuit is changed from standard.
The Colpitts circuit is not suited for overtone resonators and crystals.


* Due to the nature of a translated ground Colpitts oscillator a DC voltage bias is applied to the crystal.

Please contact the crystal manufacturer for crystal DC bias conditions and recommended capacitor value CDC.
Figure 5-1. Colpitts Oscillator Connections (XCLKS =0)
NOTE
The Pierce circuit is not suited for overtone resonators and crystals without a careful component selection.


* Rs can be zero (shorted) when used with higher frequency crystals. Refer to manufacturer's data.
Figure 5-2. Pierce Oscillator Connections (XCLKS = 1)


Figure 5-3. External Clock Connections (XCLKS = 1)

### 5.2.3 XCLKS — Colpitts/Pierce Oscillator Selection Signal

The XCLKS is an input signal which controls whether a crystal in combination with the internal Colpitts (low power) oscillator is used or whether the Pierce oscillator/external clock circuitry is used. The XCLKS signal is sampled during reset with the rising edge of RESET. Table 5-1 lists the state coding of the sampled XCLKS signal. Refer to the device overview chapter for polarity of the XCLKS pin.

Table 5-1. Clock Selection Based on XCLKS

| XCLKS | Description |
| :---: | :--- |
| 0 | Colpitts oscillator selected |
| 1 | Pierce oscillator/external clock selected |

### 5.3 Memory Map and Register Definition

The CRG contains the registers and associated bits for controlling and monitoring the OSCV2 module.

### 5.4 Functional Description

The OSCV2 block has two external pins, EXTAL and XTAL. The oscillator input pin, EXTAL, is intended to be connected to either a crystal or an external clock source. The selection of Colpitts oscillator or Pierce oscillator/external clock depends on the XCLKS signal which is sampled during reset. The XTAL pin is an output signal that provides crystal circuit feedback.

A buffered EXTAL signal, OSCCLK, becomes the internal reference clock. To improve noise immunity, the oscillator is powered by the $V_{\text {DDPLL }}$ and $\mathrm{V}_{\text {SSPLL }}$ power supply pins.

The Pierce oscillator can be used for higher frequencies compared to the low power Colpitts oscillator.

### 5.4.1 Amplitude Limitation Control (ALC)

The Colpitts oscillator is equipped with a feedback system which does not waste current by generating harmonics. Its configuration is "Colpitts oscillator with translated ground." The transconductor used is driven by a current source under the control of a peak detector which will measure the amplitude of the AC signal appearing on EXTAL node in order to implement an amplitude limitation control (ALC) loop. The ALC loop is in charge of reducing the quiescent current in the transconductor as a result of an increase in the oscillation amplitude. The oscillation amplitude can be limited to two values. The normal amplitude which is intended for non power saving modes and a small amplitude which is intended for low power operation modes. Please refer to the CRG block description chapter for the control and assignment of the amplitude value to operation modes.

### 5.4.2 Clock Monitor (CM)

The clock monitor circuit is based on an internal resistor-capacitor (RC) time delay so that it can operate without any MCU clocks. If no OSCCLK edges are detected within this RC time delay, the clock monitor indicates a failure which asserts self clock mode or generates a system reset depending on the state of SCME bit. If the clock monitor is disabled or the presence of clocks is detected no failure is indicated.The clock monitor function is enabled/disabled by the CME control bit, described in the CRG block description chapter.

### 5.5 Interrupts

OSCV2 contains a clock monitor, which can trigger an interrupt or reset. The control bits and status bits for the clock monitor are described in the CRG block description chapter.

## Chapter 6 Analog-to-Digital Converter (ATD10B16CV2)

### 6.1 Introduction

The ATD10B16C is a 16 -channel, 10-bit, multiplexed input successive approximation analog-to-digital converter. Refer to the Electrical Specifications chapter for ATD accuracy.

### 6.1.1 Features

- 8-/10-bit resolution
- $7 \mu \mathrm{~s}, 10$-bit single conversion time
- Sample buffer amplifier
- Programmable sample time
- Left/right justified, signed/unsigned result data
- External trigger control
- Conversion completion interrupt generation
- Analog input multiplexer for 16 analog input channels
- Analog/digital input pin multiplexing
- 1 to 16 conversion sequence lengths
- Continuous conversion mode
- Multiple channel scans


### 6.1.2 Modes of Operation

There is software programmable selection between performing single or continuous conversion on a single channel or multiple channels.

### 6.1.3 Block Diagram

Refer to Figure 6-1 for a block diagram of the ATD0B16C block.


Figure 6-1. ATD10B16C Block Diagram

### 6.2 External Signal Description

This section lists all inputs to the ATD10B16C block.

### 6.2.1 AN15/ETRIG - Analog Input Channel 15 / External trigger Pin

This pin serves as the analog input channel 15. It can also be configured as general-purpose digital input and/or external trigger for the ATD conversion.

### 6.2.2 ANx $(x=14,13,12,11,10,9,8,7,6,5,4,3,2,1,0)$ - Analog Input Channel $x$ Pins

This pin serves as the analog input channel $x$. It can also be configured as general-purpose digital input .

### 6.2.3 $\quad \mathrm{V}_{\mathrm{RH}}, \mathrm{V}_{\mathrm{RL}}$ — High Reference Voltage Pin, Low Reference Voltage Pin

$\mathrm{V}_{\mathrm{RH}}$ is the high reference voltage, $\mathrm{V}_{\mathrm{RL}}$ is the low reference voltage for ATD conversion.

### 6.2.4 $\quad V_{\text {DDA }}, V_{\text {SSA }}$ - Analog Circuitry Power Supply Pins

These pins are the power supplies for the analog circuitry of the ATD10B16CV2 block.

### 6.3 Memory Map and Register Definition

This section provides a detailed description of all registers accessible in the ATD10B16C.

### 6.3.1 Module Memory Map

Table 6-1 gives an overview of all ATD10B16C registers

Table 6-1. ATD10B16CV2 Memory Map

| Address Offset | Use | Access |
| :---: | :---: | :---: |
| 0x0000 | ATD Control Register 0 (ATDCTL0) ${ }^{1}$ | R/W |
| 0x0001 | ATD Control Register 1 (ATDCTL1) ${ }^{2}$ | R/W |
| 0x0002 | ATD Control Register 2 (ATDCTL2) | R/W |
| 0x0003 | ATD Control Register 3 (ATDCTL3) | R/W |
| 0x0004 | ATD Control Register 4 (ATDCTL4) | R/W |
| 0x0005 | ATD Control Register 5 (ATDCTL5) | R/W |
| 0x0006 | ATD Status Register 0 (ATDSTAT0) | R/W |
| 0x0007 | Unimplemented |  |
| 0x0008 | ATD Test Register 0 (ATDTESTO) ${ }^{3}$ | R |
| 0x0009 | ATD Test Register 1 (ATDTEST1) | R/W |
| 0x000A | ATD Status Register 2 (ATDSTAT2) | R |
| 0x000B | ATD Status Register 1 (ATDSTAT1) | R |
| 0x000C | ATD Input Enable Register 0 (ATDDIEN0) | R/W |
| 0x000D | ATD Input Enable Register 1 (ATDDIEN1) | R/W |
| 0x000E | Port Data Register 0 (PORTAD0) | R |
| 0x000F | Port Data Register 1 (PORTAD1) | R |
| 0x0010, 0x0011 | ATD Result Register 0 (ATDDR0H, ATDDR0L) | R/W |
| 0x0012, $0 \times 0013$ | ATD Result Register 1 (ATDDR1H, ATDDR1L) | R/W |
| 0x0014, 0x0015 | ATD Result Register 2 (ATDDR2H, ATDDR2L) | R/W |
| 0x0016, 0x0017 | ATD Result Register 3 (ATDDR3H, ATDDR3L) | R/W |
| 0x0018, 0x0019 | ATD Result Register 4 (ATDDR4H, ATDDR4L) | R/W |
| 0x001A, 0x001B | ATD Result Register 5 (ATDDR5H, ATDDR5L) | R/W |
| 0x001C, 0x001D | ATD Result Register 6 (ATDDR6H, ATDDR6L) | R/W |
| 0x001E, 0x001F | ATD Result Register 7 (ATDDR7H, ATDDR7L) | R/W |
| 0x0020, 0x0021 | ATD Result Register 8 (ATDDR8H, ATDDR8L) | R/W |
| 0x0022, 0x0023 | ATD Result Register 9 (ATDDR9H, ATDDR9L) | R/W |
| 0x0024, 0x0025 | ATD Result Register 10 (ATDDR10H, ATDDR10L) | R/W |
| 0x0026, 0x0027 | ATD Result Register 11 (ATDDR11H, ATDDR11L) | R/W |
| 0x0028, 0x0029 | ATD Result Register 12 (ATDDR12H, ATDDR12L) | R/W |
| 0x002A, 0x002B | ATD Result Register 13 (ATDDR13H, ATDDR13L) | R/W |
| 0x002C, 0x002D | ATD Result Register 14 (ATDDR14H, ATDDR14L) | R/W |
| 0x002E, 0x002F | ATD Result Register 15 (ATDDR15H, ATDDR15L) | R/W |

${ }^{1}$ ATDCTLO is intended for factory test purposes only.
${ }^{2}$ ATDCTL1 is intended for factory test purposes only.
${ }^{3}$ ATDTESTO is intended for factory test purposes only.

## NOTE

Register Address $=$ Base Address + Address Offset, where the Base Address is defined at the MCU level and the Address Offset is defined at the module level.

### 6.3.2 Register Descriptions

This section describes in address order all the ATD10B16C registers and their individual bits.


Figure 6-2. ATD Register Summary

Chapter 6 Analog-to-Digital Converter (ATD10B16CV2)

| Register Name | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\begin{array}{cc} \text { 0x000D } & R \\ \text { ATDDIEN1 } & W \end{array}$ | IEN7 | IEN6 | IEN5 | IEN4 | IEN3 | IEN2 | IEN1 | IEN0 |
| 0x000E R | PTAD15 | PTAD14 | PTAD13 | PTAD12 | PTAD11 | PTAD10 | PTAD9 | PTAD8 |
| PORTAD0 W |  |  |  |  |  |  |  |  |
| 0x000F R | PTAD7 | PTAD6 | PTAD5 | PTAD4 | PTAD3 | PTAD2 | PTAD1 | PTAD0 |
| PORTAD1 W |  |  |  |  |  |  |  |  |
| R | BIT 9 MSB BIT 7 MSB | BIT 8 BIT 6 | BIT 7 <br> BIT 5 | $\begin{aligned} & \text { BIT } 6 \\ & \text { BIT } 4 \end{aligned}$ | BIT 5 BIT 3 | $\begin{aligned} & \text { BIT } 4 \\ & \text { BIT } 2 \end{aligned}$ | $\begin{aligned} & \text { BIT } 3 \\ & \text { BIT } 1 \end{aligned}$ | $\begin{aligned} & \text { BIT } 2 \\ & \text { BIT } 0 \end{aligned}$ |
| 0x0010-0x002F W |  |  |  |  |  |  |  |  |
| ATDDRxHATDDRxL R | $\begin{gathered} \text { BIT } 1 \\ \mathrm{u} \end{gathered}$ | $\begin{gathered} \text { BIT } 0 \\ \mathrm{u} \end{gathered}$ | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ | 0 | 0 | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ | $\begin{aligned} & 0 \\ & 0 \end{aligned}$ |
| W |  |  |  |  |  |  |  |  |
|  |  | = Unimplemented or Reserved |  |  | $\mathrm{u}=$ Unaffected |  |  |  |

Figure 6-2. ATD Register Summary (continued)

### 6.3.2.1 Reserved Register (ATDCTLO)



Figure 6-3. Reserved Register (ATDCTLO)
Read: always read \$00 in normal modes
Write: unimplemented in normal modes

### 6.3.2.2 Reserved Register (ATDCTL1)



Figure 6-4. Reserved Register (ATDCTL1)

Read: always read \$00 in normal modes
Write: unimplemented in normal modes

### 6.3.2.3 ATD Control Register 2 (ATDCTL2)

This register controls power down, interrupt and external trigger. Writes to this register will abort current conversion sequence but will not start a new sequence.


Figure 6-5. ATD Control Register 2 (ATDCTL2)
Read: Anytime
Write: Anytime
Table 6-2. ATDCTL2 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { ADPU } \end{gathered}$ | ATD Power Down - This bit provides on/off control over the ATD10B16C block allowing reduced MCU power consumption. Because analog electronic is turned off when powered down, the ATD requires a recovery time period after ADPU bit is enabled. <br> 0 Power down ATD <br> 1 Normal ATD functionality |
| $\begin{gathered} 6 \\ \text { AFFC } \end{gathered}$ | ATD Fast Flag Clear All <br> 0 ATD flag clearing operates normally (read the status register ATDSTAT1 before reading the result register to clear the associate CCF flag). <br> 1 Changes all ATD conversion complete flags to a fast clear sequence. Any access to a result register will cause the associate CCF flag to clear automatically. |
| $\stackrel{5}{\text { AWAI }}$ | ATD Power Down in Wait Mode - When entering Wait Mode this bit provides on/off control over the ATD10B16C block allowing reduced MCU power. Because analog electronic is turned off when powered down, the ATD requires a recovery time period after exit from Wait mode. <br> 0 ATD continues to run in Wait mode <br> 1 Halt conversion and power down ATD during Wait mode After exiting Wait mode with an interrupt conversion will resume. But due to the recovery time the result of this conversion should be ignored. |
| 4 ETRIGLE | External Trigger Level/Edge Control - This bit controls the sensitivity of the external trigger signal. See Table 6-3 for details. |
| $\begin{gathered} 3 \\ \text { ETRIGP } \end{gathered}$ | External Trigger Polarity — This bit controls the polarity of the external trigger signal. See Table 6-3 for details. |
| $2$ <br> ETRIGE | External Trigger Mode Enable - This bit enables the external trigger on ATD channel 15. The external trigger allows to synchronize the start of conversion with external events. <br> 0 Disable external trigger <br> 1 Enable external trigger |

Table 6-2. ATDCTL2 Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 1 | $\begin{array}{l}\text { ATD Sequence Complete Interrupt Enable } \\ 0 \\ \text { ASCIE } \\ 1\end{array}$ |
| 0 | ATD Sequence Complete interrupt requests are disabled. |$]$| ATD Sequence Complete Interrupt Flag - If ASCIE $=1$ the ASCIF flag equals the SCF flag (see |
| :--- |
| ASCIF |
|  |
|  |
| 0 Noction 6.3.2.7, "ATD Status Register 0 (ATDSTAT0)"), else ASCIF reads zero. Writes have no effect. |
| 1 ATD sequence complete interrupt pending |

Table 6-3. External Trigger Configurations

| ETRIGLE | ETRIGP | External Trigger Sensitivity |
| :---: | :---: | :---: |
| 0 | 0 | Falling Edge |
| 0 | 1 | Ring Edge |
| 1 | 0 | Low Level |
| 1 | 1 | High Level |

### 6.3.2.4 ATD Control Register 3 (ATDCTL3)

This register controls the conversion sequence length, FIFO for results registers and behavior in Freeze Mode. Writes to this register will abort current conversion sequence but will not start a new sequence.


Figure 6-6. ATD Control Register 3 (ATDCTL3)
Read: Anytime
Write: Anytime
Table 6-4. ATDCTL3 Field Descriptions

| Field | Description |
| :---: | :--- |
| 6 | Conversion Sequence Length — This bit controls the number of conversions per sequence. Table 6-5 shows <br> all combinations. At reset, S4C is set to 1 (sequence length is 4). This is to maintain software continuity to HC12 <br> Family. |
| 5 | Conversion Sequence Length — This bit controls the number of conversions per sequence. Table 6-5 shows <br> all combinations. At reset, S4C is set to 1 (sequence length is 4). This is to maintain software continuity to HC12 <br> Family. |
| 4 | Conversion Sequence Length — This bit controls the number of conversions per sequence. Table 6-5 shows <br> all combinations. At reset, S4C is set to 1 (sequence length is 4). This is to maintain software continuity to HC12 <br> Family. |
| 3 | Conversion Sequence Length — This bit controls the number of conversions per sequence. Table 6-5 shows <br> S2ll combinations. At reset, S4C is set to 1 (sequence length is 4). This is to maintain software continuity to HC12 <br> Family. |

Table 6-4. ATDCTL3 Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 2 | Result Register FIFO Mode —If this bit is zero (non-FIFO mode), the A/D conversion results map into the <br> result registers based on the conversion sequence; the result of the first conversion appears in the first result <br> register, the second result in the second result register, and so on. <br> If this bit is one (FIFO mode) the conversion counter is not reset at the beginning or ending of a conversion <br> sequence; sequential conversion results are placed in consecutive result registers. In a continuously scanning <br> conversion sequence, the result register counter will wrap around when it reaches the end of the result register <br> file. The conversion counter value (CC3-0 in ATDSTAT0) can be used to determine where in the result register <br> file, the current conversion result will be placed. <br> Aborting a conversion or starting a new conversion by write to an ATDCTL register (ATDCTL5-0) clears the <br> conversion counter even if FIFO=1. So the first result of a new conversion sequence, started by writing to <br> ATDCTL5, will always be place in the first result register (ATDDDR0). Intended usage of FIFO mode is <br> continuos conversion (SCAN=1) or triggered conversion (ETRIG=1). <br> Finally, which result registers hold valid data can be tracked using the conversion complete flags. Fast flag clear <br> mode may or may not be useful in a particular application to track valid data. <br> 0 Conversion results are placed in the corresponding result register up to the selected sequence length. <br> 1 Conversion results are placed in consecutive result registers (wrap around at end). |
| $1: 0$ | Background Debug Freeze Enable - When debugging an application, it is useful in many cases to have the <br> ATD pause when a breakpoint (Freeze Mode) is encountered. These 2 bits determine how the ATD will respond |
| FRZ[1:0] |  |
| to a breakpoint as shown in Table 6-6. Leakage onto the storage node and comparator reference capacitors |  |
| may compromise the accuracy of an immediately frozen conversion depending on the length of the freeze |  |
| period. |  |

Table 6-5. Conversion Sequence Length Coding

| S8C | S4C | S2C | S1C | Number of Conversions <br> per Sequence |
| :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | 16 |
| 0 | 0 | 0 | 1 | 1 |
| 0 | 0 | 1 | 0 | 2 |
| 0 | 0 | 1 | 1 | 3 |
| 0 | 1 | 0 | 0 | 4 |
| 0 | 1 | 0 | 1 | 5 |
| 0 | 1 | 1 | 0 | 6 |
| 0 | 1 | 1 | 1 | 7 |
| 1 | 0 | 0 | 0 | 8 |
| 1 | 0 | 0 | 1 | 9 |
| 1 | 0 | 1 | 0 | 10 |
| 1 | 0 | 1 | 1 | 11 |
| 1 | 1 | 0 | 0 | 12 |
| 1 | 1 | 0 | 1 | 13 |
| 1 | 1 | 1 | 0 | 14 |
| 1 | 1 | 1 | 1 | 15 |

Table 6-6. ATD Behavior in Freeze Mode (Breakpoint)

| FRZ1 | FRZ0 | Behavior in Freeze Mode |
| :---: | :---: | :---: |
| 0 | 0 | Continue conversion |
| 0 | 1 | Reserved |
| 1 | 0 | Finish current conversion, then freeze |
| 1 | 1 | Freeze Immediately |

Chapter 6 Analog-to-Digital Converter (ATD10B16CV2)

### 6.3.2.5 ATD Control Register 4 (ATDCTL4)

This register selects the conversion clock frequency, the length of the second phase of the sample time and the resolution of the $\mathrm{A} / \mathrm{D}$ conversion (i.e., 8 -bits or 10 -bits). Writes to this register will abort current conversion sequence but will not start a new sequence.


Figure 6-7. ATD Control Register 4 (ATDCTL4)
Read: Anytime
Write: Anytime
Table 6-7. ATDCTL4 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { SRES8 } \end{gathered}$ | A/D Resolution Select - This bit selects the resolution of A/D conversion results as either 8 or 10 bits. The A/D converter has an accuracy of 10 bits. However, if low resolution is required, the conversion can be speeded up by selecting 8-bit resolution. <br> 010 bit resolution <br> 18 bit resolution |
| $\begin{gathered} \hline 6: 5 \\ \text { SMP[1:0] } \end{gathered}$ | Sample Time Select - These two bits select the length of the second phase of the sample time in units of ATD conversion clock cycles. Note that the ATD conversion clock period is itself a function of the prescaler value (bits PRS4-0). The sample time consists of two phases. The first phase is two ATD conversion clock cycles long and transfers the sample quickly (via the buffer amplifier) onto the A/D machine's storage node. The second phase attaches the external analog signal directly to the storage node for final charging and high accuracy. Table 6-8 lists the lengths available for the second sample phase. |
| $\begin{gathered} \hline 4: 0 \\ \text { PRS[4:0] } \end{gathered}$ | ATD Clock Prescaler - These 5 bits are the binary value prescaler value PRS. The ATD conversion clock frequency is calculated as follows: $\text { ATDclock }=\frac{[\text { BusClock }]}{[\mathrm{PRS}+1]} \times 0.5$ <br> Note: The maximum ATD conversion clock frequency is half the bus clock. The default (after reset) prescaler value is 5 which results in a default ATD conversion clock frequency that is bus clock divided by 12. Table 6-9 illustrates the divide-by operation and the appropriate range of the bus clock. |

Table 6-8. Sample Time Select

| SMP1 | SMP0 | Length of 2nd Phase of Sample Time |
| :---: | :---: | :---: |
| 0 | 0 | 2 A/D conversion clock periods |
| 0 | 1 | 4 A/D conversion clock periods |
| 1 | 0 | 8 A/D conversion clock periods |
| 1 | 1 | 16 A/D conversion clock periods |

Table 6-9. Clock Prescaler Values

| Prescale Value | Total Divisor Value | Max. Bus Clock ${ }^{1}$ | Min. Bus Clock ${ }^{2}$ |
| :---: | :---: | :---: | :---: |
| 00000 | Divide by 2 | 4 MHz | 1 MHz |
| 00001 | Divide by 4 | 8 MHz | 2 MHz |
| 00010 | Divide by 6 | 12 MHz | 3 MHz |
| 00011 | Divide by 8 | 16 MHz | 4 MHz |
| 00100 | Divide by 10 | 20 MHz | 5 MHz |
| 00101 | Divide by 12 | 24 MHz | 6 MHz |
| 00110 | Divide by 14 | 28 MHz | 7 MHz |
| 00111 | Divide by 16 | 32 MHz | 8 MHz |
| 01000 | Divide by 18 | 36 MHz | 9 MHz |
| 01001 | Divide by 20 | 40 MHz | 10 MHz |
| 01010 | Divide by 22 | 44 MHz | 11 MHz |
| 01011 | Divide by 24 | 48 MHz | 12 MHz |
| 01100 | Divide by 26 | 52 MHz | 13 MHz |
| 01101 | Divide by 28 | 56 MHz | 14 MHz |
| 01110 | Divide by 30 | 60 MHz | 15 MHz |
| 01111 | Divide by 32 | 64 MHz | 16 MHz |
| 10000 | Divide by 34 | 68 MHz | 17 MHz |
| 10001 | Divide by 36 | 72 MHz | 18 MHz |
| 10010 | Divide by 38 | 76 MHz | 19 MHz |
| 10011 | Divide by 40 | 80 MHz | 20 MHz |
| 10100 | Divide by 42 | 84 MHz | 21 MHz |
| 10101 | Divide by 44 | 88 MHz | 22 MHz |
| 10110 | Divide by 46 | 92 MHz | 23 MHz |
| 10111 | Divide by 48 | 96 MHz | 24 MHz |
| 11000 | Divide by 50 | 100 MHz | 25 MHz |
| 11001 | Divide by 52 | 104 MHz | 26 MHz |
| 11010 | Divide by 54 | 108 MHz | 27 MHz |
| 11011 | Divide by 56 | 112 MHz | 28 MHz |
| 11100 | Divide by 58 | 116 MHz | 29 MHz |
| 11101 | Divide by 60 | 120 MHz | 30 MHz |
| 11110 | Divide by 62 | 124 MHz | 31 MHz |
| 11111 | Divide by 64 | 128 MHz | 32 MHz |

${ }^{1}$ Maximum ATD conversion clock frequency is 2 MHz . The maximum allowed bus clock frequency is shown in this column.
2 Minimum ATD conversion clock frequency is 500 kHz . The minimum allowed bus clock frequency is shown in this column.

### 6.3.2.6 ATD Control Register 5 (ATDCTL5)

This register selects the type of conversion sequence and the analog input channels sampled. Writes to this register will abort current conversion sequence and start a new conversion sequence. If external trigger is enabled (ETRIGE $=1$ ) an initial write to ATDCTL5 is required to allow starting of a conversion sequence which will then occur on each trigger event. Start of conversion means the beginning of the sampling phase.


Figure 6-8. ATD Control Register 5 (ATDCTL5)
Read: Anytime
Write: Anytime
Table 6-10. ATDCTL5 Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| DJM | Result Register Data Justification - This bit controls justification of conversion data in the result registers. <br> See Section 6.3.2.16, "ATD Conversion Result Registers (ATDDRx)" for details. <br> 0 Left justified data in the result registers. <br> 1 <br> Right justified data in the result registers. |
| 6 <br> DSGN | Result Register Data Signed or Unsigned Representation - This bit selects between signed and unsigned <br> conversion data representation in the result registers. Signed data is represented as 2's complement. Signed <br> data is not available in right justification. See <st-bold>6.3.2.16 ATD Conversion Result Registers (ATDDRx) <br> for details. <br> 0 <br> O Unsigned data representation in the result registers. <br> 1 <br> Signed data representation in the result registers. <br> Table 6-11 summarizes the result data formats available and how they are set up using the control bits. <br> Table 6-12 illustrates the difference between the signed and unsigned, left justified output codes for an input <br> signal range between 0 and 5.12 Volts. |
| 5 | Continuous Conversion Sequence Mode - This bit selects whether conversion sequences are performed <br> continuously or only once. If external trigger is enabled (ETRIGE=1) setting this bit has no effect, that means <br> each trigger event starts a single conversion sequence. <br> 0 Single conversion sequence <br> 1 |
| Continuous conversion sequences (scan mode) |  |

Table 6-10. ATDCTL5 Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 3:0 | Analog Input Channel Select Code - These bits select the analog input channel(s) whose signals are <br> sampled and converted to digital codes. Table 6-13 lists the coding used to select the various analog input <br> channels. <br> In the case of single channel conversions (MULT $=0$ ), this selection code specified the channel to be examined. |
| In the case of multiple channel conversions (MULT $=1$ ), this selection code represents the first channel to be |  |
| examined in the conversion sequence. Subsequent channels are determined by incrementing the channel |  |
| selection code or wrapping around to AN0 (after converting the channel defined by the Wrap Around Channel |  |
| Select Bits WRAP[3:0] in ATDCTL0). In case starting with a channel number higher than the one defined by |  |
| WRAP[3:0] the first wrap around will be AN15 to AN0. |  |

Table 6-11. Available Result Data Formats.

| SRES8 | DJM | DSGN | Result Data Formats <br> Description and Bus Bit Mapping |
| :---: | :---: | :---: | :---: |
| 1 | 0 | 0 | 8 -bit / left justified / unsigned - bits $15: 8$ |
| 1 | 0 | 1 | 8 -bit / left justified / signed - bits $15: 8$ |
| 1 | 1 | X | 8 -bit / right justified / unsigned - bits $7: 0$ |
| 0 | 0 | 0 | 10 -bit / left justified / unsigned - bits $15: 6$ |
| 0 | 0 | 1 | $10-$ bit / left justified / signed --bits $15: 6$ |
| 0 | 1 | X | 10-bit / right justified / unsigned - bits $9: 0$ |

Table 6-12. Left Justified, Signed and Unsigned ATD Output Codes.

| Input Signal <br> $\mathbf{V}_{\mathbf{R L}}=\mathbf{0}$ Volts <br> $\mathbf{V}_{\mathbf{R H}}=\mathbf{5 . 1 2}$ Volts | Signed <br> 8-Bit Codes | Unsigned <br> 8-Bit Codes | Signed <br> $\mathbf{1 0 - B i t ~ C o d e s ~}$ | Unsigned <br> $\mathbf{1 0}$-Bit Codes |
| :---: | :---: | :---: | :---: | :---: |
| 5.120 Volts | 7 F | FF | $7 \mathrm{FC0}$ | FFC0 |
| 5.100 | 7 F | FF | 7 F 00 | FF00 |
| 5.080 | 7 E | FE | 7 F 00 | FE00 |
| 2.580 | 01 | 81 | 0100 | 8100 |
| 2.560 | 00 | 80 | 0000 | 8000 |
| 2.540 | FF | 7 F | FF00 | $7 F 00$ |
| 0.020 | 81 | 01 | 8100 | 0100 |
| 0.000 | 80 | 00 | 8000 | 0000 |

Table 6-13. Analog Input Channel Select Coding

| $\mathbf{C D}$ | $\mathbf{C C}$ | $\mathbf{C B}$ | $\mathbf{C A}$ | Analog Input <br> Channel |
| :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | AN0 |
| 0 | 0 | 0 | 1 | AN1 |
| 0 | 0 | 1 | 0 | AN2 |
| 0 | 0 | 1 | 1 | AN3 |
| 0 | 1 | 0 | 0 | AN4 |
| 0 | 1 | 0 | 1 | AN5 |
| 0 | 1 | 1 | 0 | AN6 |
| 0 | 1 | 1 | 1 | AN7 |
| 1 | 0 | 0 | 0 | AN8 |
| 1 | 0 | 0 | 1 | AN9 |
| 1 | 0 | 1 | 0 | AN10 |
| 1 | 0 | 1 | 1 | AN11 |
| 1 | 1 | 0 | 0 | AN12 |
| 1 | 1 | 0 | 1 | AN13 |
| 1 | 1 | 1 | 1 | 1 |
| 1 | 1 |  |  | AN14 |
|  |  | 1 |  |  |

### 6.3.2.7 ATD Status Register 0 (ATDSTATO)

This read-only register contains the Sequence Complete Flag, overrun flags for external trigger and FIFO mode, and the conversion counter.


Figure 6-9. ATD Status Register 0 (ATDSTATO)
Read: Anytime
Write: Anytime (No effect on CC[3:0])
Table 6-14. ATDSTATO Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| SCF | Sequence Complete Flag - This flag is set upon completion of a conversion sequence. If conversion <br> sequences are continuously performed (SCAN = 1), the flag is set after each one is completed. This flag is <br> cleared when one of the following occurs: <br> - Write "1" to SCF <br> - Write to ATDCTL5 (a new conversion sequence is started) <br> - If AFFC = 1 and read of a result register |
| 0 Conversion sequence not completed |  |
| 1 Conversion sequence has completed |  |

Table 6-14. ATDSTATO Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 4 |  |
| FIFOR | FIFO Over Run Flag - This bit indicates that a result register has been written to before its associated <br> conversion complete flag (CCF) has been cleared. This flag is most useful when using the FIFO mode because <br> the flag potentially indicates that result registers are out of sync with the input channels. However, it is also <br> practical for non-FIFO modes, and indicates that a result register has been over written before it has been read <br> (i.e., the old data has been lost). This flag is cleared when one of the following occurs: <br> - Write "1" to FIFOR <br> - Start a new conversion sequence (write to ATDCTL5 or external trigger) <br> 0 No over run has occurred <br> 1 Overrun condition exists (result register has been written while associated CCFx flag remained set) |
| CC[3:0\} | Conversion Counter - These 4 read-only bits are the binary value of the conversion counter. The conversion <br> counter points to the result register that will receive the result of the current conversion. For example, CC3 = 0, <br> CC2 = 1, CC1 = 1, CC0 = indicates that the result of the current conversion will be in ATD Result Register 6. <br> If in non-FIFO mode (FIFO = 0) the conversion counter is initialized to zero at the begin and end of the <br> conversion sequence. If in FIFO mode (FIFO = 1) the register counter is not initialized. The conversion <br> counters wraps around when its maximum value is reached. <br> Aborting a conversion or starting a new conversion by write to an ATDCTL register (ATDCTL5-0) clears the <br> conversion counter even if FIFO=1. |

### 6.3.2.8 Reserved Register 0 (ATDTESTO)



Figure 6-10. Reserved Register 0 (ATDTESTO)
Read: Anytime, returns unpredictable values
Write: Anytime in special modes, unimplemented in normal modes

## NOTE

Writing to this register when in special modes can alter functionality.

### 6.3.2.9 ATD Test Register 1 (ATDTEST1)

This register contains the SC bit used to enable special channel conversions.


Figure 6-11. Reserved Register 1 (ATDTEST1)
Read: Anytime, returns unpredictable values for bit 7 and bit 6
Write: Anytime

## NOTE

Writing to this register when in special modes can alter functionality.
Table 6-15. ATDTEST1 Field Descriptions

| Field | Description |
| :---: | :--- |
| 0 | Special Channel Conversion Bit - If this bit is set, then special channel conversion can be selected using <br> CC, CB, and CA of ATDCTL5. Table 6-16 lists the coding. <br> 0 |
| 1 | Special channel conversions disabled |
| 1 | Special channel conversions enabled |

Table 6-16. Special Channel Select Coding

| $\mathbf{S C}$ | $\mathbf{C D}$ | $\mathbf{C C}$ | $\mathbf{C B}$ | $\mathbf{C A}$ | Analog Input Channel |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 0 | 0 | X | X | Reserved |
| 1 | 0 | 1 | 0 | 0 | $\mathrm{~V}_{\mathrm{RH}}$ |
| 1 | 0 | 1 | 0 | 1 | $\mathrm{~V}_{\mathrm{RL}}$ |
| 1 | 0 | 1 | 1 | 0 | $\left(\mathrm{~V}_{\mathrm{RH}}+\mathrm{V}_{\mathrm{RL}}\right) / 2$ |
| 1 | 0 | 1 | 1 | 1 | Reserved |
| 1 | 1 | X | X | X | Reserved |

### 6.3.2.10 ATD Status Register 2 (ATDSTAT2)

This read-only register contains the Conversion Complete Flags CCF15 to CCF8.


Figure 6-12. ATD Status Register 2 (ATDSTAT2)
Read: Anytime
Write: Anytime, no effect
Table 6-17. ATDSTAT2 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ |  |
| CCF[15:8] | Conversion Complete Flag Bits - A conversion complete flag is set at the end of each conversion in a <br> conversion sequence. The flags are associated with the conversion position in a sequence (and also the result <br> register number). Therefore, CCF8 is set when the ninth conversion in a sequence is complete and the result <br> is available in result register ATDDR8; CCF9 is set when the tenth conversion in a sequence is complete and <br> the result is available in ATDDR9, and so forth. A flag CCFx ( $x=15,14,13,12,11,10,9,8)$ is cleared when <br> one of the following occurs: <br> - Write to ATDCTL5 (a new conversion sequence is started) <br> - If AFFC = 0 and read of ATDSTAT2 followed by read of result register ATDDRx <br> - If AFFC = 1 and read of result register ATDDRx |
| In case of a concurrent set and clear on CCFx: The clearing by method A) will overwrite the set. The clearing <br> by methods B) or C) will be overwritten by the set. <br> 0 Conversion number $x$ not completed <br> 1 Conversion number $x$ has completed, result ready in ATDDRx |  |

### 6.3.2.11 ATD Status Register 1 (ATDSTAT1)

This read-only register contains the Conversion Complete Flags CCF7 to CCF0


Figure 6-13. ATD Status Register 1 (ATDSTAT1)
Read: Anytime
Write: Anytime, no effect
Table 6-18. ATDSTAT1 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ |  |
| CCF[7:0] | Conversion Complete Flag Bits - A conversion complete flag is set at the end of each conversion in a <br> conversion sequence. The flags are associated with the conversion position in a sequence (and also the result <br> register number). Therefore, CCFO is set when the first conversion in a sequence is complete and the result is <br> available in result register ATDDR0; CCF1 is set when the second conversion in a sequence is complete and <br> the result is available in ATDDR1, and so forth. A CCF flag is cleared when one of the following occurs: <br> - Write to ATDCTL5 (a new conversion sequence is started) <br> - If AFFC = 0 and read of ATDSTAT1 followed by read of result register ATDDRx <br> - If AFFC = 1 and read of result register ATDDRx |
| In case of a concurrent set and clear on CCFx: The clearing by method A) will overwrite the set. The clearing <br> by methods B) or C) will be overwritten by the set. <br> Conversion number $x$ not completed <br> Conversion number $x$ has completed, result ready in ATDDRx |  |

### 6.3.2.12 ATD Input Enable Register 0 (ATDDIENO)



Figure 6-14. ATD Input Enable Register 0 (ATDDIENO)
Read: Anytime
Write: anytime
Table 6-19. ATDDIEN0 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | ATD Digital Input Enable on Channel Bits - This bit controls the digital input buffer from the analog input <br> pin (ANx) to PTADx data register. <br> 0 Disable digital input buffer to PTADx <br> 1 Enable digital input buffer to PTADx. <br> Note: Setting this bit will enable the corresponding digital input buffer continuously. If this bit is set while <br> simultaneously using it as an analog port, there is potentially increased power consumption because the <br> digital input buffer maybe in the linear region. |

### 6.3.2.13 ATD Input Enable Register 1 (ATDDIEN1)



Figure 6-15. ATD Input Enable Register 1 (ATDDIEN1)
Read: Anytime
Write: Anytime

Table 6-20. ATDDIEN1 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | ATD Digital Input Enable on Channel Bits - This bit controls the digital input buffer from the analog input <br> pin (ANx) to PTADx data register. <br> 0 IEN[7:0] <br> 1 Eisable digital input buffer to PTADx <br> Enable digital input buffer to PTADx. <br> Note: Setting this bit will enable the corresponding digital input buffer continuously. If this bit is set while <br> simultaneously using it as an analog port, there is potentially increased power consumption because the <br> digital input buffer maybe in the linear region. |

### 6.3.2.14 Port Data Register 0 (PORTADO)

The data port associated with the ATD is input-only. The port pins are shared with the analog A/D inputs AN[15:8].


Figure 6-16. Port Data Register 0 (PORTAD0)
Read: Anytime
Write: Anytime, no effect
The A/D input channels may be used for general-purpose digital input.
Table 6-21. PORTADO Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7: 0 \\ \operatorname{PTAD}[15: 8] \end{gathered}$ | A/D Channel $x$ (ANx) Digital Input Bits- If the digital input buffer on the ANx pin is enabled (IENx=1) or channel $x$ is enabled as external trigger (ETRIGE $=1$, ETRIGCH[3-0] $=x$, ETRIGSEL $=0$ ) read returns the logic level on ANx pin (signal potentials not meeting $\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ specifications will have an indeterminate value)). If the digital input buffers are disabled $(\operatorname{IENx}=0)$ and channel x is not enabled as external trigger, read returns a "1". <br> Reset sets all PORTAD0 bits to " 1 ". |

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### 6.3.2.15 Port Data Register 1 (PORTAD1)

The data port associated with the ATD is input-only. The port pins are shared with the analog A/D inputs AN7-0.


Figure 6-17. Port Data Register 1 (PORTAD1)
Read: Anytime
Write: Anytime, no effect
The $\mathrm{A} / \mathrm{D}$ input channels may be used for general-purpose digital input.
Table 6-22. PORTAD1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7: 0 \\ \operatorname{PTAD}[7: 8] \end{gathered}$ | A/D Channel $\mathbf{x}$ (ANx) Digital Input Bits - If the digital input buffer on the ANx pin is enabled (IENx=1) or channel $x$ is enabled as external trigger (ETRIGE $=1$, ETRIGCH[3-0] $=x$, ETRIGSEL $=0$ ) read returns the logic level on $A N x$ pin (signal potentials not meeting $\mathrm{V}_{I L}$ or $\mathrm{V}_{I H}$ specifications will have an indeterminate value)). If the digital input buffers are disabled $(\operatorname{IENx}=0)$ and channel x is not enabled as external trigger, read returns a "1". <br> Reset sets all PORTAD1 bits to "1". |

### 6.3.2.16 ATD Conversion Result Registers (ATDDRx)

The A/D conversion results are stored in 16 read-only result registers. The result data is formatted in the result registers bases on two criteria. First there is left and right justification; this selection is made using the DJM control bit in ATDCTL5. Second there is signed and unsigned data; this selection is made using the DSGN control bit in ATDCTL5. Signed data is stored in 2's complement format and only exists in left justified format. Signed data selected for right justified format is ignored.

Read: Anytime
Write: Anytime in special mode, unimplemented in normal modes

### 6.3.2.16.1 Left Justified Result Data



Figure 6-18. Left Justified, ATD Conversion Result Register x, High Byte (ATDDRxH)


Figure 6-19. Left Justified, ATD Conversion Result Register x, Low Byte (ATDDRxL)

### 6.3.2.16.2 Right Justified Result Data



Figure 6-20. Right Justified, ATD Conversion Result Register x, High Byte (ATDDRxH)


Figure 6-21. Right Justified, ATD Conversion Result Register x, Low Byte (ATDDRxL)

### 6.4 Functional Description

The ATD10B16C is structured in an analog and a digital sub-block.

### 6.4.1 Analog Sub-block

The analog sub-block contains all analog electronics required to perform a single conversion. Separate power supplies $\mathrm{V}_{\mathrm{DDA}}$ and $\mathrm{V}_{\mathrm{SSA}}$ allow to isolate noise of other MCU circuitry from the analog sub-block.

### 6.4.1.1 Sample and Hold Machine

The sample and hold $(\mathrm{S} / \mathrm{H})$ machine accepts analog signals from the external world and stores them as capacitor charge on a storage node.

The sample process uses a two stage approach. During the first stage, the sample amplifier is used to quickly charge the storage node. The second stage connects the input directly to the storage node to complete the sample for high accuracy.
When not sampling, the sample and hold machine disables its own clocks. The analog electronics continue drawing their quiescent current. The power down (ADPU) bit must be set to disable both the digital clocks and the analog power consumption.

The input analog signals are unipolar and must fall within the potential range of $\mathrm{V}_{\text {SSA }}$ to VDDA.

### 6.4.1.2 Analog Input Multiplexer

The analog input multiplexer connects one of the 16 external analog input channels to the sample and hold machine.

### 6.4.1.3 Sample Buffer Amplifier

The sample amplifier is used to buffer the input analog signal so that the storage node can be quickly charged to the sample potential.

### 6.4.1.4 Analog-to-Digital (A/D) Machine

The $\mathrm{A} / \mathrm{D}$ machine performs analog to digital conversions. The resolution is program selectable at either 8 or 10 bits. The $\mathrm{A} / \mathrm{D}$ machine uses a successive approximation architecture. It functions by comparing the stored analog sample potential with a series of digitally generated analog potentials. By following a binary search algorithm, the $\mathrm{A} / \mathrm{D}$ machine locates the approximating potential that is nearest to the sampled potential.

When not converting the $\mathrm{A} / \mathrm{D}$ machine disables its own clocks. The analog electronics continue drawing quiescent current. The power down (ADPU) bit must be set to disable both the digital clocks and the analog power consumption.

Only analog input signals within the potential range of $\mathrm{V}_{\mathrm{RL}}$ to $\mathrm{V}_{\mathrm{RH}}$ ( $\mathrm{A} / \mathrm{D}$ reference potentials) will result in a non-railed digital output codes.

### 6.4.2 Digital Sub-Block

This subsection explains some of the digital features in more detail. See register descriptions for all details.

### 6.4.2.1 External Trigger Input (ETRIG)

The external trigger feature allows the user to synchronize ATD conversions to the external environment events rather than relying on software to signal the ATD module when ATD conversions are to take place. The external trigger signal (ATD channel 15) is programmable to be edge or level sensitive with polarity control. Table 6-23 gives a brief description of the different combinations of control bits and their effect on the external trigger function.

Table 6-23. External Trigger Control Bits

| ETRIGLE | ETRIGP | ETRIGE | SCAN | Description |
| :---: | :---: | :---: | :---: | :--- |
| X | X | 0 | 0 | Ignores external trigger. Performs one conversion sequence and stops. |
| X | X | 0 | 1 | Ignores external trigger. Performs continuous conversion sequences. |
| 0 | 0 | 1 | X | Falling edge triggered. Performs one conversion sequence per trigger. |
| 0 | 1 | 1 | X | Rising edge triggered. Performs one conversion sequence per trigger. |
| 1 | 0 | 1 | X | Trigger active low. Performs continuous conversions while trigger is active. |
| 1 | 1 | 1 | X | Trigger active high. Performs continuous conversions while trigger is active. |

During a conversion, if additional active edges are detected the overrun error flag ETORF is set.

In either level or edge triggered modes, the first conversion begins when the trigger is received. In both cases, the maximum latency time is one bus clock cycle plus any skew or delay introduced by the trigger circuitry.

After ETRIGE is enabled, conversions cannot be started by a write to ATDCTL5, but rather must be triggered externally.

If the level mode is active and the external trigger both de-asserts and re-asserts itself during a conversion sequence, this does not constitute an overrun. Therefore, the flag is not set. If the trigger remains asserted in level mode while a sequence is completing, another sequence will be triggered immediately.

### 6.4.2.2 General-Purpose Digital Input Port Operation

The input channel pins can be multiplexed between analog and digital data. As analog inputs, they are multiplexed and sampled to supply signals to the A/D converter. As digital inputs, they supply external input data that can be accessed through the digital port registers (PORTAD0 \& PORTAD1) (input-only).

The analog/digital multiplex operation is performed in the input pads. The input pad is always connected to the analog inputs of the ATD10B16C. The input pad signal is buffered to the digital port registers. This buffer can be turned on or off with the ATDDIEN0 \& ATDDIEN1 register. This is important so that the buffer does not draw excess current when analog potentials are presented at its input.

### 6.4.3 Operation in Low Power Modes

The ATD10B16C can be configured for lower MCU power consumption in three different ways:

- Stop Mode

Stop Mode: This halts A/D conversion. Exit from Stop mode will resume A/D conversion, But due to the recovery time the result of this conversion should be ignored.
Entering stop mode causes all clocks to halt and thus the system is placed in a minimum power standby mode. This halts any conversion sequence in progress. During recovery from stop mode, there must be a minimum delay for the stop recovery time $\mathrm{t}_{\mathrm{SR}}$ before initiating a new ATD conversion sequence.

- Wait Mode

Wait Mode with AWAI = 1 : This halts A/D conversion. Exit from Wait mode will resume A/D conversion, but due to the recovery time the result of this conversion should be ignored.
Entering wait mode, the ATD conversion either continues or halts for low power depending on the logical value of the AWAIT bit.

- Freeze Mode

Writing ADPU $=0$ (Note that all ATD registers remain accessible.): This aborts any A/D conversion in progress.
In freeze mode, the ATD10B16C will behave according to the logical values of the FRZ1 and FRZ0 bits. This is useful for debugging and emulation.

## NOTE

The reset value for the ADPU bit is zero. Therefore, when this module is reset, it is reset into the power down state.

### 6.5 Resets

At reset the ATD10B16C is in a power down state. The reset state of each individual bit is listed within Section 6.3, "Memory Map and Register Definition," which details the registers and their bit fields.

### 6.6 Interrupts

The interrupt requested by the ATD10B16C is listed in Table 6-24. Refer to MCU specification for related vector address and priority.

Table 6-24. ATD Interrupt Vectors

| Interrupt Source | CCR Mask | Local Enable |
| :---: | :---: | :---: |
| Sequence Complete Interrupt | I bit | ASCIE in ATDCTL2 |

See Section 6.3.2, "Register Descriptions," for further details.

## Chapter 7 <br> Digital-to-Analog Converter (DAC8B1CV1)

### 7.1 Introduction

The DAC8B1C is a 8-bit, 1-channel digital-to-analog converter module.

### 7.1.1 Features

The DAC8B1C includes these features:

- 8-bit resolution.
- One output independent monotonic channel.


### 7.1.2 Modes of Operation

The DAC8B1C functions the same in normal, special, and emulation modes. It has two low-power modes, wait and stop modes.

### 7.1.2.1 Run Mode

Normal mode of operation.

### 7.1.2.2 Wait Mode

Entering wait mode, the DAC conversion either continues or aborts for low power, depending on the logical state of the DACWAI bit.

### 7.1.2.3 Stop Mode

The DAC8B1C module is disabled in stop mode for reduced power consumption. The STOP instruction does not affect DAC register states.

### 7.1.3 Block Diagram

Figure 7-1 illustrates the functional block diagram of the DAC8B1C module.

## Chapter 7 Digital-to-Analog Converter (DAC8B1CV1)



Figure 7-1. DAC8B1C Functional Block Diagram

### 7.2 External Signal Description

The DAC8B1C module requires four external pins. These pins are listed in Table 7-1 below.
Table 7-1. DAC8B1C External Pin Descriptions

| Name | Function |
| :---: | :---: |
| DAO | DAC channel output |
| $\mathrm{V}_{\text {DDA }}$ | DAC power supply |
| $\mathrm{V}_{\text {SSA }}$ | DAC ground supply |
| $\mathrm{V}_{\text {REF }}$ | Reference voltage for DAC conversion |
| $\mathrm{V}_{\mathrm{RL}}$ | Reference ground voltage connected <br> to $\mathrm{V}_{\text {SSA }}$ outside the DAC boundary |

### 7.2.1 DAO - DAC Channel Output

This pin is used as the analog output pin of the DAC8B1C module. The value represents the analog voltage level between $\mathrm{V}_{\mathrm{SSA}}$ and $\mathrm{V}_{\text {REF }}$.

### 7.2.2 $\quad V_{D D A}$ — DAC Power Supply

This pin serves as the power supply pin. 1

### 7.2.3 $\quad \mathrm{V}_{\mathrm{SSA}}$ — DAC Ground Supply

This pin serves as an analog ground reference to the DAC.

### 7.2.4 $\quad V_{\text {REF }}$ — DAC Reference Supply

This pin serves as the source for the high reference potential. Separation from the power supply pins accommodates the filtering necessary to achieve the accuracy of which the system is capable.

### 7.2.5 $\quad \mathrm{V}_{\mathrm{RL}}$ — DAC Reference Ground Supply

This pin serves as the ground for the low reference potential. This pin is connected to $\mathrm{V}_{\text {SSA }}$ outside the DAC module boundary to accommodate the filtering necessary to achieve the accuracy of which the system is capable.

### 7.3 Memory Map and Registers

This section provides a detailed description of all memory and registers accessible to the end user.

### 7.3.1 Module Memory Map

Figure 7-2 summarizes the DAC8B1C memory map. The base address is defined at the chip level and the address offset is defined at the module level.


Figure 7-2. DAC8B1C Register Summary

### 7.3.2 Register Descriptions

This section consists of register descriptions arranged in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in descending bit order.

### 7.3.2.1 DAC Control Register 0 (DACCO)



Figure 7-3. DAC Control Register 0 (DACCO)
Read: anytime (reserved locations read zero)
Write: anytime except DACTE is available only in special modes
Table 7-2. DACCO Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 | DAC Enable - This bit enables digital-to-analog converter functionality. When enabled, an analog voltage <br> DACE <br> based on the digital value in the DAC data register will be output. When disabled, DAO pin is high-impedance. <br> 0 <br> DAC is disabled and powered down |
| 1 DAC is enabled for conversion |  |

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### 7.3.2.2 Reserved Register (DACC1)

This register is reserved.
Module Base $+0 \times 0000$


Figure 7-4. Reserved Register (DACC1)
Read: always read \$00
Write: unimplemented

### 7.3.2.3 DAC Data Register — Left Justified (DACD)

Module Base + 0x0002


Figure 7-5. DAC Data Register — Left Justified (DACD)
Read: read zeroes when DJM is set
Write: unimplemented when DJM is set
The DAC data register is an 8-bit readable/writable register that stores the data to be converted when DJM bit is clear. When the DACE bit is set, the value in this register is converted into an analog voltage such that values from $\$ 00$ to $\$ F F$ result in equal voltage increments from $V_{\text {SSA }}$ to $V_{\text {REF }}$. When DJM bit is set, this register reads zeroes and cannot be written.

## Chapter 7 Digital-to-Analog Converter (DAC8B1CV1)

### 7.3.2.4 DAC Data Register — Right Justified (DACD)



Figure 7-6. DAC Data Register - Right Justified (DACD)
Read: read zeroes when DJM is clear
Write: unimplemented when DJM is clear
The DAC data register is an 8-bit readable/writable register that stores the data to be converted when DJM bit is set. When the DACE bit is set, the value in this register is converted into an analog voltage such that values from $\$ 00$ to $\$ F F$ result in equal voltage increments from $V_{S S A}$ to $V_{\text {REF }}$. When DJM bit is clear, this register reads zeroes and cannot be written.

### 7.4 Functional Description

The DAC8B1C module consists of analog and digital sub-blocks.

### 7.4.1 Functional Description

Data to be converted is written to DACD register. The data can be mapped either to left end or right end of DACD register by clearing or setting DJM bit of DACC0 register. Also, the data written to DACD can be a signed or unsigned data depending on DSGN bit of DACC0 register. See Table 7-3 below for data formats. The maximum unsigned data that can be written to DACD register is $\$ F F$ while the minimum value is $\$ 00$. If the data is signed, the maximum value that can be written to DACD is $\$ 7 \mathrm{~F}$ while the minimum value is $\$ 80$, where $\$ 7 \mathrm{~F}$ (signed) corresponds to $\$ \mathrm{FF}$ (unsigned) and $\$ 80$ (signed) corresponds to $\$ 00$ (unsigned). Table $7-4$ shows this characteristic between signed, unsigned data values and their corresponding voltage output. See Table 7-4 for DAC signed and un-signed data and DAC output codes.

Table 7-3. Data Formats

| DJM | DSGN | Description and Bus Bit Mapping |
| :---: | :---: | :---: |
| 0 | 0 | $8 \mathrm{bit} /$ left justified/unsigned - bits $15-8$ |
| 0 | 1 | $8 \mathrm{bit} /$ left justified/signed - bits $15-8$ |
| 1 | 0 | $8 \mathrm{bit} /$ right justified/unsigned - bits $7-0$ |
| 1 | 1 | 8 bit/right justified/signed bits $-7-0$ |

Table 7-4. Signed and Unsigned Data and DAC Output Codes

| Input signal <br> $\mathbf{V}_{\mathbf{R L}}=\mathbf{0}$ <br> $\mathbf{V}_{\mathbf{R E F}} / \mathbf{V}_{\mathbf{R H}}=\mathbf{5 . 1 2 v o l t s}$ | Signed <br> $\mathbf{8 - B i t}$ <br> Codes | Unsigned <br> $\mathbf{8 - B i t}$ <br> Codes |
| :---: | :---: | :---: |
| 5.12 | 7 F | FF |
| 5.08 | 7 E | FE |
| 5.07 | 7 D | FD |
|  |  |  |
| 2.580 | 01 | 81 |
| 2.56 | FF | 7 F |
| 2.54 |  | 7 E |
| 2.52 | 81 | 01 |
|  | 80 | 00 |
| 0.020 |  |  |
| 0.000 |  |  |

## Chapter 7 Digital-to-Analog Converter (DAC8B1CV1)

Conversion of the data in DACD register takes place as soon as DACE bit of DACC0 is set. The transfer characteristic of the day module is shown in Figure 7-7.


Figure 7-7. DAC8B1C Transfer Function

### 7.5 Resets

### 7.5.1 General

The DAC8B1C module is reset on a system reset. If the system reset signal is activated, the DAC registers are initialized to their reset state and the DAC8B1C module is powered down. This occurs as a function of the register file initialization. If the module is performing a conversion, the current conversion is terminated.

## Chapter 8

## Serial Communication Interface (SCIV3)

### 8.1 Introduction

This block description chapter provides an overview of serial communication interface (SCI) module.
The SCI allows full duplex, asynchronous, serial communication between the CPU and remote devices, including other CPUs. The SCI transmitter and receiver operate independently, although they use the same baud rate generator. The CPU monitors the status of the SCI, writes the data to be transmitted, and processes received data.

### 8.1.1 Glossary

IR: infrared
IrDA: Infrared Design Association
IRQ: interrupt request
LSB: least significant bit
MSB: most significant bit
NRZ: non-return-to-Zero
RZI: return-to-zero-inverted
RXD: receive pin
SCI: serial communication interface
TXD: transmit pin

### 8.1.2 Features

The SCI includes these distinctive features:

- Full-duplex or single-wire operation
- Standard mark/space non-return-to-zero (NRZ) format
- Selectable IrDA 1.4 return-to-zero-inverted (RZI) format with programmable pulse widths
- 13-bit baud rate selection
- Programmable 8-bit or 9-bit data format
- Separately enabled transmitter and receiver
- Programmable transmitter output parity
- Two receiver wakeup methods:
- Idle line wakeup
- Address mark wakeup
- Interrupt-driven operation with eight flags:
- Transmitter empty
- Transmission complete
- Receiver full
- Idle receiver input
- Receiver overrun
- Noise error
- Framing error
- Parity error
- Receiver framing error detection
- Hardware parity checking
- $1 / 16$ bit-time noise detection


### 8.1.3 Modes of Operation

The SCI functions the same in normal, special, and emulation modes. It has two low-power modes, wait and stop modes.

### 8.1.3.1 Run Mode

Normal mode of operation.

### 8.1.3.2 Wait Mode

SCI operation in wait mode depends on the state of the SCISWAI bit in the SCI control register 1 (SCICR1).

- If SCISWAI is clear, the SCI operates normally when the CPU is in wait mode.
- If SCISWAI is set, SCI clock generation ceases and the SCI module enters a power-conservation state when the CPU is in wait mode. Setting SCISWAI does not affect the state of the receiver enable bit, RE, or the transmitter enable bit, TE.
If SCISWAI is set, any transmission or reception in progress stops at wait mode entry. The transmission or reception resumes when either an internal or external interrupt brings the CPU out of wait mode. Exiting wait mode by reset aborts any transmission or reception in progress and resets the SCI.


### 8.1.3.3 Stop Mode

The SCI is inactive during stop mode for reduced power consumption. The STOP instruction does not affect the SCI register states, but the SCI bus clock will be disabled. The SCI operation resumes after an
external interrupt brings the CPU out of stop mode. Exiting stop mode by reset aborts any transmission or reception in progress and resets the SCI .

### 8.1.4 Block Diagram

Figure 8-1 is a high level block diagram of the SCI module, showing the interaction of various function blocks.


Figure 8-1. SCI Block Diagram

### 8.2 External Signal Description

The SCI module has a total of two external pins.

### 8.2.1 TXD — SCI Transmit Pin

The TXD pin transmits SCI (standard or infrared) data. It will idle high in either mode and is high impedance anytime the transmitter is disabled.

### 8.2.2 RXD - SCI Receive Pin

The RXD pin receives SCI (standard or infrared) data. An idle line is detected as a line high. This input is ignored when the receiver is disabled and should be terminated to a known voltage.

### 8.3 Memory Map and Register Definition

This subsection provides a detailed description of all the SCI registers.

### 8.3.1 Module Memory Map

The memory map for the SCI module is given in Figure 8-2. The address listed for each register is the address offset. The total address for each register is the sum of the base address for the SCI module and the address offset for each register.

### 8.3.2 Register Descriptions

This subsection consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Writes to reserved register locations do not have any effect and reads of these locations return a 0 . Details of register bit and field function follow the register diagrams, in bit order.


Figure 8-2. SCI Registers Summary


Figure 8-2. SCI Registers Summary

Chapter 8 Serial Communication Interface (SCIV3)

### 8.3.2.1 SCI Baud Rate Registers (SCIBDH and SCIBDL)



Figure 8-3. SCI Baud Rate Register High (SCIBDH)
Table 8-1. SCIBDH Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { IREN } \end{gathered}$ | Infrared Enable Bit - This bit enables/disables the infrared modulation/demodulation submodule. <br> 0 IR disabled <br> 1 IR enabled |
| $\begin{gathered} 6: 5 \\ \text { TNP[1:0] } \end{gathered}$ | Transmitter Narrow Pulse Bits — These bits determine if the SCI will transmit a 1/16, $3 / 16$ or $1 / 32$ narrow pulse. Refer to Table 8-3. |
| $\begin{gathered} 4: 0 \\ \text { SBR[11:8] } \end{gathered}$ | SCI Baud Rate Bits - The baud rate for the SCI is determined by the bits in this register. The baud rate is calculated two different ways depending on the state of the IREN bit. <br> The formulas for calculating the baud rate are: <br> When IREN $=0$ then, <br> SCI baud rate $=$ SCI module clock / (16 x SBR[12:0] $)$ <br> When IREN = 1 then, <br> SCI baud rate $=$ SCI module clock $/(32 \times$ SBR[12:1] $)$ |



Figure 8-4. SCI Baud Rate Register Low (SCIBDL)
Table 8-2. SCIBDL Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ |  |
| SBR[7:0] | SCI Baud Rate Bits - The baud rate for the SCI is determined by the bits in this register. The baud rate is <br> calculated two different ways depending on the state of the IREN bit. <br> The formulas for calculating the baud rate are: <br> When IREN $=0$ then, <br> SCI baud rate $=$ SCI module clock $/(16 \times$ SBR[12:0] $)$ <br> When IREN $=1$ then, <br> SCI baud rate $=$ SCI module clock $/(32 \times$ SBR[12:1] $)$ |
|  |  |

Read: anytime

## NOTE

If only SCIBDH is written to, a read will not return the correct data until SCIBDL is written to as well, following a write to SCIBDH.

Write: anytime
The SCI baud rate register is used to determine the baud rate of the SCI and to control the infrared modulation/demodulation submodule.

Table 8-3. IRSCI Transmit Pulse Width

| TNP[1:0] | Narrow Pulse Width |
| :---: | :---: |
| 11 | Reserved |
| 10 | $1 / 32$ |
| 01 | $1 / 16$ |
| 00 | $3 / 16$ |

## NOTE

The baud rate generator is disabled after reset and not started until the TE bit or the RE bit is set for the first time. The baud rate generator is disabled when $(\operatorname{SBR}[12: 0]=0$ and $\operatorname{IREN}=0)$ or $(\operatorname{SBR}[12: 1]=0$ and $\operatorname{IREN}=1)$.
Writing to SCIBDH has no effect without writing to SCIBDL, because writing to SCIBDH puts the data in a temporary location until SCIBDL is written to.

### 8.3.2.2 SCI Control Register 1 (SCICR1)



Figure 8-5. SCI Control Register 1 (SCICR1)
Read: anytime
Write: anytime

Table 8-4. SCICR1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { LOOPS } \end{gathered}$ | Loop Select Bit - LOOPS enables loop operation. In loop operation, the RXD pin is disconnected from the SCI and the transmitter output is internally connected to the receiver input. Both the transmitter and the receiver must be enabled to use the loop function. <br> 0 Normal operation enabled <br> 1 Loop operation enabled <br> The receiver input is determined by the RSRC bit. |
| $\begin{gathered} 6 \\ \text { SCISWAI } \end{gathered}$ | SCI Stop in Wait Mode Bit - SCISWAI disables the SCI in wait mode. <br> 0 SCl enabled in wait mode <br> 1 SCl disabled in wait mode |
| $\begin{gathered} 5 \\ \text { RSRC } \end{gathered}$ | Receiver Source Bit - When LOOPS = 1, the RSRC bit determines the source for the receiver shift register input. <br> 0 Receiver input internally connected to transmitter output <br> 1 Receiver input connected externally to transmitter <br> Refer to Table 8-5. |
| $\begin{aligned} & \hline 4 \\ & M \end{aligned}$ | Data Format Mode Bit - MODE determines whether data characters are eight or nine bits long. <br> 0 One start bit, eight data bits, one stop bit <br> 1 One start bit, nine data bits, one stop bit |
| $\begin{gathered} 3 \\ \text { WAKE } \end{gathered}$ | Wakeup Condition Bit - WAKE determines which condition wakes up the SCI: a logic 1 (address mark) in the most significant bit position of a received data character or an idle condition on the RXD pin. <br> 0 Idle line wakeup <br> 1 Address mark wakeup |
| $\begin{gathered} 2 \\ \text { ILT } \end{gathered}$ | Idle Line Type Bit - ILT determines when the receiver starts counting logic 1 s as idle character bits. The counting begins either after the start bit or after the stop bit. If the count begins after the start bit, then a string of logic 1s preceding the stop bit may cause false recognition of an idle character. Beginning the count after the stop bit avoids false idle character recognition, but requires properly synchronized transmissions. <br> 0 Idle character bit count begins after start bit <br> 1 Idle character bit count begins after stop bit |
| $\begin{gathered} \hline 1 \\ \text { PE } \end{gathered}$ | Parity Enable Bit - PE enables the parity function. When enabled, the parity function inserts a parity bit in the most significant bit position. <br> 0 Parity function disabled <br> 1 Parity function enabled |
| $\begin{gathered} \hline 0 \\ \text { PT } \end{gathered}$ | Parity Type Bit — PT determines whether the SCI generates and checks for even parity or odd parity. With even parity, an even number of 1 s clears the parity bit and an odd number of 1 s sets the parity bit. With odd parity, an odd number of 1 s clears the parity bit and an even number of 1 s sets the parity bit. <br> 0 Even parity <br> 1 Odd parity |

Table 8-5. Loop Functions

| LOOPS | RSRC | Function |
| :---: | :---: | :--- |
| 0 | $x$ | Normal operation |
| 1 | 0 | Loop mode with transmitter output internally connected to receiver input |
| 1 | 1 | Single-wire mode with TXD pin connected to receiver input |

### 8.3.2.3 SCI Control Register 2 (SCICR2)



Figure 8-6. SCI Control Register 2 (SCICR2)
Read: anytime
Write: anytime
Table 8-6. SCICR2 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { TIE } \end{gathered}$ | Transmitter Interrupt Enable Bit -TIE enables the transmit data register empty flag, TDRE, to generate interrupt requests. <br> 0 TDRE interrupt requests disabled <br> 1 TDRE interrupt requests enabled |
| $\begin{gathered} 6 \\ \text { TCIE } \end{gathered}$ | Transmission Complete Interrupt Enable Bit - TCIE enables the transmission complete flag, TC, to generate interrupt requests. <br> 0 TC interrupt requests disabled <br> 1 TC interrupt requests enabled |
| $\begin{gathered} 5 \\ \text { RIE } \end{gathered}$ | Receiver Full Interrupt Enable Bit — RIE enables the receive data register full flag, RDRF, or the overrun flag, OR, to generate interrupt requests. <br> 0 RDRF and OR interrupt requests disabled <br> 1 RDRF and OR interrupt requests enabled |
| $\begin{gathered} 4 \\ \hline \text { ILIE } \end{gathered}$ | Idle Line Interrupt Enable Bit - ILIE enables the idle line flag, IDLE, to generate interrupt requests. <br> 0 IDLE interrupt requests disabled <br> 1 IDLE interrupt requests enabled |
| $\begin{gathered} 3 \\ T E \end{gathered}$ | Transmitter Enable Bit - TE enables the SCI transmitter and configures the TXD pin as being controlled by the SCI. The TE bit can be used to queue an idle preamble. <br> 0 Transmitter disabled <br> 1 Transmitter enabled |
| $\begin{gathered} 2 \\ \mathrm{RE} \end{gathered}$ | Receiver Enable Bit - RE enables the SCI receiver. <br> 0 Receiver disabled <br> 1 Receiver enabled |
| $\begin{gathered} 1 \\ \text { RWU } \end{gathered}$ | Receiver Wakeup Bit - Standby state <br> 0 Normal operation. <br> 1 RWU enables the wakeup function and inhibits further receiver interrupt requests. Normally, hardware wakes the receiver by automatically clearing RWU. |
| $\begin{gathered} 0 \\ \text { SBK } \end{gathered}$ | Send Break Bit - Toggling SBK sends one break character (10 or 11 logic 0s, respectively 13 or 14 logics 0 s if BRK13 is set). Toggling implies clearing the SBK bit before the break character has finished transmitting. As long as SBK is set, the transmitter continues to send complete break characters ( 10 or 11 bits, respectively 13 or 14 bits). <br> 0 No break characters <br> 1 Transmit break characters |

### 8.3.2.4 SCI Status Register 1 (SCISR1)

The SCISR1 and SCISR2 registers provide inputs to the MCU for generation of SCI interrupts. Also, these registers can be polled by the MCU to check the status of these bits. The flag-clearing procedures require that the status register be read followed by a read or write to the SCI data register. It is permissible to execute other instructions between the two steps as long as it does not compromise the handling of I/O. Note that the order of operations is important for flag clearing.


Figure 8-7. SCI Status Register 1 (SCISR1)
Read: anytime
Write: has no meaning or effect
Table 8-7. SCISR1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { TDRE } \end{gathered}$ | Transmit Data Register Empty Flag - TDRE is set when the transmit shift register receives a byte from the SCI data register. When TDRE is 1 , the transmit data register (SCIDRH/L) is empty and can receive a new value to transmit.Clear TDRE by reading SCI status register 1 (SCISR1), with TDRE set and then writing to SCI data register low (SCIDRL). <br> 0 No byte transferred to transmit shift register <br> 1 Byte transferred to transmit shift register; transmit data register empty |
| $\begin{gathered} 6 \\ \text { TC } \end{gathered}$ | Transmit Complete Flag - TC is set low when there is a transmission in progress or when a preamble or break character is loaded. TC is set high when the TDRE flag is set and no data, preamble, or break character is being transmitted. When TC is set, the TXD pin becomes idle (logic 1). Clear TC by reading SCI status register 1 (SCISR1) with TC set and then writing to SCI data register low (SCIDRL). TC is cleared automatically when data, preamble, or break is queued and ready to be sent. TC is cleared in the event of a simultaneous set and clear of the TC flag (transmission not complete). <br> 0 Transmission in progress <br> 1 No transmission in progress |
| $\begin{gathered} 5 \\ \text { RDRF } \end{gathered}$ | Receive Data Register Full Flag — RDRF is set when the data in the receive shift register transfers to the SCI data register. Clear RDRF by reading SCI status register 1 (SCISR1) with RDRF set and then reading SCI data register low (SCIDRL). <br> 0 Data not available in SCl data register <br> 1 Received data available in SCl data register |
| $\begin{gathered} \hline 4 \\ \text { IDLE } \end{gathered}$ | Idle Line Flag ${ }^{1}$ — IDLE is set when 10 consecutive logic 1s (if $\mathrm{M}=0$ ) or 11 consecutive logic 1s (if $\mathrm{M}=1$ ) appear on the receiver input. After the IDLE flag is cleared, a valid frame must again set the RDRF flag before an idle condition can set the IDLE flag.Clear IDLE by reading SCI status register 1 (SCISR1) with IDLE set and then reading SCI data register low (SCIDRL). <br> 0 Receiver input is either active now or has never become active since the IDLE flag was last cleared <br> 1 Receiver input has become idle |

Table 8-7. SCISR1 Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 3 |  |
| OR | Overrun Flag ${ }^{2}$ —OR is set when software fails to read the SCI data register before the receive shift register <br> receives the next frame. The OR bit is set immediately after the stop bit has been completely received for the <br> second frame. The data in the shift register is lost, but the data already in the SCI data registers is not affected. <br> Clear OR by reading SCI status register 1 (SCISR1) with OR set and then reading SCI data register low <br> (SCIDRL). <br> 0 <br> 1 <br> 1 <br> No overrun |
| 2 | Noverrun |
| NF Foise Flag - NF is set when the SCI detects noise on the receiver input. NF bit is set during the same cycle as |  |
| the RDRF flag but does not get set in the case of an overrun. Clear NF by reading SCI status register 1(SCISR1), |  |
| and then reading SCI data register low (SCIDRL). |  |
| 0 | No noise |
| 1 | Noise |

[^3]
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### 8.3.2.5 SCI Status Register 2 (SCISR2)



Figure 8-8. SCI Status Register 2 (SCISR2)
Read: anytime
Write: anytime
Table 8-8. SCISR2 Field Descriptions

| Field | Description |
| :---: | :--- |
| 2 | Break Transmit Character Length - This bit determines whether the transmit break character is 10 or 11 bit <br> respectively 13 or 14 bits long. The detection of a framing error is not affected by this bit. <br> 0 <br> BRK13 <br> 1 <br> Break character is 10 or 11 bit long |
| 1 | Transmitter Pin Data Direction in Single-Wire Mode - This bit determines whether the TXD pin is going to <br> be used as an input or output, in the single-wire mode of operation. This bit is only relevant in the single-wire <br> mode of operation. <br> 0 |
| TXDIR pin to be used as an input in single-wire mode |  |
| 1 | TXD pin to be used as an output in single-wire mode |

### 8.3.2.6 SCI Data Registers (SCIDRH and SCIDRL)



Figure 8-9. SCI Data Register High (SCIDRH)

Table 8-9. SCIDRH Field Descriptions

| Field | Description |
| :---: | :---: |
| 7 | Received Bit 8 - R8 is the ninth data bit received when the SCI is configured for 9-bit data format $(\mathrm{M}=1)$. |
| $\mathrm{R8}$ |  |
| 6 | Transmit Bit 8 - T8 is the ninth data bit transmitted when the SCI is configured for 9-bit data format $(\mathrm{M}=1)$. |


|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | R7 | R6 | R5 | R4 | R3 | R2 | R1 | R0 |
| W | T7 | T6 | T5 | T4 | T3 | T2 | T1 | T0 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 8-10. SCI Data Register Low (SCIDRL)
Read: anytime; reading accesses SCI receive data register
Write: anytime; writing accesses SCI transmit data register; writing to R8 has no effect

Table 8-10. SCIDRL Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Received bits 7 through 0 - For 9-bit or 8-bit data formats |
| $\mathrm{R}[7: 0]$ | Transmit bits 7 through 0 - For 9-bit or 8-bit formats |
| $\mathrm{T}[7: 0\}$ |  |

## NOTE

If the value of T 8 is the same as in the previous transmission, T 8 does not have to be rewritten. The same value is transmitted until T8 is rewritten

In 8-bit data format, only SCI data register low (SCIDRL) needs to be accessed.

When transmitting in 9-bit data format and using 8-bit write instructions, write first to SCI data register high (SCIDRH) then to SCIDRL.

### 8.4 Functional Description

This subsection provides a complete functional description of the SCI block, detailing the operation of the design from the end user's perspective in a number of descriptions.

Figure 8-11 shows the structure of the SCI module. The SCI allows full duplex, asynchronous, serial communication between the CPU and remote devices, including other CPUs. The SCI transmitter and receiver operate independently, although they use the same baud rate generator. The CPU monitors the status of the SCI, writes the data to be transmitted, and processes received data.


Figure 8-11. Detailed SCI Block Diagram

### 8.4.1 Infrared Interface Submodule

This module provides the capability of transmitting narrow pulses to an IR LED and receiving narrow pulses and transforming them to serial bits, which are sent to the SCI. The IrDA physical layer specification defines a half-duplex infrared communication link for exchange data. The full standard includes data rates up to $16 \mathrm{Mbits} / \mathrm{s}$. This design covers only data rates between $2.4 \mathrm{kbits} / \mathrm{s}$ and 115.2 kbits/s.

The infrared submodule consists of two major blocks: the transmit encoder and the receive decoder. The SCI transmits serial bits of data which are encoded by the infrared submodule to transmit a narrow pulse for every 0 bit. No pulse is transmitted for every 1 bit. When receiving data, the IR pulses should be detected using an IR photo diode and transformed to CMOS levels by the IR receive decoder (external from the MCU). The narrow pulses are then stretched by the infrared submodule to get back to a serial bit stream to be received by the SCI. The polarity of transmitted pulses and expected receive pulses can be inverted so that a direct connection can be made to external IrDA transceiver modules that uses active low pulses.

The infrared submodule receives its clock sources from the SCI. One of these two clocks are selected in the infrared submodule in order to generate either $3 / 16,1 / 16$, or $1 / 32$ narrow pulses during transmission. The infrared block receives two clock sources from the SCI, R16XCLK, and R32XCLK, which are configured to generate the narrow pulse width during transmission. The R16XCLK and R32XCLK are internal clocks with frequencies 16 and 32 times the baud rate respectively. Both R16XCLK and R32XCLK clocks are used for transmitting data. The receive decoder uses only the R16XCLK clock.

### 8.4.1.1 Infrared Transmit Encoder

The infrared transmit encoder converts serial bits of data from transmit shift register to the TXD pin. A narrow pulse is transmitted for a 0 bit and no pulse for a 1 bit. The narrow pulse is sent in the middle of the bit with a duration of $1 / 32,1 / 16$, or $3 / 16$ of a bit time.

### 8.4.1.2 Infrared Receive Decoder

The infrared receive block converts data from the RXD pin to the receive shift register. A narrow pulse is expected for each 0 received and no pulse is expected for each 1 received. This receive decoder meets the edge jitter requirement as defined by the IrDA serial infrared physical layer specification.

### 8.4.2 Data Format

The SCI uses the standard NRZ mark/space data format. When Infrared is enabled, the SCI uses RZI data format where 0 s are represented by light pulses and 1s remain low. See Figure 8-12.

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Figure 8-12. SCI Data Formats
Each data character is contained in a frame that includes a start bit, eight or nine data bits, and a stop bit. Clearing the M bit in SCI control register 1 configures the SCI for 8-bit data characters. A frame with eight data bits has a total of 10 bits. Setting the M bit configures the SCI for nine-bit data characters. A frame with nine data bits has a total of 11 bits

Table 8-11. Example of 8-bit Data Formats

| Start <br> Bit | Data <br> Bits | Address <br> Bits | Parity <br> Bits | Stop <br> Bit |
| :---: | :---: | :---: | :---: | :---: |
| 1 | 8 | 0 | 0 | 1 |
| 1 | 7 | 0 | 1 | 1 |
| 1 | 7 | $1^{1}$ | 0 | 1 |

1 The address bit identifies the frame as an address character. See Section 8.4.5.6, "Receiver Wakeup".

When the SCI is configured for 9-bit data characters, the ninth data bit is the T8 bit in SCI data register high (SCIDRH). It remains unchanged after transmission and can be used repeatedly without rewriting it. A frame with nine data bits has a total of 11 bits.

Table 8-12. Example of 9-Bit Data Formats

| Start <br> Bit | Data <br> Bits | Address <br> Bits | Parity <br> Bits | Stop <br> Bit |
| :---: | :---: | :---: | :---: | :---: |
| 1 | 9 | 0 | 0 | 1 |
| 1 | 8 | 0 | 1 | 1 |
| 1 | 8 | $1^{1}$ | 0 | 1 |

1 The address bit identifies the frame as an address character. See Section 8.4.5.6, "Receiver Wakeup".

### 8.4.3 Baud Rate Generation

A 13-bit modulus counter in the baud rate generator derives the baud rate for both the receiver and the transmitter. The value from 0 to 8191 written to the $\operatorname{SBR}[12: 0]$ bits determines the module clock divisor. The SBR bits are in the SCI baud rate registers (SCIBDH and SCIBDL). The baud rate clock is synchronized with the bus clock and drives the receiver. The baud rate clock divided by 16 drives the transmitter. The receiver has an acquisition rate of 16 samples per bit time.

Baud rate generation is subject to one source of error:

- Integer division of the module clock may not give the exact target frequency.

Table 8-13 lists some examples of achieving target baud rates with a module clock frequency of 10.2 MHz .
When IREN $=0$ then,
SCI baud rate $=$ SCI module clock $/(16 * \operatorname{SCIBR[12:0]})$

Table 8-13. Baud Rates (Example: Module Clock $=\mathbf{1 0 . 2} \mathbf{~ M H z}$ )

| Bits <br> SBR[12-0] | Receiver <br> Clock (Hz) | Transmitter <br> Clock (Hz) | Target Baud <br> Rate | Error <br> (\%) |
| :---: | :---: | :---: | :---: | :---: |
| 17 | $600,000.0$ | $37,500.0$ | 38,400 | 2.3 |
| 33 | $309,090.9$ | $19,318.2$ | 19,200 | .62 |
| 66 | $154,545.5$ | 9659.1 | 9600 | .62 |
| 133 | $76,691.7$ | 4793.2 | 4800 | .14 |
| 266 | $38,345.9$ | 2396.6 | 2400 | .14 |
| 531 | $19,209.0$ | 1200.6 | 1200 | .11 |
| 1062 | 9604.5 | 600.3 | 600 | .05 |
| 2125 | 4800.0 | 300.0 | 300 | .00 |
| 4250 | 2400.0 | 150.0 | 150 | .00 |
| 5795 | 1760.1 | 110.0 | 110 | .00 |

### 8.4.4 Transmitter



Figure 8-13. Transmitter Block Diagram

### 8.4.4.1 Transmitter Character Length

The SCI transmitter can accommodate either 8-bit or 9-bit data characters. The state of the M bit in SCI control register 1 (SCICR1) determines the length of data characters. When transmitting 9-bit data, bit T8 in SCI data register high (SCIDRH) is the ninth bit (bit 8).

### 8.4.4.2 Character Transmission

To transmit data, the MCU writes the data bits to the SCI data registers (SCIDRH/SCIDRL), which in turn are transferred to the transmitter shift register. The transmit shift register then shifts a frame out through the TXD pin, after it has prefaced them with a start bit and appended them with a stop bit. The SCI data registers (SCIDRH and SCIDRL) are the write-only buffers between the internal data bus and the transmit shift register.

The SCI also sets a flag, the transmit data register empty flag (TDRE), every time it transfers data from the buffer (SCIDRH/L) to the transmitter shift register. The transmit driver routine may respond to this
flag by writing another byte to the transmitter buffer (SCIDRH/SCIDRL), while the shift register is shifting out the first byte.

To initiate an SCI transmission:

1. Configure the SCI :
a) Select a baud rate. Write this value to the SCI baud registers $(\mathrm{SCIBDH} / \mathrm{L})$ to begin the baud rate generator. Remember that the baud rate generator is disabled when the baud rate is 0 . Writing to the SCIBDH has no effect without also writing to SCIBDL.
b) Write to SCICR1 to configure word length, parity, and other configuration bits (LOOPS, RSRC, M, WAKE, ILT, PE, and PT).
c) Enable the transmitter, interrupts, receive, and wake up as required, by writing to the SCICR2 register bits (TIE, TCIE, RIE, ILIE, TE, RE, RWU, and SBK). A preamble or idle character will now be shifted out of the transmitter shift register.
2. Transmit procedure for each byte:
a) Poll the TDRE flag by reading the SCISR1 or responding to the TDRE interrupt. Keep in mind that the TDRE bit resets to 1 .
b) If the TDRE flag is set, write the data to be transmitted to SCIDRH/L, where the ninth bit is written to the T 8 bit in SCIDRH if the SCI is in 9-bit data format. A new transmission will not result until the TDRE flag has been cleared.
3. Repeat step 2 for each subsequent transmission.

## NOTE

The TDRE flag is set when the shift register is loaded with the next data to be transmitted from SCIDRH/L, which happens, generally speaking, a little over half-way through the stop bit of the previous frame. Specifically, this transfer occurs 9/16ths of a bit time AFTER the start of the stop bit of the previous frame.
Writing the TE bit from 0 to a 1 automatically loads the transmit shift register with a preamble of 10 logic 1s (if $M=0$ ) or 11 logic 1s (if $M=1$ ). After the preamble shifts out, control logic transfers the data from the SCI data register into the transmit shift register. A logic 0 start bit automatically goes into the least significant bit position of the transmit shift register. A logic 1 stop bit goes into the most significant bit position.
Hardware supports odd or even parity. When parity is enabled, the most significant bit (MSB) of the data character is the parity bit.

The transmit data register empty flag, TDRE, in SCI status register 1 (SCISR1) becomes set when the SCI data register transfers a byte to the transmit shift register. The TDRE flag indicates that the SCI data register can accept new data from the internal data bus. If the transmit interrupt enable bit, TIE, in SCI control register 2 (SCICR2) is also set, the TDRE flag generates a transmitter interrupt request.

When the transmit shift register is not transmitting a frame, the TXD pin goes to the idle condition, logic 1 . If at any time software clears the TE bit in SCI control register 2 (SCICR2), the transmitter enable signal goes low and the transmit signal goes idle.

If software clears TE while a transmission is in progress $(\mathrm{TC}=0)$, the frame in the transmit shift register continues to shift out. To avoid accidentally cutting off the last frame in a message, always wait for TDRE to go high after the last frame before clearing TE.

To separate messages with preambles with minimum idle line time, use this sequence between messages:

1. Write the last byte of the first message to SCIDRH/L.
2. Wait for the TDRE flag to go high, indicating the transfer of the last frame to the transmit shift register.
3. Queue a preamble by clearing and then setting the TE bit.
4. Write the first byte of the second message to SCIDRH/L.

### 8.4.4.3 Break Characters

Writing a logic 1 to the send break bit, SBK, in SCI control register 2 (SCICR2) loads the transmit shift register with a break character. A break character contains all logic 0 s and has no start, stop, or parity bit. Break character length depends on the M bit in SCI control register 1 (SCICR1). As long as SBK is at logic 1 , transmitter logic continuously loads break characters into the transmit shift register. After software clears the SBK bit, the shift register finishes transmitting the last break character and then transmits at least one logic 1. The automatic logic 1 at the end of a break character guarantees the recognition of the start bit of the next frame.

The SCI recognizes a break character when a start bit is followed by eight or nine logic 0 data bits and a logic 0 where the stop bit should be. Receiving a break character has these effects on SCI registers:

- Sets the framing error flag, FE
- Sets the receive data register full flag, RDRF
- Clears the SCI data registers (SCIDRH/L)
- May set the overrun flag, OR, noise flag, NF, parity error flag, PE, or the receiver active flag, RAF (see Section 8.3.2.4, "SCI Status Register 1 (SCISR1)" and Section 8.3.2.5, "SCI Status Register 2 (SCISR2)").


### 8.4.4.4 Idle Characters

An idle character (or preamble) contains all logic 1s and has no start, stop, or parity bit. Idle character length depends on the M bit in SCI control register 1 (SCICR1). The preamble is a synchronizing idle character that begins the first transmission initiated after writing the TE bit from 0 to 1 .

If the TE bit is cleared during a transmission, the TXD pin becomes idle after completion of the transmission in progress. Clearing and then setting the TE bit during a transmission queues an idle character to be sent after the frame currently being transmitted.

## NOTE

When queueing an idle character, return the TE bit to logic 1 before the stop bit of the current frame shifts out through the TXD pin. Setting TE after the stop bit appears on TXD causes data previously written to the SCI data register to be lost. Toggle the TE bit for a queued idle character while the

TDRE flag is set and immediately before writing the next byte to the SCI data register.

If the TE bit is clear and the transmission is complete, the SCI is not the master of the TXD pin

### 8.4.5 Receiver



Figure 8-14. SCI Receiver Block Diagram

### 8.4.5.1 Receiver Character Length

The SCI receiver can accommodate either 8-bit or 9-bit data characters. The state of the M bit in SCI control register 1 (SCICR1) determines the length of data characters. When receiving 9-bit data, bit R8 in SCI data register high (SCIDRH) is the ninth bit (bit 8).

### 8.4.5.2 Character Reception

During an SCI reception, the receive shift register shifts a frame in from the RXD pin. The SCI data register is the read-only buffer between the internal data bus and the receive shift register.

After a complete frame shifts into the receive shift register, the data portion of the frame transfers to the SCI data register. The receive data register full flag, RDRF, in SCI status register 1 (SCISR1) becomes set,
indicating that the received byte can be read. If the receive interrupt enable bit, RIE, in SCI control register 2 (SCICR2) is also set, the RDRF flag generates an RDRF interrupt request.

### 8.4.5.3 Data Sampling

The receiver samples the RXD pin at the RT clock rate. The RT clock is an internal signal with a frequency 16 times the baud rate. To adjust for baud rate mismatch, the RT clock (see Figure 8-15) is re-synchronized:

- After every start bit
- After the receiver detects a data bit change from logic 1 to logic 0 (after the majority of data bit samples at RT8, RT9, and RT10 returns a valid logic 1 and the majority of the next RT8, RT9, and RT10 samples returns a valid logic 0)

To locate the start bit, data recovery logic does an asynchronous search for a logic 0 preceded by three logic 1 s . When the falling edge of a possible start bit occurs, the RT clock begins to count to 16 .


Figure 8-15. Receiver Data Sampling
To verify the start bit and to detect noise, data recovery logic takes samples at RT3, RT5, and RT7.
Table 8-14 summarizes the results of the start bit verification samples.

Table 8-14. Start Bit Verification

| RT3, RT5, and RT7 Samples | Start Bit Verification | Noise Flag |
| :---: | :---: | :---: |
| 000 | Yes | 0 |
| 001 | Yes | 1 |
| 010 | Yes | 1 |
| 011 | No | 0 |
| 100 | Yes | 1 |
| 101 | No | 0 |
| 110 | No | 0 |
| 111 | No | 0 |

If start bit verification is not successful, the RT clock is reset and a new search for a start bit begins.

To determine the value of a data bit and to detect noise, recovery logic takes samples at RT8, RT9, and RT10. Table 8-15 summarizes the results of the data bit samples.

Table 8-15. Data Bit Recovery

| RT8, RT9, and RT10 Samples | Data Bit Determination | Noise Flag |
| :---: | :---: | :---: |
| 000 | 0 | 0 |
| 001 | 0 | 1 |
| 010 | 0 | 1 |
| 011 | 1 | 1 |
| 100 | 0 | 1 |
| 101 | 1 | 1 |
| 110 | 1 | 1 |
| 111 | 1 | 0 |

NOTE
The RT8, RT9, and RT10 samples do not affect start bit verification. If any or all of the RT8, RT9, and RT10 start bit samples are logic 1s following a successful start bit verification, the noise flag (NF) is set and the receiver assumes that the bit is a start bit $(\operatorname{logic} 0)$.

To verify a stop bit and to detect noise, recovery logic takes samples at RT8, RT9, and RT10. Table 8-16 summarizes the results of the stop bit samples.

Table 8-16. Stop Bit Recovery

| RT8, RT9, and RT10 Samples | Framing Error Flag | Noise Flag |
| :---: | :---: | :---: |
| 000 | 1 | 0 |
| 001 | 1 | 1 |
| 010 | 1 | 1 |
| 011 | 0 | 1 |
| 100 | 1 | 1 |
| 101 | 0 | 1 |
| 110 | 0 | 1 |
| 111 | 0 | 0 |

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In Figure 8-16 the verification samples RT3 and RT5 determine that the first low detected was noise and not the beginning of a start bit. The RT clock is reset and the start bit search begins again. The noise flag is not set because the noise occurred before the start bit was found.


Figure 8-16. Start Bit Search Example 1
In Figure 8-17, verification sample at RT3 is high. The RT3 sample sets the noise flag. Although the perceived bit time is misaligned, the data samples RT8, RT9, and RT10 are within the bit time and data recovery is successful.


Figure 8-17. Start Bit Search Example 2

In Figure 8-18, a large burst of noise is perceived as the beginning of a start bit, although the test sample at RT5 is high. The RT5 sample sets the noise flag. Although this is a worst-case misalignment of perceived bit time, the data samples RT8, RT9, and RT10 are within the bit time and data recovery is successful.


Figure 8-18. Start Bit Search Example 3
Figure 8-19 shows the effect of noise early in the start bit time. Although this noise does not affect proper synchronization with the start bit time, it does set the noise flag.


Figure 8-19. Start Bit Search Example 4

Figure 8-20 shows a burst of noise near the beginning of the start bit that resets the RT clock. The sample after the reset is low but is not preceded by three high samples that would qualify as a falling edge.
Depending on the timing of the start bit search and on the data, the frame may be missed entirely or it may set the framing error flag.


Figure 8-20. Start Bit Search Example 5
In Figure 8-21, a noise burst makes the majority of data samples RT8, RT9, and RT10 high. This sets the noise flag but does not reset the RT clock. In start bits only, the RT8, RT9, and RT10 data samples are ignored.


Figure 8-21. Start Bit Search Example 6

### 8.4.5.4 Framing Errors

If the data recovery logic does not detect a logic 1 where the stop bit should be in an incoming frame, it sets the framing error flag, FE, in SCI status register 1 (SCISR1). A break character also sets the FE flag because a break character has no stop bit. The FE flag is set at the same time that the RDRF flag is set.

### 8.4.5.5 Baud Rate Tolerance

A transmitting device may be operating at a baud rate below or above the receiver baud rate. Accumulated bit time misalignment can cause one of the three stop bit data samples (RT8, RT9, and RT10) to fall outside the actual stop bit. A noise error will occur if the RT8, RT9, and RT10 samples are not all the same logical values. A framing error will occur if the receiver clock is misaligned in such a way that the majority of the RT8, RT9, and RT10 stop bit samples are a logic 0 .

As the receiver samples an incoming frame, it re-synchronizes the RT clock on any valid falling edge within the frame. Re synchronization within frames will correct a misalignment between transmitter bit times and receiver bit times.

### 8.4.5.5.1 Slow Data Tolerance

Figure 8-22 shows how much a slow received frame can be misaligned without causing a noise error or a framing error. The slow stop bit begins at RT8 instead of RT1 but arrives in time for the stop bit data samples at RT8, RT9, and RT10.


Figure 8-22. Slow Data
Let's take RTr as receiver RT clock and RTt as transmitter RT clock.
For an 8-bit data character, it takes the receiver 9 bit times x 16 RTr cycles +7 RTr cycles $=151 \mathrm{RTr}$ cycles to start data sampling of the stop bit.
With the misaligned character shown in Figure 8-22, the receiver counts 151 RTr cycles at the point when the count of the transmitting device is 9 bit times $\times 16$ RTt cycles $=144 \mathrm{RTt}$ cycles.

The maximum percent difference between the receiver count and the transmitter count of a slow 8-bit data character with no errors is:

$$
((151-144) / 151) \times 100=4.63 \%
$$

For a 9-bit data character, it takes the receiver 10 bit times $x 16 \mathrm{RTr}$ cycles +7 RTr cycles $=167 \mathrm{RTr}$ cycles to start data sampling of the stop bit.

With the misaligned character shown in Figure 8-22, the receiver counts 167 RTr cycles at the point when the count of the transmitting device is 10 bit times $x 16 \mathrm{RTt}$ cycles $=160 \mathrm{RTt}$ cycles.
The maximum percent difference between the receiver count and the transmitter count of a slow 9-bit character with no errors is:

$$
((167-160) / 167) \times 100=4.19 \%
$$

### 8.4.5.5.2 Fast Data Tolerance

Figure 8-23 shows how much a fast received frame can be misaligned. The fast stop bit ends at RT10 instead of RT16 but continues to be sampled at RT8, RT9, and RT10.


Figure 8-23. Fast Data
For an 8-bit data character, it takes the receiver 9 bit times $\times 16 \mathrm{RTr}$ cycles +10 RTr cycles $=154 \mathrm{RTr}$ cycles to finish data sampling of the stop bit.

With the misaligned character shown in Figure 8-23, the receiver counts 154 RTr cycles at the point when the count of the transmitting device is 10 bit times $x 16 \mathrm{RTt}$ cycles $=160 \mathrm{RTt}$ cycles.

The maximum percent difference between the receiver count and the transmitter count of a fast 8-bit character with no errors is:

$$
((160-154) / 160) \times 100=3.75 \%
$$

For a 9-bit data character, it takes the receiver 10 bit times x 16 RTr cycles +10 RTr cycles $=170 \mathrm{RTr}$ cycles to finish data sampling of the stop bit.

With the misaligned character shown in Figure 8-23, the receiver counts 170 RTr cycles at the point when the count of the transmitting device is 11 bit times $\times 16 \mathrm{RTt}$ cycles $=176 \mathrm{RTt}$ cycles.

The maximum percent difference between the receiver count and the transmitter count of a fast 9-bit character with no errors is:

$$
((176-170) / 176) \times 100=3.40 \%
$$

### 8.4.5.6 Receiver Wakeup

To enable the SCI to ignore transmissions intended only for other receivers in multiple-receiver systems, the receiver can be put into a standby state. Setting the receiver wakeup bit, RWU, in SCI control register 2 (SCICR2) puts the receiver into standby state during which receiver interrupts are disabled.The SCI will continue to load the receive data into the SCIDRH/L registers, but it will not set the RDRF flag.

The transmitting device can address messages to selected receivers by including addressing information in the initial frame or frames of each message.

The WAKE bit in SCI control register 1 (SCICR1) determines how the SCI is brought out of the standby state to process an incoming message. The WAKE bit enables either idle line wakeup or address mark wakeup.

### 8.4.5.6.1 Idle Input Line Wakeup (WAKE = 0)

In this wakeup method, an idle condition on the RXD pin clears the RWU bit and wakes up the SCI. The initial frame or frames of every message contain addressing information. All receivers evaluate the addressing information, and receivers for which the message is addressed process the frames that follow. Any receiver for which a message is not addressed can set its RWU bit and return to the standby state. The RWU bit remains set and the receiver remains on standby until another idle character appears on the RXD pin.

Idle line wakeup requires that messages be separated by at least one idle character and that no message contains idle characters.

The idle character that wakes a receiver does not set the receiver idle bit, IDLE, or the receive data register full flag, RDRF.

The idle line type bit, ILT, determines whether the receiver begins counting logic 1 s as idle character bits after the start bit or after the stop bit. ILT is in SCI control register 1 (SCICR1).

### 8.4.5.6.2 Address Mark Wakeup (WAKE =1)

In this wakeup method, a logic 1 in the most significant bit (MSB) position of a frame clears the RWU bit and wakes up the SCI. The logic 1 in the MSB position marks a frame as an address frame that contains addressing information. All receivers evaluate the addressing information, and the receivers for which the message is addressed process the frames that follow. Any receiver for which a message is not addressed can set its RWU bit and return to the standby state. The RWU bit remains set and the receiver remains on standby until another address frame appears on the RXD pin.

The logic 1 MSB of an address frame clears the receiver's RWU bit before the stop bit is received and sets the RDRF flag.
Address mark wakeup allows messages to contain idle characters but requires that the MSB be reserved for use in address frames.

## NOTE

With the WAKE bit clear, setting the RWU bit after the RXD pin has been idle can cause the receiver to wake up immediately.

### 8.4.6 Single-Wire Operation

Normally, the SCI uses two pins for transmitting and receiving. In single-wire operation, the RXD pin is disconnected from the SCI. The SCI uses the TXD pin for both receiving and transmitting.


Figure 8-24. Single-Wire Operation (LOOPS =1, RSRC = 1)

Enable single-wire operation by setting the LOOPS bit and the receiver source bit, RSRC, in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the RXD pin to the receiver. Setting the RSRC bit connects the TXD pin to the receiver. Both the transmitter and receiver must be enabled ( $\mathrm{TE}=1$ and $\mathrm{RE}=1$ ). The TXDIR bit (SCISR2[1]) determines whether the TXD pin is going to be used as an input $(\mathrm{TXDIR}=0)$ or an output $(\mathrm{TXDIR}=1)$ in this mode of operation.

### 8.4.7 Loop Operation

In loop operation the transmitter output goes to the receiver input. The RXD pin is disconnected from the SCI


Figure 8-25. Loop Operation (LOOPS $=1$, RSRC $=0$ )
Enable loop operation by setting the LOOPS bit and clearing the RSRC bit in SCI control register 1 (SCICR1). Setting the LOOPS bit disables the path from the RXD pin to the receiver. Clearing the RSRC bit connects the transmitter output to the receiver input. Both the transmitter and receiver must be enabled ( $\mathrm{TE}=1$ and $\mathrm{RE}=1$ ).

### 8.5 Interrupts

This section describes the interrupt originated by the SCI block.The MCU must service the interrupt requests. Table 8-17 lists the five interrupt sources of the SCI.

Table 8-17. SCI Interrupt Sources

| Interrupt | Source | Local Enable | Description |
| :---: | :---: | :---: | :--- |
| TDRE | SCISR1[7] | TIE | Active high level. Indicates that a byte was <br> transferred from SCIDRH/L to the transmit <br> shift register. |
| TC | SCISR1[6] | TCIE | Active high level. Indicates that a transmit is <br> complete. |
| RDRF | SCISR1[5] | RIE | Active high level. The RDRF interrupt indicates <br> that received data is available in the SCI data <br> register. |
| OR | SCISR1[3] |  | Active high level. This interrupt indicates that <br> an overrun condition has occurred. |
| IDLE | SCISR1[4] | ILIE | Active high level. Indicates that receiver input <br> has become idle. |

### 8.5.1 Description of Interrupt Operation

The SCI only originates interrupt requests. The following is a description of how the SCI makes a request and how the MCU should acknowledge that request. The interrupt vector offset and interrupt number are
chip dependent. The SCI only has a single interrupt line (SCI interrupt signal, active high operation) and all the following interrupts, when generated, are ORed together and issued through that port.

### 8.5.1.1 TDRE Description

The TDRE interrupt is set high by the SCI when the transmit shift register receives a byte from the SCI data register. A TDRE interrupt indicates that the transmit data register (SCIDRH/L) is empty and that a new byte can be written to the SCIDRH/L for transmission.Clear TDRE by reading SCI status register 1 with TDRE set and then writing to SCI data register low (SCIDRL).

### 8.5.1.2 TC Description

The TC interrupt is set by the SCI when a transmission has been completed.A TC interrupt indicates that there is no transmission in progress. TC is set high when the TDRE flag is set and no data, preamble, or break character is being transmitted. When TC is set, the TXD pin becomes idle (logic 1). Clear TC by reading SCI status register 1 (SCISR1) with TC set and then writing to SCI data register low (SCIDRL).TC is cleared automatically when data, preamble, or break is queued and ready to be sent.

### 8.5.1.3 RDRF Description

The RDRF interrupt is set when the data in the receive shift register transfers to the SCI data register. A RDRF interrupt indicates that the received data has been transferred to the SCI data register and that the byte can now be read by the MCU. The RDRF interrupt is cleared by reading the SCI status register one (SCISR1) and then reading SCI data register low (SCIDRL).

### 8.5.1.4 OR Description

The OR interrupt is set when software fails to read the SCI data register before the receive shift register receives the next frame. The newly acquired data in the shift register will be lost in this case, but the data already in the SCI data registers is not affected. The OR interrupt is cleared by reading the SCI status register one (SCISR1) and then reading SCI data register low (SCIDRL).

### 8.5.1.5 IDLE Description

The IDLE interrupt is set when 10 consecutive logic 1s (if $M=0$ ) or 11 consecutive logic 1 s (if $\mathrm{M}=1$ ) appear on the receiver input. After the IDLE is cleared, a valid frame must again set the RDRF flag before an idle condition can set the IDLE flag. Clear IDLE by reading SCI status register 1 (SCISR1) with IDLE set and then reading SCI data register low (SCIDRL).

### 8.5.2 Recovery from Wait Mode

The SCI interrupt request can be used to bring the CPU out of wait mode.

## Chapter 9 Serial Peripheral Interface (SPIV3)

### 9.1 Introduction

The SPI module allows a duplex, synchronous, serial communication between the MCU and peripheral devices. Software can poll the SPI status flags or the SPI operation can be interrupt driven.

### 9.1.1 Features

The SPIV3 includes these distinctive features:

- Master mode and slave mode
- Bidirectional mode
- Slave select output
- Mode fault error flag with CPU interrupt capability
- Double-buffered data register
- Serial clock with programmable polarity and phase
- Control of SPI operation during wait mode


### 9.1.2 Modes of Operation

The SPI functions in three modes, run, wait, and stop.

- Run Mode

This is the basic mode of operation.

- Wait Mode

SPI operation in wait mode is a configurable low power mode, controlled by the SPISWAI bit located in the SPICR2 register. In wait mode, if the SPISWAI bit is clear, the SPI operates like in Run Mode. If the SPISWAI bit is set, the SPI goes into a power conservative state, with the SPI clock generation turned off. If the SPI is configured as a master, any transmission in progress stops, but is resumed after CPU goes into Run Mode. If the SPI is configured as a slave, reception and transmission of a byte continues, so that the slave stays synchronized to the master.

- Stop Mode

The SPI is inactive in stop mode for reduced power consumption. If the SPI is configured as a master, any transmission in progress stops, but is resumed after CPU goes into run mode. If the SPI is configured as a slave, reception and transmission of a byte continues, so that the slave stays synchronized to the master.

This is a high level description only, detailed descriptions of operating modes are contained in Section 9.4, "Functional Description."

## Chapter 9 Serial Peripheral Interface (SPIV3)

### 9.1.3 Block Diagram

Figure 9-1 gives an overview on the SPI architecture. The main parts of the SPI are status, control, and data registers, shifter logic, baud rate generator, master/slave control logic, and port control logic.


Figure 9-1. SPI Block Diagram

### 9.2 External Signal Description

This section lists the name and description of all ports including inputs and outputs that do, or may, connect off chip. The SPIV3 module has a total of four external pins.

### 9.2.1 MOSI — Master Out/Slave In Pin

This pin is used to transmit data out of the SPI module when it is configured as a master and receive data when it is configured as slave.

### 9.2.2 MISO — Master In/Slave Out Pin

This pin is used to transmit data out of the SPI module when it is configured as a slave and receive data when it is configured as master.

### 9.2.3 $\quad \overline{S S}$ - Slave Select Pin

This pin is used to output the select signal from the SPI module to another peripheral with which a data transfer is to take place when its configured as a master and its used as an input to receive the slave select signal when the SPI is configured as slave.

### 9.2.4 SCK — Serial Clock Pin

This pin is used to output the clock with respect to which the SPI transfers data or receive clock in case of slave.

### 9.3 Memory Map and Register Definition

This section provides a detailed description of address space and registers used by the SPI.
The memory map for the SPIV3 is given below in Table 9-1. The address listed for each register is the sum of a base address and an address offset. The base address is defined at the SoC level and the address offset is defined at the module level. Reads from the reserved bits return zeros and writes to the reserved bits have no effect.

### 9.3.1 Module Memory Map

Table 9-1. SPIV3 Memory Map

| Address | Use | Access |
| :---: | :--- | :---: |
| $0 \times 0000$ | SPI Control Register 1 (SPICR1) | $\mathrm{R} / \mathrm{W}$ |
| $0 \times 0001$ | SPI Control Register 2 (SPICR2) | $\mathrm{R} / \mathrm{W}^{1}$ |
| $0 \times 0002$ | SPI Baud Rate Register (SPIBR) | $\mathrm{R} / \mathrm{W}^{1}$ |
| $0 \times 0003$ | SPI Status Register (SPISR) | $\mathrm{R}^{2}$ |
| $0 \times 0004$ | Reserved | $-{ }^{2,3}$ |
| $0 \times 0005$ | SPI Data Register (SPIDR) | $\mathrm{R} / \mathrm{W}$ |
| $0 \times 0006$ | Reserved | $-{ }^{2,3}$ |
| $0 \times 0007$ | Reserved | $-{ }^{2,3}$ |

[^4]
### 9.3.2 Register Descriptions

This section consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in bit order.

| Name |  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SPICR1 | R W | SPIE | SPE | SPTIE | MSTR | CPOL | CPHA | SSOE | LSBFE |
| SPICR2 | R | 0 | 0 | 0 | MODFEN | BIDIROE | 0 | SPISWAI | SPCO |
|  | W |  |  |  |  |  |  |  |  |
| SPIBR | R | 0 | SPPR2 | SPPR1 | SPPR0 | 0 | SPR2 | SPR1 | SPRO |
|  | w |  |  |  |  |  |  |  |  |
| SPISR | R | SPIF | 0 | SPTEF | MODF | 0 | 0 | 0 | 0 |
|  | W |  |  |  |  |  |  |  |  |
| Reserved | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ |  |  |  |  |  |  |  |  |
| SPIDR | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 2 | Bit 0 |
| Reserved | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ |  |  |  |  |  |  |  |  |
| Reserved | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ |  |  |  |  |  |  |  |  |
|  |  |  | = Unimplemented or Reserved |  |  |  |  |  |  |

Figure 9-2. SPI Register Summary

### 9.3.2.1 SPI Control Register 1 (SPICR1)



Figure 9-3. SPI Control Register 1 (SPICR1)
Read: anytime
Write: anytime

Table 9-2. SPICR1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { SPIE } \end{gathered}$ | SPI Interrupt Enable Bit — This bit enables SPI interrupt requests, if SPIF or MODF status flag is set. <br> 0 SPI interrupts disabled. <br> 1 SPI interrupts enabled. |
| $\begin{gathered} \hline 6 \\ \text { SPE } \end{gathered}$ | SPI System Enable Bit - This bit enables the SPI system and dedicates the SPI port pins to SPI system functions. If SPE is cleared, SPI is disabled and forced into idle state, status bits in SPISR register are reset. 0 SPI disabled (lower power consumption). <br> 1 SPI enabled, port pins are dedicated to SPI functions. |
| $\begin{gathered} 5 \\ \text { SPTIE } \end{gathered}$ | SPI Transmit Interrupt Enable - This bit enables SPI interrupt requests, if SPTEF flag is set. <br> 0 SPTEF interrupt disabled. <br> 1 SPTEF interrupt enabled. |
| $\begin{gathered} 4 \\ \text { MSTR } \end{gathered}$ | SPI Master/Slave Mode Select Bit — This bit selects, if the SPI operates in master or slave mode. Switching the SPI from master to slave or vice versa forces the SPI system into idle state. <br> 0 SPI is in slave mode <br> 1 SPI is in master mode |
| $\stackrel{3}{\mathrm{CPOL}}$ | SPI Clock Polarity Bit - This bit selects an inverted or non-inverted SPI clock. To transmit data between SPI modules, the SPI modules must have identical CPOL values. In master mode, a change of this bit will abort a transmission in progress and force the SPI system into idle state. <br> 0 Active-high clocks selected. In idle state SCK is low. <br> 1 Active-low clocks selected. In idle state SCK is high. |
| $\stackrel{2}{\mathrm{CPHA}}$ | SPI Clock Phase Bit - This bit is used to select the SPI clock format. In master mode, a change of this bit will abort a transmission in progress and force the SPI system into idle state. <br> 0 Sampling of data occurs at odd edges $(1,3,5, \ldots, 15)$ of the SCK clock <br> 1 Sampling of data occurs at even edges $(2,4,6, \ldots, 16)$ of the SCK clock |
| $\begin{gathered} 1 \\ \text { SSOE } \end{gathered}$ | Slave Select Output Enable - The $\overline{\mathrm{SS}}$ output feature is enabled only in master mode, if MODFEN is set, by asserting the SSOE as shown in Table 9-3. In master mode, a change of this bit will abort a transmission in progress and force the SPI system into idle state. |
| $\begin{gathered} 0 \\ \text { LSBFE } \end{gathered}$ | LSB-First Enable - This bit does not affect the position of the MSB and LSB in the data register. Reads and writes of the data register always have the MSB in bit 7. In master mode, a change of this bit will abort a transmission in progress and force the SPI system into idle state. <br> 0 Data is transferred most significant bit first. <br> 1 Data is transferred least significant bit first. |

Table 9-3. $\overline{\text { SS }}$ Input / Output Selection

| MODFEN | SSOE | Master Mode | Slave Mode |
| :---: | :---: | :---: | :---: |
| 0 | 0 | $\overline{\mathrm{SS}}$ not used by SPI | $\overline{\mathrm{SS}}$ input |
| 0 | 1 | $\overline{\mathrm{SS}}$ not used by SPI | $\overline{\mathrm{SS}}$ input |
| 1 | 0 | $\overline{\mathrm{SS}}$ input with MODF feature | $\overline{\mathrm{SS}}$ input |
| 1 | 1 | $\overline{\mathrm{SS}}$ is slave select output | $\overline{\mathrm{SS}}$ input |

### 9.3.2.2 SPI Control Register 2 (SPICR2)



Figure 9-4. SPI Control Register 2 (SPICR2)
Read: anytime
Write: anytime; writes to the reserved bits have no effect
Table 9-4. SPICR2 Field Descriptions

| Field | Description |
| :---: | :--- |
| 4 |  |
| MODFEN | Mode Fault Enable Bit - This bit allows the MODF failure being detected. If the SPI is in master mode and <br> MODFEN is cleared, then the $\overline{\text { SS }}$ port pin is not used by the SPI. In slave mode, the $\overline{\text { SS is available only as an }}$ <br> input regardless of the value of MODFEN. For an overview on the impact of the MODFEN bit on the SS port pin <br> configuration refer to Table 9-3. In master mode, a change of this bit will abort a transmission in progress and <br> force the SPI system into idle state. <br> 0 <br> 1 <br> 1 <br> SS port pin is not used by the SPI |
| 3 | Output Enable in the Bidirectional Mode of Operation - This bit controls the MOSI and MISO output buffer <br> of the SPI, when in bidirectional mode of operation (SPCO is set). In master mode this bit controls the output <br> buffer of the MOSI port, in slave mode it controls the output buffer of the MISO port. In master mode, with SPCO <br> set, a change of this bit will abort a transmission in progress and force the SPI into idle state. <br> 0 <br> 1 <br> Output buffer disabled |
| BIDIROutput buffer enabled |  |

Table 9-5. Bidirectional Pin Configurations

| Pin Mode | SPCO | BIDIROE | MISO | MOSI |
| :---: | :---: | :---: | :---: | :---: |
| Master Mode of Operation |  |  |  |  |
| Normal | 0 | $X$ | Master In | Master Out |
| Bidirectional | 1 | 0 | MISO not used by SPI | Master In |
|  |  | 1 |  | Master I/O |
| Slave Mode of Operation |  |  |  |  |
| Normal | 0 | $X$ | Slave Out | Slave In |
| Bidirectional | 1 | 0 | Slave In | MOSI not used by SPI |
|  |  | 1 | Slave I/O |  |

### 9.3.2.3 SPI Baud Rate Register (SPIBR)



Figure 9-5. SPI Baud Rate Register (SPIBR)
Read: anytime
Write: anytime; writes to the reserved bits have no effect
Table 9-6. SPIBR Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 4$ | SPI Baud Rate Preselection Bits - These bits specify the SPI baud rates as shown in Table 9-7. In master <br> mode, a change of these bits will abort a transmission in progress and force the SPI system into idle state. |
| SPPR[2:0] | med |
| $2: 0$ | SPI Baud Rate Selection Bits - These bits specify the SPI baud rates as shown in Table 9-7. In master mode, <br> a change of these bits will abort a transmission in progress and force the SPI system into idle state. |

The baud rate divisor equation is as follows:

$$
\text { BaudRateDivisor }=(S P P R+1) \bullet 2^{(S P R+1)}
$$

The baud rate can be calculated with the following equation:
Baud Rate = BusClock/BaudRateDivisor

Table 9-7. Example SPI Baud Rate Selection ( $\mathbf{2 5} \mathbf{~ M H z ~ B u s ~ C l o c k ) ~}$

| SPPR2 | SPPR1 | SPPR0 | SPR2 | SPR1 | SPR0 | Baud Rate Divisor | Baud Rate |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | 0 | 0 | 2 | 12.5 MHz |
| 0 | 0 | 0 | 0 | 0 | 1 | 4 | 6.25 MHz |
| 0 | 0 | 0 | 0 | 1 | 0 | 8 | 3.125 MHz |
| 0 | 0 | 0 | 0 | 1 | 1 | 16 | 1.5625 MHz |
| 0 | 0 | 0 | 1 | 0 | 0 | 32 | 781.25 kHz |
| 0 | 0 | 0 | 1 | 0 | 1 | 64 | 390.63 kHz |
| 0 | 0 | 0 | 1 | 1 | 0 | 128 | 195.31 kHz |
| 0 | 0 | 0 | 1 | 1 | 1 | 256 | 97.66 kHz |
| 0 | 0 | 1 | 0 | 0 | 0 | 4 | 6.25 MHz |
| 0 | 0 | 1 | 0 | 0 | 1 | 8 | 3.125 MHz |
| 0 | 0 | 1 | 0 | 1 | 0 | 16 | 1.5625 MHz |
| 0 | 0 | 1 | 0 | 1 | 1 | 32 | 781.25 kHz |
| 0 | 0 | 1 | 1 | 0 | 0 | 64 | 390.63 kHz |
| 0 | 0 | 1 | 1 | 0 | 1 | 128 | 195.31 kHz |
| 0 | 0 | 1 | 1 | 1 | 0 | 256 | 97.66 kHz |
| 0 | 0 | 1 | 1 | 1 | 1 | 512 | 48.83 kHz |
| 0 | 1 | 0 | 0 | 0 | 0 | 6 | 4.16667 MHz |
| 0 | 1 | 0 | 0 | 0 | 1 | 12 | 2.08333 MHz |
| 0 | 1 | 0 | 0 | 1 | 0 | 24 | 1.04167 MHz |
| 0 | 1 | 0 | 0 | 1 | 1 | 48 | 520.83 kHz |
| 0 | 1 | 0 | 1 | 0 | 0 | 96 | 260.42 kHz |
| 0 | 1 | 0 | 1 | 0 | 1 | 192 | 130.21 kHz |
| 0 | 1 | 0 | 1 | 1 | 0 | 384 | 65.10 kHz |
| 0 | 1 | 0 | 1 | 1 | 1 | 768 | 32.55 kHz |
| 0 | 1 | 1 | 0 | 0 | 0 | 8 | 3.125 MHz |
| 0 | 1 | 1 | 0 | 0 | 1 | 16 | 1.5625 MHz |
| 0 | 1 | 1 | 0 | 1 | 0 | 32 | 781.25 kHz |
| 0 | 1 | 1 | 0 | 1 | 1 | 64 | 390.63 kHz |
| 0 | 1 | 1 | 1 | 0 | 0 | 128 | 195.31 kHz |
| 0 | 1 | 1 | 1 | 0 | 1 | 256 | 97.66 kHz |
| 0 | 1 | 1 | 1 | 1 | 0 | 512 | 48.83 kHz |
| 0 | 1 | 1 | 1 | 1 | 1 | 1024 | 24.41 kHz |
| 1 | 0 | 0 | 0 | 0 | 0 | 10 | 2.5 MHz |
| 1 | 0 | 0 | 0 | 0 | 1 | 20 | 1.25 MHz |
| 1 | 0 | 0 | 0 | 1 | 0 | 40 | 625 kHz |
| 1 | 0 | 0 | 0 | 1 | 1 | 80 | 312.5 kHz |
| 1 | 0 | 0 | 1 | 0 | 0 | 160 | 156.25 kHz |
| 1 | 0 | 0 | 1 | 0 | 1 | 320 | 78.13 kHz |
| 1 | 0 | 0 | 1 | 1 | 0 | 640 | 39.06 kHz |

Table 9-7. Example SPI Baud Rate Selection ( 25 MHz Bus Clock) (continued)

| SPPR2 | SPPR1 | SPPR0 | SPR2 | SPR1 | SPR0 | Baud Rate Divisor | Baud Rate |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 0 | 0 | 1 | 1 | 1 | 1280 | 19.53 kHz |
| 1 | 0 | 1 | 0 | 0 | 0 | 12 | 2.08333 MHz |
| 1 | 0 | 1 | 0 | 0 | 1 | 24 | 1.04167 MHz |
| 1 | 0 | 1 | 0 | 1 | 0 | 48 | 520.83 kHz |
| 1 | 0 | 1 | 0 | 1 | 1 | 96 | 260.42 kHz |
| 1 | 0 | 1 | 1 | 0 | 0 | 192 | 130.21 kHz |
| 1 | 0 | 1 | 1 | 0 | 1 | 384 | 65.10 kHz |
| 1 | 0 | 1 | 1 | 1 | 0 | 768 | 32.55 kHz |
| 1 | 0 | 1 | 1 | 1 | 1 | 1536 | 16.28 kHz |
| 1 | 1 | 0 | 0 | 0 | 0 | 14 | 1.78571 MHz |
| 1 | 1 | 0 | 0 | 0 | 1 | 28 | 892.86 kHz |
| 1 | 1 | 0 | 0 | 1 | 0 | 56 | 446.43 kHz |
| 1 | 1 | 0 | 0 | 1 | 1 | 112 | 223.21 kHz |
| 1 | 1 | 0 | 1 | 0 | 0 | 224 | 111.61 kHz |
| 1 | 1 | 0 | 1 | 0 | 1 | 448 | 55.80 kHz |
| 1 | 1 | 0 | 1 | 1 | 0 | 896 | 27.90 kHz |
| 1 | 1 | 0 | 1 | 1 | 1 | 1792 | 13.95 kHz |
| 1 | 1 | 1 | 0 | 0 | 0 | 16 | 1.5625 MHz |
| 1 | 1 | 1 | 0 | 0 | 1 | 32 | 781.25 kHz |
| 1 | 1 | 1 | 0 | 1 | 0 | 64 | 390.63 kHz |
| 1 | 1 | 1 | 0 | 1 | 1 | 128 | 195.31 kHz |
| 1 | 1 | 1 | 1 | 0 | 0 | 256 | 97.66 kHz |
| 1 | 1 | 1 | 1 | 0 | 1 | 512 | 48.83 kHz |
| 1 | 1 | 1 | 1 | 1 | 0 | 1024 | 24.41 kHz |
| 1 | 1 | 1 | 1 | 1 | 1 | 2048 | 12.21 kHz |

NOTE
In slave mode of SPI S-clock speed DIV2 is not supported.

### 9.3.2.4 SPI Status Register (SPISR)



Figure 9-6. SPI Status Register (SPISR)
Read: anytime
Write: has no effect
Table 9-8. SPISR Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} \hline 7 \\ \text { SPIF } \end{gathered}$ | SPIF Interrupt Flag - This bit is set after a received data byte has been transferred into the SPI Data Register. This bit is cleared by reading the SPISR register (with SPIF set) followed by a read access to the SPI Data Register. <br> 0 Transfer not yet complete <br> 1 New data copied to SPIDR |
| $\begin{gathered} 5 \\ \text { SPTEF } \end{gathered}$ | SPI Transmit Empty Interrupt Flag — If set, this bit indicates that the transmit data register is empty. To clear this bit and place data into the transmit data register, SPISR has to be read with SPTEF = 1, followed by a write to SPIDR. Any write to the SPI Data Register without reading SPTEF $=1$, is effectively ignored. <br> 0 SPI Data register not empty <br> 1 SPI Data register empty |
| $\begin{gathered} 4 \\ \text { MODF } \end{gathered}$ | Mode Fault Flag - This bit is set if the $\overline{S S}$ input becomes low while the SPI is configured as a master and mode fault detection is enabled, MODFEN bit of SPICR2 register is set. Refer to MODFEN bit description in <br> Section 9.3.2.2, "SPI Control Register 2 (SPICR2)." The flag is cleared automatically by a read of the SPI Status Register (with MODF set) followed by a write to the SPI Control Register 1. <br> 0 Mode fault has not occurred. <br> 1 Mode fault has occurred. |

### 9.3.2.5 SPI Data Register (SPIDR)



Figure 9-7. SPI Data Register (SPIDR)
Read: anytime; normally read only after SPIF is set
Write: anytime

The SPI Data Register is both the input and output register for SPI data. A write to this register allows a data byte to be queued and transmitted. For a SPI configured as a master, a queued data byte is transmitted immediately after the previous transmission has completed. The SPI Transmitter Empty Flag SPTEF in the SPISR register indicates when the SPI Data Register is ready to accept new data.

Reading the data can occur anytime from after the SPIF is set to before the end of the next transfer. If the SPIF is not serviced by the end of the successive transfers, those data bytes are lost and the data within the SPIDR retains the first byte until SPIF is serviced.

### 9.4 Functional Description

The SPI module allows a duplex, synchronous, serial communication between the MCU and peripheral devices. Software can poll the SPI status flags or SPI operation can be interrupt driven.

The SPI system is enabled by setting the SPI enable (SPE) bit in SPI Control Register 1. While SPE bit is set, the four associated SPI port pins are dedicated to the SPI function as:

- Slave select $(\overline{\mathrm{SS}})$
- Serial clock (SCK)
- Master out/slave in (MOSI)
- Master in/slave out (MISO)

The main element of the SPI system is the SPI Data Register. The 8 -bit data register in the master and the 8 -bit data register in the slave are linked by the MOSI and MISO pins to form a distributed 16-bit register. When a data transfer operation is performed, this 16-bit register is serially shifted eight bit positions by the S-clock from the master, so data is exchanged between the master and the slave. Data written to the master SPI Data Register becomes the output data for the slave, and data read from the master SPI Data Register after a transfer operation is the input data from the slave.

A read of SPISR with SPTEF $=1$ followed by a write to SPIDR puts data into the transmit data register. When a transfer is complete, received data is moved into the receive data register. Data may be read from this double-buffered system any time before the next transfer has completed. This 8-bit data register acts as the SPI receive data register for reads and as the SPI transmit data register for writes. A single SPI register address is used for reading data from the read data buffer and for writing data to the transmit data register.

The clock phase control bit (CPHA) and a clock polarity control bit (CPOL) in the SPI Control Register 1 (SPICR1) select one of four possible clock formats to be used by the SPI system. The CPOL bit simply selects a non-inverted or inverted clock. The CPHA bit is used to accommodate two fundamentally different protocols by sampling data on odd numbered SCK edges or on even numbered SCK edges (see Section 9.4.3, "Transmission Formats").

The SPI can be configured to operate as a master or as a slave. When the MSTR bit in SPI Control Register1 is set, master mode is selected, when the MSTR bit is clear, slave mode is selected.

### 9.4.1 Master Mode

The SPI operates in master mode when the MSTR bit is set. Only a master SPI module can initiate transmissions. A transmission begins by writing to the master SPI Data Register. If the shift register is empty, the byte immediately transfers to the shift register. The byte begins shifting out on the MOSI pin under the control of the serial clock.

- S-clock

The SPR2, SPR1, and SPR0 baud rate selection bits in conjunction with the SPPR2, SPPR1, and SPPR0 baud rate preselection bits in the SPI Baud Rate register control the baud rate generator and determine the speed of the transmission. The SCK pin is the SPI clock output. Through the SCK pin, the baud rate generator of the master controls the shift register of the slave peripheral.

- MOSI and MISO Pins

In master mode, the function of the serial data output pin (MOSI) and the serial data input pin (MISO) is determined by the SPC0 and BIDIROE control bits.

- $\overline{\mathrm{SS}}$ Pin

If MODFEN and SSOE bit are set, the $\overline{\mathrm{SS}}$ pin is configured as slave select output. The $\overline{\mathrm{SS}}$ output becomes low during each transmission and is high when the SPI is in idle state.
If MODFEN is set and SSOE is cleared, the $\overline{\mathrm{SS}}$ pin is configured as input for detecting mode fault error. If the $\overline{\mathrm{SS}}$ input becomes low this indicates a mode fault error where another master tries to drive the MOSI and SCK lines. In this case, the SPI immediately switches to slave mode, by clearing the MSTR bit and also disables the slave output buffer MISO (or SISO in bidirectional mode). So the result is that all outputs are disabled and SCK, MOSI and MISO are inputs. If a transmission is in progress when the mode fault occurs, the transmission is aborted and the SPI is forced into idle state.

This mode fault error also sets the mode fault (MODF) flag in the SPI Status Register (SPISR). If the SPI interrupt enable bit (SPIE) is set when the MODF flag gets set, then an SPI interrupt sequence is also requested.

When a write to the SPI Data Register in the master occurs, there is a half SCK-cycle delay. After the delay, SCK is started within the master. The rest of the transfer operation differs slightly, depending on the clock format specified by the SPI clock phase bit, CPHA, in SPI Control Register 1 (see Section 9.4.3, "Transmission Formats").

## NOTE

A change of the bits CPOL, CPHA, SSOE, LSBFE, MODFEN, SPC0, BIDIROE with SPC0 set, SPPR2-SPPR0 and SPR2-SPR0 in master mode will abort a transmission in progress and force the SPI into idle state. The remote slave cannot detect this, therefore the master has to ensure that the remote slave is set back to idle state.

### 9.4.2 Slave Mode

The SPI operates in slave mode when the MSTR bit in SPI Control Register1 is clear.

- SCK Clock

In slave mode, SCK is the SPI clock input from the master.

- MISO and MOSI Pins

In slave mode, the function of the serial data output pin (MISO) and serial data input pin (MOSI) is determined by the SPC0 bit and BIDIROE bit in SPI Control Register 2.

- $\overline{\text { SS Pin }}$

The $\overline{\mathrm{SS}}$ pin is the slave select input. Before a data transmission occurs, the $\overline{\mathrm{SS}}$ pin of the slave SPI must be low. $\overline{\mathrm{SS}}$ must remain low until the transmission is complete. If $\overline{\mathrm{SS}}$ goes high, the SPI is forced into idle state.
The $\overline{\mathrm{SS}}$ input also controls the serial data output pin, if $\overline{\mathrm{SS}}$ is high (not selected), the serial data output pin is high impedance, and, if $\overline{\mathrm{SS}}$ is low the first bit in the SPI Data Register is driven out of the serial data output pin. Also, if the slave is not selected ( $\overline{\mathrm{SS}}$ is high), then the SCK input is ignored and no internal shifting of the SPI shift register takes place.

Although the SPI is capable of duplex operation, some SPI peripherals are capable of only receiving SPI data in a slave mode. For these simpler devices, there is no serial data out pin.

## NOTE

When peripherals with duplex capability are used, take care not to simultaneously enable two receivers whose serial outputs drive the same system slave's serial data output line.

As long as no more than one slave device drives the system slave's serial data output line, it is possible for several slaves to receive the same transmission from a master, although the master would not receive return information from all of the receiving slaves.

If the CPHA bit in SPI Control Register 1 is clear, odd numbered edges on the SCK input cause the data at the serial data input pin to be latched. Even numbered edges cause the value previously latched from the serial data input pin to shift into the LSB or MSB of the SPI shift register, depending on the LSBFE bit.

If the CPHA bit is set, even numbered edges on the SCK input cause the data at the serial data input pin to be latched. Odd numbered edges cause the value previously latched from the serial data input pin to shift into the LSB or MSB of the SPI shift register, depending on the LSBFE bit.

When CPHA is set, the first edge is used to get the first data bit onto the serial data output pin. When CPHA is clear and the $\overline{\mathrm{SS}}$ input is low (slave selected), the first bit of the SPI data is driven out of the serial data output pin. After the eighth shift, the transfer is considered complete and the received data is transferred into the SPI Data Register. To indicate transfer is complete, the SPIF flag in the SPI Status Register is set.

## NOTE

A change of the bits CPOL, CPHA, SSOE, LSBFE, MODFEN, SPC0 and BIDIROE with SPC0 set in slave mode will corrupt a transmission in progress and has to be avoided.

### 9.4.3 Transmission Formats

During an SPI transmission, data is transmitted (shifted out serially) and received (shifted in serially) simultaneously. The serial clock (SCK) synchronizes shifting and sampling of the information on the two serial data lines. A slave select line allows selection of an individual slave SPI device, slave devices that are not selected do not interfere with SPI bus activities. Optionally, on a master SPI device, the slave select line can be used to indicate multiple-master bus contention.


Figure 9-8. Master/Slave Transfer Block Diagram

### 9.4.3.1 Clock Phase and Polarity Controls

Using two bits in the SPI Control Register1, software selects one of four combinations of serial clock phase and polarity.

The CPOL clock polarity control bit specifies an active high or low clock and has no significant effect on the transmission format.

The CPHA clock phase control bit selects one of two fundamentally different transmission formats.
Clock phase and polarity should be identical for the master SPI device and the communicating slave device. In some cases, the phase and polarity are changed between transmissions to allow a master device to communicate with peripheral slaves having different requirements.

### 9.4.3.2 CPHA $=0$ Transfer Format

The first edge on the SCK line is used to clock the first data bit of the slave into the master and the first data bit of the master into the slave. In some peripherals, the first bit of the slave's data is available at the slave's data out pin as soon as the slave is selected. In this format, the first SCK edge is issued a half cycle after $\overline{\mathrm{SS}}$ has become low.

A half SCK cycle later, the second edge appears on the SCK line. When this second edge occurs, the value previously latched from the serial data input pin is shifted into the LSB or MSB of the shift register, depending on LSBFE bit.

After this second edge, the next bit of the SPI master data is transmitted out of the serial data output pin of the master to the serial input pin on the slave. This process continues for a total of 16 edges on the SCK line, with data being latched on odd numbered edges and shifted on even numbered edges.

Data reception is double buffered. Data is shifted serially into the SPI shift register during the transfer and is transferred to the parallel SPI Data Register after the last bit is shifted in.

After the 16th (last) SCK edge:

- Data that was previously in the master SPI Data Register should now be in the slave data register and the data that was in the slave data register should be in the master.
- The SPIF flag in the SPI Status Register is set indicating that the transfer is complete.

Figure 9-9 is a timing diagram of an SPI transfer where CPHA $=0$. SCK waveforms are shown for $\mathrm{CPOL}=0$ and $\mathrm{CPOL}=1$. The diagram may be interpreted as a master or slave timing diagram because the SCK, MISO, and MOSI pins are connected directly between the master and the slave. The MISO signal is the output from the slave and the MOSI signal is the output from the master. The $\overline{\mathrm{SS}}$ pin of the master must be either high or reconfigured as a general-purpose output not affecting the SPI.


Figure 9-9. SPI Clock Format $0(C P H A=0)$
In slave mode, if the $\overline{\mathrm{SS}}$ line is not deasserted between the successive transmissions then the content of the SPI Data Register is not transmitted, instead the last received byte is transmitted. If the $\overline{\mathrm{SS}}$ line is deasserted for at least minimum idle time (half SCK cycle) between successive transmissions then the content of the SPI Data Register is transmitted.

In master mode, with slave select output enabled the $\overline{\mathrm{SS}}$ line is always deasserted and reasserted between successive transfers for at least minimum idle time.

### 9.4.3.3 CPHA = 1 Transfer Format

Some peripherals require the first SCK edge before the first data bit becomes available at the data out pin, the second edge clocks data into the system. In this format, the first SCK edge is issued by setting the CPHA bit at the beginning of the 8-cycle transfer operation.

The first edge of SCK occurs immediately after the half SCK clock cycle synchronization delay. This first edge commands the slave to transfer its first data bit to the serial data input pin of the master.

A half SCK cycle later, the second edge appears on the SCK pin. This is the latching edge for both the master and slave.

When the third edge occurs, the value previously latched from the serial data input pin is shifted into the LSB or MSB of the SPI shift register, depending on LSBFE bit. After this edge, the next bit of the master data is coupled out of the serial data output pin of the master to the serial input pin on the slave.

This process continues for a total of 16 edges on the SCK line with data being latched on even numbered edges and shifting taking place on odd numbered edges.

Data reception is double buffered, data is serially shifted into the SPI shift register during the transfer and is transferred to the parallel SPI Data Register after the last bit is shifted in.

After the 16th SCK edge:

- Data that was previously in the SPI Data Register of the master is now in the data register of the slave, and data that was in the data register of the slave is in the master.
- The SPIF flag bit in SPISR is set indicating that the transfer is complete.

Figure 9-10 shows two clocking variations for $\mathrm{CPHA}=1$. The diagram may be interpreted as a master or slave timing diagram because the SCK, MISO, and MOSI pins are connected directly between the master and the slave. The MISO signal is the output from the slave, and the MOSI signal is the output from the master. The $\overline{\mathrm{SS}}$ line is the slave select input to the slave. The $\overline{\mathrm{SS}}$ pin of the master must be either high or reconfigured as a general-purpose output not affecting the SPI.
The $\overline{\mathrm{SS}}$ line can remain active low between successive transfers (can be tied low at all times). This format is sometimes preferred in systems having a single fixed master and a single slave that drive the MISO data line.

- Back-to-back transfers in master mode

In master mode, if a transmission has completed and a new data byte is available in the SPI Data Register, this byte is send out immediately without a trailing and minimum idle time.

The SPI interrupt request flag (SPIF) is common to both the master and slave modes. SPIF gets set one half SCK cycle after the last SCK edge.


Figure 9-10. SPI Clock Format 1 (CPHA =1)

### 9.4.4 SPI Baud Rate Generation

Baud rate generation consists of a series of divider stages. Six bits in the SPI Baud Rate register (SPPR2, SPPR1, SPPR0, SPR2, SPR1, and SPR0) determine the divisor to the SPI module clock which results in the SPI baud rate.

The SPI clock rate is determined by the product of the value in the baud rate preselection bits (SPPR2-SPPR0) and the value in the baud rate selection bits (SPR2-SPR0). The module clock divisor equation is shown in Figure 9-11

When all bits are clear (the default condition), the SPI module clock is divided by 2 . When the selection bits (SPR2-SPR0) are 001 and the preselection bits (SPPR2-SPPR0) are 000, the module clock divisor becomes 4 . When the selection bits are 010 , the module clock divisor becomes 8 etc.

When the preselection bits are 001 , the divisor determined by the selection bits is multiplied by 2 . When the preselection bits are 010, the divisor is multiplied by 3, etc. See Table 9-7 for baud rate calculations for all bit conditions, based on a $25-\mathrm{MHz}$ bus clock. The two sets of selects allows the clock to be divided by a non-power of two to achieve other baud rates such as divide by 6 , divide by 10 , etc.

The baud rate generator is activated only when the SPI is in the master mode and a serial transfer is taking place. In the other cases, the divider is disabled to decrease $\mathrm{I}_{\mathrm{DD}}$ current.

$$
\text { BaudRateDivisor }=(\operatorname{SPPR}+1) \cdot 2^{(\mathrm{SPR}+1)}
$$

Figure 9-11. Baud Rate Divisor Equation

### 9.4.5 Special Features

### 9.4.5.1 $\overline{\text { SS Output }}$

The $\overline{\text { SS }}$ output feature automatically drives the $\overline{\mathrm{SS}}$ pin low during transmission to select external devices and drives it high during idle to deselect external devices. When $\overline{\mathrm{SS}}$ output is selected, the $\overline{\mathrm{SS}}$ output pin is connected to the $\overline{\mathrm{SS}}$ input pin of the external device.

The $\overline{\mathrm{SS}}$ output is available only in master mode during normal SPI operation by asserting SSOE and MODFEN bit as shown in Table 9-3.

The mode fault feature is disabled while $\overline{\mathrm{SS}}$ output is enabled.

## NOTE

Care must be taken when using the $\overline{\mathrm{SS}}$ output feature in a multimaster system because the mode fault feature is not available for detecting system errors between masters.

### 9.4.5.2 Bidirectional Mode (MOSI or MISO)

The bidirectional mode is selected when the SPC0 bit is set in SPI Control Register 2 (see Table 9-9). In this mode, the SPI uses only one serial data pin for the interface with external device(s). The MSTR bit decides which pin to use. The MOSI pin becomes the serial data I/O (MOMI) pin for the master mode, and the MISO pin becomes serial data I/O (SISO) pin for the slave mode. The MISO pin in master mode and MOSI pin in slave mode are not used by the SPI.

Table 9-9. Normal Mode and Bidirectional Mode


The direction of each serial I/O pin depends on the BIDIROE bit. If the pin is configured as an output, serial data from the shift register is driven out on the pin. The same pin is also the serial input to the shift register.

The SCK is output for the master mode and input for the slave mode.
The $\overline{\mathrm{SS}}$ is the input or output for the master mode, and it is always the input for the slave mode.
The bidirectional mode does not affect SCK and $\overline{\mathrm{SS}}$ functions.

## NOTE

In bidirectional master mode, with mode fault enabled, both data pins MISO and MOSI can be occupied by the SPI, though MOSI is normally used for transmissions in bidirectional mode and MISO is not used by the SPI. If a mode fault occurs, the SPI is automatically switched to slave mode, in this case MISO becomes occupied by the SPI and MOSI is not used. This has to be considered, if the MISO pin is used for other purpose.

### 9.4.6 Error Conditions

The SPI has one error condition:

- Mode fault error


### 9.4.6.1 Mode Fault Error

If the $\overline{\mathrm{SS}}$ input becomes low while the SPI is configured as a master, it indicates a system error where more than one master may be trying to drive the MOSI and SCK lines simultaneously. This condition is not permitted in normal operation, the MODF bit in the SPI Status Register is set automatically provided the MODFEN bit is set.

In the special case where the SPI is in master mode and MODFEN bit is cleared, the $\overline{\mathrm{SS}} \mathrm{pin}$ is not used by the SPI. In this special case, the mode fault error function is inhibited and MODF remains cleared. In case the SPI system is configured as a slave, the $\overline{\mathrm{SS}}$ pin is a dedicated input pin. Mode fault error doesn't occur in slave mode.

If a mode fault error occurs the SPI is switched to slave mode, with the exception that the slave output buffer is disabled. So SCK, MISO and MOSI pins are forced to be high impedance inputs to avoid any possibility of conflict with another output driver. A transmission in progress is aborted and the SPI is forced into idle state.

If the mode fault error occurs in the bidirectional mode for a SPI system configured in master mode, output enable of the MOMI (MOSI in bidirectional mode) is cleared if it was set. No mode fault error occurs in the bidirectional mode for SPI system configured in slave mode.

The mode fault flag is cleared automatically by a read of the SPI Status Register (with MODF set) followed by a write to SPI Control Register 1. If the mode fault flag is cleared, the SPI becomes a normal master or slave again.

### 9.4.7 Operation in Run Mode

In run mode with the SPI system enable (SPE) bit in the SPI control register clear, the SPI system is in a low-power, disabled state. SPI registers remain accessible, but clocks to the core of this module are disabled.

### 9.4.8 Operation in Wait Mode

SPI operation in wait mode depends upon the state of the SPISWAI bit in SPI Control Register 2.

- If SPISWAI is clear, the SPI operates normally when the CPU is in wait mode
- If SPISWAI is set, SPI clock generation ceases and the SPI module enters a power conservation state when the CPU is in wait mode.
- If SPISWAI is set and the SPI is configured for master, any transmission and reception in progress stops at wait mode entry. The transmission and reception resumes when the SPI exits wait mode.
- If SPISWAI is set and the SPI is configured as a slave, any transmission and reception in progress continues if the SCK continues to be driven from the master. This keeps the slave synchronized to the master and the SCK.
If the master transmits several bytes while the slave is in wait mode, the slave will continue to send out bytes consistent with the operation mode at the start of wait mode (i.e. If the slave is currently sending its SPIDR to the master, it will continue to send the same byte. Else if the slave is currently sending the last received byte from the master, it will continue to send each previous master byte).


## NOTE

Care must be taken when expecting data from a master while the slave is in wait or stop mode. Even though the shift register will continue to operate, the rest of the SPI is shut down (i.e. a SPIF interrupt will not be generated until exiting stop or wait mode). Also, the byte from the shift register will not be copied into the SPIDR register until after the slave SPI has exited wait or stop mode. A SPIF flag and SPIDR copy is only generated if wait mode is entered or exited during a tranmission. If the slave enters wait mode in idle mode and exits wait mode in idle mode, neither a SPIF nor a SPIDR copy will occur.

### 9.4.9 Operation in Stop Mode

Stop mode is dependent on the system. The SPI enters stop mode when the module clock is disabled (held high or low). If the SPI is in master mode and exchanging data when the CPU enters stop mode, the transmission is frozen until the CPU exits stop mode. After stop, data to and from the external SPI is exchanged correctly. In slave mode, the SPI will stay synchronized with the master.

The stop mode is not dependent on the SPISWAI bit.

### 9.5 Reset

The reset values of registers and signals are described in the Memory Map and Registers section (see Section 9.3, "Memory Map and Register Definition") which details the registers and their bit-fields.

- If a data transmission occurs in slave mode after reset without a write to SPIDR, it will transmit garbage, or the byte last received from the master before the reset.
- Reading from the SPIDR after reset will always read a byte of zeros.


### 9.6 Interrupts

The SPIV3 only originates interrupt requests when SPI is enabled (SPE bit in SPICR1 set). The following is a description of how the SPIV3 makes a request and how the MCU should acknowledge that request. The interrupt vector offset and interrupt priority are chip dependent.

The interrupt flags MODF, SPIF and SPTEF are logically ORed to generate an interrupt request.

### 9.6.1 MODF

MODF occurs when the master detects an error on the $\overline{\mathrm{SS}}$ pin. The master SPI must be configured for the MODF feature (see Table 9-3). After MODF is set, the current transfer is aborted and the following bit is changed:

- $\quad$ MSTR $=0$, The master bit in SPICR1 resets.

The MODF interrupt is reflected in the status register MODF flag. Clearing the flag will also clear the interrupt. This interrupt will stay active while the MODF flag is set. MODF has an automatic clearing process which is described in Section 9.3.2.4, "SPI Status Register (SPISR)."

### 9.6.2 SPIF

SPIF occurs when new data has been received and copied to the SPI Data Register. After SPIF is set, it does not clear until it is serviced. SPIF has an automatic clearing process which is described in Section 9.3.2.4, "SPI Status Register (SPISR)." In the event that the SPIF is not serviced before the end of the next transfer (i.e. SPIF remains active throughout another transfer), the latter transfers will be ignored and no new data will be copied into the SPIDR.

### 9.6.3 SPTEF

SPTEF occurs when the SPI Data Register is ready to accept new data. After SPTEF is set, it does not clear until it is serviced. SPTEF has an automatic clearing process which is described in Section 9.3.2.4, "SPI Status Register (SPISR)."

Chapter 9 Serial Peripheral Interface (SPIV3)

## Chapter 10 Inter-Integrated Circuit (IICV2)

### 10.1 Introduction

The inter-IC bus (IIC) is a two-wire, bidirectional serial bus that provides a simple, efficient method of data exchange between devices. Being a two-wire device, the IIC bus minimizes the need for large numbers of connections between devices, and eliminates the need for an address decoder.

This bus is suitable for applications requiring occasional communications over a short distance between a number of devices. It also provides flexibility, allowing additional devices to be connected to the bus for further expansion and system development.

The interface is designed to operate up to 100 kbps with maximum bus loading and timing. The device is capable of operating at higher baud rates, up to a maximum of clock/20, with reduced bus loading. The maximum communication length and the number of devices that can be connected are limited by a maximum bus capacitance of 400 pF .

### 10.1.1 Features

The IIC module has the following key features:

- Compatible with I2C bus standard
- Multi-master operation
- Software programmable for one of 256 different serial clock frequencies
- Software selectable acknowledge bit
- Interrupt driven byte-by-byte data transfer
- Arbitration lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- Start and stop signal generation/detection
- Repeated start signal generation
- Acknowledge bit generation/detection
- Bus busy detection


## Chapter 10 Inter-Integrated Circuit (IICV2)

### 10.1.2 Modes of Operation

The IIC functions the same in normal, special, and emulation modes. It has two low power modes: wait and stop modes.

### 10.1.3 Block Diagram

The block diagram of the IIC module is shown in Figure 10-1.


Figure 10-1. IIC Block Diagram

### 10.2 External Signal Description

The IICV2 module has two external pins.

### 10.2.1 IIC_SCL — Serial Clock Line Pin

This is the bidirectional serial clock line (SCL) of the module, compatible to the IIC bus specification.

### 10.2.2 IIC_SDA — Serial Data Line Pin

This is the bidirectional serial data line (SDA) of the module, compatible to the IIC bus specification.

### 10.3 Memory Map and Register Definition

This section provides a detailed description of all memory and registers for the IIC module.

### 10.3.1 Module Memory Map

The memory map for the IIC module is given below in Table 10-1. The address listed for each register is the address offset.The total address for each register is the sum of the base address for the IIC module and the address offset for each register.

## Chapter 10 Inter-Integrated Circuit (IICV2)

### 10.3.2 Register Descriptions

This section consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in bit order.

Table 10-1. IIC Register Summary

| Register Name | Bit 7 |  | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| IBAD | R | ADR7 | ADR6 | ADR5 | ADR4 | ADR3 | ADR2 | ADR1 | 0 |
|  | W |  |  |  |  |  |  |  |  |
| IBFD | R | IBC7 | IBC6 | IBC5 | IBC4 | IBC3 | IBC2 | IBC1 | IBC0 |
|  | W |  |  |  |  |  |  |  |  |
| IBCR | R | IBEN | IBIE | MS/SL | $\mathrm{Tx} / \overline{\mathrm{Rx}}$ | TXAK | 0 | 0 | IBSWAI |
|  | W |  |  |  |  |  | RSTA |  |  |
| IBSR | R | TCF | IAAS | IBB | IBAL | 0 | SRW | IBIF | RXAK |
|  | W |  |  |  |  |  |  |  |  |
| IBDR | R | D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|  | W |  |  |  |  |  |  |  |  |
|  |  |  | = Unimp | nted or | erved |  |  |  |  |

### 10.3.2.1 IIC Address Register (IBAD)



Figure 10-2. IIC Bus Address Register (IBAD)
Read and write anytime
This register contains the address the IIC bus will respond to when addressed as a slave; note that it is not the address sent on the bus during the address transfer.

Table 10-2. IBAD Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 1$ |  |
| ADR[7:1] |  | | Slave Address - Bit 1 to bit 7 contain the specific slave address to be used by the IIC bus module.The default |
| :--- |
| mode of IIC bus is slave mode for an address match on the bus. |
| 0 |
| Reserved | Reserved - Bit 0 of the IBAD is reserved for future compatibility. This bit will always read 0.

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### 10.3.2.2 IIC Frequency Divider Register (IBFD)



Figure 10-3. IIC Bus Frequency Divider Register (IBFD)
Read and write anytime
Table 10-3. IBFD Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:0 | I Bus Clock Rate 7:0 - This field is used to prescale the clock for bit rate selection. The bit clock generator is <br> implemented as a prescale divider - IBC7:6, prescaled shift register - IBC5:3 select the prescaler divider and |
| IBC[7:0] | IBC2-0 select the shift register tap point. The IBC bits are decoded to give the tap and prescale values as shown <br> in Table 10-4. |

Table 10-4. I-Bus Tap and Prescale Values

| IBC2-0 <br> (bin) | SCL Tap <br> (clocks) | SDA Tap <br> (clocks) |
| :---: | :---: | :---: |
| 000 | 5 | 1 |
| 001 | 6 | 1 |
| 010 | 7 | 2 |
| 011 | 8 | 2 |
| 100 | 9 | 3 |
| 101 | 10 | 3 |
| 110 | 12 | 4 |
| 111 | 15 | 4 |


| IBC5-3 <br> (bin) | scl2start <br> (clocks) | scl2stop <br> (clocks) | scl2tap <br> (clocks) | tap2tap <br> (clocks) |
| :---: | :---: | :---: | :---: | :---: |
| 000 | 2 | 7 | 4 | 1 |
| 001 | 2 | 7 | 4 | 2 |
| 010 | 2 | 9 | 6 | 4 |
| 011 | 6 | 9 | 6 | 8 |
| 100 | 14 | 17 | 14 | 16 |
| 101 | 30 | 33 | 30 | 32 |
| 110 | 62 | 65 | 62 | 64 |
| 111 | 126 | 129 | 126 | 128 |

## Chapter 10 Inter-Integrated Circuit (IICV2)

Table 10-5. Multiplier Factor

| IBC7-6 | MUL |
| :---: | :---: |
| 00 | 01 |
| 01 | 02 |
| 10 | 04 |
| 11 | RESERVED |

The number of clocks from the falling edge of SCL to the first tap (Tap[1]) is defined by the values shown in the scl2tap column of Table 10-4, all subsequent tap points are separated by $2^{\mathrm{IBC} 5-3}$ as shown in the tap2tap column in Table 10-4. The SCL Tap is used to generated the SCL period and the SDA Tap is used to determine the delay from the falling edge of SCL to SDA changing, the SDA hold time.
IBC7-6 defines the multiplier factor MUL. The values of MUL are shown in the Table 10-5.


Figure 10-4. SCL Divider and SDA Hold
The equation used to generate the divider values from the IBFD bits is:
SCL Divider $=$ MUL $\mathbf{x}\left\{\mathbf{2} \times\left(\operatorname{scl} 2 \operatorname{tap}+\left[\left(S C L \_T a p-1\right) \times \operatorname{tap} 2 t a p\right]+2\right)\right\}$

The SDA hold delay is equal to the CPU clock period multiplied by the SDA Hold value shown in Table 10-6. The equation used to generate the SDA Hold value from the IBFD bits is:

## SDA Hold $=$ MUL $\mathbf{x}\left\{\operatorname{scl} 2 t a p+\left[\left(S D A \_T a p-1\right) \times \operatorname{tap} 2 t a p\right]+3\right\}$

The equation for SCL Hold values to generate the start and stop conditions from the IBFD bits is:

> SCL Hold(start) $=$ MUL $\times[$ scl2start $+($ SCL_Tap -1$)$ x tap2tap $]$
> SCL Hold(stop) $=$ MUL $\times[$ scl2stop $+($ SCL_Tap -1$)$ x tap2tap $]$

Table 10-6. IIC Divider and Hold Values (Sheet 1 of 5)

| $\begin{gathered} \text { IBC[7:0] } \\ \text { (hex) } \end{gathered}$ | SCL Divider (clocks) | SDA Hold (clocks) | SCL Hold (start) | SCL Hold (stop) |
| :---: | :---: | :---: | :---: | :---: |
| MUL=1 |  |  |  |  |
| 00 | 20 | 7 | 6 | 11 |
| 01 | 22 | 7 | 7 | 12 |
| 02 | 24 | 8 | 8 | 13 |
| 03 | 26 | 8 | 9 | 14 |
| 04 | 28 | 9 | 10 | 15 |
| 05 | 30 | 9 | 11 | 16 |
| 06 | 34 | 10 | 13 | 18 |
| 07 | 40 | 10 | 16 | 21 |
| 08 | 28 | 7 | 10 | 15 |
| 09 | 32 | 7 | 12 | 17 |
| 0A | 36 | 9 | 14 | 19 |
| 0B | 40 | 9 | 16 | 21 |
| OC | 44 | 11 | 18 | 23 |
| 0D | 48 | 11 | 20 | 25 |
| OE | 56 | 13 | 24 | 29 |
| 0F | 68 | 13 | 30 | 35 |
| 10 | 48 | 9 | 18 | 25 |
| 11 | 56 | 9 | 22 | 29 |
| 12 | 64 | 13 | 26 | 33 |
| 13 | 72 | 13 | 30 | 37 |
| 14 | 80 | 17 | 34 | 41 |
| 15 | 88 | 17 | 38 | 45 |
| 16 | 104 | 21 | 46 | 53 |
| 17 | 128 | 21 | 58 | 65 |
| 18 | 80 | 9 | 38 | 41 |
| 19 | 96 | 9 | 46 | 49 |
| 1A | 112 | 17 | 54 | 57 |
| 1B | 128 | 17 | 62 | 65 |
| 1C | 144 | 25 | 70 | 73 |
| 1D | 160 | 25 | 78 | 81 |
| 1E | 192 | 33 | 94 | 97 |
| 1F | 240 | 33 | 118 | 121 |
| 20 | 160 | 17 | 78 | 81 |
| 21 | 192 | 17 | 94 | 97 |
| 22 | 224 | 33 | 110 | 113 |

Table 10-6. IIC Divider and Hold Values (Sheet 2 of 5)

| $\begin{gathered} \text { IBC[7:0] } \\ \text { (hex) } \end{gathered}$ | SCL Divider (clocks) | SDA Hold (clocks) | SCL Hold (start) | SCL Hold (stop) |
| :---: | :---: | :---: | :---: | :---: |
| 23 | 256 | 33 | 126 | 129 |
| 24 | 288 | 49 | 142 | 145 |
| 25 | 320 | 49 | 158 | 161 |
| 26 | 384 | 65 | 190 | 193 |
| 27 | 480 | 65 | 238 | 241 |
| 28 | 320 | 33 | 158 | 161 |
| 29 | 384 | 33 | 190 | 193 |
| 2A | 448 | 65 | 222 | 225 |
| 2B | 512 | 65 | 254 | 257 |
| 2C | 576 | 97 | 286 | 289 |
| 2D | 640 | 97 | 318 | 321 |
| 2E | 768 | 129 | 382 | 385 |
| 2 F | 960 | 129 | 478 | 481 |
| 30 | 640 | 65 | 318 | 321 |
| 31 | 768 | 65 | 382 | 385 |
| 32 | 896 | 129 | 446 | 449 |
| 33 | 1024 | 129 | 510 | 513 |
| 34 | 1152 | 193 | 574 | 577 |
| 35 | 1280 | 193 | 638 | 641 |
| 36 | 1536 | 257 | 766 | 769 |
| 37 | 1920 | 257 | 958 | 961 |
| 38 | 1280 | 129 | 638 | 641 |
| 39 | 1536 | 129 | 766 | 769 |
| 3A | 1792 | 257 | 894 | 897 |
| 3B | 2048 | 257 | 1022 | 1025 |
| 3C | 2304 | 385 | 1150 | 1153 |
| 3D | 2560 | 385 | 1278 | 1281 |
| 3E | 3072 | 513 | 1534 | 1537 |
| 3F | 3840 | 513 | 1918 | 1921 |
| MUL=2 |  |  |  |  |
| 40 | 40 | 14 | 12 | 22 |
| 41 | 44 | 14 | 14 | 24 |
| 42 | 48 | 16 | 16 | 26 |
| 43 | 52 | 16 | 18 | 28 |
| 44 | 56 | 18 | 20 | 30 |
| 45 | 60 | 18 | 22 | 32 |
| 46 | 68 | 20 | 26 | 36 |
| 47 | 80 | 20 | 32 | 42 |
| 48 | 56 | 14 | 20 | 30 |
| 49 | 64 | 14 | 24 | 34 |
| 4A | 72 | 18 | 28 | 38 |
| 4B | 80 | 18 | 32 | 42 |
| 4C | 88 | 22 | 36 | 46 |
| 4D | 96 | 22 | 40 | 50 |
| 4E | 112 | 26 | 48 | 58 |

Table 10-6. IIC Divider and Hold Values (Sheet 3 of 5)

| $\begin{aligned} & \text { IBC[7:0] } \\ & \text { (hex) } \end{aligned}$ | SCL Divider (clocks) | SDA Hold (clocks) | SCL Hold (start) | SCL Hold (stop) |
| :---: | :---: | :---: | :---: | :---: |
| 4F | 136 | 26 | 60 | 70 |
| 50 | 96 | 18 | 36 | 50 |
| 51 | 112 | 18 | 44 | 58 |
| 52 | 128 | 26 | 52 | 66 |
| 53 | 144 | 26 | 60 | 74 |
| 54 | 160 | 34 | 68 | 82 |
| 55 | 176 | 34 | 76 | 90 |
| 56 | 208 | 42 | 92 | 106 |
| 57 | 256 | 42 | 116 | 130 |
| 58 | 160 | 18 | 76 | 82 |
| 59 | 192 | 18 | 92 | 98 |
| 5A | 224 | 34 | 108 | 114 |
| 5B | 256 | 34 | 124 | 130 |
| 5C | 288 | 50 | 140 | 146 |
| 5D | 320 | 50 | 156 | 162 |
| 5E | 384 | 66 | 188 | 194 |
| 5F | 480 | 66 | 236 | 242 |
| 60 | 320 | 34 | 156 | 162 |
| 61 | 384 | 34 | 188 | 194 |
| 62 | 448 | 66 | 220 | 226 |
| 63 | 512 | 66 | 252 | 258 |
| 64 | 576 | 98 | 284 | 290 |
| 65 | 640 | 98 | 316 | 322 |
| 66 | 768 | 130 | 380 | 386 |
| 67 | 960 | 130 | 476 | 482 |
| 68 | 640 | 66 | 316 | 322 |
| 69 | 768 | 66 | 380 | 386 |
| 6A | 896 | 130 | 444 | 450 |
| 6B | 1024 | 130 | 508 | 514 |
| 6C | 1152 | 194 | 572 | 578 |
| 6D | 1280 | 194 | 636 | 642 |
| 6E | 1536 | 258 | 764 | 770 |
| 6 F | 1920 | 258 | 956 | 962 |
| 70 | 1280 | 130 | 636 | 642 |
| 71 | 1536 | 130 | 764 | 770 |
| 72 | 1792 | 258 | 892 | 898 |
| 73 | 2048 | 258 | 1020 | 1026 |
| 74 | 2304 | 386 | 1148 | 1154 |
| 75 | 2560 | 386 | 1276 | 1282 |
| 76 | 3072 | 514 | 1532 | 1538 |
| 77 | 3840 | 514 | 1916 | 1922 |
| 78 | 2560 | 258 | 1276 | 1282 |
| 79 | 3072 | 258 | 1532 | 1538 |
| 7A | 3584 | 514 | 1788 | 1794 |
| 7B | 4096 | 514 | 2044 | 2050 |

Table 10-6. IIC Divider and Hold Values (Sheet 4 of 5)

| $\begin{gathered} \text { IBC[7:0] } \\ \text { (hex) } \end{gathered}$ | SCL Divider (clocks) | SDA Hold (clocks) | SCL Hold (start) | SCL Hold (stop) |
| :---: | :---: | :---: | :---: | :---: |
| 7C | 4608 | 770 | 2300 | 2306 |
| 7D | 5120 | 770 | 2556 | 2562 |
| 7E | 6144 | 1026 | 3068 | 3074 |
| 7F | 7680 | 1026 | 3836 | 3842 |
| MUL=4 |  |  |  |  |
| 80 | 80 | 28 | 24 | 44 |
| 81 | 88 | 28 | 28 | 48 |
| 82 | 96 | 32 | 32 | 52 |
| 83 | 104 | 32 | 36 | 56 |
| 84 | 112 | 36 | 40 | 60 |
| 85 | 120 | 36 | 44 | 64 |
| 86 | 136 | 40 | 52 | 72 |
| 87 | 160 | 40 | 64 | 84 |
| 88 | 112 | 28 | 40 | 60 |
| 89 | 128 | 28 | 48 | 68 |
| 8A | 144 | 36 | 56 | 76 |
| 8B | 160 | 36 | 64 | 84 |
| 8C | 176 | 44 | 72 | 92 |
| 8D | 192 | 44 | 80 | 100 |
| 8E | 224 | 52 | 96 | 116 |
| 8F | 272 | 52 | 120 | 140 |
| 90 | 192 | 36 | 72 | 100 |
| 91 | 224 | 36 | 88 | 116 |
| 92 | 256 | 52 | 104 | 132 |
| 93 | 288 | 52 | 120 | 148 |
| 94 | 320 | 68 | 136 | 164 |
| 95 | 352 | 68 | 152 | 180 |
| 96 | 416 | 84 | 184 | 212 |
| 97 | 512 | 84 | 232 | 260 |
| 98 | 320 | 36 | 152 | 164 |
| 99 | 384 | 36 | 184 | 196 |
| 9A | 448 | 68 | 216 | 228 |
| 9B | 512 | 68 | 248 | 260 |
| 9C | 576 | 100 | 280 | 292 |
| 9D | 640 | 100 | 312 | 324 |
| 9E | 768 | 132 | 376 | 388 |
| 9F | 960 | 132 | 472 | 484 |
| A0 | 640 | 68 | 312 | 324 |
| A1 | 768 | 68 | 376 | 388 |
| A2 | 896 | 132 | 440 | 452 |
| A3 | 1024 | 132 | 504 | 516 |
| A4 | 1152 | 196 | 568 | 580 |
| A5 | 1280 | 196 | 632 | 644 |
| A6 | 1536 | 260 | 760 | 772 |
| A7 | 1920 | 260 | 952 | 964 |

Table 10-6. IIC Divider and Hold Values (Sheet 5 of 5)

| IBC[7:0] <br> (hex) | SCL Divider <br> (clocks) | SDA Hold <br> (clocks) | SCL Hold <br> (start) | SCL Hold <br> (stop) |
| :---: | :---: | :---: | :---: | :---: |
| A8 | 1280 | 132 | 632 | 644 |
| A9 | 1536 | 132 | 760 | 772 |
| AA | 1792 | 260 | 888 | 900 |
| AB | 2048 | 260 | 1016 | 1144 |
| AC | 2304 | 388 | 1272 | 1156 |
| AD | 2560 | 388 | 1528 | 1284 |
| AE | 3072 | 516 | 1912 | 1540 |
| AF | 3840 | 516 | 1272 | 1924 |
| B0 | 2560 | 260 | 1528 | 1284 |
| B1 | 3072 | 260 | 1784 | 1540 |
| B2 | 3584 | 516 | 2040 | 1796 |
| B3 | 4096 | 516 | 2552 | 2052 |
| B4 | 4608 | 772 | 3064 | 2308 |
| B5 | 5120 | 1028 | 3832 | 2564 |
| B6 | 6144 | 1028 | 2552 | 3076 |
| B7 | 7680 | 516 | 3064 | 3844 |
| B8 | 5120 | 516 | 3576 | 2564 |
| B9 | 6144 | 1028 | 4088 | 3076 |
| BA | 7168 | 1028 | 5600 | 3588 |
| BB | 8192 | 1540 | 6136 | 4100 |
| BC | 9216 | 1540 | 7672 | 4612 |
| BD | 10240 | 2052 | 5124 |  |
| BE | 12288 | 15360 |  | 6148 |
| BF |  |  |  | 7684 |

### 10.3.2.3 IIC Control Register (IBCR)



Figure 10-5. IIC Bus Control Register (IBCR)
Read and write anytime

## Table 10-7. IBCR Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { IBEN } \end{gathered}$ | I-Bus Enable - This bit controls the software reset of the entire IIC bus module. <br> 0 The module is reset and disabled. This is the power-on reset situation. When low the interface is held in reset but registers can be accessed <br> 1 The IIC bus module is enabled. This bit must be set before any other IBCR bits have any effect If the IIC bus module is enabled in the middle of a byte transfer the interface behaves as follows: slave mode ignores the current transfer on the bus and starts operating whenever a subsequent start condition is detected. Master mode will not be aware that the bus is busy, hence if a start cycle is initiated then the current bus cycle may become corrupt. This would ultimately result in either the current bus master or the IIC bus module losing arbitration, after which bus operation would return to normal. |
| $\begin{gathered} \hline 6 \\ \text { IBIE } \end{gathered}$ | I-Bus Interrupt Enable <br> 0 Interrupts from the IIC bus module are disabled. Note that this does not clear any currently pending interrupt condition <br> 1 Interrupts from the IIC bus module are enabled. An IIC bus interrupt occurs provided the IBIF bit in the status register is also set. |
| $\begin{gathered} 5 \\ M S / S L \end{gathered}$ | Master/Slave Mode Select Bit — Upon reset, this bit is cleared. When this bit is changed from 0 to 1, a START signal is generated on the bus, and the master mode is selected. When this bit is changed from 1 to 0 , a STOP signal is generated and the operation mode changes from master to slave.A STOP signal should only be generated if the IBIF flag is set. MS/SL is cleared without generating a STOP signal when the master loses arbitration. <br> 0 Slave Mode <br> 1 Master Mode |
| $\begin{gathered} 4 \\ \mathrm{Tx} / R x \end{gathered}$ | Transmit/Receive Mode Select Bit — This bit selects the direction of master and slave transfers. When addressed as a slave this bit should be set by software according to the SRW bit in the status register. In master mode this bit should be set according to the type of transfer required. Therefore, for address cycles, this bit will always be high. <br> 0 Receive <br> 1 Transmit |
| $\begin{gathered} 3 \\ \text { TXAK } \end{gathered}$ | Transmit Acknowledge Enable - This bit specifies the value driven onto SDA during data acknowledge cycles for both master and slave receivers. The IIC module will always acknowledge address matches, provided it is enabled, regardless of the value of TXAK. Note that values written to this bit are only used when the IIC bus is a receiver, not a transmitter. <br> 0 An acknowledge signal will be sent out to the bus at the 9th clock bit after receiving one byte data <br> 1 No acknowledge signal response is sent (i.e., acknowledge bit = 1) |
| $\begin{gathered} 2 \\ \text { RSTA } \end{gathered}$ | Repeat Start - Writing a 1 to this bit will generate a repeated START condition on the bus, provided it is the current bus master. This bit will always be read as a low. Attempting a repeated start at the wrong time, if the bus is owned by another master, will result in loss of arbitration. <br> 1 Generate repeat start cycle |
| $\begin{gathered} 1 \\ \text { RESERVED } \end{gathered}$ | Reserved - Bit 1 of the IBCR is reserved for future compatibility. This bit will always read 0 . |
| 0 IBSWAI | I Bus Interface Stop in Wait Mode <br> 0 IIC bus module clock operates normally <br> 1 Halt IIC bus module clock generation in wait mode |

Wait mode is entered via execution of a CPU WAI instruction. In the event that the IBSWAI bit is set, all clocks internal to the IIC will be stopped and any transmission currently in progress will halt.If the CPU were woken up by a source other than the IIC module, then clocks would restart and the IIC would resume
from where was during the previous transmission. It is not possible for the IIC to wake up the CPU when its internal clocks are stopped.

If it were the case that the IBSWAI bit was cleared when the WAI instruction was executed, the IIC internal clocks and interface would remain alive, continuing the operation which was currently underway. It is also possible to configure the IIC such that it will wake up the CPU via an interrupt at the conclusion of the current operation. See the discussion on the IBIF and IBIE bits in the IBSR and IBCR, respectively.

### 10.3.2.4 IIC Status Register (IBSR)



Figure 10-6. IIC Bus Status Register (IBSR)
This status register is read-only with exception of bit 1 (IBIF) and bit 4 (IBAL), which are software clearable.

Table 10-8. IBSR Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| TCF | Data Transferring Bit - While one byte of data is being transferred, this bit is cleared. It is set by the falling <br> edge of the 9th clock of a byte transfer. Note that this bit is only valid during or immediately following a transfer <br> to the IIC module or from the IIC module. <br> 0 <br> 0 Transfer in progress |
| 1 Transfer complete |  |

Table 10-8. IBSR Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 2 |  |
| SRW | Slave Read/Write - When IAAS is set this bit indicates the value of the R/W command bit of the calling address <br> sent from the master <br> This bit is only valid when the I-bus is in slave mode, a complete address transfer has occurred with an address <br> match and no other transfers have been initiated. <br> Checking this bit, the CPU can select slave transmit/receive mode according to the command of the master. <br> 0 Slave receive, master writing to slave <br> 1 <br> Slave transmit, master reading from slave |
| 1 | I-Bus Interrupt - The IBIF bit is set when one of the following conditions occurs: <br> - Arbitration lost (IBAL bit set) <br> - Byte transfer complete (TCF bit set) |
| IBAddressed as slave (IAAS bit set) |  |

### 10.3.2.5 IIC Data I/O Register (IBDR)



Figure 10-7. IIC Bus Data I/O Register (IBDR)
In master transmit mode, when data is written to the IBDR a data transfer is initiated. The most significant bit is sent first. In master receive mode, reading this register initiates next byte data receiving. In slave mode, the same functions are available after an address match has occurred.Note that the $\mathrm{Tx} / \mathrm{Rx}$ bit in the IBCR must correctly reflect the desired direction of transfer in master and slave modes for the transmission to begin. For instance, if the IIC is configured for master transmit but a master receive is desired, then reading the IBDR will not initiate the receive.

Reading the IBDR will return the last byte received while the IIC is configured in either master receive or slave receive modes. The IBDR does not reflect every byte that is transmitted on the IIC bus, nor can software verify that a byte has been written to the IBDR correctly by reading it back.

In master transmit mode, the first byte of data written to IBDR following assertion of MS/ $\overline{\mathrm{SL}}$ is used for the address transfer and should com.prise of the calling address (in position D7:D1) concatenated with the required $\mathrm{R} / \overline{\mathrm{W}}$ bit (in position D0).

### 10.4 Functional Description

This section provides a complete functional description of the IICV2.

### 10.4.1 I-Bus Protocol

The IIC bus system uses a serial data line (SDA) and a serial clock line (SCL) for data transfer. All devices connected to it must have open drain or open collector outputs. Logic AND function is exercised on both lines with external pull-up resistors. The value of these resistors is system dependent.

Normally, a standard communication is composed of four parts: START signal, slave address transmission, data transfer and STOP signal. They are described briefly in the following sections and illustrated in Figure 10-8.


Figure 10-8. IIC-Bus Transmission Signals

### 10.4.1.1 START Signal

When the bus is free, i.e. no master device is engaging the bus (both SCL and SDA lines are at logical high), a master may initiate communication by sending a START signal.As shown in Figure 10-8, a START signal is defined as a high-to-low transition of SDA while SCL is high. This signal denotes the beginning of a new data transfer (each data transfer may contain several bytes of data) and brings all slaves out of their idle states.


Figure 10-9. Start and Stop Conditions

### 10.4.1.2 Slave Address Transmission

The first byte of data transfer immediately after the START signal is the slave address transmitted by the master. This is a seven-bit calling address followed by a R/W bit. The R/W bit tells the slave the desired direction of data transfer.
$1=$ Read transfer, the slave transmits data to the master.
$0=$ Write transfer, the master transmits data to the slave.
Only the slave with a calling address that matches the one transmitted by the master will respond by sending back an acknowledge bit. This is done by pulling the SDA low at the 9th clock (see Figure 10-8).

No two slaves in the system may have the same address. If the IIC bus is master, it must not transmit an address that is equal to its own slave address. The IIC bus cannot be master and slave at the same time.However, if arbitration is lost during an address cycle the IIC bus will revert to slave mode and operate correctly even if it is being addressed by another master.

### 10.4.1.3 Data Transfer

As soon as successful slave addressing is achieved, the data transfer can proceed byte-by-byte in a direction specified by the $\mathrm{R} / \mathrm{W}$ bit sent by the calling master

All transfers that come after an address cycle are referred to as data transfers, even if they carry sub-address information for the slave device.

Each data byte is 8 bits long. Data may be changed only while SCL is low and must be held stable while SCL is high as shown in Figure 10-8. There is one clock pulse on SCL for each data bit, the MSB being transferred first. Each data byte has to be followed by an acknowledge bit, which is signalled from the receiving device by pulling the SDA low at the ninth clock. So one complete data byte transfer needs nine clock pulses.

If the slave receiver does not acknowledge the master, the SDA line must be left high by the slave. The master can then generate a stop signal to abort the data transfer or a start signal (repeated start) to commence a new calling.

If the master receiver does not acknowledge the slave transmitter after a byte transmission, it means 'end of data' to the slave, so the slave releases the SDA line for the master to generate STOP or START signal.

### 10.4.1.4 STOP Signal

The master can terminate the communication by generating a STOP signal to free the bus. However, the master may generate a START signal followed by a calling command without generating a STOP signal first. This is called repeated START. A STOP signal is defined as a low-to-high transition of SDA while SCL at logical 1 (see Figure 10-8).

The master can generate a STOP even if the slave has generated an acknowledge at which point the slave must release the bus.

### 10.4.1.5 Repeated START Signal

As shown in Figure 10-8, a repeated START signal is a START signal generated without first generating a STOP signal to terminate the communication. This is used by the master to communicate with another slave or with the same slave in different mode (transmit/receive mode) without releasing the bus.

### 10.4.1.6 Arbitration Procedure

The Inter-IC bus is a true multi-master bus that allows more than one master to be connected on it. If two or more masters try to control the bus at the same time, a clock synchronization procedure determines the bus clock, for which the low period is equal to the longest clock low period and the high is equal to the shortest one among the masters. The relative priority of the contending masters is determined by a data arbitration procedure, a bus master loses arbitration if it transmits logic 1 while another master transmits logic 0 . The losing masters immediately switch over to slave receive mode and stop driving SDA output. In this case the transition from master to slave mode does not generate a STOP condition. Meanwhile, a status bit is set by hardware to indicate loss of arbitration.

### 10.4.1.7 Clock Synchronization

Because wire-AND logic is performed on SCL line, a high-to-low transition on SCL line affects all the devices connected on the bus. The devices start counting their low period and as soon as a device's clock has gone low, it holds the SCL line low until the clock high state is reached.However, the change of low to high in this device clock may not change the state of the SCL line if another device clock is within its low period. Therefore, synchronized clock SCL is held low by the device with the longest low period. Devices with shorter low periods enter a high wait state during this time (see Figure 10-9). When all devices concerned have counted off their low period, the synchronized clock SCL line is released and pulled high. There is then no difference between the device clocks and the state of the SCL line and all the devices start counting their high periods. The first device to complete its high period pulls the SCL line low again.


Figure 10-10. IIC-Bus Clock Synchronization

### 10.4.1.8 Handshaking

The clock synchronization mechanism can be used as a handshake in data transfer. Slave devices may hold the SCL low after completion of one byte transfer ( 9 bits). In such case, it halts the bus clock and forces the master clock into wait states until the slave releases the SCL line.

### 10.4.1.9 Clock Stretching

The clock synchronization mechanism can be used by slaves to slow down the bit rate of a transfer. After the master has driven SCL low the slave can drive SCL low for the required period and then release it.If the slave SCL low period is greater than the master SCL low period then the resulting SCL bus signal low period is stretched.

### 10.4.2 Operation in Run Mode

This is the basic mode of operation.

### 10.4.3 Operation in Wait Mode

IIC operation in wait mode can be configured. Depending on the state of internal bits, the IIC can operate normally when the CPU is in wait mode or the IIC clock generation can be turned off and the IIC module enters a power conservation state during wait mode. In the later case, any transmission or reception in progress stops at wait mode entry.

### 10.4.4 Operation in Stop Mode

The IIC is inactive in stop mode for reduced power consumption. The STOP instruction does not affect IIC register states.

### 10.5 Resets

The reset state of each individual bit is listed in Section 10.3, "Memory Map and Register Definition," which details the registers and their bit-fields.

### 10.6 Interrupts

IICV2 uses only one interrupt vector.
Table 10-9. Interrupt Summary

| Interrupt | Offset | Vector | Priority | Source | Description |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Interrupt <br> Interup | - | - | - | IBAL, TCF IAAS <br> bits in IBSR <br> register | When either of IBAL, TCF or IAAS bits is set <br> may cause an interrupt based on arbitration <br> lost, transfer complete or address detect <br> conditions |

Internally there are three types of interrupts in IIC. The interrupt service routine can determine the interrupt type by reading the status register.

IIC Interrupt can be generated on

1. Arbitration lost condition (IBAL bit set)
2. Byte transfer condition (TCF bit set)
3. Address detect condition (IAAS bit set)

The IIC interrupt is enabled by the IBIE bit in the IIC control register. It must be cleared by writing 0 to the IBF bit in the interrupt service routine.

### 10.7 Initialization/Application Information

### 10.7.1 IIC Programming Examples

### 10.7.1.1 Initialization Sequence

Reset will put the IIC bus control register to its default status. Before the interface can be used to transfer serial data, an initialization procedure must be carried out, as follows:

1. Update the frequency divider register (IBFD) and select the required division ratio to obtain SCL frequency from system clock.
2. Update the IIC bus address register (IBAD) to define its slave address.
3. Set the IBEN bit of the IIC bus control register (IBCR) to enable the IIC interface system.
4. Modify the bits of the IIC bus control register (IBCR) to select master/slave mode, transmit/receive mode and interrupt enable or not.

### 10.7.1.2 Generation of START

After completion of the initialization procedure, serial data can be transmitted by selecting the 'master transmitter' mode. If the device is connected to a multi-master bus system, the state of the IIC bus busy bit (IBB) must be tested to check whether the serial bus is free.

If the bus is free ( $\mathrm{IBB}=0$ ), the start condition and the first byte (the slave address) can be sent. The data written to the data register comprises the slave calling address and the LSB set to indicate the direction of transfer required from the slave.
The bus free time (i.e., the time between a STOP condition and the following START condition) is built into the hardware that generates the START cycle. Depending on the relative frequencies of the system clock and the SCL period it may be necessary to wait until the IIC is busy after writing the calling address to the IBDR before proceeding with the following instructions. This is illustrated in the following example.

An example of a program which generates the START signal and transmits the first byte of data (slave address) is shown below:

```
CHFLAG BRSET IBSR,#$20,* ;WAIT FOR IBB FLAG TO CLEAR
TXSTART BSET IBCR,#$30 ;SET TRANSMIT AND MASTER MODE;i.e. GENERATE START CONDITION
    MOVB CALLING,IBDR ;TRANSMIT THE CALLING ADDRESS,D0=R/W
IBFREE BRCLR IBSR,#$20,* ;WAIT FOR IBB FLAG TO SET
```


### 10.7.1.3 Post-Transfer Software Response

Transmission or reception of a byte will set the data transferring bit (TCF) to 1 , which indicates one byte communication is finished. The IIC bus interrupt bit (IBIF) is set also; an interrupt will be generated if the interrupt function is enabled during initialization by setting the IBIE bit. Software must clear the IBIF bit in the interrupt routine first. The TCF bit will be cleared by reading from the IIC bus data I/O register (IBDR) in receive mode or writing to IBDR in transmit mode.

Software may service the IIC I/O in the main program by monitoring the IBIF bit if the interrupt function is disabled. Note that polling should monitor the IBIF bit rather than the TCF bit because their operation is different when arbitration is lost.

Note that when an interrupt occurs at the end of the address cycle the master will always be in transmit mode, i.e. the address is transmitted. If master receive mode is required, indicated by R/W bit in IBDR, then the $T x / R x$ bit should be toggled at this stage.

During slave mode address cycles (IAAS $=1$ ), the SRW bit in the status register is read to determine the direction of the subsequent transfer and the $\mathrm{Tx} / \mathrm{Rx}$ bit is programmed accordingly. For slave mode data cycles (IAAS=0) the SRW bit is not valid, the $\mathrm{Tx} / \mathrm{Rx}$ bit in the control register should be read to determine the direction of the current transfer.

The following is an example of a software response by a 'master transmitter' in the interrupt routine.

| ISR | BCLR | IBSR,\#\$02 | ;CLEAR THE IBIF FLAG |
| :--- | :--- | :--- | :--- |
|  | BRCLR | IBCR,\#\$20,SLAVE | ;BRANCH IF IN SLAVE MODE |
|  | BRCLR | IBCR,\#\$10,RECEIVE | ;BRANCH IF IN RECEIVE MODE |
|  | BRSET | IBSR,\#\$01,END | ;IF NO ACK, END OF TRANSMISSION |
| TRANSMIT | MOVB | DATABUF,IBDR | ;TRANSMIT NEXT BYTE OF DATA |

### 10.7.1.4 Generation of STOP

A data transfer ends with a STOP signal generated by the 'master' device. A master transmitter can simply generate a STOP signal after all the data has been transmitted. The following is an example showing how a stop condition is generated by a master transmitter.

| MASTX | TST | TXCNT | ;GET VALUE FROM THE TRANSMITING COUNTER |
| :--- | :--- | :--- | :--- |
|  | BEQ | END | ;END IF NO MORE DATA |
|  | BRSET | IBSR,\#\$01,END | ;END IF NO ACK |
|  | MOVB | DATABUF,IBDR | ;TRANSMIT NEXT BYTE OF DATA |
|  | DEC | TXCNT | ;DECREASE THE TXCNT |
|  | BRA | EMASTX | ;EXIT |
| END | BCLR | IBCR,\#\$20 | ;GENERATE A STOP CONDITION |
| EMASTX | RTI |  | ;RETURN FROM INTERRUPT |

If a master receiver wants to terminate a data transfer, it must inform the slave transmitter by not acknowledging the last byte of data which can be done by setting the transmit acknowledge bit (TXAK) before reading the 2 nd last byte of data. Before reading the last byte of data, a STOP signal must be generated first. The following is an example showing how a STOP signal is generated by a master receiver.

| MASR | DEC | RXCNT | ;DECREASE THE RXCNT |
| :--- | :--- | :--- | :--- |
|  | BEQ | ENMASR | ;LAST BYTE TO BE READ |
|  | MOVB | RXCNT,D1 | ;CHECK SECOND LAST BYTE |
|  | DEC | D1 | ;TO BE READ |
|  | BNE | NXMAR | ;NOT LAST OR SECOND LAST |
| LAMAR | BSET | IBCR,\#\$08 | ;SECOND LAST, DISABLE ACK |
|  |  |  | ;TRANSMITTING |
|  | BRA | NXMAR |  |
| ENMASR | BCLR | IBCR,\#\$20 | ;LAST ONE, GENERATE ‘STOP' SIGNAL |
| NXMAR | MOVB | IBDR,RXBUF | ;READ DATA AND STORE |

### 10.7.1.5 Generation of Repeated START

At the end of data transfer, if the master continues to want to communicate on the bus, it can generate another START signal followed by another slave address without first generating a STOP signal. A program example is as shown.

| RESTART | BSET | IBCR,\#\$04 | ;ANOTHER START (RESTART) |
| :--- | :--- | :--- | :--- |
|  | MOVB | CALLING,IBDR | ;TRANSMIT THE CALLING ADDRESS;D0=R/W |

### 10.7.1.6 Slave Mode

In the slave interrupt service routine, the module addressed as slave bit (IAAS) should be tested to check if a calling of its own address has just been received. If IAAS is set, software should set the transmit/receive mode select bit (Tx/Rx bit of IBCR) according to the R/W command bit (SRW). Writing to the IBCR clears the IAAS automatically. Note that the only time IAAS is read as set is from the interrupt at the end of the address cycle where an address match occurred, interrupts resulting from subsequent data transfers will have IAAS cleared. A data transfer may now be initiated by writing information to IBDR, for slave transmits, or dummy reading from IBDR, in slave receive mode. The slave will drive SCL low in-between byte transfers, SCL is released when the IBDR is accessed in the required mode.

In slave transmitter routine, the received acknowledge bit (RXAK) must be tested before transmitting the next byte of data. Setting RXAK means an 'end of data' signal from the master receiver, after which it must be switched from transmitter mode to receiver mode by software. A dummy read then releases the SCL line so that the master can generate a STOP signal.

### 10.7.1.7 Arbitration Lost

If several masters try to engage the bus simultaneously, only one master wins and the others lose arbitration. The devices which lost arbitration are immediately switched to slave receive mode by the hardware. Their data output to the SDA line is stopped, but SCL continues to be generated until the end of the byte during which arbitration was lost. An interrupt occurs at the falling edge of the ninth clock of this transfer with $\mathrm{IBAL}=1$ and $\mathrm{MS} / \mathrm{SL}=0$. If one master attempts to start transmission while the bus is being engaged by another master, the hardware will inhibit the transmission; switch the MS/SL bit from 1 to 0 without generating STOP condition; generate an interrupt to CPU and set the IBAL to indicate that the attempt to engage the bus is failed. When considering these cases, the slave service routine should test the IBAL first and the software should clear the IBAL bit if it is set.


Figure 10-11. Flow-Chart of Typical IIC Interrupt Routine

Chapter 10 Inter-Integrated Circuit (IICV2)

## Chapter 11 Pulse Width Modulator with Fault Protection (PMF15B6CV2)

### 11.1 Introduction

The $\underline{\text { Pulse width Modulator with Fault protection (PMF) module can be configured for one, two, or three }}$ complementary pairs. For example:

- One complementary pair and four independent PWM outputs
- Two complementary pair and two independent PWM outputs
- Three complementary pair and zero independent PWM outputs
- Zero complementary pair and six independent PWM outputs

All PWM outputs can be generated from the same counter, or each pair can have its own counter for three independent PWM frequencies. Complementary operation permits programmable dead-time insertion, distortion correction through current sensing by software, and separate top and bottom output polarity control. Each counter value is programmable to support a continuously variable PWM frequency. Both edge- and center-aligned synchronous pulse width-control and full range modulation from 0 percent to 100 percent, are supported. The PMF is capable of controlling most motor types: AC induction motors (ACIM), both brushless (BLDC) and brush DC motors (BDC), switched (SRM), and variable reluctance motors (VRM), and stepper motors.

### 11.1.1 Features

- Three complementary PWM signal pairs, or six independent PWM signals
- Three 15 -bit counters
- Features of complementary channel operation
- Deadtime insertion
- Separate top and bottom pulse width correction via current status inputs or software
- Separate top and bottom polarity control
- Edge-aligned or center-aligned PWM signals
- Half-cycle reload capability
- Integral reload rates from 1 to 16
- Individual software-controlled PWM output
- Programmable fault protection
- Polarity control


### 11.1.2 Modes of Operation

Care must be exercised when using this module in the modes listed in Table 11-1. PWM outputs are placed in their inactive states in stop mode, and optionally under WAIT and freeze modes. PWM outputs will be reactivated (assuming they were active to begin with) when these modes are exited.

Table 11-1. Modes When PWM Operation is Restricted

| Mode | Description |
| :---: | :---: |
| Stop | PWM outputs are disabled |
| Wait | PWM outputs are disabled as a function of the PMFWAI bit. |
| Freeze | PWM outputs are disabled as a function of the PMFFRZ bit. |

### 11.1.3 Block Diagrams

Figure 11-1 provides an overview of the PMF module.
The Mux/Swap/Current Sense block is tightly integrated with the dead time insertion block. This detail is shown in Figure 11-2.

## NOTE

It is possible to have both channels of a complementary pair to be high. For example, if the TOPNEGA (negative polarity for PWM0), BOTNEGA (negative polarity for PWM1), MASK0, and MASK1 bits are set, both the PWM complementary outputs of generator A will be high. See Section 11.3.2.2, "PMF Configure 1 Register (PMFCFG1)" for the description of TOPNEG and BOTNEG bits, and Section 11.3.2.3, "PMF Configure 2 Register (PMFCFG2)" for the description of the MSK0 and MSK1 bits.


Figure 11-1. PMF Block Diagram

PWM source selection is based on a number of factors:

- State of current sense pins
- IPOL bit
- OUTCTL bit
- Center vs edge aligned


Figure 11-2. Detail of Mux, Swap, and Deadtime Functions

### 11.2 External Signal Description

The pulse width modulator has external pins named PWM0-5, FAULT0-3, and $\overline{\text { IS0 }}-\overline{\mathrm{IS}} 2$.

### 11.2.1 PWM0-PWM5 Pins

PWM0-PWM5 are the output pins of the six PWM channels.

### 11.2.2 FAULT0-FAULT3 Pins

FAULT0-FAULT3 are input pins for disabling selected PWM outputs.

### 11.2.3 $\overline{\mathrm{ISO}}-\overline{\mathrm{IS} 2}$ Pins

$\overline{\text { IS0 }}-\overline{\mathrm{IS} 2}$ are current status pins for top/bottom pulse width correction in complementary channel operation while deadtime is asserted.

### 11.3 Memory Map and Registers

### 11.3.1 Module Memory Map



Figure 11-3. PMF15B6C Register Summary (Sheet 1 of 3)

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Chapter 11 Pulse Width Modulator with Fault Protection (PMF15B6CV2)


Figure 11-3. PMF15B6C Register Summary (Sheet 2 of 3)


Figure 11-3. PMF15B6C Register Summary (Sheet 3 of 3)

### 11.3.2 Register Descriptions

The address of a register is the sum of a base address and an address offset. The base address is defined at the chip level and the address offset is defined at the module level.

### 11.3.2.1 PMF Configure 0 Register (PMFCFGO)



Figure 11-4. PMF Configure 0 Register (PMFCFGO)
Read anytime.
See bit description for write conditions.
Table 11-2. PMFCFG0 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { WP } \end{gathered}$ | Write Protect - This bit enables write protection to be used for all write-protectable registers. While clear, WP allows write-protected registers to be written. When set, WP prevents any further writes to write-protected registers. Once set, WP can be cleared only by reset. <br> 0 Write-protectable registers may be written. <br> 1 Write-protectable registers are write-protected. |
| $\begin{gathered} \hline 6 \\ \text { MTG } \end{gathered}$ | Multiple Timebase Generators - This bit determines the number of timebase counters used. Once set, MTG can be cleared only by reset. <br> If MTG is set, PWM generators B and C and registers \$xx28-\$xx37 are available. The three generators have their own variable frequencies and are not synchronized. <br> If MTG is cleared, PMF registers from \$xx28-\$xx37 can not be written and read zeroes, and bits EDGEC and EDGEB are ignored. Pair A, Pair B and Pair C PWMs are synchronized to PWM generator A and use registers from \$xx20-\$xx27. <br> 0 Single timebase generator. <br> 1 Multiple timebase generators. |
| $\begin{gathered} 5 \\ \text { EDGEC } \end{gathered}$ | Edge-Aligned or Center-Aligned PWM for Pair C - This bit determines whether PWM4 and PWM5 channels will use edge-aligned or center-aligned waveforms. This bit has no effect if MTG bit is cleared. This bit cannot be modified after the WP bit is set. <br> 0 PWM4 and PWM5 are center-aligned PWMs <br> 1 PWM4 and PWM5 are edge-aligned PWMs |
| $\stackrel{4}{\text { EDGEB }}$ | Edge-Aligned or Center-Aligned PWM for Pair B — This bit determines whether PWM2 and PWM3 channels will use edge-aligned or center-aligned waveforms. This bit has no effect if MTG bit is cleared. This bit cannot be modified after the WP bit is set. <br> 0 PWM2 and PWM3 are center-aligned PWMs <br> 1 PWM2 and PWM3 are edge-aligned PWMs |

Table 11-2. PMFCFG0 Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 3 \\ \text { EDGEA } \end{gathered}$ | Edge-Aligned or Center-Aligned PWM for Pair A - This bit determines whether PWM0 and PWM1 channels will use edge-aligned or center-aligned waveforms. It determines waveforms for Pair B and Pair C if the MTG bit is cleared. This bit cannot be modified after the WP bit is set. <br> 0 PWM0 and PWM1 are center-aligned PWMs <br> 1 PWM0 and PWM1 are edge-aligned PWMs |
| $\begin{gathered} 2 \\ \text { INDEPC } \end{gathered}$ | Independent or Complimentary Operation for Pair C - This bit determines if the PWM channels 4 and 5 will be independent PWMs or complementary PWMs. This bit cannot be modified after the WP bit is set. <br> 0 PWM4 and PWM5 are complementary PWM pair <br> 1 PWM4 and PWM5 are independent PWMs |
| INDEPB | Independent or Complimentary Operation for Pair B - This bit determines if the PWM channels 2 and 3 will be independent PWMs or complementary PWMs. This bit cannot be modified after the WP bit is set. <br> 0 PWM2 and PWM3 are complementary PWM pair <br> 1 PWM2 and PWM3 are independent PWMs |
| 0 INDEPA | Independent or Complimentary Operation for Pair A - This bit determines if the PWM channels 0 and 1 will be independent PWMs or complementary PWMs. This bit cannot be modified after the WP bit is set. <br> 0 PWM0 and PWM1 are complementary PWM pair <br> 1 PWM0 and PWM1 are independent PWMs |

### 11.3.2.2 PMF Configure 1 Register (PMFCFG1)

Module Base $+0 \times 0001$


Figure 11-5. PMF Configure 1 Register (PMFCFG1)
Read anytime. This register cannot be modified after the WP bit is set.
A normal PWM output or positive polarity means that the PWM channel outputs high when the counter value is smaller than or equal to the pulse width value and outputs low otherwise. An inverted output or negative polarity means that the PWM channel outputs low when the counter value is smaller than or equal to the pulse width value and outputs high otherwise.

Table 11-3. PMFCFG1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { ENHA } \end{gathered}$ | Enable Hardware Acceleration - This bit enables writing to the VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits in the PMFCFG3 register. This bit cannot be modified after the WP bit is set. <br> 0 Disable writing to VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits <br> 1 Enable writing to VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits |
| $\begin{gathered} 5 \\ \text { BOTNEGC } \end{gathered}$ | Pair C Bottom-side PWM Polarity — This bit determines the polarity for Pair C bottom-side PWM (PWM5). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWM5 polarity <br> 1 Negative PWM5 polarity |
| $\begin{gathered} 4 \\ \text { TOPNEGC } \end{gathered}$ | Pair C Top-side PWM Polarity — This bit determines the polarity for Pair C top-side PWM (PWM4). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWM4 polarity <br> 1 Negative PWM4 polarity |
| $\begin{gathered} 3 \\ \text { BOTNEGB } \end{gathered}$ | Pair B Bottom-side PWM Polarity - This bit determines the polarity for Pair B bottom-side PWM (PWM3). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWM3 polarity <br> 1 Negative PWM3 polarity |
| $\begin{gathered} 2 \\ \text { TOPNEGB } \end{gathered}$ | Pair B Top-side PWM Polarity — This bit determines the polarity for Pair B top-side PWM (PWM2). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWM2 polarity <br> 1 Negative PWM2 polarity |
| $\begin{gathered} 1 \\ \text { BOTNEGA } \end{gathered}$ | Pair A Bottom-side PWM Polarity — This bit determines the polarity for Pair A bottom-side PWM (PWM1). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWM1 polarity <br> 1 Negative PWM1 polarity |
| $\begin{gathered} 0 \\ \text { TOPNEGA } \end{gathered}$ | Pair A Top-side PWM Polarity - This bit determines the polarity for Pair A top-side PWM (PWM0). This bit cannot be modified after the WP bit is set. <br> 0 Positive PWMO polarity <br> 1 Negative PWMO polarity |

### 11.3.2.3 PMF Configure 2 Register (PMFCFG2)

Module Base $+0 \times 0002$


Figure 11-6. PMF Configure 2 Register (PMFCFG2)
Read and write anytime.
Table 11-4. PMFCFG2 Field Descriptions

| Field | Description |
| :---: | :--- |
| $5-0$ | Mask PWMx—Where $x$ is $0,1,2,3,4$, and 5. <br> 0 MSK[5:0] <br> 1 PWM is unmasked. |
| Note: WARNING When using the TOPNEG/BOTNEG bits and the MSKx bits at the same time, when in <br> complementary mode, it is possible to have both pmf channel outputs of a channel pair set to one. |  |

### 11.3.2.4 PMF Configure 3 Register (PMFCFG3)

Module Base + 0x0003


Figure 11-7. PMF Configure 3 Register (PMFCFG3)
Read and write anytime.
Table 11-5. PMFCFG3 Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| 7 |  |
| PMFWAI | $\begin{array}{l}\text { PMF Stops While in Wait Mode - When set to zero, the PWM generators will continue to run while the chip is } \\ \text { in wait mode. In this mode, the peripheral clock continues to run but the CPU clock does not. If the device enters } \\ \text { wait mode and this bit is one, then the PWM outputs will be switched to their inactive state until wait mode is } \\ \text { exited. At that point the PWM pins will resume operation as programmed in the PWM registers. } \\ 0 \\ 1\end{array}$ |
| PMF continues to run in wait mode. |  |$\}$| PMF is disabled in wait mode. |
| :---: |

### 11.3.2.5 PMF Fault Control Register (PMFFCTL)

Module Base + 0x0004


Figure 11-8. PMF Fault Control Register (PMFFCTL))
Read and write anytime.
Table 11-6. PMFFCTL Field Descriptions

| Field | Description |
| :---: | :--- |
| $7,5,3,1$ |  |
| FMODE[3:0] | Fault $x$ Pin Clearing Mode - This bit selects automatic or manual clearing of FAULTx pin faults. See <br> Section 11.4.8.2, "Automatic Fault Clearing" and Section 11.4.8.3, "Manual Fault Clearing" for more details. <br> $0 \quad$ Manual fault clearing of FAULTx pin faults. <br> 1 <br> Automatic fault clearing of FAULTx pin faults. <br> where $x$ is $0,1,2$, and 3. |
| $6,4,2,0$ | Fault $x$ Pin Interrupt Enable - This bit enables CPU interrupt requests to be generated by the FAULTx pin. The <br> fault protection circuit is independent of the FIEx bit and is active when FPINEx is set. If a fault is detected, the <br> PWM pins are disabled according to the PMF Disable Mapping registers. <br> $0 \quad$ Fault $x$ CPU interrupt requests disabled. <br> 1 <br> Fault x CPU interrupt requests enabled. <br> where $x$ is $0,1,2$ and 3. |

### 11.3.2.6 PMF Fault Pin Enable Register (PMFFPIN)

Module Base $+0 \times 0005$


Figure 11-9. PMF Fault Pin Enable Register (PMFFPIN)
Read anytime. This register cannot be modified after the WP bit is set.
Table 11-7. PMFFPIN Field Descriptions

| Field |  |
| :---: | :--- |
| $6,4,2,0$ | Fault $x$ Pin Enable - Where $x$ is $0,1,2$ and 3. |
| FPINE[2:0] | 0 <br>  <br>  <br> 1 FAULTx pin is disabled for fault protection. |

### 11.3.2.7 PMF Fault Status Register (PMFFSTA)

Module Base + 0x0006


Figure 11-10. PMF Fault Flag Register (PMFFSTA)
Read and write anytime.
Table 11-8. PMFFSTA Field Descriptions

| Field | Description |
| :---: | :--- |
| $6,4,2,0$ | Fault $x$ Pin Flag - This flag is set after the required number of samples have been detected after a rising edge <br> FFLAG[3:0] <br> on the FAULTx pin. Writing a logic one to FFLAGx clears it. Writing a logic zero has no effect. The fault protection <br> is enabled when FPINEx is set even when the PWMs are not enabled; therefore, a fault will be latched in, <br> requiring to be cleared in order to prevent an interrupt. <br> 0 No fault on the FAULTx pin. <br> 1 Fault on the FAULTx pin. <br> Note: Clearing FFLAGx satisfies pending FFLAGx CPU interrupt requests. <br> where $x$ is $0,1,2$ and 3. |

### 11.3.2.8 PMF Fault Qualifying Samples Register (PMFQSMP)

```
Module Base + 0x0007
```



Figure 11-11. PMF Fault Qualifying Samples Register (PMFQSMP))
Read anytime. This register cannot be modified after the WP bit is set.
Table 11-9. PMFQSMP Field Descriptions

| Field | Description |
| :---: | :--- |
| $7-0$ | Fault $x$ Qualifying Samples - This field indicates the number of consecutive samples taken at the FAULTx pin <br> QSMP[3:0 determine if a fault is detected. The first sample is qualified after two bus cycles from the time the fault is <br> present and each sample after that is taken every four bus cycles. See Table 11-10. <br> where $x$ is $0,1,2$ and 3. |

Table 11-10. Qualifying Samples

| QSMPx | Number of Samples |
| :---: | :---: |
| 00 | 1 sample $^{1}$ |
| 01 | 5 samples |
| 10 | 10 samples |
| 11 | 15 samples |

1 There is an asynchronous path from fault pin to disable PWMs immediately but the fault is qualified in two bus cycles.

### 11.3.2.9 PMF Disable Mapping Registers

Module Base $+0 \times 0008$


Figure 11-12. PMF Disable Mapping A Register (PMFDMPA)

Module Base $+0 \times 0009$


Figure 11-13. PMF Disable Mapping B Register (PMFDMPB)

Module Base $+0 \times 000 \mathrm{~A}$


Figure 11-14. PMF Disable Mapping C Register (PMFDMPC)
Read anytime. These registers cannot be modified after the WP bit is set.
Table 11-11. PMFDMPA, PMFDMPB, and PMFDMPC Field Descriptions

| Field | Description |
| :---: | :--- |
| $7-0$ | PMF Disable Mapping Bits - The fault decoder disables PWM pins selected by the fault logic and the disable <br> mapping registers. See Figure 11-15. Each bank of four bits in the disable mapping registers control the mapping <br> of a single PWM pin. Refer to Table 11-12. |

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Figure 11-15. Fault Decoder
Table 11-12. Fault Mapping

| PWM Pin | Controlling Register Bits |
| :---: | :---: |
| PWM0 | DMP03 - DMP00 |
| PWM1 | DMP13 - DMP10 |
| PWM2 | DMP23 - DMP20 |
| PWM3 | DMP33 - DMP30 |
| PWM4 | DMP43 - DMP40 |
| PWM5 | DMP53 - DMP50 |

### 11.3.2.10 PMF Output Control Register (PMFOUTC)

Module Base $+0 \times 000 \mathrm{C}$


Figure 11-16. PMF Output Control Register (PMFOUTC)
Read and write anytime.
Table 11-13. PMFOUTC Field Descriptions

| Field | Description |
| :---: | :--- |
| 5-0 | PMF Output Control Bits - These bits enable software control of their corresponding PWM pin. When <br> OUTCTL[5:0] <br> OUTCTLx is set, the OUTx bit activates and deactivates the PWMx output. <br> When operating the PWM in complementary mode, these bits must be switched in pairs for proper operation. <br> That is OUTCTLO and OUTCTL1 must have the same value; OUTCTL2 and OUTCTL3 must have the same <br> value; and OUTCTL4 and OUTCTL5 must have the same value. <br> 0 Software control disabled <br> 1 <br> Software control enabled <br> where $X$ is $0,1,2,3,4$ and 5 |

### 11.3.2.11 PMF Output Control Bit Register (PMFOUTB)

Module Base + 0x000D


Figure 11-17. PMF Output Control Bit Register (PMFOUTB)
Read and write anytime.
Table 11-14. PMFOUTB Field Descriptions

| Field | Description |
| :---: | :--- |
| 5-0 | PMF Output Control Bits - When the corresponding OUTCTL bit is set, these bits control the PWM pins, <br> illustrated in Table 11-15. |

Table 11-15. Software Output Control

| OUTx Bit | Complementary Channel Operation | Independent Channel Operation |
| :---: | :---: | :---: |
| OUTO | 1—PWM0 is active $0-\mathrm{PWM0}$ is inactive | 1—PWM0 is active 0 - PWMO is inactive |
| OUT1 | 1—PWM1 is complement of PWM0 $0 —$ PWM1 is inactive | 1—PWM1 is active 0 —PWM1 is inactive |
| OUT2 | 1—PWM2 is active 0 -PWM2 is inactive | 1—PWM2 is active 0 —PWM2 is inactive |
| OUT3 | 1—PWM3 is complement of PWM2 $0-\mathrm{PWM} 3$ is inactive | 1—PWM3 is active 0 —PWM3 is inactive |
| OUT4 | 1—PWM4 is active 0—PWM4 is inactive | 1—PWM4 is active 0 —PWM4 is inactive |
| OUT5 | 1—PWM5 is complement of PWM4 0-PWM5 is inactive | 1—PWM5 is active 0 -PWM5 is inactive |

### 11.3.2.12 PMF Deadtime Sample Register (PMFDTMS)

Module Base + 0x000E


Figure 11-18. PMF Deadtime Sample Register (PMFDTMS))
Read anytime and writes have no effect.
Table 11-16. PMFDTMS Field Descriptions

| Field | Description |
| :---: | :--- |
| $5-0$ | PMF Deadtime Sample Bits - The DTx bits are grouped in pairs, DT0 and DT1, DT2 and DT3, DT4, and DT5. <br> ET[5:0] <br> Each pair reflects the corresponding $\overline{\text { ISx pin value as sampled at the end of deadtime. }}$ |

### 11.3.2.13 PMF Correction Control Register (PMFCCTL)

Module Base $+0 \times 000 \mathrm{~F}$


Figure 11-19. PMF Correction Control Register (PMFCCTL)
Read and write anytime.
Table 11-17. PMFCCTL Field Descriptions

| Field | Description |
| :---: | :--- |
| $5-4$ |  |
| ISENS | Current Status Sensing Method - This field selects the top/bottom correction scheme, illustrated in <br> Table 11-18. <br> Note: Assume the user will provide current sensing circuitry causing the voltage at the corresponding input pin <br> to be low for positive current and high for negative current. In addition, it assumes the top PWMs are PWM <br> 0,2, and 4 while the bottom PWMs are PWM 1, 3, and 5. |
| Note: The ISENS bits are not buffered. Changing the current status sensing method can affect the present PWM <br> cycle. |  |

Table 11-17. PMFCCTL Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\stackrel{2}{\text { IPOLC }}$ | Current Polarity — This buffered bit selects the PMF Value register for the PWM4 and PWM5 pins in top/bottom software correction in complementary mode. <br> 0 PMF Value 4 register in next PWM cycle. <br> 1 PMF Value 5 register in next PWM cycle. <br> Note: The IPOLx bits take effect at the beginning of the next load cycle, regardless of the state of the load okay bit, LDOK. Select top/bottom software correction by writing 01 to the current select bits, ISENS[1:0], in the PWM control register. Reading the IPOLx bits read the buffered value and not necessarily the value currently in effect. |
| $\stackrel{1}{\text { IPOLB }}$ | Current Polarity — This buffered bit selects the PMF Value register for the PWM2 and PWM3 pins in top/bottom software correction in complementary mode. <br> 0 PMF Value 2 register in next PWM cycle. <br> 1 PMF Value 3 register in next PWM cycle. <br> Note: The IPOLx bits take effect at the beginning of the next load cycle, regardless of the state of the load okay bit, LDOK. Select top/bottom software correction by writing 01 to the current select bits, ISENS[1:0], in the PWM control register. Reading the IPOLx bits read the buffered value and not necessarily the value currently in effect. |
| $\begin{gathered} 0 \\ \text { IPOLA } \end{gathered}$ | Current Polarity — This buffered bit selects the PMF Value register for the PWM0 and PWM1 pins in top/bottom software correction in complementary mode. <br> 0 PMF Value 0 register in next PWM cycle. <br> 1 PMF Value 1 register in next PWM cycle. <br> Note: The IPOLx bits take effect at the beginning of the next load cycle, regardless of the state of the load okay bit, LDOK. Select top/bottom software correction by writing 01 to the current select bits, ISENS[1:0], in the PWM control register. Reading the IPOLx bits read the buffered value and not necessarily the value currently in effect. |

Table 11-18. Correction Method Selection

| ISENS | Correction Method |
| :---: | :---: |
| 00 | No correction ${ }^{1}$ |
| 01 | Manual correction |
| 10 | Current status sample correction on pins $\overline{\mathrm{IS} 0}, \overline{\mathrm{IS} 1}$, and $\overline{\mathrm{IS} 2}$ during deadtime ${ }^{2}$ |
| 11 | Current status sample on pins IS0, $\overline{\text { IS1 }}$, and $\overline{\text { IS2 }}^{3}$ At the half cycle in center-aligned operation At the end of the cycle in edge-aligned operation |

${ }^{1}$ The current status pins can be used as general purpose input/output ports.
${ }^{2}$ The polarity of the $\overline{\mathrm{ISx}}$ pin is latched when both the top and bottom PWMs are off. At the $0 \%$ and $100 \%$ duty cycle boundaries, there is no deadtime, so no new current value is sensed.
${ }^{3}$ Current is sensed even with $0 \%$ or $100 \%$ duty cycle.

### 11.3.2.14 PMF Value 0 Register (PMFVALO)



Figure 11-20. PMF Value 0 Register (PMFVALO)
Read and write anytime.
Table 11-19. PMFVALO Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 0 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM0 clock period. <br> A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms <br> PMFVALivate and deactivate refer to the high and low logic states of the PWM output. <br> Note: PMFVALO is buffered. The value written does not take effect until the LDOK bit is set and the next PWM <br> load cycle begins Reading PMFVALO reads the value in the buffer and not necessarily the value the PWM <br> generator is currently using. |

### 11.3.2.15 PMF Value 1 Register (PMFVAL1)



Figure 11-21. PMF Value 1 Register (PMFVAL1)
Read and write anytime.
Table 11-20. PMFVAL1 Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 1 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM1 clock period. |
| PMFVAL1 | A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms <br> activate and deactivate refer to the high and low logic states of the PWM output. <br> Note: PMFVAL1 is buffered. The value written does not take effect until the LDOK bit is set and the next PWM <br> load cycle begins. Reading PMFVAL1 reads the value in the buffer and not necessarily the value the PWM <br> generator is currently using. |

### 11.3.2.16 PMF Value 2 Register (PMFVAL2)



Figure 11-22. PMF Value 2 Register (PMFVAL2)
Read and write anytime.
Table 11-21. PMFVAL2 Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 2 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM2 clock period. |
| PMFVAL2 | A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms <br> activate and deactivate refer to the high and low logic states of the PWM output. <br> Note: PMFVAL2 is buffered. The value written does not take effect until the LDOK bit is set and the next PWM <br> load cycle begins. Reading PMFVAL2 reads the value in the buffer and not necessarily the value the PWM <br> generator is currently using. |

### 11.3.2.17 PMF Value 3 Register (PMFVAL3)



Figure 11-23. PMF Value 3 Register (PMFVAL3)
Read and write anytime.
Table 11-22. PMFVAL3 Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 3 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM3 clock period. |
| PMFVAL3 | A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms <br> activate and deactivate refer to the high and low logic states of the PWM output. <br> Note: PMFVAL3 is buffered. The value written does not take effect until the LDOK bit is set and the next PWM <br> load cycle begins. Reading PMFVAL3 reads the value in the buffer and not necessarily the value the PWM <br> generator is currently using. |

### 11.3.2.18 PMF Value 4 Register (PMFVAL4)



Figure 11-24. PMF Value 4 Register (PMFVAL4)
Read and write anytime.
Table 11-23. PMFVAL4 Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 4 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM4 clock period. <br> A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms |
| activate and deactivate refer to the high and low logic states of the PWM output. |  |
| Note: PMFVAL4 is buffered. The value written does not take effect until the LDOK bit is set and the next PWM |  |
| load cycle begins. Reading PMFVAL4 reads the value in the buffer and not necessarily the value the PWM |  |
| generator is currently using. |  |

### 11.3.2.19 PMF Value 5 Register (PMFVAL5)



Figure 11-25. PMF Value 5 Register (PMFVAL5)
Read and write anytime.
Table 11-24. PMFVAL5 Field Descriptions

| Field | Description |
| :---: | :--- |
| 16-0 | PMF Value 5 Bits - The 16-bit signed value in this buffered register is the pulse width in PWM5 clock period. |
| PMFVAL5 | A value less than or equal to zero deactivates the PWM output for the entire PWM period. A value greater than, <br> or equal to the modulus, activates the PWM output for the entire PWM period. See Table 11-46. The terms <br> activate and deactivate refer to the high and low logic states of the PWM output. <br> Note: PMFVAL5 is buffered. The value written does not take effect until the LDOK bit is set and the next PWM <br> load cycle begins. Reading PMFVAL5 reads the value in the buffer and not necessarily the value the PWM <br> generator is currently using. |

### 11.3.2.20 PMF Enable Control A Register (PMFENCA)

Module Base $+0 \times 0020$


Figure 11-26. PMF Enable Control A Register (PMFENCA)
Read and write anytime.
Table 11-25. PMFENCA Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| 7 |  |
| PWMENA | PWM Generator A Enable - When MTG is clear, this bit when set enables the PWM generators A, B and C <br> and the PWM0-5 pins. When PWMENA is clear, PWM generators A, B and C are disabled, and the PWM0-5 <br> pins are in their inactive states unless the corresponding OUTCTLx bits are set. <br> When MTG is set, this bit when set enables the PWM generator A and the PWM0 and PWM1 pins. When <br> PWMENA is clear, the PWM generator A is disabled and PWM0 and PWM1 pins are in their inactive states <br> unless the OUTCTL0 and OUTCTL1 bits are set. <br> 0 <br> 1 |
| 1 | PWM generator A and PWM0-1 (2-5 if MTG=0) pins disabled unless the respective OUTCTL bit is set. |
| LDOKA | Load Okay A - When MTG is clear, this bit allows loads of the PRSCA bits, the PMFMODA register and the <br> PWMVAL0-5 registers into a set of buffers. The buffered prescaler A divisor, PWM counter modulus A value, and <br> all PWM pulse widths take effect at the next PWM reload. <br> When MTG is set, this bit allows loads of the PRSCA bits, the PMFMODA register and the PWMVAL0-1 registers <br> into a set of buffers. The buffered prescaler divisor A, PWM counter modulus A value, PWM0-1 pulse widths take <br> effect at the next PWM reload. <br> Set LDOKA by reading it when it is logic zero and then writing a logic one to it. LDOKA is automatically cleared <br> after the new values are loaded, or can be manually cleared before a reload by writing a logic zero to it. Reset <br> clears LDOKA. <br> 0 <br> 1 <br> Do not load new modulus A, prescaler A, and PWM0-1 (2-5 if MTG=0) values <br> Load prescaler A, modulus A, and PWM0-1 (2-5 if MTG=0) values |
| 0 |  |
| Note not set PWMENA bit before setting the LDOKA bit and do not clear the LDOKA bit at the same time as |  |
| setting the PWMENA bit. |  |

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### 11.3.2.21 PMF Frequency Control A Register (PMFFQCA)

Module Base + 0x0021


Figure 11-27. PMF Frequency Control A Register (PMFFQCA)
Read and write anytime.
Table 11-26. PMFFQCA Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7-4 \\ \text { LDFQA } \end{gathered}$ | Load Frequency A - This field selects the PWM load frequency according to Table 11-27. See Section 11.4.7.2, "Load Frequency" for more details. <br> Note: The LDFQA field takes effect when the current load cycle is complete, regardless of the state of the load okay bit, LDOKA. Reading the LDFQA field reads the buffered value and not necessarily the value currently in effect. |
| $\begin{gathered} 3 \\ \text { HALFA } \end{gathered}$ | Half Cycle Reload A - This bit enables half-cycle reloads in center-aligned PWM mode. This bit has no effect on edge-aligned PWMs. <br> 0 Half-cycle reloads disabled <br> 1 Half-cycle reloads enabled |
| $\begin{gathered} 2-1 \\ \text { PRSCA } \end{gathered}$ | Prescaler A - This buffered field selects the PWM clock frequency illustrated in Table 11-28. <br> Note: Reading the PRSCA field reads the buffered value and not necessarily the value currently in effect. The PRSCA field takes effect at the beginning of the next PWM cycle and only when the load okay bit, LDOKA, is set. |
| 0 PWMRFA | PWM Reload Flag A - This flag is set at the beginning of every reload cycle regardless of the state of the LDOKA bit. Clear PWMRFA by reading PMFFQCA with PWMRFA set and then writing a logic one to the PWMRFA bit. If another reload occurs before the clearing sequence is complete, writing logic one to PWMRFA has no effect. <br> 0 No new reload cycle since last PWMRFA clearing <br> 1 New reload cycle since last PWMRFA clearing <br> Note: Clearing PWMRFA satisfies pending PWMRFA CPU interrupt requests. |

Table 11-27. PWM Reload Frequency A

| LDFQA | PWM Reload Frequency | LDFQ[3:0] | PWM Reload Frequency |
| :---: | :---: | :---: | :---: |
| 0000 | Every PWM opportunity | 1000 | Every 9 PWM opportunities |
| 0001 | Every 2 PWM opportunities | 1001 | Every 10 PWM opportunities |
| 0010 | Every 3 PWM opportunities | 1010 | Every 11 PWM opportunities |
| 0011 | Every 4 PWM opportunities | 1011 | Every 12 PWM opportunities |
| 0100 | Every 5 PWM opportunities | 1100 | Every 13 PWM opportunities |
| 0101 | Every 6 PWM opportunities | 1101 | Every 14 PWM opportunities |
| 0110 | Every 7 PWM opportunities | 1110 | Every 15 PWM opportunities |
| 0111 | Every 8 PWM opportunities | 1111 | Every 16 PWM opportunities |

Table 11-28. PWM Prescaler A

| PRSCA | PWM Clock Frequency |
| :---: | :---: |
| 00 | $\mathrm{f}_{\text {bus }}$ |
| 01 | $\mathrm{f}_{\text {bus }} / 2$ |
| 10 | $\mathrm{f}_{\text {bus }} / 4$ |
| 11 | $\mathrm{f}_{\text {bus }} / 8$ |

### 11.3.2.22 PMF Counter A Register (PMFCNTA)

Module Base $+0 \times 0022$


Figure 11-28. PMF Counter A Register (PMFCNTA)
Read anytime and writes have no effect.
Table 11-29. PMFCNTA Field Descriptions

| Field | Description |
| :---: | :---: |
| $14-0$ | PMF Counter A Bits — This register displays the state of the 15-bit PWM A counter. |
| PMFCNTA |  |

### 11.3.2.23 PMF Counter Modulo A Register (PMFMODA)

Module Base + 0x0024


Figure 11-29. PMF Counter Modulo A Register (PMFMODA)
Read and write anytime.

## Table 11-30. PMFMODA Field Descriptions

| Field | Description |
| :---: | :--- |
| 14-0 | PMF Counter Modulo A Bits - The 15-bit unsigned value written to this register is the PWM period in PWM <br> clock periods. Do not write a modulus value of zero. <br> Note: The PWM counter modulo register is buffered. The value written does not take effect until the LDOKA bit <br> is set and the next PWM load cycle begins. Reading PMFMODA reads the value in the buffer. It is not <br> necessarily the value the PWM generator A is currently using. |

### 11.3.2.24 PMF Deadtime A Register (PMFDTMA)



Figure 11-30. PMF Deadtime A Register (PMFDTMA)
Read anytime. This register cannot be modified after the WP bit is set.
Table 11-31. PMFDTMA Field Descriptions

| Field | Description |
| :---: | :---: |
| 11-0 | PMF Deadtime A Bits - The 12-bit value written to this register is the number of PWM clock cycles in <br> complementary channel operation. A reset sets the PWM deadtime register to a default value of 0x0FFF, <br> selecting a deadtime of 256-PWM clock cycles minus one bus clock cycle. <br> Note: Deadtime is affected by changes to the prescaler value. The deadtime duration is determined as follows: <br> DT $=P \times$ PMFDTMA -1, where DT is deadtime, P is the prescaler value, PMFDTMA is the programmed <br> value of dead time. For example: if the prescaler is programmed for a divide-by-two and the PMFDTMA is <br> set to five, then $P=2$ and the deadtime value is equal to $\mathrm{DT}=2 \times 5-1=9$ IPbus clock cycles. A special <br> case exists when the $\mathrm{P}=1$, then $\mathrm{DT}=$ PMFDTMA. |

### 11.3.2.25 PMF Enable Control B Register (PMFENCB)

Module Base $+0 \times 0028$


Figure 11-31. PMF Enable Control B Register (PMFENCB)
Read anytime and write only if MTG is set.
Table 11-32. PMFENCB Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| 7 |  |
| PWMENB | $\begin{array}{l}\text { PWM Generator B Enable - If MTG is clear, this bit reads zero and cannot be written. } \\ \text { If MTG is set, this bit when set enables the PWM generator B and the PWM2 and PWM3 pins. When PWMENB } \\ \text { is clear, PWM generator B is disabled, and the PWM2 and PWM3 pins are in their inactive states unless the } \\ \text { OUTCTL2 and OUTCTL3 bits are set. } \\ 0 \\ 1\end{array}$ |
| 1 | PWM generator B and PWM2-3 pins disabled unless the respective OUTCTL bit is set. |$\}$| Load Okay B - If MTG is clear, this bit reads zero and cannot be written. |
| :--- |
| If MTG is set, this bit loads the PRSCB bits, the PMFMODB register and the PWMVAL2-3 registers into a set of |
| buffers. The buffered prescaler divisor B, PWM counter modulus B value, PWM2-3 pulse widths take effect at |
| the next PWM reload. |
| Set LDOKB by reading it when it is logic zero and then writing a logic one to it. LDOKB is automatically cleared |
| after the new values are loaded, or can be manually cleared before a reload by writing a logic zero to it. Reset |
| clears LDOKB. |
| 0 |
| 1 |
| Do not load new modulus B, prescaler B, and PWM2-3 values. |
| Note: Do not set PWMENB bit before setting the LDOKB bit and do not clear the LDOKB bit at the same time as |
| setting the PWMENB bit. |

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### 11.3.2.26 PMF Frequency Control B Register (PMFFQCB)

Module Base $+0 \times 0029$


Figure 11-32. PMF Frequency Control B Register (PMFFQCB)
Read anytime and write only if MTG is set.
Table 11-33. PMFFQCB Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7-4 \\ \text { LDFQB } \end{gathered}$ | Load Frequency B - This field selects the PWM load frequency according to Table 11-34. See Section 11.4.7.2, "Load Frequency" for more details. <br> Note: The LDFQB field takes effect when the current load cycle is complete, regardless of the state of the load okay bit, LDOKB. Reading the LDFQB field reads the buffered value and not necessarily the value currently in effect. |
| $\stackrel{3}{\text { HALFB }}$ | Half Cycle Reload B - This bit enables half-cycle reloads in center-aligned PWM mode. This bit has no effect on edge-aligned PWMs. <br> 0 Half-cycle reloads disabled <br> 1 Half-cycle reloads enabled |
| $\begin{gathered} 2-1 \\ \text { PRSCB } \end{gathered}$ | Prescaler B — This buffered field selects the PWM clock frequency illustrated in Table 11-35. <br> Note: Reading the PRSCB field reads the buffered value and not necessarily the value currently in effect. The PRSCB field takes effect at the beginning of the next PWM cycle and only when the load okay bit, LDOKB, is set. |
| 0 PWMRFB | PWM Reload Flag B — This flag is set at the beginning of every reload cycle regardless of the state of the LDOKB bit. Clear PWMRFB by reading PMFFQCB with PWMRFB set and then writing a logic one to the PWMRFB bit. If another reload occurs before the clearing sequence is complete, writing logic one to PWMRFB has no effect. <br> 0 No new reload cycle since last PWMRFB clearing <br> 1 New reload cycle since last PWMRFB clearing <br> Note: Clearing PWMRFB satisfies pending PWMRFB CPU interrupt requests. |

Table 11-34. PWM Reload Frequency B

| LDFQB | PWM Reload Frequency | LDFQ[3:0] | PWM Reload Frequency |
| :---: | :---: | :---: | :---: |
| 0000 | Every PWM opportunity | 1000 | Every 9 PWM opportunities |
| 0001 | Every 2 PWM opportunities | 1001 | Every 10 PWM opportunities |
| 0010 | Every 3 PWM opportunities | 1010 | Every 11 PWM opportunities |
| 0011 | Every 4 PWM opportunities | 1011 | Every 12 PWM opportunities |
| 0100 | Every 5 PWM opportunities | 1100 | Every 13 PWM opportunities |
| 0101 | Every 6 PWM opportunities | 1101 | Every 14 PWM opportunities |
| 0110 | Every 7 PWM opportunities | 1110 | Every 15 PWM opportunities |
| 0111 | Every 8 PWM opportunities | 1111 | Every 16 PWM opportunities |

Table 11-35. PWM Prescaler B

| PRSCB | PWM Clock Frequency |
| :---: | :---: |
| 00 | $\mathrm{f}_{\text {bus }}$ |
| 01 | $\mathrm{f}_{\text {bus }} / 2$ |
| 10 | $\mathrm{f}_{\text {bus }} / 4$ |
| 11 | $\mathrm{f}_{\text {bus }} / 8$ |

### 11.3.2.27 PMF Counter B Register (PMFCNTB)

Module Base + 0x002A

|  | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | PMFCNTB |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| w |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  | Unimplemented or Reserved |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |

Figure 11-33. PMF Counter B Register (PMFCNTB)
Read anytime and writes have no effect.
Table 11-36. PMFCNTB Field Descriptions

| Field | Description |
| :---: | :---: |
| $14-0$ | PMF Counter B — This register displays the state of the 15-bit PWM B counter. |
| PMFCNTB |  |

### 11.3.2.28 PMF Counter Modulo B Register (PMFMODB)



Figure 11-34. PMF Counter Modulo B Register (PMFMODB)
Read anytime and write only if MTG is set.
Table 11-37. PMFMODB Field Descriptions

| Field | Description |
| :---: | :--- |
| $14-0$ | PMF Counter Modulo B - The 15-bit unsigned value written to this register is the PWM period in PWM clock <br> periods. Do not write a modulus value of zero. <br> Note: The PWM counter modulo register is buffered. The value written does not take effect until the LDOKB bit <br> is set and the next PWM load cycle begins. Reading PMFMODB reads the value in the buffer. It is not <br> necessarily the value the PWM generator B is currently using. |

### 11.3.2.29 PMF Deadtime B Register (PMFDTMB)



Figure 11-35. PMF Deadtime B Register (PMFDTMB)
Read anytime and write only if MTG is set. This register cannot be modified after the WP bit is set.
Table 11-38. PMFDTMB Field Descriptions

| Field | Description |
| :---: | :--- |
| 11-0 | PMF Deadtime B - The 12-bit value written to this register is the number of PWM clock cycles in <br> complementary channel operation. A reset sets the PWM deadtime register to a default value of 0x0FFF, <br> selecting a deadtime of 256-PWM clock cycles minus one bus clock cycle. <br> Note: Deadtime is affected by changes to the prescaler value. The deadtime duration is determined as follows: <br> DT $=P \times$ PMFDTMB -1, where DT is deadtime, P is the prescaler value, PMFDTMB is the programmed <br> value of dead time. For example: if the prescaler is programmed for a divide-by-two and the PMFDTMB is <br> set to five, then $\mathrm{P}=2$ and the deadtime value is equal to $\mathrm{DT}=2 \times 5-1=9$ IPbus clock cycles. A special <br> case exists when the $\mathrm{P}=1$, then $\mathrm{DT}=\mathrm{PMFDTMB}$. |

### 11.3.2.30 PMF Enable Control C Register (PMFENCC)

Module Base $+0 \times 0030$


Figure 11-36. PMF Enable Control C Register (PMFENCC)
Read anytime and write only if MTG is set.
Table 11-39. PMFENCC Field Descriptions

| Field | Description |
| :---: | :---: |
| $7$ <br> PWMENC | PWM Generator C Enable - If MTG is clear, this bit reads zero and cannot be written. <br> If MTG is set, this bit when set enables the PWM generator $C$ and the PWM4 and PWM5 pins. When PWMENC is clear, PWM generator $C$ is disabled, and the PWM4 and PWM5 pins are in their inactive states unless the OUTCTL4 and OUTCTL5 bits are set. <br> 0 PWM generator $C$ and PWM4-5 pins disabled unless the respective OUTCTL bit is set. <br> 1 PWM generator $C$ and PWM4-5 pins enabled. |
| $\begin{gathered} 1 \\ \text { LDOKC } \end{gathered}$ | Load Okay C - If MTG is clear, this bit reads zero and can not be written. <br> If MTG is set, this bit loads the PRSCC bits, the PMFMODC register and the PWMVAL4-5 registers into a set of buffers. The buffered prescaler divisor C, PWM counter modulus $C$ value, PWM4-5 pulse widths take effect at the next PWM reload. <br> Set LDOKC by reading it when it is logic zero and then writing a logic one to it. LDOKC is automatically cleared after the new values are loaded, or can be manually cleared before a reload by writing a logic zero to it. Reset clears LDOKC. <br> 0 Do not load new modulus C, prescaler C, and PWM4-5 values. <br> 1 Load prescaler C, modulus C, and PWM4-5 values. <br> Note: Do not set PWMENC bit before setting the LDOKC bit and do not clear the LDOKC bit at the same time as setting the PWMENC bit. |
| 0 PWMRIEC | PWM Reload Interrupt Enable C - If MTG is clear, this bit reads zero and cannot be written. If MTG is set, this bit enables the PWMRFC flag to generate CPU interrupt requests. <br> 0 PWMRFC CPU interrupt requests disabled <br> 1 PWMRFC CPU interrupt requests enabled |

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### 11.3.2.31 PMF Frequency Control C Register (PMFFQCC)

Module Base + 0x0031


Figure 11-37. PMF Frequency Control C Register (PMFFQCC)
Read anytime and write only if MTG is set.
Table 11-40. PMFFQCC Field Descriptions

| Field | Description |
| :---: | :---: |
| $7-4$ |  |
| LDFQC | Load Frequency C - This field selects the PWM load frequency according to Table 11-41. See <br> Section 11.4.7.2, "Load Frequency" for more details. <br> Note: The LDFQC field takes effect when the current load cycle is complete, regardless of the state of the load <br> okay bit, LDOKC. Reading the LDFQC field reads the buffered value and not necessarily the value <br> currently in effect. |
| 3 | Half Cycle Reload C - This bit enables half-cycle reloads in center-aligned PWM mode. This bit has no effect <br> on edge-aligned PWMs. <br> 0 Half-cycle reloads disabled <br> 1 Half-cycle reloads enabled |
| 2 | Prescaler C - This buffered field selects the PWM clock frequency illustrated in Table 11-42. <br> Note: Reading the PRSCC field reads the buffered value and not necessarily the value currently in effect. The <br> PRSCC field takes effect at the beginning of the next PWM cycle and only when the load okay bit, LDOKC, <br> is set. |
| 0 | PWM Reload Flag C - This flag is set at the beginning of every reload cycle regardless of the state of the <br> PDOKC bit. Clear PWMRFC by reading PMFFQCC with PWMRFC set and then writing a logic one to the |
| PWMRFC |  |
| PWMRFC bit. If another reload occurs before the clearing sequence is complete, writing logic one to PWMRFC |  |
| has no effect. |  |
| 0 No new reload cycle since last PWMRFC clearing |  |
| 1 New reload cycle since last PWMRFC clearing |  |
| Note: Clearing PWMRFC satisfies pending PWMRFC CPU interrupt requests. |  |

Table 11-41. PWM Reload Frequency C

| LDFQC | PWM Reload Frequency | LDFQ[3:0] | PWM Reload Frequency |
| :---: | :---: | :---: | :---: |
| 0000 | Every PWM opportunity | 1000 | Every 9 PWM opportunities |
| 0001 | Every 2 PWM opportunities | 1001 | Every 10 PWM opportunities |
| 0010 | Every 3 PWM opportunities | 1010 | Every 11 PWM opportunities |
| 0011 | Every 4 PWM opportunities | 1011 | Every 12 PWM opportunities |
| 0100 | Every 5 PWM opportunities | 1100 | Every 13 PWM opportunities |
| 0101 | Every 6 PWM opportunities | 1101 | Every 14 PWM opportunities |
| 0110 | Every 7 PWM opportunities | 1110 | Every 15 PWM opportunities |
| 0111 | Every 8 PWM opportunities | 1111 | Every 16 PWM opportunities |

Table 11-42. PWM Prescaler C

| PRSCC | PWM Clock Frequency |
| :---: | :---: |
| 00 | $\mathrm{f}_{\text {bus }}$ |
| 01 | $\mathrm{f}_{\text {bus }} / 2$ |
| 10 | $\mathrm{f}_{\text {bus }} / 4$ |
| 11 | $\mathrm{f}_{\text {bus }} / 8$ |

### 11.3.2.32 PMF Counter C Register (PMFCNTC)

Module Base $+0 \times 0032$

|  | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | PMFCNTC |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| w |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  | Unimplemented or Res |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |

Figure 11-38. PMF Counter C Register (PMFCNTC)
Read anytime and writes have no effect.
Table 11-43. PMFCNTC Field Descriptions

| Field | Description |
| :---: | :---: |
| $14-0$ | PMF Counter C — This register displays the state of the 15-bit PWM C counter. |
| PMFCNTC‘ |  |

### 11.3.2.33 PMF Counter Modulo C Register (PMFMODC)

Module Base + 0x0034

|  | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | PMFMODC |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| W |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  | = Unimplemented or Reserved |  |  |  |  |  |  |  |  |  |  |  |  |  |  |  |

Figure 11-39. PMF Counter Modulo C Register (PMFMODC)
Read anytime and write only if MTG is set.
Table 11-44. PMFMODC Field Descriptions

| Field | Description |
| :---: | :--- |
| $14-0$ | PMF Couner Modulo C - The 15-bit unsigned value written to this register is the PWM period in PWM clock <br> periods. Do not write a modulus value of zero. <br> Note: The PWM counter modulo register is buffered. The value written does not take effect until the LDOKC bit <br> is set and the next PWM load cycle begins. Reading PMFMODC reads the value in the buffer. It is not <br> necessarily the value the PWM generator A is currently using. |

### 11.3.2.34 PMF Deadtime C Register (PMFDTMC)



Figure 11-40. PMF Deadtime C Register (PMFDTMC)
Read anytime and write only if MTG is set. This register cannot be modified after the WP bit is set.
Table 11-45. PMFDTMC Field Descriptions

| Field | Description |
| :---: | :--- |
| 11-0 | PMF Deadtime C - The 12-bit value written to this register is the number of PWM clock cycles in <br> complementary channel operation. A reset sets the PWM deadtime register to a default value of 0x0FFF, <br> selecting a deadtime of 4096-PWM clock cycles minus one bus clock cycle. <br> Note: Deadtime is affected by changes to the prescaler value. The deadtime duration is determined as follows: <br> DT $=P \times$ PMFDTMC - 1, where DT is deadtime, P is the prescaler value, PMFDTMC is the programmed <br> value of dead time. For example: if the prescaler is programmed for a divide-by-two and the PMFDTMC is <br> set to five, then $P=2$ and the deadtime value is equal to $\mathrm{DT}=2 \times 5-1=9$ IPbus clock cycles. A special <br> case exists when the $P=1$, then $\mathrm{DT}=$ PMFDTMC. |

### 11.4 Functional Description

### 11.4.1 Block Diagram

A block diagram of the PMF is shown in Figure 11-1. The MTG bit allows the use of multiple PWM generators (A, B, and C) or just a single generator (A). PWM0 and PWM1 constitute Pair A, PWM2 and PWM3 constitute Pair B, and PWM4 and PWM5 constitute Pair C.

### 11.4.2 Prescaler

To permit lower PWM frequencies, the prescaler produces the PWM clock frequency by dividing the bus clock frequency by one, two, four, and eight. Each PWM generator has its own prescaler divisor. Each prescaler is buffered and will not be used by its PWM generator until the corresponding Load OK bit is set and a new PWM reload cycle begins.

### 11.4.3 PWM Generator

Each PWM generator contains a 15-bit up/down PWM counter producing output signals with software-selectables:

- Alignment-The logic state of each pair EDGE bit determines whether the PWM pair outputs are edge-aligned or center-aligned
- Period-The value written to each pair PWM counter modulo register is used to determine the PWM pair period. The period can also be varied by using the prescaler
- With edge-aligned output, the modulus is the period of the PWM output in clock cycles
- With center-aligned output, the modulus is one-half of the PWM output period in clock cycles
- Pulse width-The number written to the PWM value register determines the pulse width duty cycle of the PWM output in clock cycles
- With center-aligned output, the pulse width is twice the value written to the PWM value register
- With edge-aligned output, the pulse width is the value written to the PWM value register


### 11.4.3.1 Alignment

Each edge-align bit, EDGEx, selects either center-aligned or edge-aligned PWM generator outputs.


Figure 11-41. Center-Aligned PWM Output


Figure 11-42. Edge-Aligned PWM Output
NOTE
Because of the equals-comparator architecture of this PMF, the modulus equals zero case is considered illegal. Therefore, the modulus register does not return to zero, and a modulus value of zero will result in waveforms inconsistent with the other modulus waveforms. If a modulus of zero is loaded, the counter will continually count down from \$7FFF. This operation will not be tested or guaranteed. Consider it illegal. However, the dead-time constraints and fault conditions will still be guaranteed.

### 11.4.3.2 Period

A PWM period is determined by the value written to the PWM counter modulo register.
The PWM counter is an up/down counter in a center-aligned operation. In this mode the PWM highest output resolution is two bus clock cycles.

PWM period $=(\mathrm{PWM}$ modulus $) \times(\mathrm{PWM}$ clock period $) \times 2$


Figure 11-43. Center-Aligned PWM Period

In an edge-aligned operation, the PWM counter is an up counter. The PWM output resolution is one bus clock cycle.

PWM period $=$ PWM modulus $\times$ PWM clock period


Figure 11-44. Edge-Aligned PWM Period

### 11.4.3.3 Duty Cycle

The signed 16-bit number written to the PMF value registers is the pulse width in PWM clock periods of the PWM generator output.

$$
\text { Duty cycle }=\frac{\text { PMFVAL }}{\text { MODULUS }} \times 100
$$

## NOTE

A PWM value less than or equal to zero deactivates the PWM output for the entire PWM period. A PWM value greater than or equal to the modulus activates the PWM output for the entire PWM period.

Table 11-46. PWM Value and Underflow Conditions

| PMFVALx | Condition | PWM Value Used |
| :---: | :---: | :---: |
| $\$ 0000-\$ 7 F F F$ | Normal | Value in registers |
| $\$ 8000-\$ F F F F$ | Underflow | $\$ 0000$ |

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Center-aligned operation is illustrated in Figure 11-45.
PWM pulse width $=($ PWM value $) \times($ PWM clock period $) \times 2$


Figure 11-45. Center-Aligned PWM Pulse Width
Edge-aligned operation is illustrated in Figure 11-46.
PWM pulse width $=(\mathrm{PWM}$ value $) \times(\mathrm{PWM}$ clock period $)$


Figure 11-46. Edge-Aligned PWM Pulse Width

### 11.4.4 Independent or Complementary Channel Operation

Writing a logic one to a INDEPx bit configures a pair of the PWM outputs as two independent PWM channels. Each PWM output has its own PWM value register operating independently of the other channels in independent channel operation.

Writing a logic zero to a INDEPx bit configures the PWM output as a pair of complementary channels. The PWM pins are paired as shown in Figure 11-47 in complementary channel operation.


Figure 11-47. Complementary Channel Pairs
The complementary channel operation is for driving top and bottom transistors in a motor drive circuit, such as the one in Figure 11-48.


Figure 11-48. Typical 3 Phase AC Motor Drive

In complementary channel operation, there are three additional features:

- Deadtime insertion
- Separate top and bottom pulse width correction for distortions are caused by deadtime inserted and the motor drive characteristics
- Separate top and bottom output polarity control
- Swap functionality


### 11.4.5 Deadtime Generators

While in the complementary mode, each PWM pair can be used to drive top/bottom transistors, as shown in Figure 11-49. Ideally, the PWM pairs are an inversion of each other. When the top PWM channel is active, the bottom PWM channel is inactive, and vice versa.

## NOTE

To avoid a short-circuit on the DC bus and endangering the transistor, there must be no overlap of conducting intervals between top and bottom transistor. But the transistor's characteristics make its switching-off time longer than switching-on time. To avoid the conducting overlap of top and bottom transistors, deadtime needs to be inserted in the switching period.

Deadtime generators automatically insert software-selectable activation delays into each pair of PWM outputs. The deadtime register (PMFDTMx) specifies the number of PWM clock cycles to use for deadtime delay. Every time the deadtime generator inputs changes state, deadtime is inserted. Deadtime forces both PWM outputs in the pair to the inactive state.

A method of correcting this, adding to or subtracting from the PWM value used, is discussed next.


Figure 11-49. Deadtime Generators


Figure 11-50. Deadtime Insertion, Center Alignment


Figure 11-51. Deadtime at Duty Cycle Boundaries


Figure 11-52. Deadtime and Small Pulse Widths NOTE
The waveform at the pad is delayed by two bus clock cycles for deadtime insertion.

### 11.4.5.1 Top/Bottom Correction

In complementary mode, either the top or the bottom transistor controls the output voltage. However, deadtime has to be inserted to avoid overlap of conducting interval between the top and bottom transistor. Both transistors in complementary mode are off during deadtime, allowing the output voltage to be determined by the current status of load and introduce distortion in the output voltage. See Figure 11-53. On AC induction motors running open-loop, the distortion typically manifests itself as poor low-speed performance, such as torque ripple and rough operation.


Figure 11-53. Deadtime Distortion
During deadtime, load inductance distorts output voltage by keeping current flowing through the diodes. This deadtime current flow creates a load voltage that varies with current direction. With a positive current flow, the load voltage during deadtime is equal to the bottom supply, putting the top transistor in control. With a negative current flow, the load voltage during deadtime is equal to the top supply putting the bottom transistor in control.

Remembering that the original PWM pulse widths were shortened by deadtime insertion, the averaged sinusoidal output will be less than desired value. However, when deadtime is inserted, it creates a distortion in motor current waveform. This distortion is aggravated by dissimilar turn-on and turn-off delays of each of the transistors. By giving the PWM module information on which transistor is controlling at a given time this distortion can be corrected.

For a typical circuit in complementary channel operation, only one of the transistors will be effective in controlling the output voltage at any given time. This depends on the direction of the motor current for that pair. See Figure 11-53. To correct distortion one of two different factors must be added to the desired PWM value, depending on whether the top or bottom transistor is controlling the output voltage. Therefore, the software is responsible for calculating both compensated PWM values prior to placing them in an odd-numbered/even numbered PWM register pair. Either the odd or the even PMFVAL register controls the pulse width at any given time.

For a given PWM pair, whether the odd or even PMFVAL register is active depends on either:

- The state of the current status pin, $\overline{\mathrm{ISx}}$, for that driver
- The state of the odd/even correction bit, IPOLx, for that driver

To correct deadtime distortion, software can decrease or increase the value in the appropriate PMFVAL register.

- In edge-aligned operation, decreasing or increasing the PWM value by a correction value equal to the deadtime typically compensates for deadtime distortion.
- In center-aligned operation, decreasing or increasing the PWM value by a correction value equal to one-half the deadtime typically compensates for deadtime distortion.

In the complementary channel operation, ISENS selects one of three correction methods:

- Manual correction
- Automatic current status correction during deadtime
- Automatic current status correction when the PWM counter value equals the value in the PWM counter modulus registers

Table 11-47. Correction Method Selection

| ISENS | Correction Method |
| :---: | :---: |
| 00 | No correction ${ }^{1}$ |
| 01 | Manual correction |
| 10 | Current status sample correction on pins IS0, IS1, and $\overline{\text { IS2 }}$ during deadtime ${ }^{2}$ |
| 11 | Current status sample on pins IS0, IS1, and $\overline{\text { IS2 }}^{3}$ <br> At the half cycle in center-aligned operation <br> At the end of the cycle in edge-aligned operation |

1 The current status pins can be used as general purpose input/output ports.
2 The polarity of the $\overline{I S x}$ pin is latched when both the top and bottom PWMs are off. At the 0\% and $100 \%$ duty cycle boundaries, there is no deadtime, so no new current value is sensed.
${ }^{3}$ Current is sensed even with $0 \%$ or $100 \%$ duty cycle.

## NOTE

Assume the user will provide current status sensing circuitry causing the voltage at the corresponding input pin to be low for positive current and high for negative current. In addition, it assumes the top PWMs are PWM 0, 2, and 4 while the bottom PWMS are PWM 1, 3, and 5.

### 11.4.5.2 Manual Correction

The IPOLx bits select either the odd or the even PWM value registers to use in the next PWM cycle.
Table 11-48. Top/Bottom Manual Correction

| Bit | Logic Atate | Output Control |
| :---: | :---: | :--- |
| IPOLA | 0 | PMFVAL0 controls PWM0/PWM1 pair |
|  | 1 | PMFVAL1 controls PWM0/PWM1 pair |
|  | 0 | PMFVAL2 controls PWM2/PWM3 pair |
|  | 1 | PMFVAL3 controls PWM2/PWM3 pair |
| IPOLC | 0 | PMFVAL4 controls PWM4/PWM5 pair |
|  | 1 | PMFVAL5 controls PWM4/PWM5 pair |

## NOTE

IPOLx bits are buffered so only one PWM register is used per PWM cycle. If an IPOLx bit changes during a PWM period, the new value does not take effect until the next PWM period.

IPOLx bits take effect at the end of each PWM cycle regardless of the state of the load okay bit, LDOK.


Figure 11-54. Internal Correction Logic when ISENS = 01
To detect the current status, the voltage on each $\overline{\mathrm{ISx}}$ pin is sampled twice in a PWM period, at the end of each deadtime. The value is stored in the DTx bits in the PMF Deadtime Sample register (PMFDTMS). The DTx bits are a timing marker especially indicating when to toggle between PWM value registers. Software can then set the IPOLx bit to toggle PMFVAL registers according to DTx values.


Figure 11-55. Current-Status Sense Scheme for Deadtime Correction
If both D flip-flops latch low, $\mathrm{DT} 0=0, \mathrm{DT} 1=0$, during deadtime periods if current is large and flowing out of the complementary circuit. See Figure 11-55. If both D flip-flops latch the high, DT0 $=1$, DT1 $=1$, during deadtime periods if current is also large and flowing into the complementary circuit. However, under low-current, the output voltage of the complementary circuit during deadtime is somewhere between the high and low levels. The current cannot free-wheel throughout the opposition anti-body diode, regardless of polarity, giving additional distortion when the current crosses zero. Sampled results will be DT0 $=0$ and DT1 $=1$. Thus, the best time to change one PWM value register to another is just before the current zero crossing.


T = DEADTIME INTERVAL BEFORE ASSERTION OF TOP PWM
B = DEADTIME INTERVAL BEFORE ASSERTION OF BOTTOM PWM
Figure 11-56. Output Voltage Waveforms

### 11.4.5.3 Current-Sensing Correction

A current sense pin, $\overline{\mathrm{ISx}}$, for a PWM pair selects either the odd or the even PWM value registers to use in the next PWM cycle. The selection is based on user-provided current sense circuitry driving the $\overline{\mathrm{ISx}} \mathrm{pin}$ high for negative current and low for positive current.

Table 11-49. Top/Bottom Current-Sense Correction

| Pin | Logic State | Output Control |
| :---: | :---: | :---: |
| IS0 | 0 | PMFVAL0 controls PWM0/PWM1 pair |
|  | 1 | PMFVAL1 controls PWM0/PWM1 pair |
| IS1 | 0 | PMFVAL2 controls PWM2/PWM3 pair |
|  | 1 | PMFVAL3 controls PWM2/PWM3 pair |
| IS2 | 0 | PMFVAL4 controls PWM4/PWM5 pair |
|  | 1 | PMFVAL5 controls PWM4/PWM5 pair |

Previously shown, the current direction can be determined by the output voltage during deadtime. Thus, a simple external voltage sensor can be used when current status is completed during deadtime, ISENS $=10$. Deadtime does not exists at the 100 percent and zero percent duty cycle boundaries. Therefore, the second automatic mode must be used for correction, ISENS $=11$, where current status is sampled at the half cycle in center-aligned operation and at the end of cycle in edge-aligned operation. Using this mode requires external circuitry. It actually senses current direction.


Figure 11-57. Internal Correction Logic when ISENS = 10


Figure 11-58. Internal Correction Logic when ISENS = 11

## NOTE

Values latched on the $\overline{\mathrm{ISx}}$ pins are buffered so only one PWM register is used per PWM cycle. If a current status changes during a PWM period, the new value does not take effect until the next PWM period.

When initially enabled by setting the PWMEN bit, no current status has previously been sampled. PWM value registers one, three, and five initially control the three PWM pairs when configured for current status correction.

### 11.4.5.4 Output Polarity

Output polarity of the PWMs is determined by two options: TOPNEG and BOTNEG. The top polarity option, TOPNEG, controls the polarity of PWM0, PWM2 and PWM4. The bottom polarity option, BOTNEG, controls the polarity of PWM1, PWM3 and PWM5. Positive polarity means when the PWM is active its output is high. Conversely, negative polarity means when the PWM is active its output is low.
The TOPNEG and BOTNEG are in the configure register. TOPNEG is the output of PWM0, PWM2 and PWM4. They are active low. If TOPNEG is set, PWM0, PWM2, and PWM4 outputs become active-low. When BOTNEG is set, PWM1, PWM3, and PWM5 outputs are active-low. When these bits are clear, their respective PWM pins are active-high. See Figure 11-59 and Figure 11-60.


Figure 11-59. Correction with Positive Current


Figure 11-60. Correction with Negative Current


Figure 11-61. PWM Polarity

### 11.4.6 Software Output Control

Setting output control enable bit, OUTCTLx, enables software to drive the PWM outputs rather than the PWM generator. In an independent mode, with OUTCTLx $=1$, the output bit OUTx, controls the PWMx channel. In a complementary channel operation the even OUTCTL bit is used to enable software output control for the pair. But the OUTCTL bits must be switched in pairs for proper operation. The OUTCTLx and OUTx bits are in the PWM output control register.

## NOTE

During software output control, TOPNEG and BOTNEG still control output polarity. It will take upto 3 clock cycles to see the effect of output control on the PWM output pins.

In independent PWM operation, setting or clearing the OUTx bit activates or deactivates the PWMx output.

In complementary channel operation, the even-numbered OUTx bits replace the PWM generator outputs as inputs to the deadtime generators. Complementary channel pairs still cannot be active simultaneously, and the deadtime generators continue to insert deadtime in both channels of that pair, whenever an even OUTx bit toggles. Even OUTx bits control the top PWM signals while the odd OUTx bits control the bottom PWM signals with respect to the even OUTx bits. Setting the odd OUTx bit makes its corresponding PWMx the complement of its even pair, while clearing the odd OUTx bit deactivates the odd PWMx.

Setting the OUTCTLx bits do not disable the PWM generators and current status sensing circuitry. They continue to run, but no longer control the output pins. When the OUTCTLx bits are cleared, the outputs of the PWM generator become the inputs to the deadtime generators at the beginning of the next PWM cycle. Software can drive the PWM outputs even when PWM enable bit (PWMEN) is set to zero.

## NOTE

Avoid an unexpected deadtime insertion by clearing the OUTx bits before setting and after clearing the OUTCTLx bits.


Figure 11-62. Setting OUTO with OUTCTL Set in Complementary Mode

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Figure 11-63. Clearing OUT0 with OUTCTL Set In Complementary Mode


Figure 11-64. Setting OUTCTL with OUTO Set in Complementary Mode

### 11.4.7 PWM Generator Loading

### 11.4.7.1 Load Enable

The load okay bit, LDOK, enables loading the PWM generator with:

- A prescaler divisor-from the PRSC1 and PRSC0 bits in PWM control register
- A PWM period-from the PWM counter modulus registers
- A PWM pulse width—from the PWM value registers

LDOK prevents reloading of these PWM parameters before software is finished calculating them Setting LDOK allows the prescaler bits, PMFMOD and PMFVALx registers to be loaded into a set of buffers. The loaded buffers use the PWM generator at the beginning of the next PWM reload cycle. Set LDOK by reading it when it is a logic zero and then writing a logic one to it. After loading, LDOK is automatically cleared.

### 11.4.7.2 Load Frequency

The LDFQ3, LDFQ2, LDFQ1, and LDFQ0 bits in the PWM control register (PWMCTL) select an integral loading frequency of one to $16-\mathrm{PWM}$ reload opportunities. The LDFQ bits take effect at every PWM reload opportunity, regardless the state of the load okay bit, LDOK. The half bit in the PWMCTL register controls half-cycle reloads for center-aligned PWMs. If the half bit is set, a reload opportunity occurs at the beginning of every PWM cycle and half cycle when the count equals the modulus. If the half bit is not set, a reload opportunity occurs only at the beginning of every cycle. Reload opportunities can only occur at the beginning of a PWM cycle in edge-aligned mode.

## NOTE

Loading a new modulus on a half cycle will force the count to the new modulus value minus one on the next clock cycle. Half cycle reloads are possible only in center-aligned mode. Enabling or disabling half-cycle reloads in edge-aligned mode will have no effect on the reload rate.


Figure 11-65. Full Cycle Reload Frequency Change


Figure 11-66. Half Cycle Reload Frequency Change

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### 11.4.7.3 Reload Flag

With a reload opportunity, regardless an actual reload occurs as determined by LDOK bit, the PWMF reload flag is set. If the PWM reload interrupt enable bit, PWMRIE is set, the PWMF flag generates CPU interrupt requests allowing software to calculate new PWM parameters in real time. When PWMRIE is not set, reloads still occur at the selected reload rate without generating CPU interrupt requests.


Figure 11-67. PWMRF Reload Interrupt Request


Figure 11-68. Full-Cycle Center-Aligned PWM Value Loading


Figure 11-69. Full-Cycle Center-Aligned Modulus Loading


Figure 11-70. Half-Cycle Center-Aligned PWM Value Loading


Figure 11-71. Half-Cycle Center-Aligned Modulus Loading


Figure 11-72. Edge-Aligned PWM Value Loading


Figure 11-73. Untitled Figure

### 11.4.7.4 Initialization

Initialize all registers and set the LDOK bit before setting the PWMEN bit. With LDOK set, setting PWMEN for the first time after reset, immediately loads the PWM generator thereby setting the PWMRF flag. PWMRF generates a CPU interrupt request if the PWMRIE bit is set. In complementary channel operation with current-status correction selected, PWM value registers one, three, and five control the outputs for the first PWM cycle.

## NOTE

Even if LDOK is not set, setting PWMEN also sets the PWMRF flag. To prevent a CPU interrupt request, clear the PWMRIE bit before setting PWMEN.

Setting PWMEN for the first time after reset without first setting LDOK loads a prescaler divisor of one, a PWM value of $\$ 0000$, and an unknown modulus. The PWM generator uses the last values loaded if PWMEN is cleared and then set while LDOK equals zero.Initializing the deadtime register, after setting PWMEN or OUTCTLx, can cause an improper deadtime insertion. However, the deadtime can never be shorter than the specified value.


Figure 11-74. PWMEN and PWM Pins in Independent Operation


Figure 11-75. PWMEN and PWM Pins in Complementary Operation

When the PWMEN bit is cleared:

- The PWMx outputs will be tri-stated unless OUTCTLx $=1$
- The PWM counter is cleared and does not count
- The PWM generator forces its outputs to zero
- The PWMRF flag and pending CPU interrupt requests are not cleared
- All fault circuitry remains active unless FPINEx $=0$
- Software output control remains active
- Deadtime insertion continues during software output control


### 11.4.8 Fault Protection

Fault protection can disable any combination of PWM pins. Faults are generated by a logic one on any of the FAULT pins. Each FAULT pin can be mapped arbitrarily to any of the PWM pins.

When fault protection hardware disables PWM pins, the PWM generator continues to run, only the output pins are deactivated.

The fault decoder disables PWM pins selected by the fault logic and the disable mapping register. See Figure 11-15. Each bank of four bits in the disable mapping register control the mapping for a single PWM pin. Refer to Table 11-12.

The fault protection is enabled even when the PWM is not enabled; therefore, a fault will be latched in and will be cleared in order to prevent an interrupt when the PWM is enabled.

### 11.4.8.1 Fault Pin Sample Filter

Each fault pin has a sample filter to test for fault conditions. After every bus cycle setting the FAULTx pin at logic zero, the filter synchronously samples the pin once every four bus cycles. QSMP determines the number of consecutive samples that must be logic one for a fault to be detected. When a fault is detected, the corresponding FAULTx pin flag, FFLAGx, is set. Clear FFLAGx by writing a logic one to it.

If the FIEx, FAULTx pin interrupt enable bit is set, the FFLAGx flag generates a CPU interrupt request. The interrupt request latch remains set until:

- Software clears the FFLAGx flag by writing a logic one to it
- Software clears the FIEx bit by writing a logic zero to it
- A reset occurs


### 11.4.8.2 Automatic Fault Clearing

Setting a fault mode bit, FMODEx, configures faults from the FAULTx pin for automatic clearing.
When FMODEx is set, disabled PWM pins are enabled when the FAULTx pin returns to logic zero and a new PWM half cycle begins. See Figure 11-76. Clearing the FFLAGx flag does not affect disabled PWM pins when FMODEx is set.


Figure 11-76. Automatic Fault Clearing

### 11.4.8.3 Manual Fault Clearing

Clearing a fault mode bit, FMODEx, configures faults from the FAULTx pin for manual clearing:

- PWM pins disabled by the FAULT0 pin or the FAULT2 pin are enabled by clearing the corresponding FFLAGx flag. The time at which the PWM pins are enabled depends on the corresponding QSMPx bit setting. If QSMPx $=00$, the PWM pins are enabled on the next IP bus cycle when the logic level detected by the filter at the fault pin is logic zero. If QSMPx $=01,10$ or 11, the PWMs are enabled when the next PWM half cycle begins regardless of the state of the logic level detected by the filter at the fault. See Figure 11-77 and Figure 11-78.
- PWM pins disabled by the FAULT1 pin or the FAULT3 pin are enabled when
- Software clears the corresponding FFLAGx flag
- The filter detects a logic zero on the fault pin at the start of the next PWM half cycle boundary. See Figure 11-79.


Figure 11-77. Manual Fault Clearing (Faults 0 \& 2) — QSMP = 00


Figure 11-78. Manual Fault Clearing (Faults 0 \& 2) - QSMP=01, 10, or 11


Figure 11-79. Manual Fault Clearing (Faults 1 \& 3)

## NOTE

PWM half-cycle boundaries occur at both the PWM cycle start and when the counter equals the modulus, so in edge-aligned operation full-cycles and half-cycles are equal.

## NOTE

Fault protection also applies during software output control when the OUTCTLx bits are set. Fault clearing still occurs at half PWM cycle boundaries while the PWM generator is engaged, PWMEN equals one. But the OUTx bits can control the PWM pins while the PWM generator is off, PWMEN equals zero. Thus, fault clearing occurs at IPbus cycles while the PWM generator is off and at the start of PWM cycles when the generator is engaged.

### 11.5 Resets

All PWM registers are reset to their default values upon any system reset.

### 11.6 Clocks

The system bus clock is the only clock required by this module.

### 11.7 Interrupts

Seven PWM sources can generate CPU interrupt requests:

- Reload flag $x$ (PWMRFx)—PWMRFx is set at the beginning of every PWM Generator x reload cycle. The reload interrupt enable bit, PWMRIEx, enables PWMRFx to generate CPU interrupt requests.
where x is $\mathrm{A}, \mathrm{B}$ and C .
- Fault flag x (FFLAGx) - The FFLAGx bit is set when a logic one occurs on the FAULTx pin. The fault pin interrupt enable $x$ bit, FIEx, enables the FFLAGx flag to generate CPU interrupt requests. where x is $0,1,2$ and 3 .


## Chapter 12 Pulse-Width Modulator (PWM8B6CV1)

### 12.1 Introduction

The pulse width modulation (PWM) definition is based on the HC12 PWM definitions. The PWM8B6CV1 module contains the basic features from the HC 11 with some of the enhancements incorporated on the HC12, that is center aligned output mode and four available clock sources. The PWM8B6CV1 module has six channels with independent control of left and center aligned outputs on each channel.

Each of the six PWM channels has a programmable period and duty cycle as well as a dedicated counter. A flexible clock select scheme allows a total of four different clock sources to be used with the counters. Each of the modulators can create independent continuous waveforms with software-selectable duty rates from $0 \%$ to $100 \%$. The PWM outputs can be programmed as left aligned outputs or center aligned outputs

### 12.1.1 Features

- Six independent PWM channels with programmable period and duty cycle
- Dedicated counter for each PWM channel
- Programmable PWM enable/disable for each channel
- Software selection of PWM duty pulse polarity for each channel
- Period and duty cycle are double buffered. Change takes effect when the end of the effective period is reached (PWM counter reaches 0 ) or when the channel is disabled.
- Programmable center or left aligned outputs on individual channels
- Six 8-bit channel or three 16 -bit channel PWM resolution
- Four clock sources (A, B, SA, and SB) provide for a wide range of frequencies.
- Programmable clock select logic
- Emergency shutdown


### 12.1.2 Modes of Operation

There is a software programmable option for low power consumption in wait mode that disables the input clock to the prescaler.

In freeze mode there is a software programmable option to disable the input clock to the prescaler. This is useful for emulation.

### 12.1.3 Block Diagram



Figure 12-1. PWM8B6CV1 Block Diagram

### 12.2 External Signal Description

The PWM8B6CV1 module has a total of six external pins.

### 12.2.1 PWM5 — Pulse Width Modulator Channel 5 Pin

This pin serves as waveform output of PWM channel 5 and as an input for the emergency shutdown feature.

### 12.2.2 PWM4 — Pulse Width Modulator Channel 4 Pin

This pin serves as waveform output of PWM channel 4.

### 12.2.3 PWM3 — Pulse Width Modulator Channel 3 Pin

This pin serves as waveform output of PWM channel 3.

### 12.2.4 PWM2 — Pulse Width Modulator Channel 2 Pin

This pin serves as waveform output of PWM channel 2.

### 12.2.5 PWM1 — Pulse Width Modulator Channel 1 Pin

This pin serves as waveform output of PWM channel 1.

### 12.2.6 PWMO — Pulse Width Modulator Channel 0 Pin

This pin serves as waveform output of PWM channel 0.

### 12.3 Memory Map and Register Definition

This subsection describes in detail all the registers and register bits in the PWM8B6CV1 module.
The special-purpose registers and register bit functions that would not normally be made available to device end users, such as factory test control registers and reserved registers are clearly identified by means of shading the appropriate portions of address maps and register diagrams. Notes explaining the reasons for restricting access to the registers and functions are also explained in the individual register descriptions.

### 12.3.1 Module Memory Map

The following paragraphs describe the content of the registers in the PWM8B6CV1 module. The base address of the PWM8B6CV1 module is determined at the MCU level when the MCU is defined. The register decode map is fixed and begins at the first address of the module address offset. Table 12-1 shows the registers associated with the PWM and their relative offset from the base address. The register detail description follows the order in which they appear in the register map.
Reserved bits within a register will always read as 0 and the write will be unimplemented. Unimplemented functions are indicated by shading the bit.

Table 12-1 shows the memory map for the PWM8B6CV1 module.

## NOTE

Register address $=$ base address + address offset, where the base address is defined at the MCU level and the address offset is defined at the module level.

Chapter 12 Pulse-Width Modulator (PWM8B6CV1)
Table 12-1. PWM8B6CV1 Memory Map

| Address Offset | Register | Access |
| :---: | :---: | :---: |
| 0x0000 | PWM Enable Register (PWME) | R/W |
| 0x0001 | PWM Polarity Register (PWMPOL) | R/W |
| 0x0002 | PWM Clock Select Register (PWMCLK) | R/W |
| $0 \times 0003$ | PWM Prescale Clock Select Register (PWMPRCLK) | R/W |
| 0x0004 | PWM Center Align Enable Register (PWMCAE) | R/W |
| $0 \times 0005$ | PWM Control Register (PWMCTL) | R/W |
| $0 \times 0006$ | PWM Test Register (PWMTST) ${ }^{1}$ | R/W |
| $0 \times 0007$ | PWM Prescale Counter Register (PWMPRSC) ${ }^{2}$ | R/W |
| 0x0008 | PWM Scale A Register (PWMSCLA) | R/W |
| 0x0009 | PWM Scale B Register (PWMSCLB) | R/W |
| 0x000A | PWM Scale A Counter Register (PWMSCNTA) ${ }^{3}$ | R/W |
| 0x000B | PWM Scale B Counter Register (PWMSCNTB) ${ }^{4}$ | R/W |
| 0x000C | PWM Channel 0 Counter Register (PWMCNT0) | R/W |
| 0x000D | PWM Channel 1 Counter Register (PWMCNT1) | R/W |
| 0x000E | PWM Channel 2 Counter Register (PWMCNT2) | R/W |
| 0x000F | PWM Channel 3 Counter Register (PWMCNT3) | R/W |
| $0 \times 0010$ | PWM Channel 4 Counter Register (PWMCNT4) | R/W |
| $0 \times 0011$ | PWM Channel 5 Counter Register (PWMCNT5) | R/W |
| $0 \times 0012$ | PWM Channel 0 Period Register (PWMPER0) | R/W |
| $0 \times 0013$ | PWM Channel 1 Period Register (PWMPER1) | R/W |
| $0 \times 0014$ | PWM Channel 2 Period Register (PWMPER2) | R/W |
| $0 \times 0015$ | PWM Channel 3 Period Register (PWMPER3) | R/W |
| $0 \times 0016$ | PWM Channel 4 Period Register (PWMPER4) | R/W |
| $0 \times 0017$ | PWM Channel 5 Period Register (PWMPER5) | R/W |
| $0 \times 0018$ | PWM Channel 0 Duty Register (PWMDTY0) | R/W |
| $0 \times 0019$ | PWM Channel 1 Duty Register (PWMDTY1) | R/W |
| 0x001A | PWM Channel 2 Duty Register (PWMDTY2) | R/W |
| 0x001B | PWM Channel 3 Duty Register (PWMDTY3) | R/W |
| 0x001C | PWM Channel 4 Duty Register (PWMDTY4) | R/W |
| 0x001D | PWM Channel 5 Duty Register (PWMDTY5) | R/W |
| 0x001E | PWM Shutdown Register (PWMSDN) | R/W |

1 PWMTST is intended for factory test purposes only.
2 PWMPRSC is intended for factory test purposes only.
3 PWMSCNTA is intended for factory test purposes only.
4 PWMSCNTB is intended for factory test purposes only.

### 12.3.2 Register Descriptions

The following paragraphs describe in detail all the registers and register bits in the PWM8B6CV1 module.


Figure 12-2. PWM Register Summary

Chapter 12 Pulse-Width Modulator (PWM8B6CV1)

| Register Name |  | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PWMCNT3 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| PWMCNT4 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| PWMCNT5 | R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  | W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| PWMPER0 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER1 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER2 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER3 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER4 | $R$ $W$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER5 | $R$ W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMDTY0 | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER1 | $R$ W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER2 | $R$ W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER3 | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER4 | $R$ W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMPER5 | R W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| PWMSDB | R W | PWMIF | PWMIE | $\begin{array}{\|c} 0 \\ \hline \text { PWMRSTRT } \end{array}$ | PWMLVL | 0 | PWM5IN | PWM5INL | PWM5ENA |
| = Unimplemented or Reserved |  |  |  |  |  |  |  |  |  |

Figure 12-2. PWM Register Summary (continued)

### 12.3.2.1 PWM Enable Register (PWME)

Each PWM channel has an enable bit (PWMEx) to start its waveform output. When any of the PWMEx bits are set $(\mathrm{PWMEx}=1)$, the associated PWM output is enabled immediately. However, the actual PWM waveform is not available on the associated PWM output until its clock source begins its next cycle due to the synchronization of PWMEx and the clock source.

## NOTE

The first PWM cycle after enabling the channel can be irregular.
An exception to this is when channels are concatenated. After concatenated mode is enabled (CONxx bits set in PWMCTL register), enabling/disabling the corresponding 16-bit PWM channel is controlled by the low-order PWMEx bit. In this case, the high-order bytes PWMEx bits have no effect and their corresponding PWM output lines are disabled.

While in run mode, if all six PWM channels are disabled (PWME5-PWME $0=0$ ), the prescaler counter shuts off for power savings.


Figure 12-3. PWM Enable Register (PWME)
Read: anytime
Write: anytime
Table 12-2. PWME Field Descriptions

| Field | Description |
| :---: | :---: |
| 5 PWME5 | Pulse Width Channel 5 Enable <br> 0 Pulse width channel 5 is disabled. <br> 1 Pulse width channel 5 is enabled. The pulse modulated signal becomes available at PWM,output bit 5 when its clock source begins its next cycle. |
| $\begin{gathered} 4 \\ \text { PWME4 } \end{gathered}$ | Pulse Width Channel 4 Enable <br> 0 Pulse width channel 4 is disabled. <br> 1 Pulse width channel 4 is enabled. The pulse modulated signal becomes available at PWM, output bit 4 when its clock source begins its next cycle. If CON45 $=1$, then bit has no effect and PWM output line 4 is disabled. |
| 3 <br> PWME3 | Pulse Width Channel 3 Enable <br> 0 Pulse width channel 3 is disabled. <br> 1 Pulse width channel 3 is enabled. The pulse modulated signal becomes available at PWM, output bit 3 when its clock source begins its next cycle. |
| $\begin{gathered} 2 \\ \text { PWME2 } \end{gathered}$ | Pulse Width Channel 2 Enable <br> 0 Pulse width channel 2 is disabled. <br> 1 Pulse width channel 2 is enabled. The pulse modulated signal becomes available at PWM, output bit 2 when its clock source begins its next cycle. If CON23 = 1, then bit has no effect and PWM output line 2 is disabled. |

Table 12-2. PWME Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 1 |  |
| PWME1 | Pulse Width Channel 1 Enable <br> 0 <br> 1 <br> 1 <br> Pulse width channel 1 is disabled. <br> its clock source begins its next cycle. |
| 0 | Pulse Width Channel 0 Enable <br> 0 <br> 1 |
| Pulse width channel 0 is disabled. |  |
| PWME width channel 0 is enabled. The pulse modulated signal becomes available at PWM, output bit 0 when |  |
| its clock source begins its next cycle. If CON01 $=1$, then bit has no effect and PWM output line 0 is disabled. |  |

### 12.3.2.2 PWM Polarity Register (PWMPOL)

The starting polarity of each PWM channel waveform is determined by the associated PPOLx bit in the PWMPOL register. If the polarity bit is 1 , the PWM channel output is high at the beginning of the cycle and then goes low when the duty count is reached. Conversely, if the polarity bit is 0 the output starts low and then goes high when the duty count is reached.


Figure 12-4. PWM Polarity Register (PWMPOL)
Read: anytime
Write: anytime

## NOTE

PPOLx register bits can be written anytime. If the polarity is changed while a PWM signal is being generated, a truncated or stretched pulse can occur during the transition

Table 12-3. PWMPOL Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 5 \\ \text { PPOL5 } \end{gathered}$ | Pulse Width Channel 5 Polarity <br> 0 PWM channel 5 output is low at the beginning of the period, then goes high when the duty count is reached. <br> 1 PWM channel 5 output is high at the beginning of the period, then goes low when the duty count is reached. |
| $\begin{gathered} 4 \\ \text { PPOL4 } \end{gathered}$ | Pulse Width Channel 4 Polarity <br> 0 PWM channel 4 output is low at the beginning of the period, then goes high when the duty count is reached. <br> 1 PWM channel 4 output is high at the beginning of the period, then goes low when the duty count is reached. |
| $\begin{gathered} 3 \\ \text { PPOL3 } \end{gathered}$ | Pulse Width Channel 3 Polarity <br> 0 PWM channel 3 output is low at the beginning of the period, then goes high when the duty count is reached. <br> 1 PWM channel 3 output is high at the beginning of the period, then goes low when the duty count is reached. |

Table 12-3. PWMPOL Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\stackrel{2}{\text { PPOL2 }}$ | Pulse Width Channel 2 Polarity <br> 0 PWM channel 2 output is low at the beginning of the period, then goes high when the duty count is reached. <br> 1 PWM channel 2 output is high at the beginning of the period, then goes low when the duty count is reached. |
| $\begin{gathered} 1 \\ \text { PPOL1 } \end{gathered}$ | Pulse Width Channel 1 Polarity <br> 0 PWM channel 1 output is low at the beginning of the period, then goes high when the duty count is reached. <br> 1 PWM channel 1 output is high at the beginning of the period, then goes low when the duty count is reached. |
| $\begin{gathered} 0 \\ \text { PPOLO } \end{gathered}$ | Pulse Width Channel 0 Polarity <br> 0 PWM channel 0 output is low at the beginning of the period, then goes high when the duty count is reached <br> 1 PWM channel 0 output is high at the beginning of the period, then goes low when the duty count is reached. |

### 12.3.2.3 PWM Clock Select Register (PWMCLK)

Each PWM channel has a choice of two clocks to use as the clock source for that channel as described below.


Figure 12-5. PWM Clock Select Register (PWMCLK)
Read: anytime
Write: anytime

## NOTE

Register bits PCLK0 to PCLK5 can be written anytime. If a clock select is changed while a PWM signal is being generated, a truncated or stretched pulse can occur during the transition.

Table 12-4. PWMCLK Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 5 \\ \text { PCLK5 } \end{gathered}$ | Pulse Width Channel 5 Clock Select <br> 0 Clock A is the clock source for PWM channel 5. <br> 1 Clock SA is the clock source for PWM channel 5. |
| $\begin{gathered} 4 \\ \text { PCLK4 } \end{gathered}$ | Pulse Width Channel 4 Clock Select <br> 0 Clock A is the clock source for PWM channel 4. <br> 1 Clock SA is the clock source for PWM channel 4. |
| $\begin{gathered} 3 \\ \text { PCLK3 } \end{gathered}$ | Pulse Width Channel 3 Clock Select <br> 0 Clock B is the clock source for PWM channel 3. <br> 1 Clock SB is the clock source for PWM channel 3. |

Table 12-4. PWMCLK Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 2 | Pulse Width Channel 2 Clock Select <br> 0 <br> Clock B is the clock source for PWM channel 2. |
| PCLK2 | Clock SB is the clock source for PWM channel 2. |

### 12.3.2.4 PWM Prescale Clock Select Register (PWMPRCLK)

This register selects the prescale clock source for clocks A and B independently.


Figure 12-6. PWM Prescaler Clock Select Register (PWMPRCLK)
Read: anytime
Write: anytime

## NOTE

PCKB2-PCKB0 and PCKA2-PCKA0 register bits can be written anytime. If the clock prescale is changed while a PWM signal is being generated, a truncated or stretched pulse can occur during the transition.

Table 12-5. PWMPRCLK Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 5$ | Prescaler Select for Clock B - Clock B is 1 of two clock sources which can be used for channels 2 or 3. These |
| PCKB[2:0] | three bits determine the rate of clock B, as shown in Table 12-6. |
| $2: 0$ | Prescaler Select for Clock A - Clock A is 1 of two clock sources which can be used for channels 0, 1, 4, or 5. <br> PCKA[2:0] |
| These three bits determine the rate of clock A, as shown in Table 12-7. |  |

Table 12-6. Clock B Prescaler Selects

| PCKB2 | PCKB1 | PCKB0 | Value of Clock B |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | Bus Clock |
| 0 | 0 | 1 | Bus Clock / 2 |
| 0 | 1 | 0 | Bus Clock / 4 |
| 0 | 1 | 1 | Bus Clock / 8 |
| 1 | 0 | 0 | Bus Clock / 16 |
| 1 | 0 | 1 | Bus Clock / 32 |
| 1 | 1 | 0 | Bus Clock / 64 |
| 1 | 1 | 1 | Bus Clock / 128 |

Table 12-7. Clock A Prescaler Selects

| PCKA2 | PCKA1 | PCKA0 | Value of Clock A |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | Bus Clock |
| 0 | 0 | 1 | Bus Clock / 2 |
| 0 | 1 | 0 | Bus Clock / 4 |
| 0 | 1 | 1 | Bus Clock / 8 |
| 1 | 0 | 0 | Bus Clock / 16 |
| 1 | 0 | 1 | Bus Clock / 32 |
| 1 | 1 | 0 | Bus Clock / 64 |
| 1 | 1 | 1 | Bus Clock / 128 |

### 12.3.2.5 PWM Center Align Enable Register (PWMCAE)

The PWMCAE register contains six control bits for the selection of center aligned outputs or left aligned outputs for each PWM channel. If the CAEx bit is set to a 1, the corresponding PWM output will be center aligned. If the CAEx bit is cleared, the corresponding PWM output will be left aligned. Reference Section 12.4.2.5, "Left Aligned Outputs," and Section 12.4.2.6, "Center Aligned Outputs," for a more detailed description of the PWM output modes.


Figure 12-7. PWM Center Align Enable Register (PWMCAE)
Read: anytime
Write: anytime

## NOTE

Write these bits only when the corresponding channel is disabled.

Table 12-8. PWMCAE Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 5 \\ \text { CAE5 } \end{gathered}$ | Center Aligned Output Mode on Channel 5 <br> 0 Channel 5 operates in left aligned output mode. <br> 1 Channel 5 operates in center aligned output mode. |
| $\begin{gathered} 4 \\ \text { CAE4 } \end{gathered}$ | Center Aligned Output Mode on Channel 4 <br> 0 Channel 4 operates in left aligned output mode. <br> 1 Channel 4 operates in center aligned output mode. |
| $\begin{gathered} 3 \\ \text { CAE3 } \end{gathered}$ | Center Aligned Output Mode on Channel 3 <br> 1 Channel 3 operates in left aligned output mode. <br> 1 Channel 3 operates in center aligned output mode. |
| $\begin{gathered} 2 \\ \text { CAE2 } \end{gathered}$ | Center Aligned Output Mode on Channel 2 <br> 0 Channel 2 operates in left aligned output mode. <br> 1 Channel 2 operates in center aligned output mode. |
| $\begin{gathered} 1 \\ \text { CAE1 } \end{gathered}$ | Center Aligned Output Mode on Channel 1 <br> 0 Channel 1 operates in left aligned output mode. <br> 1 Channel 1 operates in center aligned output mode. |
| $\begin{gathered} 0 \\ \text { CAEO } \end{gathered}$ | Center Aligned Output Mode on Channel 0 <br> 0 Channel 0 operates in left aligned output mode. <br> 1 Channel 0 operates in center aligned output mode. |

### 12.3.2.6 PWM Control Register (PWMCTL)

The PWMCTL register provides for various control of the PWM module.


Figure 12-8. PWM Control Register (PWMCTL)
Read: anytime
Write: anytime
There are three control bits for concatenation, each of which is used to concatenate a pair of PWM channels into one 16 -bit channel. When channels 4 and 5 are concatenated, channel 4 registers become the high-order bytes of the double-byte channel. When channels 2 and 3 are concatenated, channel 2 registers become the high-order bytes of the double-byte channel. When channels 0 and 1 are concatenated, channel 0 registers become the high-order bytes of the double-byte channel.

Reference Section 12.4.2.7, "PWM 16-Bit Functions," for a more detailed description of the concatenation PWM function.

## NOTE

## Change these bits only when both corresponding channels are disabled.

## Table 12-9. PWMCTL Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 6 \\ \text { CON45 } \end{gathered}$ | Concatenate Channels 4 and 5 <br> 0 Channels 4 and 5 are separate 8 -bit PWMs. <br> 1 Channels 4 and 5 are concatenated to create one 16 -bit PWM channel. Channel 4 becomes the high-order byte and channel 5 becomes the low-order byte. Channel 5 output pin is used as the output for this 16 -bit PWM (bit 5 of port PWMP). Channel 5 clock select control bit determines the clock source, channel 5 polarity bit determines the polarity, channel 5 enable bit enables the output and channel 5 center aligned enable bit determines the output mode. |
| $\begin{gathered} 5 \\ \text { CON23 } \end{gathered}$ | Concatenate Channels 2 and 3 <br> 0 Channels 2 and 3 are separate 8 -bit PWMs. <br> 1 Channels 2 and 3 are concatenated to create one 16-bit PWM channel. Channel 2 becomes the high-order byte and channel 3 becomes the low-order byte. Channel 3 output pin is used as the output for this 16-bit PWM (bit 3 of port PWMP). Channel 3 clock select control bit determines the clock source, channel 3 polarity bit determines the polarity, channel 3 enable bit enables the output and channel 3 center aligned enable bit determines the output mode. |
| $\begin{gathered} 4 \\ \text { CONO1 } \end{gathered}$ | Concatenate Channels 0 and 1 <br> 0 Channels 0 and 1 are separate 8 -bit PWMs. <br> 1 Channels 0 and 1 are concatenated to create one 16 -bit PWM channel. Channel 0 becomes the high-order byte and channel 1 becomes the low-order byte. Channel 1 output pin is used as the output for this 16 -bit PWM (bit 1 of port PWMP). Channel 1 clock select control bit determines the clock source, channel 1 polarity bit determines the polarity, channel 1 enable bit enables the output and channel 1 center aligned enable bit determines the output mode. |
| $\begin{gathered} 3 \\ \text { PSWAI } \end{gathered}$ | PWM Stops in Wait Mode - Enabling this bit allows for lower power consumption in wait mode by disabling the input clock to the prescaler. <br> 0 Allow the clock to the prescaler to continue while in wait mode. <br> 1 Stop the input clock to the prescaler whenever the MCU is in wait mode. |
| $\begin{gathered} 2 \\ \text { PFRZ } \end{gathered}$ | PWM Counters Stop in Freeze Mode - In freeze mode, there is an option to disable the input clock to the prescaler by setting the PFRZ bit in the PWMCTL register. If this bit is set, whenever the MCU is in freeze mode the input clock to the prescaler is disabled. This feature is useful during emulation as it allows the PWM function to be suspended. In this way, the counters of the PWM can be stopped while in freeze mode so that after normal program flow is continued, the counters are re-enabled to simulate real-time operations. Because the registers remain accessible in this mode, to re-enable the prescaler clock, either disable the PFRZ bit or exit freeze mode. <br> 0 Allow PWM to continue while in freeze mode. <br> 1 Disable PWM input clock to the prescaler whenever the part is in freeze mode. This is useful for emulation. |

### 12.3.2.7 Reserved Register (PWMTST)

This register is reserved for factory testing of the PWM module and is not available in normal modes.


Figure 12-9. Reserved Register (PWMTST)
Read: always read 0x0000 in normal modes
Write: unimplemented in normal modes

## NOTE

Writing to this register when in special modes can alter the PWM functionality.

### 12.3.2.8 Reserved Register (PWMPRSC)

This register is reserved for factory testing of the PWM module and is not available in normal modes.


Figure 12-10. Reserved Register (PWMPRSC)
Read: always read $0 x 0000$ in normal modes
Write: unimplemented in normal modes

## NOTE

Writing to this register when in special modes can alter the PWM functionality.

### 12.3.2.9 PWM Scale A Register (PWMSCLA)

PWMSCLA is the programmable scale value used in scaling clock A to generate clock SA. Clock SA is generated by taking clock A, dividing it by the value in the PWMSCLA register and dividing that by two.

Clock SA $=$ Clock A / ( 2 * PWMSCLA $)$

## NOTE

When PWMSCLA $=0 \times 0000$, PWMSCLA value is considered a full scale value of 256 . Clock A is thus divided by 512 .

Any value written to this register will cause the scale counter to load the new scale value (PWMSCLA).


Figure 12-11. PWM Scale A Register (PWMSCLA)
Read: anytime
Write: anytime (causes the scale counter to load the PWMSCLA value)

### 12.3.2.10 PWM Scale B Register (PWMSCLB)

PWMSCLB is the programmable scale value used in scaling clock B to generate clock SB. Clock SB is generated by taking clock B, dividing it by the value in the PWMSCLB register and dividing that by two.

Clock SB $=$ Clock B $/(2$ * PWMSCLB $)$

## NOTE

When PWMSCLB $=0 \times 0000$, PWMSCLB value is considered a full scale value of 256 . Clock B is thus divided by 512 .

Any value written to this register will cause the scale counter to load the new scale value (PWMSCLB).


Figure 12-12. PWM Scale B Register (PWMSCLB)
Read: anytime
Write: anytime (causes the scale counter to load the PWMSCLB value).

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### 12.3.2.11 Reserved Registers (PWMSCNTx)

The registers PWMSCNTA and PWMSCNTB are reserved for factory testing of the PWM module and are not available in normal modes.


Figure 12-13. Reserved Register (PWMSCNTA)


Figure 12-14. Reserved Register (PWMSCNTB)
Read: always read 0x0000 in normal modes
Write: unimplemented in normal modes
NOTE
Writing to these registers when in special modes can alter the PWM functionality.

### 12.3.2.12 PWM Channel Counter Registers (PWMCNTx)

Each channel has a dedicated 8-bit up/down counter which runs at the rate of the selected clock source. The counter can be read at any time without affecting the count or the operation of the PWM channel. In left aligned output mode, the counter counts from 0 to the value in the period register -1 . In center aligned output mode, the counter counts from 0 up to the value in the period register and then back down to 0 .

Any value written to the counter causes the counter to reset to $0 x 0000$, the counter direction to be set to up, the immediate load of both duty and period registers with values from the buffers, and the output to change according to the polarity bit. The counter is also cleared at the end of the effective period (see Section 12.4.2.5, "Left Aligned Outputs," and Section 12.4.2.6, "Center Aligned Outputs," for more details). When the channel is disabled ( $\mathrm{PWMEx}=0$ ), the PWMCNTx register does not count. When a channel becomes enabled ( $\mathrm{PWMEx}=1$ ), the associated PWM counter starts at the count in the PWMCNTx register. For more detailed information on the operation of the counters, reference Section 12.4.2.4, "PWM Timer Counters."

In concatenated mode, writes to the 16 -bit counter by using a 16 -bit access or writes to either the low- or high-order byte of the counter will reset the 16 -bit counter. Reads of the 16 -bit counter must be made by 16-bit access to maintain data coherency.

## NOTE

Writing to the counter while the channel is enabled can cause an irregular PWM cycle to occur.


Figure 12-15. PWM Channel Counter Registers (PWMCNTO)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| W | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 12-16. PWM Channel Counter Registers (PWMCNT1)


Figure 12-17. PWM Channel Counter Registers (PWMCNT2)


Figure 12-18. PWM Channel Counter Registers (PWMCNT3)


Figure 12-19. PWM Channel Counter Registers (PWMCNT4)


Figure 12-20. PWM Channel Counter Registers (PWMCNT5)
Read: anytime
Write: anytime (any value written causes PWM counter to be reset to $0 x 0000$ ).

### 12.3.2.13 PWM Channel Period Registers (PWMPERx)

There is a dedicated period register for each channel. The value in this register determines the period of the associated PWM channel.

The period registers for each channel are double buffered so that if they change while the channel is enabled, the change will NOT take effect until one of the following occurs:

- The effective period ends
- The counter is written (counter resets to $0 x 0000$ )
- The channel is disabled

In this way, the output of the PWM will always be either the old waveform or the new waveform, not some variation in between. If the channel is not enabled, then writes to the period register will go directly to the latches as well as the buffer.

## NOTE

Reads of this register return the most recent value written. Reads do not necessarily return the value of the currently active period due to the double buffering scheme.

Reference Section 12.4.2.3, "PWM Period and Duty," for more information.

To calculate the output period, take the selected clock source period for the channel of interest (A, B, SA, or SB ) and multiply it by the value in the period register for that channel:

- Left aligned output $(\mathrm{CAEx}=0)$
- PWMx period $=$ channel clock period $*$ PWMPERx center aligned output $(\operatorname{CAEx}=1)$
- PWMx period $=$ channel clock period $*(2 *$ PWMPERx $)$

For boundary case programming values, please refer to Section 12.4.2.8, "PWM Boundary Cases."


Figure 12-21. PWM Channel Period Registers (PWMPERO)


Figure 12-22. PWM Channel Period Registers (PWMPER1)


Figure 12-23. PWM Channel Period Registers (PWMPER2)


Figure 12-24. PWM Channel Period Registers (PWMPER3)


Figure 12-25. PWM Channel Period Registers (PWMPER4)


Figure 12-26. PWM Channel Period Registers (PWMPER5)
Read: anytime
Write: anytime

### 12.3.2.14 PWM Channel Duty Registers (PWMDTYx)

There is a dedicated duty register for each channel. The value in this register determines the duty of the associated PWM channel. The duty value is compared to the counter and if it is equal to the counter value a match occurs and the output changes state.

The duty registers for each channel are double buffered so that if they change while the channel is enabled, the change will NOT take effect until one of the following occurs:

- The effective period ends
- The counter is written (counter resets to $0 x 0000$ )
- The channel is disabled

In this way, the output of the PWM will always be either the old duty waveform or the new duty waveform, not some variation in between. If the channel is not enabled, then writes to the duty register will go directly to the latches as well as the buffer.

## NOTE

Reads of this register return the most recent value written. Reads do not necessarily return the value of the currently active duty due to the double buffering scheme.

Reference Section 12.4.2.3, "PWM Period and Duty," for more information.

## NOTE

Depending on the polarity bit, the duty registers will contain the count of either the high time or the low time. If the polarity bit is 1 , the output starts high and then goes low when the duty count is reached, so the duty registers contain a count of the high time. If the polarity bit is 0 , the output starts low and then goes high when the duty count is reached, so the duty registers contain a count of the low time.

To calculate the output duty cycle (high time as a $\%$ of period) for a particular channel:

- Polarity $=0($ PPOLx $=0)$

Duty cycle $=[($ PWMPERx PWMDTYx $) /$ PWMPERx $] * 100 \%$

- Polarity $=1($ PPOLx $=1)$

Duty cycle $=[$ PWMDTYx $/$ PWMPERx $] * 100 \%$

- For boundary case programming values, please refer to Section 12.4.2.8, "PWM Boundary Cases."


Figure 12-27. PWM Channel Duty Registers (PWMDTYO)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| Reset | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |

Figure 12-28. PWM Channel Duty Registers (PWMDTY1)


Figure 12-29. PWM Channel Duty Registers (PWMDTY2)


Figure 12-30. PWM Channel Duty Registers (PWMDTY3)


Figure 12-31. PWM Channel Duty Registers (PWMDTY4)


Figure 12-32. PWM Channel Duty Registers (PWMDTY5)
Read: anytime
Write: anytime

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### 12.3.2.15 PWM Shutdown Register (PWMSDN)

The PWMSDN register provides for the shutdown functionality of the PWM module in the emergency cases.


Figure 12-33. PWM Shutdown Register (PWMSDN)
Read: anytime
Write: anytime
Table 12-10. PWMSDN Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { PWMIF } \end{gathered}$ | PWM Interrupt Flag - Any change from passive to asserted (active) state or from active to passive state will be flagged by setting the PWMIF flag $=1$. The flag is cleared by writing a logic 1 to it. Writing a 0 has no effect. <br> 0 No change on PWM5IN input. <br> 1 Change on PWM5IN input |
| $\begin{gathered} 6 \\ \text { PWMIE } \end{gathered}$ | PWM Interrupt Enable - If interrupt is enabled an interrupt to the CPU is asserted. <br> 0 PWM interrupt is disabled. <br> 1 PWM interrupt is enabled. |
| $\begin{array}{\|c} \hline 5 \\ \text { PWMRSTRT } \end{array}$ | PWM Restart - The PWM can only be restarted if the PWM channel input 5 is deasserted. After writing a logic 1 to the PWMRSTRT bit (trigger event) the PWM channels start running after the corresponding counter passes next "counter = 0" phase. <br> Also, if the PWM5ENA bit is reset to 0 , the PWM do not start before the counter passes $0 \times 0000$. <br> The bit is always read as 0 . |
| $\begin{gathered} \hline 4 \\ \text { PWMLVL } \end{gathered}$ | PWM Shutdown Output Level - If active level as defined by the PWM5IN input, gets asserted all enabled PWM channels are immediately driven to the level defined by PWMLVL. <br> 0 PWM outputs are forced to 0 <br> 1 PWM outputs are forced to 1 . |
| $\stackrel{2}{\stackrel{2}{\text { PWM5IN }}}$ | PWM Channel 5 Input Status - This reflects the current status of the PWM5 pin. |
| $\stackrel{1}{\text { PWM5INL }}$ | PWM Shutdown Active Input Level for Channel 5 - If the emergency shutdown feature is enabled (PWM5ENA = 1), this bit determines the active level of the PWM5 channel. <br> 0 Active level is low <br> 1 Active level is high |
| $\begin{gathered} 0 \\ \text { PWM5ENA } \end{gathered}$ | PWM Emergency Shutdown Enable - If this bit is logic 1 the pin associated with channel 5 is forced to input and the emergency shutdown feature is enabled. All the other bits in this register are meaningful only if PWM5ENA = 1 . <br> 0 PWM emergency feature disabled. <br> 1 PWM emergency feature is enabled. |

### 12.4 Functional Description

### 12.4.1 PWM Clock Select

There are four available clocks called clock A, clock B, clock SA (scaled A), and clock SB (scaled B). These four clocks are based on the bus clock.

Clock A and B can be software selected to be $1,1 / 2,1 / 4,1 / 8, \ldots, 1 / 64,1 / 128$ times the bus clock. Clock SA uses clock A as an input and divides it further with a reloadable counter. Similarly, clock SB uses clock B as an input and divides it further with a reloadable counter. The rates available for clock SA are software selectable to be clock A divided by $2,4,6,8, \ldots$, or 512 in increments of divide by 2 . Similar rates are available for clock SB. Each PWM channel has the capability of selecting one of two clocks, either the pre-scaled clock (clock A or B) or the scaled clock (clock SA or SB).

The block diagram in Figure 12-34 shows the four different clocks and how the scaled clocks are created.

### 12.4.1.1 Prescale

The input clock to the PWM prescaler is the bus clock. It can be disabled whenever the part is in freeze mode by setting the PFRZ bit in the PWMCTL register. If this bit is set, whenever the MCU is in freeze mode the input clock to the prescaler is disabled. This is useful for emulation in order to freeze the PWM. The input clock can also be disabled when all six PWM channels are disabled (PWME5-PWME0 $=0$ ) This is useful for reducing power by disabling the prescale counter.

Clock A and clock B are scaled values of the input clock. The value is software selectable for both clock A and clock $B$ and has options of $1,1 / 2,1 / 4,1 / 8,1 / 16,1 / 32,1 / 64$, or $1 / 128$ times the bus clock. The value selected for clock A is determined by the PCKA2, PCKA1, and PCKA0 bits in the PWMPRCLK register. The value selected for clock B is determined by the PCKB2, PCKB1, and PCKB0 bits also in the PWMPRCLK register.

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Figure 12-34. PWM Clock Select Block Diagram

### 12.4.1.2 Clock Scale

The scaled A clock uses clock A as an input and divides it further with a user programmable value and then divides this by 2 . The scaled B clock uses clock B as an input and divides it further with a user programmable value and then divides this by 2 . The rates available for clock SA are software selectable to be clock A divided by $2,4,6,8, \ldots$, or 512 in increments of divide by 2 . Similar rates are available for clock SB.

Clock A is used as an input to an 8-bit down counter. This down counter loads a user programmable scale value from the scale register (PWMSCLA). When the down counter reaches 1, two things happen; a pulse is output and the 8 -bit counter is re-loaded. The output signal from this circuit is further divided by two.

This gives a greater range with only a slight reduction in granularity. Clock SA equals clock A divided by two times the value in the PWMSCLA register.

## NOTE

Clock SA $=$ Clock A $/(2 *$ PWMSCLA $)$
When PWMSCLA $=0 \times 0000$, PWMSCLA value is considered a full scale value of 256 . Clock A is thus divided by 512.

Similarly, clock B is used as an input to an 8-bit down counter followed by a divide by two producing clock SB. Thus, clock SB equals clock B divided by two times the value in the PWMSCLB register.

## NOTE

Clock SB $=$ Clock B $/(2 *$ PWMSCLB $)$
When PWMSCLB $=0 \times 0000$, PWMSCLB value is considered a full scale value of 256 . Clock B is thus divided by 512 .

As an example, consider the case in which the user writes 0x00FF into the PWMSCLA register. Clock A for this case will be bus clock divided by 4 . A pulse will occur at a rate of once every $255 \times 4$ bus cycles. Passing this through the divide by two circuit produces a clock signal at a bus clock divided by 2040 rate. Similarly, a value of $0 x 0001$ in the PWMSCLA register when clock $A$ is bus clock divided by 4 will produce a bus clock divided by 8 rate.

Writing to PWMSCLA or PWMSCLB causes the associated 8-bit down counter to be re-loaded.
Otherwise, when changing rates the counter would have to count down to $0 x 0001$ before counting at the proper rate. Forcing the associated counter to re-load the scale register value every time PWMSCLA or PWMSCLB is written prevents this.

## NOTE

Writing to the scale registers while channels are operating can cause irregularities in the PWM outputs.

### 12.4.1.3 Clock Select

Each PWM channel has the capability of selecting one of two clocks. For channels $0,1,4$, and 5 the clock choices are clock A or clock SA. For channels 2 and 3 the choices are clock B or clock SB. The clock selection is done with the PCLKx control bits in the PWMCLK register.

## NOTE

Changing clock control bits while channels are operating can cause irregularities in the PWM outputs.

### 12.4.2 PWM Channel Timers

The main part of the PWM module are the actual timers. Each of the timer channels has a counter, a period register and a duty register (each are 8 bit). The waveform output period is controlled by a match between the period register and the value in the counter. The duty is controlled by a match between the duty register and the counter value and causes the state of the output to change during the period. The starting polarity of the output is also selectable on a per channel basis. Figure 12-35 shows a block diagram for PWM timer.


Figure 12-35. PWM Timer Channel Block Diagram

### 12.4.2.1 PWM Enable

Each PWM channel has an enable bit (PWMEx) to start its waveform output. When any of the PWMEx bits are set $(P W M E x=1)$, the associated $P W M$ output signal is enabled immediately. However, the actual PWM waveform is not available on the associated PWM output until its clock source begins its next cycle due to the synchronization of PWMEx and the clock source. An exception to this is when channels are concatenated. Refer to Section 12.4.2.7, "PWM 16-Bit Functions," for more detail.

## NOTE

The first PWM cycle after enabling the channel can be irregular.
On the front end of the PWM timer, the clock is enabled to the PWM circuit by the PWMEx bit being high. There is an edge-synchronizing circuit to guarantee that the clock will only be enabled or disabled at an edge. When the channel is disabled ( $\mathrm{PWMEx}=0$ ), the counter for the channel does not count.

### 12.4.2.2 PWM Polarity

Each channel has a polarity bit to allow starting a waveform cycle with a high or low signal. This is shown on the block diagram as a mux select of either the Q output or the $\overline{\mathrm{Q}}$ output of the PWM output flip-flop. When one of the bits in the PWMPOL register is set, the associated PWM channel output is high at the beginning of the waveform, then goes low when the duty count is reached. Conversely, if the polarity bit is 0 , the output starts low and then goes high when the duty count is reached.

### 12.4.2.3 PWM Period and Duty

Dedicated period and duty registers exist for each channel and are double buffered so that if they change while the channel is enabled, the change will NOT take effect until one of the following occurs:

- The effective period ends
- The counter is written (counter resets to $0 x 0000$ )
- The channel is disabled

In this way, the output of the PWM will always be either the old waveform or the new waveform, not some variation in between. If the channel is not enabled, then writes to the period and duty registers will go directly to the latches as well as the buffer.

A change in duty or period can be forced into effect "immediately" by writing the new value to the duty and/or period registers and then writing to the counter. This forces the counter to reset and the new duty and/or period values to be latched. In addition, because the counter is readable it is possible to know where the count is with respect to the duty value and software can be used to make adjustments.

## NOTE

When forcing a new period or duty into effect immediately, an irregular PWM cycle can occur.

Depending on the polarity bit, the duty registers will contain the count of either the high time or the low time.

### 12.4.2.4 PWM Timer Counters

Each channel has a dedicated 8-bit up/down counter which runs at the rate of the selected clock source (reference Figure 12-34 for the available clock sources and rates). The counter compares to two registers, a duty register and a period register as shown in Figure 12-35. When the PWM counter matches the duty register the output flip-flop changes state causing the PWM waveform to also change state. A match between the PWM counter and the period register behaves differently depending on what output mode is selected as shown in Figure 12-35 and described in Section 12.4.2.5, "Left Aligned Outputs," and Section 12.4.2.6, "Center Aligned Outputs."

Each channel counter can be read at anytime without affecting the count or the operation of the PWM channel.

Any value written to the counter causes the counter to reset to $0 x 0000$, the counter direction to be set to up, the immediate load of both duty and period registers with values from the buffers, and the output to change according to the polarity bit. When the channel is disabled $(\mathrm{PWMEx}=0)$, the counter stops. When a channel becomes enabled ( $\mathrm{PWMEx}=1$ ), the associated PWM counter continues from the count in the PWMCNTx register. This allows the waveform to resume when the channel is re-enabled. When the channel is disabled, writing 0 to the period register will cause the counter to reset on the next selected clock.

## NOTE

If the user wants to start a new "clean" PWM waveform without any
"history" from the old waveform, the user must write to channel counter
( PWMCNTx ) prior to enabling the PWM channel $(\mathrm{PWMEx}=1)$.
Generally, writes to the counter are done prior to enabling a channel to start from a known state. However, writing a counter can also be done while the PWM channel is enabled (counting). The effect is similar to writing the counter when the channel is disabled except that the new period is started immediately with the output set according to the polarity bit.

## NOTE

Writing to the counter while the channel is enabled can cause an irregular PWM cycle to occur.

The counter is cleared at the end of the effective period (see Section 12.4.2.5, "Left Aligned Outputs," and Section 12.4.2.6, "Center Aligned Outputs," for more details).

Table 12-11. PWM Timer Counter Conditions

| Counter Clears (0x0000) | Counter Counts | Counter Stops |
| :--- | :--- | :--- |
| When PWMCNTx register <br> written to any value | When PWM channel is <br> enabled (PWMEx $=1$ ). Counts <br> from last value in PWMCNTx. | When PWM channel is <br> disabled (PWMEx $=0)$ |
| Effective period ends |  |  |

### 12.4.2.5 Left Aligned Outputs

The PWM timer provides the choice of two types of outputs, left aligned or center aligned outputs. They are selected with the CAEx bits in the PWMCAE register. If the CAEx bit is cleared $(\mathrm{CAEx}=0)$, the corresponding PWM output will be left aligned.

In left aligned output mode, the 8 -bit counter is configured as an up counter only. It compares to two registers, a duty register and a period register as shown in the block diagram in Figure 12-35. When the PWM counter matches the duty register the output flip-flop changes state causing the PWM waveform to also change state. A match between the PWM counter and the period register resets the counter and the output flip-flop as shown in Figure 12-35 as well as performing a load from the double buffer period and duty register to the associated registers as described in Section 12.4.2.3, "PWM Period and Duty." The counter counts from 0 to the value in the period register - 1 .

## NOTE

Changing the PWM output mode from left aligned output to center aligned output (or vice versa) while channels are operating can cause irregularities in the PWM output. It is recommended to program the output mode before enabling the PWM channel.


Figure 12-36. PWM Left Aligned Output Waveform
To calculate the output frequency in left aligned output mode for a particular channel, take the selected clock source frequency for the channel (A, B, SA, or SB ) and divide it by the value in the period register for that channel.

- PWMx frequency = clock (A, B, SA, or SB) / PWMPERx
- PWMx duty cycle (high time as $\mathrm{a} \%$ of period):
- Polarity $=0($ PPOLx $=0)$ Duty cycle $=[($ PWMPERx-PWMDTYx $) /$ PWMPERx $] * 100 \%$
- Polarity $=1($ PPOLx $=1)$

Duty cycle $=[$ PWMDTYx $/$ PWMPERx $] * 100 \%$
As an example of a left aligned output, consider the following case:
Clock source $=$ bus clock, where bus clock $=10 \mathrm{MHz}(100 \mathrm{~ns}$ period $)$
PPOLx $=0$
PWMPERx $=4$
PWMDTYx = 1
PWMx frequency $=10 \mathrm{MHz} / 4=2.5 \mathrm{MHz}$
PWMx period $=400 \mathrm{~ns}$
PWMx duty cycle $=3 / 4 * 100 \%=75 \%$

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Shown below is the output waveform generated.


Figure 12-37. PWM Left Aligned Output Example Waveform

### 12.4.2.6 Center Aligned Outputs

For center aligned output mode selection, set the CAEx bit (CAEx $=1$ ) in the PWMCAE register and the corresponding PWM output will be center aligned.

The 8 -bit counter operates as an up/down counter in this mode and is set to up whenever the counter is equal to $0 x 0000$. The counter compares to two registers, a duty register and a period register as shown in the block diagram in Figure 12-35. When the PWM counter matches the duty register the output flip-flop changes state causing the PWM waveform to also change state. A match between the PWM counter and the period register changes the counter direction from an up-count to a down-count. When the PWM counter decrements and matches the duty register again, the output flip-flop changes state causing the PWM output to also change state. When the PWM counter decrements and reaches 0 , the counter direction changes from a down-count back to an up-count and a load from the double buffer period and duty registers to the associated registers is performed as described in Section 12.4.2.3, "PWM Period and Duty." The counter counts from 0 up to the value in the period register and then back down to 0 . Thus the effective period is PWMPERx*2.

## NOTE

Changing the PWM output mode from left aligned output to center aligned output (or vice versa) while channels are operating can cause irregularities in the PWM output. It is recommended to program the output mode before enabling the PWM channel.


Figure 12-38. PWM Center Aligned Output Waveform

To calculate the output frequency in center aligned output mode for a particular channel, take the selected clock source frequency for the channel ( $\mathrm{A}, \mathrm{B}, \mathrm{SA}$, or SB ) and divide it by twice the value in the period register for that channel.

- PWMx frequency $=\operatorname{clock}(\mathrm{A}, \mathrm{B}, \mathrm{SA}$, or SB) / ( $2 *$ PWMPERx $)$
- PWMx duty cycle (high time as $\mathrm{a} \%$ of period):
- Polarity $=0($ PPOLx $=0)$

Duty cycle $=[($ PWMPERx-PWMDTYx $) /$ PWMPERx $] * 100 \%$

- Polarity $=1($ PPOLx $=1)$

Duty cycle $=[$ PWMDTYx $/$ PWMPERx $] * 100 \%$
As an example of a center aligned output, consider the following case:
Clock source $=$ bus clock, where bus clock $=10 \mathrm{MHz}(100 \mathrm{~ns}$ period $)$
PPOLx $=0$
PWMPERx $=4$
PWMDTYx = 1
PWMx frequency $=10 \mathrm{MHz} / 8=1.25 \mathrm{MHz}$
PWMx period $=800 \mathrm{~ns}$
PWMx duty cycle $=3 / 4 * 100 \%=75 \%$
Shown below is the output waveform generated.


Figure 12-39. PWM Center Aligned Output Example Waveform

### 12.4.2.7 PWM 16-Bit Functions

The PWM timer also has the option of generating 6-channels of 8-bits or 3-channels of 16-bits for greater PWM resolution \}. This 16-bit channel option is achieved through the concatenation of two 8-bit channels.

The PWMCTL register contains three control bits, each of which is used to concatenate a pair of PWM channels into one 16-bit channel. Channels 4 and 5 are concatenated with the CON45 bit, channels 2 and 3 are concatenated with the CON23 bit, and channels 0 and 1 are concatenated with the CON01 bit.

## NOTE

Change these bits only when both corresponding channels are disabled.
When channels 4 and 5 are concatenated, channel 4 registers become the high-order bytes of the double byte channel as shown in Figure 12-40. Similarly, when channels 2 and 3 are concatenated, channel 2 registers become the high-order bytes of the double byte channel. When channels 0 and 1 are concatenated, channel 0 registers become the high-order bytes of the double byte channel.


Figure 12-40. PWM 16-Bit Mode
When using the 16 -bit concatenated mode, the clock source is determined by the low-order 8-bit channel clock select control bits. That is channel 5 when channels 4 and 5 are concatenated, channel 3 when channels 2 and 3 are concatenated, and channel 1 when channels 0 and 1 are concatenated. The resulting PWM is output to the pins of the corresponding low-order 8-bit channel as also shown in Figure 12-40. The polarity of the resulting PWM output is controlled by the PPOLx bit of the corresponding low-order 8 -bit channel as well.

After concatenated mode is enabled (CONxx bits set in PWMCTL register), enabling/disabling the corresponding 16-bit PWM channel is controlled by the low-order PWMEx bit. In this case, the high-order bytes PWMEx bits have no effect and their corresponding PWM output is disabled.

In concatenated mode, writes to the 16 -bit counter by using a 16-bit access or writes to either the low or high-order byte of the counter will reset the 16 -bit counter. Reads of the 16 -bit counter must be made by 16-bit access to maintain data coherency.

Either left aligned or center aligned output mode can be used in concatenated mode and is controlled by the low-order CAEx bit. The high-order CAEx bit has no effect.

Table 12-12 is used to summarize which channels are used to set the various control bits when in 16 -bit mode.

Table 12-12. 16-bit Concatenation Mode Summary

| CONxx | PWMEx | PPOLx | PCLKx | CAEx | PWMx Output |
| :---: | :---: | :---: | :---: | :---: | :---: |
| CON45 | PWME5 | PPOL5 | PCLK5 | CAE5 | PWM5 |
| CON23 | PWME3 | PPOL3 | PCLK3 | CAE3 | PWM3 |
| CON01 | PWME1 | PPOL1 | PCLK1 | CAE1 | PWM1 |

### 12.4.2.8 PWM Boundary Cases

Table 12-13 summarizes the boundary conditions for the PWM regardless of the output mode (left aligned or center aligned) and 8-bit (normal) or 16-bit (concatenation):

Table 12-13. PWM Boundary Cases

| PWMDTYx | PWMPERx | PPOLx | PWMx Output |
| :---: | :---: | :---: | :---: |
| $0 \times 0000$ <br> (indicates no duty) | $>0 \times 0000$ | 1 | Always Low |
| $0 \times 0000$ <br> (indicates no duty) | $>0 \times 0000$ | 0 | Always High |
| XX | $0 \times 0000^{1}$ <br> (indicates no period) | 1 | Always High |
| XX | $0 \times 0000^{1}$ <br> (indicates no period) | 0 | Always Low |
| $>=$ PWMPERx | $X X$ | 1 | Always High |
| $>=$ PWMPERx | $X X$ | 0 | Always Low |

1 Counter $=0 \times 0000$ and does not count.

### 12.5 Resets

The reset state of each individual bit is listed within the register description section (see Section 12.3, "Memory Map and Register Definition," which details the registers and their bit-fields. All special functions or modes which are initialized during or just following reset are described within this section.

- The 8 -bit up/down counter is configured as an up counter out of reset.
- All the channels are disabled and all the counters don't count.


### 12.6 Interrupts

The PWM8B6CV1 module has only one interrupt which is generated at the time of emergency shutdown, if the corresponding enable bit (PWMIE) is set. This bit is the enable for the interrupt. The interrupt flag PWMIF is set whenever the input level of the PWM5 channel changes while PWM5ENA=1 or when PWMENA is being asserted while the level at PWM5 is active.

A description of the registers involved and affected due to this interrupt is explained in Section 12.3.2.15, "PWM Shutdown Register (PWMSDN)."

Chapter 12 Pulse-Width Modulator (PWM8B6CV1)

## Chapter 13 <br> Timer Module (TIM16B4CV1)

### 13.1 Introduction

The basic timer consists of a 16-bit, software-programmable counter driven by a seven-stage programmable prescaler.

This timer can be used for many purposes, including input waveform measurements while simultaneously generating an output waveform. Pulse widths can vary from microseconds to many seconds.

This timer contains 4 complete input capture/output compare channels IOC[7:4] and one pulse accumulator. The input capture function is used to detect a selected transition edge and record the time. The output compare function is used for generating output signals or for timer software delays. The 16-bit pulse accumulator is used to operate as a simple event counter or a gated time accumulator. The pulse accumulator shares timer channel 7 when in event mode.

A full access for the counter registers or the input capture/output compare registers should take place in one clock cycle. Accessing high byte and low byte separately for all of these registers may not yield the same result as accessing them in one word.

### 13.1.1 Features

The TIM16B4CV1 includes these distinctive features:

- Four input capture/output compare channels.
- Clock prescaling.
- 16-bit counter.
- 16-bit pulse accumulator.


### 13.1.2 Modes of Operation

Stop: Timer is off because clocks are stopped.
Freeze: $\quad$ Timer counter keep on running, unless TSFRZ in TSCR ( 0 x 0006 ) is set to 1 .
Wait: $\quad$ Counters keep on running, unless TSWAI in TSCR (0x0006) is set to 1.
Normal: Timer counter keep on running, unless TEN in TSCR ( $0 x 0006$ ) is cleared to 0 .

### 13.1.3 Block Diagrams



Figure 13-1. TIM16B4CV1 Block Diagram


Figure 13-2. 16-Bit Pulse Accumulator Block Diagram


Figure 13-3. Interrupt Flag Setting


Figure 13-4. Channel 7 Output Compare/Pulse Accumulator Logic
NOTE
For more information see the respective functional descriptions in Section 13.4, "Functional Description," of this document.

### 13.2 External Signal Description

The TIM16B4CV1 module has a total of four external pins.

### 13.2.1 IOC7 — Input Capture and Output Compare Channel 7 Pin

This pin serves as input capture or output compare for channel 7. This can also be configured as pulse accumulator input.

### 13.2.2 IOC6 - Input Capture and Output Compare Channel 6 Pin

This pin serves as input capture or output compare for channel 6 .

### 13.2.3 IOC5 - Input Capture and Output Compare Channel 5 Pin

This pin serves as input capture or output compare for channel 5.

### 13.2.4 IOC4 — Input Capture and Output Compare Channel 4 Pin

This pin serves as input capture or output compare for channel 4.
NOTE
For the description of interrupts see Section 13.6, "Interrupts".

### 13.3 Memory Map and Register Definition

This section provides a detailed description of all memory and registers.

### 13.3.1 Module Memory Map

The memory map for the TIM16B4CV1 module is given below in Table 13-1. The address listed for each register is the address offset. The total address for each register is the sum of the base address for the TIM16B4CV1 module and the address offset for each register.

Table 13-1. TIM16B4CV1 Memory Map

| Address Offset | Use | Access |
| :---: | :---: | :---: |
| $0 \times 0000$ | Timer Input Capture/Output Compare Select (TIOS) | R/W |
| $0 \times 0001$ | Timer Compare Force Register (CFORC) | R/W ${ }^{1}$ |
| $0 \times 0002$ | Output Compare 7 Mask Register (OC7M) | R/W |
| $0 \times 0003$ | Output Compare 7 Data Register (OC7D) | R/W |
| 0x0004 | Timer Count Register (TCNT(hi)) | R/W ${ }^{2}$ |
| $0 \times 0005$ | Timer Count Register (TCNT(lo)) | R/W ${ }^{2}$ |
| $0 \times 0006$ | Timer System Control Register1 (TSCR1) | R/W |
| $0 \times 0007$ | Timer Toggle Overflow Register (TTOV) | R/W |
| $0 \times 0008$ | Timer Control Register1 (TCTL1) | R/W |
| $0 \times 0009$ | Reserved | $-{ }^{3}$ |
| 0x000A | Timer Control Register3 (TCTL3) | R/W |
| 0x000B | Reserved | $-{ }^{3}$ |
| 0x000C | Timer Interrupt Enable Register (TIE) | R/W |
| 0x000D | Timer System Control Register2 (TSCR2) | R/W |
| 0x000E | Main Timer Interrupt Flag1 (TFLG1) | R/W |
| 0x000F | Main Timer Interrupt Flag2 (TFLG2) | R/W |
| 0x0010-0x0017 | Reserved | $-{ }^{3}$ |
| $0 \times 0018$ | Timer Input Capture/Output Compare Register4 (TC4(hi)) | R/W ${ }^{4}$ |
| 0x0019 | Timer Input Capture/Output Compare Register 4 (TC4(lo)) | R/W ${ }^{4}$ |
| 0x001A | Timer Input Capture/Output Compare Register 5 (TC5(hi)) | R/W ${ }^{4}$ |
| 0x001B | Timer Input Capture/Output Compare Register 5 (TC5(lo)) | R/W ${ }^{4}$ |
| 0x001C | Timer Input Capture/Output Compare Register 6 (TC6(hi)) | R/W ${ }^{4}$ |
| 0x001D | Timer Input Capture/Output Compare Register 6 (TC6(Io)) | R/W ${ }^{4}$ |
| 0x001E | Timer Input Capture/Output Compare Register 7 (TC7(hi)) | R/W ${ }^{4}$ |
| 0x001F | Timer Input Capture/Output Compare Register 7 (TC7(lo)) | R/W ${ }^{4}$ |
| $0 \times 0020$ | 16-Bit Pulse Accumulator Control Register (PACTL) | R/W |
| 0x0021 | Pulse Accumulator Flag Register (PAFLG) | R/W |
| $0 \times 0022$ | Pulse Accumulator Count Register (PACNT(hi)) | R/W |
| $0 \times 0023$ | Pulse Accumulator Count Register (PACNT(Io)) | R/W |
| 0x0024-0x002C | Reserved | - ${ }^{3}$ |
| 0x002D | Timer Test Register (TIMTST) | R/W ${ }^{2}$ |
| 0x002E-0x002F | Reserved | $-{ }^{3}$ |

[^5]Chapter 13 Timer Module (TIM16B4CV1)
2 Only writable in special modes (test_mode = 1).
3 Write has no effect; return 0 on read
4 Write to these registers have no meaning or effect during input capture.

### 13.3.2 Register Descriptions

This section consists of register descriptions in address order. Each description includes a standard register diagram with an associated figure number. Details of register bit and field function follow the register diagrams, in bit order.


Figure 13-5. TIM16B4CV1 Register Summary


Figure 13-5. TIM16B4CV1 Register Summary (continued)

### 13.3.2.1 Timer Input Capture/Output Compare Select (TIOS)



Figure 13-6. Timer Input Capture/Output Compare Select (TIOS)
Read: Anytime
Write: Anytime
Table 13-2. TIOS Field Descriptions

| Field |  |
| :---: | :--- |
| $7: 4$ | Description |
| $10 S[7: 4]$ | Input Capture or Output Compare Channel Configuration <br> 0 <br>  <br> 1 The corresponding channel acts as an input capture. |

### 13.3.2.2 Timer Compare Force Register (CFORC)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W | FOC7 | FOC6 | FOC5 | FOC4 |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 13-7. Timer Compare Force Register (CFORC)
Read: Anytime but will always return 0x0000 (1 state is transient)
Write: Anytime
Table 13-3. CFORC Field Descriptions

| Field | Description |
| :---: | :---: |
| $7: 4$ |  |
| FOC[7:4] | Force Output Compare Action for Channel 7:4 - A write to this register with the corresponding data bit(s) set <br> causes the action which is programmed for output compare " $x$ " to occur immediately. The action taken is the <br> same as if a successful comparison had just taken place with the TCx register except the interrupt flag does not <br> get set. <br> Note: A successful channel 7 output compare overrides any channel 6:4 compares. If forced output compare on <br> any channel occurs at the same time as the successful output compare then forced output compare action <br> will take precedence and interrupt flag won't get set. |

### 13.3.2.3 Output Compare 7 Mask Register (OC7M)



Figure 13-8. Output Compare 7 Mask Register (OC7M)
Read: Anytime
Write: Anytime
Table 13-4. OC7M Field Descriptions

| Field | Description |
| :---: | :---: |
| $7: 4$ | Output Compare 7 Mask - Setting the OC7Mx (x ranges from 4 to 6) will set the corresponding port to be an <br> OUtput port when the corresponding TIOSx (x ranges from 4 to 6) bit is set to be an output compare. <br> Note: A successful channel 7 output compare overrides any channel 6:4 compares. For each OC7M bit that is <br> set, the output compare action reflects the corresponding OC7D bit. |

### 13.3.2.4 Output Compare 7 Data Register (OC7D)



Figure 13-9. Output Compare 7 Data Register (OC7D)
Read: Anytime
Write: Anytime
Table 13-5. OC7D Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 4$ | Output Compare 7 Data - A channel 7 output compare can cause bits in the output compare 7 data register <br> Oo transfer to the timer port data register depending on the output compare 7 mask register. |

### 13.3.2.5 Timer Count Register (TCNT)



Figure 13-10. Timer Count Register High (TCNTH)


Figure 13-11. Timer Count Register Low (TCNTL)
The 16 -bit main timer is an up counter.
A full access for the counter register should take place in one clock cycle. A separate read/write for high byte and low byte will give a different result than accessing them as a word.

Read: Anytime
Write: Has no meaning or effect in the normal mode; only writable in special modes (test_mode = 1 ).
The period of the first count after a write to the TCNT registers may be a different size because the write is not synchronized with the prescaler clock.

### 13.3.2.6 Timer System Control Register 1 (TSCR1)



Figure 13-12. Timer System Control Register 1 (TSCR2)
Read: Anytime
Write: Anytime
Table 13-6. TSCR1 Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| TEN | Timer Enable <br> 0 <br> 1 <br> Disables the main timer, including the counter. Can be used for reducing power consumption. <br> If for any reason the timer is not active, there is no $\div 64$ clock for the pulse accumulator because the $\div 64$ is <br> generated by the timer prescaler. |
| 6 | Timer Module Stops While in Wait <br> 0 <br> TSWAI <br> 1 <br> Disabs the timer module to continue running during wait. <br> out of wait. <br> TSWAI also affects pulse accumulator. |

Table 13-6. TSCR1 Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\stackrel{5}{\text { TSFRZ }}$ | Timer Stops While in Freeze Mode <br> 0 Allows the timer counter to continue running while in freeze mode. <br> 1 Disables the timer counter whenever the MCU is in freeze mode. This is useful for emulation. TSFRZ does not stop the pulse accumulator. |
| $\begin{gathered} 4 \\ \text { TFFCA } \end{gathered}$ | Timer Fast Flag Clear All <br> 0 Allows the timer flag clearing to function normally. <br> 1 For TFLG1 (0x000E), a read from an input capture or a write to the output compare channel (0x0010-0x001F) causes the corresponding channel flag, CnF, to be cleared. For TFLG2 (0x000F), any access to the TCNT register ( $0 \times 0004,0 \times 0005$ ) clears the TOF flag. Any access to the PACNT registers ( $0 \times 0022,0 \times 0023$ ) clears the PAOVF and PAIF flags in the PAFLG register (0x0021). This has the advantage of eliminating software overhead in a separate clear sequence. Extra care is required to avoid accidental flag clearing due to unintended accesses. |

### 13.3.2.7 Timer Toggle On Overflow Register 1 (TTOV)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | TOV7 | TOV6 | TOV5 | TOV4 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 13-13. Timer Toggle On Overflow Register 1 (TTOV)
Read: Anytime
Write: Anytime
Table 13-7. TTOV Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 4$ | Toggle On Overflow Bits - TOVx toggles output compare pin on overflow. This feature only takes effect when <br> in output compare mode. When set, it takes precedence over forced output compare but not channel 7 override <br> events. <br> 0 |
| 1 Toggle output compare pin on overflow feature disabled. |  |
| 1 | Toggle output compare pin on overflow feature enabled. |

### 13.3.2.8 Timer Control Register 1 (TCTL1)

| 7 |  | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W | OM7 | OL7 | OM6 | OL6 | OM5 | OL5 | OM4 | OL4 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 13-14. Timer Control Register 1 (TCTL1)
Read: Anytime
Write: Anytime

Table 13-8. TCTL1/TCTL2 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 4$ | Output Mode - These four pairs of control bits are encoded to specify the output action to be taken as a result <br> of a successful OCx compare. When either OMx or OLx is 1, the pin associated with OCx becomes an output <br> tied to OCx. <br> Note: To enable output action by OMx bits on timer port, the corresponding bit in OC7M should be cleared. |
| 7:4 | Output Level - These four pairs of control bits are encoded to specify the output action to be taken as a result <br> of a successful OCx compare. When either OMx or OLx is 1, the pin associated with OCx becomes an output <br> tied to OCx. <br> Note: To enable output action by OLx bits on timer port, the corresponding bit in OC7M should be cleared. |

Table 13-9. Compare Result Output Action

| OMx | OLx | Action |
| :---: | :---: | :---: |
| 0 | 0 | Timer disconnected from output pin logic |
| 0 | 1 | Toggle OCx output line |
| 1 | 0 | Clear OCx output line to zero |
| 1 | 1 | Set OCx output line to one |

To operate the 16-bit pulse accumulator independently of input capture or output compare 7 and 4 respectively the user must set the corresponding bits $\operatorname{IOSx}=1, \mathrm{OMx}=0$ and $\mathrm{OLx}=0$. OC7M7 in the OC7M register must also be cleared.

### 13.3.2.9 Timer Control Register 3 (TCTL3)



Figure 13-15. Timer Control Register 3 (TCTL3)
Read: Anytime
Write: Anytime.
Table 13-10. TCTL3/TCTL4 Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:0 | Input Capture Edge Control — These eight pairs of control bits configure the input capture edge detector |
| EDGnB | circuits. |
| EDGnA |  |

Table 13-11. Edge Detector Circuit Configuration

| EDGnB | EDGnA | Configuration |
| :---: | :---: | :---: |
| 0 | 0 | Capture disabled |
| 0 | 1 | Capture on rising edges only |
| 1 | 0 | Capture on falling edges only |
| 1 | 1 | Capture on any edge (rising or falling) |

### 13.3.2.10 Timer Interrupt Enable Register (TIE)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | C71 | C6I | C5I | C4I | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 13-16. Timer Interrupt Enable Register (TIE)
Read: Anytime
Write: Anytime.
Table 13-12. TIE Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 4$ | Input Capture/Output Compare " $x$ " Interrupt Enable - The bits in TIE correspond bit-for-bit with the bits in |
| C7I:C0I | the TFLG1 status register. If cleared, the corresponding flag is disabled from causing a hardware interrupt. If set, <br> the corresponding flag is enabled to cause a interrupt. |

### 13.3.2.11 Timer System Control Register 2 (TSCR2)



Figure 13-17. Timer System Control Register 2 (TSCR2)
Read: Anytime
Write: Anytime.
Table 13-13. TSCR2 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \mathrm{TOI} \end{gathered}$ | Timer Overflow Interrupt Enable <br> 0 Interrupt inhibited. <br> 1 Hardware interrupt requested when TOF flag set. |
| $\begin{gathered} 3 \\ \text { TCRE } \end{gathered}$ | Timer Counter Reset Enable - This bit allows the timer counter to be reset by a successful output compare 7 event. This mode of operation is similar to an up-counting modulus counter. <br> 0 Counter reset inhibited and counter free runs. <br> 1 Counter reset by a successful output compare 7. <br> If TC7 $=0 \times 0000$ and TCRE $=1$, TCNT will stay at $0 \times 0000$ continuously. If TC7 $=0 \times F F F F$ and TCRE $=1$, TOF will never be set when TCNT is reset from $0 \times$ FFFF to $0 \times 0000$. |
| $\begin{gathered} 2 \\ \operatorname{PR}[2: 0] \end{gathered}$ | Timer Prescaler Select - These three bits select the frequency of the timer prescaler clock derived from the Bus Clock as shown in Table 13-14. |

Table 13-14. Timer Clock Selection

| PR2 | PR1 | PR0 | Timer Clock |
| :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | Bus Clock / 1 |
| 0 | 0 | 1 | Bus Clock / 2 |
| 0 | 1 | 0 | Bus Clock / 4 |
| 0 | 1 | 1 | Bus Clock / 8 |
| 1 | 0 | 0 | Bus Clock / 16 |
| 1 | 0 | 1 | Bus Clock / 32 |
| 1 | 1 | 0 | Bus Clock / 64 |
| 1 | 1 | 1 | Bus Clock / 128 |

## NOTE

The newly selected prescale factor will not take effect until the next synchronized edge where all prescale counter stages equal zero.

### 13.3.2.12 Main Timer Interrupt Flag 1 (TFLG1)



Figure 13-18. Main Timer Interrupt Flag 1 (TFLG1)
Read: Anytime
Write: Used in the clearing mechanism (set bits cause corresponding bits to be cleared). Writing a zero will not affect current status of the bit.

Table 13-15. TRLG1 Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 4$ | Input Capture/Output Compare Channel " $x$ " Flag - These flags are set when an input capture or output |
| C $[7: 4] F$ | (ompare event occurs. Clear a channel flag by writing one to it. <br> When TFFCA bit in TSCR register is set, a read from an input capture or a write into an output compare channel <br> (0x0010-0x001F) will cause the corresponding channel flag CxF to be cleared. |

### 13.3.2.13 Main Timer Interrupt Flag 2 (TFLG2)



Figure 13-19. Main Timer Interrupt Flag 2 (TFLG2)
TFLG2 indicates when interrupt conditions have occurred. To clear a bit in the flag register, write the bit to one.

Read: Anytime
Write: Used in clearing mechanism (set bits cause corresponding bits to be cleared).
Any access to TCNT will clear TFLG2 register if the TFFCA bit in TSCR register is set.
Table 13-16. TRLG2 Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 | Timer Overflow Flag - Set when 16-bit free-running timer overflows from 0xFFFF to 0x0000. This bit is cleared <br> TOF <br> automatically by a write to the TFLG2 register with bit 7 set. (See also TCRE control bit explanation.) |

### 13.3.2.14 Timer Input Capture/Output Compare Registers High and Low 4-7 (TCxH and TCxL)

| 15 14 |  |  | 11 | 12 | 11 | 10 | 9 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| W | Bit 15 | Bit 14 | Bit 13 | Bit 12 | Bit 11 | Bit 10 | Bit 9 | Bit 8 |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 13-20. Timer Input Capture/Output Compare Register x High (TCxH)


Figure 13-21. Timer Input Capture/Output Compare Register x Low (TCxL)
Depending on the TIOS bit for the corresponding channel, these registers are used to latch the value of the free-running counter when a defined transition is sensed by the corresponding input capture edge detector or to trigger an output action for output compare.

Read: Anytime

Write: Anytime for output compare function.Writes to these registers have no meaning or effect during input capture. All timer input capture/output compare registers are reset to 0x0000.

## NOTE

Read/Write access in byte mode for high byte should takes place before low byte otherwise it will give a different result.

### 13.3.2.15 16-Bit Pulse Accumulator Control Register (PACTL)



Figure 13-22. 16-Bit Pulse Accumulator Control Register (PACTL)
When PAEN is set, the PACT is enabled.The PACT shares the input pin with IOC7.
Read: Any time
Write: Any time
Table 13-17. PACTL Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 6 \\ \text { PAEN } \end{gathered}$ | Pulse Accumulator System Enable - PAEN is independent from TEN. With timer disabled, the pulse accumulator can function unless pulse accumulator is disabled. <br> 0 16-Bit Pulse Accumulator system disabled. <br> 1 Pulse Accumulator system enabled. |
| $\begin{gathered} 5 \\ \text { PAMOD } \end{gathered}$ | Pulse Accumulator Mode - This bit is active only when the Pulse Accumulator is enabled (PAEN =1). See Table 13-18. <br> 0 Event counter mode. <br> 1 Gated time accumulation mode. |
| $\begin{gathered} 4 \\ \text { PEDGE } \end{gathered}$ | Pulse Accumulator Edge Control - This bit is active only when the Pulse Accumulator is enabled (PAEN = 1). For PAMOD bit = 0 (event counter mode). See Table 13-18. <br> 0 Falling edges on IOC7 pin cause the count to be incremented. <br> 1 Rising edges on IOC7 pin cause the count to be incremented. <br> For PAMOD bit = 1 (gated time accumulation mode). <br> 0 IOC7 input pin high enables M (bus clock) divided by 64 clock to Pulse Accumulator and the trailing falling edge on IOC7 sets the PAIF flag. <br> 1 IOC7 input pin low enables M (bus clock) divided by 64 clock to Pulse Accumulator and the trailing rising edge on IOC7 sets the PAIF flag. |
| $\begin{gathered} 3: 2 \\ \text { CLK[1:0] } \end{gathered}$ | Clock Select Bits - Refer to Table 13-19. |

Table 13-17. PACTL Field Descriptions (continued)

\left.| Field | Description |
| :---: | :--- |
| 1 | Pulse Accumulator Overflow Interrupt Enable |
| PAOVI | 0 |
|  | 1 |
| 1 | Interrupt inhibited. |$\right]$| Pulse Accumulator Input Interrupt Enable |
| :--- |
| 0 |
| PAI |
|  |$\quad$ Interrupt inhibited. $\quad$ Interrupt requested if PAIF is set. $\quad$.

Table 13-18. Pin Action

| PAMOD | PEDGE | Pin Action |
| :---: | :---: | :---: |
| 0 | 0 | Falling edge |
| 0 | 1 | Rising edge |
| 1 | 0 | Div. by 64 clock enabled with pin high level |
| 1 | 1 | Div. by 64 clock enabled with pin low level |

## NOTE

If the timer is not active (TEN $=0$ in TSCR), there is no divide-by-64 because the $\div 64$ clock is generated by the timer prescaler.

Table 13-19. Timer Clock Selection

| CLK1 | CLK0 | Timer Clock |
| :---: | :---: | :---: |
| 0 | 0 | Use timer prescaler clock as timer counter clock |
| 0 | 1 | Use PACLK as input to timer counter clock |
| 1 | 0 | Use PACLK/256 as timer counter clock frequency |
| 1 | 1 | Use PACLK/65536 as timer counter clock frequency |

For the description of PACLK please refer Figure 13-22.
If the pulse accumulator is disabled ( $\mathrm{PAEN}=0$ ), the prescaler clock from the timer is always used as an input clock to the timer counter. The change from one selected clock to the other happens immediately after these bits are written.

### 13.3.2.16 Pulse Accumulator Flag Register (PAFLG)



Figure 13-23. Pulse Accumulator Flag Register (PAFLG)
Read: Anytime
Write: Anytime
When the TFFCA bit in the TSCR register is set, any access to the PACNT register will clear all the flags in the PAFLG register.

Table 13-20. PAFLG Field Descriptions

| Field | Description |
| :---: | :--- |
| 1 |  |
| PAOVF | Pulse Accumulator Overflow Flag - Set when the 16-bit pulse accumulator overflows from 0xFFFF to 0x0000. <br> This bit is cleared automatically by a write to the PAFLG register with bit 1 set. |
| 0 | Pulse Accumulator Input edge Flag - Set when the selected edge is detected at the IOC7 input pin. In event <br> mode the event edge triggers PAIF and in gated time accumulation mode the trailing edge of the gate signal at <br> the IOC7 input pin triggers PAIF. <br> This bit is cleared by a write to the PAFLG register with bit 0 set. <br> Any access to the PACNT register will clear all the flags in this register when TFFCA bit in register TSCR(0x0006) <br> is set. |

### 13.3.2.17 Pulse Accumulators Count Registers (PACNT)



Figure 13-24. Pulse Accumulator Count Register High (PACNTH)


Figure 13-25. Pulse Accumulator Count Register Low (PACNTL)
Read: Anytime
Write: Anytime
These registers contain the number of active input edges on its input pin since the last reset.
When PACNT overflows from 0xFFFF to 0x0000, the Interrupt flag PAOVF in PAFLG (0x0021) is set.
Full count register access should take place in one clock cycle. A separate read/write for high byte and low byte will give a different result than accessing them as a word.

## NOTE

Reading the pulse accumulator counter registers immediately after an active edge on the pulse accumulator input pin may miss the last count because the input has to be synchronized with the bus clock first.

### 13.4 Functional Description

This section provides a complete functional description of the timer TIM16B4CV1 block. Please refer to the detailed timer block diagram in Figure 13-26 as necessary.


Figure 13-26. Detailed Timer Block Diagram

### 13.4.1 Prescaler

The prescaler divides the bus clock by $1,2,4,8,16,32,64$ or 128 . The prescaler select bits, $\operatorname{PR}[2: 0]$, select the prescaler divisor. PR[2:0] are in timer system control register 2 (TSCR2).

### 13.4.2 Input Capture

Clearing the I/O (input/output) select bit, IOSx, configures channel $x$ as an input capture channel. The input capture function captures the time at which an external event occurs. When an active edge occurs on the pin of an input capture channel, the timer transfers the value in the timer counter into the timer channel registers, TCx.

The minimum pulse width for the input capture input is greater than two bus clocks.
An input capture on channel x sets the CxF flag. The CxI bit enables the CxF flag to generate interrupt requests.

### 13.4.3 Output Compare

Setting the I/O select bit, IOSx, configures channel $x$ as an output compare channel. The output compare function can generate a periodic pulse with a programmable polarity, duration, and frequency. When the timer counter reaches the value in the channel registers of an output compare channel, the timer can set, clear, or toggle the channel pin. An output compare on channel $x$ sets the CxF flag. The CxI bit enables the CxF flag to generate interrupt requests.

The output mode and level bits, OMx and OLx, select set, clear, toggle on output compare. Clearing both OMx and OLx disconnects the pin from the output logic.

Setting a force output compare bit, FOCx, causes an output compare on channel x. A forced output compare does not set the channel flag.

A successful output compare on channel 7 overrides output compares on all other output compare channels. The output compare 7 mask register masks the bits in the output compare 7 data register. The timer counter reset enable bit, TCRE, enables channel 7 output compares to reset the timer counter. A channel 7 output compare can reset the timer counter even if the IOC7 pin is being used as the pulse accumulator input.

Writing to the timer port bit of an output compare pin does not affect the pin state. The value written is stored in an internal latch. When the pin becomes available for general-purpose output, the last value written to the bit appears at the pin.

### 13.4.4 Pulse Accumulator

The pulse accumulator (PACNT) is a 16-bit counter that can operate in two modes:
Event counter mode - Counting edges of selected polarity on the pulse accumulator input pin, PAI.
Gated time accumulation mode - Counting pulses from a divide-by- 64 clock. The PAMOD bit selects the mode of operation.

The minimum pulse width for the PAI input is greater than two bus clocks.

### 13.4.5 Event Counter Mode

Clearing the PAMOD bit configures the PACNT for event counter operation. An active edge on the IOC7 pin increments the pulse accumulator counter. The PEDGE bit selects falling edges or rising edges to increment the count.

## NOTE

The PACNT input and timer channel 7 use the same pin IOC7. To use the IOC7, disconnect it from the output logic by clearing the channel 7 output mode and output level bits, OM7 and OL7. Also clear the channel 7 output compare 7 mask bit, OC7M7.

The Pulse Accumulator counter register reflect the number of active input edges on the PACNT input pin since the last reset.

The PAOVF bit is set when the accumulator rolls over from $0 x F F F F$ to $0 x 0000$. The pulse accumulator overflow interrupt enable bit, PAOVI, enables the PAOVF flag to generate interrupt requests.

## NOTE

The pulse accumulator counter can operate in event counter mode even when the timer enable bit, TEN, is clear.

### 13.4.6 Gated Time Accumulation Mode

Setting the PAMOD bit configures the pulse accumulator for gated time accumulation operation. An active level on the PACNT input pin enables a divided-by-64 clock to drive the pulse accumulator. The PEDGE bit selects low levels or high levels to enable the divided-by-64 clock.

The trailing edge of the active level at the IOC7 pin sets the PAIF. The PAI bit enables the PAIF flag to generate interrupt requests.

The pulse accumulator counter register reflect the number of pulses from the divided-by-64 clock since the last reset.

## NOTE

The timer prescaler generates the divided-by-64 clock. If the timer is not active, there is no divided-by-64 clock.

### 13.5 Resets

The reset state of each individual bit is listed within Section 13.3, "Memory Map and Register Definition" which details the registers and their bit fields.

### 13.6 Interrupts

This section describes interrupts originated by the TIM16B4CV1 block. Table 13-21 lists the interrupts generated by the TIM16B4CV1 to communicate with the MCU.

Table 13-21. TIM16B8CV1 Interrupts

| Interrupt | Offset $^{\mathbf{1}}$ | Vector $^{\mathbf{1}}$ | Priority $^{\mathbf{1}}$ | Source | Description |
| :---: | :---: | :---: | :---: | :---: | :---: |
| C[7:4]F | - | - | - | Timer Channel 7-4 | Active high timer channel interrupts 7-4 |
| PAOVI | - | - | - | Pulse Accumulator <br> Input | Active high pulse accumulator input interrupt |
| PAOVF | - | - | - | Pulse Accumulator <br> Overflow | Pulse accumulator overflow interrupt |
| TOF | - | - | - | Timer Overflow | Timer Overflow interrupt |

1 Chip Dependent.
The TIM16B4CV1 uses a total of 7 interrupt vectors. The interrupt vector offsets and interrupt numbers are chip dependent.

### 13.6.1 Channel [7:4] Interrupt (C[7:4]F)

This active high outputs will be asserted by the module to request a timer channel $7-4$ interrupt to be serviced by the system controller.

### 13.6.2 Pulse Accumulator Input Interrupt (PAOVI)

This active high output will be asserted by the module to request a timer pulse accumulator input interrupt to be serviced by the system controller.

### 13.6.3 Pulse Accumulator Overflow Interrupt (PAOVF)

This active high output will be asserted by the module to request a timer pulse accumulator overflow interrupt to be serviced by the system controller.

### 13.6.4 Timer Overflow Interrupt (TOF)

This active high output will be asserted by the module to request a timer overflow interrupt to be serviced by the system controller.

## Chapter 14 <br> Dual Output Voltage Regulator (VREG3V3V2)

### 14.1 Introduction

The VREG3V3V2 is a dual output voltage regulator providing two separate 2.5 V (typical) supplies differing in the amount of current that can be sourced. The regulator input voltage range is from 3.3 V up to 5 V (typical).

### 14.1.1 Features

The block VREG3V3V2 includes these distinctive features:

- Two parallel, linear voltage regulators
- Bandgap reference
- Low-voltage detect (LVD) with low-voltage interrupt (LVI)
- Power-on reset (POR)
- Low-voltage reset (LVR)


### 14.1.2 Modes of Operation

There are three modes VREG3V3V2 can operate in:

- Full-performance mode (FPM) (MCU is not in stop mode)

The regulator is active, providing the nominal supply voltage of 2.5 V with full current sourcing capability at both outputs. Features LVD (low-voltage detect), LVR (low-voltage reset), and POR (power-on reset) are available.

- Reduced-power mode (RPM) (MCU is in stop mode)

The purpose is to reduce power consumption of the device. The output voltage may degrade to a lower value than in full-performance mode, additionally the current sourcing capability is substantially reduced. Only the POR is available in this mode, LVD and LVR are disabled.

- Shutdown mode

Controlled by $\mathrm{V}_{\text {REGEN }}$ (see device overview chapter for connectivity of $\mathrm{V}_{\text {REGEN }}$ ).
This mode is characterized by minimum power consumption. The regulator outputs are in a high impedance state, only the POR feature is available, LVD and LVR are disabled.
This mode must be used to disable the chip internal regulator VREG3V3V2, i.e., to bypass the VREG3V3V2 to use external supplies.

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### 14.1.3 Block Diagram

Figure 14-1 shows the function principle of VREG3V3V2 by means of a block diagram. The regulator core REG consists of two parallel sub-blocks, REG1 and REG2, providing two independent output voltages.


REG: Regulator Core
LVD: Low Voltage Detect
CTRL: Regulator Control
LVR: Low Voltage Reset
POR: Power-on Reset
Q PIN
Figure 14-1. VREG3V3 Block Diagram

### 14.2 External Signal Description

Due to the nature of VREG3V3V2 being a voltage regulator providing the chip internal power supply voltages most signals are power supply signals connected to pads.
Table 14-1 shows all signals of VREG3V3V2 associated with pins.
Table 14-1. VREG3V3V2 - Signal Properties

| Name | Port | Function | Reset State | Pull Up |
| :---: | :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\text {DDR }}$ | - | VREG3V3V2 power input (positive supply) | - | - |
| $\mathrm{V}_{\mathrm{DDA}}$ | - | VREG3V3V2 quiet input (positive supply) | - | - |
| $\mathrm{V}_{\text {SSA }}$ | - | VREG3V3V2 quiet input (ground) | - | - |
| $\mathrm{V}_{\mathrm{DD}}$ | - | VREG3V3V2 primary output (positive supply) | - | - |
| $\mathrm{V}_{\text {SS }}$ | - | VREG3V3V2 primary output (ground) | - | - |
| $\mathrm{V}_{\text {DDPLL }}$ | - | VREG3V3V2 secondary output (positive supply) | - | - |
| $\mathrm{V}_{\text {SSPLL }}$ | - | VREG3V3V2 secondary output (ground) | - | - |
| $\mathrm{V}_{\text {REGEN }}$ (optional) | - | VREG3V3V2 (Optional) Regulator Enable | - | - |

## NOTE

Check device overview chapter for connectivity of the signals.

### 14.2.1 $V_{D D R}$ - Regulator Power Input

Signal $\mathrm{V}_{\mathrm{DDR}}$ is the power input of VREG3V3V2. All currents sourced into the regulator loads flow through this pin. A chip external decoupling capacitor ( $100 \mathrm{nF} . .220 \mathrm{nF}, \mathrm{X} 7 \mathrm{R}$ ceramic) between $\mathrm{V}_{\mathrm{DDR}}$ and $\mathrm{V}_{\mathrm{SSR}}$ can smoothen ripple on $\mathrm{V}_{\mathrm{DDR}}$.
For entering shutdown mode, pin $V_{\text {DDR }}$ should also be tied to ground on devices without a $V_{\text {REGEN }}$ pin.

### 14.2.2 $\mathrm{V}_{\mathrm{DDA}}, \mathrm{V}_{\mathrm{SSA}}$ - Regulator Reference Supply

Signals $\mathrm{V}_{\mathrm{DDA}} / \mathrm{V}_{\mathrm{SSA}}$ which are supposed to be relatively quiet are used to supply the analog parts of the regulator. Internal precision reference circuits are supplied from these signals. A chip external decoupling capacitor ( $100 \mathrm{nF} \ldots 220 \mathrm{nF}, \mathrm{X} 7 \mathrm{R}$ ceramic) between $\mathrm{V}_{\mathrm{DDA}}$ and $\mathrm{V}_{\mathrm{SSA}}$ can further improve the quality of this supply.

### 14.2.3 $\quad \mathrm{V}_{\mathrm{DD}}, \mathrm{V}_{\mathrm{SS}}$ - Regulator Output1 (Core Logic)

Signals $\mathrm{V}_{\mathrm{DD}} / \mathrm{V}_{\mathrm{SS}}$ are the primary outputs of VREG3V3V2 that provide the power supply for the core logic. These signals are connected to device pins to allow external decoupling capacitors ( $100 \mathrm{nF} \ldots 220 \mathrm{nF}$, X7R ceramic).

In shutdown mode an external supply at $\mathrm{V}_{\mathrm{DD}} / \mathrm{V}_{\mathrm{SS}}$ can replace the voltage regulator.

### 14.2.4 $\mathrm{V}_{\text {DDPLL }}, \mathrm{V}_{\text {SSPLL }}$ — Regulator Output2 (PLL)

Signals $\mathrm{V}_{\text {DDPLL }} / \mathrm{V}_{\text {SSPLL }}$ are the secondary outputs of VREG3V3V2 that provide the power supply for the PLL and oscillator. These signals are connected to device pins to allow external decoupling capacitors ( $100 \mathrm{nF} . . .220 \mathrm{nF}$, X7R ceramic).

In shutdown mode an external supply at $\mathrm{V}_{\text {DDPLL }} / \mathrm{V}_{\text {SSPLL }}$ can replace the voltage regulator.

### 14.2.5 $\quad V_{\text {REGEN }}$ — Optional Regulator Enable

This optional signal is used to shutdown VREG3V3V2. In that case $\mathrm{V}_{\mathrm{DD}} / \mathrm{V}_{\mathrm{SS}}$ and $\mathrm{V}_{\text {DDPLL }} / \mathrm{V}_{\text {SSPLL }}$ must be provided externally. shutdown mode is entered with $V_{\text {REGEN }}$ being low. If $\mathrm{V}_{\text {REGEN }}$ is high, the VREG3V3V2 is either in full-performance mode or in reduced-power mode.

For the connectivity of $V_{\text {REGEN }}$ see device overview chapter.
NOTE
Switching from FPM or RPM to shutdown of VREG3V3V2 and vice versa is not supported while the MCU is powered.

### 14.3 Memory Map and Register Definition

This subsection provides a detailed description of all registers accessible in VREG3V3V2.

### 14.3.1 Module Memory Map

Figure 14-2 provides an overview of all used registers.
Table 14-2. VREG3V3V2 Memory Map

| Address <br> Offset | Use | Access |
| :---: | :---: | :---: |
| $0 \times 0000$ | VREG3V3V2 Control Register (VREGCTRL) | R/W |

### 14.3.2 Register Descriptions

The following paragraphs describe, in address order, all the VREG3V3V2 registers and their individual bits.

### 14.3.2.1 VREG3V3V2 - Control Register (VREGCTRL)

The VREGCTRL register allows to separately enable features of VREG3V3V2.


Figure 14-2. VREG3V3 - Control Register (VREGCTRL)
Table 14-3. MCCTL1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 2 \\ \text { LVDS } \end{gathered}$ | Low-Voltage Detect Status Bit — This read-only status bit reflects the input voltage. Writes have no effect. 0 Input voltage $\mathrm{V}_{\mathrm{DDA}}$ is above level $\mathrm{V}_{\mathrm{LVID}}$ or RPM or shutdown mode. <br> 1 Input voltage $\mathrm{V}_{\text {DDA }}$ is below level $\mathrm{V}_{\text {LVIA }}$ and FPM. |
| $\begin{gathered} 1 \\ \text { LVIE } \end{gathered}$ | Low-Voltage Interrupt Enable Bit <br> 0 Interrupt request is disabled. <br> 1 Interrupt will be requested whenever LVIF is set. |
| $\begin{gathered} 0 \\ \text { LVIF } \end{gathered}$ | Low-Voltage Interrupt Flag - LVIF is set to 1 when LVDS status bit changes. This flag can only be cleared by writing a 1 . Writing a 0 has no effect. If enabled (LVIE = 1), LVIF causes an interrupt request. <br> 0 No change in LVDS bit. <br> 1 LVDS bit has changed. |

## NOTE

On entering the reduced-power mode the LVIF is not cleared by the VREG3V3V2.

### 14.4 Functional Description

Block VREG3V3V2 is a voltage regulator as depicted in Figure 14-1. The regulator functional elements are the regulator core (REG), a low-voltage detect module (LVD), a power-on reset module (POR) and a low-voltage reset module (LVR). There is also the regulator control block (CTRL) which represents the interface to the digital core logic but also manages the operating modes of VREG3V3V2.

### 14.4.1 REG — Regulator Core

VREG3V3V2, respectively its regulator core has two parallel, independent regulation loops (REG1 and REG2) that differ only in the amount of current that can be sourced to the connected loads. Therefore, only REG1 providing the supply at $\mathrm{V}_{\mathrm{DD}} / \mathrm{V}_{\mathrm{SS}}$ is explained. The principle is also valid for REG2.

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The regulator is a linear series regulator with a bandgap reference in its full-performance mode and a voltage clamp in reduced-power mode. All load currents flow from input $\mathrm{V}_{\mathrm{DDR}}$ to $\mathrm{V}_{\mathrm{SS}}$ or $\mathrm{V}_{\text {SSPLL }}$, the reference circuits are connected to $\mathrm{V}_{\mathrm{DDA}}$ and $\mathrm{V}_{\mathrm{SSA}}$.

### 14.4.2 Full-Performance Mode

In full-performance mode, a fraction of the output voltage $\left(\mathrm{V}_{\mathrm{DD}}\right)$ and the bandgap reference voltage are fed to an operational amplifier. The amplified input voltage difference controls the gate of an output driver which basically is a large NMOS transistor connected to the output.

### 14.4.3 Reduced-Power Mode

In reduced-power mode, the driver gate is connected to a buffered fraction of the input voltage $\left(\mathrm{V}_{\mathrm{DDR}}\right)$. The operational amplifier and the bandgap are disabled to reduce power consumption.

### 14.4.4 LVD — Low-Voltage Detect

sub-block LVD is responsible for generating the low-voltage interrupt (LVI). LVD monitors the input voltage ( $\mathrm{V}_{\mathrm{DDA}}-\mathrm{V}_{\mathrm{SSA}}$ ) and continuously updates the status flag LVDS. Interrupt flag LVIF is set whenever status flag LVDS changes its value. The LVD is available in FPM and is inactive in reduced-power mode and shutdown mode.

### 14.4.5 POR — Power-On Reset

This functional block monitors output $\mathrm{V}_{\mathrm{DD}}$. If $\mathrm{V}_{\mathrm{DD}}$ is below $\mathrm{V}_{\text {PORD }}$, signal POR is high, if it exceeds $\mathrm{V}_{\text {PORD }}$, the signal goes low. The transition to low forces the CPU in the power-on sequence.

Due to its role during chip power-up this module must be active in all operating modes of VREG3V3V2.

### 14.4.6 LVR — Low-Voltage Reset

Block LVR monitors the primary output voltage $\mathrm{V}_{\mathrm{DD}}$. If it drops below the assertion level ( $\mathrm{V}_{\mathrm{LVRA}}$ ) signal LVR asserts and when rising above the deassertion level ( $\mathrm{V}_{\mathrm{LVRD}}$ ) signal LVR negates again. The LVR function is available only in full-performance mode.

### 14.4.7 CTRL — Regulator Control

This part contains the register block of VREG3V3V2 and further digital functionality needed to control the operating modes. CTRL also represents the interface to the digital core logic.

### 14.5 Resets

This subsection describes how VREG3V3V2 controls the reset of the MCU.The reset values of registers and signals are provided in Section 14.3, "Memory Map and Register Definition". Possible reset sources are listed in Table 14-4.

Table 14-4. VREG3V3V2 - Reset Sources

| Reset Source | Local Enable |
| :--- | :--- |
| Power-on reset | Always active |
| Low-voltage reset | Available only in full-performance mode |

### 14.5.1 Power-On Reset

During chip power-up the digital core may not work if its supply voltage $\mathrm{V}_{\mathrm{DD}}$ is below the POR deassertion level ( $\mathrm{V}_{\text {PORD }}$ ). Therefore, signal POR which forces the other blocks of the device into reset is kept high until $\mathrm{V}_{\mathrm{DD}}$ exceeds $\mathrm{V}_{\text {PORD }}$. Then POR becomes low and the reset generator of the device continues the start-up sequence. The power-on reset is active in all operation modes of VREG3V3V2.

### 14.5.2 Low-Voltage Reset

For details on low-voltage reset see Section 14.4.6, "LVR — Low-Voltage Reset".

### 14.6 Interrupts

This subsection describes all interrupts originated by VREG3V3V2.
The interrupt vectors requested by VREG3V3V2 are listed in Table 14-5. Vector addresses and interrupt priorities are defined at MCU level.

Table 14-5. VREG3V3V2 - Interrupt Vectors

| Interrupt Source | Local Enable |
| :---: | :--- |
| Low Voltage Interrupt (LVI) | LVIE = 1; Available only in full-performance mode |

### 14.6.1 LVI — Low-Voltage Interrupt

In FPM VREG3V3V2 monitors the input voltage $V_{\text {DDA }}$. Whenever $V_{\text {DDA }}$ drops below level $V_{\text {LVIA }}$ the status bit LVDS is set to 1 . Vice versa, LVDS is reset to 0 when $V_{\text {DDA }}$ rises above level $V_{\text {LVID }}$. An interrupt, indicated by flag LVIF $=1$, is triggered by any change of the status bit LVDS if interrupt enable bit LVIE $=1$.

## NOTE

On entering the reduced-power mode, the LVIF is not cleared by the VREG3V3V2.

## Chapter 15 Background Debug Module (BDMV4)

### 15.1 Introduction

This section describes the functionality of the background debug module (BDM) sub-block of the HCS12 core platform.

A block diagram of the BDM is shown in Figure 15-1.


Figure 15-1. BDM Block Diagram
The background debug module (BDM) sub-block is a single-wire, background debug system implemented in on-chip hardware for minimal CPU intervention. All interfacing with the BDM is done via the BKGD pin.

BDMV4 has enhanced capability for maintaining synchronization between the target and host while allowing more flexibility in clock rates. This includes a sync signal to show the clock rate and a handshake signal to indicate when an operation is complete. The system is backwards compatible with older external interfaces.

### 15.1.1 Features

- Single-wire communication with host development system
- BDMV4 (and BDM2): Enhanced capability for allowing more flexibility in clock rates
- BDMV4: SYNC command to determine communication rate
- BDMV4: GO_UNTIL command
- BDMV4: Hardware handshake protocol to increase the performance of the serial communication
- Active out of reset in special single-chip mode
- Nine hardware commands using free cycles, if available, for minimal CPU intervention
- Hardware commands not requiring active BDM
- 15 firmware commands execute from the standard BDM firmware lookup table
- Instruction tagging capability
- Software control of BDM operation during wait mode
- Software selectable clocks
- When secured, hardware commands are allowed to access the register space in special single-chip mode, if the FLASH and EEPROM erase tests fail.


### 15.1.2 Modes of Operation

BDM is available in all operating modes but must be enabled before firmware commands are executed. Some system peripherals may have a control bit which allows suspending the peripheral function during background debug mode.

### 15.1.2.1 Regular Run Modes

All of these operations refer to the part in run mode. The BDM does not provide controls to conserve power during run mode.

- Normal operation

General operation of the BDM is available and operates the same in all normal modes.

- Special single-chip mode

In special single-chip mode, background operation is enabled and active out of reset. This allows programming a system with blank memory.

- Special peripheral mode

BDM is enabled and active immediately out of reset. BDM can be disabled by clearing the BDMACT bit in the BDM status (BDMSTS) register. The BDM serial system should not be used in special peripheral mode.

- Emulation modes

General operation of the BDM is available and operates the same as in normal modes.

### 15.1.2.2 Secure Mode Operation

If the part is in secure mode, the operation of the BDM is reduced to a small subset of its regular run mode operation. Secure operation prevents access to FLASH or EEPROM other than allowing erasure.

### 15.2 External Signal Description

A single-wire interface pin is used to communicate with the BDM system. Two additional pins are used for instruction tagging. These pins are part of the multiplexed external bus interface (MEBI) sub-block and all interfacing between the MEBI and BDM is done within the core interface boundary. Functional descriptions of the pins are provided below for completeness.

- BKGD — Background interface pin
- $\overline{\text { TAGHI }}$ - High byte instruction tagging pin
- $\overline{\text { TAGLO }}$ - Low byte instruction tagging pin
- BKGD and TAGHI share the same pin.
- $\overline{\text { TAGLO }}$ and $\overline{\mathrm{LSTRB}}$ share the same pin.


## NOTE

Generally these pins are shared as described, but it is best to check the device overview chapter to make certain. All MCUs at the time of this writing have followed this pin sharing scheme.

### 15.2.1 BKGD — Background Interface Pin

Debugging control logic communicates with external devices serially via the single-wire background interface pin (BKGD). During reset, this pin is a mode select input which selects between normal and special modes of operation. After reset, this pin becomes the dedicated serial interface pin for the background debug mode.

### 15.2.2 TAGHI — High Byte Instruction Tagging Pin

This pin is used to tag the high byte of an instruction. When instruction tagging is on, a logic 0 at the falling edge of the external clock (ECLK) tags the high half of the instruction word being read into the instruction queue.

### 15.2.3 TAGLO — Low Byte Instruction Tagging Pin

This pin is used to tag the low byte of an instruction. When instruction tagging is on and low strobe is enabled, a logic 0 at the falling edge of the external clock (ECLK) tags the low half of the instruction word being read into the instruction queue.

## Chapter 15 Background Debug Module (BDMV4)

### 15.3 Memory Map and Register Definition

A summary of the registers associated with the BDM is shown in Figure 15-2. Registers are accessed by host-driven communications to the BDM hardware using READ_BD and WRITE_BD commands. Detailed descriptions of the registers and associated bits are given in the subsections that follow.

### 15.3.1 Module Memory Map

Table 15-1. INT Memory Map

| Register <br> Address | Use | Access |
| :---: | :--- | :---: |
|  | Reserved | - |
|  | BDM Status Register (BDMSTS) | R/W |
|  | Reserved | - |
|  | BDM CCR Holding Register (BDMCCR) | R/W |
| 7 | BDM Internal Register Position (BDMINR) | R |
| $8-$ | Reserved | - |

### 15.3.2 Register Descriptions



Figure 15-2. BDM Register Summary

### 15.3.2.1 BDM Status Register (BDMSTS)



Figure 15-3. BDM Status Register (BDMSTS)

## Note:

${ }^{1}$ ENBDM is read as "1" by a debugging environment in Special single-chip mode when the device is not secured or secured but fully erased (Flash and EEPROM). This is because the ENBDM bit is set by the standard firmware before a BDM command can be fully transmitted and executed.
${ }^{2}$ UNSEC is read as "1" by a debugging environment in Special single-chip mode when the device is secured and fully erased, else it is " 0 " and can only be read if not secure (see also bit description).

Read: All modes through BDM operation
Write: All modes but subject to the following:

- BDMACT can only be set by BDM hardware upon entry into BDM. It can only be cleared by the standard BDM firmware lookup table upon exit from BDM active mode.
- CLKSW can only be written via BDM hardware or standard BDM firmware write commands.
- All other bits, while writable via BDM hardware or standard BDM firmware write commands, should only be altered by the BDM hardware or standard firmware lookup table as part of BDM command execution.
- ENBDM should only be set via a BDM hardware command if the BDM firmware commands are needed. (This does not apply in special single-chip mode).

Table 15-2. BDMSTS Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| ENBDM | Enable BDM - This bit controls whether the BDM is enabled or disabled. When enabled, BDM can be made <br> active to allow firmware commands to be executed. When disabled, BDM cannot be made active but BDM <br> hardware commands are allowed. <br> 0 <br> 1 <br> BDM disabled <br> Note: ENBDM is set by the firmware immediately out of reset in special single-chip mode. In secure mode, this <br> bit will not be set by the firmware until after the EEPROM and FLASH erase verify tests are complete. |
| 6 <br> BDMACT | BDM Active Status - This bit becomes set upon entering BDM. The standard BDM firmware lookup table is <br> then enabled and put into the memory map. BDMACT is cleared by a carefully timed store instruction in the <br> standard BDM firmware as part of the exit sequence to return to user code and remove the BDM memory from <br> the map. <br> 0 <br> 1 |
| BDM not active |  |

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Table 15-2. BDMSTS Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 5 | Tagging Enable - This bit indicates whether instruction tagging in enabled or disabled. It is set when the <br> ENTAGG <br> TAGGO command is executed and cleared when BDM is entered. The serial system is disabled and the tag <br> function enabled 16 cycles after this bit is written. BDM cannot process serial commands while tagging is active. <br> O Tagging not enabled or BDM active <br> 1 |
| Tagging enabled |  |$|$| Shift Data Valid - This bit is set and cleared by the BDM hardware. It is set after data has been transmitted as |
| :--- |
| part of a firmware read command or after data has been received as part of a firmware write command. It is |
| cleared when the next BDM command has been received or BDM is exited. SDV is used by the standard BDM |
| firmware to control program flow execution. |
| 0 Data phase of command not complete |
| 1 Data phase of command is complete |

Table 15-3. BDM Clock Sources

| PLLSEL | CLKSW |  |
| :---: | :---: | :--- |
| 0 | 0 | Bus clock |
| 0 | 1 | Bus clock |

Table 15-3. BDM Clock Sources

| PLLSEL | CLKSW | BDMCLK |
| :---: | :---: | :--- |
| 1 | 0 | Alternate clock (refer to the device overview chapter to determine the alternate clock <br> source) |
| 1 | 1 | Bus clock dependent on the PLL |

### 15.3.2.2 BDM CCR Holding Register (BDMCCR)



Figure 15-4. BDM CCR Holding Register (BDMCCR)
Read: All modes
Write: All modes

## NOTE

When BDM is made active, the CPU stores the value of the CCR register in the BDMCCR register. However, out of special single-chip reset, the BDMCCR is set to 0 xD 8 and not 0 xD 0 which is the reset value of the CCR register.

When entering background debug mode, the BDM CCR holding register is used to save the contents of the condition code register of the user's program. It is also used for temporary storage in the standard BDM firmware mode. The BDM CCR holding register can be written to modify the CCR value.

### 15.3.2.3 BDM Internal Register Position Register (BDMINR)



Figure 15-5. BDM Internal Register Position (BDMINR)
Read: All modes
Write: Never
Table 15-4. BDMINR Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 3$ | Internal Register Map Position - These four bits show the state of the upper five bits of the base address for <br> REG $[14: 11]$ <br> the system's relocatable register block. BDMINR is a shadow of the INITRG register which maps the register <br> block to any 2K byte space within the first 32K bytes of the 64K byte address space. |

### 15.4 Functional Description

The BDM receives and executes commands from a host via a single wire serial interface. There are two types of BDM commands, namely, hardware commands and firmware commands.

Hardware commands are used to read and write target system memory locations and to enter active background debug mode, see Section 15.4.3, "BDM Hardware Commands." Target system memory includes all memory that is accessible by the CPU.

Firmware commands are used to read and write CPU resources and to exit from active background debug mode, see Section 15.4.4, "Standard BDM Firmware Commands." The CPU resources referred to are the accumulator (D), X index register (X), Y index register (Y), stack pointer (SP), and program counter (PC).
Hardware commands can be executed at any time and in any mode excluding a few exceptions as highlighted, see Section 15.4.3, "BDM Hardware Commands." Firmware commands can only be executed when the system is in active background debug mode (BDM).

### 15.4.1 Security

If the user resets into special single-chip mode with the system secured, a secured mode BDM firmware lookup table is brought into the map overlapping a portion of the standard BDM firmware lookup table. The secure BDM firmware verifies that the on-chip EEPROM and FLASH EEPROM are erased. This being the case, the UNSEC bit will get set. The BDM program jumps to the start of the standard BDM firmware and the secured mode BDM firmware is turned off and all BDM commands are allowed. If the EEPROM or FLASH do not verify as erased, the BDM firmware sets the ENBDM bit, without asserting UNSEC, and the firmware enters a loop. This causes the BDM hardware commands to become enabled, but does not enable the firmware commands. This allows the BDM hardware to be used to erase the EEPROM and FLASH. After execution of the secure firmware, regardless of the results of the erase tests, the CPU registers, INITEE and PPAGE, will no longer be in their reset state.

### 15.4.2 Enabling and Activating BDM

The system must be in active BDM to execute standard BDM firmware commands. BDM can be activated only after being enabled. BDM is enabled by setting the ENBDM bit in the BDM status (BDMSTS) register. The ENBDM bit is set by writing to the BDM status (BDMSTS) register, via the single-wire interface, using a hardware command such as WRITE_BD_BYTE.
After being enabled, BDM is activated by one of the following ${ }^{1}$ :

- Hardware BACKGROUND command
- BDM external instruction tagging mechanism
- CPU BGND instruction
- Breakpoint sub-block's force or tag mechanism ${ }^{2}$

When BDM is activated, the CPU finishes executing the current instruction and then begins executing the firmware in the standard BDM firmware lookup table. When BDM is activated by the breakpoint

[^6]sub-block, the type of breakpoint used determines if BDM becomes active before or after execution of the next instruction.


#### Abstract

NOTE If an attempt is made to activate BDM before being enabled, the CPU resumes normal instruction execution after a brief delay. If BDM is not enabled, any hardware BACKGROUND commands issued are ignored by the BDM and the CPU is not delayed.


In active BDM , the BDM registers and standard BDM firmware lookup table are mapped to addresses $0 x F F 00$ to $0 x F F F F$. BDM registers are mapped to addresses $0 x F F 00$ to $0 x F F 07$. The BDM uses these registers which are readable anytime by the BDM. However, these registers are not readable by user programs.

### 15.4.3 BDM Hardware Commands

Hardware commands are used to read and write target system memory locations and to enter active background debug mode. Target system memory includes all memory that is accessible by the CPU such as on-chip RAM, EEPROM, FLASH EEPROM, I/O and control registers, and all external memory.

Hardware commands are executed with minimal or no CPU intervention and do not require the system to be in active BDM for execution, although they can continue to be executed in this mode. When executing a hardware command, the BDM sub-block waits for a free CPU bus cycle so that the background access does not disturb the running application program. If a free cycle is not found within 128 clock cycles, the CPU is momentarily frozen so that the BDM can steal a cycle. When the BDM finds a free cycle, the operation does not intrude on normal CPU operation provided that it can be completed in a single cycle. However, if an operation requires multiple cycles the CPU is frozen until the operation is complete, even though the BDM found a free cycle.

The BDM hardware commands are listed in Table 15-5.
Table 15-5. Hardware Commands

| Command | Opcode (hex) | Data | Description |
| :---: | :---: | :---: | :---: |
| BACKGROUND | 90 | None | Enter background mode if firmware is enabled. If enabled, an ACK will be issued when the part enters active background mode. |
| ACK_ENABLE | D5 | None | Enable handshake. Issues an ACK pulse after the command is executed. |
| ACK_DISABLE | D6 | None | Disable handshake. This command does not issue an ACK pulse. |
| READ_BD_BYTE | E4 | 16-bit address 16-bit data out | Read from memory with standard BDM firmware lookup table in map. Odd address data on low byte; even address data on high byte. |
| READ_BD_WORD | EC | 16-bit address 16-bit data out | Read from memory with standard BDM firmware lookup table in map. Must be aligned access. |
| READ_BYTE | E0 | 16-bit address 16-bit data out | Read from memory with standard BDM firmware lookup table out of map. Odd address data on low byte; even address data on high byte. |
| READ_WORD | E8 | 16-bit address 16-bit data out | Read from memory with standard BDM firmware lookup table out of map. Must be aligned access. |
| WRITE_BD_BYTE | C4 | 16-bit address 16-bit data in | Write to memory with standard BDM firmware lookup table in map. Odd address data on low byte; even address data on high byte. |
| WRITE_BD_WORD | CC | 16-bit address 16-bit data in | Write to memory with standard BDM firmware lookup table in map. Must be aligned access. |
| WRITE_BYTE | C0 | 16-bit address 16-bit data in | Write to memory with standard BDM firmware lookup table out of map. Odd address data on low byte; even address data on high byte. |
| WRITE_WORD | C8 | 16-bit address 16-bit data in | Write to memory with standard BDM firmware lookup table out of map. Must be aligned access. |

## NOTE:

If enabled, ACK will occur when data is ready for transmission for all BDM READ commands and will occur after the write is complete for all BDM WRITE commands.

The READ_BD and WRITE_BD commands allow access to the BDM register locations. These locations are not normally in the system memory map but share addresses with the application in memory. To distinguish between physical memory locations that share the same address, BDM memory resources are enabled just for the READ_BD and WRITE_BD access cycle. This allows the BDM to access BDM locations unobtrusively, even if the addresses conflict with the application memory map.

### 15.4.4 Standard BDM Firmware Commands

Firmware commands are used to access and manipulate CPU resources. The system must be in active BDM to execute standard BDM firmware commands, see Section 15.4.2, "Enabling and Activating BDM." Normal instruction execution is suspended while the CPU executes the firmware located in the standard BDM firmware lookup table. The hardware command BACKGROUND is the usual way to activate BDM.

As the system enters active BDM, the standard BDM firmware lookup table and BDM registers become visible in the on-chip memory map at $0 \times x F F 00-0 x F F F F$, and the CPU begins executing the standard BDM
firmware. The standard BDM firmware watches for serial commands and executes them as they are received.

The firmware commands are shown in Table 15-6.
Table 15-6. Firmware Commands

| Command ${ }^{1}$ | Opcode (hex) | Data | Description |
| :---: | :---: | :---: | :---: |
| READ_NEXT | 62 | 16-bit data out | Increment $X$ by $2(X=X+2)$, then read word $X$ points to. |
| READ_PC | 63 | 16-bit data out | Read program counter. |
| READ_D | 64 | 16-bit data out | Read D accumulator. |
| READ_X | 65 | 16-bit data out | Read X index register. |
| READ_Y | 66 | 16-bit data out | Read Y index register. |
| READ_SP | 67 | 16-bit data out | Read stack pointer. |
| WRITE_NEXT | 42 | 16-bit data in | Increment $X$ by $2(X=X+2)$, then write word to location pointed to by $X$. |
| WRITE_PC | 43 | 16-bit data in | Write program counter. |
| WRITE_D | 44 | 16-bit data in | Write D accumulator. |
| WRITE_X | 45 | 16-bit data in | Write X index register. |
| WRITE_Y | 46 | 16-bit data in | Write Y index register. |
| WRITE_SP | 47 | 16-bit data in | Write stack pointer. |
| GO | 08 | None | Go to user program. If enabled, ACK will occur when leaving active background mode. |
| GO_UNTIL ${ }^{2}$ | OC | None | Go to user program. If enabled, ACK will occur upon returning to active background mode. |
| TRACE1 | 10 | None | Execute one user instruction then return to active BDM. If enabled, ACK will occur upon returning to active background mode. |
| TAGGO | 18 | None | Enable tagging and go to user program. There is no ACK pulse related to this command. |

1 If enabled, ACK will occur when data is ready for transmission for all BDM READ commands and will occur after the write is complete for all BDM WRITE commands.
2 Both WAIT (with clocks to the S12 CPU core disabled) and STOP disable the ACK function. The GO_UNTIL command will not get an Acknowledge if one of these two CPU instructions occurs before the "UNTIL" instruction. This can be a problem for any instruction that uses ACK, but GO_UNTIL is a lot more difficult for the development tool to time-out.

### 15.4.5 BDM Command Structure

Hardware and firmware BDM commands start with an 8-bit opcode followed by a 16 -bit address and/or a 16-bit data word depending on the command. All the read commands return 16 bits of data despite the byte or word implication in the command name.

## NOTE

8-bit reads return 16-bits of data, of which, only one byte will contain valid data. If reading an even address, the valid data will appear in the MSB. If reading an odd address, the valid data will appear in the LSB.

## NOTE

16-bit misaligned reads and writes are not allowed. If attempted, the BDM will ignore the least significant bit of the address and will assume an even address from the remaining bits.

For hardware data read commands, the external host must wait 150 bus clock cycles after sending the address before attempting to obtain the read data. This is to be certain that valid data is available in the BDM shift register, ready to be shifted out. For hardware write commands, the external host must wait 150 bus clock cycles after sending the data to be written before attempting to send a new command. This is to avoid disturbing the BDM shift register before the write has been completed. The 150 bus clock cycle delay in both cases includes the maximum 128 cycle delay that can be incurred as the BDM waits for a free cycle before stealing a cycle.

For firmware read commands, the external host should wait 44 bus clock cycles after sending the command opcode and before attempting to obtain the read data. This includes the potential of an extra 7 cycles when the access is external with a narrow bus access ( +1 cycle) and / or a stretch ( $+1,2$, or 3 cycles), ( 7 cycles could be needed if both occur). The 44 cycle wait allows enough time for the requested data to be made available in the BDM shift register, ready to be shifted out.

## NOTE

This timing has increased from previous BDM modules due to the new capability in which the BDM serial interface can potentially run faster than the bus. On previous BDM modules this extra time could be hidden within the serial time.

For firmware write commands, the external host must wait 32 bus clock cycles after sending the data to be written before attempting to send a new command. This is to avoid disturbing the BDM shift register before the write has been completed.

The external host should wait 64 bus clock cycles after a TRACE1 or GO command before starting any new serial command. This is to allow the CPU to exit gracefully from the standard BDM firmware lookup table and resume execution of the user code. Disturbing the BDM shift register prematurely may adversely affect the exit from the standard BDM firmware lookup table.

## NOTE

If the bus rate of the target processor is unknown or could be changing, it is recommended that the ACK (acknowledge function) be used to indicate when an operation is complete. When using ACK, the delay times are automated.

Figure 15-6 represents the BDM command structure. The command blocks illustrate a series of eight bit times starting with a falling edge. The bar across the top of the blocks indicates that the BKGD line idles in the high state. The time for an 8 -bit command is $8 \times 16$ target clock cycles. ${ }^{1}$

[^7]

Figure 15-6. BDM Command Structure

### 15.4.6 BDM Serial Interface

The BDM communicates with external devices serially via the BKGD pin. During reset, this pin is a mode select input which selects between normal and special modes of operation. After reset, this pin becomes the dedicated serial interface pin for the BDM.

The BDM serial interface is timed using the clock selected by the CLKSW bit in the status register see Section 15.3.2.1, "BDM Status Register (BDMSTS)." This clock will be referred to as the target clock in the following explanation.

The BDM serial interface uses a clocking scheme in which the external host generates a falling edge on the BKGD pin to indicate the start of each bit time. This falling edge is sent for every bit whether data is transmitted or received. Data is transferred most significant bit (MSB) first at 16 target clock cycles per bit. The interface times out if 512 clock cycles occur between falling edges from the host.

The BKGD pin is a pseudo open-drain pin and has an weak on-chip active pull-up that is enabled at all times. It is assumed that there is an external pull-up and that drivers connected to BKGD do not typically drive the high level. Because R-C rise time could be unacceptably long, the target system and host provide brief driven-high (speedup) pulses to drive BKGD to a logic 1. The source of this speedup pulse is the host for transmit cases and the target for receive cases.

The timing for host-to-target is shown in Figure 15-7 and that of target-to-host in Figure 15-8 and Figure 15-9. All four cases begin when the host drives the BKGD pin low to generate a falling edge. Because the host and target are operating from separate clocks, it can take the target system up to one full clock cycle to recognize this edge. The target measures delays from this perceived start of the bit time while the host measures delays from the point it actually drove BKGD low to start the bit up to one target

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clock cycle earlier. Synchronization between the host and target is established in this manner at the start of every bit time.

Figure 15-7 shows an external host transmitting a logic 1 and transmitting a logic 0 to the BKGD pin of a target system. The host is asynchronous to the target, so there is up to a one clock-cycle delay from the host-generated falling edge to where the target recognizes this edge as the beginning of the bit time. Ten target clock cycles later, the target senses the bit level on the BKGD pin. Internal glitch detect logic requires the pin be driven high no later that eight target clock cycles after the falling edge for a logic 1 transmission.

Because the host drives the high speedup pulses in these two cases, the rising edges look like digitally driven signals.


Figure 15-7. BDM Host-to-Target Serial Bit Timing
The receive cases are more complicated. Figure $15-8$ shows the host receiving a logic 1 from the target system. Because the host is asynchronous to the target, there is up to one clock-cycle delay from the host-generated falling edge on BKGD to the perceived start of the bit time in the target. The host holds the BKGD pin low long enough for the target to recognize it (at least two target clock cycles). The host must release the low drive before the target drives a brief high speedup pulse seven target clock cycles after the perceived start of the bit time. The host should sample the bit level about 10 target clock cycles after it started the bit time.


Figure 15-8. BDM Target-to-Host Serial Bit Timing (Logic 1)
Figure 15-9 shows the host receiving a logic 0 from the target. Because the host is asynchronous to the target, there is up to a one clock-cycle delay from the host-generated falling edge on BKGD to the start of the bit time as perceived by the target. The host initiates the bit time but the target finishes it. Because the target wants the host to receive a logic 0 , it drives the BKGD pin low for 13 target clock cycles then briefly drives it high to speed up the rising edge. The host samples the bit level about 10 target clock cycles after starting the bit time.


Figure 15-9. BDM Target-to-Host Serial Bit Timing (Logic 0)

### 15.4.7 Serial Interface Hardware Handshake Protocol

BDM commands that require CPU execution are ultimately treated at the MCU bus rate. Because the BDM clock source can be asynchronously related to the bus frequency, when CLKSW $=0$, it is very helpful to provide a handshake protocol in which the host could determine when an issued command is executed by the CPU. The alternative is to always wait the amount of time equal to the appropriate number of cycles at the slowest possible rate the clock could be running. This sub-section will describe the hardware handshake protocol.
The hardware handshake protocol signals to the host controller when an issued command was successfully executed by the target. This protocol is implemented by a 16 serial clock cycle low pulse followed by a brief speedup pulse in the BKGD pin. This pulse is generated by the target MCU when a command, issued by the host, has been successfully executed (see Figure 15-10). This pulse is referred to as the ACK pulse. After the ACK pulse has finished: the host can start the bit retrieval if the last issued command was a read command, or start a new command if the last command was a write command or a control command (BACKGROUND, GO, GO_UNTIL, or TRACE1). The ACK pulse is not issued earlier than 32 serial clock cycles after the BDM command was issued. The end of the BDM command is assumed to be the 16th tick of the last bit. This minimum delay assures enough time for the host to perceive the ACK pulse. Note also that, there is no upper limit for the delay between the command and the related ACK pulse, because the command execution depends upon the CPU bus frequency, which in some cases could be very slow compared to the serial communication rate. This protocol allows a great flexibility for the POD designers, because it does not rely on any accurate time measurement or short response time to any event in the serial communication.


Figure 15-10. Target Acknowledge Pulse (ACK)

## NOTE

If the ACK pulse was issued by the target, the host assumes the previous command was executed. If the CPU enters WAIT or STOP prior to executing a hardware command, the ACK pulse will not be issued meaning that the BDM command was not executed. After entering wait or stop mode, the BDM command is no longer pending.

Figure 15-11 shows the ACK handshake protocol in a command level timing diagram. The READ_BYTE instruction is used as an example. First, the 8 -bit instruction opcode is sent by the host, followed by the address of the memory location to be read. The target BDM decodes the instruction. A bus cycle is grabbed (free or stolen) by the BDM and it executes the READ_BYTE operation. Having retrieved the data, the BDM issues an ACK pulse to the host controller, indicating that the addressed byte is ready to be retrieved. After detecting the ACK pulse, the host initiates the byte retrieval process. Note that data is sent in the form of a word and the host needs to determine which is the appropriate byte based on whether the address was odd or even.


Figure 15-11. Handshake Protocol at Command Level
Differently from the normal bit transfer (where the host initiates the transmission), the serial interface ACK handshake pulse is initiated by the target MCU by issuing a falling edge in the BKGD pin. The hardware handshake protocol in Figure 15-10 specifies the timing when the BKGD pin is being driven, so the host should follow this timing constraint in order to avoid the risk of an electrical conflict in the BKGD pin.

## NOTE

The only place the BKGD pin can have an electrical conflict is when one side is driving low and the other side is issuing a speedup pulse (high). Other "highs" are pulled rather than driven. However, at low rates the time of the speedup pulse can become lengthy and so the potential conflict time becomes longer as well.

The ACK handshake protocol does not support nested ACK pulses. If a BDM command is not acknowledge by an ACK pulse, the host needs to abort the pending command first in order to be able to issue a new BDM command. When the CPU enters WAIT or STOP while the host issues a command that requires CPU execution (e.g., WRITE_BYTE), the target discards the incoming command due to the WAIT or STOP being detected. Therefore, the command is not acknowledged by the target, which means that the ACK pulse will not be issued in this case. After a certain time the host should decide to abort the ACK sequence in order to be free to issue a new command. Therefore, the protocol should provide a mechanism in which a command, and therefore a pending ACK, could be aborted.

## NOTE

Differently from a regular BDM command, the ACK pulse does not provide a time out. This means that in the case of a WAIT or STOP instruction being executed, the ACK would be prevented from being issued. If not aborted, the ACK would remain pending indefinitely. See the handshake abort procedure described in Section 15.4.8, "Hardware Handshake Abort Procedure."

### 15.4.8 Hardware Handshake Abort Procedure

The abort procedure is based on the SYNC command. In order to abort a command, which had not issued the corresponding ACK pulse, the host controller should generate a low pulse in the BKGD pin by driving it low for at least 128 serial clock cycles and then driving it high for one serial clock cycle, providing a speedup pulse. By detecting this long low pulse in the BKGD pin, the target executes the SYNC protocol, see Section 15.4.9, "SYNC - Request Timed Reference Pulse," and assumes that the pending command and therefore the related ACK pulse, are being aborted. Therefore, after the SYNC protocol has been completed the host is free to issue new BDM commands.

Although it is not recommended, the host could abort a pending BDM command by issuing a low pulse in the BKGD pin shorter than 128 serial clock cycles, which will not be interpreted as the SYNC command. The ACK is actually aborted when a falling edge is perceived by the target in the BKGD pin. The short abort pulse should have at least 4 clock cycles keeping the BKGD pin low, in order to allow the falling edge to be detected by the target. In this case, the target will not execute the SYNC protocol but the pending command will be aborted along with the ACK pulse. The potential problem with this abort procedure is when there is a conflict between the ACK pulse and the short abort pulse. In this case, the target may not perceive the abort pulse. The worst case is when the pending command is a read command (i.e., READ_BYTE). If the abort pulse is not perceived by the target the host will attempt to send a new command after the abort pulse was issued, while the target expects the host to retrieve the accessed memory byte. In this case, host and target will run out of synchronism. However, if the command to be aborted is not a read command the short abort pulse could be used. After a command is aborted the target assumes the next falling edge, after the abort pulse, is the first bit of a new BDM command.

## NOTE

The details about the short abort pulse are being provided only as a reference for the reader to better understand the BDM internal behavior. It is not recommended that this procedure be used in a real application.

Because the host knows the target serial clock frequency, the SYNC command (used to abort a command) does not need to consider the lower possible target frequency. In this case, the host could issue a SYNC very close to the 128 serial clock cycles length. Providing a small overhead on the pulse length in order to assure the SYNC pulse will not be misinterpreted by the target. See Section 15.4.9, "SYNC - Request Timed Reference Pulse."

Figure 15-12 shows a SYNC command being issued after a READ_BYTE, which aborts the
READ_BYTE command. Note that, after the command is aborted a new command could be issued by the host computer.

## NOTE

Figure 15-12 does not represent the signals in a true timing scale


Figure 15-12. ACK Abort Procedure at the Command Level
Figure 15-13 shows a conflict between the ACK pulse and the SYNC request pulse. This conflict could occur if a POD device is connected to the target BKGD pin and the target is already in debug active mode. Consider that the target CPU is executing a pending BDM command at the exact moment the POD is being connected to the BKGD pin. In this case, an ACK pulse is issued along with the SYNC command. In this case, there is an electrical conflict between the ACK speedup pulse and the SYNC pulse. Because this is not a probable situation, the protocol does not prevent this conflict from happening.


Figure 15-13. ACK Pulse and SYNC Request Conflict
NOTE
This information is being provided so that the MCU integrator will be aware that such a conflict could eventually occur.

The hardware handshake protocol is enabled by the ACK_ENABLE and disabled by the ACK_DISABLE BDM commands. This provides backwards compatibility with the existing POD devices which are not able to execute the hardware handshake protocol. It also allows for new POD devices, that support the hardware handshake protocol, to freely communicate with the target device. If desired, without the need for waiting for the ACK pulse.

The commands are described as follows:

- ACK_ENABLE - enables the hardware handshake protocol. The target will issue the ACK pulse when a CPU command is executed by the CPU. The ACK_ENABLE command itself also has the ACK pulse as a response.
- ACK_DISABLE - disables the ACK pulse protocol. In this case, the host needs to use the worst case delay time at the appropriate places in the protocol.

The default state of the BDM after reset is hardware handshake protocol disabled.
All the read commands will ACK (if enabled) when the data bus cycle has completed and the data is then ready for reading out by the BKGD serial pin. All the write commands will ACK (if enabled) after the data has been received by the BDM through the BKGD serial pin and when the data bus cycle is complete. See Section 15.4.3, "BDM Hardware Commands," and Section 15.4.4, "Standard BDM Firmware Commands," for more information on the BDM commands.

The ACK_ENABLE sends an ACK pulse when the command has been completed. This feature could be used by the host to evaluate if the target supports the hardware handshake protocol. If an ACK pulse is issued in response to this command, the host knows that the target supports the hardware handshake protocol. If the target does not support the hardware handshake protocol the ACK pulse is not issued. In this case, the ACK_ENABLE command is ignored by the target because it is not recognized as a valid command.

The BACKGROUND command will issue an ACK pulse when the CPU changes from normal to background mode. The ACK pulse related to this command could be aborted using the SYNC command.

The GO command will issue an ACK pulse when the CPU exits from background mode. The ACK pulse related to this command could be aborted using the SYNC command.

The GO_UNTIL command is equivalent to a GO command with exception that the ACK pulse, in this case, is issued when the CPU enters into background mode. This command is an alternative to the GO command and should be used when the host wants to trace if a breakpoint match occurs and causes the CPU to enter active background mode. Note that the ACK is issued whenever the CPU enters BDM, which could be caused by a breakpoint match or by a BGND instruction being executed. The ACK pulse related to this command could be aborted using the SYNC command.

The TRACE1 command has the related ACK pulse issued when the CPU enters background active mode after one instruction of the application program is executed. The ACK pulse related to this command could be aborted using the SYNC command.

The TAGGO command will not issue an ACK pulse because this would interfere with the tagging function shared on the same pin.

### 15.4.9 SYNC - Request Timed Reference Pulse

The SYNC command is unlike other BDM commands because the host does not necessarily know the correct communication speed to use for BDM communications until after it has analyzed the response to the SYNC command. To issue a SYNC command, the host should perform the following steps:

1. Drive the BKGD pin low for at least 128 cycles at the lowest possible BDM serial communication frequency (the lowest serial communication frequency is determined by the crystal oscillator or the clock chosen by CLKSW.)
2. Drive BKGD high for a brief speedup pulse to get a fast rise time (this speedup pulse is typically one cycle of the host clock.)
3. Remove all drive to the BKGD pin so it reverts to high impedance.
4. Listen to the BKGD pin for the sync response pulse.

Upon detecting the SYNC request from the host, the target performs the following steps:

1. Discards any incomplete command received or bit retrieved.
2. Waits for BKGD to return to a logic 1 .
3. Delays 16 cycles to allow the host to stop driving the high speedup pulse.
4. Drives BKGD low for 128 cycles at the current BDM serial communication frequency.
5. Drives a one-cycle high speedup pulse to force a fast rise time on BKGD.
6. Removes all drive to the BKGD pin so it reverts to high impedance.

The host measures the low time of this 128 cycle SYNC response pulse and determines the correct speed for subsequent BDM communications. Typically, the host can determine the correct communication speed within a few percent of the actual target speed and the communication protocol can easily tolerate speed errors of several percent.

As soon as the SYNC request is detected by the target, any partially received command or bit retrieved is discarded. This is referred to as a soft-reset, equivalent to a time-out in the serial communication. After the SYNC response, the target will consider the next falling edge (issued by the host) as the start of a new BDM command or the start of new SYNC request.

Another use of the SYNC command pulse is to abort a pending ACK pulse. The behavior is exactly the same as in a regular SYNC command. Note that one of the possible causes for a command to not be acknowledged by the target is a host-target synchronization problem. In this case, the command may not have been understood by the target and so an ACK response pulse will not be issued.

### 15.4.10 Instruction Tracing

When a TRACE1 command is issued to the BDM in active BDM, the CPU exits the standard BDM firmware and executes a single instruction in the user code. As soon as this has occurred, the CPU is forced to return to the standard BDM firmware and the BDM is active and ready to receive a new command. If the TRACE1 command is issued again, the next user instruction will be executed. This facilitates stepping or tracing through the user code one instruction at a time.

If an interrupt is pending when a TRACE1 command is issued, the interrupt stacking operation occurs but no user instruction is executed. Upon return to standard BDM firmware execution, the program counter points to the first instruction in the interrupt service routine.

### 15.4.11 Instruction Tagging

The instruction queue and cycle-by-cycle CPU activity are reconstructible in real time or from trace history that is captured by a logic analyzer. However, the reconstructed queue cannot be used to stop the CPU at a specific instruction. This is because execution already has begun by the time an operation is visible outside the system. A separate instruction tagging mechanism is provided for this purpose.

The tag follows program information as it advances through the instruction queue. When a tagged instruction reaches the head of the queue, the CPU enters active BDM rather than executing the instruction.

## NOTE

Tagging is disabled when BDM becomes active and BDM serial commands are not processed while tagging is active.
Executing the BDM TAGGO command configures two system pins for tagging. The $\overline{\text { TAGLO }}$ signal shares a pin with the $\overline{\text { LSTRB }}$ signal, and the $\overline{\text { TAGHI }}$ signal shares a pin with the BKGD signal.

Table 15-7 shows the functions of the two tagging pins. The pins operate independently, that is the state of one pin does not affect the function of the other. The presence of logic level 0 on either pin at the fall of the external clock (ECLK) performs the indicated function. High tagging is allowed in all modes. Low tagging is allowed only when low strobe is enabled (LSTRB is allowed only in wide expanded modes and emulation expanded narrow mode).

Table 15-7. Tag Pin Function

| TAGHI | TAGLO | Tag |
| :---: | :---: | :---: |
| 1 | 1 | No tag |
| 1 | 0 | Low byte |
| 0 | 1 | High byte |
| 0 | 0 | Both bytes |

### 15.4.12 Serial Communication Time-Out

The host initiates a host-to-target serial transmission by generating a falling edge on the BKGD pin. If BKGD is kept low for more than 128 target clock cycles, the target understands that a SYNC command was issued. In this case, the target will keep waiting for a rising edge on BKGD in order to answer the SYNC request pulse. If the rising edge is not detected, the target will keep waiting forever without any time-out limit.

Consider now the case where the host returns BKGD to logic one before 128 cycles. This is interpreted as a valid bit transmission, and not as a SYNC request. The target will keep waiting for another falling edge marking the start of a new bit. If, however, a new falling edge is not detected by the target within 512 clock cycles since the last falling edge, a time-out occurs and the current command is discarded without affecting memory or the operating mode of the MCU. This is referred to as a soft-reset.

If a read command is issued but the data is not retrieved within 512 serial clock cycles, a soft-reset will occur causing the command to be disregarded. The data is not available for retrieval after the time-out has occurred. This is the expected behavior if the handshake protocol is not enabled. However, consider the behavior where the BDC is running in a frequency much greater than the CPU frequency. In this case, the command could time out before the data is ready to be retrieved. In order to allow the data to be retrieved even with a large clock frequency mismatch (between BDC and CPU) when the hardware handshake protocol is enabled, the time out between a read command and the data retrieval is disabled. Therefore, the host could wait for more then 512 serial clock cycles and continue to be able to retrieve the data from an issued read command. However, as soon as the handshake pulse (ACK pulse) is issued, the time-out feature is re-activated, meaning that the target will time out after 512 clock cycles. Therefore, the host needs to retrieve the data within a 512 serial clock cycles time frame after the ACK pulse had been issued. After that period, the read command is discarded and the data is no longer available for retrieval. Any falling edge of the BKGD pin after the time-out period is considered to be a new command or a SYNC request.
Note that whenever a partially issued command, or partially retrieved data, has occurred the time out in the serial communication is active. This means that if a time frame higher than 512 serial clock cycles is observed between two consecutive negative edges and the command being issued or data being retrieved is not complete, a soft-reset will occur causing the partially received command or data retrieved to be disregarded. The next falling edge of the BKGD pin, after a soft-reset has occurred, is considered by the target as the start of a new BDM command, or the start of a SYNC request pulse.

### 15.4.13 Operation in Wait Mode

The BDM cannot be used in wait mode if the system disables the clocks to the BDM.
There is a clearing mechanism associated with the WAIT instruction when the clocks to the BDM (CPU core platform) are disabled. As the clocks restart from wait mode, the BDM receives a soft reset (clearing any command in progress) and the ACK function will be disabled. This is a change from previous BDM modules.

### 15.4.14 Operation in Stop Mode

The BDM is completely shutdown in stop mode.
There is a clearing mechanism associated with the STOP instruction. STOP must be enabled and the part must go into stop mode for this to occur. As the clocks restart from stop mode, the BDM receives a soft reset (clearing any command in progress) and the ACK function will be disabled. This is a change from previous BDM modules.

## Chapter 16 Debug Module (DBGV1)

### 16.1 Introduction

This section describes the functionality of the debug (DBG) sub-block of the HCS12 core platform.
The DBG module is designed to be fully compatible with the existing BKP_HCS12_A module (BKP mode) and furthermore provides an on-chip trace buffer with flexible triggering capability (DBG mode). The DBG module provides for non-intrusive debug of application software. The DBG module is optimized for the HCS12 16-bit architecture.

### 16.1.1 Features

The DBG module in BKP mode includes these distinctive features:

- Full or dual breakpoint mode
- Compare on address and data (full)
- Compare on either of two addresses (dual)
- BDM or SWI breakpoint
- Enter BDM on breakpoint (BDM)
- Execute SWI on breakpoint (SWI)
- Tagged or forced breakpoint
- Break just before a specific instruction will begin execution (TAG)
- Break on the first instruction boundary after a match occurs (Force)
- Single, range, or page address compares
- Compare on address (single)
- Compare on address 256 byte (range)
- Compare on any 16 K page (page)
- At forced breakpoints compare address on read or write
- High and/or low byte data compares
- Comparator C can provide an additional tag or force breakpoint (enhancement for BKP mode)

The DBG in DBG mode includes these distinctive features:

- Three comparators (A, B, and C)
- Dual mode, comparators A and B used to compare addresses
- Full mode, comparator A compares address and comparator B compares data
- Can be used as trigger and/or breakpoint
- Comparator C used in LOOP1 capture mode or as additional breakpoint
- Four capture modes
- Normal mode, change-of-flow information is captured based on trigger specification
- Loop1 mode, comparator C is dynamically updated to prevent redundant change-of-flow storage.
- Detail mode, address and data for all cycles except program fetch ( P ) and free (f) cycles are stored in trace buffer
- Profile mode, last instruction address executed by CPU is returned when trace buffer address is read
- Two types of breakpoint or debug triggers
- Break just before a specific instruction will begin execution (tag)
- Break on the first instruction boundary after a match occurs (force)
- BDM or SWI breakpoint
- Enter BDM on breakpoint (BDM)
- Execute SWI on breakpoint (SWI)
- Nine trigger modes for comparators A and B
- A
- A or B
- A then B
- A and B, where B is data (full mode)
- A and not B, where B is data (full mode)
- Event only B, store data
- A then event only B, store data
- Inside range, $\mathrm{A} \leq$ address $\leq \mathrm{B}$
- Outside range, address $<\mathrm{A}$ or address $>\mathrm{B}$
- Comparator C provides an additional tag or force breakpoint when capture mode is not configured in LOOP1 mode.
- Sixty-four word (16 bits wide) trace buffer for storing change-of-flow information, event only data and other bus information.
- Source address of taken conditional branches (long, short, bit-conditional, and loop constructs)
- Destination address of indexed JMP, JSR, and CALL instruction.
- Destination address of RTI, RTS, and RTC instructions
- Vector address of interrupts, except for SWI and BDM vectors
- Data associated with event B trigger modes
- Detail report mode stores address and data for all cycles except program (P) and free (f) cycles
- Current instruction address when in profiling mode
- BGND is not considered a change-of-flow (cof) by the debugger


### 16.1.2 Modes of Operation

There are two main modes of operation: breakpoint mode and debug mode. Each one is mutually exclusive of the other and selected via a software programmable control bit.

In the breakpoint mode there are two sub-modes of operation:

- Dual address mode, where a match on either of two addresses will cause the system to enter background debug mode (BDM) or initiate a software interrupt (SWI).
- Full breakpoint mode, where a match on address and data will cause the system to enter background debug mode (BDM) or initiate a software interrupt (SWI).

In debug mode, there are several sub-modes of operation.

- Trigger modes

There are many ways to create a logical trigger. The trigger can be used to capture bus information either starting from the trigger or ending at the trigger. Types of triggers ( A and B are registers):

- A only
- A or B
- A then B
- Event only B (data capture)
- A then event only B (data capture)
- A and B, full mode
- A and not B, full mode
- Inside range
- Outside range
- Capture modes

There are several capture modes. These determine which bus information is saved and which is ignored.

- Normal: save change-of-flow program fetches
- Loop1: save change-of-flow program fetches, ignoring duplicates
- Detail: save all bus operations except program and free cycles
- Profile: poll target from external device


### 16.1.3 Block Diagram

Figure 16-1 is a block diagram of this module in breakpoint mode. Figure 16-2 is a block diagram of this module in debug mode.

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Figure 16-1. DBG Block Diagram in BKP Mode


Figure 16-2. DBG Block Diagram in DBG Mode

### 16.2 External Signal Description

The DBG sub-module relies on the external bus interface (generally the MEBI) when the DBG is matching on the external bus.

The tag pins in Table 16-1 (part of the MEBI) may also be a part of the breakpoint operation.

Table 16-1. External System Pins Associated with DBG and MEBI

| Pin Name | Pin Functions | Description |
| :---: | :---: | :--- |
| BKGD/MODC/ <br> $\overline{T A G H I}$ | $\overline{T A G H I}$ | When instruction tagging is on, a 0 at the falling edge of $E$ tags the high half of the <br> instruction word being read into the instruction queue. |
| PE3/ $\overline{\text { LSTRB/ TAGLO }}$ | $\overline{\text { TAGLO }}$ | In expanded wide mode or emulation narrow modes, when instruction tagging is on <br> and low strobe is enabled, a 0 at the falling edge of $E$ tags the low half of the <br> instruction word being read into the instruction queue. |

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### 16.3 Memory Map and Register Definition

A summary of the registers associated with the DBG sub-block is shown in Figure 16-3. Detailed descriptions of the registers and bits are given in the subsections that follow.

### 16.3.1 Module Memory Map

Table 16-2. DBGV1 Memory Map

| Address <br> Offset | Use | Access |
| :---: | :--- | :---: |
|  | Debug Control Register (DBGC1) | R/W |
|  | Debug Status and Control Register (DBGSC) | R/W |
|  | Debug Trace Buffer Register High (DBGTBH) | R |
|  | Debug Trace Buffer Register Low (DBGTBL) | R |
| 4 | Debug Count Register (DBGCNT) | R |
| 5 | Debug Comparator C Extended Register (DBGCCX) | R/W |
| 6 | Debug Comparator C Register High (DBGCCH) | R/W |
| 8 | Debug Comparator C Register Low (DBGCCL) | R/W |
| 9 | Debug Control Register 2 (DBGC2) / (BKPCT0) | R/W |
| A | Debug Comparator A Extended Register (DBGCAX) / (BKP0X) | R/W |
| B | Debug Comparator A Register High (DBGCAH) / (BKP0H) | R/W |
|  | Debug Comparator A Register Low (DBGCAL) / (BKPOL) | R/W |
| E | Debug Comparator B Extended Register (DBGCBX) / (BKP1X) | R/W |
| F | Debug Comparator B Register High (DBGCBH) / (BKP1H) | R/W |
|  | Rebug Comparator B Register Low (DBGCBL) / (BKP1L) | R/W |

### 16.3.2 Register Descriptions

This section consists of the DBG register descriptions in address order. Most of the register bits can be written to in either BKP or DBG mode, although they may not have any effect in one of the modes. However, the only bits in the DBG module that can be written while the debugger is armed ( $\mathrm{ARM}=1$ ) are DBGEN and ARM


Figure 16-3. DBG Register Summary


Figure 16-3. DBG Register Summary (continued)
1 The DBG module is designed for backwards compatibility to existing BKP modules. Register and bit names have changed from the BKP module. This column shows the DBG register name, as well as the BKP register name for reference.
2 Comparator C can be used to enhance the BKP mode by providing a third breakpoint.

### 16.3.2.1 Debug Control Register 1 (DBGC1)

## NOTE

All bits are used in DBG mode only.


Figure 16-4. Debug Control Register (DBGC1)
NOTE
This register cannot be written if BKP mode is enabled (BKABEN in DBGC2 is set).

Table 16-3. DBGC1 Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { DBGEN } \end{gathered}$ | DBG Mode Enable Bit - The DBGEN bit enables the DBG module for use in DBG mode. This bit cannot be set if the MCU is in secure mode. <br> 0 DBG mode disabled <br> 1 DBG mode enabled |
| $\begin{gathered} 6 \\ \text { ARM } \end{gathered}$ | Arm Bit - The ARM bit controls whether the debugger is comparing and storing data in the trace buffer. See Section 16.4.2.4, "Arming the DBG Module," for more information. <br> 0 Debugger unarmed <br> 1 Debugger armed <br> Note: This bit cannot be set if the DBGEN bit is not also being set at the same time. For example, a write of 01 to DBGEN[7:6] will be interpreted as a write of 00. |
| $\begin{gathered} 5 \\ \text { TRGSEL } \end{gathered}$ | Trigger Selection Bit - The TRGSEL bit controls the triggering condition for comparators A and B in DBG mode. It serves essentially the same function as the TAGAB bit in the DBGC2 register does in BKP mode. See Section 16.4.2.1.2, "Trigger Selection," for more information. TRGSEL may also determine the type of breakpoint based on comparator $A$ and $B$ if enabled in DBG mode (DBGBRK = 1). Please refer to Section 16.4.3.1, <br> "Breakpoint Based on Comparator A and B." <br> 0 Trigger on any compare address match <br> 1 Trigger before opcode at compare address gets executed (tagged-type) |
| $\begin{gathered} 4 \\ \text { BEGIN } \end{gathered}$ | Begin/End Trigger Bit - The BEGIN bit controls whether the trigger begins or ends storing of data in the trace buffer. See Section 16.4.2.8.1, "Storing with Begin-Trigger," and Section 16.4.2.8.2, "Storing with End-Trigger," for more details. <br> 0 Trigger at end of stored data <br> 1 Trigger before storing data |

Table 16-3. DBGC1 Field Descriptions (continued)

| Field | Description |
| :---: | :--- |
| 3 | DBG Breakpoint Enable Bit - The DBGBRK bit controls whether the debugger will request a breakpoint based <br> on comparator A and B to the CPU upon completion of a tracing session. Please refer to Section 16.4.3, <br> "Breakpoints," for further details. <br> 0 CPU break request not enabled <br> 1 <br> CPU break request enabled |
| $1: 0$ | Capture Mode Field - See Table 16-4 for capture mode field definitions. In LOOP1 mode, the debugger will <br> automatically inhibit redundant entries into capture memory. In detail mode, the debugger is storing address and <br> data for all cycles except program fetch (P) and free (f) cycles. In profile mode, the debugger is returning the <br> address of the last instruction executed by the CPU on each access of trace buffer address. Refer to <br> Section 16.4.2.6, "Capture Modes," for more information. |

Table 16-4. CAPMOD Encoding

| CAPMOD | Description |
| :---: | :---: |
| 00 | Normal |
| 01 | LOOP1 |
| 10 | DETAIL |
| 11 | PROFILE |

### 16.3.2.2 Debug Status and Control Register (DBGSC)



Figure 16-5. Debug Status and Control Register (DBGSC)
Table 16-5. DBGSC Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { AF } \end{gathered}$ | Trigger A Match Flag - The AF bit indicates if trigger A match condition was met since arming. This bit is cleared when ARM in DBGC1 is written to a 1 or on any write to this register. <br> 0 Trigger A did not match <br> 1 Trigger A match |
| $\begin{gathered} 6 \\ B F \end{gathered}$ | Trigger B Match Flag - The BF bit indicates if trigger B match condition was met since arming. This bit is cleared when ARM in DBGC1 is written to a 1 or on any write to this register. <br> 0 Trigger B did not match <br> 1 Trigger B match |
| $\begin{gathered} 5 \\ C F \end{gathered}$ | Comparator C Match Flag - The CF bit indicates if comparator C match condition was met since arming.This bit is cleared when ARM in DBGC1 is written to a 1 or on any write to this register. <br> 0 Comparator C did not match <br> 1 Comparator C match |
| $\begin{gathered} \hline \text { 3:0 } \\ \text { TRG } \end{gathered}$ | Trigger Mode Bits - The TRG bits select the trigger mode of the DBG module as shown Table 16-6. See Section 16.4.2.5, "Trigger Modes," for more detail. |

Table 16-6. Trigger Mode Encoding

| TRG Value | Meaning |
| :---: | :---: |
| 0000 | A only |
| 0001 | A or B |
| 0010 | A then B |
| 0011 | Event only B |
| 0100 | A then event only B |
| 0101 | A and B (full mode) |
| 0110 | A and Not B (full mode) |
| 0111 | Inside range |
| 1000 | Outside range |
| 1001 | Reserved |
| $\downarrow$ | (Defaults to A only) |
| 111 |  |

### 16.3.2.3 Debug Trace Buffer Register (DBGTB)



Figure 16-6. Debug Trace Buffer Register High (DBGTBH)


Figure 16-7. Debug Trace Buffer Register Low (DBGTBL)
Table 16-7. DBGTB Field Descriptions

| Field | Description |
| :---: | :--- |
| $15: 0$ | Trace Buffer Data Bits - The trace buffer data bits contain the data of the trace buffer. This register can be read <br> only as a word read. Any byte reads or misaligned access of these registers will return 0 and will not cause the <br> trace buffer pointer to increment to the next trace buffer address. The same is true for word reads while the <br> debugger is armed. In addition, this register may appear to contain incorrect data if it is not read with the same <br> capture mode bit settings as when the trace buffer data was recorded (See Section 16.4.2.9, "Reading Data from <br> Trace Buffer"). Because reads will reflect the contents of the trace buffer RAM, the reset state is undefined. |

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### 16.3.2.4 Debug Count Register (DBGCNT)



Figure 16-8. Debug Count Register (DBGCNT)
Table 16-8. DBGCNT Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| TBF | Trace Buffer Full - The TBF bit indicates that the trace buffer has stored 64 or more words of data since it was <br> last armed. If this bit is set, then all 64 words will be valid data, regardless of the value in CNT[5:0]. The TBF bit <br> is cleared when ARM in DBGC1 is written to a 1. |
| $5: 0$ | Count Value - The CNT bits indicate the number of valid data words stored in the trace buffer. Table 16-9 shows <br> the correlation between the CNT bits and the number of valid data words in the trace buffer. When the CNT rolls <br> over to 0, the TBF bit will be set and incrementing of CNT will continue if DBG is in end-trigger mode. The <br> DBGCNT register is cleared when ARM in DBGC1 is written to a 1. |

Table 16-9. CNT Decoding Table

| TBF | CNT | Description |
| :---: | :---: | :---: |
| 0 | 000000 | No data valid |
| 0 | 000001 | 1 word valid |
| 0 | $\begin{gathered} 000010 \\ . . \\ . . \\ 111110 \end{gathered}$ | 2 words valid <br> 62 words valid |
| 0 | 111111 | 63 words valid |
| 1 | 000000 | 64 words valid; if BEGIN = 1, the ARM bit will be cleared. A breakpoint will be generated if DBGBRK = 1 |
| 1 | $\begin{gathered} 000001 \\ . . \\ . . \\ 111111 \end{gathered}$ | 64 words valid, oldest data has been overwritten by most recent data |

### 16.3.2.5 Debug Comparator C Extended Register (DBGCCX)



Figure 16-9. Debug Comparator C Extended Register (DBGCCX)
Table 16-10. DBGCCX Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 6$ |  |
| PAGSEL | Page Selector Field — In both BKP and DBG mode, PAGSEL selects the type of paging as shown in <br> Table 16-11. <br> DPAGE and EPAGE are not yet implemented so the value in bit 7 will be ignored (i.e., PAGSEL values of 10 and <br> 11 will be interpreted as values of 00 and 01, respectively). |
| $5: 0$ | Comparator C Extended Compare Bits - The EXTCMP bits are used as comparison address bits as shown <br> in Table 16-11 along with the appropriate PPAGE, DPAGE, or EPAGE signal from the core. <br> Note: Comparator C can be used when the DBG module is configured for BKP mode. Extended addressing <br> comparisons for comparator C use PAGSEL and will operate differently to the way that comparator A and <br> B operate in BKP mode. |

Table 16-11. PAGSEL Decoding ${ }^{1}$

| PAGSEL | Description | EXTCMP | Comment |
| :---: | :---: | :---: | :---: |
| 00 | Normal (64k) | Not used | No paged memory |
| 01 | $\begin{gathered} \text { PPAGE } \\ (256-16 K \text { pages }) \end{gathered}$ | EXTCMP[5:0] is compared to address bits $[21: 16]^{2}$ | PPAGE[7:0] / XAB[21:14] becomes address bits [21:14] ${ }^{1}$ |
| $10^{3}$ | DPAGE (reserved) (256 - 4K pages) | EXTCMP[3:0] is compared to address bits [19:16] | DPAGE / XAB[21:14] becomes address bits [19:12] |
| $11^{2}$ | EPAGE (reserved) <br> (256 - 1K pages) | EXTCMP[1:0] is compared to address bits [17:16] | EPAGE / XAB[21:14] becomes address bits [17:10] |

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NOTES:

1. In BKP and DBG mode, PAGSEL selects the type of paging as shown in Table 16-11.
2. Current HCS12 implementations are limited to six PPAGE bits, PIX[5:0]. Therefore, EXTCMP[5:4] $=00$.

Figure 16-10. Comparator C Extended Comparison in BKP/DBG Mode

### 16.3.2.6 Debug Comparator C Register (DBGCC)

|  | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | Bit 15 | Bit 14 | Bit 13 | Bit 12 | Bit 11 | Bit 10 | Bit 9 | Bit 8 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 16-11. Debug Comparator C Register High (DBGCCH)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 16-12. Debug Comparator C Register Low (DBGCCL)
Table 16-12. DBGCC Field Descriptions

| Field | Description |
| :---: | :--- |
| $15: 0$ | Comparator C Compare Bits - The comparator C compare bits control whether comparator C will compare <br> the address bus bits [15:0] to a logic 1 or logic 0. See Table 16-13. <br> 0 Compare corresponding address bit to a logic 0 <br> 1 Compare corresponding address bit to a logic 1 <br> Note: This register will be cleared automatically when the DBG module is armed in LOOP1 mode. |

Table 16-13. Comparator C Compares

| PAGSEL | EXTCMP Compare | High-Byte Compare |
| :---: | :---: | :---: |
| $\mathbf{x 0}$ | No compare | DBGCCH[7:0] $=\mathrm{AB}[15: 8]$ |
| $\mathbf{x 1}$ | EXTCMP[5:0] = XAB[21:16] | $\mathrm{DBGCCH}[7: 0]=\mathrm{XAB}[15: 14], \mathrm{AB}[13: 8]$ |

### 16.3.2.7 Debug Control Register 2 (DBGC2)



1 When BKABEN is set (BKP mode), all bits in DBGC2 are available. When BKABEN is cleared and DBG is used in DBG mode, bits FULL and TAGAB have no meaning.
2 These bits can be used in BKP mode and DBG mode (when capture mode is not set in LOOP1) to provide a third breakpoint.
Figure 16-13. Debug Control Register 2 (DBGC2)
Table 16-14. DBGC2 Field Descriptions

| Field | Description |
| :---: | :---: |
| $7$ <br> BKABEN | Breakpoint Using Comparator A and B Enable - This bit enables the breakpoint capability using comparator $A$ and $B$, when set (BKP mode) the DBGEN bit in DBGC1 cannot be set. <br> 0 Breakpoint module off <br> 1 Breakpoint module on |
| $\begin{gathered} 6 \\ \text { FULL } \end{gathered}$ | Full Breakpoint Mode Enable - This bit controls whether the breakpoint module is in dual mode or full mode. In full mode, comparator $A$ is used to match address and comparator $B$ is used to match data. See Section 16.4.1.2, "Full Breakpoint Mode," for more details. <br> 0 Dual address mode enabled <br> 1 Full breakpoint mode enabled |
| $\begin{gathered} 5 \\ \text { BDM } \end{gathered}$ | Background Debug Mode Enable - This bit determines if the breakpoint causes the system to enter background debug mode (BDM) or initiate a software interrupt (SWI). <br> 0 Go to software interrupt on a break request <br> 1 Go to BDM on a break request |
| $\begin{gathered} 4 \\ \text { TAGAB } \end{gathered}$ | Comparator A/B Tag Select - This bit controls whether the breakpoint will cause a break on the next instruction boundary (force) or on a match that will be an executable opcode (tagged). Non-executed opcodes cannot cause a tagged breakpoint. <br> 0 On match, break at the next instruction boundary (force) <br> 1 On match, break if/when the instruction is about to be executed (tagged) |
| $3$ <br> BKCEN | Breakpoint Comparator C Enable Bit — This bit enables the breakpoint capability using comparator C. <br> 0 Comparator C disabled for breakpoint <br> 1 Comparator C enabled for breakpoint <br> Note: This bit will be cleared automatically when the DBG module is armed in loop1 mode. |
| $\stackrel{2}{\text { TAGC }}$ | Comparator C Tag Select - This bit controls whether the breakpoint will cause a break on the next instruction boundary (force) or on a match that will be an executable opcode (tagged). Non-executed opcodes cannot cause a tagged breakpoint. <br> 0 On match, break at the next instruction boundary (force) <br> 1 On match, break if/when the instruction is about to be executed (tagged) |

Table 16-14. DBGC2 Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 1 \\ \text { RWCEN } \end{gathered}$ | Read/Write Comparator C Enable Bit — The RWCEN bit controls whether read or write comparison is enabled for comparator C. RWCEN is not useful for tagged breakpoints. <br> 0 Read/Write is not used in comparison <br> 1 Read/Write is used in comparison |
| $\begin{gathered} 0 \\ \text { RWC } \end{gathered}$ | Read/Write Comparator C Value Bit - The RWC bit controls whether read or write is used in compare for comparator C . The RWC bit is not used if RWCEN $=0$. <br> 0 Write cycle will be matched <br> 1 Read cycle will be matched |

### 16.3.2.8 Debug Control Register 3 (DBGC3)



1 In DBG mode, BKAMBH:BKAMBL has no meaning and are forced to 0's.
2 In DBG mode, BKBMBH:BKBMBL are used in full mode to qualify data.
Figure 16-14. Debug Control Register 3 (DBGC3)
Table 16-15. DBGC3 Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| $7: 6$ |  |
| BKAMB[H:L] | Breakpoint Mask High Byte for First Address - In dual or full mode, these bits may be used to mask (disable) <br> the comparison of the high and/or low bytes of the first address breakpoint. The functionality is as given in <br> Table 16-16. <br> The x:0 case is for a full address compare. When a program page is selected, the full address compare will be <br> based on bits for a 20-bit compare. The registers used for the compare are \{DBGCAX[5:0], DBGCAH[5:0], <br> DBGCAL[7:0]\}, where DBGAX[5:0] corresponds to PPAGE[5:0] or extended address bits [19:14] and CPU <br> address [13:0]. When a program page is not selected, the full address compare will be based on bits for a 16-bit <br> compare. The registers used for the compare are \{DBGCAH[7:0], DBGCAL[7:0]\} which corresponds to CPU <br> address [15:0]. <br> Note: This extended address compare scheme causes an aliasing problem in BKP mode in which several <br> physical addresses may match with a single logical address. This problem may be avoided by using DBG <br> mode to generate breakpoints. |
| The 1:0 case is not sensible because it would ignore the high order address and compare the low order and <br> expansion addresses. Logic forces this case to compare all address lines (effectively ignoring the BKAMBH <br> control bit). <br> The 1:1 case is useful for triggering a breakpoint on any access to a particular expansion page. This only makes <br> sense if a program page is being accessed so that the breakpoint trigger will occur only if DBGCAX compares. |  |

Table 16-15. DBGC3 Field Descriptions (continued)

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 5: 4 \\ \text { BKBMB[H:L] } \end{gathered}$ | Breakpoint Mask High Byte and Low Byte of Data (Second Address) - In dual mode, these bits may be used to mask (disable) the comparison of the high and/or low bytes of the second address breakpoint. The functionality is as given in Table 16-17. <br> The $\mathrm{x}: 0$ case is for a full address compare. When a program page is selected, the full address compare will be based on bits for a 20-bit compare. The registers used for the compare are \{DBGCBX[5:0], DBGCBH[5:0], DBGCBL[7:0]\} where DBGCBX[5:0] corresponds to PPAGE[5:0] or extended address bits [19:14] and CPU address [13:0]. When a program page is not selected, the full address compare will be based on bits for a 16-bit compare. The registers used for the compare are \{DBGCBH[7:0], DBGCBL[7:0]\} which corresponds to CPU address [15:0]. <br> Note: This extended address compare scheme causes an aliasing problem in BKP mode in which several physical addresses may match with a single logical address. This problem may be avoided by using DBG mode to generate breakpoints. <br> The 1:0 case is not sensible because it would ignore the high order address and compare the low order and expansion addresses. Logic forces this case to compare all address lines (effectively ignoring the BKBMBH control bit). <br> The 1:1 case is useful for triggering a breakpoint on any access to a particular expansion page. This only makes sense if a program page is being accessed so that the breakpoint trigger will occur only if DBGCBX compares. In full mode, these bits may be used to mask (disable) the comparison of the high and/or low bytes of the data breakpoint. The functionality is as given in Table 16-18. |
| $\begin{gathered} 3 \\ \text { RWAEN } \end{gathered}$ | Read/Write Comparator A Enable Bit - The RWAEN bit controls whether read or write comparison is enabled for comparator A. See Section 16.4.2.1.1, "Read or Write Comparison," for more information. This bit is not useful for tagged operations. <br> 0 Read/Write is not used in comparison <br> 1 Read/Write is used in comparison |
| $\begin{gathered} 2 \\ \text { RWA } \end{gathered}$ | Read/Write Comparator A Value Bit - The RWA bit controls whether read or write is used in compare for comparator A. The RWA bit is not used if RWAEN $=0$. <br> 0 Write cycle will be matched <br> 1 Read cycle will be matched |
| $\begin{gathered} 1 \\ \text { RWBEN } \end{gathered}$ | Read/Write Comparator B Enable Bit - The RWBEN bit controls whether read or write comparison is enabled for comparator B. See Section 16.4.2.1.1, "Read or Write Comparison," for more information. This bit is not useful for tagged operations. <br> 0 Read/Write is not used in comparison <br> 1 Read/Write is used in comparison |
| $\begin{gathered} 0 \\ \text { RWB } \end{gathered}$ | Read/Write Comparator B Value Bit - The RWB bit controls whether read or write is used in compare for comparator B . The RWB bit is not used if RWBEN $=0$. <br> 0 Write cycle will be matched <br> 1 Read cycle will be matched <br> Note: RWB and RWBEN are not used in full mode. |

Table 16-16. Breakpoint Mask Bits for First Address

| BKAMBH:BKAMBL | Address Compare | DBGCAX | DBGCAH | DBGCAL |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{x}: 0$ | Full address compare | Yes $^{1}$ | Yes | Yes |
| $0: 1$ | 256 byte address range | Yes $^{1}$ | Yes | No |
| $1: 1$ | 16 K byte address range | Yes $^{1}$ | No | No |

1 If PPAGE is selected.

Table 16-17. Breakpoint Mask Bits for Second Address (Dual Mode)

| BKBMBH:BKBMBL | Address Compare | DBGCBX | DBGCBH | DBGCBL |
| :---: | :---: | :---: | :---: | :---: |
| $\mathrm{x}: 0$ | Full address compare | Yes $^{1}$ | Yes | Yes |
| $0: 1$ | 256 byte address range | Yes $^{1}$ | Yes | No |
| $1: 1$ | 16 K byte address range | Yes $^{1}$ | No | No |

1 If PPAGE is selected.

Table 16-18. Breakpoint Mask Bits for Data Breakpoints (Full Mode)

| BKBMBH:BKBMBL | Data Compare | DBGCBX | DBGCBH | DBGCBL |
| :---: | :---: | :---: | :---: | :---: |
| $0: 0$ | High and low byte compare | No $^{1}$ | Yes | Yes |
| $0: 1$ | High byte | No $^{1}$ | Yes | No |
| $1: 0$ | Low byte | No $^{1}$ | No | Yes |
| $1: 1$ | No compare | No $^{1}$ | No | No |

1 Expansion addresses for breakpoint B are not applicable in this mode.

### 16.3.2.9 Debug Comparator A Extended Register (DBGCAX)



Figure 16-15. Debug Comparator A Extended Register (DBGCAX)
Table 16-19. DBGCAX Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 6$ |  |
| PAGSEL | Page Selector Field - If DBGEN is set in DBGC1, then PAGSEL selects the type of paging as shown in <br> Table 16-20. <br> DPAGE and EPAGE are not yet implemented so the value in bit 7 will be ignored (i.e., PAGSEL values of 10 and <br> 11 will be interpreted as values of 00 and 01, respectively). <br> In BKP mode, PAGSEL has no meaning and EXTCMP[5:0] are compared to address bits [19:14] if the address <br> is in the FLASH/ROM memory space. |
| 5:0 | Comparator A Extended Compare Bits - The EXTCMP bits are used as comparison address bits as shown <br> in Table 16-20 along with the appropriate PPAGE, DPAGE, or EPAGE signal from the core. |

Table 16-20. Comparator A or B Compares

| Mode |  | EXTCMP Compare | High-Byte Compare |
| :---: | :---: | :---: | :---: |
| BKP $^{1}$ | Not FLASH/ROM access | No compare | DBGCxH[7:0] = AB[15:8] |
|  | FLASH/ROM access | EXTCMP[5:0] = XAB[19:14] | DBGCxH[5:0] = AB[13:8] |
| DBG $^{2}$ | PAGSEL $=00$ | No compare | DBGCxH[7:0] = AB[15:8] |
|  | PAGSEL $=01$ | EXTCMP[5:0] $=$ XAB[21:16] | DBGCxH[7:0] = XAB[15:14], AB[13:8] |

[^9]

NOTES:

1. In BKP mode, PAGSEL has no functionality. Therefore, set PAGSEL to 00 (reset state).
2. Current HCS12 implementations are limited to six PPAGE bits, PIX[5:0].

Figure 16-16. Comparators A and B Extended Comparison in BKP Mode

## Chapter 16 Debug Module (DBGV1)

### 16.3.2.10 Debug Comparator A Register (DBGCA)



Figure 16-17. Debug Comparator A Register High (DBGCAH)


Figure 16-18. Debug Comparator A Register Low (DBGCAL)
Table 16-21. DBGCA Field Descriptions

| Field | Description |
| :---: | :--- |
| $15: 0$ | Comparator A Compare Bits - The comparator A compare bits control whether comparator A compares the |
| $15: 0$ | address bus bits [15:0] to a logic 1 or logic 0. See Table 16-20. <br> 0 <br> Compare corresponding address bit to a logic 0 <br> 1 <br> Compare corresponding address bit to a logic 1 |

### 16.3.2.11 Debug Comparator B Extended Register (DBGCBX)



Figure 16-19. Debug Comparator B Extended Register (DBGCBX)
Table 16-22. DBGCBX Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:6 | Page Selector Field — If DBGEN is set in DBGC1, then PAGSEL selects the type of paging as shown in <br> Table 16-11. <br> DPAGE and EPAGE are not yet implemented so the value in bit 7 will be ignored (i.e., PAGSEL values of 10 and <br> 11 will be interpreted as values of 00 and 01, respectively.) <br> In BKP mode, PAGSEL has no meaning and EXTCMP[5:0] are compared to address bits [19:14] if the address <br> is in the FLASH/ROM memory space. |
| $5: 0$ | Comparator B Extended Compare Bits - The EXTCMP bits are used as comparison address bits as shown <br> in Table 16-11 along with the appropriate PPAGE, DPAGE, or EPAGE signal from the core. Also see Table 16-20. |

### 16.3.2.12 Debug Comparator B Register (DBGCB)



Figure 16-20. Debug Comparator B Register High (DBGCBH)


Figure 16-21. Debug Comparator B Register Low (DBGCBL)
Table 16-23. DBGCB Field Descriptions

| Field | Description |
| :---: | :--- |
| $15: 0$ | Comparator B Compare Bits - The comparator B compare bits control whether comparator B compares the |
| $15: 0$ | address bus bits [15:0] or data bus bits [15:0] to a logic 1 or logic 0. See Table 16-20. |
|  | 0 Compare corresponding address bit to a logic 0, compares to data if in Full mode |
| 1 | Compare corresponding address bit to a logic 1, compares to data if in Full mode |

### 16.4 Functional Description

This section provides a complete functional description of the DBG module. The DBG module can be configured to run in either of two modes, BKP or DBG. BKP mode is enabled by setting BKABEN in DBGC2. DBG mode is enabled by setting DBGEN in DBGC1. Setting BKABEN in DBGC2 overrides the DBGEN in DBGC1 and prevents DBG mode. If the part is in secure mode, DBG mode cannot be enabled.

### 16.4.1 DBG Operating in BKP Mode

In BKP mode, the DBG will be fully backwards compatible with the existing BKP_ST12_A module. The DBGC2 register has four additional bits that were not available on existing BKP_ST12_A modules. As long as these bits are written to either all 1 s or all 0 s , they should be transparent to the user. All 1 s would enable comparator $C$ to be used as a breakpoint, but tagging would be enabled. The match address register would be all 0 s if not modified by the user. Therefore, code executing at address $0 x 0000$ would have to occur before a breakpoint based on comparator C would happen.

The DBG module in BKP mode supports two modes of operation: dual address mode and full breakpoint mode. Within each of these modes, forced or tagged breakpoint types can be used. Forced breakpoints occur at the next instruction boundary if a match occurs and tagged breakpoints allow for breaking just before the tagged instruction executes. The action taken upon a successful match can be to either place the CPU in background debug mode or to initiate a software interrupt.

The breakpoint can operate in dual address mode or full breakpoint mode. Each of these modes is discussed in the subsections below.

### 16.4.1.1 Dual Address Mode

When dual address mode is enabled, two address breakpoints can be set. Each breakpoint can cause the system to enter background debug mode or to initiate a software interrupt based upon the state of BDM in DBGC2 being logic 1 or logic 0 , respectively. BDM requests have a higher priority than SWI requests. No data breakpoints are allowed in this mode.

TAGAB in DBGC2 selects whether the breakpoint mode is forced or tagged. The $\mathrm{BKxMBH}: \mathrm{L}$ bits in DBGC3 select whether or not the breakpoint is matched exactly or is a range breakpoint. They also select whether the address is matched on the high byte, low byte, both bytes, and/or memory expansion. The RWx and RWxEN bits in DBGC3 select whether the type of bus cycle to match is a read, write, or read/write when performing forced breakpoints.

### 16.4.1.2 Full Breakpoint Mode

Full breakpoint mode requires a match on address and data for a breakpoint to occur. Upon a successful match, the system will enter background debug mode or initiate a software interrupt based upon the state of BDM in DBGC2 being logic 1 or logic 0 , respectively. BDM requests have a higher priority than SWI requests. R/W matches are also allowed in this mode.

TAGAB in DBGC2 selects whether the breakpoint mode is forced or tagged. When TAGAB is set in DBGC2, only addresses are compared and data is ignored. The BKAMBH:L bits in DBGC3 select whether or not the breakpoint is matched exactly, is a range breakpoint, or is in page space. The BKBMBH:L bits in DBGC3 select whether the data is matched on the high byte, low byte, or both bytes. RWA and RWAEN bits in DBGC2 select whether the type of bus cycle to match is a read or a write when performing forced breakpoints. RWB and RWBEN bits in DBGC2 are not used in full breakpoint mode.


#### Abstract

NOTE The full trigger mode is designed to be used for either a word access or a byte access, but not both at the same time. Confusing trigger operation (seemingly false triggers or no trigger) can occur if the trigger address occurs in the user program as both byte and word accesses.


### 16.4.1.3 Breakpoint Priority

Breakpoint operation is first determined by the state of the BDM module. If the BDM module is already active, meaning the CPU is executing out of BDM firmware, breakpoints are not allowed. In addition, while executing a BDM TRACE command, tagging into BDM is not allowed. If BDM is not active, the breakpoint will give priority to BDM requests over SWI requests. This condition applies to both forced and tagged breakpoints.

In all cases, BDM related breakpoints will have priority over those generated by the Breakpoint sub-block. This priority includes breakpoints enabled by the TAGLO and TAGHI external pins of the system that interface with the BDM directly and whose signal information passes through and is used by the breakpoint sub-block.

## NOTE

BDM should not be entered from a breakpoint unless the ENABLE bit is set in the BDM. Even if the ENABLE bit in the BDM is cleared, the CPU actually executes the BDM firmware code. It checks the ENABLE and returns if ENABLE is not set. If the BDM is not serviced by the monitor then the breakpoint would be re-asserted when the BDM returns to normal CPU flow.

There is no hardware to enforce restriction of breakpoint operation if the BDM is not enabled.

When program control returns from a tagged breakpoint through an RTI or a BDM GO command, it will return to the instruction whose tag generated the breakpoint. Unless breakpoints are disabled or modified in the service routine or active BDM session, the instruction will be tagged again and the breakpoint will be repeated. In the case of BDM breakpoints, this situation can also be avoided by executing a TRACE1 command before the GO to increment the program flow past the tagged instruction.

### 16.4.1.4 Using Comparator C in BKP Mode

The original BKP_ST12_A module supports two breakpoints. The DBG_ST12_A module can be used in BKP mode and allow a third breakpoint using comparator C. Four additional bits, BKCEN, TAGC, RWCEN, and RWC in DBGC2 in conjunction with additional comparator C address registers, DBGCCX, DBGCCH, and DBGCCL allow the user to set up a third breakpoint. Using PAGSEL in DBGCCX for expanded memory will work differently than the way paged memory is done using comparator A and B in BKP mode. See Section 16.3.2.5, "Debug Comparator C Extended Register (DBGCCX)," for more information on using comparator C .

### 16.4.2 DBG Operating in DBG Mode

Enabling the DBG module in DBG mode, allows the arming, triggering, and storing of data in the trace buffer and can be used to cause CPU breakpoints. The DBG module is made up of three main blocks, the comparators, trace buffer control logic, and the trace buffer.

## NOTE

In general, there is a latency between the triggering event appearing on the bus and being detected by the DBG circuitry. In general, tagged triggers will be more predictable than forced triggers.

### 16.4.2.1 Comparators

The DBG contains three comparators, A, B, and C. Comparator A compares the core address bus with the address stored in DBGCAH and DBGCAL. Comparator B compares the core address bus with the address stored in DBGCBH and DBGCBL except in full mode, where it compares the data buses to the data stored in DBGCBH and DBGCBL. Comparator C can be used as a breakpoint generator or as the address comparison unit in the loop1 mode. Matches on comparator A, B, and C are signaled to the trace buffer
control (TBC) block. When PAGSEL $=01$, registers DBGCAX, DBGCBX, and DBGCCX are used to match the upper addresses as shown in Table 16-11.

## NOTE

If a tagged-type C breakpoint is set at the same address as an $\mathrm{A} / \mathrm{B}$ tagged-type trigger (including the initial entry in an inside or outside range trigger), the C breakpoint will have priority and the trigger will not be recognized.

### 16.4.2.1.1 Read or Write Comparison

Read or write comparisons are useful only with TRGSEL $=0$, because only opcodes should be tagged as they are "read" from memory. RWAEN and RWBEN are ignored when TRGSEL = 1 .

In full modes ("A and B" and "A and not B") RWAEN and RWA are used to select read or write comparisons for both comparators A and B. Table 16-24 shows the effect for RWAEN, RWA, and RW on the DBGCB comparison conditions. The RWBEN and RWB bits are not used and are ignored in full modes.

Table 16-24. Read or Write Comparison Logic Table

| RWAEN bit | RWA bit | RW signal | Comment |
| :---: | :---: | :---: | :---: |
| 0 | x | 0 | Write data bus |
| 0 | x | 1 | Read data bus |
| 1 | 0 | 0 | Write data bus |
| 1 | 0 | 1 | No data bus compare since RW=1 |
| 1 | 1 | 0 | No data bus compare since RW=0 |
| 1 | 1 | 1 | Read data bus |

### 16.4.2.1.2 Trigger Selection

The TRGSEL bit in DBGC1 is used to determine the triggering condition in DBG mode. TRGSEL applies to both trigger A and B except in the event only trigger modes. By setting TRGSEL, the comparators A and B will qualify a match with the output of opcode tracking logic and a trigger occurs before the tagged instruction executes (tagged-type trigger). With the TRGSEL bit cleared, a comparator match forces a trigger when the matching condition occurs (force-type trigger).

## NOTE

If the TRGSEL is set, the address stored in the comparator match address registers must be an opcode address for the trigger to occur.

### 16.4.2.2 Trace Buffer Control (TBC)

The TBC is the main controller for the DBG module. Its function is to decide whether data should be stored in the trace buffer based on the trigger mode and the match signals from the comparator. The TBC also determines whether a request to break the CPU should occur.

### 16.4.2.3 Begin- and End-Trigger

The definitions of begin- and end-trigger as used in the DBG module are as follows:

- Begin-trigger: Storage in trace buffer occurs after the trigger and continues until 64 locations are filled.
- End-trigger: Storage in trace buffer occurs until the trigger, with the least recent data falling out of the trace buffer if more than 64 words are collected.


### 16.4.2.4 Arming the DBG Module

In DBG mode, arming occurs by setting DBGEN and ARM in DBGC1. The ARM bit in DBGC1 is cleared when the trigger condition is met in end-trigger mode or when the Trace Buffer is filled in begin-trigger mode. The TBC logic determines whether a trigger condition has been met based on the trigger mode and the trigger selection.

### 16.4.2.5 Trigger Modes

The DBG module supports nine trigger modes. The trigger modes are encoded as shown in Table 16-6. The trigger mode is used as a qualifier for either starting or ending the storing of data in the trace buffer. When the match condition is met, the appropriate flag A or B is set in DBGSC. Arming the DBG module clears the A, B, and C flags in DBGSC. In all trigger modes except for the event-only modes and DETAIL capture mode, change-of-flow addresses are stored in the trace buffer. In the event-only modes only the value on the data bus at the trigger event B will be stored. In DETAIL capture mode address and data for all cycles except program fetch $(\mathrm{P})$ and free (f) cycles are stored in trace buffer.

### 16.4.2.5.1 A Only

In the A only trigger mode, if the match condition for A is met, the A flag in DBGSC is set and a trigger occurs.

### 16.4.2.5.2 A or B

In the A or B trigger mode, if the match condition for A or B is met, the corresponding flag in DBGSC is set and a trigger occurs.

### 16.4.2.5.3 $\quad A$ then $B$

In the A then B trigger mode, the match condition for A must be met before the match condition for B is compared. When the match condition for A or B is met, the corresponding flag in DBGSC is set. The trigger occurs only after A then B have matched.

## NOTE

When tagging and using A then B , if addresses A and B are close together, then B may not complete the trigger sequence. This occurs when A and B are in the instruction queue at the same time. Basically the A trigger has not yet occurred, so the $B$ instruction is not tagged. Generally, if address B is at
least six addresses higher than address A (or B is lower than A ) and there are not changes of flow to put these in the queue at the same time, then this operation should trigger properly.

### 16.4.2.5.4 Event-Only B (Store Data)

In the event-only B trigger mode, if the match condition for B is met, the B flag in DBGSC is set and a trigger occurs. The event-only B trigger mode is considered a begin-trigger type and the BEGIN bit in DBGC1 is ignored. Event-only B is incompatible with instruction tagging (TRGSEL = 1), and thus the value of TRGSEL is ignored. Please refer to Section 16.4.2.7, "Storage Memory," for more information.

This trigger mode is incompatible with the detail capture mode so the detail capture mode will have priority. TRGSEL and BEGIN will not be ignored and this trigger mode will behave as if it were "B only".

### 16.4.2.5.5 A then Event-Only B (Store Data)

In the A then event-only B trigger mode, the match condition for A must be met before the match condition for B is compared, after the A match has occurred, a trigger occurs each time B matches. When the match condition for A or B is met, the corresponding flag in DBGSC is set. The A then event-only B trigger mode is considered a begin-trigger type and BEGIN in DBGC1 is ignored. TRGSEL in DBGC1 applies only to the match condition for A. Please refer to Section 16.4.2.7, "Storage Memory," for more information.

This trigger mode is incompatible with the detail capture mode so the detail capture mode will have priority. TRGSEL and BEGIN will not be ignored and this trigger mode will be the same as A then B.

### 16.4.2.5.6 A and B (Full Mode)

In the A and B trigger mode, comparator A compares to the address bus and comparator B compares to the data bus. In the $A$ and $B$ trigger mode, if the match condition for $A$ and $B$ happen on the same bus cycle, both the A and B flags in the DBGSC register are set and a trigger occurs.

If TRGSEL $=1$, only matches from comparator A are used to determine if the trigger condition is met and comparator B matches are ignored. If TRGSEL $=0$, full-word data matches on an odd address boundary (misaligned access) do not work unless the access is to a RAM that manages misaligned accesses in a single clock cycle (which is typical of RAM modules used in HCS12 MCUs).

### 16.4.2.5.7 A and Not B (Full Mode)

In the A and not B trigger mode, comparator A compares to the address bus and comparator B compares to the data bus. In the A and not B trigger mode, if the match condition for A and not B happen on the same bus cycle, both the A and B flags in DBGSC are set and a trigger occurs.

If TRGSEL $=1$, only matches from comparator $A$ are used to determine if the trigger condition is met and comparator B matches are ignored. As described in Section 16.4.2.5.6, "A and B (Full Mode)," full-word data compares on misaligned accesses will not match expected data (and thus will cause a trigger in this mode) unless the access is to a RAM that manages misaligned accesses in a single clock cycle.

### 16.4.2.5.8 Inside Range ( $\mathbf{A} \leq$ address $\leq B$ )

In the inside range trigger mode, if the match condition for A and B happen on the same bus cycle, both the A and B flags in DBGSC are set and a trigger occurs. If a match condition on only A or only B occurs no flags are set. If TRGSEL $=1$, the inside range is accurate only to word boundaries. If TRGSEL $=0$, an aligned word access which straddles the range boundary will cause a trigger only if the aligned address is within the range.

### 16.4.2.5.9 Outside Range (address < A or address > B)

In the outside range trigger mode, if the match condition for A or B is met, the corresponding flag in DBGSC is set and a trigger occurs. If TRGSEL $=1$, the outside range is accurate only to word boundaries. If TRGSEL $=0$, an aligned word access which straddles the range boundary will cause a trigger only if the aligned address is outside the range.

### 16.4.2.5.10 Control Bit Priorities

The definitions of some of the control bits are incompatible with each other. Table 16-25 and the notes associated with it summarize how these incompatibilities are managed:

- Read/write comparisons are not compatible with TRGSEL $=1$. Therefore, RWAEN and RWBEN are ignored.
- Event-only trigger modes are always considered a begin-type trigger. See Section 16.4.2.8.1, "Storing with Begin-Trigger," and Section 16.4.2.8.2, "Storing with End-Trigger."
- Detail capture mode has priority over the event-only trigger/capture modes. Therefore, event-only modes have no meaning in detail mode and their functions default to similar trigger modes.

Table 16-25. Resolution of Mode Conflicts

| Mode | Normal / Loop1 |  | Detail |  |
| :--- | :---: | :---: | :---: | :---: |
|  | Tag | Force | Tag | Force |
| A only |  |  |  |  |
| A or B |  |  |  |  |
| A then B |  |  |  |  |
| Event-only B | 1 |  | 4,3 | 3 |
| A then event-only B | 2 |  | 5 | 4 |
| A and B (full mode) | 5 |  | 6 |  |
| A and not B (full mode) | 5 |  | 6 |  |
| Inside range | 6 |  |  |  |
| Outside range | 6 |  |  |  |

1 - Ignored - same as force
2 - Ignored for comparator B
3 - Reduces to effectively "B only"
4 - Works same as A then B
5 - Reduces to effectively "A only" - B not compared
6 - Only accurate to word boundaries

### 16.4.2.6 Capture Modes

The DBG in DBG mode can operate in four capture modes. These modes are described in the following subsections.

### 16.4.2.6.1 Normal Mode

In normal mode, the DBG module uses comparator A and B as triggering devices. Change-of-flow information or data will be stored depending on TRG in DBGSC.

### 16.4.2.6.2 Loop1 Mode

The intent of loopl mode is to prevent the trace buffer from being filled entirely with duplicate information from a looping construct such as delays using the DBNE instruction or polling loops using BRSET/BRCLR instructions. Immediately after address information is placed in the trace buffer, the DBG module writes this value into the C comparator and the C comparator is placed in ignore address mode. This will prevent duplicate address entries in the trace buffer resulting from repeated bit-conditional branches. Comparator C will be cleared when the ARM bit is set in loop1 mode to prevent the previous contents of the register from interfering with loop1 mode operation. Breakpoints based on comparator C are disabled.

Loop1 mode only inhibits duplicate source address entries that would typically be stored in most tight looping constructs. It will not inhibit repeated entries of destination addresses or vector addresses, because repeated entries of these would most likely indicate a bug in the user's code that the DBG module is designed to help find.


### 16.4.2.6.3 Detail Mode

In the detail mode, address and data for all cycles except program fetch ( P ) and free (f) cycles are stored in trace buffer. This mode is intended to supply additional information on indexed, indirect addressing modes where storing only the destination address would not provide all information required for a user to determine where his code was in error.

### 16.4.2.6.4 Profile Mode

This mode is intended to allow a host computer to poll a running target and provide a histogram of program execution. Each read of the trace buffer address will return the address of the last instruction executed. The DBGCNT register is not incremented and the trace buffer does not get filled. The ARM bit is not used and all breakpoints and all other debug functions will be disabled.

### 16.4.2.7 Storage Memory

The storage memory is a 64 words deep by 16 -bits wide dual port RAM array. The CPU accesses the RAM array through a single memory location window (DBGTBH:DBGTBL). The DBG module stores trace information in the RAM array in a circular buffer format. As data is read via the CPU, a pointer into the RAM will increment so that the next CPU read will receive fresh information. In all trigger modes except for event-only and detail capture mode, the data stored in the trace buffer will be change-of-flow addresses. change-of-flow addresses are defined as follows:

- Source address of conditional branches (long, short, BRSET, and loop constructs) taken
- Destination address of indexed JMP, JSR, and CALL instruction
- Destination address of RTI, RTS, and RTC instructions
- Vector address of interrupts except for SWI and BDM vectors

In the event-only trigger modes only the 16-bit data bus value corresponding to the event is stored. In the detail capture mode, address and then data are stored for all cycles except program fetch ( P ) and free (f) cycles.

### 16.4.2.8 Storing Data in Memory Storage Buffer

### 16.4.2.8.1 Storing with Begin-Trigger

Storing with begin-trigger can be used in all trigger modes. When DBG mode is enabled and armed in the begin-trigger mode, data is not stored in the trace buffer until the trigger condition is met. As soon as the trigger condition is met, the DBG module will remain armed until 64 words are stored in the trace buffer. If the trigger is at the address of the change-of-flow instruction the change-of-flow associated with the trigger event will be stored in the trace buffer.

### 16.4.2.8.2 Storing with End-Trigger

Storing with end-trigger cannot be used in event-only trigger modes. When DBG mode is enabled and armed in the end-trigger mode, data is stored in the trace buffer until the trigger condition is met. When the trigger condition is met, the DBG module will become de-armed and no more data will be stored. If
the trigger is at the address of a change-of-flow address the trigger event will not be stored in the trace buffer.

### 16.4.2.9 Reading Data from Trace Buffer

The data stored in the trace buffer can be read using either the background debug module (BDM) module or the CPU provided the DBG module is enabled and not armed. The trace buffer data is read out first-in first-out. By reading CNT in DBGCNT the number of valid words can be determined. CNT will not decrement as data is read from DBGTBH:DBGTBL. The trace buffer data is read by reading DBGTBH:DBGTBL with a 16-bit read. Each time DBGTBH:DBGTBL is read, a pointer in the DBG will be incremented to allow reading of the next word.

Reading the trace buffer while the DBG module is armed will return invalid data and no shifting of the RAM pointer will occur.

## NOTE

The trace buffer should be read with the DBG module enabled and in the same capture mode that the data was recorded. The contents of the trace buffer counter register (DBGCNT) are resolved differently in detail mode verses the other modes and may lead to incorrect interpretation of the trace buffer data.

### 16.4.3 Breakpoints

There are two ways of getting a breakpoint in DBG mode. One is based on the trigger condition of the trigger mode using comparator A and/or B, and the other is using comparator C. External breakpoints generated using the $\overline{\text { TAGHI }}$ and $\overline{\text { TAGLO }}$ external pins are disabled in DBG mode.

### 16.4.3.1 Breakpoint Based on Comparator A and B

A breakpoint request to the CPU can be enabled by setting DBGBRK in DBGC1. The value of BEGIN in DBGC1 determines when the breakpoint request to the CPU will occur. When BEGIN in DBGC1 is set, begin-trigger is selected and the breakpoint request will not occur until the trace buffer is filled with 64 words. When BEGIN in DBGC1 is cleared, end-trigger is selected and the breakpoint request will occur immediately at the trigger cycle.

There are two types of breakpoint requests supported by the DBG module, tagged and forced. Tagged breakpoints are associated with opcode addresses and allow breaking just before a specific instruction executes. Forced breakpoints are not associated with opcode addresses and allow breaking at the next instruction boundary. The type of breakpoint based on comparators A and B is determined by TRGSEL in the DBGC1 register (TRGSEL $=1$ for tagged breakpoint, TRGSEL $=0$ for forced breakpoint).
Table 16-26 illustrates the type of breakpoint that will occur based on the debug run.

Table 16-26. Breakpoint Setup

| BEGIN | TRGSEL | DBGBRK | Type of Debug Run |
| :---: | :---: | :---: | :--- |
| 0 | 0 | 0 | Fill trace buffer until trigger address <br> (no CPU breakpoint - keep running) |
| 0 | 0 | 1 | Fill trace buffer until trigger address, then a forced breakpoint <br> request occurs |
| 0 | 1 | 0 | Fill trace buffer until trigger opcode is about to execute <br> (no CPU breakpoint -keep running) |
| 0 | 1 | 1 | Fill trace buffer until trigger opcode about to execute, then a <br> tagged breakpoint request occurs |
| 1 | 0 | 0 | Start trace buffer at trigger address <br> (no CPU breakpoint - keep running) |
| 1 | 0 | 1 | Start trace buffer at trigger address, a forced breakpoint <br> request occurs when trace buffer is full |
| 1 | 1 | 0 | Start trace buffer at trigger opcode <br> (no CPU breakpoint - keep running) |
| 1 | 1 | 1 | Start trace buffer at trigger opcode, a forced breakpoint request <br> occurs when trace buffer is full |

### 16.4.3.2 Breakpoint Based on Comparator C

A breakpoint request to the CPU can be created if BKCEN in DBGC2 is set. Breakpoints based on a successful comparator $C$ match can be accomplished regardless of the mode of operation for comparator A or B, and do not affect the status of the ARM bit. TAGC in DBGC2 is used to select either tagged or forced breakpoint requests for comparator C . Breakpoints based on comparator C are disabled in LOOP1 mode.

## NOTE

Because breakpoints cannot be disabled when the DBG is armed, one must be careful to avoid an "infinite breakpoint loop" when using tagged-type C breakpoints while the DBG is armed. If BDM breakpoints are selected, executing a TRACE1 instruction before the GO instruction is the recommended way to avoid re-triggering a breakpoint if one does not wish to de-arm the DBG. If SWI breakpoints are selected, disarming the DBG in the SWI interrupt service routine is the recommended way to avoid re-triggering a breakpoint.

### 16.5 Resets

The DBG module is disabled after reset.
The DBG module cannot cause a MCU reset.

### 16.6 Interrupts

The DBG contains one interrupt source. If a breakpoint is requested and BDM in DBGC2 is cleared, an SWI interrupt will be generated.

Chapter 16 Debug Module (DBGV1)

## Chapter 17 Interrupt (INTV1)

### 17.1 Introduction

This section describes the functionality of the interrupt (INT) sub-block of the S12 core platform. A block diagram of the interrupt sub-block is shown in Figure 17-1.


Figure 17-1. INTV1 Block Diagram

The interrupt sub-block decodes the priority of all system exception requests and provides the applicable vector for processing the exception. The INT supports I-bit maskable and X-bit maskable interrupts, a non-maskable unimplemented opcode trap, a non-maskable software interrupt (SWI) or background debug mode request, and three system reset vector requests. All interrupt related exception requests are managed by the interrupt sub-block (INT).

### 17.1.1 Features

The INT includes these features:

- Provides two to 122 I-bit maskable interrupt vectors (0xFF00-0xFFF2)
- Provides one X-bit maskable interrupt vector (0xFFF4)
- Provides a non-maskable software interrupt (SWI) or background debug mode request vector (0xFFF6)
- Provides a non-maskable unimplemented opcode trap (TRAP) vector (0xFFF8)
- Provides three system reset vectors (0xFFFA-0xFFFE) (reset, CMR, and COP)
- Determines the appropriate vector and drives it onto the address bus at the appropriate time
- Signals the CPU that interrupts are pending
- Provides control registers which allow testing of interrupts
- Provides additional input signals which prevents requests for servicing I and X interrupts
- Wakes the system from stop or wait mode when an appropriate interrupt occurs or whenever XIRQ is active, even if $\overline{\mathrm{XIRQ}}$ is masked
- Provides asynchronous path for all I and X interrupts, ( $0 x$ xF00 $-0 x F F F 4$ )
- (Optional) selects and stores the highest priority I interrupt based on the value written into the HPRIO register


### 17.1.2 Modes of Operation

The functionality of the INT sub-block in various modes of operation is discussed in the subsections that follow.

- Normal operation

The INT operates the same in all normal modes of operation.

- Special operation

Interrupts may be tested in special modes through the use of the interrupt test registers.

- Emulation modes

The INT operates the same in emulation modes as in normal modes.

- Low power modes

See Section 17.4.1, "Low-Power Modes," for details

### 17.2 External Signal Description

Most interfacing with the interrupt sub-block is done within the core. However, the interrupt does receive direct input from the multiplexed external bus interface (MEBI) sub-block of the core for the $\overline{\mathrm{IRQ}}$ and $\overline{\text { XIRQ }}$ pin data.

### 17.3 Memory Map and Register Definition

Detailed descriptions of the registers and associated bits are given in the subsections that follow.

### 17.3.1 Module Memory Map

Table 17-1. INT Memory Map

| Address <br> Offset | Use | Access |
| :---: | :--- | :---: |
| $0 \times 0015$ | Interrupt Test Control Register (ITCR) | R/W |
| $0 \times 0016$ | Interrupt Test Registers (ITEST) | R/W |
| $0 \times 001 \mathrm{~F}$ | Highest Priority Interrupt (Optional) (HPRIO) | R/W |

### 17.3.2 Register Descriptions

### 17.3.2.1 Interrupt Test Control Register



Figure 17-2. Interrupt Test Control Register (ITCR)
Read: See individual bit descriptions
Write: See individual bit descriptions

Table 17-2. ITCR Field Descriptions

| Field | Description |
| :---: | :--- |
| 4 |  |
| WRTINT | Write to the Interrupt Test Registers <br> Read: anytime <br> Write: only in special modes and with I-bit mask and X-bit mask set. <br> 0 <br> 1 <br> Disables writes to the test registers; reads of the test registers will return the state of the interrupt inputs. <br> instead. <br> Note: Any interrupts which are pending at the time that WRTINT is set will remain until they are overwritten. |
| $3: 0$ | Test Register Select Bits <br> Read: anytime <br> Write: anytime <br> These bits determine which test register is selected on a read or write. The hexadecimal value written here will <br> be the same as the upper nibble of the lower byte of the vector selects. That is, an "F" written into ADR[3:0] will <br> select vectors 0xFFFE-0xFFF0 while a "7" written to ADR[3:0] will select vectors 0xFF7E-0xFF70. |

### 17.3.2.2 Interrupt Test Registers



Figure 17-3. Interrupt TEST Registers (ITEST)
Read: Only in special modes. Reads will return either the state of the interrupt inputs of the interrupt sub-block (WRTINT $=0$ ) or the values written into the TEST registers (WRTINT $=1$ ). Reads will always return 0s in normal modes.

Write: Only in special modes and with WRTINT $=1$ and CCR I mask $=1$.
Table 17-3. ITEST Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 0$ | Interrupt TEST Bits - These registers are used in special modes for testing the interrupt logic and priority <br> independent of the system configuration. Each bit is used to force a specific interrupt vector by writing it to a <br> logic 1 state. Bits are named INTE through INT0 to indicate vectors 0xFFxE through 0xFFx0. These bits can be <br> written only in special modes and only with the WRTINT bit set (logic 1) in the interrupt test control register <br> (ITCR). In addition, I interrupts must be masked using the I bit in the CCR. In this state, the interrupt input lines <br> to the interrupt sub-block will be disconnected and interrupt requests will be generated only by this register. <br> These bits can also be read in special modes to view that an interrupt requested by a system block (such as a <br> peripheral block) has reached the INT module. <br> There is a test register implemented for every eight interrupts in the overall system. All of the test registers share <br> the same address and are individually selected using the value stored in the ADR[3:0] bits of the interrupt test <br> control register (ITCR). <br> Note: When ADR[3:0] have the value of 0x000F, only bits 2:0 in the ITEST register will be accessible. That is, <br> vectors higher than 0xFFF4 cannot be tested using the test registers and bits 7:3 will always read as a <br> logic 0. If ADR[3:0] point to an unimplemented test register, writes will have no effect and reads will always <br> return a logic 0 value. |

### 17.3.2.3 Highest Priority I Interrupt (Optional)



Figure 17-4. Highest Priority I Interrupt Register (HPRIO)
Read: Anytime
Write: Only if I mask in CCR $=1$
Table 17-4. HPRIO Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 1$ | Highest Priority I Interrupt Select Bits - The state of these bits determines which I-bit maskable interrupt will <br> be promoted to highest priority (of the I-bit maskable interrupts). To promote an interrupt, the user writes the least <br> significant byte of the associated interrupt vector address to this register. If an unimplemented vector address or <br> a non I-bit masked vector address (value higher than 0x00F2) is written, IRQ (0xFFF2) will be the default highest <br> priority interrupt. |

### 17.4 Functional Description

The interrupt sub-block processes all exception requests made by the CPU. These exceptions include interrupt vector requests and reset vector requests. Each of these exception types and their overall priority level is discussed in the subsections below.

### 17.4.1 Low-Power Modes

The INT does not contain any user-controlled options for reducing power consumption. The operation of the INT in low-power modes is discussed in the following subsections.

### 17.4.1.1 Operation in Run Mode

The INT does not contain any options for reducing power in run mode.

### 17.4.1.2 Operation in Wait Mode

Clocks to the INT can be shut off during system wait mode and the asynchronous interrupt path will be used to generate the wake-up signal upon recognition of a valid interrupt or any $\overline{\mathrm{XIRQ}}$ request.

### 17.4.1.3 Operation in Stop Mode

Clocks to the INT can be shut off during system stop mode and the asynchronous interrupt path will be used to generate the wake-up signal upon recognition of a valid interrupt or any XIRQ request.

### 17.5 Resets

The INT supports three system reset exception request types: normal system reset or power-on-reset request, crystal monitor reset request, and COP watchdog reset request. The type of reset exception request must be decoded by the system and the proper request made to the core. The INT will then provide the service routine address for the type of reset requested.

### 17.6 Interrupts

As shown in the block diagram in Figure 17-1, the INT contains a register block to provide interrupt status and control, an optional highest priority I interrupt (HPRIO) block, and a priority decoder to evaluate whether pending interrupts are valid and assess their priority.

### 17.6.1 Interrupt Registers

The INT registers are accessible only in special modes of operation and function as described in Section 17.3.2.1, "Interrupt Test Control Register," and Section 17.3.2.2, "Interrupt Test Registers," previously.

### 17.6.2 Highest Priority I-Bit Maskable Interrupt

When the optional HPRIO block is implemented, the user is allowed to promote a single I-bit maskable interrupt to be the highest priority I interrupt. The HPRIO evaluates all interrupt exception requests and passes the HPRIO vector to the priority decoder if the highest priority I interrupt is active. RTI replaces the promoted interrupt source.

### 17.6.3 Interrupt Priority Decoder

The priority decoder evaluates all interrupts pending and determines their validity and priority. When the CPU requests an interrupt vector, the decoder will provide the vector for the highest priority interrupt request. Because the vector is not supplied until the CPU requests it, it is possible that a higher priority interrupt request could override the original exception that caused the CPU to request the vector. In this case, the CPU will receive the highest priority vector and the system will process this exception instead of the original request.

## NOTE

Care must be taken to ensure that all exception requests remain active until the system begins execution of the applicable service routine; otherwise, the exception request may not be processed.

If for any reason the interrupt source is unknown (e.g., an interrupt request becomes inactive after the interrupt has been recognized but prior to the vector request), the vector address will default to that of the last valid interrupt that existed during the particular interrupt sequence. If the CPU requests an interrupt vector when there has never been a pending interrupt request, the INT will provide the software interrupt (SWI) vector address.

### 17.7 Exception Priority

The priority (from highest to lowest) and address of all exception vectors issued by the INT upon request by the CPU is shown in Table 17-5.

Table 17-5. Exception Vector Map and Priority

| Vector Address | Source |
| :---: | :--- |
| 0xFFFE-0xFFFF | System reset |
| 0xFFFC-0xFFFD | Crystal monitor reset |
| 0xFFFA-0xFFFB | COP reset |
| 0xFFF8-0xFFF9 | Unimplemented opcode trap |
| 0xFFF6-0xFFF7 | Software interrupt instruction (SWI) or BDM vector request |
| 0xFFF4-0xFFF5 | XIRQ signal |
| 0xFFF2-0xFFF3 | $\overline{\text { IRQ }}$ signal |
| 0xFFF0-0xFF00 | Device-specific I-bit maskable interrupt sources (priority in descending order) |

## Chapter 18 <br> Multiplexed External Bus Interface (MEBIV3)

### 18.1 Introduction

This section describes the functionality of the multiplexed external bus interface (MEBI) sub-block of the S12 core platform. The functionality of the module is closely coupled with the S12 CPU and the memory map controller (MMC) sub-blocks.

Figure 18-1 is a block diagram of the MEBI. In Figure 18-1, the signals on the right hand side represent pins that are accessible externally. On some chips, these may not all be bonded out.

The MEBI sub-block of the core serves to provide access and/or visibility to internal core data manipulation operations including timing reference information at the external boundary of the core and/or system. Depending upon the system operating mode and the state of bits within the control registers of the MEBI, the internal 16-bit read and write data operations will be represented in 8-bit or 16-bit accesses externally. Using control information from other blocks within the system, the MEBI will determine the appropriate type of data access to be generated.

### 18.1.1 Features

The block name includes these distinctive features:

- External bus controller with four 8-bit ports A,B, E, and K
- Data and data direction registers for ports $\mathrm{A}, \mathrm{B}, \mathrm{E}$, and K when used as general-purpose I/O
- Control register to enable/disable alternate functions on ports E and K
- Mode control register
- Control register to enable/disable pull resistors on ports A, B, E, and K
- Control register to enable/disable reduced output drive on ports A, B, E, and K
- Control register to configure external clock behavior
- Control register to configure $\overline{\mathrm{IRQ}}$ pin operation
- Logic to capture and synchronize external interrupt pin inputs


Figure 18-1. MEBI Block Diagram

### 18.1.2 Modes of Operation

- Normal expanded wide mode

Ports A and B are configured as a 16-bit multiplexed address and data bus and port E provides bus control and status signals. This mode allows 16-bit external memory and peripheral devices to be interfaced to the system.

- Normal expanded narrow mode

Ports A and B are configured as a 16-bit address bus and port A is multiplexed with 8-bit data. Port E provides bus control and status signals. This mode allows 8-bit external memory and peripheral devices to be interfaced to the system.

- Normal single-chip mode

There is no external expansion bus in this mode. The processor program is executed from internal memory. Ports A, B, K, and most of E are available as general-purpose I/O.

- Special single-chip mode

This mode is generally used for debugging single-chip operation, boot-strapping, or security related operations. The active background mode is in control of CPU execution and BDM firmware is waiting for additional serial commands through the BKGD pin. There is no external expansion bus after reset in this mode.

- Emulation expanded wide mode

Developers use this mode for emulation systems in which the users target application is normal expanded wide mode.

- Emulation expanded narrow mode

Developers use this mode for emulation systems in which the users target application is normal expanded narrow mode.

- Special test mode

Ports A and B are configured as a 16-bit multiplexed address and data bus and port E provides bus control and status signals. In special test mode, the write protection of many control bits is lifted so that they can be thoroughly tested without needing to go through reset.

- Special peripheral mode

This mode is intended for Freescale Semiconductor factory testing of the system. The CPU is inactive and an external (tester) bus master drives address, data, and bus control signals.

Chapter 18 Multiplexed External Bus Interface (MEBIV3)

### 18.2 External Signal Description

In typical implementations, the MEBI sub-block of the core interfaces directly with external system pins. Some pins may not be bonded out in all implementations.

Table 18-1 outlines the pin names and functions and gives a brief description of their operation reset state of these pins and associated pull-ups or pull-downs is dependent on the mode of operation and on the integration of this block at the chip level (chip dependent).

Table 18-1. External System Pins Associated With MEBI

| Pin Name | Pin Functions | Description |
| :---: | :---: | :---: |
| $\begin{array}{\|l\|} \hline \text { BKGD/MODC/ } \\ \hline \text { TAGHI } \end{array}$ | MODC | At the rising edge on RESET, the state of this pin is registered into the MODC bit to set the mode. (This pin always has an internal pullup.) |
|  | BKGD | Pseudo open-drain communication pin for the single-wire background debug mode. There is an internal pull-up resistor on this pin. |
|  | TAGHI | When instruction tagging is on, $a 0$ at the falling edge of $E$ tags the high half of the instruction word being read into the instruction queue. |
| PA7/A15/D15/D7 thru PA0/A8/D8/D0 | PA7-PA0 | General-purpose I/O pins, see PORTA and DDRA registers. |
|  | A15-A8 | High-order address lines multiplexed during ECLK low. Outputs except in special peripheral mode where they are inputs from an external tester system. |
|  | D15-D8 | High-order bidirectional data lines multiplexed during ECLK high in expanded wide modes, special peripheral mode, and visible internal accesses (IVIS = 1) in emulation expanded narrow mode. Direction of data transfer is generally indicated by R/W. |
|  | $\begin{aligned} & \text { D15/D7 } \\ & \text { thru } \\ & \text { D8/D0 } \end{aligned}$ | Alternate high-order and low-order bytes of the bidirectional data lines multiplexed during ECLK high in expanded narrow modes and narrow accesses in wide modes. Direction of data transfer is generally indicated by $\mathrm{R} / \overline{\mathrm{W}}$. |
| $\begin{aligned} & \hline \text { PB7/A7/D7 } \\ & \text { thru } \\ & \text { PBO/AO/DO } \end{aligned}$ | PB7-PB0 | General-purpose I/O pins, see PORTB and DDRB registers. |
|  | A7-A0 | Low-order address lines multiplexed during ECLK low. Outputs except in special peripheral mode where they are inputs from an external tester system. |
|  | D7-D0 | Low-order bidirectional data lines multiplexed during ECLK high in expanded wide modes, special peripheral mode, and visible internal accesses (with IVIS = 1) in emulation expanded narrow mode. Direction of data transfer is generally indicated by R/W. |
| PE7/NOACC | PE7 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | NOACC | CPU No Access output. Indicates whether the current cycle is a free cycle. Only available in expanded modes. |
| PE6/PIPE1/ MODB/CLKTO | MODB | At the rising edge of RESET, the state of this pin is registered into the MODB bit to set the mode. |
|  | PE6 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | IPIPE1 | Instruction pipe status bit 1, enabled by PIPOE bit in PEAR. |
|  | CLKTO | System clock test output. Only available in special modes. PIPOE $=1$ overrides this function. The enable for this function is in the clock module. |

Table 18-1. External System Pins Associated With MEBI (continued)

| Pin Name | Pin Functions | Description |
| :---: | :---: | :---: |
| PE5/IPIPE0/MODA | MODA | At the rising edge on $\overline{R E S E T}$, the state of this pin is registered into the MODA bit to set the mode. |
|  | PE5 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | IPIPE0 | Instruction pipe status bit 0, enabled by PIPOE bit in PEAR. |
| PE4/ECLK | PE4 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | ECLK | Bus timing reference clock, can operate as a free-running clock at the system clock rate or to produce one low-high clock per visible access, with the high period stretched for slow accesses. ECLK is controlled by the NECLK bit in PEAR, the IVIS bit in MODE, and the ESTR bit in EBICTL. |
| PE3/LSTRB/ TAGLO | PE3 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | LSTRB | Low strobe bar, 0 indicates valid data on D7-D0. |
|  | SZ8 | In special peripheral mode, this pin is an input indicating the size of the data transfer ( $0=16$-bit; $1=8$-bit). |
|  | TAGLO | In expanded wide mode or emulation narrow modes, when instruction tagging is on and low strobe is enabled, a 0 at the falling edge of $E$ tags the low half of the instruction word being read into the instruction queue. |
| PE2/R/W | PE2 | General-purpose I/O pin, see PORTE and DDRE registers. |
|  | R/W | Read/write, indicates the direction of internal data transfers. This is an output except in special peripheral mode where it is an input. |
| PE1/IRQ | PE1 | General-purpose input-only pin, can be read even if IRQ enabled. |
|  | $\overline{\mathrm{IRQ}}$ | Maskable interrupt request, can be level sensitive or edge sensitive. |
| PE0/XIRQ | PE0 | General-purpose input-only pin. |
|  | $\overline{\text { XIRQ }}$ | Non-maskable interrupt input. |
| PK7/ECS | PK7 | General-purpose I/O pin, see PORTK and DDRK registers. |
|  | ECS | Emulation chip select |
| PK6/XCS | PK6 | General-purpose I/O pin, see PORTK and DDRK registers. |
|  | $\overline{X C S}$ | External data chip select |
| $\begin{aligned} & \text { PK5/X19 } \\ & \text { thru } \\ & \text { PK0/X14 } \end{aligned}$ | PK5-PK0 | General-purpose I/O pins, see PORTK and DDRK registers. |
|  | X19-X14 | Memory expansion addresses |

Detailed descriptions of these pins can be found in the device overview chapter.

Chapter 18 Multiplexed External Bus Interface (MEBIV3)

### 18.3 Memory Map and Register Definition

A summary of the registers associated with the MEBI sub-block is shown in Table 18-2. Detailed descriptions of the registers and bits are given in the subsections that follow. On most chips the registers are mappable. Therefore, the upper bits may not be all 0 s as shown in the table and descriptions.

### 18.3.1 Module Memory Map

Table 18-2. MEBI Memory Map

| Address Offset | Use | Access |
| :---: | :---: | :---: |
| $0 \times 0000$ | Port A Data Register (PORTA) | R/W |
| $0 \times 0001$ | Port B Data Register (PORTB) | R/W |
| 0x0002 | Data Direction Register A (DDRA) | R/W |
| $0 \times 0003$ | Data Direction Register B (DDRB) | R/W |
| 0x0004 | Reserved | R |
| 0x0005 | Reserved | R |
| $0 \times 0006$ | Reserved | R |
| $0 \times 0007$ | Reserved | R |
| $0 \times 0008$ | Port E Data Register (PORTE) | R/W |
| 0x0009 | Data Direction Register E (DDRE) | R/W |
| 0x000A | Port E Assignment Register (PEAR) | R/W |
| 0x000B | Mode Register (MODE) | R/W |
| 0x000C | Pull Control Register (PUCR) | R/W |
| 0x000D | Reduced Drive Register (RDRIV) | R/W |
| 0x000E | External Bus Interface Control Register (EBICTL) | R/W |
| 0x000F | Reserved | R |
| 0x001E | IRQ Control Register (IRQCR) | R/W |
| 0x00032 | Port K Data Register (PORTK) | R/W |
| 0x00033 | Data Direction Register K (DDRK) | R/W |

### 18.3.2 Register Descriptions

### 18.3.2.1 Port A Data Register (PORTA)



Figure 18-2. Port A Data Register (PORTA)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
Port A bits 7 through 0 are associated with address lines A15 through A8 respectively and data lines D15/D7 through D8/D0 respectively. When this port is not used for external addresses such as in single-chip mode, these pins can be used as general-purpose I/O. Data direction register A (DDRA) determines the primary direction of each pin. DDRA also determines the source of data for a read of PORTA.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

## NOTE

To ensure that you read the value present on the PORTA pins, always wait at least one cycle after writing to the DDRA register before reading from the PORTA register.

### 18.3.2.2 Port B Data Register (PORTB)



Figure 18-3. Port A Data Register (PORTB)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
Port B bits 7 through 0 are associated with address lines A7 through A0 respectively and data lines D7 through D0 respectively. When this port is not used for external addresses, such as in single-chip mode, these pins can be used as general-purpose I/O. Data direction register B (DDRB) determines the primary direction of each pin. DDRB also determines the source of data for a read of PORTB.
This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

## NOTE

To ensure that you read the value present on the PORTB pins, always wait at least one cycle after writing to the DDRB register before reading from the PORTB register.

### 18.3.2.3 Data Direction Register A (DDRA)



Figure 18-4. Data Direction Register A (DDRA)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
This register controls the data direction for port A . When port A is operating as a general-purpose I/O port, DDRA determines the primary direction for each port A pin. A 1 causes the associated port pin to be an output and a 0 causes the associated pin to be a high-impedance input. The value in a DDR bit also affects the source of data for reads of the corresponding PORTA register. If the DDR bit is 0 (input) the buffered pin input state is read. If the DDR bit is 1 (output) the associated port data register bit state is read.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally. It is reset to $0 \times 00$ so the DDR does not override the three-state control signals.

Table 18-3. DDRA Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:0 | Data Direction Port A |
| DDRA | 0 Configure the corresponding I/O pin as an input |
|  | 1 Configure the corresponding I/O pin as an output |

## Chapter 18 Multiplexed External Bus Interface (MEBIV3)

### 18.3.2.4 Data Direction Register B (DDRB)



Figure 18-5. Data Direction Register B (DDRB)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
This register controls the data direction for port B . When port B is operating as a general-purpose $\mathrm{I} / \mathrm{O}$ port, DDRB determines the primary direction for each port B pin. A 1 causes the associated port pin to be an output and a 0 causes the associated pin to be a high-impedance input. The value in a DDR bit also affects the source of data for reads of the corresponding PORTB register. If the DDR bit is 0 (input) the buffered pin input state is read. If the DDR bit is 1 (output) the associated port data register bit state is read.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally. It is reset to $0 x 00$ so the DDR does not override the three-state control signals.

Table 18-4. DDRB Field Descriptions

| Field |  |
| :---: | :--- |
| $7: 0$ | Data Direction Port B |
| DDRB | 0 Configure the corresponding I/O pin as an input |
|  | 1 Configure the corresponding I/O pin as an output |

### 18.3.2.5 Reserved Registers



Figure 18-6. Reserved Register


Figure 18-7. Reserved Register


Figure 18-8. Reserved Register


Figure 18-9. Reserved Register
These register locations are not used (reserved). All unused registers and bits in this block return logic 0 s when read. Writes to these registers have no effect.

These registers are not in the on-chip map in special peripheral mode.

### 18.3.2.6 Port E Data Register (PORTE)



Figure 18-10. Port E Data Register (PORTE)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
Port E is associated with external bus control signals and interrupt inputs. These include mode select (MODB/IPIPE1, MODA/IPIPE0), E clock, size ( $\overline{\mathrm{LSTRB}} / \overline{\mathrm{TAGLO}}$ ), read/write (R/信), $\overline{\mathrm{IRQ}}$, and $\overline{\mathrm{XIRQ}}$. When not used for one of these specific functions, port E pins 7:2 can be used as general-purpose I/O and pins 1:0 can be used as general-purpose input. The port E assignment register (PEAR) selects the function of each pin and DDRE determines whether each pin is an input or output when it is configured to be general-purpose I/O. DDRE also determines the source of data for a read of PORTE.

Some of these pins have software selectable pull resistors. $\overline{\text { IRQ }}$ and $\overline{\text { XIRQ }}$ can only be pulled up whereas the polarity of the PE7, PE4, PE3, and PE2 pull resistors are determined by chip integration. Please refer to the device overview chapter (Signal Property Summary) to determine the polarity of these resistors. A single control bit enables the pull devices for all of these pins when they are configured as inputs.

This register is not in the on-chip map in special peripheral mode or in expanded modes when the EME bit is set. Therefore, these accesses will be echoed externally.

## NOTE

It is unwise to write PORTE and DDRE as a word access. If you are changing port E pins from being inputs to outputs, the data may have extra transitions during the write. It is best to initialize PORTE before enabling as outputs.

## NOTE

To ensure that you read the value present on the PORTE pins, always wait at least one cycle after writing to the DDRE register before reading from the PORTE register.

### 18.3.2.7 Data Direction Register E (DDRE)



Figure 18-11. Data Direction Register E (DDRE)
Read: Anytime when register is in the map
Write: Anytime when register is in the map
Data direction register E is associated with port E . For bits in port E that are configured as general-purpose I/O lines, DDRE determines the primary direction of each of these pins. A 1 causes the associated bit to be an output and a 0 causes the associated bit to be an input. Port E bit 1 (associated with $\overline{\overline{\mathrm{RQ}}}$ ) and bit 0 (associated with $\overline{\text { XIRQ}}$ ) cannot be configured as outputs. Port E, bits 1 and 0 , can be read regardless of whether the alternate interrupt function is enabled. The value in a DDR bit also affects the source of data for reads of the corresponding PORTE register. If the DDR bit is 0 (input) the buffered pin input state is read. If the DDR bit is 1 (output) the associated port data register bit state is read.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally. Also, it is not in the map in expanded modes while the EME control bit is set.

Table 18-5. DDRE Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 2$ | Data Direction Port E <br> 0 Configure the corresponding I/O pin as an input <br> D Configure the corresponding I/O pin as an output <br> Note: It is unwise to write PORTE and DDRE as a word access. If you are changing port E pins from inputs to <br> outputs, the data may have extra transitions during the write. It is best to initialize PORTE before enabling <br> as outputs. |

### 18.3.2.8 Port E Assignment Register (PEAR)



Figure 18-12. Port E Assignment Register (PEAR)
Read: Anytime (provided this register is in the map).
Write: Each bit has specific write conditions. Please refer to the descriptions of each bit on the following pages.

Port E serves as general-purpose I/O or as system and bus control signals. The PEAR register is used to choose between the general-purpose I/O function and the alternate control functions. When an alternate control function is selected, the associated DDRE bits are overridden.

The reset condition of this register depends on the mode of operation because bus control signals are needed immediately after reset in some modes. In normal single-chip mode, no external bus control signals are needed so all of port E is configured for general-purpose $\mathrm{I} / \mathrm{O}$. In normal expanded modes, only the E clock is configured for its alternate bus control function and the other bits of port E are configured for general-purpose I/O. As the reset vector is located in external memory, the E clock is required for this access. $\mathrm{R} / \overline{\mathrm{W}}$ is only needed by the system when there are external writable resources. If the normal expanded system needs any other bus control signals, PEAR would need to be written before any access that needed the additional signals. In special test and emulation modes, IPIPE1, IPIPE0, E, $\overline{\mathrm{LSTRB}}$, and $\mathrm{R} / \overline{\mathrm{W}}$ are configured out of reset as bus control signals.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

Table 18-6. PEAR Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| 7 | $\begin{array}{c}\text { CPU No Access Output Enable } \\ \text { NOACCE } \\ \text { Normal: write once } \\ \text { Emulation: write never } \\ \text { Special: write anytime } \\ 1 \\ \text { The associated pin (port E, bit 7) is general-purpose I/O. } \\ 0 \\ \text { This associated pin (port E, bit 7) is output and indicates whether the cyclect in single-chip or special peripheral modes. }\end{array}$ |
| 5 | $\begin{array}{l}\text { Pipe Status Signal Output Enable } \\ \text { Normal: write once } \\ \text { Emulation: write never } \\ \text { Special: write anytime. }\end{array}$ |
| 0 The associated pins (port E, bits $6: 5$ ) are general-purpose I/O. |  |
| 1 The associated pins (port E, bits 6:5) are outputs and indicate the state of the instruction queue |  |
| This bit has no effect in single-chip or special peripheral modes. |  |$\}$

### 18.3.2.9 Mode Register (MODE)



Figure 18-13. Mode Register (MODE)
Read: Anytime (provided this register is in the map).
Write: Each bit has specific write conditions. Please refer to the descriptions of each bit on the following pages.

The MODE register is used to establish the operating mode and other miscellaneous functions (i.e., internal visibility and emulation of port E and K ).

In special peripheral mode, this register is not accessible but it is reset as shown to system configuration features. Changes to bits in the MODE register are delayed one cycle after the write.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

Table 18-7. MODE Field Descriptions

| Field | $\quad$ Description |
| :---: | :--- |
| $7: 5$ | $\begin{array}{l}\text { Mode Select Bits - These bits indicate the current operating mode. } \\ \text { If MODA = 1, then MODC, MODB, and MODA are write never. } \\ \text { If MODC = MODA = 0, then MODC, MODB, and MODA are writable with the exception that you cannot change } \\ \text { to or from special peripheral mode } \\ \text { If MODC = 1, MODB = 0, and MODA = 0, then MODC is write never. MODB and MODA are write once, except } \\ \text { that you cannot change to special peripheral mode. From normal single-chip, only normal expanded narrow and } \\ \text { normal expanded wide modes are available. } \\ \text { See Table 18-8 and Table 18-16. }\end{array}$ |
| 3 | $\begin{array}{l}\text { Internal Visibility (for both read and write accesses) - This bit determines whether internal accesses } \\ \text { generate a bus cycle that is visible on the external bus. } \\ \text { Normal: write once } \\ \text { Emulation: write never } \\ \text { Special: write anytime } \\ 0 \\ \text { No visibility of internal bus operations on external bus. } \\ 1 \\ \text { Internal bus operations are visible on external bus. }\end{array}$ |
| 1 | $\begin{array}{l}\text { Emulate Port K } \\ \text { EMK } \\ \text { Normal: write once } \\ \text { Emulation: write never } \\ \text { Special: write anytime } \\ 0 \\ \text { PORTK and DDRK are in the memory map so port K can be used for general-purpose I/O. } \\ 1 \\ \text { If in any expanded mode, PORTK and DDRK are removed from the memory map. } \\ \text { In single-chip modes, PORTK and DDRK are always in the map regardless of the state of this bit. } \\ \text { In special peripheral mode, PORTK and DDRK are never in the map regardless of the state of this bit. }\end{array}$ |
| 0 | $\begin{array}{l}\text { Emulate Port E } \\ \text { Normal and Emulation: write never } \\ \text { Special: write anytime } \\ 0 \\ 1\end{array}$ |
| If in any and DDRE are in the memory map so port E can be used for general-purpose I/O. |  |
| EMemoving the registers from the map allows the user to emulate the function of these registers externally. |  |$\}$

Table 18-8. MODC, MODB, and MODA Write Capability ${ }^{\text {a }}$

| MODC | MODB | MODA | Mode | MODx Write Capability |
| :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | Special single chip | MODC, MODB, and MODA <br> write anytime but not to 110 |
| 0 | 0 | 1 | Emulation narrow | No write |
| 0 | 1 | 0 | Special test | MODC, MODB, and MODA <br> write anytime but not to 110(2) |
| 0 | 1 | 1 | Emulation wide | No write |
| 1 | 0 | 0 | Normal single chip | MODC write never, <br> MODB and MODA write once <br> but not to 110 |
| 1 | 0 | 1 | Normal expanded narrow | No write |
| 1 | 1 | 0 | Special peripheral | No write |
| 1 | 1 | 1 | Normal expanded wide | No write |

a No writes to the MOD bits are allowed while operating in a secure mode. For more details, refer to the device overview chapter.
b If you are in a special single-chip or special test mode and you write to this register, changing to normal sin-gle-chip mode, then one allowed write to this register remains. If you write to normal expanded or emulation mode, then no writes remain.

### 18.3.2.10 Pull Control Register (PUCR)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | PUPKE | 0 | 0 | PUPEE | 0 | 0 | PUPBE | PUPAE |
| W |  |  |  |  |  |  |  |  |
| Reset ${ }^{1}$ | 1 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |

NOTES:

1. The default value of this parameter is shown. Please refer to the device overview chapter to determine the actual reset state of this register.


Figure 18-14. Pull Control Register (PUCR)
Read: Anytime (provided this register is in the map).
Write: Anytime (provided this register is in the map).
This register is used to select pull resistors for the pins associated with the core ports. Pull resistors are assigned on a per-port basis and apply to any pin in the corresponding port that is currently configured as an input. The polarity of these pull resistors is determined by chip integration. Please refer to the device overview chapter to determine the polarity of these resistors.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

NOTE
These bits have no effect when the associated pin(s) are outputs. (The pull resistors are inactive.)

Table 18-9. PUCR Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 |  |
| PUPKE | Pull resistors Port K Enable <br> 0 <br> 1 <br> 1 <br> Enable pull resistors for port K input pins. |
| 4 | Pull resistors Port E Enable <br> 0 <br> PUort E pull resistors on bits 7, 4:0 are disabled. <br> 1 <br> Enable pull resistors for port E input pins bits 7, 4:0. <br> Note: Pins 5 and 6 of port E have pull resistors which are only enabled during reset. This bit has no effect on <br> these pins. |
| 1 | Pull resistors Port B Enable <br> 0 <br> Port B pull resistors are disabled. <br> 1 <br> Enable pull resistors for all port B input pins. |
| 0 | Pull resistors Port A Enable <br> 0 |
| 1 Port A pull resistors are disabled. |  |

### 18.3.2.11 Reduced Drive Register (RDRIV)



Figure 18-15. Reduced Drive Register (RDRIV)
Read: Anytime (provided this register is in the map)
Write: Anytime (provided this register is in the map)
This register is used to select reduced drive for the pins associated with the core ports. This gives reduced power consumption and reduced RFI with a slight increase in transition time (depending on loading). This feature would be used on ports which have a light loading. The reduced drive function is independent of which function is being used on a particular port.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

Table 18-10. RDRIV Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { RDRK } \end{gathered}$ | Reduced Drive of Port K <br> 0 All port K output pins have full drive enabled. <br> 1 All port K output pins have reduced drive enabled. |
| $\begin{gathered} 4 \\ \text { RDPE } \end{gathered}$ | Reduced Drive of Port E <br> 0 All port E output pins have full drive enabled. <br> 1 All port E output pins have reduced drive enabled. |
| $\begin{gathered} 1 \\ \text { RDPB } \end{gathered}$ | Reduced Drive of Port B <br> 0 All port B output pins have full drive enabled. <br> 1 All port B output pins have reduced drive enabled. |
| $\begin{gathered} 0 \\ \text { RDPA } \end{gathered}$ | Reduced Drive of Ports A <br> 0 All port A output pins have full drive enabled. <br> 1 All port A output pins have reduced drive enabled. |

### 18.3.2.12 External Bus Interface Control Register (EBICTL)



Figure 18-16. External Bus Interface Control Register (EBICTL)
Read: Anytime (provided this register is in the map)
Write: Refer to individual bit descriptions below
The EBICTL register is used to control miscellaneous functions (i.e., stretching of external E clock).
This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

Table 18-11. EBICTL Field Descriptions

| Field | Description |
| :---: | :--- |
| 0 | E Clock Stretches - This control bit determines whether the E clock behaves as a simple free-running clock or <br> ESTR <br> as a bus control signal that is active only for external bus cycles. <br> Normal and Emulation: write once <br> Special: write anytime |
| 0 | E never stretches (always free running). |
| 1 | E stretches high during stretched external accesses and remains low during non-visible internal accesses. |
| This bit has no effect in single-chip modes. |  |

### 18.3.2.13 Reserved Register



Figure 18-17. Reserved Register
This register location is not used (reserved). All bits in this register return logic 0 s when read. Writes to this register have no effect.

This register is not in the on-chip memory map in expanded and special peripheral modes. Therefore, these accesses will be echoed externally.

### 18.3.2.14 IRQ Control Register (IRQCR)



Figure 18-18. IRQ Control Register (IRQCR)
Read: See individual bit descriptions below
Write: See individual bit descriptions below
Table 18-12. IRQCR Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 | IRQ Select Edge Sensitive Only <br> Special modes: read or write anytime <br> IRQE <br> Normal and Emulation modes: read anytime, write once <br> 0 <br> IRQ configured for low level recognition. <br> 1 <br> IRQ configured to respond only to falling edges. Falling edges on the IRQ pin will be detected anytime <br> IRQE = 1 and will be cleared only upon a reset or the servicing of the IRQ interrupt. |
| 6 | External IRQ Enable <br> IRQEN |
| Normal, emulation, and special modes: read or write anytime <br> 0 <br> External IRQ pin is disconnected from interrupt logic. <br> 1 |  |
|  | External IRQ pin is connected to interrupt logic. |
| Note: When IRQEN = 0, the edge detect latch is disabled. |  |

### 18.3.2.15 Port K Data Register (PORTK)



Figure 18-19. Port K Data Register (PORTK)
Read: Anytime
Write: Anytime
This port is associated with the internal memory expansion emulation pins. When the port is not enabled to emulate the internal memory expansion, the port pins are used as general-purpose I/O. When port K is operating as a general-purpose I/O port, DDRK determines the primary direction for each port K pin. A 1 causes the associated port pin to be an output and a 0 causes the associated pin to be a high-impedance input. The value in a DDR bit also affects the source of data for reads of the corresponding PORTK register. If the DDR bit is 0 (input) the buffered pin input is read. If the DDR bit is 1 (output) the output of the port data register is read.

This register is not in the map in peripheral or expanded modes while the EMK control bit in MODE register is set. Therefore, these accesses will be echoed externally.

When inputs, these pins can be selected to be high impedance or pulled up, based upon the state of the PUPKE bit in the PUCR register.

Table 18-13. PORTK Field Descriptions

| Field | Description |
| :---: | :---: |
| $\begin{gathered} 7 \\ \text { Port K, Bit } 7 \end{gathered}$ | Port K, Bit 7 - This bit is used as an emulation chip select signal for the emulation of the internal memory expansion, or as general-purpose I/O, depending upon the state of the EMK bit in the MODE register. While this bit is used as a chip select, the external bit will return to its de-asserted state ( $\mathrm{V}_{\mathrm{DD}}$ ) for approximately $1 / 4$ cycle just after the negative edge of ECLK, unless the external access is stretched and ECLK is free-running (ESTR bit in EBICTL = 0 ). See the MMC block description chapter for additional details on when this signal will be active. |
| $\begin{gathered} 6 \\ \text { Port K, Bit } 6 \end{gathered}$ | Port K, Bit 6 - This bit is used as an external chip select signal for most external accesses that are not selected by $\overline{\mathrm{ECS}}$ (see the MMC block description chapter for more details), depending upon the state the of the EMK bit in the MODE register. While this bit is used as a chip select, the external pin will return to its deasserted state ( $\mathrm{V}_{\mathrm{DD}}$ ) for approximately $1 / 4$ cycle just after the negative edge of ECLK, unless the external access is stretched and ECLK is free-running (ESTR bit in EBICTL $=0$ ). |
| $\begin{gathered} 5: 0 \\ \text { Port K, Bits 5:0 } \end{gathered}$ | Port K, Bits 5:0 - These six bits are used to determine which FLASH/ROM or external memory array page is being accessed. They can be viewed as expanded addresses XAB19-XAB14 of the 20-bit address used to access up to1M byte internal FLASH/ROM or external memory array. Alternatively, these bits can be used for general-purpose I/O depending upon the state of the EMK bit in the MODE register. |

### 18.3.2.16 Port K Data Direction Register (DDRK)



Figure 18-20. Port K Data Direction Register (DDRK)
Read: Anytime
Write: Anytime
This register determines the primary direction for each port K pin configured as general-purpose I/O. This register is not in the map in peripheral or expanded modes while the EMK control bit in MODE register is set. Therefore, these accesses will be echoed externally.

Table 18-14. EBICTL Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:0 | Data Direction Port K Bits <br> 0 Associated pin is a high-impedance input <br> 1 Associated pin is an output <br> Note: It is unwise to write PORTK and DDRK as a word access. If you are changing port K pins from inputs to <br> outputs, the data may have extra transitions during the write. It is best to initialize PORTK before enabling <br> as outputs. <br> Note: To ensure that you read the correct value from the PORTK pins, always wait at least one cycle after writing <br> to the DDRK register before reading from the PORTK register. |

### 18.4 Functional Description

### 18.4.1 Detecting Access Type from External Signals

The external signals $\overline{\mathrm{LSTRB}}, \mathrm{R} / \overline{\mathrm{W}}$, and AB0 indicate the type of bus access that is taking place. Accesses to the internal RAM module are the only type of access that would produce $\overline{\mathrm{LSTRB}}=\mathrm{AB} 0=1$, because the internal RAM is specifically designed to allow misaligned 16-bit accesses in a single cycle. In these cases the data for the address that was accessed is on the low half of the data bus and the data for address +1 is on the high half of the data bus. This is summarized in Table 18-15.

Table 18-15. Access Type vs. Bus Control Pins

| $\overline{\text { LSTRB }}$ | AB0 | $\mathbf{R} / \overline{\mathbf{W}}$ | Type of Access |
| :---: | :---: | :---: | :--- |
| 1 | 0 | 1 | 8-bit read of an even address |
| 0 | 1 | 1 | 8-bit read of an odd address |
| 1 | 0 | 0 | 8-bit write of an even address |
| 0 | 1 | 0 | 8-bit write of an odd address |
| 0 | 0 | 1 | 16-bit read of an even address |
| 1 | 1 | 1 | 16-bit read of an odd address <br> (low/high data swapped) |
| 0 | 0 | 0 | 16-bit write to an even address |
| 1 | 1 | 0 | 16-bit write to an odd address <br> (low/high data swapped) |

### 18.4.2 Stretched Bus Cycles

In order to allow fast internal bus cycles to coexist in a system with slower external memory resources, the HCS12 supports the concept of stretched bus cycles (module timing reference clocks for timers and baud rate generators are not affected by this stretching). Control bits in the MISC register in the MMC sub-block of the core specify the amount of stretch ( $0,1,2$, or 3 periods of the internal bus-rate clock). While stretching, the CPU state machines are all held in their current state. At this point in the CPU bus cycle, write data would already be driven onto the data bus so the length of time write data is valid is extended in the case of a stretched bus cycle. Read data would not be captured by the system until the E clock falling edge. In the case of a stretched bus cycle, read data is not required until the specified setup time before the falling edge of the stretched E clock. The chip selects, and $\mathrm{R} / \overline{\mathrm{W}}$ signals remain valid during the period of stretching (throughout the stretched E high time).

NOTE
The address portion of the bus cycle is not stretched.

### 18.4.3 Modes of Operation

The operating mode out of reset is determined by the states of the MODC, MODB, and MODA pins during reset (Table 18-16). The MODC, MODB, and MODA bits in the MODE register show the current operating mode and provide limited mode switching during operation. The states of the MODC, MODB, and MODA pins are latched into these bits on the rising edge of the reset signal.

Table 18-16. Mode Selection

| MODC | MODB | MODA | Mode Description |
| :---: | :---: | :---: | :--- |
| 0 | 0 | 0 | Special Single Chip, BDM allowed and ACTIVE. BDM is allowed in all <br> other modes but a serial command is required to make BDM active. |
| 0 | 0 | 1 | Emulation Expanded Narrow, BDM allowed |
| 0 | 1 | 0 | Special Test (Expanded Wide), BDM allowed |
| 0 | 1 | 1 | Emulation Expanded Wide, BDM allowed |
| 1 | 0 | 0 | Normal Single Chip, BDM allowed |
| 1 | 0 | 1 | Normal Expanded Narrow, BDM allowed |
| 1 | 1 | 0 | Peripheral; BDM allowed but bus operations would cause bus conflicts <br> (must not be used) |
| 1 | 1 | 1 | Normal Expanded Wide, BDM allowed |

There are two basic types of operating modes:

1. Normal modes: Some registers and bits are protected against accidental changes.
2. Special modes: Allow greater access to protected control registers and bits for special purposes such as testing.

A system development and debug feature, background debug mode (BDM), is available in all modes. In special single-chip mode, BDM is active immediately after reset.

Some aspects of Port E are not mode dependent. Bit 1 of Port E is a general purpose input or the $\overline{\mathrm{IRQ}}$ interrupt input. $\overline{\overline{I R Q}}$ can be enabled by bits in the CPU's condition codes register but it is inhibited at reset so this pin is initially configured as a simple input with a pull-up. Bit 0 of Port E is a general purpose input or the $\overline{\text { XIRQ }}$ interrupt input. $\overline{\text { XIRQ }}$ can be enabled by bits in the CPU's condition codes register but it is inhibited at reset so this pin is initially configured as a simple input with a pull-up. The ESTR bit in the EBICTL register is set to one by reset in any user mode. This assures that the reset vector can be fetched even if it is located in an external slow memory device. The PE6/MODB/IPIPE1 and PE5/MODA/IPIPE0 pins act as high-impedance mode select inputs during reset.

The following paragraphs discuss the default bus setup and describe which aspects of the bus can be changed after reset on a per mode basis.

### 18.4.3.1 Normal Operating Modes

These modes provide three operating configurations. Background debug is available in all three modes, but must first be enabled for some operations by means of a BDM background command, then activated.

### 18.4.3.1.1 Normal Single-Chip Mode

There is no external expansion bus in this mode. All pins of Ports A, B and E are configured as general purpose I/O pins Port E bits 1 and 0 are available as general purpose input only pins with internal pull resistors enabled. All other pins of Port E are bidirectional I/O pins that are initially configured as high-impedance inputs with internal pull resistors enabled. Ports A and B are configured as high-impedance inputs with their internal pull resistors disabled.

The pins associated with Port E bits 6, 5, 3, and 2 cannot be configured for their alternate functions IPIPE1, IPIPE0, $\overline{\mathrm{LSTRB}}$, and $\mathrm{R} / \overline{\mathrm{W}}$ while the MCU is in single chip modes. In single chip modes, the associated control bits PIPOE, LSTRE, and RDWE are reset to zero. Writing the opposite state into them in single chip mode does not change the operation of the associated Port E pins.
In normal single chip mode, the MODE register is writable one time. This allows a user program to change the bus mode to narrow or wide expanded mode and/or turn on visibility of internal accesses.

Port E, bit 4 can be configured for a free-running E clock output by clearing NECLK=0. Typically the only use for an E clock output while the MCU is in single chip modes would be to get a constant speed clock for use in the external application system.

### 18.4.3.1.2 Normal Expanded Wide Mode

In expanded wide modes, Ports A and B are configured as a 16-bit multiplexed address and data bus and Port E bit 4 is configured as the E clock output signal. These signals allow external memory and peripheral devices to be interfaced to the MCU.

Port E pins other than PE4/ECLK are configured as general purpose I/O pins (initially high-impedance inputs with internal pull resistors enabled). Control bits PIPOE, NECLK, LSTRE, and RDWE in the PEAR register can be used to configure Port E pins to act as bus control outputs instead of general purpose I/O pins.

It is possible to enable the pipe status signals on Port E bits 6 and 5 by setting the PIPOE bit in PEAR, but it would be unusual to do so in this mode. Development systems where pipe status signals are monitored would typically use the special variation of this mode.

The Port E bit 2 pin can be reconfigured as the $\mathrm{R} / \overline{\mathrm{W}}$ bus control signal by writing " 1 " to the RDWE bit in PEAR. If the expanded system includes external devices that can be written, such as RAM, the RDWE bit would need to be set before any attempt to write to an external location. If there are no writable resources in the external system, PE2 can be left as a general purpose I/O pin.
The Port E bit 3 pin can be reconfigured as the $\overline{\text { LSTRB }}$ bus control signal by writing " 1 " to the LSTRE bit in PEAR. The default condition of this pin is a general purpose input because the $\overline{\text { LSTRB }}$ function is not needed in all expanded wide applications.

The Port E bit 4 pin is initially configured as ECLK output with stretch. The E clock output function depends upon the settings of the NECLK bit in the PEAR register, the IVIS bit in the MODE register and the ESTR bit in the EBICTL register. The E clock is available for use in external select decode logic or as a constant speed clock for use in the external application system.

### 18.4.3.1.3 Normal Expanded Narrow Mode

This mode is used for lower cost production systems that use 8-bit wide external EPROMs or RAMs. Such systems take extra bus cycles to access 16 -bit locations but this may be preferred over the extra cost of additional external memory devices.

Ports A and B are configured as a 16-bit address bus and Port A is multiplexed with data. Internal visibility is not available in this mode because the internal cycles would need to be split into two 8-bit cycles.

Since the PEAR register can only be written one time in this mode, use care to set all bits to the desired states during the single allowed write.

The PE3//LSTRB pin is always a general purpose I/O pin in normal expanded narrow mode. Although it is possible to write the LSTRE bit in PEAR to " 1 " in this mode, the state of LSTRE is overridden and Port $E$ bit 3 cannot be reconfigured as the $\overline{\text { LSTRB }}$ output.

It is possible to enable the pipe status signals on Port E bits 6 and 5 by setting the PIPOE bit in PEAR, but it would be unusual to do so in this mode. LSTRB would also be needed to fully understand system activity. Development systems where pipe status signals are monitored would typically use special expanded wide mode or occasionally special expanded narrow mode.
The PE4/ECLK pin is initially configured as ECLK output with stretch. The E clock output function depends upon the settings of the NECLK bit in the PEAR register, the IVIS bit in the MODE register and the ESTR bit in the EBICTL register. In normal expanded narrow mode, the E clock is available for use in external select decode logic or as a constant speed clock for use in the external application system.

The PE2/R/W pin is initially configured as a general purpose input with an internal pull resistor enabled but this pin can be reconfigured as the $\mathrm{R} / \overline{\mathrm{W}}$ bus control signal by writing " 1 " to the RDWE bit in PEAR. If the expanded narrow system includes external devices that can be written such as RAM, the RDWE bit would need to be set before any attempt to write to an external location. If there are no writable resources in the external system, PE2 can be left as a general purpose I/O pin.

### 18.4.3.1.4 Emulation Expanded Wide Mode

In expanded wide modes, Ports A and B are configured as a 16-bit multiplexed address and data bus and Port E provides bus control and status signals. These signals allow external memory and peripheral devices to be interfaced to the MCU. These signals can also be used by a logic analyzer to monitor the progress of application programs.

The bus control related pins in Port E (PE7/NOACC, PE6/MODB/IPIPE1, PE5/MODA/IPIPE0, PE4/ECLK, PE3/ $\overline{\mathrm{LSTRB}} / \overline{\mathrm{TAGLO}}$, and PE2/R/ $/ \overline{\mathrm{W}}$ ) are all configured to serve their bus control output functions rather than general purpose I/O. Notice that writes to the bus control enable bits in the PEAR register in emulation mode are restricted.

### 18.4.3.1.5 Emulation Expanded Narrow Mode

Expanded narrow modes are intended to allow connection of single 8-bit external memory devices for lower cost systems that do not need the performance of a full 16-bit external data bus. Accesses to internal resources that have been mapped external (i.e. PORTA, PORTB, DDRA, DDRB, PORTE, DDRE, PEAR, PUCR, RDRIV) will be accessed with a 16-bit data bus on Ports A and B. Accesses of 16-bit external words to addresses which are normally mapped external will be broken into two separate 8 -bit accesses using Port A as an 8-bit data bus. Internal operations continue to use full 16-bit data paths. They are only visible externally as 16 -bit information if IVIS $=1$.

Ports A and B are configured as multiplexed address and data output ports. During external accesses, address A15, data D15 and D7 are associated with PA7, address A0 is associated with PB0 and data D8 and D0 are associated with PA0. During internal visible accesses and accesses to internal resources that have been mapped external, address A15 and data D15 is associated with PA7 and address A0 and data D0 is associated with PB0.

The bus control related pins in Port E (PE7/NOACC, PE6/MODB/IPIPE1, PE5/MODA/IPIPE0, PE4/ECLK, PE3/LSTRB/TAGLO, and PE2/R/ $\overline{\mathrm{W}}$ ) are all configured to serve their bus control output functions rather than general purpose I/O. Notice that writes to the bus control enable bits in the PEAR register in emulation mode are restricted.

The main difference between special modes and normal modes is that some of the bus control and system control signals cannot be written in emulation modes.

### 18.4.3.2 Special Operating Modes

There are two special operating modes that correspond to normal operating modes. These operating modes are commonly used in factory testing and system development.

### 18.4.3.2.1 Special Single-Chip Mode

When the MCU is reset in this mode, the background debug mode is enabled and active. The MCU does not fetch the reset vector and execute application code as it would in other modes. Instead the active background mode is in control of CPU execution and BDM firmware is waiting for additional serial commands through the BKGD pin. When a serial command instructs the MCU to return to normal execution, the system will be configured as described below unless the reset states of internal control registers have been changed through background commands after the MCU was reset.

There is no external expansion bus after reset in this mode. Ports A and B are initially simple bidirectional I/O pins that are configured as high-impedance inputs with internal pull resistors disabled; however, writing to the mode select bits in the MODE register (which is allowed in special modes) can change this after reset. All of the Port E pins (except PE4/ECLK) are initially configured as general purpose high-impedance inputs with internal pull resistors enabled. PE4/ECLK is configured as the E clock output in this mode.

The pins associated with Port E bits 6, 5, 3, and 2 cannot be configured for their alternate functions IPIPE1, IPIPE0, $\overline{\mathrm{LSTRB}}$, and $\mathrm{R} / \overline{\mathrm{W}}$ while the MCU is in single chip modes. In single chip modes, the associated
control bits PIPOE, LSTRE and RDWE are reset to zero. Writing the opposite value into these bits in single chip mode does not change the operation of the associated Port E pins.

Port E, bit 4 can be configured for a free-running E clock output by clearing NECLK=0. Typically the only use for an E clock output while the MCU is in single chip modes would be to get a constant speed clock for use in the external application system.

### 18.4.3.2.2 Special Test Mode

In expanded wide modes, Ports A and B are configured as a 16-bit multiplexed address and data bus and Port E provides bus control and status signals. In special test mode, the write protection of many control bits is lifted so that they can be thoroughly tested without needing to go through reset.

### 18.4.3.3 Test Operating Mode

There is a test operating mode in which an external master, such as an I.C. tester, can control the on-chip peripherals.

### 18.4.3.3.1 Peripheral Mode

This mode is intended for factory testing of the MCU. In this mode, the CPU is inactive and an external (tester) bus master drives address, data and bus control signals in through Ports A, B and E. In effect, the whole MCU acts as if it was a peripheral under control of an external CPU. This allows faster testing of on-chip memory and peripherals than previous testing methods. Since the mode control register is not accessible in peripheral mode, the only way to change to another mode is to reset the MCU into a different mode. Background debugging should not be used while the MCU is in special peripheral mode as internal bus conflicts between BDM and the external master can cause improper operation of both functions.

### 18.4.4 Internal Visibility

Internal visibility is available when the MCU is operating in expanded wide modes or emulation narrow mode. It is not available in single-chip, peripheral or normal expanded narrow modes. Internal visibility is enabled by setting the IVIS bit in the MODE register.

If an internal access is made while $\mathrm{E}, \mathrm{R} / \overline{\mathrm{W}}$, and $\overline{\mathrm{LSTRB}}$ are configured as bus control outputs and internal visibility is off (IVIS=0), E will remain low for the cycle, $\mathrm{R} / \overline{\mathrm{W}}$ will remain high, and address, data and the $\overline{\text { LSTRB }}$ pins will remain at their previous state.

When internal visibility is enabled (IVIS=1), certain internal cycles will be blocked from going external. During cycles when the BDM is selected, $\mathrm{R} / \overline{\mathrm{W}}$ will remain high, data will maintain its previous state, and address and $\overline{\text { LSTRB }}$ pins will be updated with the internal value. During CPU no access cycles when the BDM is not driving, $\mathrm{R} / \overline{\mathrm{W}}$ will remain high, and address, data and the $\overline{\mathrm{LSTRB}}$ pins will remain at their previous state.

## NOTE

When the system is operating in a secure mode, internal visibility is not available (i.e., IVIS $=1$ has no effect). Also, the IPIPE signals will not be visible, regardless of operating mode. IPIPE1-IPIPE0 will display 0es if they are enabled. In addition, the MOD bits in the MODE control register cannot be written.

### 18.4.5 Low-Power Options

The MEBI does not contain any user-controlled options for reducing power consumption. The operation of the MEBI in low-power modes is discussed in the following subsections.

### 18.4.5.1 Operation in Run Mode

The MEBI does not contain any options for reducing power in run mode; however, the external addresses are conditioned to reduce power in single-chip modes. Expanded bus modes will increase power consumption.

### 18.4.5.2 Operation in Wait Mode

The MEBI does not contain any options for reducing power in wait mode.

### 18.4.5.3 Operation in Stop Mode

The MEBI will cease to function after execution of a CPU STOP instruction.

## Chapter 19

 Module Mapping Control (MMCV4)
### 19.1 Introduction

This section describes the functionality of the module mapping control (MMC) sub-block of the S12 core platform.

The block diagram of the MMC is shown in Figure 19-1.


Figure 19-1. MMC Block Diagram
The MMC is the sub-module which controls memory map assignment and selection of internal resources and external space. Internal buses between the core and memories and between the core and peripherals is controlled in this module. The memory expansion is generated in this module.

### 19.1.1 Features

- Registers for mapping of address space for on-chip RAM, EEPROM, and FLASH (or ROM) memory blocks and associated registers
- Memory mapping control and selection based upon address decode and system operating mode
- Core address bus control
- Core data bus control and multiplexing
- Core security state decoding
- Emulation chip select signal generation ( $\overline{\mathrm{ECS}}$ )
- External chip select signal generation ( $\overline{\mathrm{XCS}})$
- Internal memory expansion
- External stretch and ROM mapping control functions via the MISC register
- Reserved registers for test purposes
- Configurable system memory options defined at integration of core into the system-on-a-chip (SoC).


### 19.1.2 Modes of Operation

Some of the registers operate differently depending on the mode of operation (i.e., normal expanded wide, special single chip, etc.). This is best understood from the register descriptions.

### 19.2 External Signal Description

All interfacing with the MMC sub-block is done within the core, it has no external signals.

### 19.3 Memory Map and Register Definition

A summary of the registers associated with the MMC sub-block is shown in Figure 19-2. Detailed descriptions of the registers and bits are given in the subsections that follow.

### 19.3.1 Module Memory Map

Table 19-1. MMC Memory Map

| Address <br> Offset | Register | Access |
| :---: | :--- | :---: |
|  | Initialization of Internal RAM Position Register (INITRM) | R/W |
|  | Initialization of Internal Registers Position Register (INITRG) | R/W |
|  | Initialization of Internal EEPROM Position Register (INITEE) | R/W |
|  | Miscellaneous System Control Register (MISC) | R/W |
|  | Reserved | - |
| $\cdot$ | $\cdot$ | - |

Table 19-1. MMC Memory Map (continued)

| Address <br> Offset | Register | Access |
| :---: | :--- | :---: |
|  | Reserved | - |
| $\cdot$ | $\cdot$ | - |
| $\cdot$ |  | $\cdot$ |
|  | Memory Size Register 0 (MEMSIZ0) | $R$ |
| $\cdot$ | Memory Size Register 1 (MEMSIZ1) | R |
|  |  | $\cdot$ |
|  | Program Page Index Register (PPAGE) | $\mathrm{R} / \mathrm{W}$ |
|  | Reserved | - |

### 19.3.2 Register Descriptions

| Name |  | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| INITRM |  | RAM15 | RAM14 | RAM13 | RAM12 | RAM11 | 0 | 0 | RAMHAL |
|  | W |  |  |  |  |  |  |  |  |
| INITRG | R | 0 | REG14 | REG13 | REG12 | REG11 | 0 | 0 | 0 |
|  | W |  |  |  |  |  |  |  |  |
| INITEE | R | EE15 | EE14 | EE13 | EE12 | EE11 | 0 | 0 | EEON |
|  | W |  |  |  |  |  |  |  |  |
| MISC | R | 0 | 0 | 0 | 0 | EXSTR1 | EXSTR0 | ROMHM | ROMON |
|  | W |  |  |  |  |  |  |  |  |
| MTSTO | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  |  |  |  |  |  |  |  |  |
| MTST1 | $\begin{gathered} \mathrm{R} \\ \mathrm{~W} \end{gathered}$ | Bit 7 | 6 | 5 | 4 | 3 | 2 | 1 | Bit 0 |
|  |  |  |  |  |  |  |  |  |  |
| MEMSIZO | R | REG_SW0 | 0 | EEP_SW1 | EEP_SW0 | 0 | RAM_SW2 | RAM_SW1 | RAM_SW0 |
|  | W |  |  |  |  |  |  |  |  |
| MEMSIZ1 | $R$$W$ | ROM_SW1 | ROM_SW0 | 0 | 0 | 0 | 0 | PAG_SW1 | PAG_SW0 |
|  |  |  |  |  |  |  |  |  |  |
| PPAGE | R | 0 | 0 | PIX5 | PIX4 | PIX3 | PIX2 | PIX1 | PIXO |
|  | W |  |  |  |  |  |  |  |  |
| Reserved | $R$$W$ | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
|  |  |  |  |  |  |  |  |  |  |
|  |  |  | = Unimplemented |  |  |  |  |  |  |

Figure 19-2. MMC Register Summary

### 19.3.2.1 Initialization of Internal RAM Position Register (INITRM)



Figure 19-3. Initialization of Internal RAM Position Register (INITRM)
Read: Anytime

Write: Once in normal and emulation modes, anytime in special modes

## NOTE

Writes to this register take one cycle to go into effect.
This register initializes the position of the internal RAM within the on-chip system memory map.
Table 19-2. INITRM Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 3$ | Internal RAM Map Position - These bits determine the upper five bits of the base address for the system's <br> RAM[15:11] |
| 0 | RAM High-Align - RAMHAL specifies the alignment of the internal RAM array. <br> 0 |
| RAMHAL Aligns the RAM to the lowest address (0x0000) of the mappable space |  |
| 1 | Aligns the RAM to the higher address (0xFFFF) of the mappable space |

### 19.3.2.2 Initialization of Internal Registers Position Register (INITRG)



Figure 19-4. Initialization of Internal Registers Position Register (INITRG)
Read: Anytime
Write: Once in normal and emulation modes and anytime in special modes
This register initializes the position of the internal registers within the on-chip system memory map. The registers occupy either a 1 K byte or 2 K byte space and can be mapped to any 2 K byte space within the first 32 K bytes of the system's address space.

Table 19-3. INITRG Field Descriptions

| Field | Description |
| :---: | :--- |
| $6: 3$ | Internal Register Map Position - These four bits in combination with the leading zero supplied by bit 7 of <br> REG[14:11] |
| INITRG determine the upper five bits of the base address for the system's internal registers (i.e., the minimum <br> base address is 0x0000 and the maximum is 0x7FFF). |  |

### 19.3.2.3 Initialization of Internal EEPROM Position Register (INITEE)



1. The reset state of this register is controlled at chip integration. Please refer to the device overview section to determine the actual reset state of this register.


Figure 19-5. Initialization of Internal EEPROM Position Register (INITEE)
Read: Anytime
Write: The EEON bit can be written to any time on all devices. Bits E[11:15] are "write anytime in all modes" on most devices. On some devices, bits $\mathrm{E}[11: 15]$ are "write once in normal and emulation modes and write anytime in special modes". See device overview chapter to determine the actual write access rights.

## NOTE

Writes to this register take one cycle to go into effect.
This register initializes the position of the internal EEPROM within the on-chip system memory map.
Table 19-4. INITEE Field Descriptions

| Field | Description |
| :---: | :--- |
| $7: 3$ | Internal EEPROM Map Position - These bits determine the upper five bits of the base address for the system's <br> EE[15:11] |
| 0 | Enable EEPROM - This bit is used to enable the EEPROM memory in the memory map. <br> 0 <br> EEON <br> 1 <br> Disables the EEPROM from the memory map. |

### 19.3.2.4 Miscellaneous System Control Register (MISC)



1. The reset state of this bit is determined at the chip integration level.


Figure 19-6. Miscellaneous System Control Register (MISC)
Read: Anytime
Write: As stated in each bit description
NOTE
Writes to this register take one cycle to go into effect.
This register initializes miscellaneous control functions.
Table 19-5. INITEE Field Descriptions

| Field | Description |
| :---: | :--- |
| $3: 2$ <br> EXSTR[1:0] | External Access Stretch Bits 1 and 0 <br> Write: once in normal and emulation modes and anytime in special modes <br> This two-bit field determines the amount of clock stretch on accesses to the external address space as shown in <br> Table 19-6. In single chip and peripheral modes these bits have no meaning or effect. |
| 1 | FLASH EEPROM or ROM Only in Second Half of Memory Map <br> Write: once in normal and emulation modes and anytime in special modes <br> 0 <br> The fixed page(s) of FLASH EEPROM or ROM in the lower half of the memory map can be accessed. <br> 1 <br> Disables direct access to the FLASH EEPROM or ROM in the lower half of the memory map. These physical <br> locations of the FLASH EEPROM or ROM remain accessible through the program page window. |
| 0 | ROMON - Enable FLASH EEPROM or ROM <br> Write: once in normal and emulation modes and anytime in special modes <br> This bit is used to enable the FLASH EEPROM or ROM memory in the memory map. <br> 0 Disables the FLASH EEPROM or ROM from the memory map. <br> 1 <br> Enables the FLASH EEPROM or ROM in the memory map. |

Table 19-6. External Stretch Bit Definition

| Stretch Bit EXSTR1 | Stretch Bit EXSTR0 | Number of E Clocks Stretched |
| :---: | :---: | :---: |
| 0 | 0 | 0 |
| 0 | 1 | 1 |
| 1 | 0 | 2 |
| 1 | 1 | 3 |

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### 19.3.2.5 Reserved Test Register 0 (MTSTO)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

Figure 19-7. Reserved Test Register 0 (MTSTO)
Read: Anytime
Write: No effect - this register location is used for internal test purposes.

### 19.3.2.6 Reserved Test Register 1 (MTST1)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| W |  |  |  |  |  |  |  |  |
| Reset | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0 |

Figure 19-8. Reserved Test Register 1 (MTST1)
Read: Anytime
Write: No effect - this register location is used for internal test purposes.

### 19.3.2.7 Memory Size Register 0 (MEMSIZO)



Figure 19-9. Memory Size Register 0 (MEMSIZO)
Read: Anytime
Write: Writes have no effect
Reset: Defined at chip integration, see device overview section.
The MEMSIZ0 register reflects the state of the register, EEPROM and RAM memory space configuration switches at the core boundary which are configured at system integration. This register allows read visibility to the state of these switches.

Table 19-7. MEMSIZO Field Descriptions

| Field | Description |
| :---: | :--- |
| 7 | Allocated System Register Space <br> 0 <br> REG_SW0 <br>  <br> 1 <br> Allocated system register space size is 1K byte |
| $5: 4$ | Allocated System EEPROM Memory Space - The allocated system EEPROM memory space size is as <br> given in Table 19-8. |
| EEP_SW[1:0] | Allocated System RAM Memory Space - The allocated system RAM memory space size is as given in <br> Table 19-9. |
| RAM_SW[2:0] |  |

Table 19-8. Allocated EEPROM Memory Space

| eep_sw1:eep_sw0 | Allocated EEPROM Space |
| :---: | :---: |
| 00 | 0 K byte |
| 01 | 2 K bytes |
| 10 | 4 K bytes |
| 11 | 8 K bytes |

Table 19-9. Allocated RAM Memory Space

| ram_sw2:ram_sw0 | Allocated <br> RAM Space | RAM <br> Mappable Region | INITRM <br> Bits Used | RAM Reset <br> Base Address ${ }^{\mathbf{1}}$ |
| :---: | :---: | :---: | :---: | :---: |
| 000 | 2 K bytes | 2 K bytes | RAM[15:11] | $0 \times 0800$ |
| 001 | 4 K bytes | 4 K bytes | RAM[15:12] | $0 \times 0000$ |
| 010 | 6 K bytes | $8{\mathrm{~K} \text { bytes }{ }^{2}}^{\text {RAM[15:13] }}$ | $0 \times 0800$ |  |
| 011 | 8 K bytes | 8 K bytes | RAM[15:13] | $0 \times 0000$ |
| 100 | 10 K bytes | 16 K bytes $^{2}$ | RAM[15:14] | $0 \times 1800$ |

Table 19-9. Allocated RAM Memory Space (continued)

| ram_sw2:ram_sw0 | Allocated <br> RAM Space | RAM <br> Mappable Region | INITRM <br> Bits Used | RAM Reset <br> Base Address ${ }^{\mathbf{1}}$ |
| :---: | :---: | :---: | :---: | :---: |
| 101 | 12 K bytes | 16 K bytes $^{2}$ | RAM[15:14] | $0 \times 1000$ |
| 110 | 14 K bytes | 16 K bytes $^{2}$ | RAM[15:14] | $0 \times 0800$ |
| 111 | 16 K bytes | 16 K bytes | RAM[15:14] | $0 \times 0000$ |

1 The RAM Reset BASE Address is based on the reset value of the INITRM register, 0x0009.
2 Alignment of the Allocated RAM space within the RAM mappable region is dependent on the value of RAMHAL.

## NOTE

As stated, the bits in this register provide read visibility to the system physical memory space allocations defined at system integration. The actual array size for any given type of memory block may differ from the allocated size. Please refer to the device overview chapter for actual sizes.

### 19.3.2.8 Memory Size Register 1 (MEMSIZ1)



Figure 19-10. Memory Size Register 1 (MEMSIZ1)
Read: Anytime
Write: Writes have no effect
Reset: Defined at chip integration, see device overview section.
The MEMSIZ1 register reflects the state of the FLASH or ROM physical memory space and paging switches at the core boundary which are configured at system integration. This register allows read visibility to the state of these switches.

Table 19-10. MEMSIZO Field Descriptions

| Field | Description |
| :---: | :--- |
| 7:6 | Allocated System FLASH or ROM Physical Memory Space - The allocated system FLASH or ROM <br> ROM_SW[1:0] <br> physical memory space is as given in Table 19-11. |
| 1:0 | Allocated Off-Chip FLASH or ROM Memory Space - The allocated off-chip FLASH or ROM memory space <br> size is as given in Table 19-12. |
| PAG_SW[1:0] |  |

Table 19-11. Allocated FLASH/ROM Physical Memory Space

| rom_sw1:rom_sw0 | Allocated FLASH <br> or ROM Space |
| :---: | :---: |
| 00 | OK byte |
| 01 | 16 K bytes |
| 10 | $48 \mathrm{~K} \mathrm{bytes}^{(1)}$ |
| 11 | $64 \mathrm{~K} \mathrm{bytes}^{(1)}$ |

NOTES:

1. The ROMHM software bit in the MISC register determines the accessibility of the FLASH/ROM memory space. Please refer to Section 19.3.2.8, "Memory Size Register 1 (MEMSIZ1)," for a detailed functional description of the ROMHM bit.

Table 19-12. Allocated Off-Chip Memory Options

| pag_sw1:pag_sw0 | Off-Chip Space | On-Chip Space |
| :---: | :---: | :---: |
| 00 | 876 K bytes | 128 K bytes |
| 01 | 768 K bytes | 256 K bytes |
| 10 | 512 K bytes | 512 K bytes |
| 11 | 0 K byte | 1 M byte |

NOTE
As stated, the bits in this register provide read visibility to the system memory space and on-chip/off-chip partitioning allocations defined at system integration. The actual array size for any given type of memory block may differ from the allocated size. Please refer to the device overview chapter for actual sizes.

### 19.3.2.9 Program Page Index Register (PPAGE)

|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| R | 0 | 0 | PIX5 | PIX4 | PIX3 | PIX2 | PIX1 | PIXO |
| W |  |  |  |  |  |  |  |  |
| Reset ${ }^{1}$ | - | - | - | - | - | - | - | - |

1. The reset state of this register is controlled at chip integration. Please refer to the device overview section to determine the actual reset state of this register.


Figure 19-11. Program Page Index Register (PPAGE)
Read: Anytime
Write: Determined at chip integration. Generally it's: "write anytime in all modes;" on some devices it will be: "write only in special modes." Check specific device documentation to determine which applies.

Reset: Defined at chip integration as either 0x00 (paired with write in any mode) or 0x3C (paired with write only in special modes), see device overview chapter.

The HCS12 core architecture limits the physical address space available to 64 K bytes. The program page index register allows for integrating up to 1 M byte of FLASH or ROM into the system by using the six page index bits to page 16 K byte blocks into the program page window located from $0 x 8000$ to 0 xBFFF as defined in Table 19-14. CALL and RTC instructions have special access to read and write this register without using the address bus.

## NOTE

Normal writes to this register take one cycle to go into effect. Writes to this register using the special access of the CALL and RTC instructions will be complete before the end of the associated instruction.

Table 19-13. MEMSIZO Field Descriptions

| Field | Description |
| :---: | :--- |
| 5:0 | Program Page Index Bits 5:0 - These page index bits are used to select which of the 64 FLASH or ROM |
| PIX[5:0] | array pages is to be accessed in the program page window as shown in Table 19-14. |

Table 19-14. Program Page Index Register Bits

| PIX5 | PIX4 | PIX3 | PIX2 | PIX1 | PIX0 | Program Space <br> Selected |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 0 | 0 | 0 | 0 | 16K page 0 |
| 0 | 0 | 0 | 0 | 0 | 1 | 16 K page 1 |
| 0 | 0 | 0 | 0 | 1 | 0 | 16 K page 2 |
| 0 | 0 | 0 | 0 | 1 | 1 | 16 K page 3 |
| . | . | $\cdot$ | . | . | $\cdot$ | $\cdot$ |
| $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ |
| $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ |
| $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ | $\cdot$ |
| 1 | 1 | 1 | 1 | 0 | 0 | 16 K page 60 |
| 1 | 1 | 1 | 1 | 0 | 1 | 16K page 61 |
| 1 | 1 | 1 | 1 | 1 | 0 | 16K page 62 |
| 1 | 1 | 1 | 1 | 1 | 1 | 16K page 63 |

### 19.4 Functional Description

The MMC sub-block performs four basic functions of the core operation: bus control, address decoding and select signal generation, memory expansion, and security decoding for the system. Each aspect is described in the following subsections.

### 19.4.1 Bus Control

The MMC controls the address bus and data buses that interface the core with the rest of the system. This includes the multiplexing of the input data buses to the core onto the main CPU read data bus and control
of data flow from the CPU to the output address and data buses of the core. In addition, the MMC manages all CPU read data bus swapping operations.

### 19.4.2 Address Decoding

As data flows on the core address bus, the MMC decodes the address information, determines whether the internal core register or firmware space, the peripheral space or a memory register or array space is being addressed and generates the correct select signal. This decoding operation also interprets the mode of operation of the system and the state of the mapping control registers in order to generate the proper select. The MMC also generates two external chip select signals, emulation chip select ( $\overline{\mathrm{ECS}}$ ) and external chip select $(\overline{\mathrm{XCS}})$.

### 19.4.2.1 Select Priority and Mode Considerations

Although internal resources such as control registers and on-chip memory have default addresses, each can be relocated by changing the default values in control registers. Normally, I/O addresses, control registers, vector spaces, expansion windows, and on-chip memory are mapped so that their address ranges do not overlap. The MMC will make only one select signal active at any given time. This activation is based upon the priority outlined in Table 19-15. If two or more blocks share the same address space, only the select signal for the block with the highest priority will become active. An example of this is if the registers and the RAM are mapped to the same space, the registers will have priority over the RAM and the portion of RAM mapped in this shared space will not be accessible. The expansion windows have the lowest priority. This means that registers, vectors, and on-chip memory are always visible to a program regardless of the values in the page select registers.

Table 19-15. Select Signal Priority

| Priority | Address Space |
| :---: | :---: |
| Highest | BDM (internal to core) firmware or register space |
| $\ldots$ | Internal register space |
| $\ldots$ | RAM memory block |
| $\ldots$ | EEPROM memory block |
| $\ldots$ | On-chip FLASH or ROM |
| Lowest | Remaining external space |

In expanded modes, all address space not used by internal resources is by default external memory space. The data registers and data direction registers for ports A and B are removed from the on-chip memory map and become external accesses. If the EME bit in the MODE register (see MEBI block description chapter) is set, the data and data direction registers for port E are also removed from the on-chip memory map and become external accesses.

In special peripheral mode, the first 16 registers associated with bus expansion are removed from the on-chip memory map (PORTA, PORTB, DDRA, DDRB, PORTE, DDRE, PEAR, MODE, PUCR, RDRIV, and the EBI reserved registers).

In emulation modes, if the EMK bit in the MODE register (see MEBI block description chapter) is set, the data and data direction registers for port K are removed from the on-chip memory map and become external accesses.

### 19.4.2.2 Emulation Chip Select Signal

When the EMK bit in the MODE register (see MEBI block description chapter) is set, port K bit 7 is used as an active-low emulation chip select signal, $\overline{\mathrm{ECS}}$. This signal is active when the system is in emulation mode, the EMK bit is set and the FLASH or ROM space is being addressed subject to the conditions outlined in Section 19.4.3.2, "Extended Address (XAB19:14) and ECS Signal Functionality." When the EMK bit is clear, this pin is used for general purpose I/O.

### 19.4.2.3 External Chip Select Signal

When the EMK bit in the MODE register (see MEBI block description chapter) is set, port K bit 6 is used as an active-low external chip select signal, $\overline{\mathrm{XCS}}$. This signal is active only when the $\overline{\mathrm{ECS}}$ signal described above is not active and when the system is addressing the external address space. Accesses to unimplemented locations within the register space or to locations that are removed from the map (i.e., ports A and B in expanded modes) will not cause this signal to become active. When the EMK bit is clear, this pin is used for general purpose I/O.

### 19.4.3 Memory Expansion

The HCS12 core architecture limits the physical address space available to 64 K bytes. The program page index register allows for integrating up to 1 M byte of FLASH or ROM into the system by using the six page index bits to page 16 K byte blocks into the program page window located from 0 x 8000 to 0 xBFFF in the physical memory space. The paged memory space can consist of solely on-chip memory or a combination of on-chip and off-chip memory. This partitioning is configured at system integration through the use of the paging configuration switches (pag_swl:pag_sw0) at the core boundary. The options available to the integrator are as given in Table 19-16 (this table matches Table 19-12 but is repeated here for easy reference).

Table 19-16. Allocated Off-Chip Memory Options

| pag_sw1:pag_sw0 | Off-Chip Space | On-Chip Space |
| :---: | :---: | :---: |
| 00 | 876 K bytes | 128 K bytes |
| 01 | 768 K bytes | 256 K bytes |
| 10 | 512 K bytes | 512 K bytes |
| 11 | 0 K byte | 1 M byte |

Based upon the system configuration, the program page window will consider its access to be either internal or external as defined in Table 19-17.

Table 19-17. External/Internal Page Window Access

| pag_sw1:pag_sw0 | Partitioning | PIX5:0 Value | Page Window Access |
| :---: | :---: | :---: | :---: |
| 00 | 876K off-Chip, 128K on-Chip | 0x0000-0x0037 | External |
|  |  | 0x0038-0x003F | Internal |
| 01 | 768K off-chip, 256K on-chip | 0x0000-0x002F | External |
|  |  | 0x0030-0x003F | Internal |
| 10 | 512K off-chip, 512K on-chip | 0x0000-0x001F | External |
|  |  | 0x0020-0x003F | Internal |
| 11 | OK off-chip, 1M on-chip | N/A | External |
|  |  | 0x0000-0x003F | Internal |

## NOTE

The partitioning as defined in Table 19-17 applies only to the allocated memory space and the actual on-chip memory sizes implemented in the system may differ. Please refer to the device overview chapter for actual sizes.

The PPAGE register holds the page select value for the program page window. The value of the PPAGE register can be manipulated by normal read and write (some devices don't allow writes in some modes) instructions as well as the CALL and RTC instructions.

Control registers, vector spaces, and a portion of on-chip memory are located in unpaged portions of the 64 K byte physical address space. The stack and I/O addresses should also be in unpaged memory to make them accessible from any page.

The starting address of a service routine must be located in unpaged memory because the 16-bit exception vectors cannot point to addresses in paged memory. However, a service routine can call other routines that are in paged memory. The upper 16 K byte block of memory space $(0 \mathrm{xC} 000-0 \mathrm{xFFFF})$ is unpaged. It is recommended that all reset and interrupt vectors point to locations in this area.

### 19.4.3.1 CALL and Return from Call Instructions

CALL and RTC are uninterruptable instructions that automate page switching in the program expansion window. CALL is similar to a JSR instruction, but the subroutine that is called can be located anywhere in the normal 64 K byte address space or on any page of program expansion memory. CALL calculates and stacks a return address, stacks the current PPAGE value, and writes a new instruction-supplied value to PPAGE. The PPAGE value controls which of the 64 possible pages is visible through the 16 K byte expansion window in the 64 K byte memory map. Execution then begins at the address of the called subroutine.

During the execution of a CALL instruction, the CPU:

- Writes the old PPAGE value into an internal temporary register and writes the new instruction-supplied PPAGE value into the PPAGE register.
- Calculates the address of the next instruction after the CALL instruction (the return address), and pushes this 16-bit value onto the stack.
- Pushes the old PPAGE value onto the stack.
- Calculates the effective address of the subroutine, refills the queue, and begins execution at the new address on the selected page of the expansion window.

This sequence is uninterruptable; there is no need to inhibit interrupts during CALL execution. A CALL can be performed from any address in memory to any other address.

The PPAGE value supplied by the instruction is part of the effective address. For all addressing mode variations except indexed-indirect modes, the new page value is provided by an immediate operand in the instruction. In indexed-indirect variations of CALL, a pointer specifies memory locations where the new page value and the address of the called subroutine are stored. Using indirect addressing for both the new page value and the address within the page allows values calculated at run time rather than immediate values that must be known at the time of assembly.

The RTC instruction terminates subroutines invoked by a CALL instruction. RTC unstacks the PPAGE value and the return address and refills the queue. Execution resumes with the next instruction after the CALL.

During the execution of an RTC instruction, the CPU:

- Pulls the old PPAGE value from the stack
- Pulls the 16-bit return address from the stack and loads it into the PC
- Writes the old PPAGE value into the PPAGE register
- Refills the queue and resumes execution at the return address

This sequence is uninterruptable; an RTC can be executed from anywhere in memory, even from a different page of extended memory in the expansion window.

The CALL and RTC instructions behave like JSR and RTS, except they use more execution cycles. Therefore, routinely substituting CALL/RTC for JSR/RTS is not recommended. JSR and RTS can be used to access subroutines that are on the same page in expanded memory. However, a subroutine in expanded memory that can be called from other pages must be terminated with an RTC. And the RTC unstacks a PPAGE value. So any access to the subroutine, even from the same page, must use a CALL instruction so that the correct PPAGE value is in the stack.

### 19.4.3.2 Extended Address (XAB19:14) and ECS Signal Functionality

If the EMK bit in the MODE register is set (see MEBI block description chapter) the PIX5:0 values will be output on XAB19:14 respectively (port K bits $5: 0$ ) when the system is addressing within the physical program page window address space ( $0 \times 8000-0 \mathrm{xBFFF}$ ) and is in an expanded mode. When addressing anywhere else within the physical address space (outside of the paging space), the XAB19:14 signals will be assigned a constant value based upon the physical address space selected. In addition, the active-low emulation chip select signal, $\overline{\mathrm{ECS}}$, will likewise function based upon the assigned memory allocation. In the cases of 48 K byte and 64 K byte allocated physical FLASH/ROM space, the operation of the $\overline{\mathrm{ECS}}$ signal will additionally depend upon the state of the ROMHM bit (see Section 19.3.2.4, "Miscellaneous System Control Register (MISC)") in the MISC register. Table 19-18, Table 19-19, Table 19-20, and

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Table 19-21 summarize the functionality of these signals based upon the allocated memory configuration. Again, this signal information is only available externally when the EMK bit is set and the system is in an expanded mode.

Table 19-18. OK Byte Physical FLASH/ROM Allocated

| Address Space | Page Window Access | ROMHM | ECS | XAB19:14 |
| :---: | :---: | :---: | :---: | :---: |
| $0 \times 0000-0 \times 3 F F F$ | N/A | N/A | 1 | $0 \times 3 \mathrm{D}$ |
| $0 \times 4000-0 \times 7 F F F$ | N/A | N/A | 1 | $0 \times 3 \mathrm{E}$ |
| $0 \times 8000-0 \times B F F F$ | $\mathrm{~N} / \mathrm{A}$ | $\mathrm{N} / \mathrm{A}$ | 0 | PIX[5:0] |
| $0 \times \mathrm{C} 000-0 \times F F F F$ | $\mathrm{~N} / \mathrm{A}$ | $\mathrm{N} / \mathrm{A}$ | 0 | $0 \times 3 \mathrm{~F}$ |

Table 19-19. 16K Byte Physical FLASH/ROM Allocated

| Address Space | Page Window Access | ROMHM | ECS | XAB19:14 |
| :---: | :---: | :---: | :---: | :---: |
| $0 \times 0000-0 \times 3 F F F$ | N/A | N/A | 1 | $0 \times 3 \mathrm{D}$ |
| $0 \times 4000-0 \times 7 F F F$ | N/A | N/A | 1 | $0 \times 3 \mathrm{E}$ |
| $0 \times 8000-0 \times B F F F$ | N/A | N/A | 1 | PIX[5:0] |
| $0 \times C 000-0 \times F F F F$ | N/A | N/A | 0 | $0 \times 3 F$ |

Table 19-20. 48K Byte Physical FLASH/ROM Allocated

| Address Space | Page Window Access | ROMHM | ECS | XAB19:14 |
| :---: | :---: | :---: | :---: | :---: |
| $0 \times 0000-0 \times 3 F F F$ | $\mathrm{~N} / \mathrm{A}$ | $\mathrm{N} / \mathrm{A}$ | 1 | $0 \times 3 \mathrm{D}$ |
| $0 \times 4000-0 \times 7 \mathrm{FFF}$ | $\mathrm{N} / \mathrm{A}$ | 0 | 0 | $0 \times 3 \mathrm{E}$ |
|  | $\mathrm{N} / \mathrm{A}$ | 1 | 1 |  |
| $0 \times 8000-0 \times B F F F$ | External | $\mathrm{N} / \mathrm{A}$ | 1 | $\mathrm{PIX}[5: 0]$ |
|  | Internal | $\mathrm{N} / \mathrm{A}$ | 0 |  |
| $0 \times \mathrm{C} 000-0 \times F F F F$ | $\mathrm{~N} / \mathrm{A}$ | $\mathrm{N} / \mathrm{A}$ | 0 | $0 \times 3 \mathrm{~F}$ |

Table 19-21. 64K Byte Physical FLASH/ROM Allocated

| Address Space | Page Window Access | ROMHM | ECS | XAB19:14 |
| :---: | :---: | :---: | :---: | :---: |
| $0 \times 0000-0 \times 3 F F F$ | $\mathrm{~N} / \mathrm{A}$ | 0 | 0 | $0 \times 3 \mathrm{D}$ |
|  | $\mathrm{N} / \mathrm{A}$ | 1 | 1 |  |
| $0 \times 4000-0 \times 7 F F F$ | $\mathrm{~N} / \mathrm{A}$ | 0 | 0 | $0 \times 3 \mathrm{E}$ |
|  | $\mathrm{N} / \mathrm{A}$ | 1 | 1 |  |
| $0 \times 8000-0 \times B F F F$ | External | $\mathrm{N} / \mathrm{A}$ | 1 | $\mathrm{PIX}[5: 0]$ |
|  | Internal | $\mathrm{N} / \mathrm{A}$ | 0 |  |
| $0 \times C 000-0 x F F F F$ | $\mathrm{~N} / \mathrm{A}$ | $\mathrm{N} / \mathrm{A}$ | 0 | $0 \times 3 \mathrm{~F}$ |

A graphical example of a memory paging for a system configured as 1 M byte on-chip FLASH/ROM with 64 K allocated physical space is given in Figure 19-12.


Figure 19-12. Memory Paging Example: 1M Byte On-Chip FLASH/ROM, 64K Allocation

Chapter 19 Module Mapping Control (MMCV4)

## Appendix A <br> Electrical Characteristics

## A. 1 General

## NOTE

The electrical characteristics given in this section are preliminary and should be used as a guide only. Values cannot be guaranteed by Freescale and are subject to change without notice.

The part is specified and tested over the 5 V and 3.3 V ranges. For the intermediate range, generally the electrical specifications for the 3.3 V range apply, but the part is not tested in production test in the intermediate range.

This supplement contains the most accurate electrical information for the MC9S12E128 microcontroller available at the time of publication. The information should be considered PRELIMINARY and is subject to change.

This introduction is intended to give an overview on several common topics like power supply, current injection etc.

## A.1.1 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding the following classification is used and the parameters are tagged accordingly in the tables where appropriate.

## NOTE

This classification will be added at a later release of the specification
P: Those parameters are guaranteed during production testing on each individual device.
C: Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations. They are regularly verified by production monitors.

T: Those parameters are achieved by design characterization on a small sample size from typical devices. All values shown in the typical column are within this category.

D: Those parameters are derived mainly from simulations.

## A.1.2 Power Supply

The MC9S12E-Family utilizes several pins to supply power to the I/O ports, A/D converter, oscillator, PLL and internal logic.

The VDDA, VSSA pair supplies the A/D converter and D/A converter.
The VDDX, VSSX pair supplies the I/O pins
The VDDR, VSSR pair supplies the internal voltage regulator.

VDD1, VSS1, VDD2 and VSS2 are the supply pins for the internal logic.
VDDPLL, VSSPLL supply the oscillator and the PLL.
VSS1 and VSS2 are internally connected by metal.
VDD1 and VDD2 are internally connected by metal.
VDDA, VDDX, VDDR as well as VSSA, VSSX, VSSR are connected by anti-parallel diodes for ESD protection.

## NOTE

In the following context VDD5 is used for either VDDA, VDDR and VDDX; VSS5 is used for either VSSA, VSSR and VSSX unless otherwise noted.

IDD5 denotes the sum of the currents flowing into the VDDA, VDDX and VDDR pins.

VDD is used for VDD1, VDD2 and VDDPLL, VSS is used for VSS1, VSS2 and VSSPLL.

IDD is used for the sum of the currents flowing into VDD1 and VDD2.

## A.1.3 Pins

There are four groups of functional pins.

## A.1.3.1 3.3V/5V I/O Pins

Those I/O pins have a nominal level of 3.3 V or 5 V depending on the application operating point. This group of pins is comprised of all port I/O pins, the analog inputs, BKGD pin and the RESET inputs.The internal structure of all those pins is identical, however some of the functionality may be disabled.

## A.1.3.2 Analog Reference

This group of pins is comprised of the VRH and VRL pins.

## A.1.3.3 Oscillator

The pins XFC, EXTAL, XTAL dedicated to the oscillator have a nominal 2.5 V level. They are supplied by VDDPLL.

## A.1.3.4 TEST

This pin is used for production testing only.

## A.1.4 Current Injection

Power supply must maintain regulation within operating $\mathrm{V}_{\mathrm{DD} 5}$ or $\mathrm{V}_{\mathrm{DD}}$ range during instantaneous and operating maximum current conditions. If positive injection current $\left(\mathrm{V}_{\mathrm{in}}>\mathrm{V}_{\mathrm{DD} 5}\right)$ is greater than $\mathrm{I}_{\mathrm{DD} 5}$, the
injection current may flow out of VDD5 and could result in external power supply going out of regulation. Insure external VDD5 load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power; e.g. if no system clock is present, or if clock rate is very low which would reduce overall power consumption.

## A.1.5 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only. A functional operation under or outside those maxima is not guaranteed. Stress beyond those limits may affect the reliability or cause permanent damage of the device.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either $\mathrm{V}_{\mathrm{SS} 5}$ or $\mathrm{V}_{\mathrm{DD} 5}$ ).

Table A-1. Absolute Maximum Ratings

| Num | Rating | Symbol | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | I/O, Regulator and Analog Supply Voltage | $\mathrm{V}_{\text {DD5 }}$ | -0.3 | 6.5 | V |
| 2 | Internal Logic Supply Voltage ${ }^{1}$ | $\mathrm{V}_{\mathrm{DD}}$ | -0.3 | 3.0 | V |
| 3 | PLL Supply Voltage ${ }^{1}$ | $\mathrm{V}_{\text {DDPLL }}$ | -0.3 | 3.0 | V |
| 4 | Voltage difference VDDX to VDDR and VDDA | $\Delta_{\text {VDDX }}$ | -0.3 | 0.3 | V |
| 5 | Voltage difference VSSX to VSSR and VSSA | $\Delta_{\text {VSSX }}$ | -0.3 | 0.3 | V |
| 6 | Digital I/O Input Voltage | $\mathrm{V}_{\text {IN }}$ | -0.3 | 6.5 | V |
| 7 | Analog Reference | $\mathrm{V}_{\mathrm{RH},} \mathrm{V}_{\mathrm{RL}}$ | -0.3 | 6.5 | V |
| 8 | XFC, EXTAL, XTAL inputs | $\mathrm{V}_{\text {ILV }}$ | -0.3 | 3.0 | V |
| 9 | TEST input | $\mathrm{V}_{\text {TEST }}$ | -0.3 | 10.0 | V |
| 10 | Instantaneous Maximum Current Single pin limit for all digital I/O pins ${ }^{2}$ | ID | -25 | +25 | mA |
| 11 | Instantaneous Maximum Current Single pin limit for XFC, EXTAL, XTAL ${ }^{3}$ | $\mathrm{I}_{\mathrm{DL}}$ | -25 | +25 | mA |
| 12 | Instantaneous Maximum Current Single pin limit for TEST ${ }^{4}$ | ${ }^{\text {DT }}$ | -0.25 | 0 | mA |
| 13 | Operating Temperature Range (packaged) | $\mathrm{T}_{\text {A }}$ | -40 | 125 | ${ }^{\circ} \mathrm{C}$ |
| 14 | Operating Temperature Range (junction) | $\mathrm{T}_{\mathrm{J}}$ | -40 | 140 | ${ }^{\circ} \mathrm{C}$ |
| 15 | Storage Temperature Range | $\mathrm{T}_{\mathrm{stg}}$ | -65 | 155 | ${ }^{\circ} \mathrm{C}$ |

[^10]
## A.1.6 ESD Protection and Latch-up Immunity

All ESD testing is in conformity with CDF-AEC-Q100 Stress test qualification for Automotive Grade Integrated Circuits. During the device qualification ESD stresses were performed for the Human Body Model (HBM), the Machine Model (MM) and the Charge Device Model.

A device will be defined as a failure if after exposure to ESD pulses the device no longer meets the device specification. Complete DC parametric and functional testing is performed per the applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

Table A-2. ESD and Latch-up Test Conditions

| Model | Description | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: | :---: |
| Human Body | Series Resistance | R1 | 1500 | Ohm |
|  | Storage Capacitance | C | 100 | pF |
|  | Number of Pulse per pin positive negative | - | $\begin{aligned} & - \\ & 3 \\ & 3 \end{aligned}$ |  |
| Machine | Series Resistance | R1 | 0 | Ohm |
|  | Storage Capacitance | C | 200 | pF |
|  | Number of Pulse per pin positive negative | - | $\begin{aligned} & 3 \\ & 3 \end{aligned}$ |  |
| Latch-up | Minimum input voltage limit | - | -2.5 | V |
|  | Maximum input voltage limit | - | 7.5 | V |

Table A-3. ESD and Latch-Up Protection Characteristics

| Num | C | Rating | Symbol | Min | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: |
| 1 | C | Human Body Model (HBM) | $\mathrm{V}_{\text {HBM }}$ | 2000 | - | V |
| 2 | C | Machine Model (MM) | $\mathrm{V}_{\text {MM }}$ | 200 | - | V |
| 3 | C | Charge Device Model (CDM) | $\mathrm{V}_{\text {CDM }}$ | 500 | - | V |
| 4 | C | Latch-up Current at $125^{\circ} \mathrm{C}$ <br> positive <br> negative | $\mathrm{I}_{\text {LAT }}$ | +100 | - | mA |
| 5 | C | Latch-up Current at $27^{\circ} \mathrm{C}$ <br> positive <br> negative | -100 | - | mA |  |

## A.1.7 Operating Conditions

This chapter describes the operating conditions of the device. Unless otherwise noted those conditions apply to all the following data.

## NOTE

Instead of specifying ambient temperature all parameters are specified for the more meaningful silicon junction temperature. For power dissipation calculations refer to Section A.1.8, "Power Dissipation and Thermal Characteristics".

Table A-4. Operating Conditions

| Rating | Symbol | Min | Typ | Max | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: |
| I/O, Regulator and Analog Supply Voltage | $\mathrm{V}_{\text {DD5 }}$ | 2.97 | $3.3 / 5$ | 5.5 | V |
| Internal Logic Supply Voltage $^{1}$ | $\mathrm{~V}_{\mathrm{DD}}$ | 2.35 | 2.5 | 2.75 | V |
| PLL Supply Voltage $^{1}$ | $\mathrm{~V}_{\text {DDPLL }}$ | 2.35 | 2.5 | 2.75 | V |
| Voltage Difference VDDX to VDDA $^{\text {Voltage Difference VSSX to VSSR and VSSA }} \quad \Delta_{\text {VDDX }}$ | -0.1 | 0 | 0.1 | V |  |
| Oscillator | $\Delta_{\text {VSSX }}$ | -0.1 | 0 | 0.1 | V |
| Bus Frequency ${ }^{2}$ | $\mathrm{f}_{\text {osc }}$ | 0.5 | - | 16 | MHz |
| Operating Junction Temperature Range | $\mathrm{f}_{\text {bus }}$ | 0.25 | - | 25 | MHz |

1 The device contains an internal voltage regulator to generate the logic and PLL supply out of the I/O supply. The given operating range applies when this regulator is disabled and the device is powered from an external source.
2 Some blocks e.g. ATD (conversion) and NVMs (program/erase) require higher bus frequencies for proper operation.

## A.1.8 Power Dissipation and Thermal Characteristics

Power dissipation and thermal characteristics are closely related. The user must assure that the maximum operating junction temperature is not exceeded. The average chip-junction temperature $\left(\mathrm{T}_{\mathrm{J}}\right)$ in ${ }^{\circ} \mathrm{C}$ can be obtained from:

$$
\begin{aligned}
& T_{J}=T_{A}+\left(P_{D} \bullet \Theta_{J A}\right) \\
& T_{J}=\text { Junction Temperature, }\left[{ }^{\circ} \mathrm{C}\right] \\
& T_{A}=\text { Ambient Temperature, }\left[{ }^{\circ} \mathrm{C}\right] \\
& P_{D}=\text { Total Chip Power Dissipation, }[\mathrm{W}] \\
& \Theta_{\mathrm{JA}}=\text { Package Thermal Resistance, }\left[{ }^{\circ} \mathrm{C} / \mathrm{W}\right]
\end{aligned}
$$

The total power dissipation can be calculated from:

$$
\begin{aligned}
& P_{\mathrm{D}}=P_{\mathrm{INT}}+\mathrm{P}_{\mathrm{IO}} \\
& \mathrm{P}_{\mathrm{INT}}=\text { Chip Internal Power Dissipation, }[\mathrm{W}]
\end{aligned}
$$

## Appendix A Electrical Characteristics

Two cases with internal voltage regulator enabled and disabled must be considered:

1. Internal Voltage Regulator disabled

$$
\begin{aligned}
& \mathrm{P}_{\mathrm{INT}}=\mathrm{I}_{\mathrm{DD}} \cdot \mathrm{~V}_{\mathrm{DD}}+\mathrm{I}_{\mathrm{DDPLL}} \cdot \mathrm{~V}_{\mathrm{DDPLL}}+\mathrm{I}_{\mathrm{DDA}} \cdot \mathrm{~V}_{\mathrm{DDA}} \\
& \mathrm{P}_{\mathrm{IO}}=\sum_{\mathrm{i}} \mathrm{R}_{\mathrm{DSON}} \cdot \mathrm{I}_{\mathrm{IO}_{\mathrm{i}}}^{2}
\end{aligned}
$$

Which is the sum of all output currents on I/O ports associated with VDDX and VDDM.
For $\mathrm{R}_{\text {DSON }}$ is valid:

$$
\mathrm{R}_{\mathrm{DSON}}=\frac{\mathrm{V}_{\mathrm{OL}}}{\mathrm{I}_{\mathrm{OL}}} \text {;for outputs driven low }
$$

respectively

$$
\mathrm{R}_{\mathrm{DSON}}=\frac{\mathrm{V}_{\mathrm{DD} 5}-\mathrm{V}_{\mathrm{OH}}}{\mathrm{I}_{\mathrm{OH}}} \text {;for outputs driven high }
$$

2. Internal voltage regulator enabled

$$
P_{\text {INT }}=I_{D D R} \cdot V_{D D R}+I_{D D A} \cdot V_{\text {DDA }}
$$

$\mathrm{I}_{\mathrm{DDR}}$ is the current shown in Table A-8 and not the overall current flowing into VDDR, which additionally contains the current flowing into the external loads with output high.

$$
\mathrm{P}_{\mathrm{IO}}=\sum_{\mathrm{i}} \mathrm{R}_{\mathrm{DSON}} \cdot \mathrm{I}_{\mathrm{IO}_{\mathrm{i}}}^{2}
$$

Which is the sum of all output currents on I/O ports associated with VDDX and VDDR.

$$
\text { Table A-5. Thermal Package Characteristics }{ }^{1}
$$

| Num | $\mathbf{C}$ | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| 1 | T | Thermal Resistance LQFP112, single sided PCB ${ }^{2}$ | $\theta_{\mathrm{JA}}$ | - | - | 54 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 2 | T | Thermal Resistance LQFP112, double sided PCB <br> with 2 internal planes ${ }^{3}$ | $\theta_{\mathrm{JA}}$ | - | - | 41 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 3 | T | Junction to Board LQFP112 | $\theta_{\mathrm{JB}}$ | - | - | 31 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 4 | T | Junction to Case LQFP112 | $\theta_{\mathrm{JC}}$ | - | - | 11 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 5 | T | Junction to Package Top LQFP112 | $\Psi_{\mathrm{JT}}$ | - | - | 2 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 6 | T | Thermal Resistance QFP 80, single sided PCB | $\theta_{\mathrm{JA}}$ | - | - | 51 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 7 | T | Thermal Resistance QFP 80, double sided PCB <br> with 2 internal planes | $\theta_{\mathrm{JA}}$ | - | - | 41 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 8 | T | Junction to Board QFP80 | $\theta_{\mathrm{JB}}$ | - | - | 27 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 9 | T | Junction to Case QFP80 | $\theta_{\mathrm{JC}}$ | - | - | 14 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| 10 | T | Junction to Package Top QFP80 | $\Psi_{\mathrm{JT}}$ | - | - | 3 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |

[^11]
## A.1.9 I/O Characteristics

This section describes the characteristics of all $3.3 \mathrm{~V} / 5 \mathrm{~V}$ I/O pins. All parameters are not always applicable, e.g., not all pins feature pull up/down resistances.

Table A-6. 5V I/O Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | P | Input High Voltage | $\mathrm{V}_{\mathrm{IH}}$ | $0.65 * V_{\text {DD5 }}$ | - | - | V |
|  | T | Input High Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | $\mathrm{V}_{\mathrm{DD5}}+0.3$ | V |
| 2 | P | Input Low Voltage | $\mathrm{V}_{\text {IL }}$ | - | - | $0.35 * V_{\text {DD5 }}$ | V |
|  | T | Input Low Voltage | $\mathrm{V}_{\text {IL }}$ | $\mathrm{V}_{\text {SS5 }}-0.3$ | - | - | V |
| 3 | C | Input Hysteresis | $\mathrm{V}_{\mathrm{HYS}}$ | - | 250 | - | mV |
| 4 | P | Input Leakage Current (pins in high ohmic input mode) ${ }^{1}$ $V_{\mathrm{in}}^{\prime}=\mathrm{V}_{\mathrm{DD5}} \text { or } \mathrm{V}_{\mathrm{SS} 5}$ | $\mathrm{I}_{\text {in }}$ | -1.0 | - | 1.0 | $\mu \mathrm{A}$ |
| 5 | C | Output High Voltage (pins in output mode) Partial Drive $\mathrm{I}_{\mathrm{OH}}=-2 m A$ | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{DD5}}-0.8$ | - | - | V |
| 6 | P | Output High Voltage (pins in output mode) Full Drive $\mathrm{IOH}=-10 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{DD5}}-0.8$ | - | - | V |
| 7 | C | Output Low Voltage (pins in output mode) <br> Partial Drive $\mathrm{IOL}=+2 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OL}}$ | - | - | 0.8 | V |
| 8 | P | Output Low Voltage (pins in output mode) <br> Full Drive $\mathrm{I}_{\mathrm{OL}}=+10 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OL}}$ | - | - | 0.8 | V |
| 9 | P | Internal Pull Up Device Current, tested at $\mathrm{V}_{\mathrm{IL}} \mathrm{Max}$. | IPUL | - | - | -130 | $\mu \mathrm{A}$ |
| 10 | C | Internal Pull Up Device Current, tested at $\mathrm{V}_{1 \mathrm{H}}$ Min. | $\mathrm{I}_{\text {PUH }}$ | -10 | - | - | $\mu \mathrm{A}$ |
| 11 | P | Internal Pull Down Device Current, tested at $\mathrm{V}_{\mathrm{IH}}$ Min. | IPDH | - | - | 130 | $\mu \mathrm{A}$ |
| 12 | C | Internal Pull Down Device Current, tested at $\mathrm{V}_{\text {IL }}$ Max. | $\mathrm{I}_{\text {PDL }}$ | 10 | - | - | $\mu \mathrm{A}$ |
| 13 | D | Input Capacitance | $\mathrm{C}_{\text {in }}$ | - | 6 | - | pF |
| 14 | T | Injection current ${ }^{2}$ <br> Single Pin limit <br> Total Device Limit. Sum of all injected currents | $\begin{aligned} & \mathrm{I}_{\mathrm{ICS}} \\ & \mathrm{I}_{\text {ICP }} \end{aligned}$ | $\begin{aligned} & -2.5 \\ & -25 \end{aligned}$ | - | $\begin{aligned} & 2.5 \\ & 25 \end{aligned}$ | mA |
| 15 | P | Port AD Interrupt Input Pulse filtered ${ }^{3}$ | $\mathrm{t}_{\text {PIGN }}$ | - | - | 3 | $\mu \mathrm{s}$ |
| 16 | P | Port AD Interrupt Input Pulse passed ${ }^{3}$ | $t_{\text {PVAL }}$ | 10 | - | - | $\mu \mathrm{s}$ |

1 Maximum leakage current occurs at maximum operating temperature. Current decreases by approximately one-half for each 8 C to 12 C in the temperture range from 50 C to 125 C
2 Refer to Section A.1.4, "Current Injection" for more details
3 Parameter only applies in STOP or Pseudo STOP mode.

Table A-7. Preliminary 3.3V I/O Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | P | Input High Voltage | $\mathrm{V}_{\mathrm{IH}}$ | $0.65 * V_{\text {DD5 }}$ | - | - | V |
|  | T | Input High Voltage | $\mathrm{V}_{\mathrm{IH}}$ | - | - | $\mathrm{V}_{\text {DD5 }}+0.3$ | V |
| 2 | P | Input Low Voltage | $\mathrm{V}_{\text {IL }}$ | - | - | $0.35 * V_{\text {DD5 }}$ | V |
|  | T | Input Low Voltage | $\mathrm{V}_{\mathrm{IL}}$ | $\mathrm{V}_{\mathrm{SS} 5}-0.3$ | - | - | V |
| 3 | C | Input Hysteresis | $\mathrm{V}_{\mathrm{HYS}}$ |  | 250 |  | mV |
| 4 | P | Input Leakage Current (pins in high ohmic input mode) ${ }^{1}$ $V_{\text {in }}^{\prime}=V_{D D 5} \text { or } V_{S S 5}$ | ${ }_{\text {in }}$ | -1.0 | - | 1.0 | $\mu \mathrm{A}$ |
| 5 | C | Output High Voltage (pins in output mode) Partial Drive ${ }^{1} \mathrm{OH}=-0.75 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{DD5}}-0.4$ | - | - | V |
| 6 | P | Output High Voltage (pins in output mode) Full Drive $\mathrm{I}_{\mathrm{OH}}=-4 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OH}}$ | $\mathrm{V}_{\mathrm{DD5}}-0.4$ | - | - | V |
| 7 | C | Output Low Voltage (pins in output mode) <br> Partial Drive $\mathrm{I}_{\mathrm{OL}}=+0.9 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OL}}$ | - | - | 0.4 | V |
| 8 | P | Output Low Voltage (pins in output mode) <br> Full Drive $\mathrm{I}_{\mathrm{OL}}=+4.75 \mathrm{~mA}$ | $\mathrm{V}_{\mathrm{OL}}$ | - | - | 0.4 | V |
| 9 | P | Internal Pull Up Device Current, tested at $\mathrm{V}_{\text {IL }}$ Max. | $\mathrm{I}_{\text {PUL }}$ | - | - | -60 | $\mu \mathrm{A}$ |
| 10 | C | Internal Pull Up Device Current, tested at $\mathrm{V}_{1 \mathrm{IH}}$ Min. | IPUH | -6 | - | - | $\mu \mathrm{A}$ |
| 11 | P | Internal Pull Down Device Current, tested at $\mathrm{V}_{\mathrm{IH}}$ Min. | $\mathrm{I}_{\text {PDH }}$ | - | - | 60 | $\mu \mathrm{A}$ |
| 12 | C | Internal Pull Down Device Current, tested at $\mathrm{V}_{\mathrm{IL}}$ Max. | $\mathrm{I}_{\text {PDL }}$ | 6 | - | - | $\mu \mathrm{A}$ |
| 13 | D | Input Capacitance | $\mathrm{C}_{\text {in }}$ | - | 6 | - | pF |
| 14 | T | ```Injection current }\mp@subsup{}{}{2 Single Pin limit Total Device Limit. Sum of all injected currents``` | $\begin{aligned} & \mathrm{I}_{\mathrm{ICS}} \\ & \mathrm{I}_{\mathrm{ICP}} \end{aligned}$ | $\begin{aligned} & -2.5 \\ & -25 \end{aligned}$ | - | $\begin{aligned} & 2.5 \\ & 25 \end{aligned}$ | mA |
| 15 | P | Port AD Interrupt Input Pulse filtered ${ }^{3}$ | tpign | - | - | 3 | $\mu \mathrm{S}$ |
| 16 | P | Port AD Interrupt Input Pulse passed ${ }^{3}$ | $t_{\text {PVAL }}$ | 10 | - | - | $\mu \mathrm{s}$ |

1 Maximum leakage current occurs at maximum operating temperature. Current decreases by approximately one-half for each 8 C to 12 C in the temperture range from 50 C to 125 C
2 Refer to Section A.1.4, "Current Injection", for more details
3 Parameter only applies in STOP or Pseudo STOP mode.

## A.1.10 Supply Currents

This section describes the current consumption characteristics of the device as well as the conditions for the measurements.

## A.1.10.1 Measurement Conditions

All measurements are without output loads. Unless otherwise noted the currents are measured in single chip mode, internal voltage regulator enabled and at 25 MHz bus frequency using a 4 MHz oscillator.

## A.1.10.2 Additional Remarks

In expanded modes the currents flowing in the system are highly dependent on the load at the address, data and control signals as well as on the duty cycle of those signals. No generally applicable numbers can be given. A very good estimate is to take the single chip currents and add the currents due to the external loads.

Table A-8. Supply Current Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | P | Run supply currents Single Chip, Internal regulator enabled | $\mathrm{I}_{\text {DD5 }}$ | - | - | 65 | mA |
| 2 | $\begin{aligned} & \mathrm{P} \\ & \mathrm{P} \end{aligned}$ | Wait Supply current <br> All modules enabled only RTI enabled | IDDW | - | - | $\begin{gathered} 40 \\ 5 \end{gathered}$ | mA |
| 3 | $\begin{aligned} & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{C} \end{aligned}$ | Pseudo Stop Current (RTI and COP enabled)1,2 <br> $-40^{\circ} \mathrm{C}$ <br> $27^{\circ} \mathrm{C}$ <br> $70^{\circ} \mathrm{C}$ <br> $85^{\circ} \mathrm{C}$ <br> $105^{\circ} \mathrm{C}$ <br> $125^{\circ} \mathrm{C}$ <br> $140^{\circ} \mathrm{C}$ | $\mathrm{I}_{\text {DDPS }}$ |  | $\begin{gathered} 570 \\ 600 \\ 650 \\ 750 \\ 850 \\ 1200 \\ 1500 \end{gathered}$ | - | $\mu \mathrm{A}$ |
| 4 | $\begin{aligned} & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{P} \end{aligned}$ |  | $\mathrm{I}_{\text {DDPS }}$ |  | $\begin{gathered} 370 \\ 400 \\ 450 \\ 550 \\ 600 \\ 650 \\ 800 \\ 850 \\ 1200 \end{gathered}$ | $\begin{gathered} \overline{500} \\ - \\ \overline{-} \\ 1600 \\ - \\ 2100 \\ \overline{5000} \end{gathered}$ | $\mu \mathrm{A}$ |
| 5 | $\begin{aligned} & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{P} \\ & \mathrm{C} \\ & \mathrm{P} \end{aligned}$ | Stop Current ${ }^{2}$ $-40^{\circ} \mathrm{C}$ <br> $27^{\circ} \mathrm{C}$  <br> $70^{\circ} \mathrm{C}$  <br> $85^{\circ} \mathrm{C}$  <br>  "C" Temp Option $100^{\circ} \mathrm{C}$ <br> $105^{\circ} \mathrm{C}$  <br>  "V" Temp Option $120^{\circ} \mathrm{C}$ <br> $125^{\circ} \mathrm{C}$  <br>  "M" Temp Option $140^{\circ} \mathrm{C}$ | $\mathrm{I}_{\text {DDS }}$ | $\begin{aligned} & - \\ & - \\ & - \\ & - \\ & - \\ & - \end{aligned}$ | $\begin{gathered} 12 \\ 30 \\ 100 \\ 130 \\ 160 \\ 200 \\ 350 \\ 400 \\ 600 \end{gathered}$ | $\begin{gathered} \overline{100} \\ - \\ \overline{-} \\ 1200 \\ \overline{1700} \\ \overline{-} \\ 5000 \end{gathered}$ | $\mu \mathrm{A}$ |

[^12]
## A. 2 Voltage Regulator

This section describes the characteristics of the on chip voltage regulator.
Table A-9. Voltage Regulator Electrical Parameters

| Num | C | Characteristic | Symbol | Min | Typical | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | P | Input Voltages | $\mathrm{V}_{\mathrm{VdDR}, \mathrm{A}}$ | 2.97 | - | 5.5 | V |
| 3 | P | Output Voltage Core <br> Full Performance Mode | $\mathrm{V}_{\mathrm{DD}}$ | 2.35 | 2.5 | 2.75 | V |
| 4 | P | Output Voltage PLL <br> Full Performance Mode | $V_{\text {DDPLL }}$ | 2.35 | 2.5 | 2.75 | V |
| 5 | P | Low Voltage Interrupt ${ }^{1}$ Assert Level Deassert Level | $\begin{aligned} & \mathrm{V}_{\text {LVIA }} \\ & \mathrm{V}_{\text {LVID }} \end{aligned}$ | $\begin{gathered} 4.1 \\ 4.25 \end{gathered}$ | $\begin{aligned} & 4.37 \\ & 4.52 \end{aligned}$ | $\begin{aligned} & 4.66 \\ & 4.77 \end{aligned}$ | $\begin{aligned} & \text { v } \\ & \text { v } \end{aligned}$ |
| 6 | P | Low Voltage Reset ${ }^{2}$ Assert Level Deassert Level | $\begin{aligned} & \mathrm{V}_{\text {LVRA }} \\ & \mathrm{V}_{\text {LVRD }} \end{aligned}$ | $2.25$ | - | $2.55$ | $\begin{aligned} & \text { v } \\ & \text { v } \end{aligned}$ |
| 7 | C | Power-on Reset ${ }^{3}$ Assert Level Deassert Level | $V_{\text {PORA }}$ <br> $V_{\text {PORD }}$ | $0.97$ | ---- | 2.05 | V |

${ }^{1}$ Monitors $\mathrm{V}_{\text {DDA }}$, active only in Full Performance Mode. Indicates I/O \& ADC performance degradation due to low supply voltage.
${ }^{2}$ Monitors $V_{D D}$, active only in Full Performance Mode. $\mathrm{V}_{\text {LVRA }}$ and $\mathrm{V}_{\text {PORD }}$ must overlap
${ }^{3}$ Monitors $V_{D D}$. Active in all modes.

The electrical characteristics given in this section are preliminary and should be used as a guide only. Values in this section cannot be guaranteed by Freescale and are subject to change without notice.

## A.2.1 Chip Power-up and LVI/LVR Graphical Explanation

Voltage regulator sub modules LVI (low voltage interrupt), POR (power-on reset) and LVR (low voltage reset) handle chip power-up or drops of the supply voltage. Their function is described in Figure A-1.


Figure A-1. Voltage Regulator - Chip Power-up and Voltage Drops (not scaled)

## A.2.2 Output Loads

## A.2.2.1 Resistive Loads

The on-chip voltage regulator is intended to supply the internal logic and oscillator circuits allows no external DC loads.

## A.2.2.2 Capacitive Loads

The capacitive loads are specified in Table A-10. Ceramic capacitors with X7R dielectricum are required.
Table A-10. Voltage Regulator - Capacitive Loads

| Num | Characteristic | Symbol | Min | Typical | Max | Unit |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| 1 | $V_{\text {DD }}$ external capacitive load | $C_{\text {DDext }}$ | 200 | 440 | 12000 | nF |
| 2 | $V_{\text {DDPLL }}$ external capacitive load | C DDPLLext | 90 | 220 | 5000 | nF |

## A. 3 Startup, Oscillator and PLL

## A.3.1 Startup

Table A-11 summarizes several startup characteristics explained in this section.

Table A-11. Startup Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | T | POR release level | $\mathrm{V}_{\text {PORR }}$ |  |  | 2.07 | V |
| 2 | T | POR assert level | $\mathrm{V}_{\text {PORA }}$ | 0.97 |  |  | V |
| 3 | D | Reset input pulse width, minimum input time | $\mathrm{PW}_{\text {RSTL }}$ | 2 |  |  | $\mathrm{t}_{\text {osc }}$ |
| 4 | D | Startup from Reset | $\mathrm{n}_{\text {RST }}$ | 192 |  | 196 | $\mathrm{n}_{\text {osc }}$ |
| 5 | D | Interrupt pulse width, $\overline{\text { IRQ edge-sensitive }}$ <br> mode | $\mathrm{PW}_{\text {IRQ }}$ | 20 |  |  | ns |
| 6 | D | Wait recovery startup time | $\mathrm{t}_{\text {WRS }}$ |  |  | 14 | $\mathrm{t}_{\text {cyc }}$ |
| 7 | P | LVR release level | $\mathrm{V}_{\text {LVRR }}$ | 2.25 |  |  | V |
| 8 | P | LVR assert level | $\mathrm{V}_{\text {LVRA }}$ |  |  | 2.55 | V |

## A.3.1.1 POR

The release level $V_{\text {PORR }}$ and the assert level $V_{\text {PORA }}$ are derived from the $V_{D D}$ Supply. They are also valid if the device is powered externally. After releasing the POR reset the oscillator and the clock quality check are started. If after a time $\mathrm{t}_{\text {CQOUT }}$ no valid oscillation is detected, the MCU will start using the internal self clock. The fastest startup time possible is given by $\mathrm{n}_{\text {uposc }}$.

## A.3.1.2 LVR

The release level $V_{\text {LVRR }}$ and the assert level $V_{\text {LVRA }}$ are derived from the $V_{D D}$ Supply. They are also valid if the device is powered externally. After releasing the LVR reset the oscillator and the clock quality check are started. If after a time $\mathrm{t}_{\mathrm{CQOUT}}$ no valid oscillation is detected, the MCU will start using the internal self clock. The fastest startup time possible is given by $\mathrm{n}_{\text {uposc }}$.

## A.3.1.3 SRAM Data Retention

Provided an appropriate external reset signal is applied to the MCU, preventing the CPU from executing code when VDD5 is out of specification limits, the SRAM contents integrity is guaranteed if after the reset the PORF bit in the CRG Flags Register has not been set.

## A.3.1.4 External Reset

When external reset is asserted for a time greater than $\mathrm{PW}_{\mathrm{RSTL}}$ the CRG module generates an internal reset, and the CPU starts fetching the reset vector without doing a clock quality check, if there was an oscillation before reset.

## A.3.1.5 Stop Recovery

Out of STOP the controller can be woken up by an external interrupt. A clock quality check as after POR is performed before releasing the clocks to the system.

## A.3.1.6 Pseudo Stop and Wait Recovery

The recovery from Pseudo STOP and Wait are essentially the same since the oscillator was not stopped in both modes. The controller can be woken up by internal or external interrupts. After $t_{w r s}$ the CPU starts fetching the interrupt vector.

## Appendix A Electrical Characteristics

## A.3.2 Oscillator

The device features an internal Colpitts and Pierce oscillator. The selection of Colpitts oscillator or Pierce oscillator/external clock depends on the $\overline{\mathrm{XCLKS}}$ signal which is sampled during reset. Pierce oscillator/external clock mode allows the input of a square wave. Before asserting the oscillator to the internal system clocks the quality of the oscillation is checked for each start from either power-on, STOP or oscillator fail. $\mathrm{t}_{\mathrm{CQOUT}}$ specifies the maximum time before switching to the internal self clock mode after POR or STOP if a proper oscillation is not detected. The quality check also determines the minimum oscillator start-up time $\mathrm{t}_{\text {UPOSC }}$. The device also features a clock monitor. A Clock Monitor Failure is asserted if the frequency of the incoming clock signal is below the Assert Frequency $f_{\text {CMFA }}$.

Table A-12. Oscillator Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1a | C | Crystal oscillator range (Colpitts) | fosc | 0.5 |  | 16 | MHz |
| 1b | C | Crystal oscillator range (Pierce) ${ }^{1}$ | $\mathrm{f}_{\text {OSC }}$ | 0.5 |  | 40 | MHz |
| 2 | P | Startup Current | iosc | 100 |  |  | $\mu \mathrm{A}$ |
| 3 | C | Oscillator start-up time (Colpitts) | $\mathrm{t}_{\text {UPOSC }}$ |  | $8^{2}$ | $100^{3}$ | ms |
| 4 | D | Clock Quality check time-out | $\mathrm{t}_{\text {CQOUT }}$ | 0.45 |  | 2.5 | S |
| 5 | P | Clock Monitor Failure Assert Frequency | $\mathrm{f}_{\text {CMFA }}$ | 50 | 100 | 200 | KHz |
| 6 | P | External square wave input frequency ${ }^{4}$ | $\mathrm{f}_{\mathrm{EXT}}$ | 0.5 |  | 50 | MHz |
| 7 | D | External square wave pulse width low ${ }^{4}$ | $\mathrm{t}_{\text {EXTL }}$ | 9.5 |  |  | ns |
| 8 | D | External square wave pulse width high ${ }^{4}$ | $\mathrm{t}_{\text {EXTH }}$ | 9.5 |  |  | ns |
| 9 | D | External square wave rise time ${ }^{4}$ | $\mathrm{t}_{\text {EXTR }}$ |  |  | 1 | ns |
| 10 | D | External square wave fall time ${ }^{4}$ | $\mathrm{t}_{\text {EXTF }}$ |  |  | 1 | ns |
| 11 | D | Input Capacitance (EXTAL, XTAL pins) | $\mathrm{C}_{\text {IN }}$ |  | 7 |  | pF |
| 12 | C | DC Operating Bias in Colpitts Configuration on EXTAL Pin | $V_{\text {dCBIAS }}$ |  | 1.1 |  | V |
| 13 | P | EXTAL Pin Input High Voltage ${ }^{4}$ | $\mathrm{V}_{\text {IH,EXTAL }}$ | $0.75 * V_{\text {DDPLL }}$ |  |  | V |
|  | T | EXTAL Pin Input High Voltage ${ }^{4}$ | $\mathrm{V}_{\text {IH,EXTAL }}$ |  |  | $\mathrm{V}_{\text {DDPLL }}+0.3$ | V |
| 14 | P | EXTAL Pin Input Low Voltage ${ }^{4}$ | $\mathrm{V}_{\text {IL, EXTAL }}$ |  |  | $0.25 * V_{\text {DDPLL }}$ | V |
|  | T | EXTAL Pin Input Low Voltage ${ }^{4}$ | $\mathrm{V}_{\text {IL, EXTAL }}$ | $\mathrm{V}_{\text {SSPLL }}-0.3$ |  |  | V |
| 15 | C | EXTAL Pin Input Hysteresis ${ }^{4}$ | $\mathrm{V}_{\text {HYS, EXTAL }}$ |  | 250 |  | mV |

${ }^{1}$ Depending on the crystal a damping series resistor might be necessary
${ }_{3}^{2} \mathrm{f}_{\text {osc }}=4 \mathrm{MHz}, \mathrm{C}=22 \mathrm{pF}$.
${ }^{3}$ Maximum value is for extreme cases using high $Q$, low frequency crystals
${ }^{4}$ Only valid if Pierce oscillator/external clock mode is selected

## A.3.3 Phase Locked Loop

The oscillator provides the reference clock for the PLL. The PLL's Voltage Controlled Oscillator (VCO) is also the system clock source in self clock mode.

## A.3.3.1 XFC Component Selection

This section describes the selection of the XFC components to achieve a good filter characteristics.


Figure A-2. Basic PLL functional diagram
The following procedure can be used to calculate the resistance and capacitance values using typical values for $\mathrm{K}_{1}, \mathrm{f}_{1}$ and $\mathrm{i}_{\mathrm{ch}}$ from Table A-13.

The grey boxes show the calculation for $\mathrm{f}_{\mathrm{VCO}}=50 \mathrm{MHz}$ and $\mathrm{f}_{\mathrm{ref}}=1 \mathrm{MHz}$. E.g., these frequencies are used for $\mathrm{f}_{\mathrm{OSC}}=4 \mathrm{MHz}$ and a 25 MHz bus clock.

The VCO Gain at the desired VCO frequency is approximated by:
$K_{V}=K_{1} \cdot e^{\frac{\left(f_{1}-f_{\text {vco }}\right)}{K_{1} \cdot 1 V}}=-100 \cdot e^{\frac{(60-50)}{-100}}=-90.48 \mathrm{MHz} / \mathrm{V}$
The phase detector relationship is given by:
$\mathrm{K}_{\Phi}=-\left|\mathrm{i}_{\mathrm{ch}}\right| \cdot \mathrm{K}_{\mathrm{V}} \quad=316.7 \mathrm{~Hz} / \Omega$
$\mathrm{i}_{\mathrm{ch}}$ is the current in tracking mode.

The loop bandwidth $\mathrm{f}_{\mathrm{C}}$ should be chosen to fulfill the Gardner's stability criteria by at least a factor of 10 , typical values are $50 . \zeta=0.9$ ensures a good transient response.

$$
\mathrm{f}_{\mathrm{C}}<\frac{2 \cdot \zeta \cdot \mathrm{f}_{\mathrm{ref}}}{\pi \cdot\left(\zeta+\sqrt{1+\zeta^{2}}\right)} \frac{1}{10} \rightarrow \mathrm{f}_{\mathrm{C}}<\frac{\mathrm{f}_{\mathrm{ref}}}{4 \cdot 10} ;(\zeta=0.9)
$$

And finally the frequency relationship is defined as

$$
\mathrm{n}=\frac{\mathrm{f}_{\mathrm{VCO}}}{\mathrm{f}_{\mathrm{ref}}}=2 \cdot(\operatorname{synr}+1)=50
$$

With the above values the resistance can be calculated. The example is shown for a loop bandwidth $\mathrm{f}_{\mathrm{C}}=10 \mathrm{kHz}$ :

$$
\mathrm{R}=\frac{2 \cdot \pi \cdot \mathrm{n} \cdot \mathrm{f}_{\mathrm{C}}}{\mathrm{~K}_{\Phi}}=2^{*} \pi^{*} 50^{*} 10 \mathrm{kHz} /(316.7 \mathrm{~Hz} / \Omega)=9.9 \mathrm{k} \Omega=\sim 10 \mathrm{k} \Omega
$$

The capacitance $\mathrm{C}_{\mathrm{s}}$ can now be calculated as:

$$
C_{s}=\frac{2 \cdot \zeta^{2}}{\pi \cdot f_{C} \cdot R} \approx \frac{0.516}{f_{C} \cdot R} ;(\zeta=0.9)=5.19 n F=\sim 4.7 n F
$$

The capacitance $C_{p}$ should be chosen in the range of:

$$
C_{s} / 20 \leq C_{p} \leq C_{s} / 10 \quad C_{p}=470 p F
$$

## A.3.3.2 Jitter Information

The basic functionality of the PLL is shown in Figure A-2. With each transition of the clock $f_{\text {cmp }}$, the deviation from the reference clock $\mathrm{f}_{\text {ref }}$ is measured and input voltage to the VCO is adjusted accordingly.The adjustment is done continuously with no abrupt changes in the clock output frequency. Noise, voltage, temperature and other factors cause slight variations in the control loop resulting in a clock jitter. This jitter affects the real minimum and maximum clock periods as illustrated in Figure A-3.


Figure A-3. Jitter Definitions
The relative deviation of $\mathrm{t}_{\text {nom }}$ is at its maximum for one clock period, and decreases towards zero for larger number of clock periods ( N ).

Defining the jitter as:
$J(N)=\max \left(\left|1-\frac{t_{\text {max }}(N)}{N \cdot t_{\text {nom }}}\right|,\left|1-\frac{t_{\text {min }}(N)}{N \cdot t_{\text {nom }}}\right|\right)$
For $\mathrm{N}<100$, the following equation is a good fit for the maximum jitter:
$\mathrm{J}(\mathrm{N})=\frac{\mathrm{j}_{1}}{\sqrt{\mathrm{~N}}}+\mathrm{j}_{2}$


This is very important to notice with respect to timers, serial modules where a pre-scaler will eliminate the effect of the jitter to a large extent.

Table A-13. PLL Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | P | Self Clock Mode frequency | $\mathrm{f}_{\text {SCM }}$ | 1 |  | 5.5 | MHz |
| 2 | D | VCO locking range | fvco | 8 |  | 50 | MHz |
| 3 | D | Lock Detector transition from Acquisition to Tracking mode | $\left\|\Delta_{\text {trk }}\right\|$ | 3 |  | 4 | \% ${ }^{1}$ |
| 4 | D | Lock Detection | \| $\Delta_{\text {Lock }}$ | 0 |  | 1.5 | \% ${ }^{1}$ |
| 5 | D | Un-Lock Detection | $\left\|\Delta_{\text {unil }}\right\|$ | 0.5 |  | 2.5 | \% ${ }^{1}$ |
| 6 | D | Lock Detector transition from Tracking to Acquisition mode | $\left\|\Delta_{\text {unt }}\right\|$ | 6 |  | 8 | \% ${ }^{1}$ |
| 7 | C | PLLON Total Stabilization delay (Auto Mode) ${ }^{2}$ | $\mathrm{t}_{\text {stab }}$ |  | 0.5 |  | ms |
| 8 | D | PLLON Acquisition mode stabilization delay ${ }^{2}$ | tacq |  | 0.3 |  | ms |
| 9 | D | PLLON Tracking mode stabilization delay ${ }^{2}$ | $\mathrm{tal}_{\text {a }}$ |  | 0.2 |  | ms |
| 10 | D | Fitting parameter VCO loop gain | $\mathrm{K}_{1}$ |  | -100 |  | MHz/V |
| 11 | D | Fitting parameter VCO loop frequency | $\mathrm{f}_{1}$ |  | 60 |  | MHz |
| 12 | D | Charge pump current acquisition mode | $\left\|\mathrm{i}_{\mathrm{ch}}\right\|$ |  | 38.5 |  | $\mu \mathrm{A}$ |
| 13 | D | Charge pump current tracking mode | $\left\|\mathrm{i}_{\mathrm{ch}}\right\|$ |  | 3.5 |  | $\mu \mathrm{A}$ |
| 14 | C | Jitter fit parameter $1^{2}$ | $\mathrm{j}_{1}$ |  |  | 1.1 | \% |
| 15 | C | Jitter fit parameter $2^{2}$ | $\mathrm{j}_{2}$ |  |  | 0.13 | \% |

${ }^{1} \%$ deviation from target frequency
${ }^{2} \mathrm{f}_{\mathrm{OSC}}=4 \mathrm{MHz}, \mathrm{f}_{\mathrm{BUS}}=25 \mathrm{MHz}$ equivalent $\mathrm{f}_{\mathrm{VcO}}=50 \mathrm{MHz}$ : REFDV $=\# \$ 03, \mathrm{SYNR}=\# \$ 018, \mathrm{Cs}=4.7 \mathrm{nF}, \mathrm{Cp}=470 \mathrm{pF}, \mathrm{Rs}=$ $10 \mathrm{~K} \Omega$.

## A. 4 Flash NVM

## A.4.1 NVM Timing

The time base for all NVM program or erase operations is derived from the oscillator. A minimum oscillator frequency $f_{\text {NVMOSC }}$ is required for performing program or erase operations. The NVM modules do not have any means to monitor the frequency and will not prevent program or erase operation at frequencies above or below the specified minimum. Attempting to program or erase the NVM modules at a lower frequency a full program or erase transition is not assured.

The Flash program and erase operations are timed using a clock derived from the oscillator using the FCLKDIV register. The frequency of this clock must be set within the limits specified as $\mathrm{f}_{\text {NVMOP }}$.

The minimum program and erase times shown in Table A-14 are calculated for maximum $f_{\text {NVMOP }}$ and maximum $f_{\text {bus }}$. The maximum times are calculated for minimum $f_{\text {NVMOP }}$ and a $f_{\text {bus }}$ of 2 MHz .

## A.4.1.1 Single Word Programming

The programming time for single word programming is dependent on the bus frequency as a well as on the frequency $\mathrm{f}^{\circ}{ }_{\mathrm{NVMOP}}$ and can be calculated according to the following formula.

$$
t_{\text {swpgm }}=9 \cdot \frac{1}{f_{\text {NVMOP }}}+25 \cdot \frac{1}{f_{\text {bus }}}
$$

## A.4.1.2 Row Programming

Flash programming where up to 64 words in a row can be programmed consecutively by keeping the command pipeline filled. The time to program a consecutive word can be calculated as:

$$
t_{\text {bwpgm }}=4 \cdot \frac{1}{f_{\mathrm{NVMOP}}}+9 \cdot \frac{1}{f_{\text {bus }}}
$$

The time to program a whole row is:

$$
\mathrm{t}_{\text {brpgm }}=\mathrm{t}_{\text {swpgm }}+63 \cdot \mathrm{t}_{\text {bwpgm }}
$$

Row programming is more than 2 times faster than single word programming.

## A.4.1.3 Sector Erase

Erasing a 1024 byte Flash sector takes:

$$
t_{\text {era }} \approx 4000 \cdot \frac{1}{f_{\text {NVMOP }}}
$$

The setup times can be ignored for this operation.

## A.4.1.4 Mass Erase

Erasing a NVM block takes:

$$
t_{\text {mass }} \approx 20000 \cdot \frac{1}{f_{\text {NVMOP }}}
$$

The setup times can be ignored for this operation.

## A.4.1.5 Blank Check

The time it takes to perform a blank check on the Flash is dependant on the location of the first non-blank word starting at relative address zero. It takes one bus cycle per word to verify plus a setup of the command.

$$
\mathrm{t}_{\mathrm{check}} \approx \text { location } \cdot \mathrm{t}_{\mathrm{cyc}}+10 \cdot \mathrm{t}_{\mathrm{cyc}}
$$

Table A-14. NVM Timing Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | D | External Oscillator Clock | $\mathrm{f}_{\text {NVMOSC }}$ | 0.5 | - | $50^{1}$ | MHz |
| 2 | D | Bus frequency for Programming or Erase Operations | $\mathrm{f}_{\text {NVMBUS }}$ | 1 | - |  | MHz |
| 3 | D | Operating Frequency | $\mathrm{f}_{\text {NVMOP }}$ | 150 | - | 200 | kHz |
| 4 | P | Single Word Programming Time | $\mathrm{t}_{\text {swpgm }}$ | $46^{2}$ | - | $74.5{ }^{3}$ | $\mu \mathrm{s}$ |
| 5 | D | Flash Burst Programming consecutive word | $t_{\text {bwpgm }}$ | $20.4{ }^{2}$ | - | $31^{3}$ | $\mu \mathrm{S}$ |
| 6 | D | Flash Burst Programming Time for 64 Word row | $t_{\text {brpgm }}$ | $1331.2^{2}$ | - | $2027.5^{3}$ | $\mu \mathrm{s}$ |
| 7 | P | Sector Erase Time | $t_{\text {era }}$ | $20^{4}$ | - | $26.7^{3}$ | ms |
| 8 | P | Mass Erase Time | $\mathrm{t}_{\text {mass }}$ | $100^{4}$ | - | $133{ }^{3}$ | ms |
| 9 | D | Blank Check Time Flash per block | $\mathrm{t}_{\text {check }}$ | $11^{5}$ | - | $65546^{6}$ | ${ }^{7} \mathrm{t}_{\mathrm{cyc}}$ |

[^13]
## A.4.2 NVM Reliability

The reliability of the NVM blocks is guaranteed by stress test during qualification, constant process monitors and burn-in to screen early life failures. The program/erase cycle count on the sector is incremented every time a sector or mass erase event is executed.

Table A-15. NVM Reliability Characteristics ${ }^{1}$

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| Flash Reliability Characteristics |  |  |  |  |  |  |  |
| 1 | C | Data retention after 10,000 program/erase cycles at an average junction temperature of $\mathrm{T}_{\text {Javg }} \leq 85^{\circ} \mathrm{C}$ | $t_{\text {FLRET }}$ | 15 | $100^{2}$ | - | Years |
| 2 | C | Data retention with <100 program/erase cycles at an average junction temperature $\mathrm{T}_{\text {Javg }} \leq 85^{\circ} \mathrm{C}$ |  | 20 | $100^{2}$ | - |  |
| 3 | C | Number of program/erase cycles $\left(-40^{\circ} \mathrm{C} \leq \mathrm{T}_{J} \leq 0^{\circ} \mathrm{C}\right)$ | $\mathrm{n}_{\mathrm{FL}}$ | 10,000 | - | - | Cycles |
| 4 | C | Number of program/erase cycles $\left(0^{\circ} \mathrm{C} \leq \mathrm{T}_{\mathrm{J}} \leq 140^{\circ} \mathrm{C}\right)$ |  | 10,000 | 100,000 ${ }^{3}$ | - |  |

${ }^{1} \mathrm{~T}_{\text {Javg }}$ will not exeed $85^{\circ} \mathrm{C}$ considering a typical temperature profile over the lifetime of a consumer, industrial or automotive application.
2 Typical data retention values are based on intrinsic capability of the technology measured at high temperature and de-rated to $25^{\circ} \mathrm{C}$ using the Arrhenius equation. For additional information on how Freescale defines Typical Data Retention, please refer to Engineering Bulletin EB618.
3 Spec table quotes typical endurance evaluated at $25^{\circ} \mathrm{C}$ for this product family, typical endurance at various temperature can be estimated using the graph below. For additional information on how Freescale defines Typical Endurance, please refer to Engineering Bulletin EB619.

## Appendix A Electrical Characteristics

Typical Endurance

------- Flash

## A. 5 SPI Characteristics

This section provides electrical parametrics and ratings for the SPI.
In Table A-16 the measurement conditions are listed.
Table A-16. Measurement Conditions

| Description | Value | Unit |
| :--- | :---: | :---: |
| Drive mode | full drive mode | - |
| Load capacitance C COAD, on all outputs | 50 | pF |
| Thresholds for delay measurement points | $(20 \% / 80 \%) \vee_{\text {DDX }}$ | V |

## A.5. $\quad$ Master Mode

In Figure A-4 the timing diagram for master mode with transmission format $\mathrm{CPHA}=0$ is depicted.


1. If configured as an output.
2. $\operatorname{LSBF}=0$. For LSBF $=1$, bit order is LSB, bit $1, \ldots$, bit 6, MSB.

Figure A-4. SPI Master Timing (CPHA = 0)

## Appendix A Electrical Characteristics

In Figure A-5 the timing diagram for master mode with transmission format CPHA=1 is depicted.


1. If configured as output
2. $\operatorname{LSBF}=0$. For LSBF $=1$, bit order is LSB, bit $1, \ldots$, bit 6, MSB.

Figure A-5. SPI Master Timing (CPHA=1)
In Table A-17 the timing characteristics for master mode are listed.
Table A-17. SPI Master Mode Timing Characteristics

| Num | C | Characteristic | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| 1 | P | SCK Frequency | $\mathrm{f}_{\text {sck }}$ | $1 / 2048$ | - | $1 / 2$ | $\mathrm{f}_{\text {bus }}$ |
| 1 | P | SCK Period | $\mathrm{t}_{\text {sck }}$ | 2 | - | 2048 | $\mathrm{t}_{\text {bus }}$ |
| 2 | D | Enable Lead Time | $\mathrm{t}_{\text {lead }}$ | - | $1 / 2$ | - | $\mathrm{t}_{\text {sck }}$ |
| 3 | D | Enable Lag Time | $\mathrm{t}_{\text {lag }}$ | - | $1 / 2$ | - | $\mathrm{t}_{\text {sck }}$ |
| 4 | D | Clock (SCK) High or Low Time | $\mathrm{t}_{\text {wsck }}$ | - | $1 / 2$ | - | $\mathrm{t}_{\text {sck }}$ |
| 5 | D | Data Setup Time (Inputs) | $\mathrm{t}_{\text {su }}$ | 8 | - | - | ns |
| 6 | D | Data Hold Time (Inputs) | $\mathrm{t}_{\mathrm{hi}}$ | 8 | - | - | ns |
| 9 | D | Data Valid after SCK Edge | $\mathrm{t}_{\text {vsck }}$ | - | - | 30 | ns |
| 10 | D | Data Valid after SS fall (CPHA $=0$ ) | $\mathrm{t}_{\text {vss }}$ | - | - | 15 | ns |
| 11 | D | Data Hold Time (Outputs) | $\mathrm{t}_{\mathrm{ho}}$ | 20 | - | - | ns |
| 12 | D | Rise and Fall Time Inputs | $\mathrm{t}_{\text {rii }}$ | - | - | 8 | ns |
| 13 | D | Rise and Fall Time Outputs | $\mathrm{t}_{\text {rfo }}$ | - | - | 8 | ns |

## A.5.2 Slave Mode

In Figure A-6 the timing diagram for slave mode with transmission format CPHA $=0$ is depicted.


NOTE: Not defined!
Figure A-6. SPI Slave Timing (CPHA = 0)
In Figure A-7 the timing diagram for slave mode with transmission format CPHA $=1$ is depicted.


NOTE: Not defined!
Figure A-7. SPI Slave Timing (CPHA = 1)

## Appendix A Electrical Characteristics

In Table A-18 the timing characteristics for slave mode are listed.
Table A-18. SPI Slave Mode Timing Characteristics

| Num | C | Characteristic | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | P | SCK Frequency | $\mathrm{f}_{\text {sck }}$ | DC | - | 1/4 | $\mathrm{f}_{\text {bus }}$ |
| 1 | P | SCK Period | $\mathrm{t}_{\text {sck }}$ | 4 | - | $\infty$ | $t_{\text {bus }}$ |
| 2 | D | Enable Lead Time | $t_{\text {lead }}$ | 4 | - | - | $\mathrm{t}_{\text {bus }}$ |
| 3 | D | Enable Lag Time | $\mathrm{t}_{\text {lag }}$ | 4 | - | - | $\mathrm{t}_{\text {bus }}$ |
| 4 | D | Clock (SCK) High or Low Time | $\mathrm{t}_{\text {wsck }}$ | 4 | - | - | $\mathrm{t}_{\text {bus }}$ |
| 5 | D | Data Setup Time (Inputs) | $\mathrm{t}_{\text {su }}$ | 8 | - | - | ns |
| 6 | D | Data Hold Time (Inputs) | $\mathrm{t}_{\mathrm{hi}}$ | 8 | - | - | ns |
| 7 | D | Slave Access Time (time to data active) | $\mathrm{ta}_{\mathrm{a}}$ | - | - | 20 | ns |
| 8 | D | Slave MISO Disable Time | $\mathrm{t}_{\text {dis }}$ | - | - | 22 | ns |
| 9 | D | Data Valid after SCK Edge | $\mathrm{t}_{\text {vsck }}$ | - | - | $30+t_{\text {bus }}{ }^{1}$ | ns |
| 10 | D | Data Valid after $\overline{\text { SS fall }}$ | $\mathrm{t}_{\text {vss }}$ | - | - | $30+t_{\text {bus }}{ }^{1}$ | ns |
| 11 | D | Data Hold Time (Outputs) | $\mathrm{t}_{\mathrm{ho}}$ | 20 | - | - | ns |
| 12 | D | Rise and Fall Time Inputs | $\mathrm{t}_{\text {rfi }}$ | - | - | 8 | ns |
| 13 | D | Rise and Fall Time Outputs | $\mathrm{t}_{\text {rfo }}$ | - | - | 8 | ns |

${ }^{1} \mathrm{t}_{\text {bus }}$ added due to internal synchronization delay

## A. 6 ATD Characteristics

This section describes the characteristics of the analog to digital converter.
The ATD is specified and tested for both the 3.3 V and 5 V range. For ranges between 3.3 V and 5 V the ATD accuracy is generally the same as in the 3.3 V range but is not tested in this range in production test.

## A.6.1 ATD Operating Characteristics - 5V Range

The Table A-19 shows conditions under which the ATD operates.
The following constraints exist to obtain full-scale, full range results:
VSSA $\leq$ VRL $\leq$ VIN $\leq$ VRH $\leq$ VDDA. This constraint exists since the sample buffer amplifier can not drive beyond the power supply levels that it ties to. If the input level goes outside of this range it will effectively be clipped.

Table A-19. 5V ATD Operating Characteristics

| Conditions are shown in Table A-4 unless otherwise noted. Supply Voltage 5V-10\% <= VDDA <=5V+10\% |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | D | Reference Potential <br> Low <br> High | $\begin{aligned} & \mathrm{V}_{\mathrm{RL}} \\ & \mathrm{~V}_{\mathrm{RH}} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{SSA}} \\ & \mathrm{~V}_{\mathrm{DDA} / 2} \end{aligned}$ | - | $\mathrm{V}_{\mathrm{DDA} / 2}$ <br> $V_{\text {DDA }}$ | $\begin{aligned} & \text { V } \\ & \text { V } \end{aligned}$ |
| 2 | C | Differential Reference Voltage ${ }^{1}$ | $\mathrm{V}_{\mathrm{RH}}-\mathrm{V}_{\mathrm{RL}}$ | 4.75 | 5.0 | 5.25 | V |
| 3 | D | ATD Clock Frequency | $\mathrm{f}_{\text {ATDCLK }}$ | 0.5 | - | 2.0 | MHz |
| 4 | D | ATD 10-Bit Conversion Period <br> Clock Cycles ${ }^{2}$ <br> Conv, Time at 2.0 MHz ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ Conv, Time at $4.0 \mathrm{MHz}^{3}$ ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ | $\mathrm{N}_{\text {CONV10 }}$ <br> TCONV10 <br> TCONV10 | $\begin{gathered} 14 \\ 7 \\ 3.5 \end{gathered}$ | - | $\begin{gathered} 28 \\ 14 \\ 7 \end{gathered}$ | $\begin{gathered} \text { Cycles } \\ \mu \mathrm{s} \\ \mu \mathrm{~s} \end{gathered}$ |
| 5 | D | ATD 8-Bit Conversion Period <br> Clock Cycles ${ }^{1}$ <br> Conv, Time at 2.0 MHz ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ | $\mathrm{N}_{\text {CONV8 }}$ <br> TCONV8 | $\begin{gathered} 12 \\ 6 \end{gathered}$ | - | $\begin{aligned} & 26 \\ & 13 \end{aligned}$ | Cycles $\mu \mathrm{s}$ |
| 6 | D | Stop Recovery Time (VDA $=5.0$ Volts) | $t_{\text {SR }}$ | - | - | 20 | $\mu \mathrm{S}$ |
| 7 | P | Reference Supply current | $\mathrm{I}_{\text {REF }}$ | - | - | 0.375 | mA |

${ }^{1}$ Full accuracy is not guaranteed when differential voltage is less than 4.75 V
${ }^{2}$ The minimum time assumes a final sample period of 2 ATD clocks cycles while the maximum time assumes a final sample period of 16 ATD clocks.
${ }^{3}$ Reduced accuracy see Table A-22 and Table A-23.

## A.6.2 ATD Operating Characteristics - 3.3V Range

The Table A-20 shows conditions under which the ATD operates.
The following constraints exist to obtain full-scale, full range results:
VSSA $\leq$ VRL $\leq$ VIN $\leq$ VRH $\leq$ VDDA. This constraint exists since the sample buffer amplifier can not drive beyond the power supply levels that it ties to. If the input level goes outside of this range it will effectively be clipped.

Table A-20. 3.3V ATD Operating Characteristics
Conditions are shown in Table A-4 unless otherwise noted; Supply Voltage 3.3V-10\% <= $\mathrm{V}_{\mathrm{DDA}}<=3.3 \mathrm{~V}+10 \%$

| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | D | Reference Potential $\begin{array}{rr}\text { Low } \\ & \text { High }\end{array}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{RL}} \\ & \mathrm{~V}_{\mathrm{RH}} \end{aligned}$ | $\begin{gathered} \mathrm{V}_{\mathrm{SSA}} \\ \mathrm{~V}_{\mathrm{DDA}} / 2 \end{gathered}$ | - | $\begin{gathered} \mathrm{V}_{\mathrm{DDA}} / 2 \\ \mathrm{~V}_{\mathrm{DDA}} \end{gathered}$ | $\begin{aligned} & \text { V } \\ & \text { V } \end{aligned}$ |
| 2 | C | Differential Reference Voltage | $\mathrm{V}_{\mathrm{RH}} \mathrm{V}_{\mathrm{RL}}$ | 3.0 | 3.3 | 3.6 | V |
| 3 | D | ATD Clock Frequency | $\mathrm{f}_{\text {ATDCLK }}$ | 0.5 | - | 2.0 | MHz |
| 4 | D | ATD 10-Bit Conversion Period <br> Clock Cycles ${ }^{1}$ <br> Conv, Time at 2.0 MHz ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ <br> Conv, Time at $4.0 \mathrm{MHz}{ }^{2}$ ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ | $\mathrm{N}_{\text {CONV10 }}$ <br> TCONV10 <br> TCONV10 | $\begin{gathered} 14 \\ 7 \\ 3.5 \end{gathered}$ | - | $\begin{gathered} 28 \\ 14 \\ 7 \end{gathered}$ | $\begin{gathered} \text { Cycles } \\ \mu \mathrm{s} \\ \mu \mathrm{~s} \end{gathered}$ |
| 5 | D | ATD 8-Bit Conversion Period Clock Cycles ${ }^{1}$ Conv, Time at 2.0 MHz ATD Clock $\mathrm{f}_{\text {ATDCLK }}$ | $\mathrm{N}_{\text {CONV8 }}$ TCONV8 | $\begin{gathered} 12 \\ 6 \end{gathered}$ | - | $\begin{aligned} & 26 \\ & 13 \end{aligned}$ | Cycles $\mu \mathrm{S}$ |
| 6 | D | Recovery Time (V $\mathrm{V}_{\text {DAA }}=3.3$ Volts) | $t_{\text {REC }}$ | - | - | 20 | $\mu \mathrm{s}$ |
| 7 | P | Reference Supply current | $I_{\text {REF }}$ | - | - | 0.250 | mA |

1 The minimum time assumes a final sample period of 2 ATD clocks cycles while the maximum time assumes a final sample period of 16 ATD clocks.
2 Reduced accuracy see Table A-22 and Table A-23.

## A.6.3 Factors Influencing Accuracy

Three factors - source resistance, source capacitance and current injection - have an influence on the accuracy of the ATD.

## A.6.3.1 Source Resistance

Due to the input pin leakage current as specified in Table A-6 and Table A-7 in conjunction with the source resistance there will be a voltage drop from the signal source to the ATD input. The maximum source resistance $\mathrm{R}_{\mathrm{S}}$ specifies results in an error of less than $1 / 2 \mathrm{LSB}(2.5 \mathrm{mV})$ at the maximum leakage current. If device or operating conditions are less than worst case or leakage-induced error is acceptable, larger values of source resistance are allowed.

## A.6.3.2 Source Capacitance

When sampling an additional internal capacitor is switched to the input. This can cause a voltage drop due to charge sharing with the external and the pin capacitance. For a maximum sampling error of the input voltage $\leq 1 \mathrm{LSB}$, then the external filter capacitor, $\mathrm{C}_{\mathrm{f}} \geq 1024 *\left(\mathrm{C}_{\mathrm{INS}}-\mathrm{C}_{\mathrm{INN}}\right)$.

## A.6.3.3 Current Injection

There are two cases to consider.

1. A current is injected into the channel being converted. The channel being stressed has conversion values of $0 \times 3 \mathrm{FF}$ ( 0 xFF in 8 -bit mode) for analog inputs greater than VRH and 0 x 000 for values less than VRL unless the current is higher than specified as disruptive conditions.
2. Current is injected into pins in the neighborhood of the channel being converted. A portion of this current is picked up by the channel (coupling ratio K ), This additional current impacts the accuracy of the conversion depending on the source resistance.
The additional input voltage error on the converted channel can be calculated as $\mathrm{V}_{\mathrm{ERR}}=\mathrm{K} * \mathrm{R}_{\mathrm{S}} * \mathrm{I}_{\mathrm{INJ}}$, with $\mathrm{I}_{\mathrm{INJ}}$ being the sum of the currents injected into the two pins adjacent to the converted channel.

Table A-21. ATD Electrical Characteristics

| Conditions are shown in Table A-4 unless otherwise noted |  |  |  |  |  |  |  |
| :---: | :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| 1 | C | Max input Source Resistance | $\mathrm{R}_{\mathrm{S}}$ | - | - | 1 | $\mathrm{~K} \Omega$ |
| 2 | T | Total Input Capacitance <br> Non Sampling <br> Sampling | $\mathrm{C}_{\mathrm{INN}}$ | - | - | 10 | pF |
| 3 | C | Disruptive Analog Input Current | $\mathrm{C}_{\mathrm{INS}}$ | - | - | 15 |  |
| 4 | C | Coupling Ratio positive current injection | $\mathrm{K}_{\mathrm{pA}}$ | -2.5 | - | 2.5 | mA |
| 5 | C | Coupling Ratio negative current injection | $\mathrm{K}_{\mathrm{n}}$ | - | - | $10^{-4}$ | $\mathrm{~A} / \mathrm{A}$ |

## Appendix A Electrical Characteristics

## A.6.4 ATD Accuracy - 5V Range

Table A-22 specifies the ATD conversion performance excluding any errors due to current injection, input capacitance and source resistance.

Table A-22. 5V ATD Conversion Performance
Conditions are shown in Table A-4 unless otherwise noted
$\mathrm{V}_{\mathrm{REF}}=\mathrm{V}_{\mathrm{RH}}-\mathrm{V}_{\mathrm{RL}}=5.12 \mathrm{~V}$. Resulting to one 8 bit count $=20 \mathrm{mV}$ and one 10 bit count $=5 \mathrm{mV}$
$\mathrm{f}_{\text {ATDCLK }}=2.0 \mathrm{MHz}$

| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :--- | :---: | :---: | :---: | :---: | :---: |
| 1 | P | 10-Bit Resolution | LSB | - | 5 | - | mV |
| 2 | P | 10-Bit Differential Nonlinearity | DNL | -1 | - | 1 | Counts |
| 3 | P | 10-Bit Integral Nonlinearity | INL | -2.0 | - | 2.0 | Counts |
| 4 | P | 10-Bit Absolute Error |  |  |  |  |  |
| 5 | C | 10-Bit Absolute Error at $\mathrm{f}_{\text {ATDCLK }}=4 \mathrm{MHz}$ | AE | -2.5 | - | 2.5 | Counts |
| 6 | P | 8-Bit Resolution | AE | - | $\pm 7.0$ | - | Counts |
| 7 | P | 8-Bit Differential Nonlinearity | LSB | - | 20 | - | mV |
| 8 | P | 8-Bit Integral Nonlinearity | INL | -1.0 | $\pm 0.5$ | 1.0 | Counts |
| 9 | P | 8-Bit Absolute Error ${ }^{1}$ | AE | -1.5 | $\pm 1.0$ | 1.5 | Counts |

1 These values include quantization error which is inherently $1 / 2$ count for any A/D converter.

## A.6.5 ATD Accuracy - 3.3V Range

Table A-23 specifies the ATD conversion performance excluding any errors due to current injection, input capacitance and source resistance.

## Table A-23. 3.3V ATD Conversion Performance

Conditions are shown in Table A-4 unless otherwise noted
$\mathrm{V}_{\mathrm{REF}}=\mathrm{V}_{\mathrm{RH}}-\mathrm{V}_{\mathrm{RL}}=3.328 \mathrm{~V}$. Resulting to one 8 bit count $=13 \mathrm{mV}$ and one 10 bit count $=3.25 \mathrm{mV}$
$\mathrm{f}_{\text {ATDCLK }}=2.0 \mathrm{MHz}$

| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :--- | :--- | :---: | :---: | :---: | :---: | :---: |
| 1 | P | 10-Bit Resolution | LSB | - | 3.25 | - | mV |
| 2 | P | 10-Bit Differential Nonlinearity | DNL | -1.5 |  | 1.5 | Counts |
| 3 | P | 10-Bit Integral Nonlinearity | INL | -3.5 | $\pm 1.5$ | 3.5 | Counts |
| 4 | P | 10-Bit Absolute Error ${ }^{1}$ | AE | -5 | $\pm 2.5$ | 5 | Counts |
| 5 | C | 10-Bit Absolute Error at $\mathrm{A}_{\text {ATDCLK }}=4 \mathrm{MHz}$ | AE | - | $\pm 7.0$ | - | Counts |
| 6 | P | 8-Bit Resolution | LSB | - | 13 | - | mV |
| 7 | P | 8-Bit Differential Nonlinearity | DNL | -0.5 | - | 0.5 | Counts |
| 8 | P | 8-Bit Integral Nonlinearity | INL | -1.5 | $\pm 1.0$ | 1.5 | Counts |
| 9 | P | 8-Bit Absolute Error ${ }^{1}$ | AE | -2.0 | $\pm 1.5$ | 2.0 | Counts |

1 These values include the quantization error which is inherently $1 / 2$ count for any $A / D$ converter.

For the following definitions see also Figure A-8.
Differential Non-Linearity (DNL) is defined as the difference between two adjacent switching steps.

$$
\mathrm{DNL}(\mathrm{i})=\frac{\mathrm{V}_{\mathrm{i}}-\mathrm{V}_{\mathrm{i}-1}}{1 \mathrm{LSB}}-1
$$

The Integral Non-Linearity (INL) is defined as the sum of all DNLs:

$$
\operatorname{INL}(\mathrm{n})=\sum_{\mathrm{i}=1}^{\mathrm{n}} \mathrm{DNL}(\mathrm{i})=\frac{\mathrm{V}_{\mathrm{n}}-\mathrm{V}_{0}}{1 \mathrm{LSB}}-\mathrm{n}
$$



Figure A-8. ATD Accuracy Definitions

## NOTE

Figure A-8 shows only definitions, for specification values refer to Table A-22 and Table A-23.

## A. 7 DAC Characteristics

This section describes the characteristics of the digital to analog converter.

## A.7.1 DAC Operating Characteristics

Table A-24. DAC Electrical Characteristics (Operating)

| Num | C | Characteristic | Condition | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | D | DAC Supply |  | $\mathrm{V}_{\text {DDA }}$ | 3.135 | - | 5.5 | V |
| 2 | D | DAC Supply Current | Running | I DDArun | - | - | 3.5 | mA |
|  | D |  | Stop (low power) | IDDstop | - | - | 1.0 | mA |
| 3 | D | Reference Potential | Low | $\mathrm{V}_{\text {SSA }}$ | $\mathrm{V}_{\text {SSA }}$ | - | $\mathrm{V}_{\text {SSA }}$ | V |
|  | D |  | High | $V_{\text {REF }}$ | $\mathrm{V}_{\mathrm{DDA}} / 2$ | - | $\mathrm{V}_{\text {DDA }}$ | V |
| 4 | D | Reference Supply Current | $\mathrm{V}_{\text {REF }}$ to $\mathrm{V}_{\text {SSA }}$ | $I_{\text {REF }}$ | - | - | 400 | mA |
| 5 | D | Input Current, Channel Off ${ }^{1}$ |  | IOFF | -200 | - | 1 | $\mu \mathrm{A}$ |
| 6 | D | Operating Temperature Range |  | T | -40 | - | 125 | C |

Table A-25. DAC Timing/Performance Characteristics

| Num | C | Parameters | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | D | DAC Operating Frequency | $\mathrm{f}_{\mathrm{BUS}}$ | - | - | 25 | MHz |
| 2 | D | Integral Non-Linearity | INL | - | 0.25 | - | Count |
| 3 | D | Differential Non-Linearity | DNL | - | 0.10 | - | Count |
| 4 | D | Resolution | RES | - | - | 8 | Bit |
| 5 | D | Settling Time | $\mathrm{T}_{\mathrm{S}}$ | 5 | - | 10 | $\mu \mathrm{s}$ |
| 6 | P | Absolute Accuracy | $\mathrm{ABS}_{\text {ACC }}$ | -1 | - | 1 | Count |
| 7 | D | Offset Error | ERR | - | +/-2.5 | - | mV |

## A. 8 External Bus Timing

A timing diagram of the external multiplexed-bus is illustrated in Figure A-9 with the actual timing values shown on table Table A-26 and Table A-27. All major bus signals are included in the diagram. While both a data write and data read cycle are shown, only one or the other would occur on a particular bus cycle.

The expanded bus timings are highly dependent on the load conditions. The timing parameters shown assume a balanced load across all outputs.


Figure A-9. General External Bus Timing

Table A-26. Expanded Bus Timing Characteristics (5V Range)
Conditions are $4.75 \mathrm{~V}<\mathrm{VDDX}<5.25 \mathrm{~V}$, Junction Temperature $-40^{\circ} \mathrm{C}$ to $+140^{\circ} \mathrm{C}, \mathrm{C}_{\mathrm{LOAD}}=50 \mathrm{pF}$

| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | P | Frequency of operation (E-clock) | $\mathrm{f}_{0}$ | 0 | - | 25.0 | MHz |
| 2 | P | Cycle time | $\mathrm{t}_{\text {cyc }}$ | 40 | - | - | ns |
| 3 | D | Pulse width, E low | PW ${ }_{\text {EL }}$ | 19 | - | - | ns |
| 4 | D | Pulse width, E high ${ }^{1}$ | $\mathrm{PW}_{\text {EH }}$ | 19 | - | - | ns |
| 5 | D | Address delay time | $t_{\text {AD }}$ | - | - | 8 | ns |
| 6 | D | Address valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{AD}}$ ) | $\mathrm{t}_{\mathrm{AV}}$ | 11 | - | - | ns |
| 7 | D | Muxed address hold time | $\mathrm{t}_{\text {MAH }}$ | 2 | - | - | ns |
| 8 | D | Address hold to data valid | $\mathrm{t}_{\text {AHDS }}$ | 7 | - | - | ns |
| 9 | D | Data hold to address | $\mathrm{t}_{\text {DHA }}$ | 2 | - | - | ns |
| 10 | D | Read data setup time | $\mathrm{t}_{\text {DSR }}$ | 13 | - | - | ns |
| 11 | D | Read data hold time | $\mathrm{t}_{\text {DHR }}$ | 0 | - | - | ns |
| 12 | D | Write data delay time | $\mathrm{t}_{\text {DDW }}$ | - | - | 7 | ns |
| 13 | D | Write data hold time | $\mathrm{t}_{\text {DHW }}$ | 2 | - | - | ns |
| 14 | D | Write data setup time ${ }^{1}\left(\mathrm{PW}_{\mathrm{EH}^{-}} \mathrm{t}_{\text {DDW }}\right)$ | $\mathrm{t}_{\text {DSW }}$ | 12 | - | - | ns |
| 15 | D | Address access time ${ }^{1}\left(\mathrm{t}_{\mathrm{cyc}}-\mathrm{t}_{\mathrm{AD}}-\mathrm{t}_{\mathrm{DSR}}\right)$ | $t_{\text {ACCA }}$ | 19 | - | - | ns |
| 16 | D | E high access time ${ }^{1}\left(\mathrm{PW}_{\mathrm{EH}^{-}} \mathrm{t}_{\mathrm{DSR}}\right)$ | $t_{\text {ACCE }}$ | 6 | - | - | ns |
| 17 | D | Non-multiplexed address delay time | $\mathrm{t}_{\text {NAD }}$ | - | - | 6 | ns |
| 18 | D | Non-muxed address valid to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\text {NAD }}$ ) | $\mathrm{t}_{\text {NAV }}$ | 14 | - | - | ns |
| 19 | D | Non-multiplexed address hold time | $\mathrm{t}_{\text {NAH }}$ | 2 | - | - | ns |
| 20 | D | Chip select delay time | $\mathrm{t}_{\text {CSD }}$ | - | - | 16 | ns |
| 21 | D | Chip select access time ${ }^{1}\left(\mathrm{t}_{\mathrm{cyc}}-\mathrm{t}_{\mathrm{CSD}}{ }^{-\mathrm{t}_{\mathrm{DSR}}}\right)$ | $t_{\text {ACCS }}$ | 11 | - | - | ns |
| 22 | D | Chip select hold time | $\mathrm{t}_{\mathrm{CSH}}$ | 2 | - | - | ns |
| 23 | D | Chip select negated time | $\mathrm{t}_{\text {CSN }}$ | 8 | - | - | ns |
| 24 | D | Read/write delay time | $t_{\text {RWD }}$ | - | - | 7 | ns |
| 25 | D | Read/write valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{RWD}}$ ) | $\mathrm{t}_{\text {RWV }}$ | 14 | - | - | ns |
| 26 | D | Read/write hold time | $\mathrm{t}_{\text {RWH }}$ | 2 | - | - | ns |
| 27 | D | Low strobe delay time | tLSD | - | - | 7 | ns |
| 28 | D | Low strobe valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{LSD}}$ ) | tisv | 14 | - | - | ns |
| 29 | D | Low strobe hold time | tish | 2 | - | - | ns |
| 30 | D | NOACC strobe delay time | $\mathrm{t}_{\text {NOD }}$ | - | - | 7 | ns |
| 31 | D | NOACC valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}{ }^{-\mathrm{t}_{\mathrm{NOD}}}$ ) | $\mathrm{t}_{\mathrm{NOV}}$ | 14 | - | - | ns |
| 32 | D | NOACC hold time | $\mathrm{t}_{\mathrm{NOH}}$ | 2 | - | - | ns |
| 33 | D | IPIPO[1:0] delay time | $\mathrm{t}_{\text {POD }}$ | 2 | - | 7 | ns |
| 34 | D | IPIPO[1:0] valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{POD}}$ ) | tpov | 11 | - | - | ns |
| 35 | D | IPIPO[1:0] delay time ${ }^{1}\left(\mathrm{PW}_{\mathrm{EH}^{-\mathrm{t}_{\mathrm{P} 1 \mathrm{~V}}} \text { ) }}\right.$ | $t_{\text {P1D }}$ | 2 | - | 25 | ns |
| 36 | D | IPIPO[1:0] valid time to E fall | $\mathrm{t}_{\mathrm{P} 1 \mathrm{~V}}$ | 11 | - | - | ns |

[^14]
## Appendix A Electrical Characteristics

Table A-27. Expanded Bus Timing Characteristics (3.3V Range)
Conditions are VDDX $=3.3 \mathrm{~V}+/-10 \%$, Junction Temperature $-40^{\circ} \mathrm{C}$ to $+140^{\circ} \mathrm{C}, \mathrm{C}_{\text {LOAD }}=50 \mathrm{pF}$

| Num | C | Rating | Symbol | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | P | Frequency of operation (E-clock) | $\mathrm{f}_{0}$ | 0 | - | 16.0 | MHz |
| 2 | P | Cycle time | $\mathrm{t}_{\text {cyc }}$ | 62.5 | - | - | ns |
| 3 | D | Pulse width, E low | PW ${ }_{\text {EL }}$ | 30 | - | - | ns |
| 4 | D | Pulse width, E high ${ }^{1}$ | $\mathrm{PW}_{\text {EH }}$ | 30 | - | - | ns |
| 5 | D | Address delay time | $t_{\text {AD }}$ | - | - | 16 | ns |
| 6 | D | Address valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{AD}}$ ) | $\mathrm{t}_{\mathrm{AV}}$ | 16 | - | - | ns |
| 7 | D | Muxed address hold time | $\mathrm{t}_{\text {MAH }}$ | 2 | - | - | ns |
| 8 | D | Address hold to data valid | $\mathrm{t}_{\text {AHDS }}$ | 7 | - | - | ns |
| 9 | D | Data hold to address | $\mathrm{t}_{\text {DHA }}$ | 2 | - | - | ns |
| 10 | D | Read data setup time | $\mathrm{t}_{\text {DSR }}$ | 15 | - | - | ns |
| 11 | D | Read data hold time | $\mathrm{t}_{\text {DHR }}$ | 0 | - | - | ns |
| 12 | D | Write data delay time | $\mathrm{t}_{\text {DDW }}$ | - | - | 15 | ns |
| 13 | D | Write data hold time | $\mathrm{t}_{\text {DHW }}$ | 2 | - | - | ns |
| 14 | D | Write data setup time ${ }^{1}\left(\mathrm{PW}_{\left.\mathrm{EH}^{-}{ }^{-\mathrm{t}_{\mathrm{DDW}}}\right)}\right.$ | tosw | 15 | - | - | ns |
| 15 | D | Address access time ${ }^{1}\left(\mathrm{t}_{\text {cyc }}-\mathrm{t}_{\mathrm{AD}}-\mathrm{t}_{\mathrm{DSR}}\right)$ | $\mathrm{t}_{\text {ACCA }}$ | 29 | - | - | ns |
| 16 | D | E high access time ${ }^{1}\left(\mathrm{PW}_{\mathrm{EH}}-\mathrm{t}_{\mathrm{DSR}}\right)$ | $\mathrm{t}_{\text {ACCE }}$ | 15 | - | - | ns |
| 17 | D | Non-multiplexed address delay time | $\mathrm{t}_{\text {NAD }}$ | - | - | 14 | ns |
| 18 | D | Non-muxed address valid to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{NAD}}$ ) | $\mathrm{t}_{\text {NAV }}$ | 16 | - | - | ns |
| 19 | D | Non-multiplexed address hold time | $\mathrm{t}_{\text {NAH }}$ | 2 | - | - | ns |
| 20 | D | Chip select delay time | $\mathrm{t}_{\text {CSD }}$ | - | - | 25 | ns |
| 21 | D | Chip select access time ${ }^{1}\left(\mathrm{t}_{\mathrm{cyc}}-\mathrm{t}_{\mathrm{CSD}}-\mathrm{t}_{\mathrm{DSR}}\right)$ | $\mathrm{t}_{\text {ACCS }}$ | 22.5 | - | - | ns |
| 22 | D | Chip select hold time | $\mathrm{t}_{\mathrm{CSH}}$ | 2 | - | - | ns |
| 23 | D | Chip select negated time | $\mathrm{t}_{\text {cSN }}$ | 8 | - | - | ns |
| 24 | D | Read/write delay time | $t_{\text {RWD }}$ | - | - | 14 | ns |
| 25 | D | Read/write valid time to E rise ( $\mathrm{PW}_{\mathrm{EL}}-\mathrm{t}_{\mathrm{RWD}}$ ) | $\mathrm{t}_{\text {RWV }}$ | 16 | - | - | ns |
| 26 | D | Read/write hold time | $\mathrm{t}_{\text {RWH }}$ | 2 | - | - | ns |
| 27 | D | Low strobe delay time | tLSD | - | - | 14 | ns |
| 28 | D | Low strobe valid time to E rise ( $\mathrm{PW}_{\text {EL- }}-\mathrm{t}_{\text {LSD }}$ ) | tLSV | 16 | - | - | ns |
| 29 | D | Low strobe hold time | tLSH | 2 | - | - | ns |
| 30 | D | NOACC strobe delay time | $\mathrm{t}_{\text {NOD }}$ | - | - | 14 | ns |
| 31 | D | NOACC valid time to E rise ( $\mathrm{PW}_{\text {EL }}-\mathrm{t}_{\mathrm{NOD}}$ ) | $\mathrm{t}_{\mathrm{NOV}}$ | 16 | - | - | ns |
| 32 | D | NOACC hold time | $\mathrm{t}_{\mathrm{NOH}}$ | 2 | - | - | ns |
| 33 | D | IPIPO[1:0] delay time | $\mathrm{t}_{\text {POD }}$ | 2 | - | 14 | ns |
| 34 | D | IPIPO[1:0] valid time to E rise ( $\mathrm{PW}_{\text {EL }}-\mathrm{t}_{\text {POD }}$ ) | $\mathrm{t}_{\text {pov }}$ | 16 | - | - | ns |
| 35 | D | IPIPO[1:0] delay time ${ }^{1}$ ( $\mathrm{PW}_{\text {EH- }}$-tpiv ) | $\mathrm{t}_{\text {P1D }}$ | 2 | - | 25 | ns |
| 36 | D | IPIPO[1:0] valid time to E fall | $\mathrm{t}_{\text {P1V }}$ | 11 | - | - | ns |

[^15]
## Appendix B <br> Package Information

## B. $1 \quad$ 64-Pin QFN Package

Figure B-1. 64-Pin QFN Mechanical Dimensions (Case no. TBD)

## Appendix B Package Information

## B. $2 \quad$ 80-Pin QFP Package


SECTION B-B VIEW ROTATED $90{ }^{\circ}$

DETAIL C

| DIM | MILLIMETERS |  |
| :---: | :---: | :---: |
|  | MIN | MAX |
| A | 13.90 | 14.10 |
| B | 13.90 | 14.10 |
| C | 2.15 | 2.45 |
| D | 0.22 | 0.38 |
| E | 2.00 | 2.40 |
| F | 0.22 | 0.33 |
| G | 0.65 BSC |  |
| H | --- | 0.25 |
| J | 0.13 | 0.23 |
| K | 0.65 | 0.95 |
| L | 12.35 REF |  |
| M | $5^{\circ}$ | $10^{\circ}$ |
| N | 0.13 | 0.17 |
| P | 0.325 BSC |  |
| Q | $0^{\circ}$ | 70 |
| R | 0.13 | 0.30 |
| S | 16.95 | 17.45 |
| T | 0.13 | --- |
| U | $0^{\circ}$ | --- |
| V | 16.95 | 17.45 |
| W | 0.35 | 0.45 |
| X | 1.6 REF |  |

Figure B-2. 80-Pin QFP Mechanical Dimensions (Case no. 841B)

## B. 3 112-Pin LQFP Package


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. DIMENSIONS IN MILLIMETERS
3. DATUMS L, MAND N TO BE DETERMINED AT SEATING PLANE, DATUM T.
4. DIMENSIONS S AND V TO BE DETERMINED
SEATING PLANE, DATUM T.
5. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSIO
DIMENSIONS
A AND B INCLUDE MOLD MISMATCH A AND B INCLUDE MOLD MISMATCH
6. DIMENSION D DOES NOT INCLUDE 6. DIMEN

| DIM | MILLIMETERS |  |
| :---: | :---: | :---: |
|  | MIN | MAX |
| A | 20.000 BSC |  |
| A1 | 10.000 BSC |  |
| B | 20.000 BSC |  |
| B1 | 10.000 BSC |  |
| C | -- | 1.600 |
| C1 | 0.050 | 0.150 |
| C2 | 1.350 | 1.450 |
| D | 0.270 | 0.370 |
| E | 0.450 | 0.750 |
| F | 0.270 | 0.330 |
| G | 0.650 BSC |  |
| J | 0.090 | 0.170 |
| K | 0.500 REF |  |
| P | 0.325 BSC |  |
| R1 | 0.100 | 0.200 |
| R2 | 0.100 | 0.200 |
| S | 22.000 BSC |  |
| S1 | 11.000 BSC |  |
| V | 22.000 BSC |  |
| V1 | 11.000 BSC |  |
| Y | 0.250 REF |  |
| Z | 1.000 REF |  |
| AA | 0.090 | 0.160 |
| $\theta$ | $0^{\circ}$ | 8 |
| $\theta 1$ | $3^{\circ}$ | 7 |
| $\theta 2$ | $11^{\circ}$ | 13 |
| $\theta 3$ | $11^{\circ}$ | $13^{\circ}$ |

VIEW AB

Figure B-3. 112-Pin QFP Mechanical Dimensions (Case no. 987)

## Appendix C <br> Ordering Information



Package Options
$\mathrm{FC}=64 \mathrm{QFN}$
$F U=80 Q F P$ $P V=112 L Q F P$
Temperature Options $\mathrm{C}=-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ $\mathrm{v}=-40^{\circ} \mathrm{C}$ to $105^{\circ} \mathrm{C}$ $\mathrm{M}=-40^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$

Figure C-1. Order Part Number Coding
Table C-1 lists the part number coding based on the package and temperature.
Table C-1. Part Number Coding

| Part Number | Temp. | Package |
| :---: | :---: | :---: |
| MC9S12E128CFU | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 80QFP |
| MC9S12E128CPV | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 112LQFP |
| MC9S12E128MFU | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 80QFP |
| MC9S12E128MPV | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 112LQFP |
| MC9S12E64CFU | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 80QFP |
| MC9S12E64CPV | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 112LQFP |
| MC9S12E64MFU | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 80QFP |
| MC9S12E64MPV | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 112LQFP |
| MC9S12E32CFC | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 64QFN |
| MC9S12E32CFU | $-40^{\circ} \mathrm{C}, 85^{\circ} \mathrm{C}$ | 80QFP |
| MC9S12E32MFC | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 64QFN |
| MC9S12E32MFU | $-40^{\circ} \mathrm{C}, 125^{\circ} \mathrm{C}$ | 80QFP |

Table C-2 summarizes the package option and size configuration.

## Table C-2. Package Option Summary

| Part Number | Package | Temp. ${ }^{1}$ Options | Flash | RAM | MEBI | TIM | SCI | SPI | IIC | A/D | D/A | PWM | PMF | KWU | $1 / O^{2}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| MC9S12E128 | 112LQFP | M, C | 128K | 8K | 1 | 12 | 3 | 1 | 1 | 16 | 2 | 6 | 6 | 16 | 92 |
|  | 80QFP |  |  |  | 0 |  |  |  |  |  |  |  |  |  | 60 |
| MC9S12E64 | 112LQFP | M, C | 64K | 4K | 1 | 12 | 3 | 1 | 1 | 16 | 2 | 6 | 6 | 16 | 92 |
|  | 80QFP |  |  |  | 0 |  |  |  |  |  |  |  |  |  | 60 |
| MC9S12E32 | 80QFP | M, C | 32K | 2K | 0 | 12 | 3 | 1 | 1 | 16 | 2 | 6 | 6 | 16 | 60 |
|  | 64QFN |  |  |  | 0 | 8 | 2 | 1 | 1 | 8 | 2 | 6 | 6 | 8 | 44 |

${ }^{1} \mathrm{C}: \mathrm{T}_{\mathrm{A}}=85^{-} \mathrm{C}, \mathrm{f}=25 \mathrm{MHz} . \quad \mathrm{M}: \mathrm{T}_{\mathrm{A}}=125^{\circ} \mathrm{C}, \mathrm{f}=25 \mathrm{MHz}$
${ }^{2} \mathrm{I} / \mathrm{O}$ is the sum of ports capable to act as digital input or output.

- TIM is the number of channels.
- $A / D$ is the number of $A / D$ channels.
- $\mathrm{D} / \mathrm{A}$ is the number of $\mathrm{D} / \mathrm{A}$ channels.
- PWM is the number of channels.
- PMF is the number of channels.
- KWU is the number of key wake up interrupt pins.
- I/O is the sum of ports capable to act as digital input or output.


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[^0]:    1. By placing $0 \times 3 \mathrm{E} / 0 \times 3 \mathrm{~F}$ in the HCS12 Core PPAGE register, the bottom/top fixed 16 Kbyte pages can be seen twice in the MCU memory map.
[^1]:    1. VCO clock cycles are generated by the PLL when running at minimum frequency $\mathrm{f}_{\mathrm{SCM}}$.
[^2]:    1. A Clock Monitor Reset will always set the SCME bit to logical'1'
[^3]:    ${ }^{1}$ When the receiver wakeup bit (RWU) is set, an idle line condition does not set the IDLE flag.
    2 The OR flag may read back as set when RDRF flag is clear. This may happen if the following sequence of events occurs:

    1. After the first frame is received, read status register SCISR1 (returns RDRF set and OR flag clear);
    2. Receive second frame without reading the first frame in the data register (the second frame is not received and OR flag is set);
    3. Read data register SCIDRL (returns first frame and clears RDRF flag in the status register);
    4. Read status register SCISR1 (returns RDRF clear and OR set).

    Event 3 may be at exactly the same time as event 2 or any time after. When this happens, a dummy SCIDRL read following event 4 will be required to clear the OR flag if further frames are to be received.

[^4]:    1 Certain bits are non-writable.
    2 Writes to this register are ignored.
    3 Reading from this register returns all zeros.

[^5]:    1 Always read $0 \times 0000$.

[^6]:    1. BDM is enabled and active immediately out of special single-chip reset.
    2. This method is only available on systems that have a a breakpoint or a debug sub-block.
[^7]:    1. Target clock cycles are cycles measured using the target MCU's serial clock rate. See Section 15.4.6, "BDM Serial Interface," and Section 15.3.2.1, "BDM Status Register (BDMSTS)," for information on how serial clock rate is selected.
[^8]:    ${ }^{1}$ See Figure 16-10.
    ${ }^{2}$ Current HCS12 implementations have PPAGE limited to 6 bits. Therefore, EXTCMP[5:4] should be set to 00 .
    ${ }^{3}$ Data page (DPAGE) and Extra page (EPAGE) are reserved for implementation on devices that support paged data and extra space.

[^9]:    1 See Figure 16-16.
    2 See Figure 16-10 (note that while this figure provides extended comparisons for comparator C , the figure also pertains to comparators A and B in DBG mode only).

[^10]:    1 The device contains an internal voltage regulator to generate the logic and PLL supply out of the I/O supply. The absolute maximum ratings apply when the device is powered from an external source.
    2 All digital $I / O$ pins are internally clamped to $\mathrm{V}_{S S X}$ and $\mathrm{V}_{\mathrm{DDX}}, \mathrm{V}_{\text {SSR }}$ and $\mathrm{V}_{\text {DDR }}$ or $\mathrm{V}_{\text {SSA }}$ and $\mathrm{V}_{\text {DDA }}$.
    3 These pins are internally clamped to $\mathrm{V}_{\text {SSPLL }}$ and $\mathrm{V}_{\text {DDPLL }}$
    4 This pin is clamped low to $\mathrm{V}_{\mathrm{SSR}}$, but not clamped high. This pin must be tied low in applications.

[^11]:    1 The values for thermal resistance are achieved by package simulations
    2 PC Board according to EIA/JEDEC Standard 51-3
    3 PC Board according to EIA/JEDEC Standard 51-7

[^12]:    1 PLL off
    2 At those low power dissipation levels $T_{J}=T_{A}$ can be assumed

[^13]:    ${ }^{1}$ Restrictions for oscillator in crystal mode apply!
    ${ }^{2}$ Minimum Programming times are achieved under maximum NVM operating frequency $\mathrm{f}_{\text {NVMOP }}$ and maximum bus frequency $\mathrm{f}_{\text {bus }}$.
    ${ }^{3}$ Maximum Erase and Programming times are achieved under particular combinations of $f_{\text {NVMOP }}$ and bus frequency $f$ bus. Refer to formulae in Sections A.3.1.1 - A.3.1.4 for guidance.
    ${ }^{4}$ Minimum Erase times are achieved under maximum NVM operating frequency $\mathrm{f}_{\text {NVMOP }}$
    ${ }^{5}$ Minimum time, if first word in the array is not blank
    ${ }^{6}$ Maximum time to complete check on an erased block
    7 Where $\mathrm{t}_{\mathrm{cyc}}$ is the system bus clock period.

[^14]:    1 Affected by clock stretch: add $N \times t_{\text {cyc }}$ where $N=0,1,2$ or 3 , depending on the number of clock stretches.

[^15]:    ${ }^{1}$ Affected by clock stretch: add $\mathrm{N} \times \mathrm{t}_{\text {cyc }}$ where $\mathrm{N}=0,1,2$ or 3 , depending on the number of clock stretches.

